



**ELDRS Report  
12-640 130125 R1.1**

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***Enhanced Low Dose Rate Sensitivity (ELDRS) Radiation Testing of the  
RH1499MW Quad Rail-to-Rail Input and Output Precision C-Load Op Amp  
for Linear Technology***

**Customer:** Linear Technology, PO# 5259J

**RAD Job Number:** 12-640

**Part Type Tested:** RH1499MW Quad Rail-to-Rail Input and Output Precision C-Load Op Amp.

**Traceability Information:** Fab Lot Number: W1046927.1, Wafer Number: 1, Assembly Lot Number: 656718.1, Date Code: 1203A. See photograph of unit under test in Appendix A.

**Quantity of Units:** 22 units received, 5 units for biased irradiation, 5 units for unbiased irradiation and 2 units for control. Serial numbers 557, 563, 564, 567 and 569 were biased during irradiation, serial numbers 570, 571, 572, 573 and 574 were unbiased during irradiation and serial numbers 584 and 585 were used as control. See Appendix B for the radiation bias connection table.

**Radiation and Electrical Test Increments:** 10mrad(Si)/s ionizing radiation with electrical test increments: pre-irradiation, 10krad(Si), 20krad(Si), 30krad(Si) and 50krad(Si).

**Pre-Irradiation Burn-In:** Burn-In performed by Linear Technology prior to receipt by RAD

**Overtest and Post-Irradiation Anneal:** No overtest. 24-hour room temperature anneal followed by a 168-hour 100°C anneal. Both anneals were performed in the same electrical bias condition as the irradiations. Electrical measurements were made following each anneal increment.

**Radiation Test Standard:** MIL-STD-750E TM1019 and/or MIL-STD-883H TM1019 Condition D.

**Test Hardware and Software:** LTS2020 Automated Tester, Entity ID TS04, Calibration Date: 4/26/2012, Calibration Due: 4/26/2013. LTS2101 Family Board, Entity ID FB10. LTS0600 Test Fixture, Entity ID TF03. RH1499 BGSS 061114 DUT Board. Test Program: RH1499X.SRC

**Facility and Radiation Source:** Aeroflex RAD's Longmire Laboratories, Colorado Springs, CO. Gamma rays provided by Co60 (GB-150) low dose rate source. Dosimetry performed by Air Ionization Chamber (AIC) traceable to NIST. Aeroflex RAD's dosimetry has been audited by DSCC and Aeroflex RAD has been awarded Laboratory Suitability for MIL-STD-750 and MIL-STD-883 TM 1019.

**Irradiation and Test Temperature:** Room temperature controlled to 24°C±6°C per MIL-STD-883 and MIL-STD-750.

**Low Dose Rate Test Result: PASSED the enhanced low dose rate sensitivity test to the maximum tested dose level of 50krad(Si) with all parameters remaining within their datasheet specifications.**



## **1.0. Overview and Background**

It is well known that total dose ionizing radiation can cause parametric degradation and ultimately functional failure in electronic devices. The damage occurs via electron-hole pair production, transport and trapping in the dielectric regions. In advanced CMOS technology nodes (0.6 $\mu$ m and smaller) the bulk of the damage is manifested in the thicker isolation regions, such as shallow trench or local oxidation of silicon (LOCOS) oxides (also known as "birds-beak" oxides). However, many linear and mixed signal devices that utilize bipolar minority carrier elements exhibit an enhanced low dose rate sensitivity (ELDRS). At this time there is no known or accepted *a priori* method for predicting susceptibility to ELDRS or simulating the low dose rate sensitivity with a "conventional" room temperature 50-300rad(Si)/s irradiation (Condition A in MIL-STD-883 TM 1019.8). Over the past 10 years a number of accelerating techniques have been examined, including an elevated temperature anneal, such as that used for MOS devices (see ASTM-F-1892 for more technical details) and irradiating at various temperatures. However, none of these techniques have proven useful across the wide variety of linear and/or mixed signal devices used in spaceborne applications.

The latest requirement incorporated in MIL-STD-883 TM 1019 requires that devices that could potentially exhibit ELDRS "shall be tested either at the intended application dose rate, at a prescribed low dose rate to an overtest radiation level, or with an accelerated test such as an elevated temperature irradiation test that includes a parameter delta design margin". While the recently released MIL-STD-883 TM 1019 allows for accelerated testing, the requirements for this are to essentially perform a low dose rate ELDRS test to verify the suitability of the acceleration method on the component of interest before the acceleration technique can be instituted. Based on the limitations of accelerated testing and to meet the requirements of MIL-STD-883 TM1019.8 Condition D, we have performed a low dose rate test at 10mrad(Si)/s.

## **2.0. Radiation Test Apparatus**

The low dose rate testing described in this final report was performed using the facilities at Aeroflex RAD's Longmire Laboratories in Colorado Springs, CO. The low dose rate source is a GB-150 irradiator modified to provide a panoramic exposure. The Co-60 rods are held in the base of the irradiator heavily shielded by lead. During the irradiation exposures the rod is raised by an electronic timer/controller and the exposure is performed in air. The dose rate for this irradiator in this configuration ranges from approximately 1mrad(Si)/s to a maximum of approximately 50rad(Si)/s, determined by the distance from the source. For low dose rate testing described in this report, the devices are placed approximately 2-meters from the Co-60 rods. The irradiator calibration is maintained by Aeroflex RAD's Longmire Laboratories using air ionization chamber (AIC) dosimetry traceable to the National Institute of Standards and Technology (NIST). Figure 2.1 shows a photograph of the GB-150 Co-60 irradiator at Aeroflex RAD's Longmire Laboratory facility.



Figure 2.1. Aeroflex RAD's Co-60 irradiator. The dose rate is obtained by positioning the device-under-test at a fixed distance from the gamma cell. The dose rate for this irradiator varies from approximately 50rad(Si)/s close to the rods down to <1mrad(Si)/s at a distance of approximately 4-meters.



### **3.0. Radiation Test Conditions**

The RH1499MW Quad Rail-to-Rail Input and Output Precision C-Load Op Amp described in this final report were irradiated using a split 15V supply and with all pins tied to ground, that is biased and unbiased. See Appendix B for details on the biasing conditions during radiation exposure. In our opinion, this bias circuit satisfies the requirements of MIL-STD-883H TM1019.8 Section 3.9.3 Bias and Loading Conditions which states "The bias applied to the test devices shall be selected to produce the greatest radiation induced damage or the worst-case damage for the intended application, if known. While maximum voltage is often worst case some bipolar linear device parameters (e.g. input bias current or maximum output load current) exhibit more degradation with 0 V bias."

The devices were irradiated to a maximum total ionizing dose level of 50krad(Si) with incremental readings at 10krad(Si), 20krad(Si) and 30krad(Si). Electrical testing occurred within one hour following the end of each irradiation segment. For intermediate irradiations, the units were tested and returned to total dose exposure within two hours from the end of the previous radiation increment. The radiation exposure bias board was positioned in the Co-60 cell to provide the targeted dose rate of 10mrad(Si)/s and was located inside a lead-aluminum enclosure. The lead-aluminum enclosure is required under MIL-STD-883H TM1019.8 Section 3.4 that reads as follows: "Lead/Aluminum (Pb/Al) container. Test specimens shall be enclosed in a Pb/Al container to minimize dose enhancement effects caused by low-energy, scattered radiation. A minimum of 1.5 mm Pb, surrounding an inner shield of at least 0.7 mm Al, is required. This Pb/Al container produces an approximate charged particle equilibrium for Si and for TLDs such as CaF<sub>2</sub>. The radiation field intensity shall be measured inside the Pb/Al container (1) initially, (2) when the source is changed, or (3) when the orientation or configuration of the source, container, or test-fixture is changed. This measurement shall be performed by placing a dosimeter (e.g., a TLD) in the device-irradiation container at the approximate test-device position. If it can be demonstrated that low energy scattered radiation is small enough that it will not cause dosimetry errors due to dose enhancement, the Pb/Al container may be omitted".

The final dose rate within the lead-aluminum box was determined based on air ionization chamber (AIC) dosimetry measurements just prior to the beginning of the total dose irradiations. The final dose rate for this work was 10mrad(Si)/s with a precision of  $\pm 5\%$ .



#### **4.0. Tested Parameters**

During the enhanced low dose rate sensitivity testing the following electrical parameters were measured pre- and post-irradiation:

1. +Supply Current 15V (A) @ VS=+/-15V
2. -Supply Current 15V (A) @ VS=+/-15V
3. Input Offset Voltage1 1 15V (V) @ VS=+/-15V, VCM=0V
4. Input Offset Voltage1 2 15V (V) @ VS=+/-15V, VCM=0V
5. Input Offset Voltage1 3 15V (V) @ VS=+/-15V, VCM=0V
6. Input Offset Voltage1 4 15V (V) @ VS=+/-15V, VCM=0V
7. Input Offset Current1 1 15V (A) @ VS=+/-15V, VCM=0V
8. Input Offset Current1 2 15V (A) @ VS=+/-15V, VCM=0V
9. Input Offset Current1 3 15V (A) @ VS=+/-15V, VCM=0V
10. Input Offset Current1 4 15V (A) @ VS=+/-15V, VCM=0V
11. +Input Bias Current BIAS1 1 15V (A) @ VS=+/-15V, VCM=0V
12. +Input Bias Current BIAS1 2 15V (A) @ VS=+/-15V, VCM=0V
13. +Input Bias Current BIAS1 3 15V (A) @ VS=+/-15V, VCM=0V
14. +Input Bias Current BIAS1 4 15V (A) @ VS=+/-15V, VCM=0V
15. -Input Bias Current BIAS1 1 15V (A) @ VS=+/-15V, VCM=0V
16. -Input Bias Current BIAS1 2 15V (A) @ VS=+/-15V, VCM=0V
17. -Input Bias Current BIAS1 3 15V (A) @ VS=+/-15V, VCM=0V
18. -Input Bias Current BIAS1 4 15V (A) @ VS=+/-15V, VCM=0V
19. Input Offset Voltage2 1 15V (V) @ VS=+/-15V, VCM=15V
20. Input Offset Voltage2 2 15V (V) @ VS=+/-15V, VCM=15V
21. Input Offset Voltage2 3 15V (V) @ VS=+/-15V, VCM=15V
22. Input Offset Voltage2 4 15V (V) @ VS=+/-15V, VCM=15V
23. Input Offset Current2 1 15V (A) @ VS=+/-15V, VCM=15V
24. Input Offset Current2 2 15V (A) @ VS=+/-15V, VCM=15V
25. Input Offset Current2 3 15V (A) @ VS=+/-15V, VCM=15V
26. Input Offset Current2 4 15V (A) @ VS=+/-15V, VCM=15V
27. +Input Bias Current BIAS2 1 15V (A) @ VS=+/-15V, VCM=15V
28. +Input Bias Current BIAS2 2 15V (A) @ VS=+/-15V, VCM=15V
29. +Input Bias Current BIAS2 3 15V (A) @ VS=+/-15V, VCM=15V
30. +Input Bias Current BIAS2 4 15V (A) @ VS=+/-15V, VCM=15V
31. -Input Bias Current BIAS2 1 15V (A) @ VS=+/-15V, VCM=15V
32. -Input Bias Current BIAS2 2 15V (A) @ VS=+/-15V, VCM=15V
33. -Input Bias Current BIAS2 3 15V (A) @ VS=+/-15V, VCM=15V
34. -Input Bias Current BIAS2 4 15V (A) @ VS=+/-15V, VCM=15V
35. Input Offset Voltage3 1 15V (V) @ VS=+/-15V, VCM=-15V
36. Input Offset Voltage3 2 15V (V) @ VS=+/-15V, VCM=-15V
37. Input Offset Voltage3 3 15V (V) @ VS=+/-15V, VCM=-15V
38. Input Offset Voltage3 4 15V (V) @ VS=+/-15V, VCM=-15V
39. Input Offset Current3 1 15V (A) @ VS=+/-15V, VCM=-15V
40. Input Offset Current3 2 15V (A) @ VS=+/-15V, VCM=-15V
41. Input Offset Current3 3 15V (A) @ VS=+/-15V, VCM=-15V



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- 42. Input Offset Current3 4 15V (A) @ VS=+/-15V, VCM=-15V
- 43. +Input Bias Current BIAS3 1 15V (A) @ VS=+/-15V, VCM=-15V
- 44. +Input Bias Current BIAS3 2 15V (A) @ VS=+/-15V, VCM=-15V
- 45. +Input Bias Current BIAS3 3 15V (A) @ VS=+/-15V, VCM=-15V
- 46. +Input Bias Current BIAS3 4 15V (A) @ VS=+/-15V, VCM=-15V
- 47. -Input Bias Current BIAS3 1 15V (A) @ VS=+/-15V, VCM=-15V
- 48. -Input Bias Current BIAS3 2 15V (A) @ VS=+/-15V, VCM=-15V
- 49. -Input Bias Current BIAS3 3 15V (A) @ VS=+/-15V, VCM=-15V
- 50. -Input Bias Current BIAS3 4 15V (A) @ VS=+/-15V, VCM=-15V
- 51. Output Voltage Swing High1 1 15V (V) @ VS=+/-15V IL=0mA
- 52. Output Voltage Swing High1 2 15V (V) @ VS=+/-15V IL=0mA
- 53. Output Voltage Swing High1 3 15V (V) @ VS=+/-15V IL=0mA
- 54. Output Voltage Swing High1 4 15V (V) @ VS=+/-15V IL=0mA
- 55. Output Voltage Swing High2 1 15V (V) @ VS=+/-15V IL=1mA
- 56. Output Voltage Swing High2 2 15V (V) @ VS=+/-15V IL=1mA
- 57. Output Voltage Swing High2 3 15V (V) @ VS=+/-15V IL=1mA
- 58. Output Voltage Swing High2 4 15V (V) @ VS=+/-15V IL=1mA
- 59. Output Voltage Swing High3 1 15V (V) @ VS=+/-15V IL=10mA
- 60. Output Voltage Swing High3 2 15V (V) @ VS=+/-15V IL=10mA
- 61. Output Voltage Swing High3 3 15V (V) @ VS=+/-15V IL=10mA
- 62. Output Voltage Swing High3 4 15V (V) @ VS=+/-15V IL=10mA
- 63. Output Voltage Swing Low1 1 15V (V) @ VS=+/-15V IL=0mA
- 64. Output Voltage Swing Low1 2 15V (V) @ VS=+/-15V IL=0mA
- 65. Output Voltage Swing Low1 3 15V (V) @ VS=+/-15V IL=0mA
- 66. Output Voltage Swing Low1 4 15V (V) @ VS=+/-15V IL=0mA
- 67. Output Voltage Swing Low2 1 15V (V) @ VS=+/-15V IL=1mA
- 68. Output Voltage Swing Low2 2 15V (V) @ VS=+/-15V IL=1mA
- 69. Output Voltage Swing Low2 3 15V (V) @ VS=+/-15V IL=1mA
- 70. Output Voltage Swing Low2 4 15V (V) @ VS=+/-15V IL=1mA
- 71. Output Voltage Swing Low3 1 15V (V) @ VS=+/-15V IL=10mA
- 72. Output Voltage Swing Low3 2 15V (V) @ VS=+/-15V IL=10mA
- 73. Output Voltage Swing Low3 3 15V (V) @ VS=+/-15V IL=10mA
- 74. Output Voltage Swing Low3 4 15V (V) @ VS=+/-15V IL=10mA
- 75. Large Signal Voltage Gain1 1 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ
- 76. Large Signal Voltage Gain1 2 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ
- 77. Large Signal Voltage Gain1 3 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ
- 78. Large Signal Voltage Gain1 4 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ
- 79. Large Signal Voltage Gain2 1 15V (V/mV) @ VO=+/-10V, RL=2kΩ
- 80. Large Signal Voltage Gain2 2 15V (V/mV) @ VO=+/-10V, RL=2kΩ
- 81. Large Signal Voltage Gain2 3 15V (V/mV) @ VO=+/-10V, RL=2kΩ
- 82. Large Signal Voltage Gain2 4 15V (V/mV) @ VO=+/-10V, RL=2kΩ
- 83. Common Mode Rejection Ratio1 1 15V (dB) @ VS=+/-15V, VCM=+/-15V
- 84. Common Mode Rejection Ratio1 2 15V (dB) @ VS=+/-15V, VCM=+/-15V
- 85. Common Mode Rejection Ratio1 3 15V (dB) @ VS=+/-15V, VCM=+/-15V
- 86. Common Mode Rejection Ratio1 4 15V (dB) @ VS=+/-15V, VCM=+/-15V
- 87. CMRR Match1 1 to 4 15V (dB) @ VS=+/-15V, VCM=+/-15V

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88. CMRR Match1 2 to 3 15V (dB) @ VS=+/-15V, VCM=+/-15V
89. Power Supply Rejection Ratio1 1 (dB) @ VS=+/-2V to +/-16V
90. Power Supply Rejection Ratio1 2 (dB) @ VS=+/-2V to +/-16V
91. Power Supply Rejection Ratio1 3 (dB) @ VS=+/-2V to +/-16V
92. Power Supply Rejection Ratio1 4 (dB) @ VS=+/-2V to +/-16V
93. PSRR Match1 1 to 4 (dB) @ VS=+/-2V to +/-16V
94. PSRR Match1 2 to 3 (dB) @ VS=+/-2V to +/-16V
95. +Short-Circuit Current1 1 15V (A) @ VS=+/-15V, VOUT=0V
96. +Short-Circuit Current1 2 15V (A) @ VS=+/-15V, VOUT=0V
97. +Short-Circuit Current1 3 15V (A) @ VS=+/-15V, VOUT=0V
98. +Short-Circuit Current1 4 15V (A) @ VS=+/-15V, VOUT=0V
99. -Short-Circuit Current1 1 15V (A) @ VS=+/-15V, VOUT=0V
100. -Short-Circuit Current1 2 15V (A) @ VS=+/-15V, VOUT=0V
101. -Short-Circuit Current1 3 15V (A) @ VS=+/-15V, VOUT=0V
102. -Short-Circuit Current1 4 15V (A) @ VS=+/-15V, VOUT=0V
103. +Supply Current 5V (A) @ VS=+5V
104. -Supply Current 5V (A) @ VS=+5V
105. Input Offset Voltage4 1 5V (V) @ VS=+5V, VCM=0V
106. Input Offset Voltage4 2 5V (V) @ VS=+5V, VCM=0V
107. Input Offset Voltage4 3 5V (V) @ VS=+5V, VCM=0V
108. Input Offset Voltage4 4 5V (V) @ VS=+5V, VCM=0V
109. Input Offset Current4 1 5V (A) @ VS=+5V, VCM=0V
110. Input Offset Current4 2 5V (A) @ VS=+5V, VCM=0V
111. Input Offset Current4 3 5V (A) @ VS=+5V, VCM=0V
112. Input Offset Current4 4 5V (A) @ VS=+5V, VCM=0V
113. +Input Bias Current BIAS4 1 5V (A) @ VS=+5V, VCM=0V
114. +Input Bias Current BIAS4 2 5V (A) @ VS=+5V, VCM=0V
115. +Input Bias Current BIAS4 3 5V (A) @ VS=+5V, VCM=0V
116. +Input Bias Current BIAS4 4 5V (A) @ VS=+5V, VCM=0V
117. -Input Bias Current BIAS4 1 5V (A) @ VS=+5V, VCM=0V
118. -Input Bias Current BIAS4 2 5V (A) @ VS=+5V, VCM=0V
119. -Input Bias Current BIAS4 3 5V (A) @ VS=+5V, VCM=0V
120. -Input Bias Current BIAS4 4 5V (A) @ VS=+5V, VCM=0V
121. Input Offset Voltage5 1 5V (V) @ VS=+5V, VCM=5V
122. Input Offset Voltage5 2 5V (V) @ VS=+5V, VCM=5V
123. Input Offset Voltage5 3 5V (V) @ VS=+5V, VCM=5V
124. Input Offset Voltage5 4 5V (V) @ VS=+5V, VCM=5V
125. Input Offset Current5 1 5V (A) @ VS=+5V, VCM=5V
126. Input Offset Current5 2 5V (A) @ VS=+5V, VCM=5V
127. Input Offset Current5 3 5V (A) @ VS=+5V, VCM=5V
128. Input Offset Current5 4 5V (A) @ VS=+5V, VCM=5V
129. +Input Bias Current BIAS5 1 5V (A) @ VS=+5V, VCM=5V
130. +Input Bias Current BIAS5 2 5V (A) @ VS=+5V, VCM=5V
131. +Input Bias Current BIAS5 3 5V (A) @ VS=+5V, VCM=5V
132. +Input Bias Current BIAS5 4 5V (A) @ VS=+5V, VCM=5V
133. -Input Bias Current BIAS5 1 5V (A) @ VS=+5V, VCM=5V

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- 134. -Input Bias Current BIAS5 2 5V (A) @ VS=+5V, VCM=5V
- 135. -Input Bias Current BIAS5 3 5V (A) @ VS=+5V, VCM=5V
- 136. -Input Bias Current BIAS5 4 5V (A) @ VS=+5V, VCM=5V
- 137. Output Voltage Swing High4 1 5V (V) @ VS=+5V IL=0mA
- 138. Output Voltage Swing High4 2 5V (V) @ VS=+5V IL=0mA
- 139. Output Voltage Swing High4 3 5V (V) @ VS=+5V IL=0mA
- 140. Output Voltage Swing High4 4 5V (V) @ VS=+5V IL=0mA
- 141. Output Voltage Swing High5 1 5V (V) @ VS=+5V IL=1mA
- 142. Output Voltage Swing High5 2 5V (V) @ VS=+5V IL=1mA
- 143. Output Voltage Swing High5 3 5V (V) @ VS=+5V IL=1mA
- 144. Output Voltage Swing High5 4 5V (V) @ VS=+5V IL=1mA
- 145. Output Voltage Swing High6 1 5V (V) @ VS=+5V IL=2.5mA
- 146. Output Voltage Swing High6 2 5V (V) @ VS=+5V IL=2.5mA
- 147. Output Voltage Swing High6 3 5V (V) @ VS=+5V IL=2.5mA
- 148. Output Voltage Swing High6 4 5V (V) @ VS=+5V IL=2.5mA
- 149. Output Voltage Swing Low4 1 5V (V) @ VS=+5V IL=0mA
- 150. Output Voltage Swing Low4 2 5V (V) @ VS=+5V IL=0mA
- 151. Output Voltage Swing Low4 3 5V (V) @ VS=+5V IL=0mA
- 152. Output Voltage Swing Low4 4 5V (V) @ VS=+5V IL=0mA
- 153. Output Voltage Swing Low5 1 5V (V) @ VS=+5V IL=1mA
- 154. Output Voltage Swing Low5 2 5V (V) @ VS=+5V IL=1mA
- 155. Output Voltage Swing Low5 3 5V (V) @ VS=+5V IL=1mA
- 156. Output Voltage Swing Low5 4 5V (V) @ VS=+5V IL=1mA
- 157. Output Voltage Swing Low6 1 5V (V) @ VS=+5V IL=2.5mA
- 158. Output Voltage Swing Low6 2 5V (V) @ VS=+5V IL=2.5mA
- 159. Output Voltage Swing Low6 3 5V (V) @ VS=+5V IL=2.5mA
- 160. Output Voltage Swing Low6 4 5V (V) @ VS=+5V IL=2.5mA
- 161. Large Signal Voltage Gain3 1 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ
- 162. Large Signal Voltage Gain3 2 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ
- 163. Large Signal Voltage Gain3 3 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ
- 164. Large Signal Voltage Gain3 4 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ
- 165. Common Mode Rejection Ratio2 1 5V (dB) @ VS=+5V, VCM=0 to +5V
- 166. Common Mode Rejection Ratio2 2 5V (dB) @ VS=+5V, VCM=0 to +5V
- 167. Common Mode Rejection Ratio2 3 5V (dB) @ VS=+5V, VCM=0 to +5V
- 168. Common Mode Rejection Ratio2 4 5V (dB) @ VS=+5V, VCM=0 to +5V
- 169. CMRR Match2 1 to 4 5V (dB) @ VS=+5V, VCM=0 to +5V
- 170. CMRR Match2 2 to 3 5V (dB) @ VS=+5V, VCM=0 to +5V
- 171. Power Supply Rejection Ratio2 1 (dB) @ VS=+4.5V to +12V
- 172. Power Supply Rejection Ratio2 2 (dB) @ VS=+4.5V to +12V
- 173. Power Supply Rejection Ratio2 3 (dB) @ VS=+4.5V to +12V
- 174. Power Supply Rejection Ratio2 4 (dB) @ VS=+4.5V to +12V
- 175. PSRR Match2 1 to 4 (dB) @ VS=+4.5V to +12V
- 176. PSRR Match2 2 to 3 (dB) @ VS=+4.5V to +12V
- 177. +Short-Circuit Current2 1 5V (A) @ VS=+5V
- 178. +Short-Circuit Current2 2 5V (A) @ VS=+5V
- 179. +Short-Circuit Current2 3 5V (A) @ VS=+5V

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- 180. +Short-Circuit Current<sub>2 4 5V (A) @ VS=+5V</sub>
- 181. -Short-Circuit Current<sub>2 1 5V (A) @ VS=+5V</sub>
- 182. -Short-Circuit Current<sub>2 2 5V (A) @ VS=+5V</sub>
- 183. -Short-Circuit Current<sub>2 3 5V (A) @ VS=+5V</sub>
- 184. -Short-Circuit Current<sub>2 4 5V (A) @ VS=+5V</sub>
- 185. Gain-Bandwidth Product<sub>1 15V (MHz) @ VS=+/-15V, f=100kHz</sub>
- 186. Gain-Bandwidth Product<sub>2 15V (MHz) @ VS=+/-15V, f=100kHz</sub>
- 187. Gain-Bandwidth Product<sub>3 15V (MHz) @ VS=+/-15V, f=100kHz</sub>
- 188. Gain-Bandwidth Product<sub>4 15V (MHz) @ VS=+/-15V, f=100kHz</sub>
- 189. +Slew Rate<sub>1 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ</sub>
- 190. +Slew Rate<sub>2 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ</sub>
- 191. +Slew Rate<sub>3 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ</sub>
- 192. +Slew Rate<sub>4 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ</sub>
- 193. -Slew Rate<sub>1 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ</sub>
- 194. -Slew Rate<sub>2 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ</sub>
- 195. -Slew Rate<sub>3 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ</sub>
- 196. -Slew Rate<sub>4 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ</sub>

Appendix C details the measured parameters, test conditions, pre-irradiation specification and measurement resolution for each of the measurements.

The parametric data was obtained as "read and record" and all the raw data plus an attributes summary are contained in this report as well as in a separate Excel file. The attributes data contains the average, standard deviation and the average with the KTL values applied. The KTL value used in this work is 2.742 per MIL-HDBK-814 using one sided tolerance limits of 90/90 and a 5-piece sample size. The 90/90 KTL values were selected to match the statistical levels specified in the MIL-PRF-38535 sampling plan for the qualification of a radiation hardness assured (RHA) component. Note that the following criteria must be met for a device to pass the low dose rate test: following the radiation exposure each of the 5 pieces irradiated under electrical bias shall pass the specification value. The units irradiated without electrical bias and the KTL statistics are included in this report for reference only. If any of the 5 pieces irradiated under electrical bias exceed the device post radiation data sheet specification limits, then the lot could be logged as a failure.

Further, MIL-STD-883H, TM 1019.8 Section 3.13.1.1 Characterization test to determine if a part exhibits ELDRS' states the following: Select a minimum random sample of 21 devices from a population representative of recent production runs. Smaller sample sizes may be used if agreed upon between the parties to the test. All of the selected devices shall have undergone appropriate elevated temperature reliability screens, e.g. burn-in and high temperature storage life. Divide the samples into four groups of 5 each and use the remaining part for a control. Perform pre-irradiation electrical characterization on all parts assuring that they meet the Group A electrical tests. Irradiate 5 samples under a 0 volt bias and another 5 under the irradiation bias given in the acquisition specification at 50-300 rad(Si)/s and room temperature. Irradiate 5 samples under a 0 volt bias and another 5 under irradiation bias given in the acquisition specification at < 10mrad(Si)/s and room temperature. Irradiate all samples to the same dose levels, including 0.5 and 1.0 times the anticipated specification dose, and

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repeat the electrical characterization on each part at each dose level. Post irradiation electrical measurements shall be performed per paragraph 3.10 where the low dose rate test is considered Condition D. Calculate the radiation induced change in each electrical parameter ( $\Delta$ para) for each sample at each radiation level. Calculate the ratio of the median  $\Delta$ para at low dose rate to the median  $\Delta$ para at high dose rate for each irradiation bias group at each total dose level. If this ratio exceeds 1.5 for any of the most sensitive parameters then the part is considered to be ELDRS susceptible. This test does not apply to parameters which exhibit changes that are within experimental error or whose values are below the pre-irradiation electrical specification limits at low dose rate at the specification dose.

Therefore, the data in this report can be analyzed along with the high dose rate report titled "Total Ionizing Dose (TID) Radiation Testing of the RH1499MW Quad Rail-to-Rail Input and Output Precision C-Load Op Amp for Linear Technology" to demonstrate that these parts do not exhibit ELDRS as defined in the current test method.



## **5.0. ELDRS Test Results**

Based on this criterion the RH1499MW Quad Rail-to-Rail Input and Output Precision C-Load Op Amp (from the lot traceability information provided on the first page of this test report) PASSED the enhanced low dose rate sensitivity test to the maximum tested dose level of 50krad(Si) with all parameters remaining within their datasheet specifications.

Figures 5.1 through 5.196 show plots of all the measured parameters versus total ionizing dose while Tables 5.1 - 5.196 show the corresponding raw data for each of these parameters. In the data plots the solid diamonds are the average of the measured data points for the sample irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the units irradiated with all pins tied to ground. The black lines (solid or dashed) are the average of the data points after application of the KTL statistics on the sample irradiated in the biased condition while the shaded lines (solid or dashed) are the average of the data points after application of the KTL statistics on the sample irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.

In addition to the radiation test results, the data plots and tables described above contain anneal data. The anneals are performed to better understand the underlying physical mechanisms responsible for radiation-induced parametric shifts and are not part of the criteria used to establish whether or not the lot passes or fails the low dose rate test. In all cases the parts either improved or exhibited no change during the anneal.

The control units, as expected, show no significant changes to any of the parameters. Therefore we can conclude that the electrical testing remained in control throughout the duration of the tests and the observed degradation was due to the radiation exposure. Appendix D lists the figures used in this section to facilitate the location of a particular parameter.

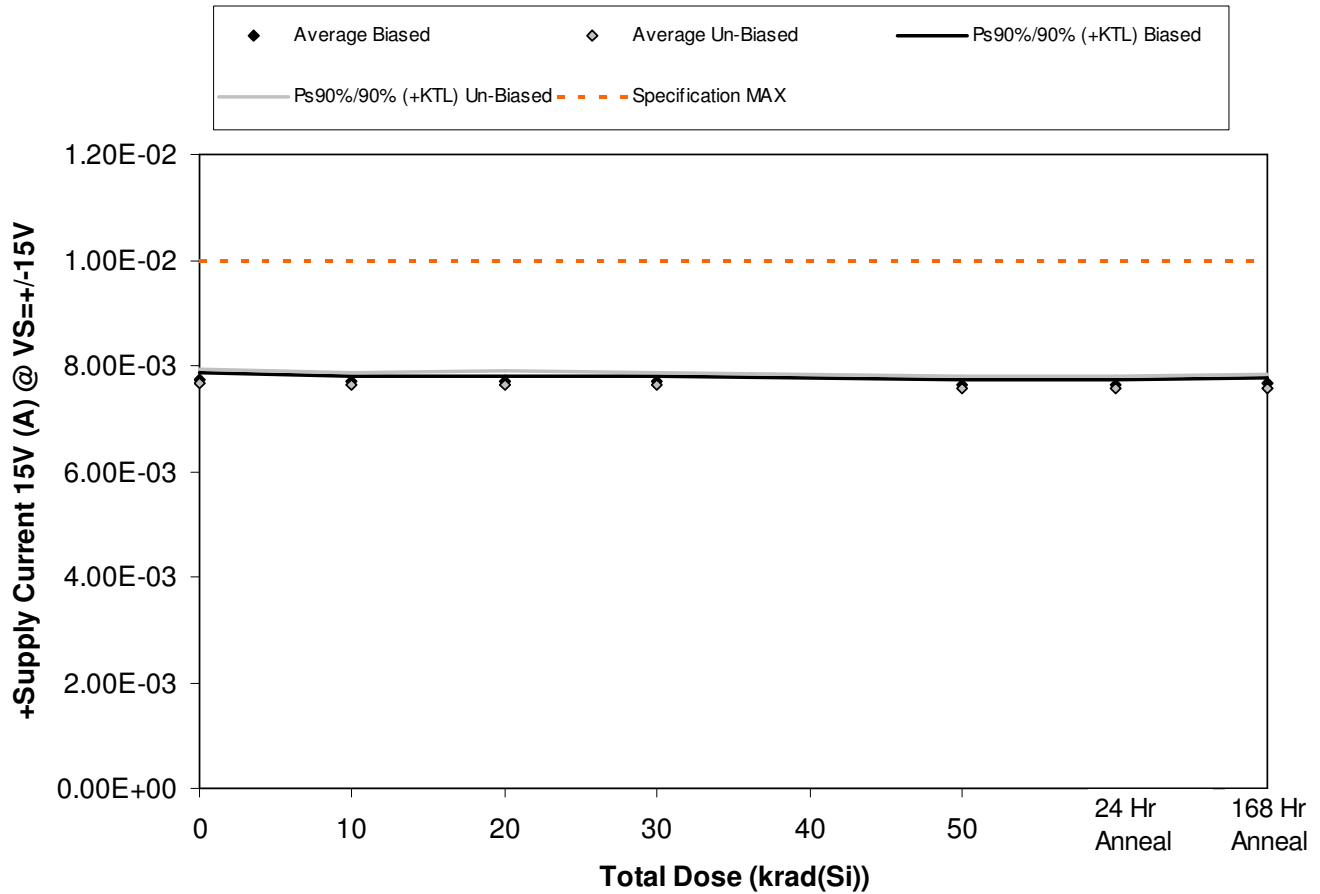


Figure 5.1. Plot of +Supply Current 15V (A) @ VS=+-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.1. Raw data for +Supply Current 15V (A) @ VS=+/-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Supply Current 15V (A) @ VS=+/-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	7.80E-03	7.75E-03	7.75E-03	7.74E-03	7.69E-03	7.68E-03	7.70E-03
563	7.75E-03	7.72E-03	7.69E-03	7.70E-03	7.64E-03	7.63E-03	7.67E-03
564	7.75E-03	7.73E-03	7.71E-03	7.74E-03	7.65E-03	7.64E-03	7.68E-03
567	7.69E-03	7.68E-03	7.65E-03	7.65E-03	7.59E-03	7.57E-03	7.61E-03
569	7.72E-03	7.69E-03	7.66E-03	7.66E-03	7.60E-03	7.60E-03	7.62E-03
570	7.71E-03	7.68E-03	7.67E-03	7.65E-03	7.58E-03	7.58E-03	7.61E-03
571	7.64E-03	7.58E-03	7.57E-03	7.57E-03	7.54E-03	7.49E-03	7.52E-03
572	7.79E-03	7.75E-03	7.74E-03	7.72E-03	7.67E-03	7.66E-03	7.68E-03
573	7.56E-03	7.55E-03	7.52E-03	7.50E-03	7.44E-03	7.43E-03	7.46E-03
574	7.73E-03	7.69E-03	7.69E-03	7.68E-03	7.61E-03	7.61E-03	7.63E-03
584	7.71E-03	7.72E-03	7.72E-03	7.72E-03	7.68E-03	7.65E-03	7.67E-03
585	7.77E-03	7.74E-03	7.82E-03	7.76E-03	7.76E-03	7.70E-03	7.73E-03
<b>Biased Statistics</b>							
Average Biased	7.74E-03	7.71E-03	7.69E-03	7.70E-03	7.63E-03	7.62E-03	7.66E-03
Std Dev Biased	3.98E-05	3.01E-05	3.86E-05	4.31E-05	4.23E-05	4.18E-05	3.82E-05
Ps90%/90% (+KTL) Biased	7.85E-03	7.79E-03	7.80E-03	7.81E-03	7.75E-03	7.74E-03	7.76E-03
Ps90%/90% (-KTL) Biased	7.63E-03	7.63E-03	7.58E-03	7.58E-03	7.52E-03	7.51E-03	7.55E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.69E-03	7.65E-03	7.64E-03	7.63E-03	7.57E-03	7.56E-03	7.58E-03
Std Dev Un-Biased	9.16E-05	8.18E-05	9.19E-05	8.73E-05	8.75E-05	8.99E-05	9.02E-05
Ps90%/90% (+KTL) Un-Biased	7.94E-03	7.87E-03	7.89E-03	7.86E-03	7.81E-03	7.80E-03	7.83E-03
Ps90%/90% (-KTL) Un-Biased	7.43E-03	7.43E-03	7.39E-03	7.39E-03	7.33E-03	7.31E-03	7.33E-03
<b>Specification MAX</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

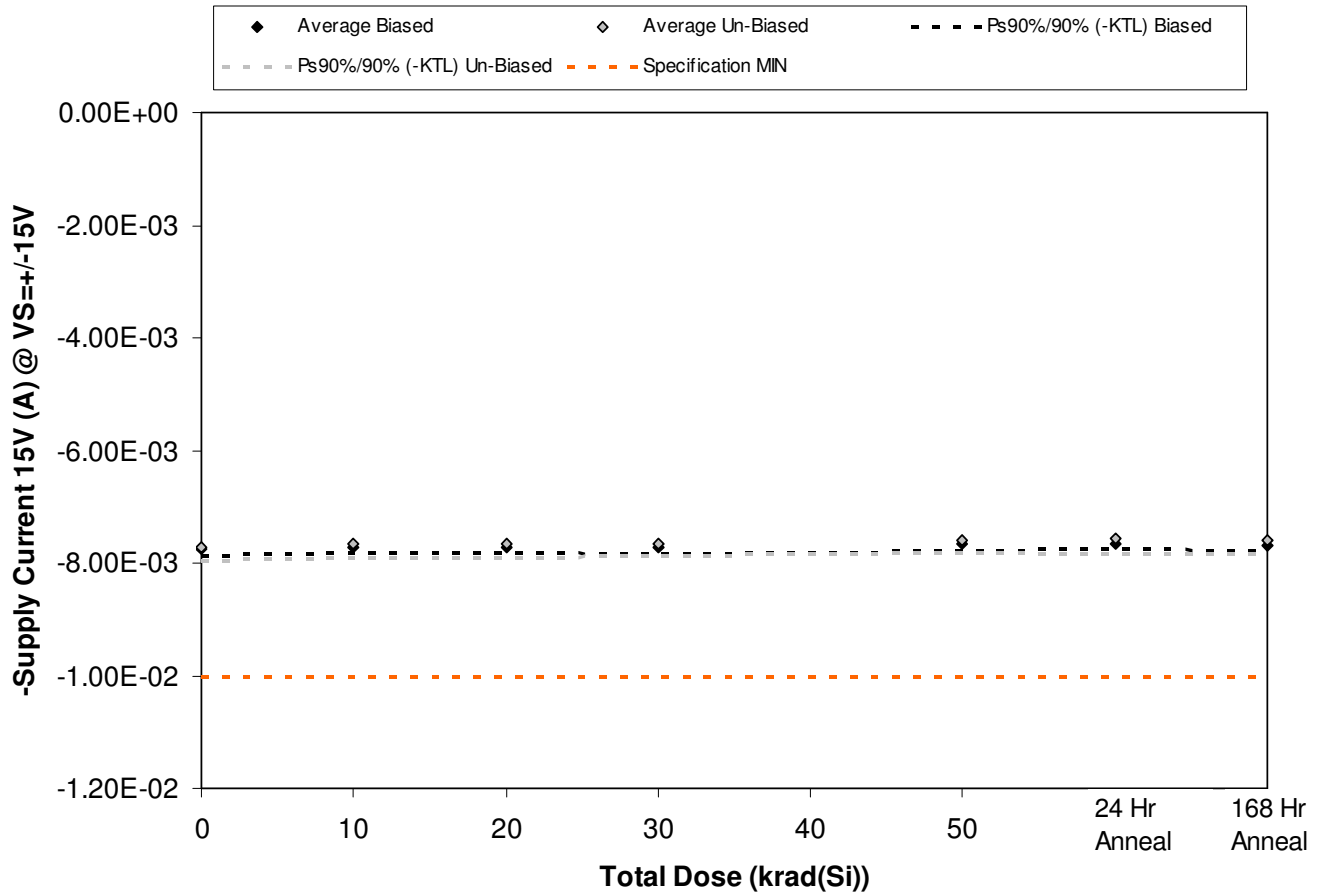


Figure 5.2. Plot of -Supply Current 15V (A) @ VS=+-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.2. Raw data for -Supply Current 15V (A) @ VS=+/-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Supply Current 15V (A) @ VS=+/-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-7.82E-03	-7.78E-03	-7.77E-03	-7.77E-03	-7.71E-03	-7.71E-03	-7.72E-03
563	-7.77E-03	-7.74E-03	-7.71E-03	-7.72E-03	-7.66E-03	-7.65E-03	-7.70E-03
564	-7.77E-03	-7.75E-03	-7.73E-03	-7.76E-03	-7.67E-03	-7.66E-03	-7.70E-03
567	-7.71E-03	-7.70E-03	-7.67E-03	-7.67E-03	-7.61E-03	-7.59E-03	-7.63E-03
569	-7.74E-03	-7.71E-03	-7.68E-03	-7.68E-03	-7.62E-03	-7.62E-03	-7.65E-03
570	-7.73E-03	-7.70E-03	-7.69E-03	-7.67E-03	-7.60E-03	-7.60E-03	-7.63E-03
571	-7.66E-03	-7.61E-03	-7.59E-03	-7.60E-03	-7.56E-03	-7.51E-03	-7.54E-03
572	-7.82E-03	-7.77E-03	-7.76E-03	-7.75E-03	-7.69E-03	-7.68E-03	-7.70E-03
573	-7.58E-03	-7.57E-03	-7.54E-03	-7.53E-03	-7.46E-03	-7.45E-03	-7.48E-03
574	-7.75E-03	-7.71E-03	-7.72E-03	-7.70E-03	-7.64E-03	-7.63E-03	-7.65E-03
584	-7.73E-03	-7.75E-03	-7.74E-03	-7.74E-03	-7.70E-03	-7.67E-03	-7.69E-03
585	-7.79E-03	-7.76E-03	-7.84E-03	-7.78E-03	-7.79E-03	-7.72E-03	-7.75E-03
<b>Biased Statistics</b>							
Average Biased	-7.76E-03	-7.73E-03	-7.71E-03	-7.72E-03	-7.66E-03	-7.65E-03	-7.68E-03
Std Dev Biased	3.98E-05	2.95E-05	3.85E-05	4.40E-05	4.16E-05	4.35E-05	3.73E-05
Ps90%/90% (+KTL) Biased	-7.65E-03	-7.65E-03	-7.61E-03	-7.60E-03	-7.54E-03	-7.53E-03	-7.58E-03
Ps90%/90% (-KTL) Biased	-7.87E-03	-7.81E-03	-7.82E-03	-7.84E-03	-7.77E-03	-7.76E-03	-7.78E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	-7.71E-03	-7.67E-03	-7.66E-03	-7.65E-03	-7.59E-03	-7.58E-03	-7.60E-03
Std Dev Un-Biased	9.12E-05	8.18E-05	9.32E-05	8.66E-05	8.80E-05	9.20E-05	9.10E-05
Ps90%/90% (+KTL) Un-Biased	-7.46E-03	-7.45E-03	-7.40E-03	-7.41E-03	-7.35E-03	-7.32E-03	-7.35E-03
Ps90%/90% (-KTL) Un-Biased	-7.96E-03	-7.90E-03	-7.92E-03	-7.89E-03	-7.83E-03	-7.83E-03	-7.85E-03
<b>Specification MIN</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



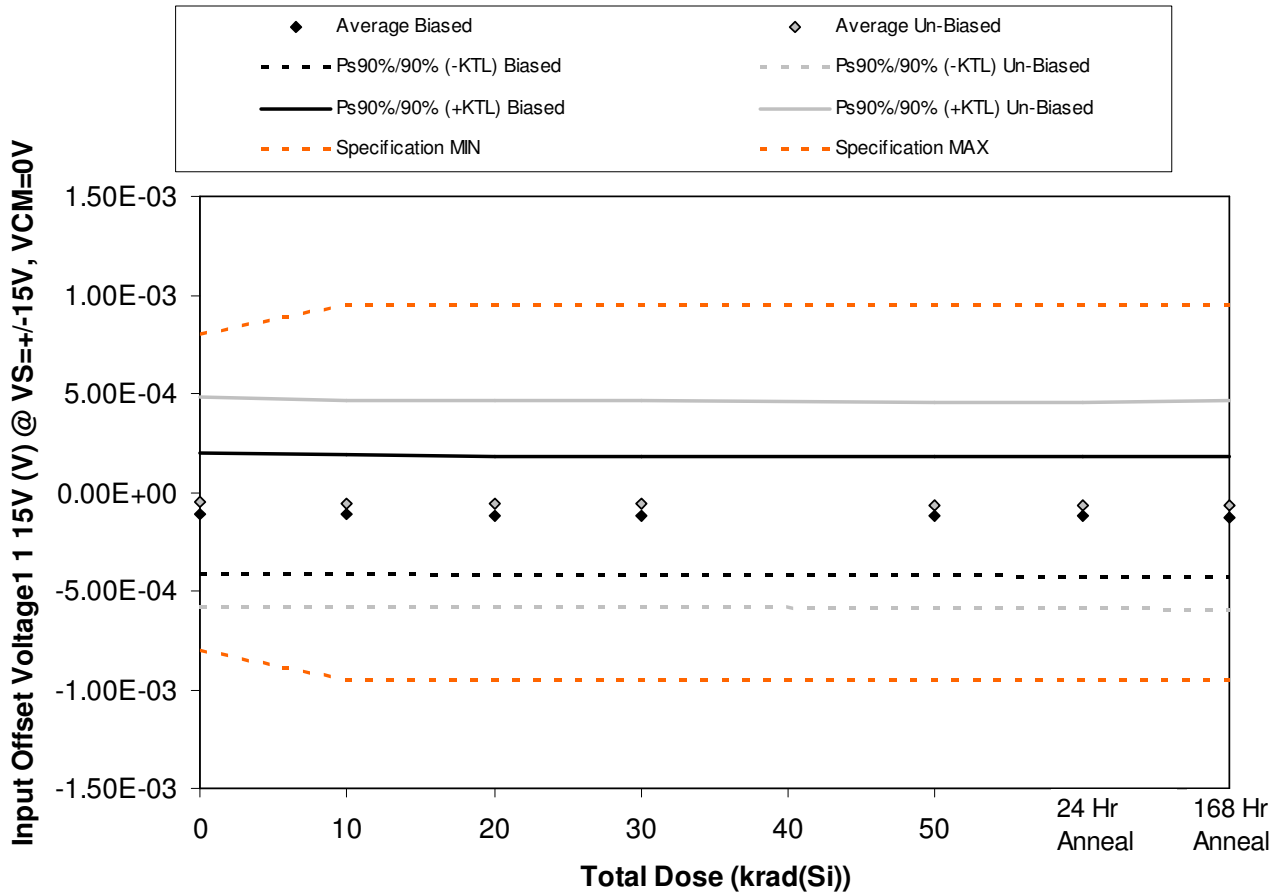


Figure 5.3. Plot of Input Offset Voltage1 1 15V (V) @ VS=+/-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.3. Raw data for Input Offset Voltage1 1 15V (V) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage1 1 15V (V) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-1.48E-04	-1.57E-04	-1.60E-04	-1.61E-04	-1.69E-04	-1.68E-04	-1.65E-04
563	-2.10E-04	-2.18E-04	-2.21E-04	-2.22E-04	-2.24E-04	-2.26E-04	-2.43E-04
564	-4.82E-05	-5.46E-05	-5.59E-05	-5.40E-05	-6.20E-05	-6.43E-05	-6.27E-05
567	5.74E-05	4.73E-05	4.52E-05	4.38E-05	4.32E-05	4.44E-05	3.74E-05
569	-1.84E-04	-1.91E-04	-1.90E-04	-1.89E-04	-1.93E-04	-1.95E-04	-1.94E-04
570	5.61E-05	4.28E-05	4.24E-05	3.99E-05	2.84E-05	2.82E-05	3.19E-05
571	-3.67E-04	-3.75E-04	-3.76E-04	-3.78E-04	-3.80E-04	-3.82E-04	-3.91E-04
572	1.40E-04	1.26E-04	1.25E-04	1.22E-04	1.22E-04	1.17E-04	1.16E-04
573	-4.45E-05	-4.97E-05	-5.16E-05	-5.65E-05	-6.55E-05	-6.15E-05	-7.41E-05
574	-8.40E-06	-1.89E-05	-1.75E-05	-2.13E-05	-2.74E-05	-2.96E-05	-2.98E-05
584	-4.66E-04	-4.67E-04	-4.67E-04	-4.67E-04	-4.70E-04	-4.70E-04	-4.69E-04
585	1.51E-04	1.46E-04	1.53E-04	1.47E-04	1.50E-04	1.43E-04	1.46E-04
<b>Biased Statistics</b>							
Average Biased	-1.07E-04	-1.15E-04	-1.16E-04	-1.17E-04	-1.21E-04	-1.22E-04	-1.25E-04
Std Dev Biased	1.10E-04	1.10E-04	1.09E-04	1.10E-04	1.10E-04	1.11E-04	1.12E-04
Ps90%/90% (+KTL) Biased	1.96E-04	1.86E-04	1.84E-04	1.84E-04	1.81E-04	1.82E-04	1.83E-04
Ps90%/90% (-KTL) Biased	-4.10E-04	-4.16E-04	-4.16E-04	-4.17E-04	-4.23E-04	-4.26E-04	-4.33E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	-4.49E-05	-5.50E-05	-5.54E-05	-5.90E-05	-6.43E-05	-6.56E-05	-6.95E-05
Std Dev Un-Biased	1.93E-04	1.91E-04	1.91E-04	1.91E-04	1.90E-04	1.90E-04	1.94E-04
Ps90%/90% (+KTL) Un-Biased	4.86E-04	4.69E-04	4.69E-04	4.65E-04	4.56E-04	4.54E-04	4.61E-04
Ps90%/90% (-KTL) Un-Biased	-5.75E-04	-5.79E-04	-5.80E-04	-5.82E-04	-5.85E-04	-5.85E-04	-6.00E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

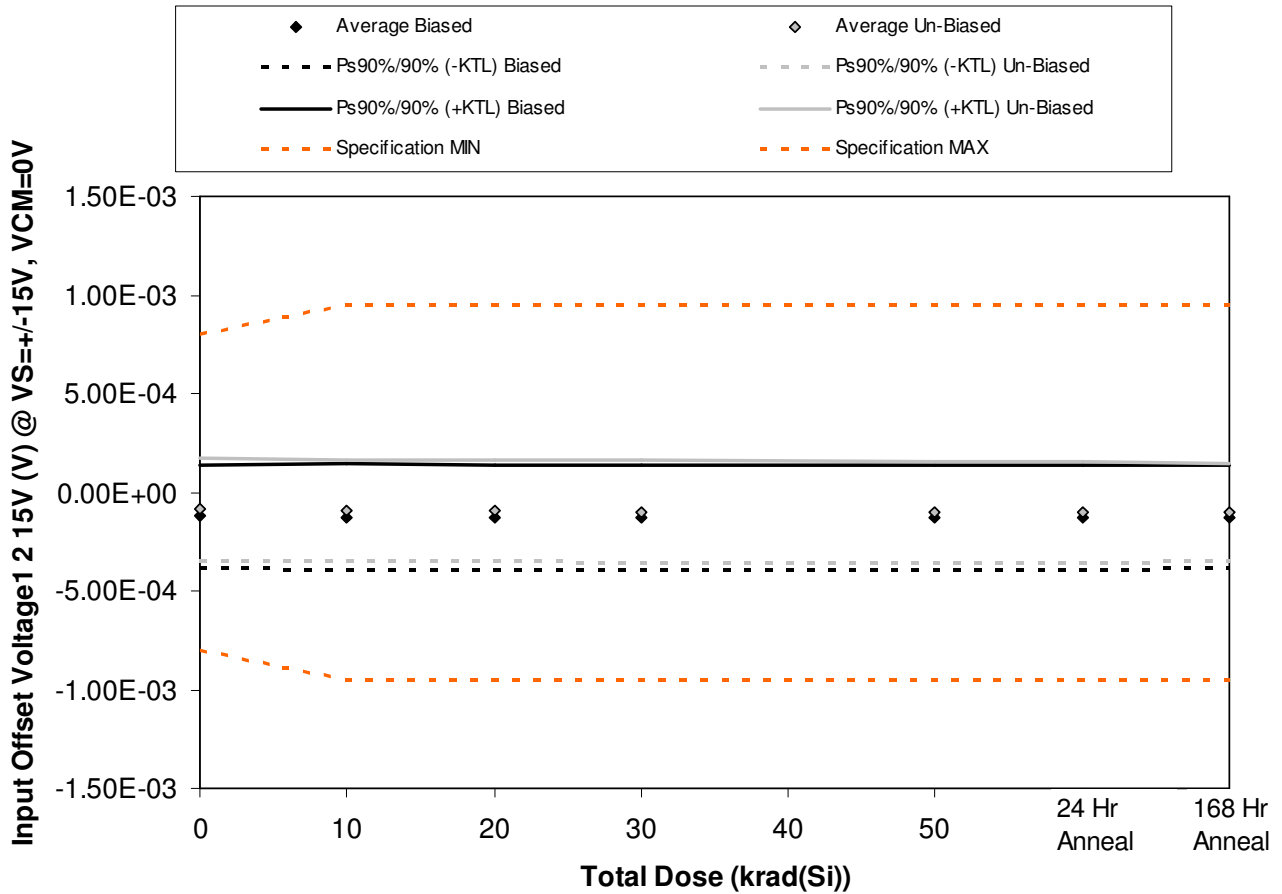


Figure 5.4. Plot of Input Offset Voltage1 2 15V (V) @ VS=+/-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.4. Raw data for Input Offset Voltage1 2 15V (V) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage1 2 15V (V) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-1.52E-04	-1.61E-04	-1.62E-04	-1.60E-04	-1.65E-04	-1.63E-04	-1.69E-04
563	-2.29E-04	-2.37E-04	-2.35E-04	-2.37E-04	-2.37E-04	-2.37E-04	-2.32E-04
564	-5.87E-05	-6.36E-05	-6.16E-05	-6.21E-05	-6.82E-05	-7.04E-05	-6.07E-05
567	-1.74E-04	-1.76E-04	-1.79E-04	-1.79E-04	-1.84E-04	-1.85E-04	-1.68E-04
569	8.87E-06	8.62E-06	6.21E-06	6.81E-06	6.22E-06	7.30E-06	3.55E-06
570	-1.31E-04	-1.39E-04	-1.39E-04	-1.41E-04	-1.44E-04	-1.42E-04	-1.42E-04
571	3.05E-05	2.60E-05	2.64E-05	2.66E-05	2.43E-05	2.37E-05	1.10E-05
572	-2.01E-05	-3.63E-05	-3.87E-05	-3.99E-05	-4.51E-05	-4.67E-05	-4.68E-05
573	-2.13E-04	-2.18E-04	-2.17E-04	-2.20E-04	-2.17E-04	-2.19E-04	-2.26E-04
574	-1.07E-04	-1.11E-04	-1.13E-04	-1.14E-04	-1.17E-04	-1.19E-04	-1.19E-04
584	-2.87E-04	-2.88E-04	-2.89E-04	-2.88E-04	-2.89E-04	-2.88E-04	-2.89E-04
585	4.11E-05	4.01E-05	4.24E-05	3.93E-05	4.26E-05	3.63E-05	3.88E-05
<b>Biased Statistics</b>							
Average Biased	-1.21E-04	-1.26E-04	-1.26E-04	-1.26E-04	-1.30E-04	-1.30E-04	-1.25E-04
Std Dev Biased	9.49E-05	9.76E-05	9.70E-05	9.74E-05	9.76E-05	9.75E-05	9.48E-05
Ps90%/90% (+KTL) Biased	1.39E-04	1.42E-04	1.40E-04	1.41E-04	1.38E-04	1.38E-04	1.35E-04
Ps90%/90% (-KTL) Biased	-3.81E-04	-3.94E-04	-3.92E-04	-3.93E-04	-3.97E-04	-3.97E-04	-3.85E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	-8.82E-05	-9.56E-05	-9.62E-05	-9.75E-05	-9.99E-05	-1.01E-04	-1.04E-04
Std Dev Un-Biased	9.56E-05	9.41E-05	9.36E-05	9.45E-05	9.28E-05	9.28E-05	9.08E-05
Ps90%/90% (+KTL) Un-Biased	1.74E-04	1.62E-04	1.61E-04	1.62E-04	1.55E-04	1.54E-04	1.44E-04
Ps90%/90% (-KTL) Un-Biased	-3.50E-04	-3.54E-04	-3.53E-04	-3.57E-04	-3.54E-04	-3.55E-04	-3.53E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

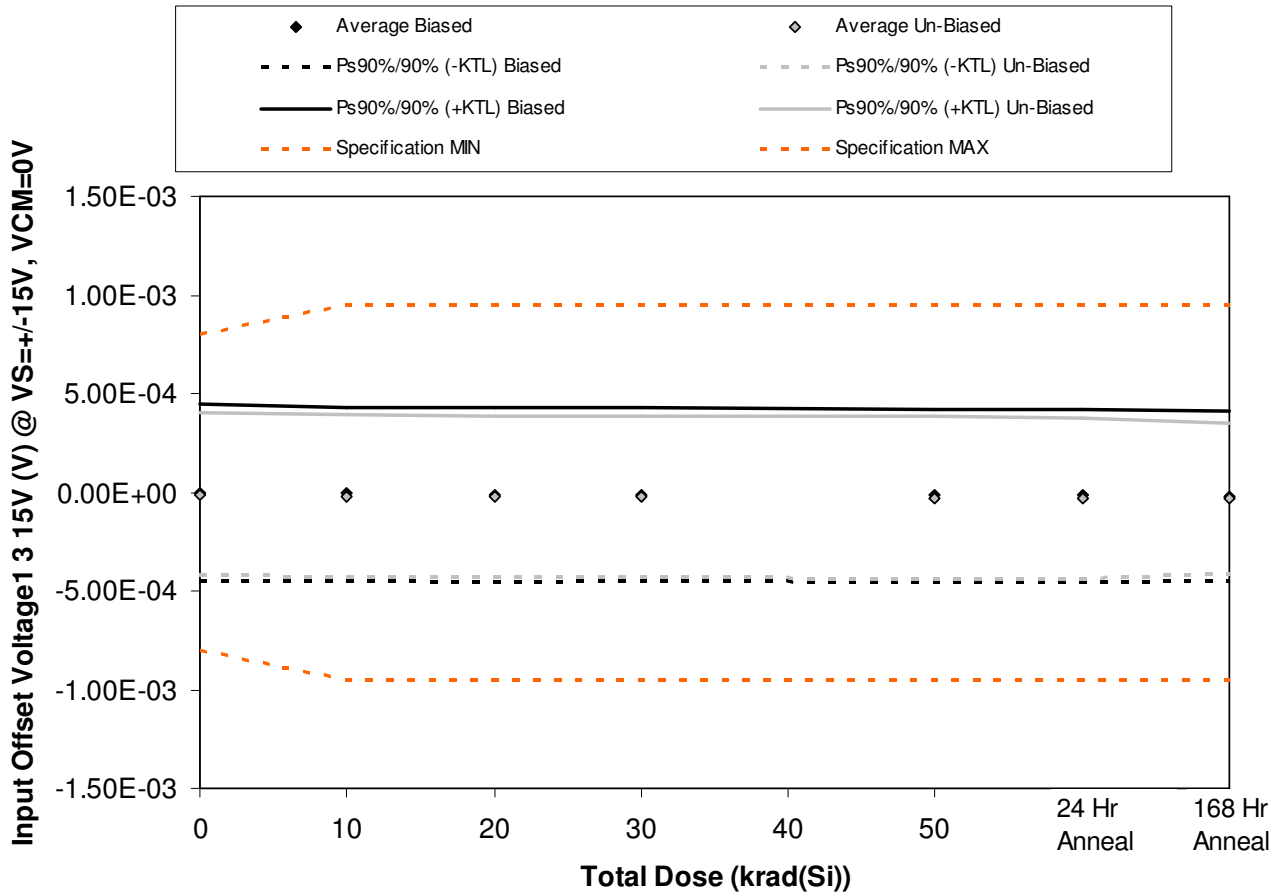


Figure 5.5. Plot of Input Offset Voltage1 3 15V (V) @ VS=+/-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.5. Raw data for Input Offset Voltage1 3 15V (V) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage1 3 15V (V) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.57E-04	2.44E-04	2.41E-04	2.37E-04	2.31E-04	2.31E-04	2.25E-04
563	-4.40E-05	-5.22E-05	-5.26E-05	-5.34E-05	-5.36E-05	-5.42E-05	-4.91E-05
564	-5.19E-05	-5.80E-05	-6.08E-05	-5.84E-05	-6.83E-05	-7.15E-05	-7.32E-05
567	2.44E-05	1.88E-05	1.56E-05	1.76E-05	1.50E-05	1.36E-05	7.42E-06
569	-1.89E-04	-1.94E-04	-1.98E-04	-2.01E-04	-2.06E-04	-2.06E-04	-1.99E-04
570	-1.03E-04	-1.10E-04	-1.12E-04	-1.14E-04	-1.18E-04	-1.19E-04	-1.14E-04
571	-2.18E-04	-2.27E-04	-2.30E-04	-2.31E-04	-2.38E-04	-2.39E-04	-2.25E-04
572	1.66E-04	1.54E-04	1.50E-04	1.46E-04	1.43E-04	1.40E-04	1.27E-04
573	6.59E-05	5.99E-05	5.81E-05	5.80E-05	5.27E-05	5.13E-05	4.73E-05
574	3.01E-05	2.34E-05	2.25E-05	1.74E-05	1.36E-05	1.26E-05	7.54E-06
584	3.35E-04	3.38E-04	3.37E-04	3.37E-04	3.34E-04	3.31E-04	3.32E-04
585	-1.15E-06	-4.05E-06	-1.88E-06	-4.06E-06	-1.39E-06	-7.67E-06	-5.86E-06
<b>Biased Statistics</b>							
Average Biased	-5.78E-07	-8.21E-06	-1.10E-05	-1.15E-05	-1.65E-05	-1.74E-05	-1.78E-05
Std Dev Biased	1.64E-04	1.61E-04	1.61E-04	1.60E-04	1.60E-04	1.60E-04	1.55E-04
Ps90%/90% (+KTL) Biased	4.48E-04	4.33E-04	4.30E-04	4.27E-04	4.22E-04	4.21E-04	4.07E-04
Ps90%/90% (-KTL) Biased	-4.49E-04	-4.49E-04	-4.52E-04	-4.50E-04	-4.55E-04	-4.56E-04	-4.43E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	-1.18E-05	-2.00E-05	-2.23E-05	-2.47E-05	-2.93E-05	-3.08E-05	-3.15E-05
Std Dev Un-Biased	1.50E-04	1.49E-04	1.49E-04	1.49E-04	1.50E-04	1.49E-04	1.39E-04
Ps90%/90% (+KTL) Un-Biased	4.00E-04	3.90E-04	3.87E-04	3.83E-04	3.81E-04	3.78E-04	3.50E-04
Ps90%/90% (-KTL) Un-Biased	-4.23E-04	-4.30E-04	-4.32E-04	-4.32E-04	-4.40E-04	-4.39E-04	-4.13E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

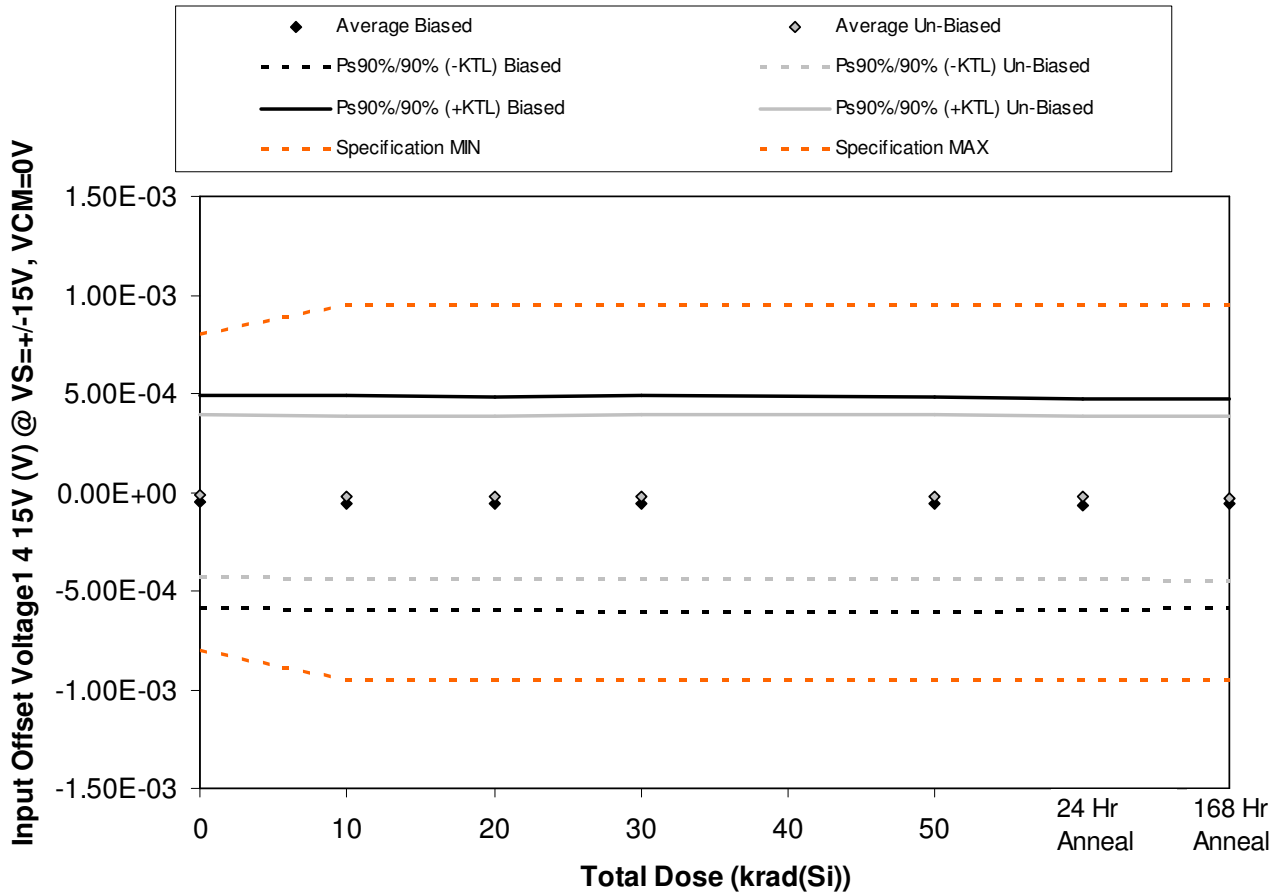


Figure 5.6. Plot of Input Offset Voltage1 4 15V (V) @ VS=+/-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.6. Raw data for Input Offset Voltage1 4 15V (V) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage1 4 15V (V) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-1.03E-04	-1.13E-04	-1.14E-04	-1.17E-04	-1.23E-04	-1.22E-04	-1.19E-04
563	-7.33E-05	-8.28E-05	-8.45E-05	-8.34E-05	-8.94E-05	-9.18E-05	-8.14E-05
564	1.41E-04	1.36E-04	1.35E-04	1.39E-04	1.32E-04	1.27E-04	1.29E-04
567	1.30E-04	1.26E-04	1.23E-04	1.27E-04	1.22E-04	1.20E-04	1.17E-04
569	-3.39E-04	-3.44E-04	-3.43E-04	-3.46E-04	-3.45E-04	-3.44E-04	-3.41E-04
570	3.99E-05	3.23E-05	3.27E-05	3.72E-05	4.01E-05	4.00E-05	3.18E-05
571	1.21E-04	1.11E-04	1.11E-04	1.12E-04	1.09E-04	1.06E-04	1.05E-04
572	-6.99E-05	-8.05E-05	-8.08E-05	-8.27E-05	-8.56E-05	-8.63E-05	-8.33E-05
573	7.85E-05	7.15E-05	7.32E-05	7.61E-05	7.35E-05	7.27E-05	6.10E-05
574	-2.56E-04	-2.63E-04	-2.60E-04	-2.61E-04	-2.62E-04	-2.62E-04	-2.72E-04
584	3.18E-05	3.22E-05	3.07E-05	3.08E-05	2.75E-05	2.40E-05	2.44E-05
585	-2.69E-04	-2.72E-04	-2.69E-04	-2.70E-04	-2.68E-04	-2.72E-04	-2.72E-04
<b>Biased Statistics</b>							
Average Biased	-4.88E-05	-5.57E-05	-5.67E-05	-5.60E-05	-6.07E-05	-6.22E-05	-5.92E-05
Std Dev Biased	1.98E-04	1.98E-04	1.97E-04	2.00E-04	1.98E-04	1.95E-04	1.93E-04
Ps90%/90% (+KTL) Biased	4.93E-04	4.87E-04	4.83E-04	4.92E-04	4.81E-04	4.73E-04	4.71E-04
Ps90%/90% (-KTL) Biased	-5.90E-04	-5.99E-04	-5.97E-04	-6.04E-04	-6.02E-04	-5.98E-04	-5.90E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	-1.72E-05	-2.58E-05	-2.47E-05	-2.38E-05	-2.49E-05	-2.59E-05	-3.15E-05
Std Dev Un-Biased	1.51E-04	1.51E-04	1.50E-04	1.52E-04	1.51E-04	1.50E-04	1.52E-04
Ps90%/90% (+KTL) Un-Biased	3.97E-04	3.87E-04	3.86E-04	3.92E-04	3.90E-04	3.87E-04	3.84E-04
Ps90%/90% (-KTL) Un-Biased	-4.32E-04	-4.39E-04	-4.35E-04	-4.40E-04	-4.40E-04	-4.39E-04	-4.47E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



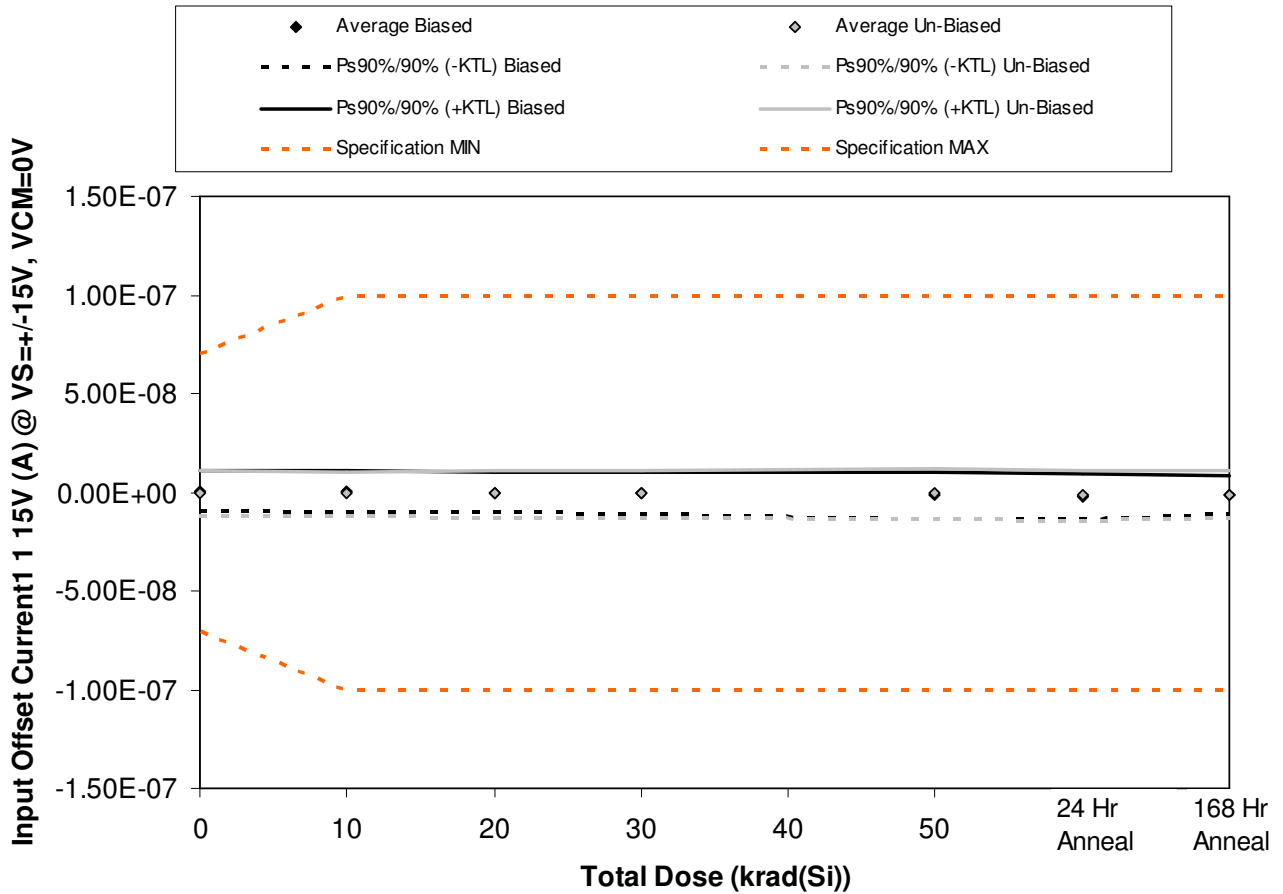


Figure 5.7. Plot of Input Offset Current1 1 15V (A) @ VS=+/-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.7. Raw data for Input Offset Current1 1 15V (A) @ VS=+-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current1 1 15V (A) @ VS=+-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.69E-09	2.54E-09	1.88E-09	1.36E-09	5.00E-10	-6.30E-10	1.02E-09
563	-4.40E-09	-4.95E-09	-5.17E-09	-5.57E-09	-7.02E-09	-7.50E-09	-6.07E-09
564	-7.80E-10	-1.07E-09	-1.63E-09	-2.18E-09	-3.88E-09	-4.75E-09	-3.29E-09
567	5.32E-09	5.02E-09	4.57E-09	4.84E-09	4.15E-09	3.53E-09	3.38E-09
569	1.41E-09	9.00E-11	-3.40E-10	-1.20E-09	-2.19E-09	-2.94E-09	-1.40E-09
570	-6.10E-10	-8.90E-10	-4.20E-10	-4.20E-10	-4.80E-10	-7.10E-10	-6.50E-10
571	-5.92E-09	-6.11E-09	-6.82E-09	-6.93E-09	-6.93E-09	-8.02E-09	-6.86E-09
572	1.79E-09	1.71E-09	1.79E-09	1.94E-09	1.45E-09	7.90E-10	1.06E-09
573	-2.68E-09	-2.81E-09	-3.10E-09	-2.94E-09	-3.34E-09	-4.25E-09	-3.29E-09
574	4.79E-09	4.55E-09	4.74E-09	4.51E-09	5.55E-09	3.99E-09	4.61E-09
584	-7.55E-09	-8.16E-09	-8.42E-09	-8.69E-09	-8.84E-09	-9.11E-09	-9.20E-09
585	1.59E-09	1.60E-10	-3.00E-11	8.00E-11	-5.00E-11	-9.00E-11	-2.70E-10
<b>Biased Statistics</b>							
Average Biased	8.48E-10	3.26E-10	-1.38E-10	-5.50E-10	-1.69E-09	-2.46E-09	-1.27E-09
Std Dev Biased	3.67E-09	3.77E-09	3.67E-09	3.90E-09	4.25E-09	4.19E-09	3.67E-09
Ps90%/90% (+KTL) Biased	1.09E-08	1.07E-08	9.92E-09	1.02E-08	9.97E-09	9.02E-09	8.80E-09
Ps90%/90% (-KTL) Biased	-9.22E-09	-1.00E-08	-1.02E-08	-1.13E-08	-1.34E-08	-1.39E-08	-1.13E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	-5.26E-10	-7.10E-10	-7.62E-10	-7.68E-10	-7.50E-10	-1.64E-09	-1.03E-09
Std Dev Un-Biased	4.10E-09	4.10E-09	4.45E-09	4.42E-09	4.73E-09	4.64E-09	4.34E-09
Ps90%/90% (+KTL) Un-Biased	1.07E-08	1.05E-08	1.14E-08	1.13E-08	1.22E-08	1.11E-08	1.09E-08
Ps90%/90% (-KTL) Un-Biased	-1.18E-08	-1.19E-08	-1.30E-08	-1.29E-08	-1.37E-08	-1.44E-08	-1.29E-08
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

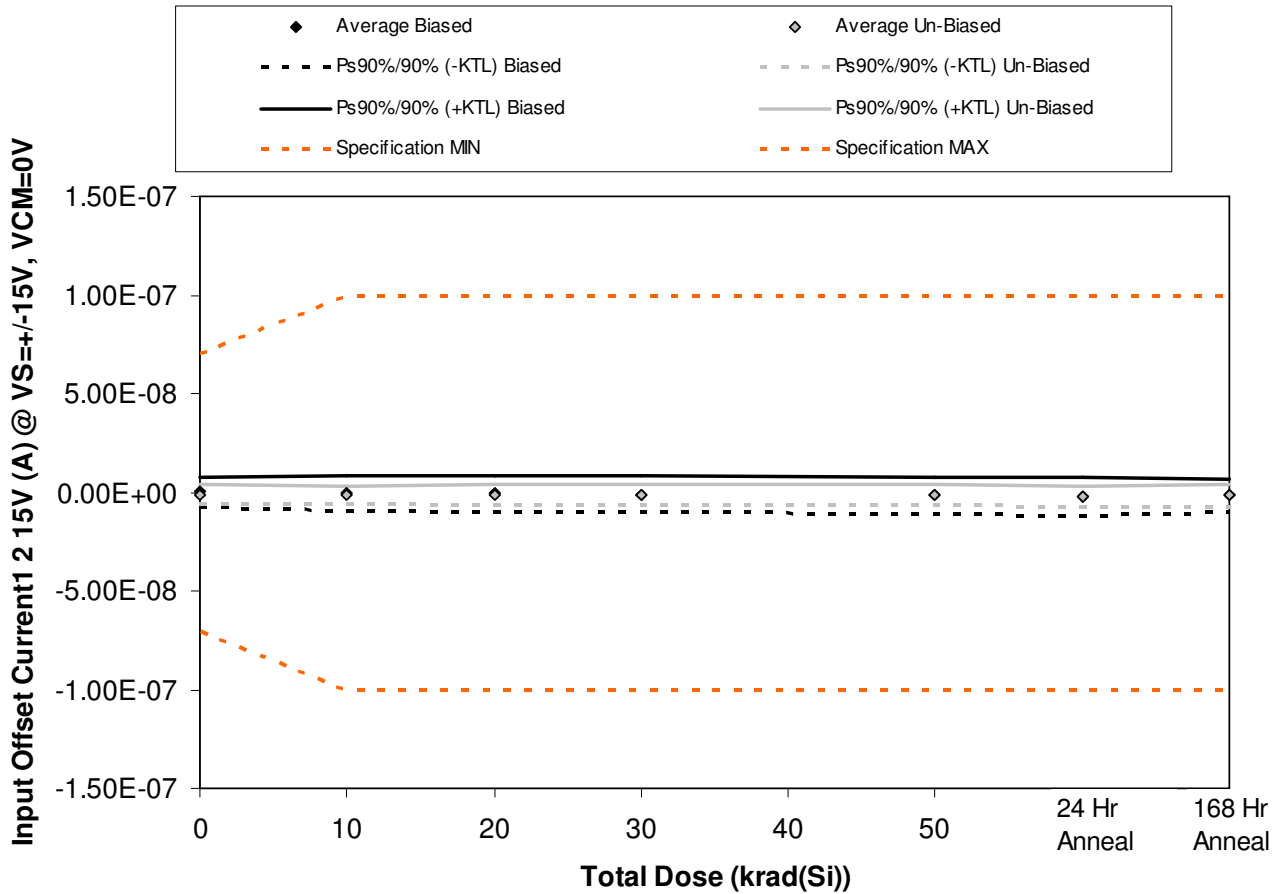


Figure 5.8. Plot of Input Offset Current1 2 15V (A) @ VS=+-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.8. Raw data for Input Offset Current1 2 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current1 2 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.87E-09	2.62E-09	2.22E-09	1.87E-09	5.10E-10	6.00E-11	9.30E-10
563	-2.46E-09	-3.31E-09	-3.44E-09	-3.78E-09	-4.33E-09	-5.24E-09	-4.13E-09
564	-2.76E-09	-3.70E-09	-4.53E-09	-4.77E-09	-5.57E-09	-6.37E-09	-4.98E-09
567	9.00E-11	-4.70E-10	-6.80E-10	-1.01E-09	-1.85E-09	-2.43E-09	-2.08E-09
569	2.82E-09	3.14E-09	3.16E-09	2.76E-09	2.58E-09	2.07E-09	1.60E-09
570	-2.56E-09	-2.69E-09	-3.18E-09	-3.34E-09	-3.43E-09	-3.94E-09	-3.55E-09
571	-1.09E-09	-1.62E-09	-1.60E-09	-9.50E-10	-2.19E-09	-3.25E-09	-2.67E-09
572	1.24E-09	1.00E-09	1.21E-09	1.20E-09	1.49E-09	5.50E-10	1.21E-09
573	2.10E-10	-1.50E-10	-5.10E-10	-7.20E-10	-6.10E-10	-1.05E-09	-3.70E-10
574	-2.40E-09	-2.53E-09	-3.06E-09	-3.00E-09	-2.36E-09	-3.49E-09	-2.94E-09
584	2.85E-09	2.38E-09	1.90E-09	1.66E-09	1.56E-09	1.31E-09	1.23E-09
585	1.97E-09	4.30E-10	2.30E-10	2.10E-10	2.50E-10	2.60E-10	1.90E-10
<b>Biased Statistics</b>							
Average Biased	1.12E-10	-3.44E-10	-6.54E-10	-9.86E-10	-1.73E-09	-2.38E-09	-1.73E-09
Std Dev Biased	2.73E-09	3.20E-09	3.38E-09	3.33E-09	3.36E-09	3.53E-09	2.94E-09
Ps90%/90% (+KTL) Biased	7.60E-09	8.43E-09	8.60E-09	8.14E-09	7.48E-09	7.30E-09	6.33E-09
Ps90%/90% (-KTL) Biased	-7.37E-09	-9.12E-09	-9.91E-09	-1.01E-08	-1.09E-08	-1.21E-08	-9.80E-09
<b>Un-Biased Statistics</b>							
Average Un-Biased	-9.20E-10	-1.20E-09	-1.43E-09	-1.36E-09	-1.42E-09	-2.24E-09	-1.66E-09
Std Dev Un-Biased	1.65E-09	1.59E-09	1.84E-09	1.85E-09	1.91E-09	1.92E-09	2.01E-09
Ps90%/90% (+KTL) Un-Biased	3.60E-09	3.16E-09	3.62E-09	3.72E-09	3.83E-09	3.02E-09	3.84E-09
Ps90%/90% (-KTL) Un-Biased	-5.44E-09	-5.56E-09	-6.48E-09	-6.44E-09	-6.67E-09	-7.49E-09	-7.17E-09
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

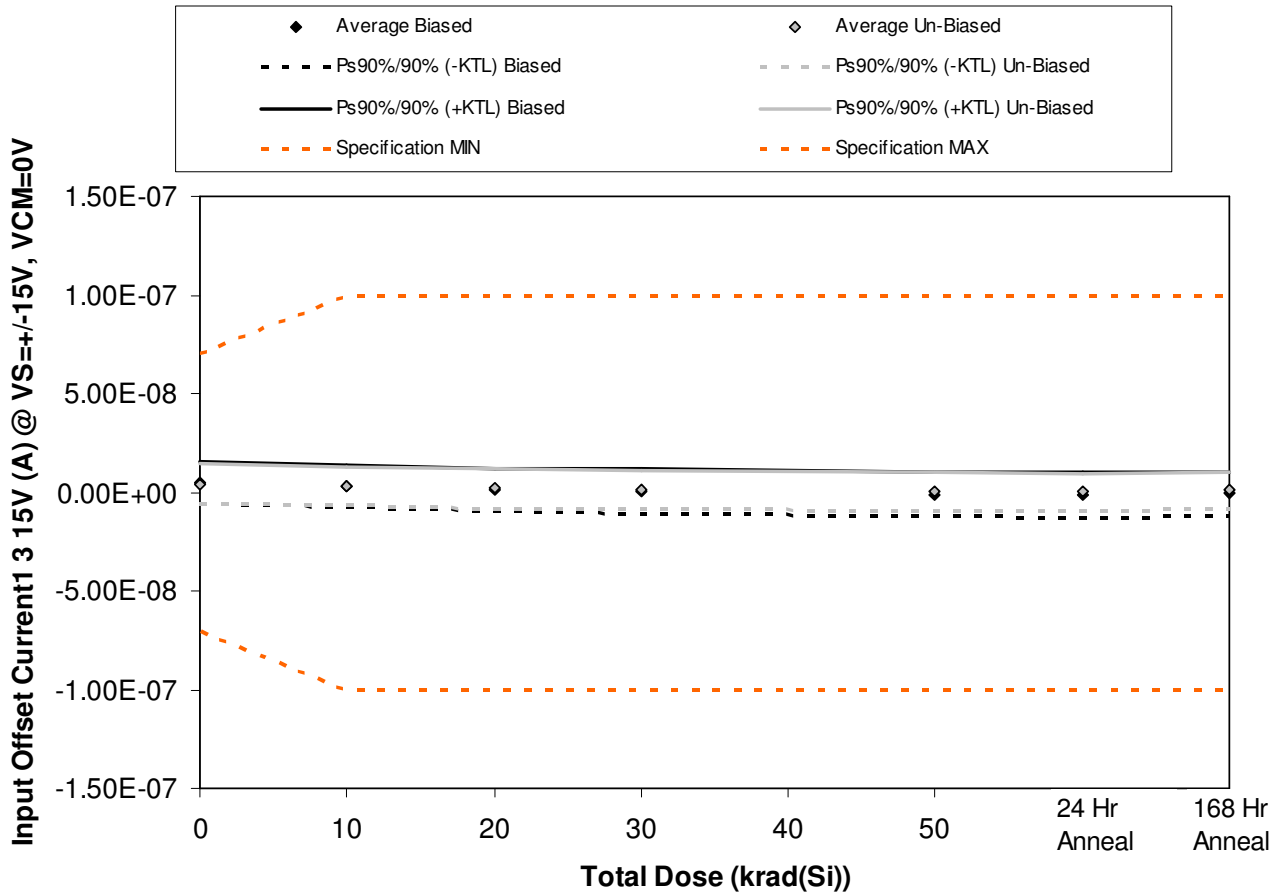


Figure 5.9. Plot of Input Offset Current1 3 15V (A) @ VS=+-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.9. Raw data for Input Offset Current1 3 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current1 3 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.99E-09	1.73E-09	6.80E-10	-5.60E-10	-1.73E-09	-2.38E-09	-1.29E-09
563	5.18E-09	3.48E-09	2.21E-09	9.80E-10	-3.80E-10	-1.36E-09	-7.80E-10
564	3.84E-09	1.74E-09	1.50E-10	-9.00E-10	-2.13E-09	-2.30E-09	-2.24E-09
567	1.11E-08	9.38E-09	7.63E-09	6.86E-09	5.63E-09	5.47E-09	6.12E-09
569	7.50E-10	-1.41E-09	-2.75E-09	-4.21E-09	-5.90E-09	-6.48E-09	-4.59E-09
570	7.99E-09	6.57E-09	5.67E-09	4.89E-09	4.04E-09	3.42E-09	3.76E-09
571	1.44E-09	-9.00E-11	-1.02E-09	-1.25E-09	-2.65E-09	-3.17E-09	-1.86E-09
572	4.53E-09	3.10E-09	2.21E-09	1.24E-09	9.60E-10	-1.70E-10	9.50E-10
573	8.00E-09	6.44E-09	5.80E-09	5.18E-09	4.28E-09	3.73E-09	4.56E-09
574	1.40E-10	-1.24E-09	-2.31E-09	-3.08E-09	-3.44E-09	-3.79E-09	-2.95E-09
584	5.40E-09	3.91E-09	2.67E-09	1.90E-09	1.25E-09	1.17E-09	1.17E-09
585	-8.40E-10	-3.49E-09	-4.29E-09	-4.93E-09	-5.64E-09	-5.78E-09	-5.54E-09
<b>Biased Statistics</b>							
Average Biased	4.97E-09	2.98E-09	1.58E-09	4.34E-10	-9.02E-10	-1.41E-09	-5.56E-10
Std Dev Biased	3.80E-09	3.99E-09	3.83E-09	4.06E-09	4.19E-09	4.32E-09	4.01E-09
Ps90%/90% (+KTL) Biased	1.54E-08	1.39E-08	1.21E-08	1.16E-08	1.06E-08	1.04E-08	1.04E-08
Ps90%/90% (-KTL) Biased	-5.45E-09	-7.95E-09	-8.91E-09	-1.07E-08	-1.24E-08	-1.33E-08	-1.15E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	4.42E-09	2.96E-09	2.07E-09	1.40E-09	6.38E-10	4.00E-12	8.92E-10
Std Dev Un-Biased	3.63E-09	3.61E-09	3.73E-09	3.66E-09	3.62E-09	3.54E-09	3.32E-09
Ps90%/90% (+KTL) Un-Biased	1.44E-08	1.29E-08	1.23E-08	1.14E-08	1.06E-08	9.70E-09	9.99E-09
Ps90%/90% (-KTL) Un-Biased	-5.54E-09	-6.94E-09	-8.16E-09	-8.64E-09	-9.28E-09	-9.70E-09	-8.20E-09
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

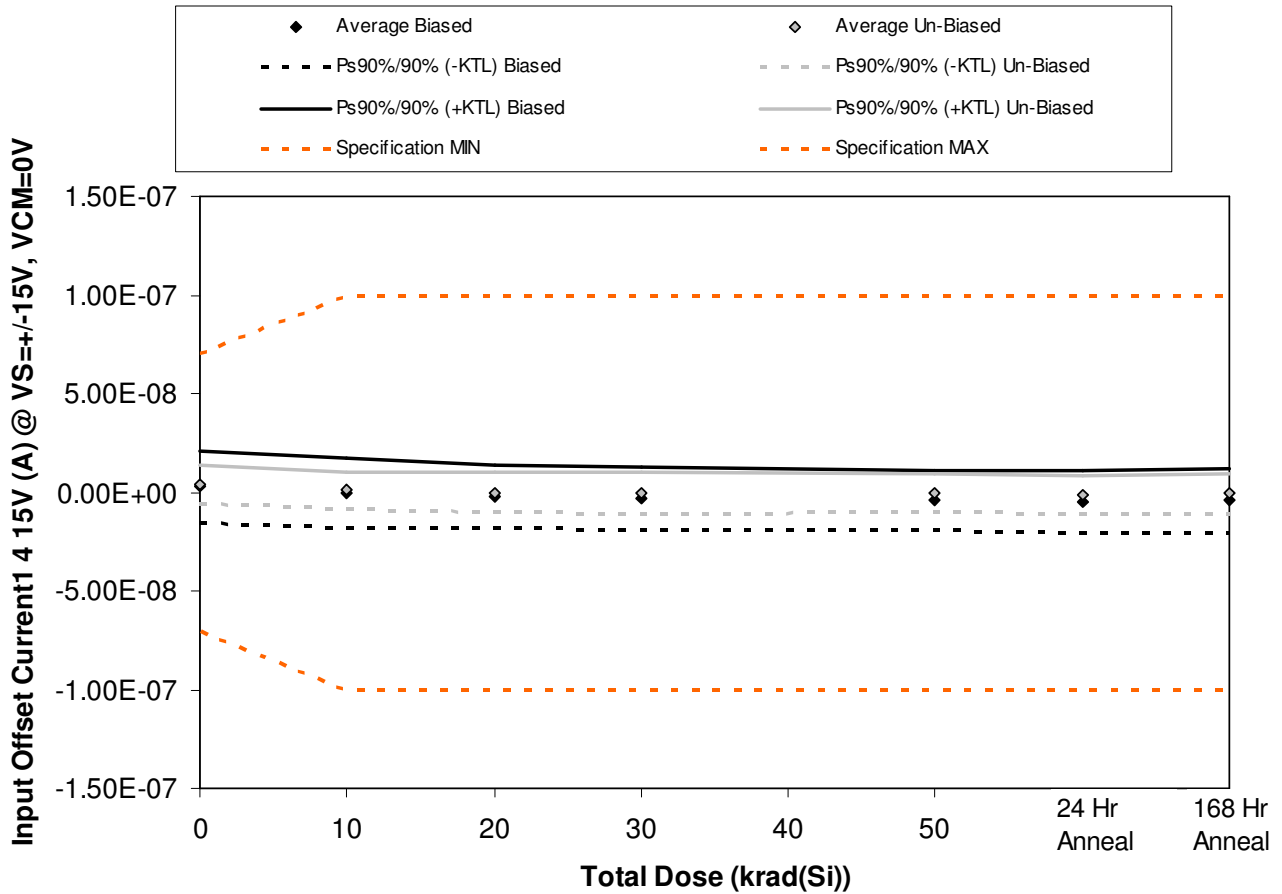


Figure 5.10. Plot of Input Offset Current1 4 15V (A) @ VS=+-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.10. Raw data for Input Offset Current1 4 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current1 4 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.06E-09	-2.35E-09	-3.80E-09	-4.69E-09	-5.64E-09	-6.27E-09	-5.35E-09
563	-2.10E-09	-5.72E-09	-7.54E-09	-8.30E-09	-9.31E-09	-1.06E-08	-9.33E-09
564	1.26E-08	9.17E-09	6.30E-09	5.26E-09	4.32E-09	3.50E-09	4.83E-09
567	6.14E-09	2.54E-09	1.60E-10	-5.30E-10	-2.08E-09	-2.02E-09	-1.27E-09
569	-3.46E-09	-5.70E-09	-7.01E-09	-8.29E-09	-8.40E-09	-8.90E-09	-9.31E-09
570	2.78E-09	-1.00E-10	-1.45E-09	-1.51E-09	-1.60E-09	-2.60E-09	-1.66E-09
571	6.18E-09	3.24E-09	2.39E-09	1.65E-09	1.52E-09	8.00E-10	1.46E-09
572	-2.00E-10	-3.05E-09	-4.01E-09	-4.97E-09	-4.48E-09	-5.48E-09	-5.14E-09
573	8.59E-09	5.79E-09	5.18E-09	4.88E-09	4.25E-09	3.22E-09	4.51E-09
574	1.74E-09	-8.60E-10	-2.14E-09	-2.04E-09	-3.07E-09	-3.62E-09	-3.16E-09
584	1.79E-09	-5.70E-10	-1.83E-09	-2.41E-09	-2.88E-09	-2.93E-09	-3.13E-09
585	-2.72E-09	-6.40E-09	-7.22E-09	-7.57E-09	-8.13E-09	-8.27E-09	-8.36E-09
<b>Biased Statistics</b>							
Average Biased	2.84E-09	-4.12E-10	-2.38E-09	-3.31E-09	-4.22E-09	-4.87E-09	-4.09E-09
Std Dev Biased	6.57E-09	6.33E-09	5.74E-09	5.76E-09	5.54E-09	5.69E-09	6.00E-09
Ps90%/90% (+KTL) Biased	2.08E-08	1.70E-08	1.34E-08	1.25E-08	1.10E-08	1.07E-08	1.24E-08
Ps90%/90% (-KTL) Biased	-1.52E-08	-1.78E-08	-1.81E-08	-1.91E-08	-1.94E-08	-2.05E-08	-2.05E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.82E-09	1.00E-09	-6.00E-12	-3.98E-10	-6.76E-10	-1.54E-09	-7.98E-10
Std Dev Un-Biased	3.53E-09	3.50E-09	3.72E-09	3.77E-09	3.54E-09	3.50E-09	3.82E-09
Ps90%/90% (+KTL) Un-Biased	1.35E-08	1.06E-08	1.02E-08	9.94E-09	9.03E-09	8.07E-09	9.68E-09
Ps90%/90% (-KTL) Un-Biased	-5.87E-09	-8.60E-09	-1.02E-08	-1.07E-08	-1.04E-08	-1.11E-08	-1.13E-08
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



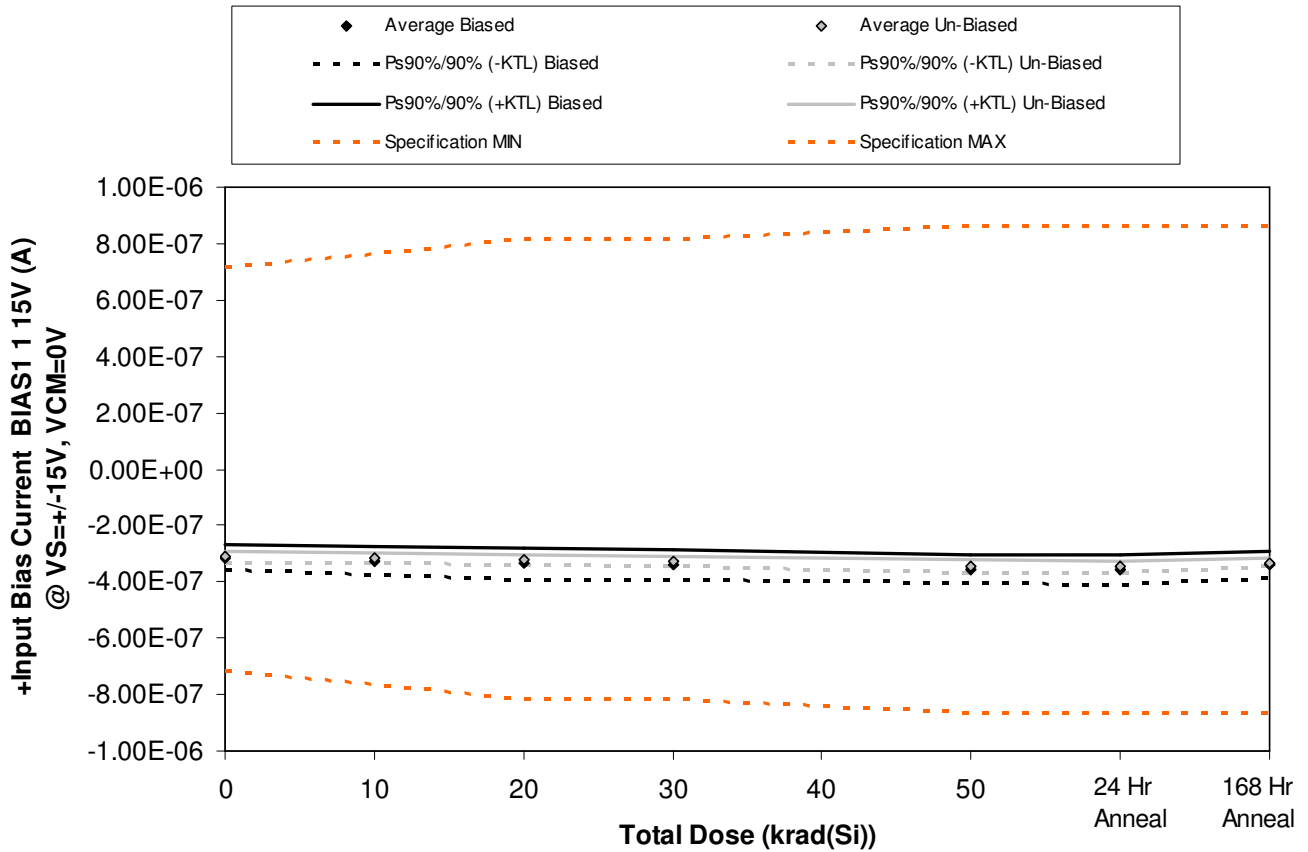


Figure 5.11. Plot of +Input Bias Current BIAS1 1 15V (A) @ VS=+/-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.11. Raw data for +Input Bias Current BIAS1 1 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS1 1 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.89E-07	-2.97E-07	-3.03E-07	-3.09E-07	-3.23E-07	-3.23E-07	-3.10E-07
563	-3.13E-07	-3.25E-07	-3.33E-07	-3.37E-07	-3.55E-07	-3.56E-07	-3.35E-07
564	-3.21E-07	-3.33E-07	-3.46E-07	-3.47E-07	-3.62E-07	-3.64E-07	-3.48E-07
567	-3.31E-07	-3.46E-07	-3.56E-07	-3.58E-07	-3.70E-07	-3.73E-07	-3.54E-07
569	-3.17E-07	-3.31E-07	-3.40E-07	-3.48E-07	-3.63E-07	-3.61E-07	-3.45E-07
570	-3.23E-07	-3.27E-07	-3.33E-07	-3.40E-07	-3.60E-07	-3.58E-07	-3.40E-07
571	-3.10E-07	-3.15E-07	-3.22E-07	-3.28E-07	-3.46E-07	-3.47E-07	-3.30E-07
572	-3.04E-07	-3.09E-07	-3.15E-07	-3.23E-07	-3.39E-07	-3.38E-07	-3.25E-07
573	-3.12E-07	-3.14E-07	-3.22E-07	-3.28E-07	-3.48E-07	-3.48E-07	-3.30E-07
574	-3.09E-07	-3.13E-07	-3.18E-07	-3.25E-07	-3.40E-07	-3.40E-07	-3.27E-07
584	-2.88E-07	-2.87E-07	-2.88E-07	-2.88E-07	-2.91E-07	-2.93E-07	-2.92E-07
585	-2.97E-07	-3.00E-07	-2.95E-07	-2.99E-07	-2.98E-07	-3.03E-07	-3.01E-07
<b>Biased Statistics</b>							
Average Biased	-3.14E-07	-3.26E-07	-3.36E-07	-3.40E-07	-3.55E-07	-3.56E-07	-3.38E-07
Std Dev Biased	1.57E-08	1.83E-08	2.00E-08	1.90E-08	1.85E-08	1.91E-08	1.73E-08
Ps90%/90% (+KTL) Biased	-2.71E-07	-2.76E-07	-2.81E-07	-2.88E-07	-3.04E-07	-3.03E-07	-2.91E-07
Ps90%/90% (-KTL) Biased	-3.57E-07	-3.76E-07	-3.90E-07	-3.92E-07	-4.06E-07	-4.08E-07	-3.86E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.12E-07	-3.15E-07	-3.22E-07	-3.29E-07	-3.47E-07	-3.46E-07	-3.30E-07
Std Dev Un-Biased	6.86E-09	6.87E-09	6.70E-09	6.58E-09	8.20E-09	7.86E-09	5.77E-09
Ps90%/90% (+KTL) Un-Biased	-2.93E-07	-2.97E-07	-3.04E-07	-3.11E-07	-3.24E-07	-3.25E-07	-3.15E-07
Ps90%/90% (-KTL) Un-Biased	-3.30E-07	-3.34E-07	-3.40E-07	-3.47E-07	-3.69E-07	-3.68E-07	-3.46E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

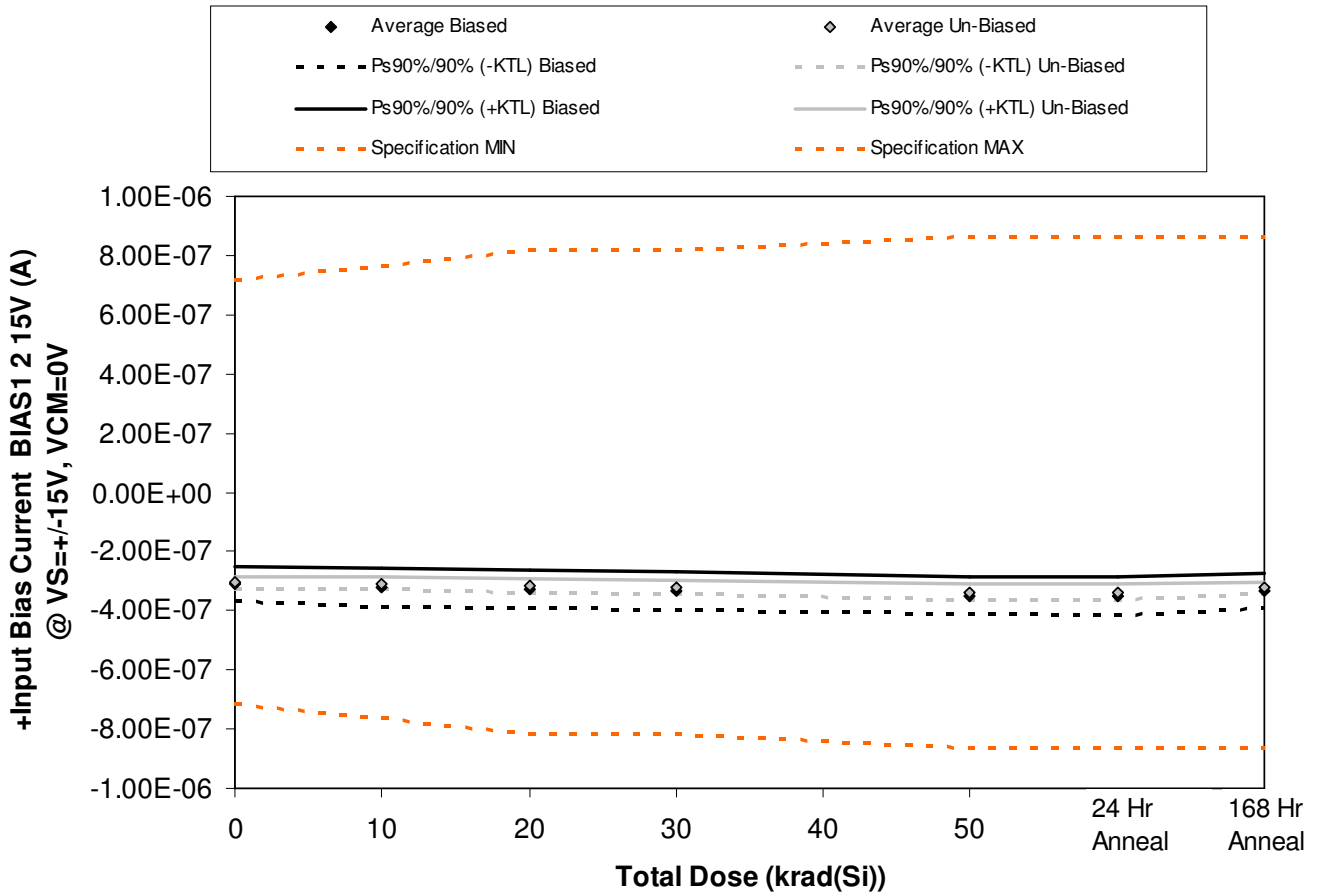


Figure 5.12. Plot of +Input Bias Current BIAS1 2 15V (A) @ VS=+/-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.12. Raw data for +Input Bias Current BIAS1 2 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS1 2 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.77E-07	-2.86E-07	-2.93E-07	-2.99E-07	-3.14E-07	-3.14E-07	-3.00E-07
563	-3.33E-07	-3.49E-07	-3.55E-07	-3.60E-07	-3.74E-07	-3.74E-07	-3.58E-07
564	-3.17E-07	-3.30E-07	-3.38E-07	-3.41E-07	-3.60E-07	-3.60E-07	-3.39E-07
567	-3.18E-07	-3.30E-07	-3.38E-07	-3.45E-07	-3.59E-07	-3.60E-07	-3.40E-07
569	-2.98E-07	-3.11E-07	-3.19E-07	-3.24E-07	-3.38E-07	-3.37E-07	-3.21E-07
570	-3.16E-07	-3.20E-07	-3.27E-07	-3.33E-07	-3.54E-07	-3.52E-07	-3.35E-07
571	-3.07E-07	-3.13E-07	-3.20E-07	-3.25E-07	-3.40E-07	-3.45E-07	-3.28E-07
572	-2.97E-07	-3.02E-07	-3.08E-07	-3.16E-07	-3.31E-07	-3.32E-07	-3.17E-07
573	-3.01E-07	-3.03E-07	-3.10E-07	-3.17E-07	-3.31E-07	-3.30E-07	-3.19E-07
574	-3.00E-07	-3.04E-07	-3.10E-07	-3.17E-07	-3.35E-07	-3.34E-07	-3.20E-07
584	-3.11E-07	-3.10E-07	-3.11E-07	-3.11E-07	-3.15E-07	-3.17E-07	-3.16E-07
585	-3.10E-07	-3.14E-07	-3.09E-07	-3.13E-07	-3.12E-07	-3.16E-07	-3.15E-07
<b>Biased Statistics</b>							
Average Biased	-3.09E-07	-3.21E-07	-3.29E-07	-3.34E-07	-3.49E-07	-3.49E-07	-3.32E-07
Std Dev Biased	2.15E-08	2.37E-08	2.37E-08	2.35E-08	2.33E-08	2.35E-08	2.18E-08
Ps90%/90% (+KTL) Biased	-2.50E-07	-2.56E-07	-2.64E-07	-2.69E-07	-2.85E-07	-2.85E-07	-2.72E-07
Ps90%/90% (-KTL) Biased	-3.68E-07	-3.86E-07	-3.94E-07	-3.98E-07	-4.13E-07	-4.14E-07	-3.91E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.04E-07	-3.08E-07	-3.15E-07	-3.22E-07	-3.38E-07	-3.39E-07	-3.24E-07
Std Dev Un-Biased	7.39E-09	7.87E-09	8.01E-09	7.60E-09	9.47E-09	9.50E-09	7.47E-09
Ps90%/90% (+KTL) Un-Biased	-2.84E-07	-2.87E-07	-2.93E-07	-3.01E-07	-3.12E-07	-3.13E-07	-3.03E-07
Ps90%/90% (-KTL) Un-Biased	-3.25E-07	-3.30E-07	-3.37E-07	-3.42E-07	-3.64E-07	-3.65E-07	-3.44E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

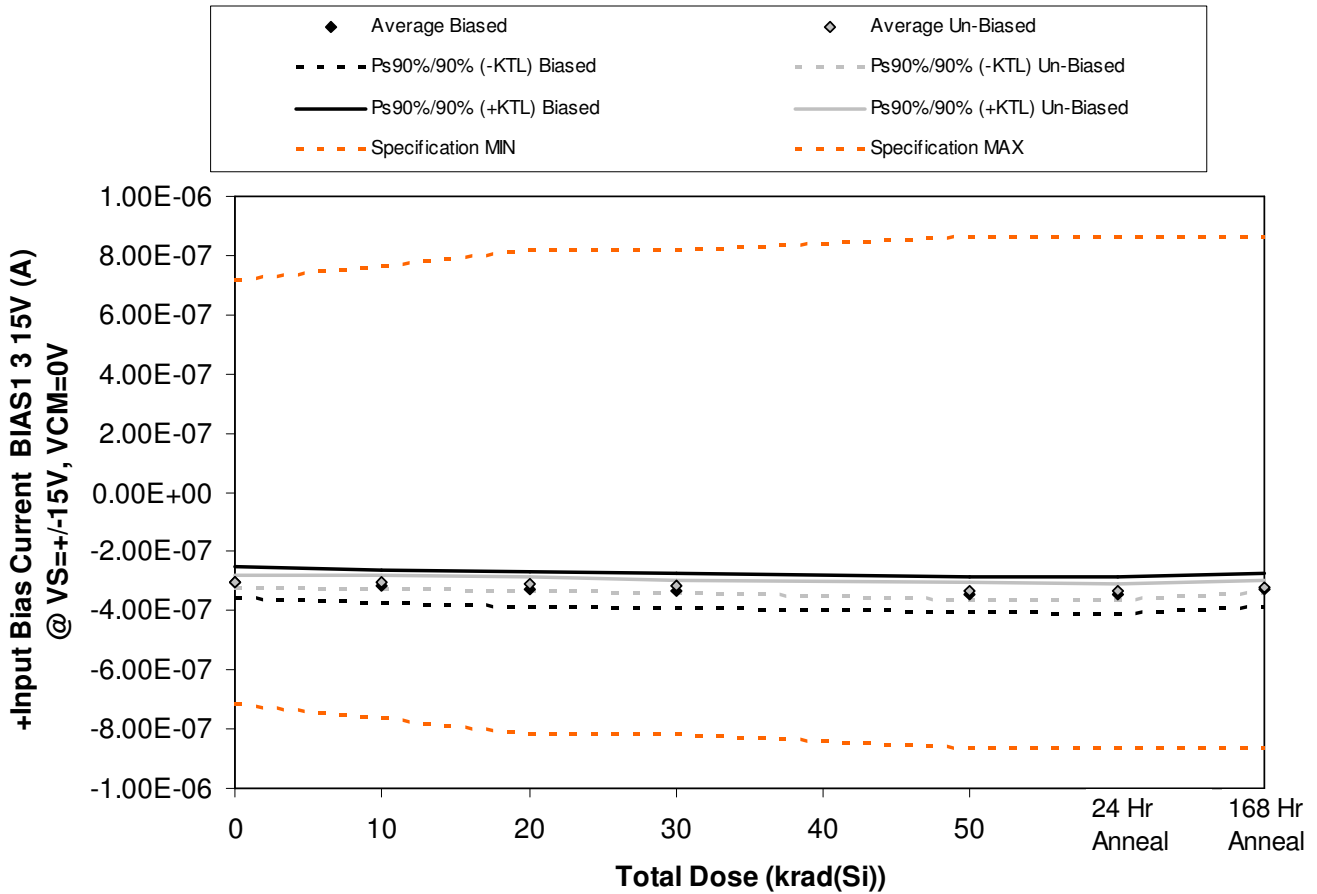


Figure 5.13. Plot of +Input Bias Current BIAS1 3 15V (A) @ VS=+/-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.13. Raw data for +Input Bias Current BIAS1 3 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS1 3 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.77E-07	-2.85E-07	-2.92E-07	-2.98E-07	-3.12E-07	-3.12E-07	-2.99E-07
563	-3.26E-07	-3.37E-07	-3.47E-07	-3.53E-07	-3.66E-07	-3.68E-07	-3.50E-07
564	-3.18E-07	-3.30E-07	-3.39E-07	-3.45E-07	-3.61E-07	-3.60E-07	-3.44E-07
567	-3.13E-07	-3.24E-07	-3.33E-07	-3.37E-07	-3.54E-07	-3.56E-07	-3.35E-07
569	-2.98E-07	-3.10E-07	-3.18E-07	-3.23E-07	-3.37E-07	-3.37E-07	-3.21E-07
570	-3.13E-07	-3.16E-07	-3.22E-07	-3.30E-07	-3.50E-07	-3.48E-07	-3.32E-07
571	-3.06E-07	-3.10E-07	-3.17E-07	-3.22E-07	-3.36E-07	-3.37E-07	-3.24E-07
572	-2.96E-07	-3.00E-07	-3.06E-07	-3.13E-07	-3.28E-07	-3.28E-07	-3.15E-07
573	-2.94E-07	-2.95E-07	-3.02E-07	-3.09E-07	-3.24E-07	-3.23E-07	-3.11E-07
574	-3.00E-07	-3.03E-07	-3.09E-07	-3.16E-07	-3.32E-07	-3.31E-07	-3.18E-07
584	-3.10E-07	-3.08E-07	-3.10E-07	-3.10E-07	-3.13E-07	-3.15E-07	-3.14E-07
585	-3.19E-07	-3.21E-07	-3.16E-07	-3.21E-07	-3.20E-07	-3.24E-07	-3.23E-07
<b>Biased Statistics</b>							
Average Biased	-3.06E-07	-3.17E-07	-3.26E-07	-3.31E-07	-3.46E-07	-3.47E-07	-3.30E-07
Std Dev Biased	1.94E-08	2.06E-08	2.16E-08	2.18E-08	2.18E-08	2.24E-08	2.04E-08
Ps90%/90% (+KTL) Biased	-2.53E-07	-2.61E-07	-2.66E-07	-2.72E-07	-2.86E-07	-2.85E-07	-2.74E-07
Ps90%/90% (-KTL) Biased	-3.60E-07	-3.74E-07	-3.85E-07	-3.91E-07	-4.06E-07	-4.08E-07	-3.86E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.02E-07	-3.05E-07	-3.11E-07	-3.18E-07	-3.34E-07	-3.34E-07	-3.20E-07
Std Dev Un-Biased	7.63E-09	8.33E-09	8.26E-09	8.09E-09	9.94E-09	9.68E-09	7.98E-09
Ps90%/90% (+KTL) Un-Biased	-2.81E-07	-2.82E-07	-2.88E-07	-2.96E-07	-3.07E-07	-3.07E-07	-2.98E-07
Ps90%/90% (-KTL) Un-Biased	-3.22E-07	-3.27E-07	-3.34E-07	-3.40E-07	-3.61E-07	-3.60E-07	-3.42E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

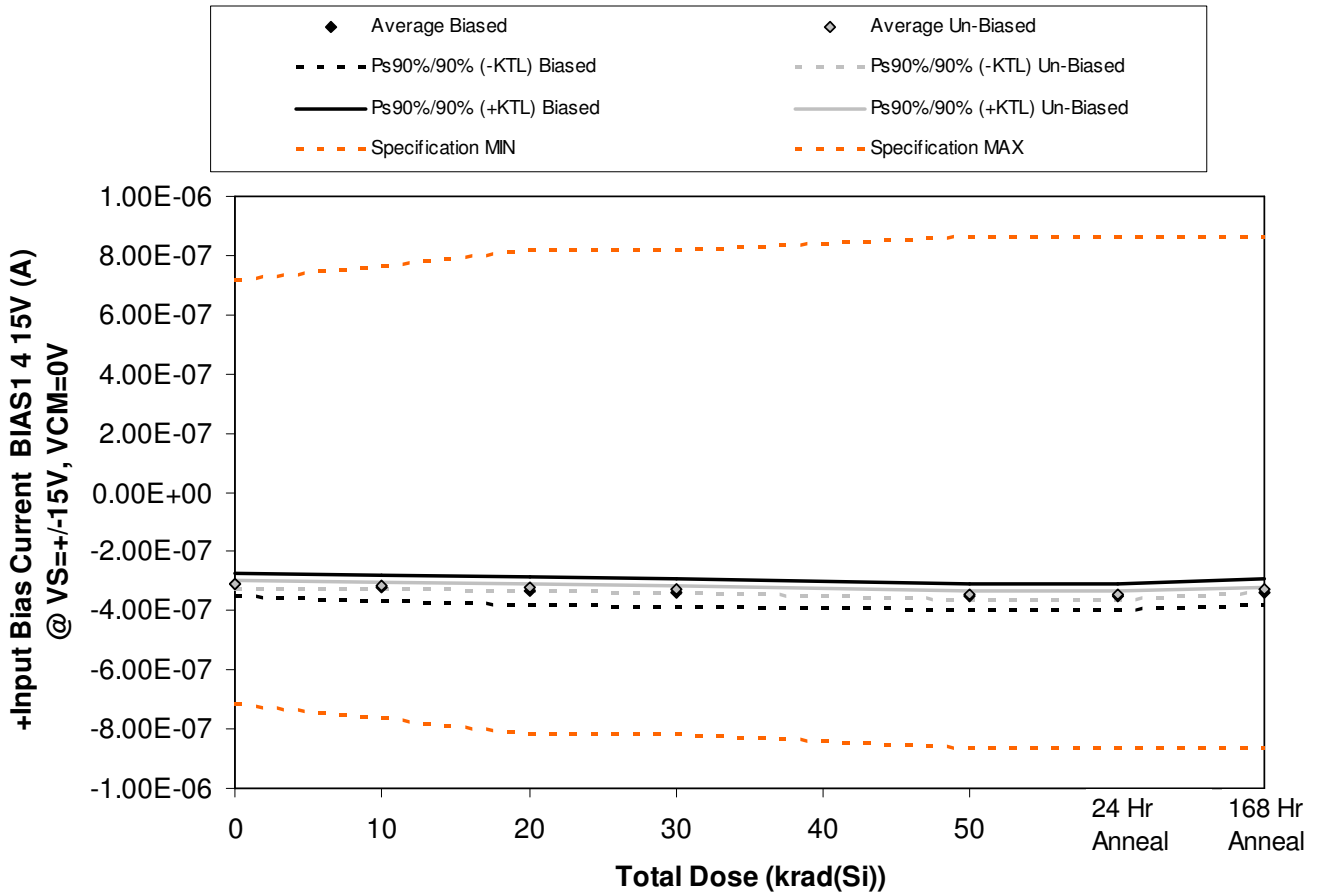


Figure 5.14. Plot of +Input Bias Current BIAS1 4 15V (A) @ VS=+/-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.14. Raw data for +Input Bias Current BIAS1 4 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS1 4 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.91E-07	-2.99E-07	-3.07E-07	-3.13E-07	-3.28E-07	-3.28E-07	-3.13E-07
563	-3.12E-07	-3.24E-07	-3.32E-07	-3.36E-07	-3.53E-07	-3.55E-07	-3.34E-07
564	-3.12E-07	-3.25E-07	-3.34E-07	-3.36E-07	-3.54E-07	-3.54E-07	-3.34E-07
567	-3.29E-07	-3.40E-07	-3.53E-07	-3.57E-07	-3.69E-07	-3.71E-07	-3.54E-07
569	-3.19E-07	-3.32E-07	-3.45E-07	-3.49E-07	-3.63E-07	-3.62E-07	-3.48E-07
570	-3.18E-07	-3.22E-07	-3.28E-07	-3.34E-07	-3.52E-07	-3.52E-07	-3.35E-07
571	-3.05E-07	-3.10E-07	-3.17E-07	-3.23E-07	-3.38E-07	-3.40E-07	-3.25E-07
572	-3.10E-07	-3.14E-07	-3.21E-07	-3.28E-07	-3.50E-07	-3.50E-07	-3.31E-07
573	-3.15E-07	-3.16E-07	-3.24E-07	-3.30E-07	-3.49E-07	-3.49E-07	-3.32E-07
574	-3.10E-07	-3.13E-07	-3.19E-07	-3.26E-07	-3.46E-07	-3.46E-07	-3.28E-07
584	-2.81E-07	-2.80E-07	-2.80E-07	-2.81E-07	-2.83E-07	-2.85E-07	-2.84E-07
585	-2.97E-07	-3.00E-07	-2.95E-07	-2.99E-07	-2.98E-07	-3.02E-07	-3.01E-07
<b>Biased Statistics</b>							
Average Biased	-3.12E-07	-3.24E-07	-3.34E-07	-3.38E-07	-3.53E-07	-3.54E-07	-3.37E-07
Std Dev Biased	1.40E-08	1.53E-08	1.77E-08	1.70E-08	1.58E-08	1.61E-08	1.58E-08
Ps90%/90% (+KTL) Biased	-2.74E-07	-2.82E-07	-2.86E-07	-2.92E-07	-3.10E-07	-3.10E-07	-2.93E-07
Ps90%/90% (-KTL) Biased	-3.51E-07	-3.66E-07	-3.83E-07	-3.85E-07	-3.97E-07	-3.98E-07	-3.80E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.12E-07	-3.15E-07	-3.22E-07	-3.28E-07	-3.47E-07	-3.47E-07	-3.30E-07
Std Dev Un-Biased	4.87E-09	4.30E-09	4.11E-09	4.03E-09	5.31E-09	5.06E-09	3.61E-09
Ps90%/90% (+KTL) Un-Biased	-2.98E-07	-3.03E-07	-3.10E-07	-3.17E-07	-3.32E-07	-3.34E-07	-3.20E-07
Ps90%/90% (-KTL) Un-Biased	-3.25E-07	-3.27E-07	-3.33E-07	-3.39E-07	-3.62E-07	-3.61E-07	-3.40E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



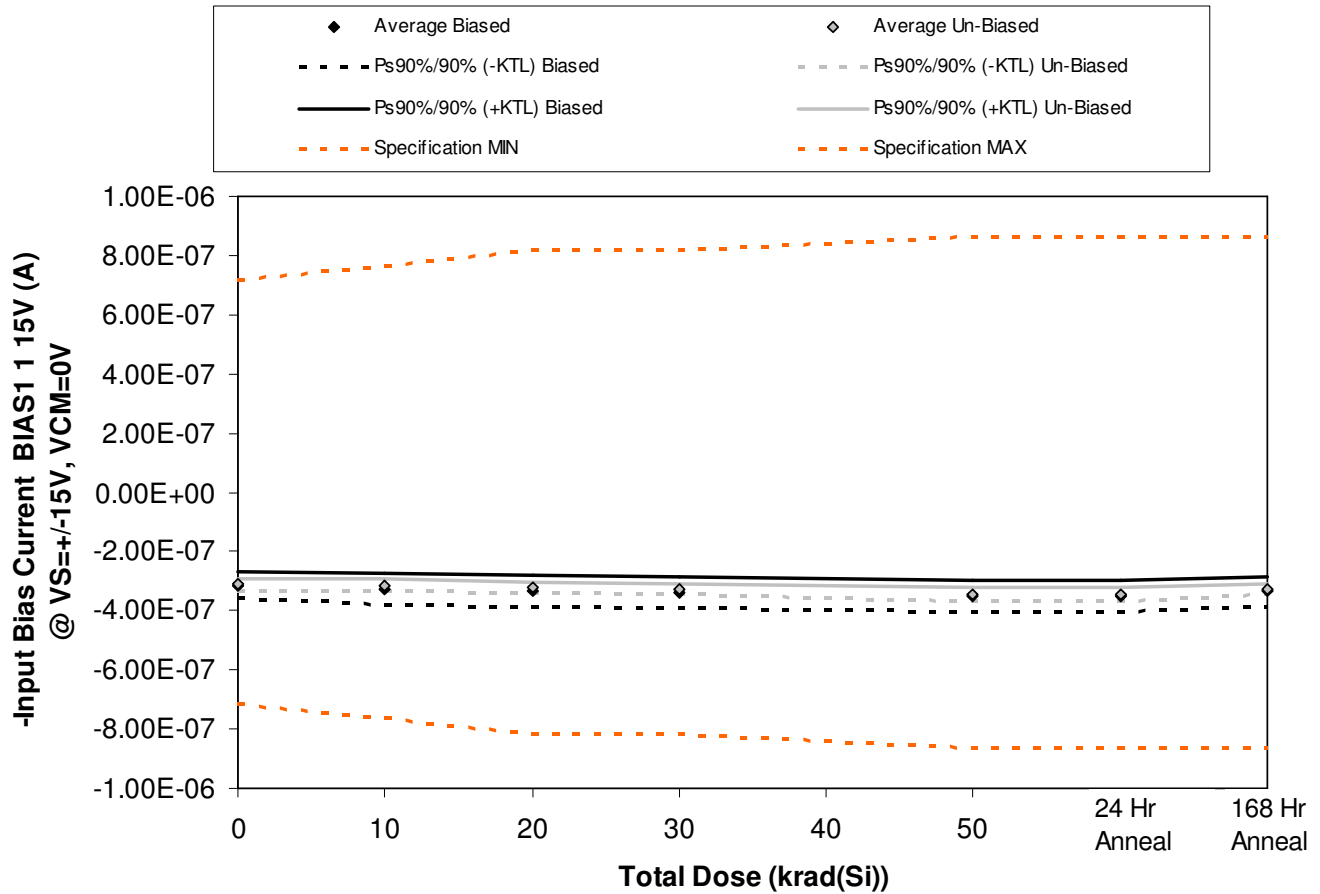


Figure 5.15. Plot of -Input Bias Current BIAS1 1 15V (A) @ VS=+-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.15. Raw data for -Input Bias Current BIAS1 1 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS1 1 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.91E-07	-2.99E-07	-3.05E-07	-3.10E-07	-3.23E-07	-3.22E-07	-3.10E-07
563	-3.08E-07	-3.20E-07	-3.27E-07	-3.31E-07	-3.47E-07	-3.47E-07	-3.28E-07
564	-3.20E-07	-3.32E-07	-3.39E-07	-3.41E-07	-3.58E-07	-3.58E-07	-3.39E-07
567	-3.36E-07	-3.51E-07	-3.60E-07	-3.62E-07	-3.75E-07	-3.76E-07	-3.59E-07
569	-3.18E-07	-3.31E-07	-3.39E-07	-3.45E-07	-3.60E-07	-3.57E-07	-3.39E-07
570	-3.22E-07	-3.25E-07	-3.32E-07	-3.39E-07	-3.57E-07	-3.56E-07	-3.39E-07
571	-3.03E-07	-3.08E-07	-3.15E-07	-3.20E-07	-3.35E-07	-3.35E-07	-3.23E-07
572	-3.06E-07	-3.10E-07	-3.17E-07	-3.24E-07	-3.40E-07	-3.38E-07	-3.26E-07
573	-3.09E-07	-3.11E-07	-3.18E-07	-3.25E-07	-3.40E-07	-3.39E-07	-3.27E-07
574	-3.13E-07	-3.17E-07	-3.22E-07	-3.29E-07	-3.49E-07	-3.48E-07	-3.31E-07
584	-2.80E-07	-2.78E-07	-2.79E-07	-2.79E-07	-2.82E-07	-2.83E-07	-2.82E-07
585	-2.98E-07	-3.00E-07	-2.95E-07	-2.99E-07	-2.98E-07	-3.02E-07	-3.00E-07
<b>Biased Statistics</b>							
Average Biased	-3.14E-07	-3.26E-07	-3.34E-07	-3.38E-07	-3.53E-07	-3.52E-07	-3.35E-07
Std Dev Biased	1.65E-08	1.91E-08	2.02E-08	1.92E-08	1.93E-08	1.97E-08	1.77E-08
Ps90%/90% (+KTL) Biased	-2.69E-07	-2.74E-07	-2.78E-07	-2.85E-07	-3.00E-07	-2.98E-07	-2.86E-07
Ps90%/90% (-KTL) Biased	-3.60E-07	-3.79E-07	-3.89E-07	-3.90E-07	-4.06E-07	-4.06E-07	-3.84E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.11E-07	-3.14E-07	-3.21E-07	-3.27E-07	-3.44E-07	-3.43E-07	-3.29E-07
Std Dev Un-Biased	7.27E-09	7.06E-09	6.84E-09	7.15E-09	8.88E-09	8.70E-09	6.29E-09
Ps90%/90% (+KTL) Un-Biased	-2.91E-07	-2.95E-07	-3.02E-07	-3.08E-07	-3.20E-07	-3.19E-07	-3.12E-07
Ps90%/90% (-KTL) Un-Biased	-3.31E-07	-3.34E-07	-3.40E-07	-3.47E-07	-3.68E-07	-3.67E-07	-3.46E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

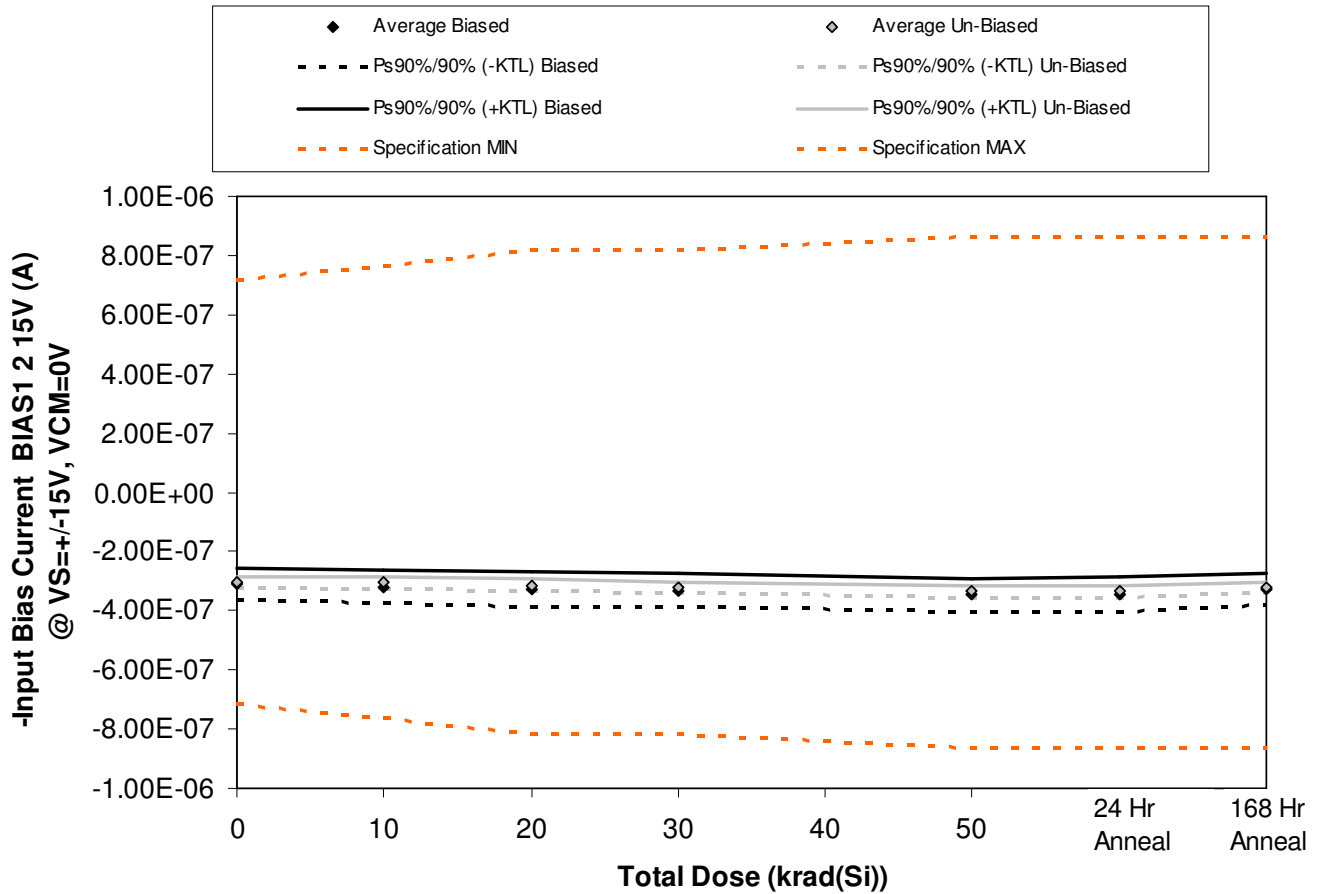


Figure 5.16. Plot of -Input Bias Current BIAS1 2 15V (A) @ VS=+-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.16. Raw data for -Input Bias Current BIAS1 2 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS1 2 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.80E-07	-2.88E-07	-2.95E-07	-3.01E-07	-3.14E-07	-3.14E-07	-3.01E-07
563	-3.30E-07	-3.41E-07	-3.52E-07	-3.55E-07	-3.68E-07	-3.68E-07	-3.53E-07
564	-3.14E-07	-3.26E-07	-3.33E-07	-3.35E-07	-3.53E-07	-3.53E-07	-3.34E-07
567	-3.17E-07	-3.29E-07	-3.37E-07	-3.41E-07	-3.55E-07	-3.58E-07	-3.37E-07
569	-3.00E-07	-3.14E-07	-3.22E-07	-3.26E-07	-3.40E-07	-3.39E-07	-3.22E-07
570	-3.13E-07	-3.17E-07	-3.23E-07	-3.30E-07	-3.49E-07	-3.49E-07	-3.31E-07
571	-3.06E-07	-3.11E-07	-3.18E-07	-3.24E-07	-3.37E-07	-3.38E-07	-3.25E-07
572	-2.98E-07	-3.02E-07	-3.09E-07	-3.16E-07	-3.33E-07	-3.32E-07	-3.18E-07
573	-3.01E-07	-3.03E-07	-3.09E-07	-3.15E-07	-3.30E-07	-3.29E-07	-3.18E-07
574	-2.97E-07	-3.01E-07	-3.07E-07	-3.14E-07	-3.31E-07	-3.30E-07	-3.16E-07
584	-3.14E-07	-3.12E-07	-3.13E-07	-3.13E-07	-3.16E-07	-3.17E-07	-3.16E-07
585	-3.12E-07	-3.14E-07	-3.09E-07	-3.13E-07	-3.12E-07	-3.16E-07	-3.14E-07
<b>Biased Statistics</b>							
Average Biased	-3.08E-07	-3.20E-07	-3.28E-07	-3.32E-07	-3.46E-07	-3.46E-07	-3.29E-07
Std Dev Biased	1.92E-08	2.00E-08	2.12E-08	2.02E-08	2.05E-08	2.10E-08	1.93E-08
Ps90%/90% (+KTL) Biased	-2.56E-07	-2.65E-07	-2.70E-07	-2.76E-07	-2.90E-07	-2.89E-07	-2.76E-07
Ps90%/90% (-KTL) Biased	-3.61E-07	-3.74E-07	-3.86E-07	-3.87E-07	-4.02E-07	-4.04E-07	-3.82E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.03E-07	-3.07E-07	-3.13E-07	-3.20E-07	-3.36E-07	-3.36E-07	-3.22E-07
Std Dev Un-Biased	6.45E-09	6.86E-09	7.01E-09	6.72E-09	7.80E-09	8.20E-09	6.17E-09
Ps90%/90% (+KTL) Un-Biased	-2.85E-07	-2.88E-07	-2.94E-07	-3.01E-07	-3.15E-07	-3.13E-07	-3.05E-07
Ps90%/90% (-KTL) Un-Biased	-3.21E-07	-3.25E-07	-3.32E-07	-3.38E-07	-3.57E-07	-3.58E-07	-3.38E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

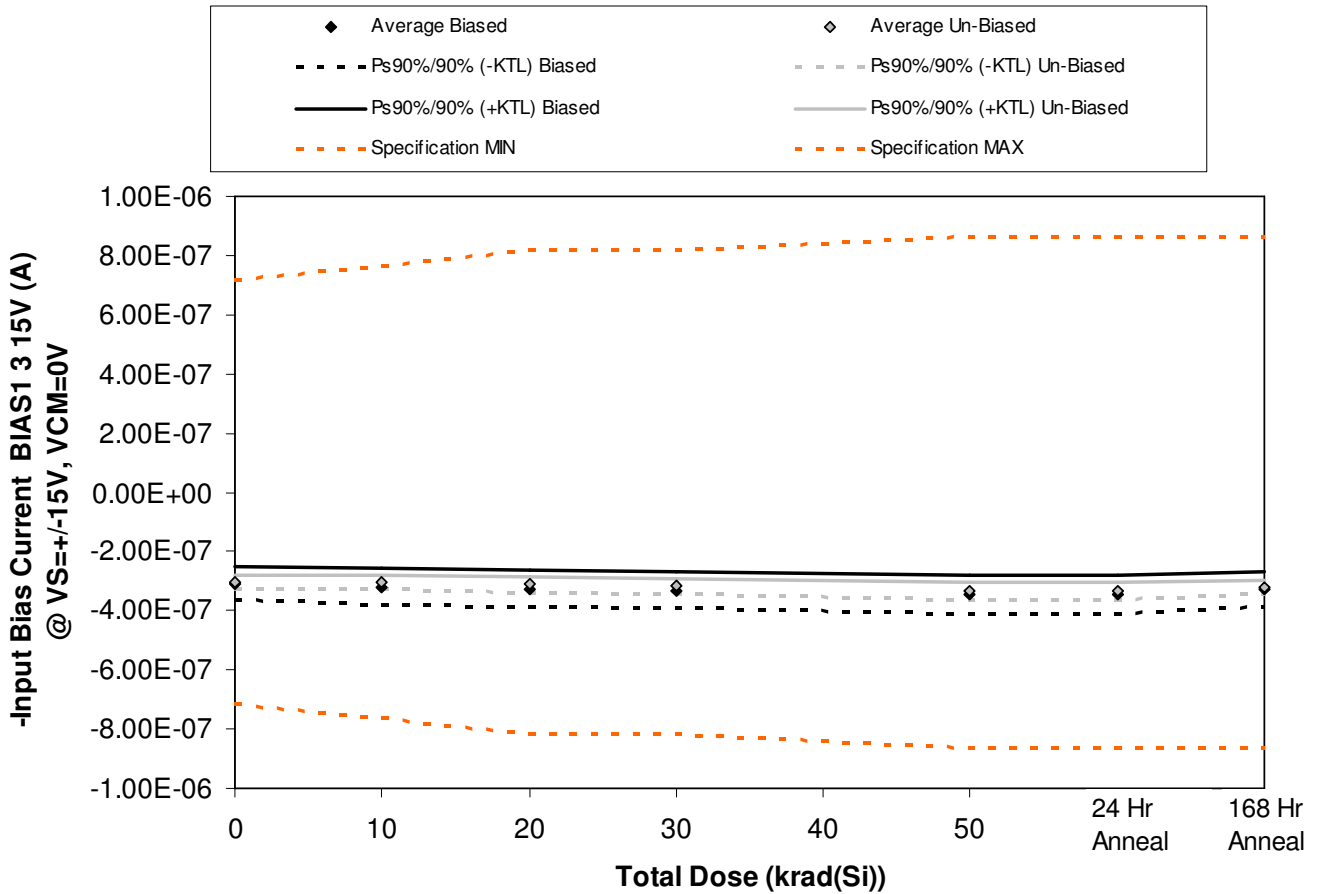


Figure 5.17. Plot of -Input Bias Current BIAS1 3 15V (A) @ VS=+-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.17. Raw data for -Input Bias Current BIAS1 3 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS1 3 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.78E-07	-2.86E-07	-2.92E-07	-2.96E-07	-3.10E-07	-3.09E-07	-2.97E-07
563	-3.27E-07	-3.39E-07	-3.48E-07	-3.53E-07	-3.65E-07	-3.64E-07	-3.51E-07
564	-3.18E-07	-3.31E-07	-3.38E-07	-3.40E-07	-3.57E-07	-3.58E-07	-3.38E-07
567	-3.20E-07	-3.31E-07	-3.39E-07	-3.46E-07	-3.58E-07	-3.61E-07	-3.40E-07
569	-2.95E-07	-3.07E-07	-3.14E-07	-3.18E-07	-3.30E-07	-3.30E-07	-3.16E-07
570	-3.17E-07	-3.20E-07	-3.27E-07	-3.34E-07	-3.52E-07	-3.51E-07	-3.35E-07
571	-3.03E-07	-3.08E-07	-3.14E-07	-3.20E-07	-3.33E-07	-3.34E-07	-3.22E-07
572	-2.97E-07	-3.01E-07	-3.07E-07	-3.13E-07	-3.28E-07	-3.27E-07	-3.15E-07
573	-2.98E-07	-3.00E-07	-3.07E-07	-3.13E-07	-3.28E-07	-3.27E-07	-3.15E-07
574	-2.96E-07	-3.00E-07	-3.05E-07	-3.12E-07	-3.28E-07	-3.27E-07	-3.15E-07
584	-3.12E-07	-3.10E-07	-3.11E-07	-3.11E-07	-3.14E-07	-3.15E-07	-3.14E-07
585	-3.14E-07	-3.16E-07	-3.11E-07	-3.14E-07	-3.14E-07	-3.18E-07	-3.16E-07
<b>Biased Statistics</b>							
Average Biased	-3.08E-07	-3.19E-07	-3.26E-07	-3.31E-07	-3.44E-07	-3.45E-07	-3.28E-07
Std Dev Biased	2.07E-08	2.21E-08	2.30E-08	2.34E-08	2.31E-08	2.41E-08	2.15E-08
Ps90%/90% (+KTL) Biased	-2.51E-07	-2.58E-07	-2.63E-07	-2.66E-07	-2.81E-07	-2.79E-07	-2.69E-07
Ps90%/90% (-KTL) Biased	-3.64E-07	-3.79E-07	-3.89E-07	-3.95E-07	-4.08E-07	-4.11E-07	-3.87E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.02E-07	-3.06E-07	-3.12E-07	-3.18E-07	-3.34E-07	-3.33E-07	-3.20E-07
Std Dev Un-Biased	8.50E-09	8.88E-09	8.94E-09	9.10E-09	1.06E-08	1.05E-08	8.58E-09
Ps90%/90% (+KTL) Un-Biased	-2.79E-07	-2.81E-07	-2.88E-07	-2.93E-07	-3.05E-07	-3.04E-07	-2.97E-07
Ps90%/90% (-KTL) Un-Biased	-3.25E-07	-3.30E-07	-3.37E-07	-3.43E-07	-3.63E-07	-3.62E-07	-3.44E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

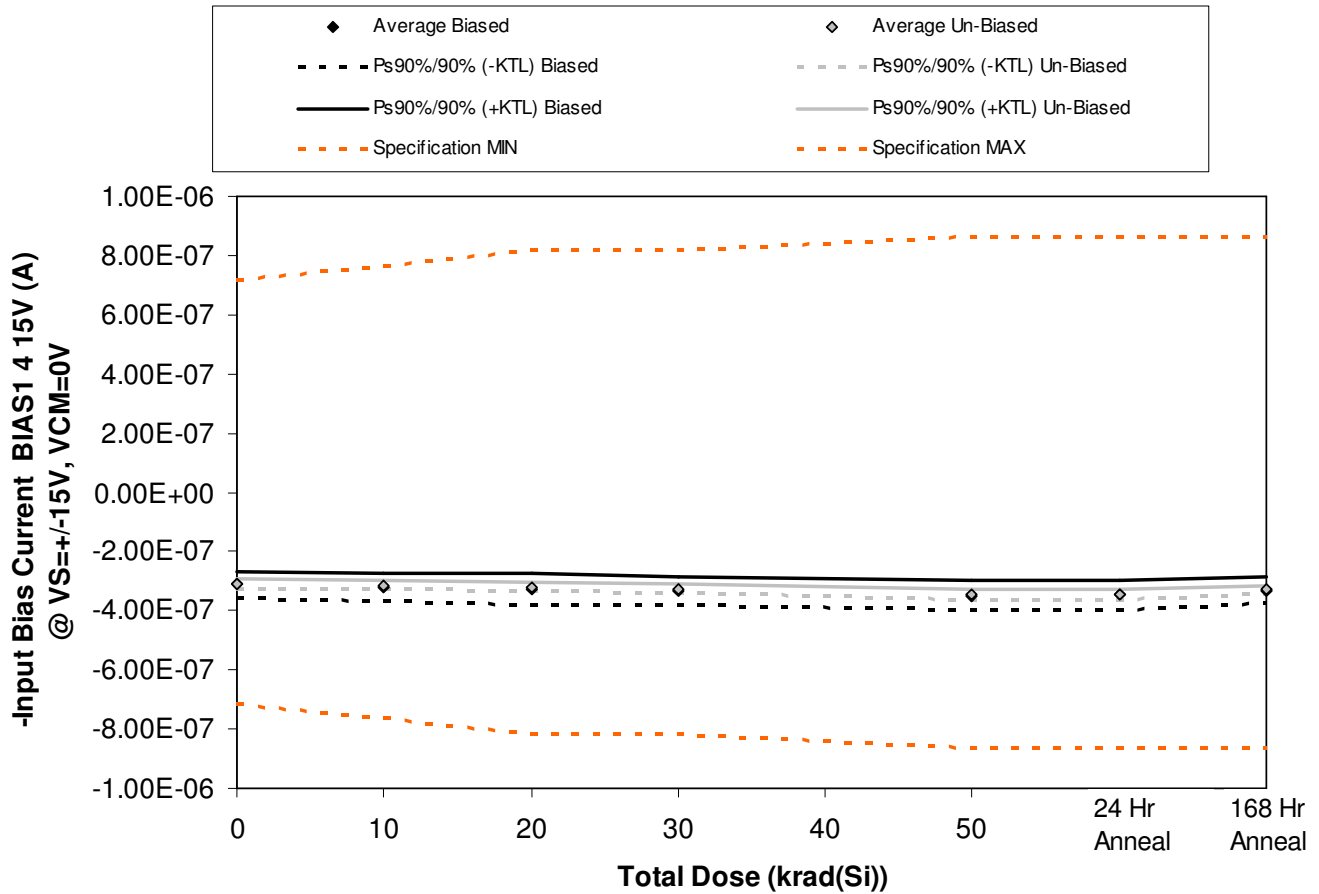


Figure 5.18. Plot of -Input Bias Current BIAS1 4 15V (A) @ VS=+-15V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.18. Raw data for -Input Bias Current BIAS1 4 15V (A) @ VS=+/-15V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS1 4 15V (A) @ VS=+/-15V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.87E-07	-2.95E-07	-3.02E-07	-3.07E-07	-3.22E-07	-3.21E-07	-3.08E-07
563	-3.05E-07	-3.16E-07	-3.23E-07	-3.27E-07	-3.41E-07	-3.40E-07	-3.24E-07
564	-3.19E-07	-3.32E-07	-3.38E-07	-3.40E-07	-3.58E-07	-3.58E-07	-3.39E-07
567	-3.30E-07	-3.40E-07	-3.54E-07	-3.56E-07	-3.68E-07	-3.69E-07	-3.52E-07
569	-3.11E-07	-3.24E-07	-3.32E-07	-3.36E-07	-3.55E-07	-3.52E-07	-3.32E-07
570	-3.16E-07	-3.19E-07	-3.25E-07	-3.31E-07	-3.48E-07	-3.48E-07	-3.32E-07
571	-3.07E-07	-3.11E-07	-3.18E-07	-3.25E-07	-3.40E-07	-3.40E-07	-3.26E-07
572	-3.05E-07	-3.10E-07	-3.16E-07	-3.23E-07	-3.39E-07	-3.39E-07	-3.26E-07
573	-3.18E-07	-3.20E-07	-3.27E-07	-3.34E-07	-3.53E-07	-3.53E-07	-3.36E-07
574	-3.07E-07	-3.10E-07	-3.16E-07	-3.23E-07	-3.38E-07	-3.37E-07	-3.24E-07
584	-2.78E-07	-2.77E-07	-2.78E-07	-2.78E-07	-2.80E-07	-2.82E-07	-2.81E-07
585	-2.90E-07	-2.91E-07	-2.87E-07	-2.90E-07	-2.90E-07	-2.94E-07	-2.92E-07
<b>Biased Statistics</b>							
Average Biased	-3.10E-07	-3.22E-07	-3.30E-07	-3.33E-07	-3.49E-07	-3.48E-07	-3.31E-07
Std Dev Biased	1.60E-08	1.72E-08	1.92E-08	1.81E-08	1.79E-08	1.83E-08	1.64E-08
Ps90%/90% (+KTL) Biased	-2.66E-07	-2.74E-07	-2.77E-07	-2.84E-07	-3.00E-07	-2.98E-07	-2.86E-07
Ps90%/90% (-KTL) Biased	-3.54E-07	-3.69E-07	-3.83E-07	-3.83E-07	-3.98E-07	-3.98E-07	-3.76E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.11E-07	-3.14E-07	-3.20E-07	-3.27E-07	-3.44E-07	-3.43E-07	-3.29E-07
Std Dev Un-Biased	5.96E-09	5.27E-09	5.51E-09	5.25E-09	6.59E-09	6.77E-09	4.96E-09
Ps90%/90% (+KTL) Un-Biased	-2.94E-07	-3.00E-07	-3.05E-07	-3.13E-07	-3.26E-07	-3.25E-07	-3.15E-07
Ps90%/90% (-KTL) Un-Biased	-3.27E-07	-3.29E-07	-3.36E-07	-3.41E-07	-3.62E-07	-3.62E-07	-3.42E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



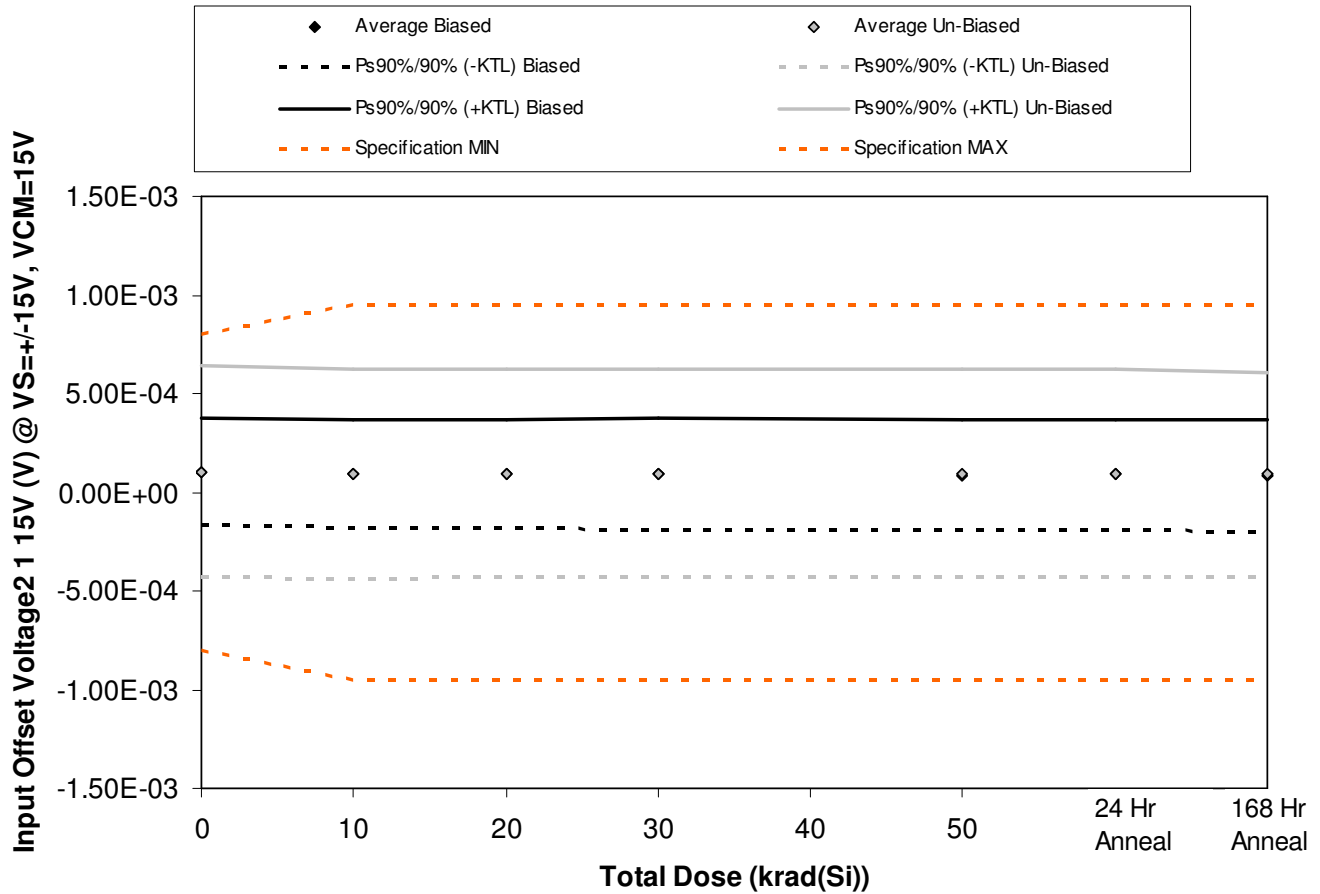


Figure 5.19. Plot of Input Offset Voltage2 1 15V (V) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.19. Raw data for Input Offset Voltage2 1 15V (V) @ VS=+-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage2 1 15V (V) @ VS=+-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	8.45E-05	7.25E-05	6.92E-05	6.52E-05	5.48E-05	5.85E-05	6.01E-05
563	-1.02E-05	-1.72E-05	-1.98E-05	-2.22E-05	-2.48E-05	-2.29E-05	-3.12E-05
564	2.28E-04	2.19E-04	2.18E-04	2.20E-04	2.16E-04	2.16E-04	2.14E-04
567	3.57E-05	2.40E-05	1.92E-05	1.88E-05	1.87E-05	2.13E-05	1.61E-05
569	1.80E-04	1.70E-04	1.73E-04	1.75E-04	1.72E-04	1.74E-04	1.68E-04
570	1.58E-04	1.49E-04	1.49E-04	1.48E-04	1.44E-04	1.46E-04	1.37E-04
571	-7.94E-05	-8.51E-05	-8.16E-05	-8.24E-05	-8.00E-05	-7.93E-05	-8.25E-05
572	4.02E-04	3.93E-04	3.93E-04	3.92E-04	3.92E-04	3.94E-04	3.82E-04
573	-5.96E-05	-6.44E-05	-6.30E-05	-6.50E-05	-6.44E-05	-6.33E-05	-7.11E-05
574	8.84E-05	8.07E-05	8.30E-05	8.14E-05	7.88E-05	7.90E-05	8.18E-05
584	-2.62E-04	-2.59E-04	-2.58E-04	-2.57E-04	-2.58E-04	-2.58E-04	-2.56E-04
585	2.31E-04	2.33E-04	2.37E-04	2.34E-04	2.36E-04	2.32E-04	2.34E-04
<b>Biased Statistics</b>							
Average Biased	1.04E-04	9.38E-05	9.20E-05	9.13E-05	8.73E-05	8.92E-05	8.55E-05
Std Dev Biased	9.90E-05	9.90E-05	1.01E-04	1.03E-04	1.03E-04	1.01E-04	1.03E-04
Ps90%/90% (+KTL) Biased	3.75E-04	3.65E-04	3.69E-04	3.73E-04	3.69E-04	3.67E-04	3.68E-04
Ps90%/90% (-KTL) Biased	-1.68E-04	-1.78E-04	-1.85E-04	-1.91E-04	-1.94E-04	-1.89E-04	-1.97E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.02E-04	9.46E-05	9.62E-05	9.48E-05	9.42E-05	9.52E-05	8.95E-05
Std Dev Un-Biased	1.95E-04	1.94E-04	1.92E-04	1.93E-04	1.92E-04	1.92E-04	1.89E-04
Ps90%/90% (+KTL) Un-Biased	6.37E-04	6.25E-04	6.24E-04	6.23E-04	6.20E-04	6.22E-04	6.09E-04
Ps90%/90% (-KTL) Un-Biased	-4.33E-04	-4.36E-04	-4.32E-04	-4.33E-04	-4.31E-04	-4.31E-04	-4.29E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

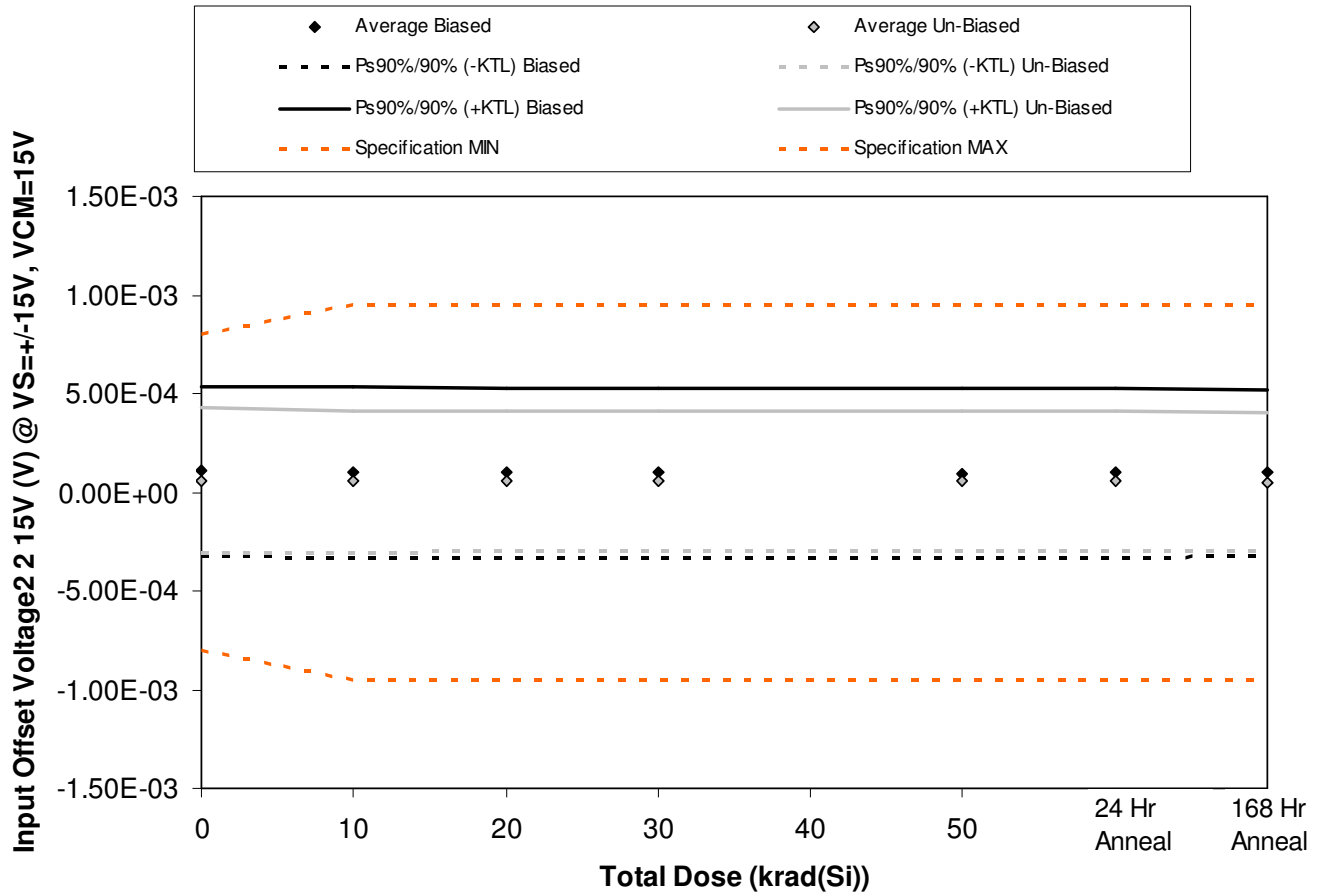


Figure 5.20. Plot of Input Offset Voltage2 2 15V (V) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.20. Raw data for Input Offset Voltage2 2 15V (V) @ VS=+-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage2 2 15V (V) @ VS=+-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.94E-05	4.88E-05	4.67E-05	4.63E-05	4.26E-05	4.41E-05	4.35E-05
563	-9.16E-05	-9.82E-05	-9.88E-05	-1.01E-04	-1.02E-04	-9.74E-05	-1.01E-04
564	1.51E-04	1.44E-04	1.46E-04	1.45E-04	1.40E-04	1.43E-04	1.44E-04
567	8.41E-05	7.84E-05	7.61E-05	7.66E-05	7.34E-05	7.39E-05	7.99E-05
569	3.38E-04	3.34E-04	3.30E-04	3.29E-04	3.26E-04	3.29E-04	3.22E-04
570	-3.28E-05	-3.76E-05	-3.71E-05	-3.73E-05	-3.52E-05	-3.21E-05	-3.73E-05
571	8.96E-05	8.69E-05	8.70E-05	8.92E-05	8.86E-05	9.41E-05	7.95E-05
572	2.47E-04	2.35E-04	2.32E-04	2.30E-04	2.26E-04	2.30E-04	2.23E-04
573	1.03E-04	1.00E-04	1.03E-04	1.03E-04	1.08E-04	1.07E-04	9.89E-05
574	-1.02E-04	-1.03E-04	-1.02E-04	-1.03E-04	-1.03E-04	-1.00E-04	-1.01E-04
584	8.57E-05	8.83E-05	8.82E-05	9.00E-05	8.89E-05	9.07E-05	9.12E-05
585	3.15E-04	3.17E-04	3.19E-04	3.16E-04	3.21E-04	3.14E-04	3.18E-04
<b>Biased Statistics</b>							
Average Biased	1.08E-04	1.01E-04	9.98E-05	9.92E-05	9.61E-05	9.86E-05	9.75E-05
Std Dev Biased	1.56E-04	1.57E-04	1.56E-04	1.57E-04	1.56E-04	1.56E-04	1.54E-04
Ps90%/90% (+KTL) Biased	5.37E-04	5.32E-04	5.28E-04	5.29E-04	5.24E-04	5.26E-04	5.21E-04
Ps90%/90% (-KTL) Biased	-3.20E-04	-3.30E-04	-3.29E-04	-3.31E-04	-3.32E-04	-3.29E-04	-3.26E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.11E-05	5.63E-05	5.66E-05	5.64E-05	5.69E-05	5.98E-05	5.27E-05
Std Dev Un-Biased	1.35E-04	1.31E-04	1.30E-04	1.30E-04	1.29E-04	1.29E-04	1.26E-04
Ps90%/90% (+KTL) Un-Biased	4.30E-04	4.16E-04	4.14E-04	4.13E-04	4.10E-04	4.13E-04	3.98E-04
Ps90%/90% (-KTL) Un-Biased	-3.08E-04	-3.03E-04	-3.01E-04	-3.01E-04	-2.96E-04	-2.93E-04	-2.93E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

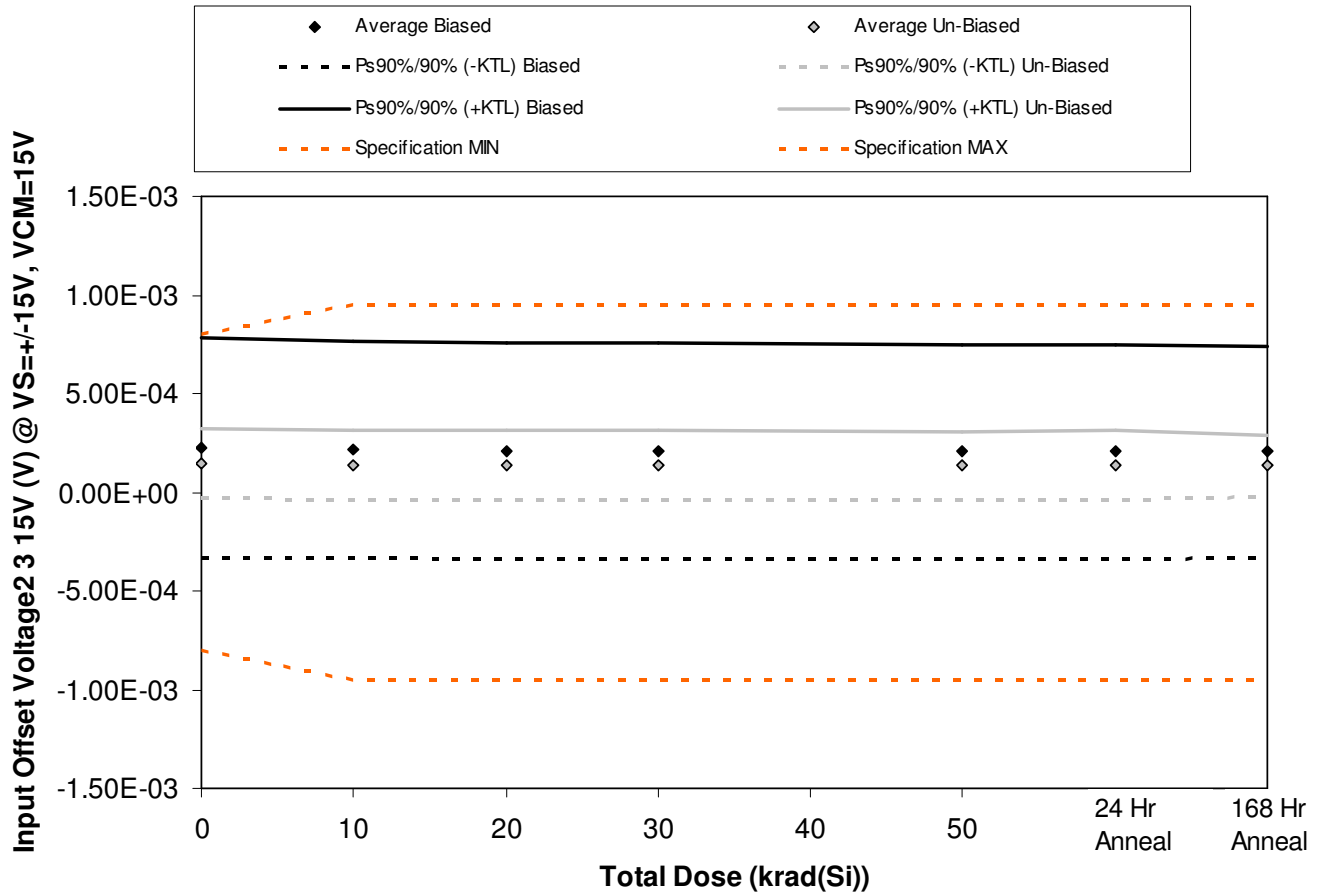


Figure 5.21. Plot of Input Offset Voltage2 3 15V (V) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.21. Raw data for Input Offset Voltage2 3 15V (V) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage2 3 15V (V) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.47E-04	5.35E-04	5.31E-04	5.27E-04	5.23E-04	5.23E-04	5.17E-04
563	1.68E-04	1.60E-04	1.59E-04	1.57E-04	1.56E-04	1.59E-04	1.61E-04
564	2.16E-04	2.09E-04	2.04E-04	2.05E-04	2.00E-04	2.00E-04	1.92E-04
567	2.00E-04	1.92E-04	1.86E-04	1.85E-04	1.81E-04	1.82E-04	1.75E-04
569	-1.24E-05	-1.75E-05	-2.18E-05	-2.46E-05	-2.72E-05	-2.71E-05	-2.68E-05
570	1.64E-04	1.57E-04	1.56E-04	1.55E-04	1.51E-04	1.52E-04	1.40E-04
571	9.88E-05	9.07E-05	9.11E-05	9.07E-05	8.65E-05	8.80E-05	9.27E-05
572	2.33E-04	2.27E-04	2.23E-04	2.21E-04	2.19E-04	2.20E-04	2.07E-04
573	1.68E-04	1.64E-04	1.63E-04	1.63E-04	1.60E-04	1.62E-04	1.64E-04
574	6.46E-05	6.10E-05	6.07E-05	5.76E-05	5.78E-05	5.95E-05	6.36E-05
584	3.99E-04	4.03E-04	4.04E-04	4.05E-04	4.06E-04	4.04E-04	4.05E-04
585	1.79E-04	1.82E-04	1.81E-04	1.81E-04	1.85E-04	1.79E-04	1.81E-04
<b>Biased Statistics</b>							
Average Biased	2.24E-04	2.16E-04	2.12E-04	2.10E-04	2.07E-04	2.07E-04	2.04E-04
Std Dev Biased	2.02E-04	2.00E-04	2.00E-04	1.99E-04	1.99E-04	1.98E-04	1.96E-04
Ps90%/90% (+KTL) Biased	7.79E-04	7.64E-04	7.61E-04	7.57E-04	7.52E-04	7.51E-04	7.42E-04
Ps90%/90% (-KTL) Biased	-3.31E-04	-3.33E-04	-3.37E-04	-3.37E-04	-3.39E-04	-3.37E-04	-3.34E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.46E-04	1.40E-04	1.39E-04	1.37E-04	1.35E-04	1.36E-04	1.34E-04
Std Dev Un-Biased	6.57E-05	6.52E-05	6.38E-05	6.42E-05	6.38E-05	6.36E-05	5.70E-05
Ps90%/90% (+KTL) Un-Biased	3.26E-04	3.19E-04	3.14E-04	3.13E-04	3.10E-04	3.11E-04	2.90E-04
Ps90%/90% (-KTL) Un-Biased	-3.44E-05	-3.91E-05	-3.63E-05	-3.86E-05	-3.99E-05	-3.81E-05	-2.26E-05
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

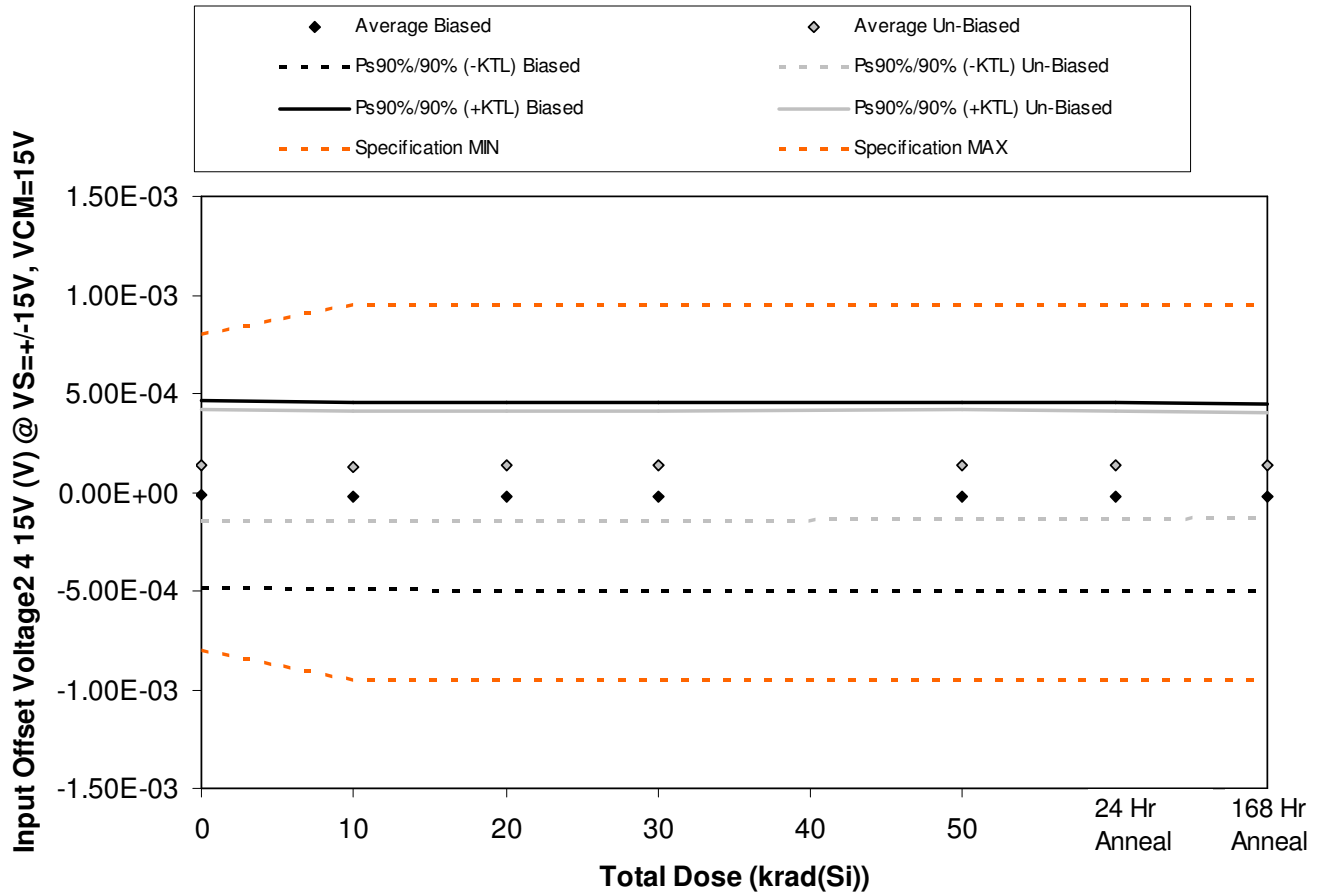


Figure 5.22. Plot of Input Offset Voltage2 4 15V (V) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.22. Raw data for Input Offset Voltage2 4 15V (V) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage2 4 15V (V) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.06E-04	-2.15E-04	-2.17E-04	-2.19E-04	-2.22E-04	-2.20E-04	-2.14E-04
563	1.16E-04	1.07E-04	1.05E-04	1.05E-04	1.01E-04	1.02E-04	1.06E-04
564	1.17E-04	1.09E-04	1.08E-04	1.09E-04	1.05E-04	1.04E-04	9.29E-05
567	1.11E-04	1.05E-04	1.05E-04	1.05E-04	1.04E-04	1.05E-04	9.81E-05
569	-1.95E-04	-2.03E-04	-2.05E-04	-2.08E-04	-2.06E-04	-2.04E-04	-2.14E-04
570	1.22E-04	1.16E-04	1.17E-04	1.22E-04	1.29E-04	1.28E-04	1.26E-04
571	3.10E-04	3.01E-04	3.03E-04	3.04E-04	3.05E-04	3.05E-04	2.95E-04
572	9.69E-05	9.05E-05	9.04E-05	9.28E-05	9.34E-05	9.63E-05	9.43E-05
573	1.29E-04	1.23E-04	1.26E-04	1.28E-04	1.31E-04	1.30E-04	1.25E-04
574	3.59E-05	2.94E-05	3.16E-05	3.17E-05	3.13E-05	3.51E-05	3.31E-05
584	3.07E-04	3.10E-04	3.10E-04	3.11E-04	3.09E-04	3.07E-04	3.09E-04
585	4.52E-06	1.31E-05	1.50E-05	1.33E-05	1.62E-05	1.33E-05	1.26E-05
<b>Biased Statistics</b>							
Average Biased	-1.14E-05	-1.93E-05	-2.06E-05	-2.16E-05	-2.37E-05	-2.25E-05	-2.64E-05
Std Dev Biased	1.73E-04	1.73E-04	1.74E-04	1.75E-04	1.74E-04	1.73E-04	1.72E-04
Ps90%/90% (+KTL) Biased	4.62E-04	4.55E-04	4.56E-04	4.58E-04	4.54E-04	4.52E-04	4.45E-04
Ps90%/90% (-KTL) Biased	-4.85E-04	-4.94E-04	-4.97E-04	-5.02E-04	-5.01E-04	-4.97E-04	-4.97E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.39E-04	1.32E-04	1.34E-04	1.36E-04	1.38E-04	1.39E-04	1.35E-04
Std Dev Un-Biased	1.03E-04	1.01E-04	1.02E-04	1.02E-04	1.02E-04	1.00E-04	9.71E-05
Ps90%/90% (+KTL) Un-Biased	4.20E-04	4.10E-04	4.12E-04	4.15E-04	4.17E-04	4.14E-04	4.01E-04
Ps90%/90% (-KTL) Un-Biased	-1.42E-04	-1.46E-04	-1.45E-04	-1.43E-04	-1.41E-04	-1.37E-04	-1.32E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



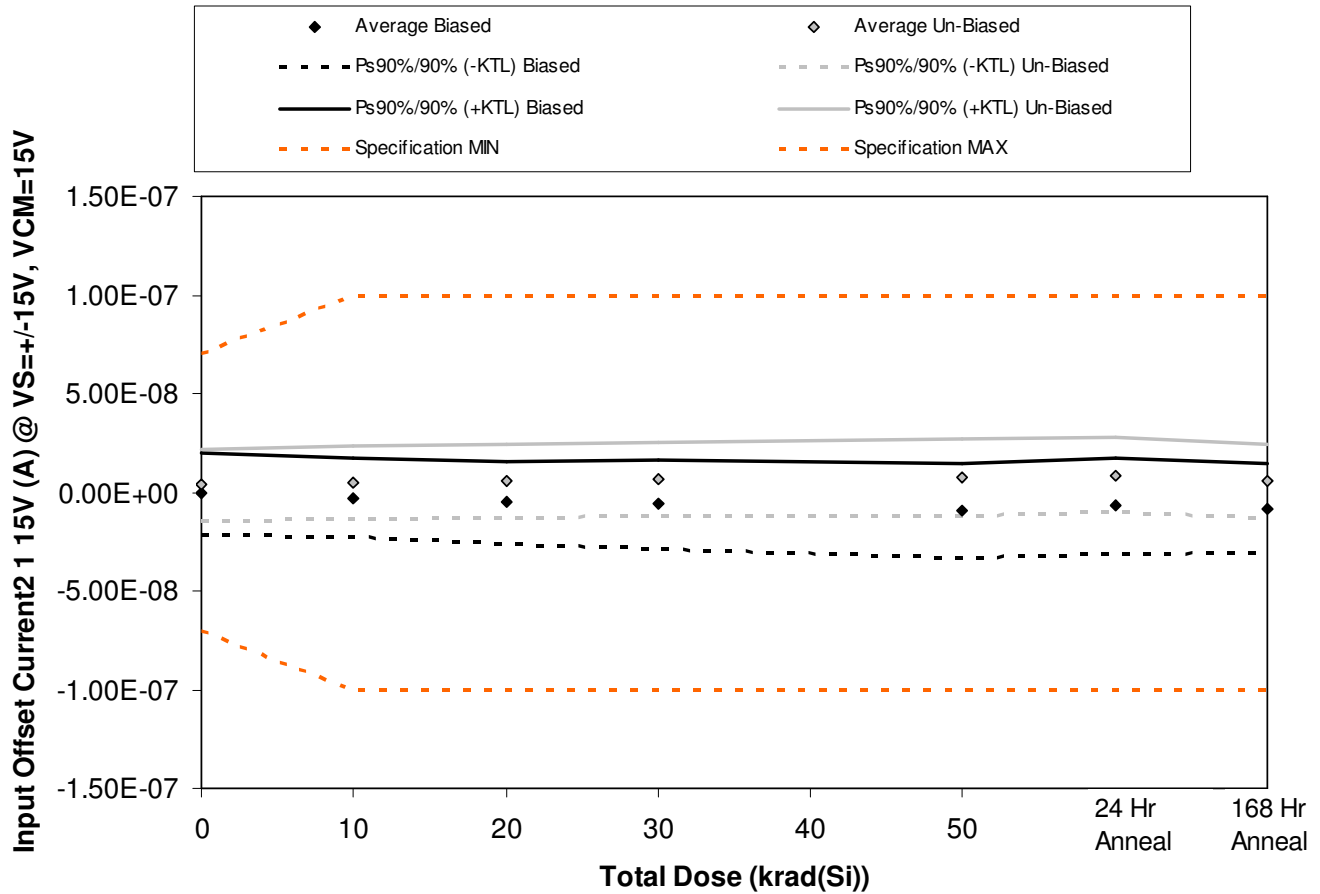


Figure 5.23. Plot of Input Offset Current2 1 15V (A) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.23. Raw data for Input Offset Current2 1 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current2 1 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-9.12E-09	-1.07E-08	-1.32E-08	-1.53E-08	-2.14E-08	-1.85E-08	-1.84E-08
563	-8.70E-10	-2.82E-09	-5.42E-09	-7.14E-09	-9.86E-09	-7.84E-09	-9.04E-09
564	-3.13E-09	-4.97E-09	-7.58E-09	-7.61E-09	-8.84E-09	-7.38E-09	-9.07E-09
567	-2.00E-09	-4.40E-09	-6.62E-09	-7.69E-09	-1.01E-08	-7.78E-09	-8.97E-09
569	1.15E-08	9.29E-09	7.28E-09	7.31E-09	3.48E-09	6.56E-09	4.93E-09
570	-1.01E-09	1.00E-11	5.80E-10	8.10E-10	6.30E-10	2.71E-09	1.30E-10
571	1.09E-08	1.27E-08	1.40E-08	1.47E-08	1.60E-08	1.77E-08	1.36E-08
572	-1.13E-09	1.00E-09	1.82E-09	2.60E-09	3.62E-09	4.74E-09	2.88E-09
573	-1.50E-09	-9.00E-10	1.50E-10	1.14E-09	3.06E-09	3.83E-09	3.00E-10
574	1.07E-08	1.18E-08	1.22E-08	1.32E-08	1.41E-08	1.49E-08	1.32E-08
584	-9.30E-10	2.21E-09	3.53E-09	4.59E-09	4.98E-09	5.70E-09	6.64E-09
585	9.40E-10	5.93E-09	7.11E-09	7.05E-09	6.80E-09	6.54E-09	7.25E-09
<b>Biased Statistics</b>							
Average Biased	-7.22E-10	-2.72E-09	-5.10E-09	-6.09E-09	-9.34E-09	-6.99E-09	-8.10E-09
Std Dev Biased	7.54E-09	7.34E-09	7.53E-09	8.23E-09	8.81E-09	8.91E-09	8.33E-09
Ps90%/90% (+KTL) Biased	2.00E-08	1.74E-08	1.55E-08	1.65E-08	1.48E-08	1.74E-08	1.47E-08
Ps90%/90% (-KTL) Biased	-2.14E-08	-2.28E-08	-2.57E-08	-2.87E-08	-3.35E-08	-3.14E-08	-3.10E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.58E-09	4.92E-09	5.73E-09	6.49E-09	7.47E-09	8.78E-09	6.02E-09
Std Dev Un-Biased	6.57E-09	6.73E-09	6.75E-09	6.86E-09	7.02E-09	6.99E-09	6.82E-09
Ps90%/90% (+KTL) Un-Biased	2.16E-08	2.34E-08	2.42E-08	2.53E-08	2.67E-08	2.79E-08	2.47E-08
Ps90%/90% (-KTL) Un-Biased	-1.44E-08	-1.35E-08	-1.28E-08	-1.23E-08	-1.18E-08	-1.04E-08	-1.27E-08
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

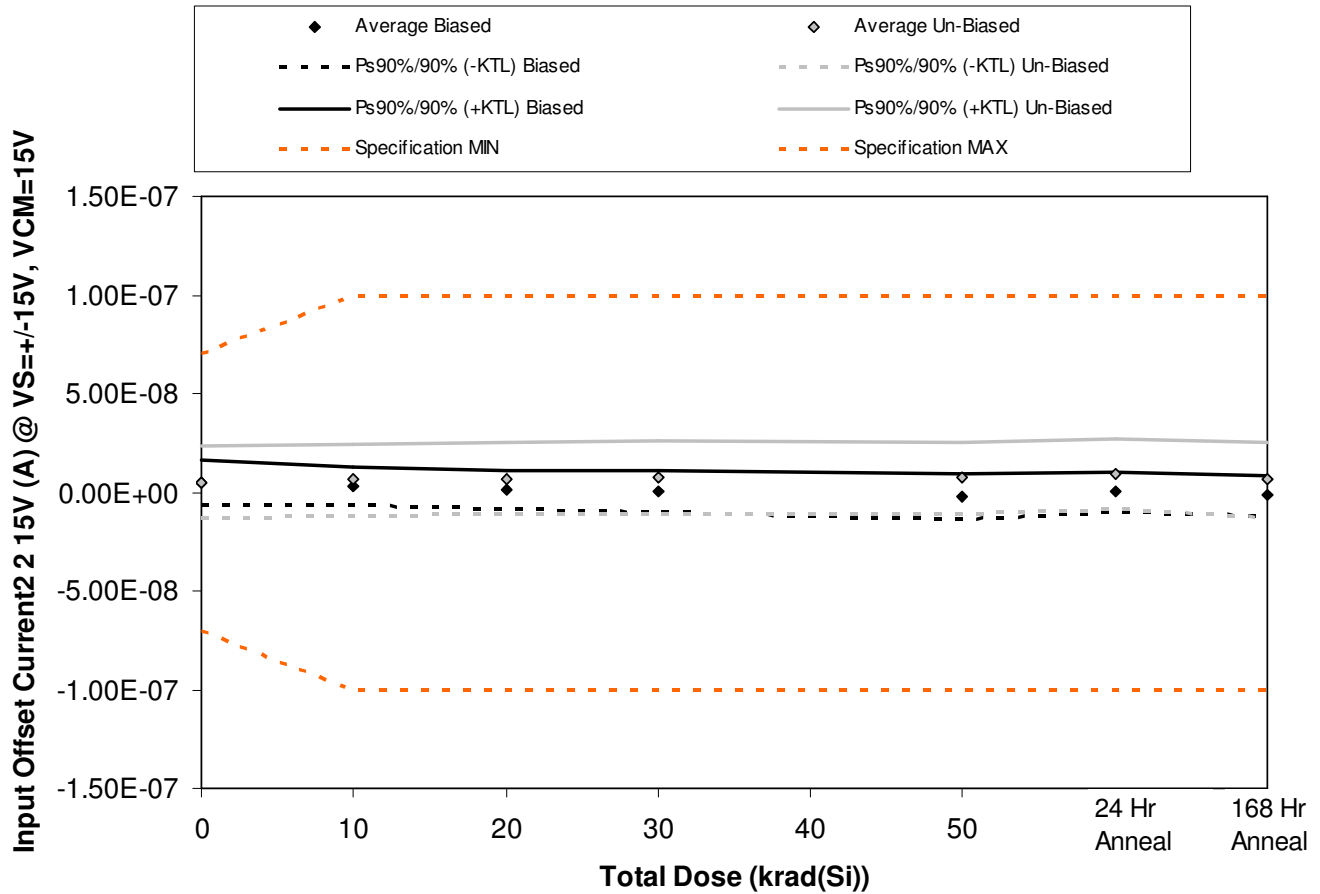


Figure 5.24. Plot of Input Offset Current2 2 15V (A) @ VS=±15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.24. Raw data for Input Offset Current2 2 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current2 2 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.23E-09	3.90E-09	2.02E-09	2.70E-10	-2.00E-09	-4.20E-10	-1.44E-09
563	1.74E-09	9.70E-10	-6.10E-10	-2.27E-09	-4.10E-09	-2.14E-09	-4.15E-09
564	3.31E-09	1.41E-09	1.50E-10	-8.40E-10	-2.74E-09	-3.90E-10	-1.91E-09
567	1.21E-08	8.96E-09	6.96E-09	6.48E-09	4.85E-09	6.56E-09	4.19E-09
569	2.92E-09	7.00E-11	-2.12E-09	-3.41E-09	-6.04E-09	-2.93E-09	-5.05E-09
570	-2.03E-09	-1.37E-09	-9.90E-10	-9.70E-10	-3.80E-10	1.52E-09	-1.31E-09
571	5.25E-09	6.27E-09	6.43E-09	7.18E-09	5.92E-09	8.17E-09	6.18E-09
572	2.56E-09	4.23E-09	4.49E-09	4.43E-09	4.19E-09	6.48E-09	2.45E-09
573	4.86E-09	6.18E-09	7.22E-09	8.52E-09	9.19E-09	1.05E-08	7.08E-09
574	1.57E-08	1.69E-08	1.75E-08	1.78E-08	1.72E-08	1.93E-08	1.72E-08
584	2.64E-09	4.85E-09	6.33E-09	7.25E-09	7.59E-09	8.17E-09	9.35E-09
585	1.36E-08	1.90E-08	1.92E-08	1.91E-08	1.94E-08	1.95E-08	1.99E-08
<b>Biased Statistics</b>							
Average Biased	5.06E-09	3.06E-09	1.28E-09	4.60E-11	-2.01E-09	1.36E-10	-1.67E-09
Std Dev Biased	4.14E-09	3.59E-09	3.51E-09	3.86E-09	4.13E-09	3.76E-09	3.61E-09
Ps90%/90% (+KTL) Biased	1.64E-08	1.29E-08	1.09E-08	1.06E-08	9.32E-09	1.04E-08	8.22E-09
Ps90%/90% (-KTL) Biased	-6.28E-09	-6.78E-09	-8.34E-09	-1.05E-08	-1.33E-08	-1.02E-08	-1.16E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.26E-09	6.44E-09	6.93E-09	7.40E-09	7.22E-09	9.19E-09	6.32E-09
Std Dev Un-Biased	6.50E-09	6.62E-09	6.72E-09	6.87E-09	6.56E-09	6.53E-09	6.92E-09
Ps90%/90% (+KTL) Un-Biased	2.31E-08	2.46E-08	2.53E-08	2.62E-08	2.52E-08	2.71E-08	2.53E-08
Ps90%/90% (-KTL) Un-Biased	-1.26E-08	-1.17E-08	-1.15E-08	-1.14E-08	-1.08E-08	-8.71E-09	-1.27E-08
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

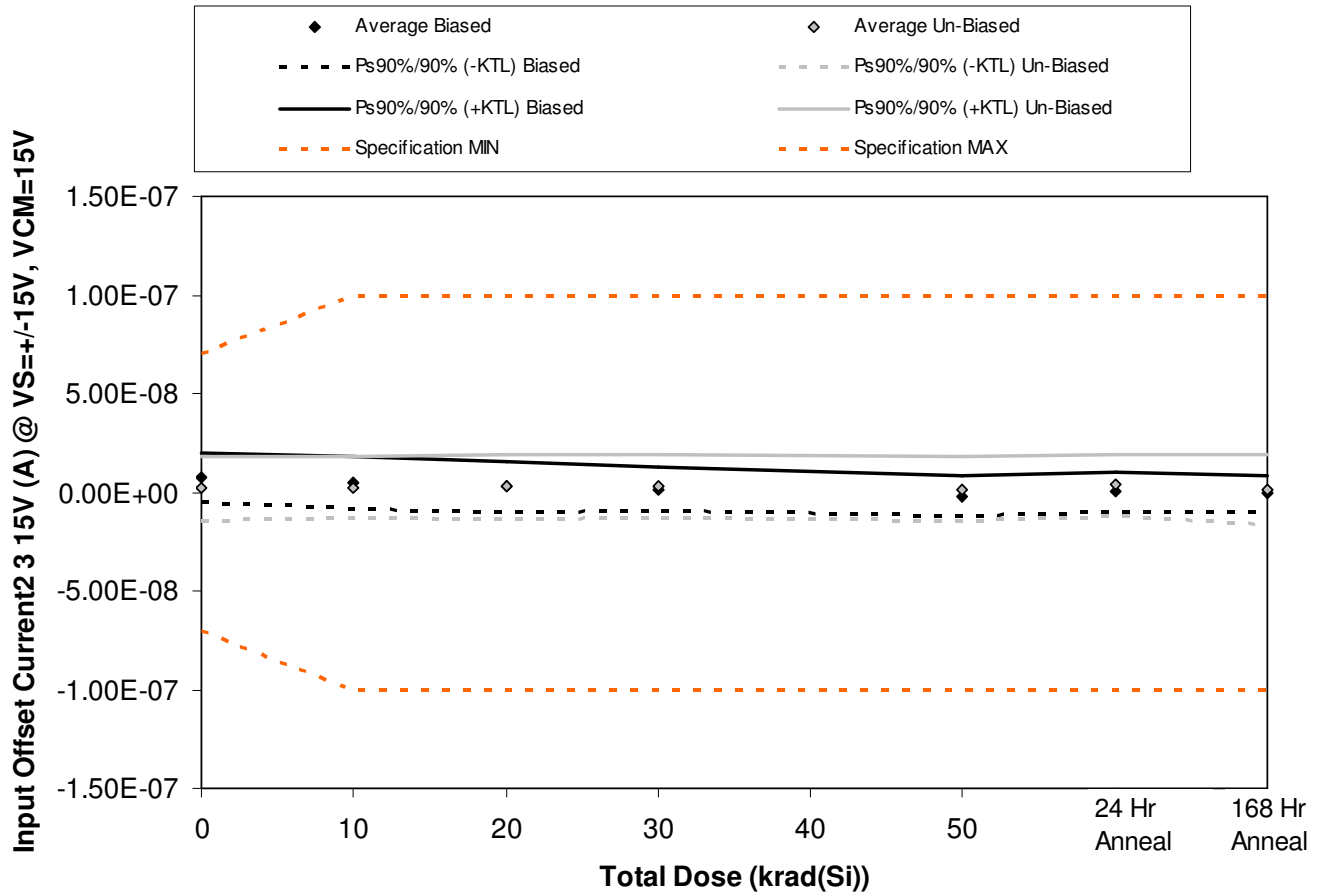


Figure 5.25. Plot of Input Offset Current2 3 15V (A) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.25. Raw data for Input Offset Current<sub>2 3 15V (A)</sub> @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current <sub>2 3 15V (A)</sub> @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.10E-08	1.01E-08	7.09E-09	4.79E-09	1.84E-09	3.04E-09	1.78E-09
563	5.99E-09	4.21E-09	3.58E-09	2.08E-09	-2.70E-10	1.25E-09	-1.36E-09
564	2.42E-09	-5.60E-10	-2.41E-09	-2.93E-09	-6.03E-09	-3.93E-09	-2.10E-09
567	4.05E-09	4.90E-10	-2.02E-09	-2.16E-09	-5.55E-09	-3.88E-09	-5.31E-09
569	1.33E-08	9.15E-09	7.08E-09	5.94E-09	1.10E-09	3.82E-09	2.89E-09
570	7.69E-09	8.38E-09	9.57E-09	1.00E-08	8.87E-09	1.06E-08	8.39E-09
571	4.87E-09	5.15E-09	5.57E-09	6.23E-09	4.21E-09	5.67E-09	4.33E-09
572	-7.59E-09	-6.04E-09	-6.11E-09	-4.78E-09	-6.58E-09	-4.06E-09	-8.41E-09
573	4.53E-09	4.64E-09	5.23E-09	5.38E-09	3.25E-09	5.79E-09	3.26E-09
574	-6.50E-10	-6.00E-11	6.20E-10	6.00E-11	-1.78E-09	2.60E-10	-1.18E-09
584	1.56E-08	1.78E-08	1.90E-08	1.96E-08	1.89E-08	2.01E-08	2.10E-08
585	6.08E-09	1.21E-08	1.24E-08	1.21E-08	1.06E-08	1.10E-08	1.16E-08
<b>Biased Statistics</b>							
Average Biased	7.33E-09	4.67E-09	2.66E-09	1.54E-09	-1.78E-09	6.00E-11	-8.20E-10
Std Dev Biased	4.60E-09	4.85E-09	4.68E-09	4.00E-09	3.74E-09	3.74E-09	3.26E-09
Ps90%/90% (+KTL) Biased	2.00E-08	1.80E-08	1.55E-08	1.25E-08	8.47E-09	1.03E-08	8.13E-09
Ps90%/90% (-KTL) Biased	-5.29E-09	-8.64E-09	-1.02E-08	-9.41E-09	-1.20E-08	-1.02E-08	-9.77E-09
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.77E-09	2.41E-09	2.98E-09	3.38E-09	1.59E-09	3.66E-09	1.28E-09
Std Dev Un-Biased	6.04E-09	5.60E-09	5.99E-09	5.78E-09	5.93E-09	5.66E-09	6.40E-09
Ps90%/90% (+KTL) Un-Biased	1.83E-08	1.78E-08	1.94E-08	1.92E-08	1.79E-08	1.92E-08	1.88E-08
Ps90%/90% (-KTL) Un-Biased	-1.48E-08	-1.30E-08	-1.34E-08	-1.25E-08	-1.47E-08	-1.19E-08	-1.63E-08
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

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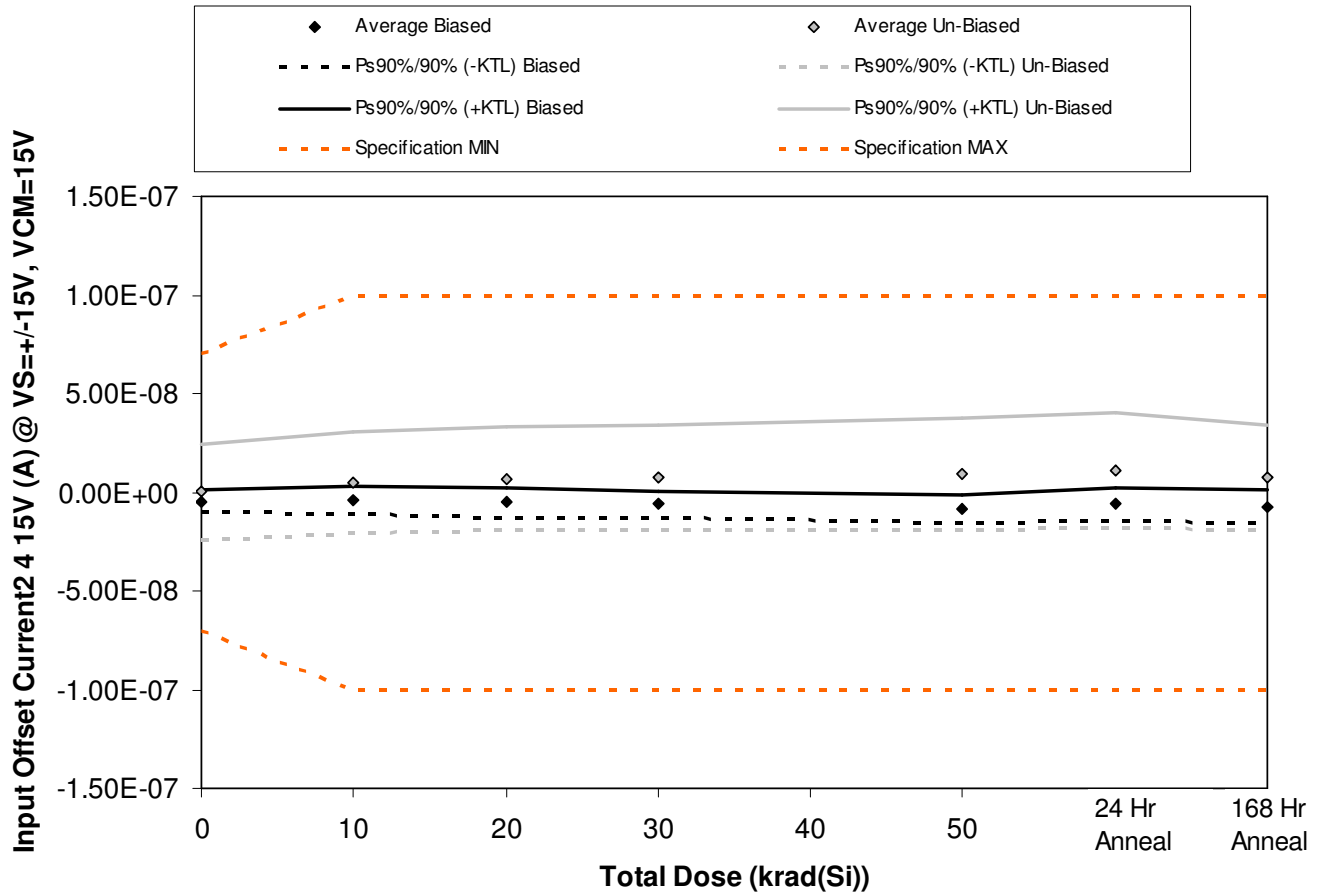


Figure 5.26. Plot of Input Offset Current2 4 15V (A) @ VS=±15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.26. Raw data for Input Offset Current2 4 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current2 4 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-4.46E-09	-2.21E-09	-3.42E-09	-4.74E-09	-8.64E-09	-6.48E-09	-7.54E-09
563	-5.78E-09	-4.45E-09	-5.50E-09	-6.32E-09	-9.23E-09	-7.11E-09	-7.11E-09
564	-2.98E-09	-2.52E-09	-4.19E-09	-4.95E-09	-6.83E-09	-4.60E-09	-5.91E-09
567	-2.11E-09	-1.83E-09	-3.07E-09	-3.99E-09	-4.94E-09	-2.23E-09	-3.69E-09
569	-7.44E-09	-7.95E-09	-9.99E-09	-9.94E-09	-1.21E-08	-1.03E-08	-1.18E-08
570	3.39E-09	7.37E-09	9.97E-09	1.09E-08	1.23E-08	1.38E-08	1.05E-08
571	-1.04E-08	-6.00E-09	-4.10E-09	-2.59E-09	-1.60E-09	6.50E-10	-3.25E-09
572	1.30E-08	1.89E-08	2.08E-08	2.25E-08	2.53E-08	2.76E-08	2.23E-08
573	-5.01E-09	-6.10E-10	9.00E-10	1.50E-09	3.09E-09	4.05E-09	1.00E-09
574	3.60E-10	4.73E-09	5.95E-09	5.63E-09	7.13E-09	9.23E-09	6.94E-09
584	-3.69E-09	2.33E-09	4.89E-09	6.33E-09	6.98E-09	7.58E-09	8.56E-09
585	-9.39E-09	8.40E-10	2.79E-09	3.16E-09	3.71E-09	2.99E-09	4.06E-09
<b>Biased Statistics</b>							
Average Biased	-4.55E-09	-3.79E-09	-5.23E-09	-5.99E-09	-8.34E-09	-6.14E-09	-7.20E-09
Std Dev Biased	2.14E-09	2.53E-09	2.82E-09	2.36E-09	2.68E-09	3.00E-09	2.95E-09
Ps90%/90% (+KTL) Biased	1.31E-09	3.16E-09	2.49E-09	4.94E-10	-9.98E-10	2.08E-09	8.89E-10
Ps90%/90% (-KTL) Biased	-1.04E-08	-1.07E-08	-1.30E-08	-1.25E-08	-1.57E-08	-1.44E-08	-1.53E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	2.62E-10	4.87E-09	6.71E-09	7.59E-09	9.24E-09	1.11E-08	7.50E-09
Std Dev Un-Biased	8.84E-09	9.36E-09	9.50E-09	9.72E-09	1.03E-08	1.05E-08	9.83E-09
Ps90%/90% (+KTL) Un-Biased	2.45E-08	3.05E-08	3.28E-08	3.42E-08	3.75E-08	3.99E-08	3.45E-08
Ps90%/90% (-KTL) Un-Biased	-2.40E-08	-2.08E-08	-1.93E-08	-1.91E-08	-1.90E-08	-1.77E-08	-1.95E-08
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



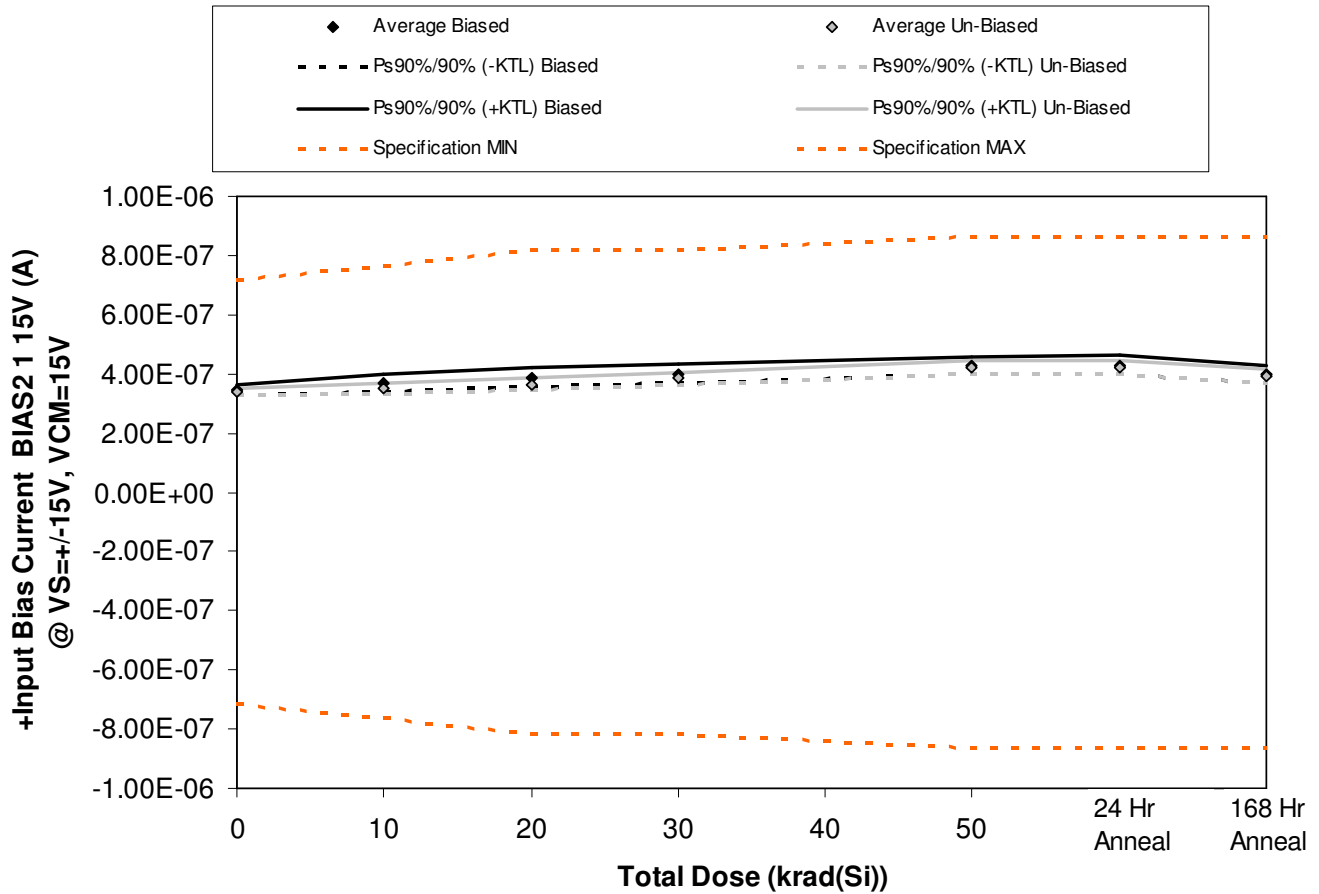


Figure 5.27. Plot of +Input Bias Current BIAS2 1 15V (A) @ VS=+/-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.27. Raw data for +Input Bias Current BIAS2 1 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS2 1 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.41E-07	3.54E-07	3.73E-07	3.88E-07	4.19E-07	4.19E-07	3.89E-07
563	3.38E-07	3.64E-07	3.81E-07	3.91E-07	4.22E-07	4.22E-07	3.90E-07
564	3.51E-07	3.77E-07	3.97E-07	4.08E-07	4.36E-07	4.37E-07	4.05E-07
567	3.40E-07	3.64E-07	3.85E-07	3.97E-07	4.23E-07	4.21E-07	3.92E-07
569	3.54E-07	3.82E-07	4.03E-07	4.16E-07	4.43E-07	4.45E-07	4.11E-07
570	3.38E-07	3.46E-07	3.62E-07	3.79E-07	4.16E-07	4.16E-07	3.87E-07
571	3.42E-07	3.53E-07	3.69E-07	3.88E-07	4.24E-07	4.26E-07	3.97E-07
572	3.47E-07	3.57E-07	3.75E-07	3.95E-07	4.33E-07	4.34E-07	4.07E-07
573	3.36E-07	3.41E-07	3.54E-07	3.74E-07	4.12E-07	4.12E-07	3.84E-07
574	3.44E-07	3.49E-07	3.64E-07	3.85E-07	4.21E-07	4.20E-07	3.94E-07
584	3.28E-07	3.31E-07	3.32E-07	3.33E-07	3.35E-07	3.37E-07	3.37E-07
585	3.46E-07	3.53E-07	3.49E-07	3.55E-07	3.57E-07	3.60E-07	3.55E-07
<b>Biased Statistics</b>							
Average Biased	3.45E-07	3.68E-07	3.88E-07	4.00E-07	4.29E-07	4.29E-07	3.97E-07
Std Dev Biased	7.20E-09	1.11E-08	1.22E-08	1.18E-08	1.03E-08	1.17E-08	1.02E-08
Ps90%/90% (+KTL) Biased	3.64E-07	3.98E-07	4.21E-07	4.33E-07	4.57E-07	4.61E-07	4.25E-07
Ps90%/90% (-KTL) Biased	3.25E-07	3.38E-07	3.55E-07	3.68E-07	4.01E-07	3.97E-07	3.70E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.41E-07	3.49E-07	3.65E-07	3.84E-07	4.21E-07	4.21E-07	3.93E-07
Std Dev Un-Biased	4.30E-09	6.27E-09	7.84E-09	8.00E-09	7.98E-09	8.79E-09	9.05E-09
Ps90%/90% (+KTL) Un-Biased	3.53E-07	3.67E-07	3.86E-07	4.06E-07	4.43E-07	4.45E-07	4.18E-07
Ps90%/90% (-KTL) Un-Biased	3.30E-07	3.32E-07	3.43E-07	3.62E-07	3.99E-07	3.97E-07	3.69E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

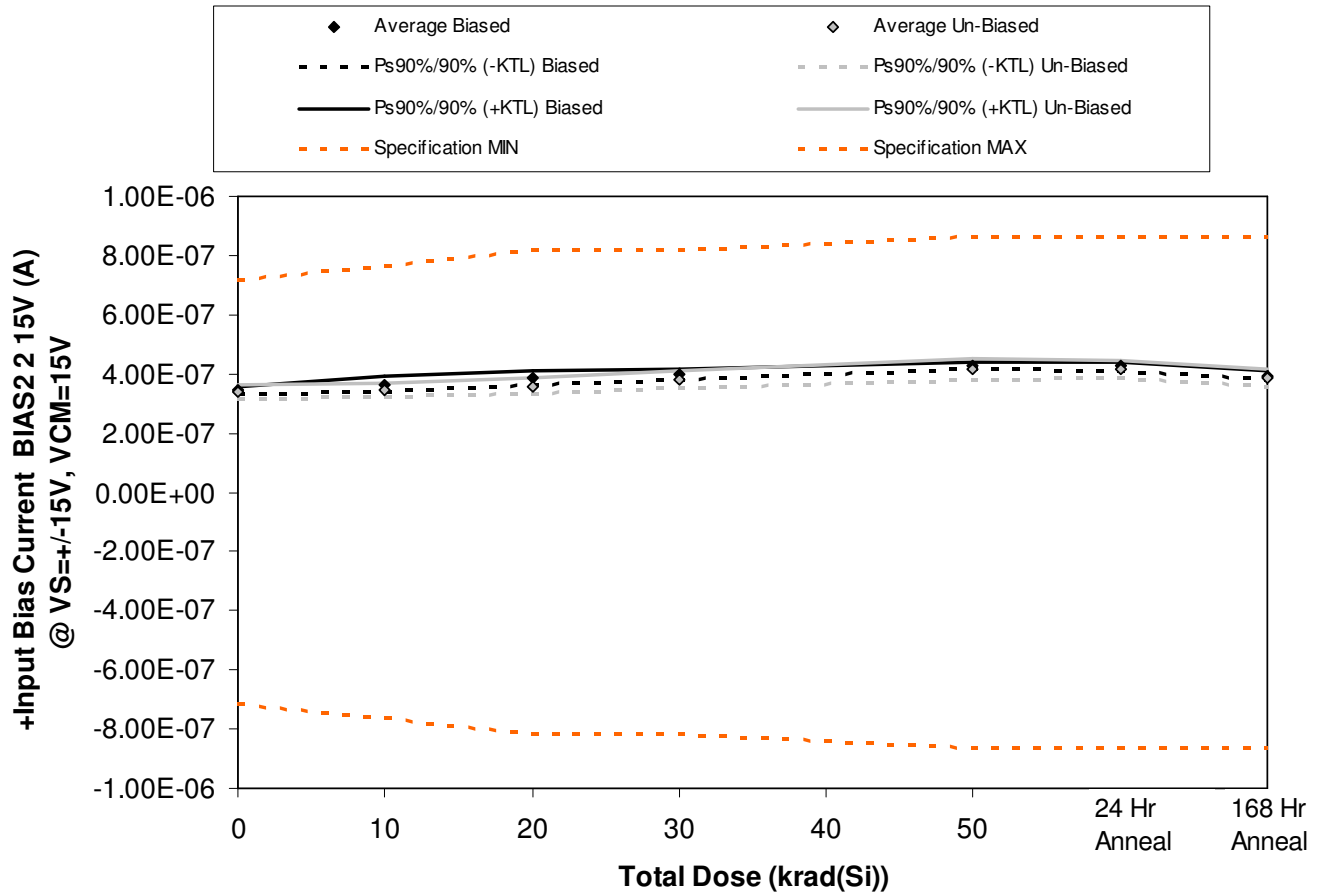


Figure 5.28. Plot of +Input Bias Current BIAS2 2 15V (A) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.28. Raw data for +Input Bias Current BIAS2 2 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS2 2 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.37E-07	3.50E-07	3.71E-07	3.87E-07	4.22E-07	4.19E-07	3.89E-07
563	3.45E-07	3.70E-07	3.87E-07	4.00E-07	4.25E-07	4.26E-07	3.96E-07
564	3.48E-07	3.73E-07	3.94E-07	4.05E-07	4.34E-07	4.35E-07	4.02E-07
567	3.45E-07	3.70E-07	3.89E-07	4.01E-07	4.28E-07	4.26E-07	3.96E-07
569	3.40E-07	3.64E-07	3.86E-07	3.98E-07	4.23E-07	4.25E-07	3.92E-07
570	3.41E-07	3.45E-07	3.61E-07	3.80E-07	4.17E-07	4.16E-07	3.89E-07
571	3.38E-07	3.44E-07	3.58E-07	3.77E-07	4.13E-07	4.13E-07	3.87E-07
572	3.37E-07	3.42E-07	3.58E-07	3.78E-07	4.14E-07	4.16E-07	3.86E-07
573	3.28E-07	3.33E-07	3.46E-07	3.64E-07	4.01E-07	3.99E-07	3.74E-07
574	3.51E-07	3.56E-07	3.74E-07	3.94E-07	4.34E-07	4.31E-07	4.04E-07
584	3.44E-07	3.48E-07	3.50E-07	3.49E-07	3.51E-07	3.51E-07	3.52E-07
585	3.53E-07	3.61E-07	3.58E-07	3.63E-07	3.64E-07	3.66E-07	3.62E-07
<b>Biased Statistics</b>							
Average Biased	3.43E-07	3.65E-07	3.85E-07	3.98E-07	4.26E-07	4.26E-07	3.95E-07
Std Dev Biased	4.57E-09	9.37E-09	8.50E-09	6.83E-09	4.72E-09	5.72E-09	5.03E-09
Ps90%/90% (+KTL) Biased	3.56E-07	3.91E-07	4.09E-07	4.17E-07	4.39E-07	4.42E-07	4.09E-07
Ps90%/90% (-KTL) Biased	3.31E-07	3.40E-07	3.62E-07	3.79E-07	4.13E-07	4.11E-07	3.81E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.39E-07	3.44E-07	3.59E-07	3.79E-07	4.16E-07	4.15E-07	3.88E-07
Std Dev Un-Biased	8.04E-09	8.27E-09	9.75E-09	1.06E-08	1.19E-08	1.15E-08	1.07E-08
Ps90%/90% (+KTL) Un-Biased	3.61E-07	3.67E-07	3.86E-07	4.08E-07	4.48E-07	4.47E-07	4.17E-07
Ps90%/90% (-KTL) Un-Biased	3.17E-07	3.21E-07	3.33E-07	3.50E-07	3.83E-07	3.84E-07	3.58E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

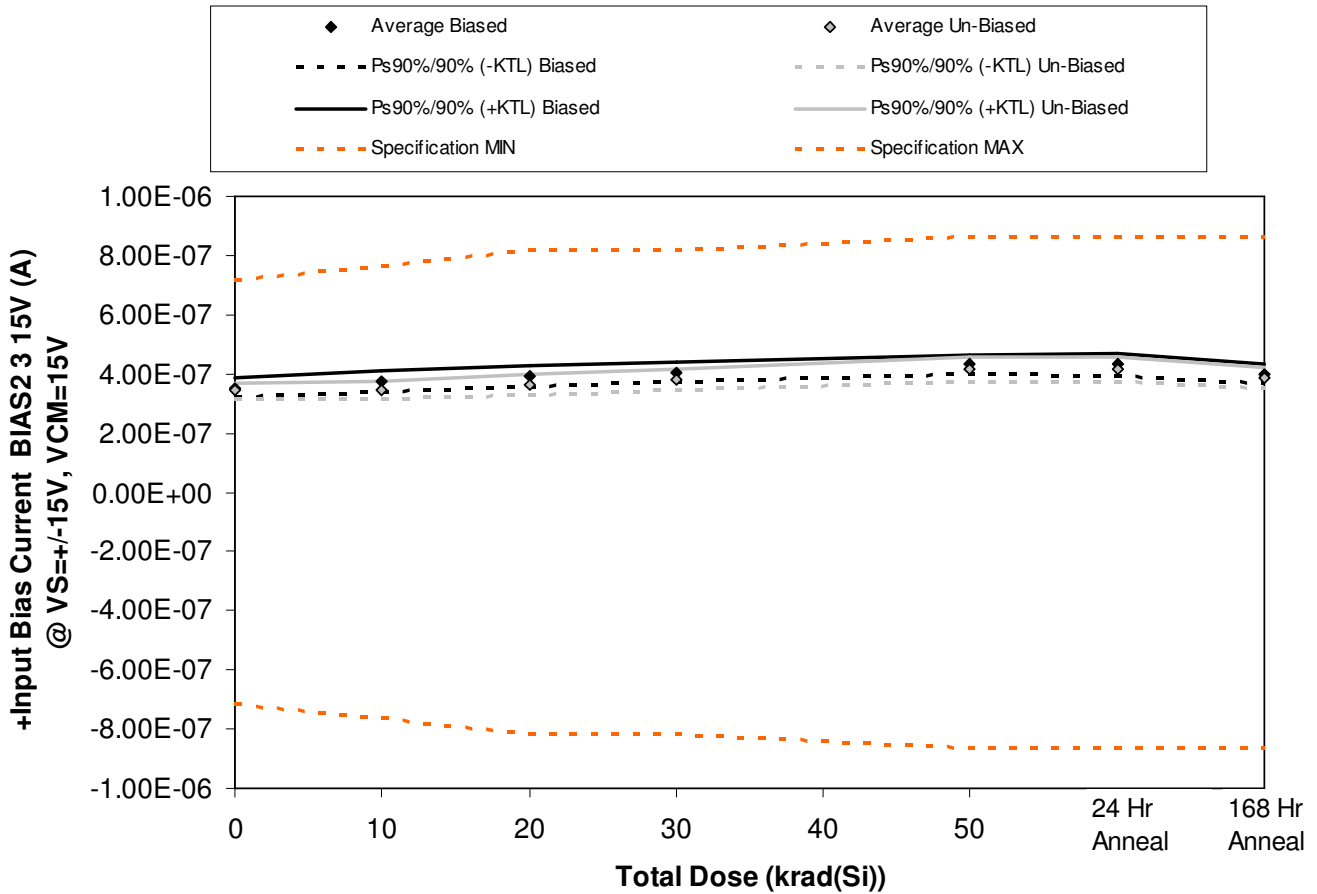


Figure 5.29. Plot of +Input Bias Current BIAS2 3 15V (A) @ VS=+/-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.29. Raw data for +Input Bias Current BIAS2 3 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS2 3 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.49E-07	3.62E-07	3.83E-07	3.96E-07	4.26E-07	4.26E-07	3.95E-07
563	3.59E-07	3.78E-07	3.95E-07	4.06E-07	4.35E-07	4.33E-07	4.02E-07
564	3.69E-07	3.93E-07	4.12E-07	4.21E-07	4.48E-07	4.49E-07	4.16E-07
567	3.38E-07	3.60E-07	3.79E-07	3.91E-07	4.14E-07	4.13E-07	3.83E-07
569	3.51E-07	3.76E-07	3.96E-07	4.08E-07	4.32E-07	4.33E-07	4.02E-07
570	3.46E-07	3.53E-07	3.67E-07	3.85E-07	4.20E-07	4.19E-07	3.91E-07
571	3.39E-07	3.41E-07	3.57E-07	3.73E-07	4.08E-07	4.07E-07	3.81E-07
572	3.43E-07	3.51E-07	3.67E-07	3.87E-07	4.20E-07	4.22E-07	3.92E-07
573	3.29E-07	3.31E-07	3.42E-07	3.61E-07	3.93E-07	3.92E-07	3.69E-07
574	3.55E-07	3.59E-07	3.75E-07	3.93E-07	4.35E-07	4.32E-07	4.05E-07
584	3.55E-07	3.57E-07	3.58E-07	3.57E-07	3.57E-07	3.58E-07	3.58E-07
585	3.57E-07	3.63E-07	3.58E-07	3.63E-07	3.64E-07	3.65E-07	3.60E-07
<b>Biased Statistics</b>							
Average Biased	3.53E-07	3.74E-07	3.93E-07	4.05E-07	4.31E-07	4.31E-07	4.00E-07
Std Dev Biased	1.14E-08	1.33E-08	1.30E-08	1.17E-08	1.25E-08	1.32E-08	1.19E-08
Ps90%/90% (+KTL) Biased	3.85E-07	4.10E-07	4.29E-07	4.37E-07	4.65E-07	4.67E-07	4.32E-07
Ps90%/90% (-KTL) Biased	3.22E-07	3.37E-07	3.57E-07	3.73E-07	3.97E-07	3.95E-07	3.67E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.42E-07	3.47E-07	3.62E-07	3.80E-07	4.15E-07	4.15E-07	3.87E-07
Std Dev Un-Biased	9.43E-09	1.09E-08	1.27E-08	1.30E-08	1.55E-08	1.53E-08	1.36E-08
Ps90%/90% (+KTL) Un-Biased	3.68E-07	3.77E-07	3.96E-07	4.15E-07	4.58E-07	4.57E-07	4.25E-07
Ps90%/90% (-KTL) Un-Biased	3.16E-07	3.17E-07	3.27E-07	3.44E-07	3.73E-07	3.72E-07	3.50E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

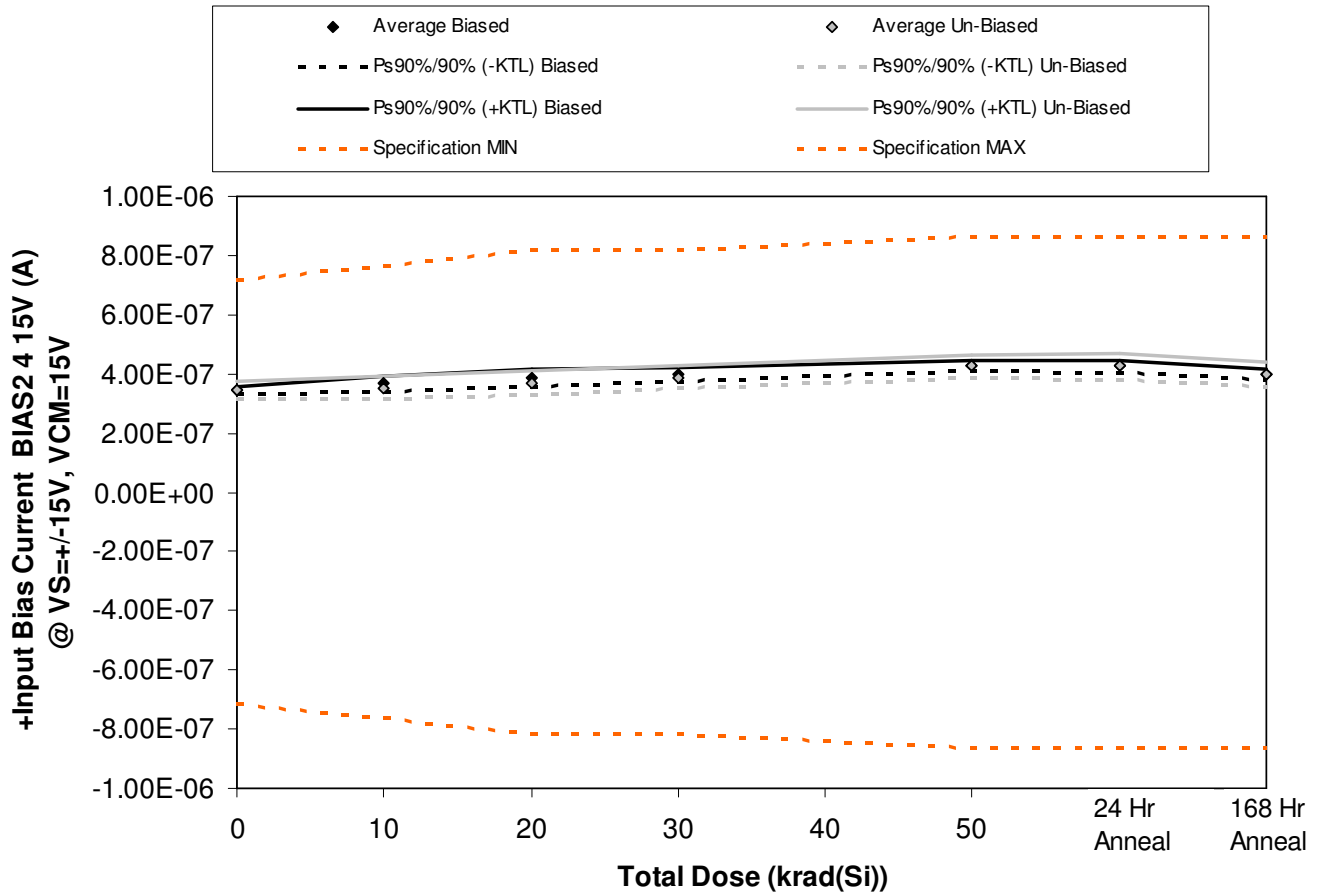


Figure 5.30. Plot of +Input Bias Current BIAS2 4 15V (A) @ VS=+/-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.30. Raw data for +Input Bias Current BIAS2 4 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS2 4 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.39E-07	3.48E-07	3.69E-07	3.84E-07	4.16E-07	4.15E-07	3.86E-07
563	3.41E-07	3.65E-07	3.82E-07	3.96E-07	4.26E-07	4.24E-07	3.95E-07
564	3.47E-07	3.72E-07	3.92E-07	4.02E-07	4.29E-07	4.31E-07	3.99E-07
567	3.48E-07	3.73E-07	3.93E-07	4.06E-07	4.33E-07	4.32E-07	4.03E-07
569	3.44E-07	3.71E-07	3.94E-07	4.04E-07	4.30E-07	4.33E-07	4.00E-07
570	3.51E-07	3.57E-07	3.75E-07	3.91E-07	4.28E-07	4.27E-07	3.99E-07
571	3.35E-07	3.41E-07	3.57E-07	3.77E-07	4.12E-07	4.14E-07	3.85E-07
572	3.63E-07	3.73E-07	3.90E-07	4.11E-07	4.50E-07	4.51E-07	4.23E-07
573	3.41E-07	3.42E-07	3.58E-07	3.78E-07	4.17E-07	4.15E-07	3.87E-07
574	3.40E-07	3.46E-07	3.61E-07	3.81E-07	4.19E-07	4.18E-07	3.92E-07
584	3.33E-07	3.36E-07	3.37E-07	3.38E-07	3.40E-07	3.38E-07	3.37E-07
585	3.45E-07	3.54E-07	3.51E-07	3.56E-07	3.58E-07	3.60E-07	3.54E-07
<b>Biased Statistics</b>							
Average Biased	3.44E-07	3.66E-07	3.86E-07	3.99E-07	4.27E-07	4.27E-07	3.96E-07
Std Dev Biased	3.83E-09	1.04E-08	1.08E-08	8.86E-09	6.62E-09	7.56E-09	6.28E-09
Ps90%/90% (+KTL) Biased	3.54E-07	3.95E-07	4.16E-07	4.23E-07	4.45E-07	4.48E-07	4.14E-07
Ps90%/90% (-KTL) Biased	3.33E-07	3.38E-07	3.57E-07	3.74E-07	4.08E-07	4.06E-07	3.79E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.46E-07	3.52E-07	3.68E-07	3.88E-07	4.25E-07	4.25E-07	3.97E-07
Std Dev Un-Biased	1.12E-08	1.37E-08	1.44E-08	1.43E-08	1.49E-08	1.53E-08	1.53E-08
Ps90%/90% (+KTL) Un-Biased	3.76E-07	3.89E-07	4.08E-07	4.27E-07	4.66E-07	4.67E-07	4.39E-07
Ps90%/90% (-KTL) Un-Biased	3.15E-07	3.14E-07	3.29E-07	3.48E-07	3.84E-07	3.83E-07	3.55E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



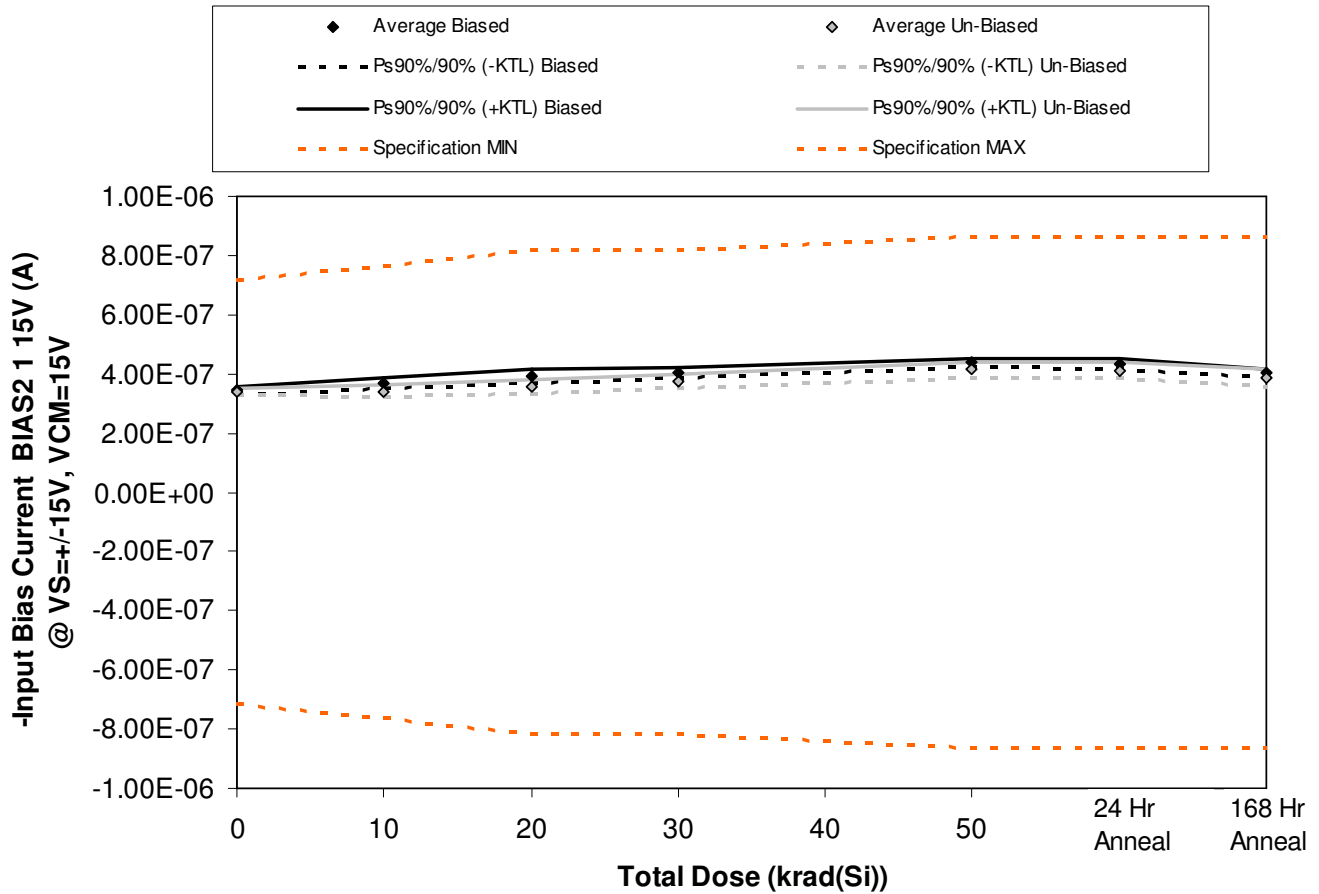


Figure 5.31. Plot of -Input Bias Current BIAS2 1 15V (A) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.31. Raw data for -Input Bias Current BIAS2 1 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS2 1 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.47E-07	3.61E-07	3.85E-07	4.01E-07	4.39E-07	4.36E-07	4.05E-07
563	3.37E-07	3.63E-07	3.84E-07	3.99E-07	4.30E-07	4.28E-07	3.98E-07
564	3.50E-07	3.79E-07	4.03E-07	4.15E-07	4.44E-07	4.43E-07	4.10E-07
567	3.40E-07	3.67E-07	3.90E-07	4.02E-07	4.32E-07	4.27E-07	3.98E-07
569	3.42E-07	3.72E-07	3.95E-07	4.07E-07	4.39E-07	4.38E-07	4.04E-07
570	3.37E-07	3.45E-07	3.60E-07	3.77E-07	4.15E-07	4.12E-07	3.85E-07
571	3.36E-07	3.39E-07	3.53E-07	3.72E-07	4.07E-07	4.07E-07	3.82E-07
572	3.46E-07	3.53E-07	3.71E-07	3.91E-07	4.30E-07	4.27E-07	4.04E-07
573	3.38E-07	3.35E-07	3.53E-07	3.71E-07	4.09E-07	4.06E-07	3.81E-07
574	3.37E-07	3.35E-07	3.50E-07	3.69E-07	4.07E-07	4.03E-07	3.79E-07
584	3.29E-07	3.28E-07	3.29E-07	3.28E-07	3.30E-07	3.31E-07	3.30E-07
585	3.43E-07	3.44E-07	3.41E-07	3.46E-07	3.49E-07	3.52E-07	3.44E-07
<b>Biased Statistics</b>							
Average Biased	3.43E-07	3.68E-07	3.92E-07	4.05E-07	4.37E-07	4.34E-07	4.03E-07
Std Dev Biased	5.31E-09	7.24E-09	8.04E-09	6.21E-09	5.93E-09	6.84E-09	5.02E-09
Ps90%/90% (+KTL) Biased	3.58E-07	3.88E-07	4.14E-07	4.22E-07	4.53E-07	4.53E-07	4.17E-07
Ps90%/90% (-KTL) Biased	3.29E-07	3.48E-07	3.69E-07	3.88E-07	4.21E-07	4.15E-07	3.89E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.39E-07	3.42E-07	3.58E-07	3.76E-07	4.14E-07	4.11E-07	3.86E-07
Std Dev Un-Biased	4.08E-09	7.80E-09	8.57E-09	8.78E-09	9.67E-09	9.54E-09	1.00E-08
Ps90%/90% (+KTL) Un-Biased	3.50E-07	3.63E-07	3.81E-07	4.00E-07	4.40E-07	4.37E-07	4.13E-07
Ps90%/90% (-KTL) Un-Biased	3.28E-07	3.20E-07	3.34E-07	3.52E-07	3.87E-07	3.85E-07	3.59E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

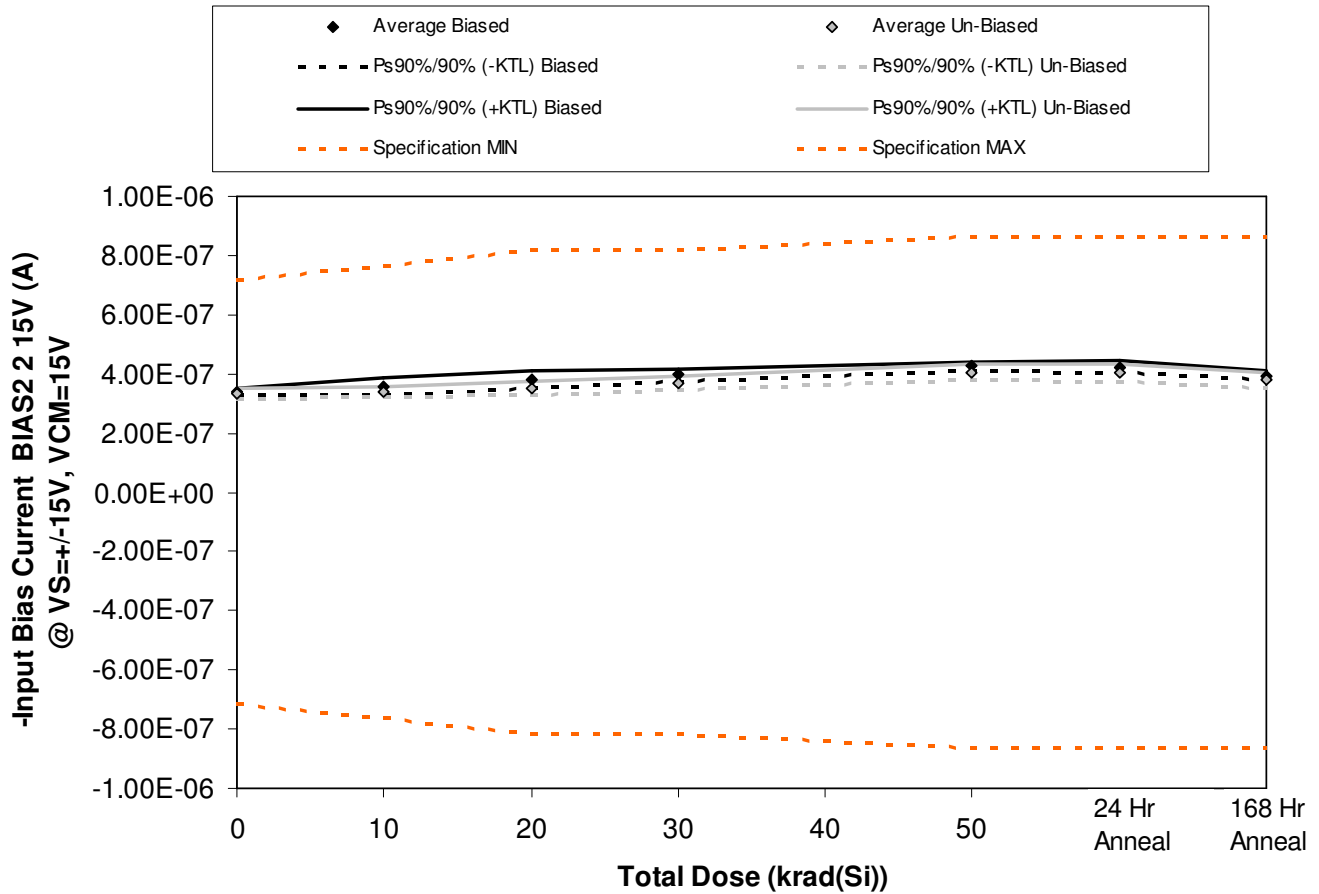


Figure 5.32. Plot of -Input Bias Current BIAS2 2 15V (A) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.32. Raw data for -Input Bias Current BIAS2 2 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS2 2 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.31E-07	3.41E-07	3.65E-07	3.83E-07	4.21E-07	4.17E-07	3.88E-07
563	3.41E-07	3.65E-07	3.85E-07	4.00E-07	4.27E-07	4.26E-07	3.98E-07
564	3.42E-07	3.69E-07	3.93E-07	4.04E-07	4.34E-07	4.34E-07	4.02E-07
567	3.36E-07	3.59E-07	3.80E-07	3.92E-07	4.21E-07	4.17E-07	3.90E-07
569	3.37E-07	3.62E-07	3.86E-07	3.98E-07	4.27E-07	4.25E-07	3.95E-07
570	3.37E-07	3.44E-07	3.61E-07	3.79E-07	4.13E-07	4.13E-07	3.88E-07
571	3.33E-07	3.40E-07	3.49E-07	3.68E-07	4.05E-07	4.03E-07	3.77E-07
572	3.34E-07	3.41E-07	3.52E-07	3.70E-07	4.08E-07	4.06E-07	3.81E-07
573	3.23E-07	3.27E-07	3.36E-07	3.54E-07	3.89E-07	3.85E-07	3.64E-07
574	3.39E-07	3.38E-07	3.54E-07	3.74E-07	4.14E-07	4.12E-07	3.86E-07
584	3.37E-07	3.40E-07	3.41E-07	3.39E-07	3.40E-07	3.42E-07	3.39E-07
585	3.36E-07	3.40E-07	3.34E-07	3.39E-07	3.43E-07	3.44E-07	3.38E-07
<b>Biased Statistics</b>							
Average Biased	3.37E-07	3.59E-07	3.82E-07	3.95E-07	4.26E-07	4.24E-07	3.95E-07
Std Dev Biased	4.31E-09	1.08E-08	1.03E-08	8.40E-09	5.43E-09	6.97E-09	5.91E-09
Ps90%/90% (+KTL) Biased	3.49E-07	3.89E-07	4.10E-07	4.18E-07	4.41E-07	4.43E-07	4.11E-07
Ps90%/90% (-KTL) Biased	3.26E-07	3.30E-07	3.54E-07	3.72E-07	4.11E-07	4.05E-07	3.78E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.33E-07	3.38E-07	3.50E-07	3.69E-07	4.06E-07	4.04E-07	3.79E-07
Std Dev Un-Biased	6.10E-09	6.58E-09	9.05E-09	9.43E-09	1.02E-08	1.10E-08	9.33E-09
Ps90%/90% (+KTL) Un-Biased	3.50E-07	3.56E-07	3.75E-07	3.95E-07	4.34E-07	4.34E-07	4.05E-07
Ps90%/90% (-KTL) Un-Biased	3.16E-07	3.20E-07	3.26E-07	3.43E-07	3.78E-07	3.74E-07	3.54E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

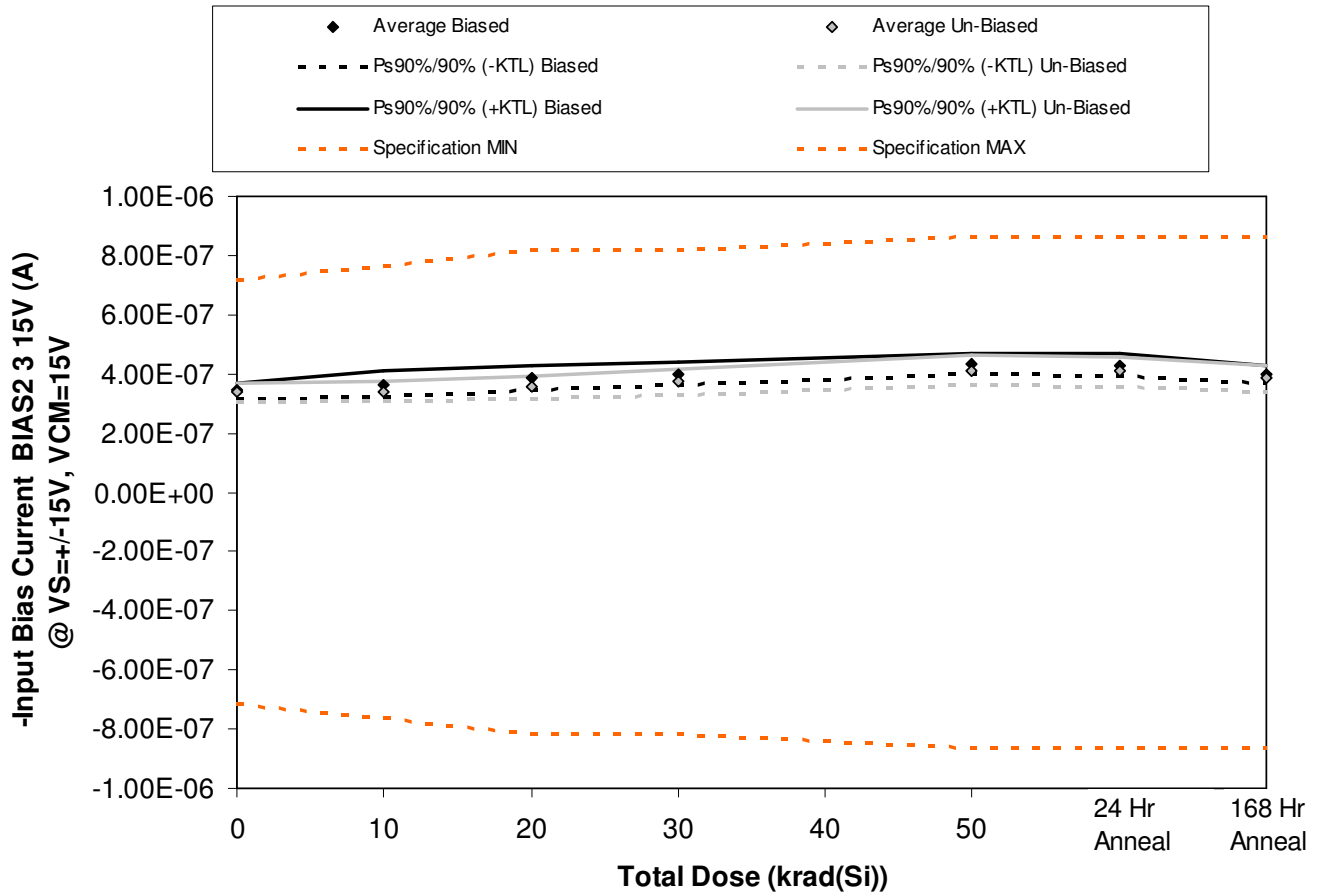


Figure 5.33. Plot of -Input Bias Current BIAS2 3 15V (A) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.33. Raw data for -Input Bias Current BIAS2 3 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS2 3 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.37E-07	3.47E-07	3.71E-07	3.88E-07	4.26E-07	4.22E-07	3.92E-07
563	3.47E-07	3.70E-07	3.89E-07	4.02E-07	4.32E-07	4.31E-07	4.02E-07
564	3.59E-07	3.88E-07	4.11E-07	4.23E-07	4.54E-07	4.52E-07	4.17E-07
567	3.34E-07	3.57E-07	3.79E-07	3.90E-07	4.19E-07	4.16E-07	3.88E-07
569	3.39E-07	3.65E-07	3.88E-07	4.01E-07	4.30E-07	4.29E-07	3.97E-07
570	3.39E-07	3.40E-07	3.55E-07	3.70E-07	4.09E-07	4.08E-07	3.81E-07
571	3.30E-07	3.37E-07	3.45E-07	3.65E-07	4.02E-07	4.00E-07	3.75E-07
572	3.44E-07	3.51E-07	3.69E-07	3.87E-07	4.26E-07	4.23E-07	3.98E-07
573	3.21E-07	3.25E-07	3.41E-07	3.52E-07	3.88E-07	3.85E-07	3.64E-07
574	3.50E-07	3.55E-07	3.72E-07	3.92E-07	4.34E-07	4.30E-07	4.03E-07
584	3.35E-07	3.37E-07	3.37E-07	3.36E-07	3.38E-07	3.37E-07	3.36E-07
585	3.46E-07	3.47E-07	3.44E-07	3.48E-07	3.51E-07	3.53E-07	3.47E-07
<b>Biased Statistics</b>							
Average Biased	3.43E-07	3.65E-07	3.87E-07	4.01E-07	4.32E-07	4.30E-07	3.99E-07
Std Dev Biased	1.01E-08	1.52E-08	1.49E-08	1.39E-08	1.32E-08	1.36E-08	1.12E-08
Ps90%/90% (+KTL) Biased	3.71E-07	4.07E-07	4.28E-07	4.39E-07	4.68E-07	4.67E-07	4.30E-07
Ps90%/90% (-KTL) Biased	3.16E-07	3.24E-07	3.47E-07	3.63E-07	3.96E-07	3.92E-07	3.68E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.37E-07	3.42E-07	3.56E-07	3.73E-07	4.12E-07	4.09E-07	3.84E-07
Std Dev Un-Biased	1.14E-08	1.22E-08	1.37E-08	1.63E-08	1.84E-08	1.80E-08	1.60E-08
Ps90%/90% (+KTL) Un-Biased	3.68E-07	3.75E-07	3.94E-07	4.18E-07	4.62E-07	4.59E-07	4.28E-07
Ps90%/90% (-KTL) Un-Biased	3.05E-07	3.08E-07	3.19E-07	3.29E-07	3.62E-07	3.60E-07	3.40E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

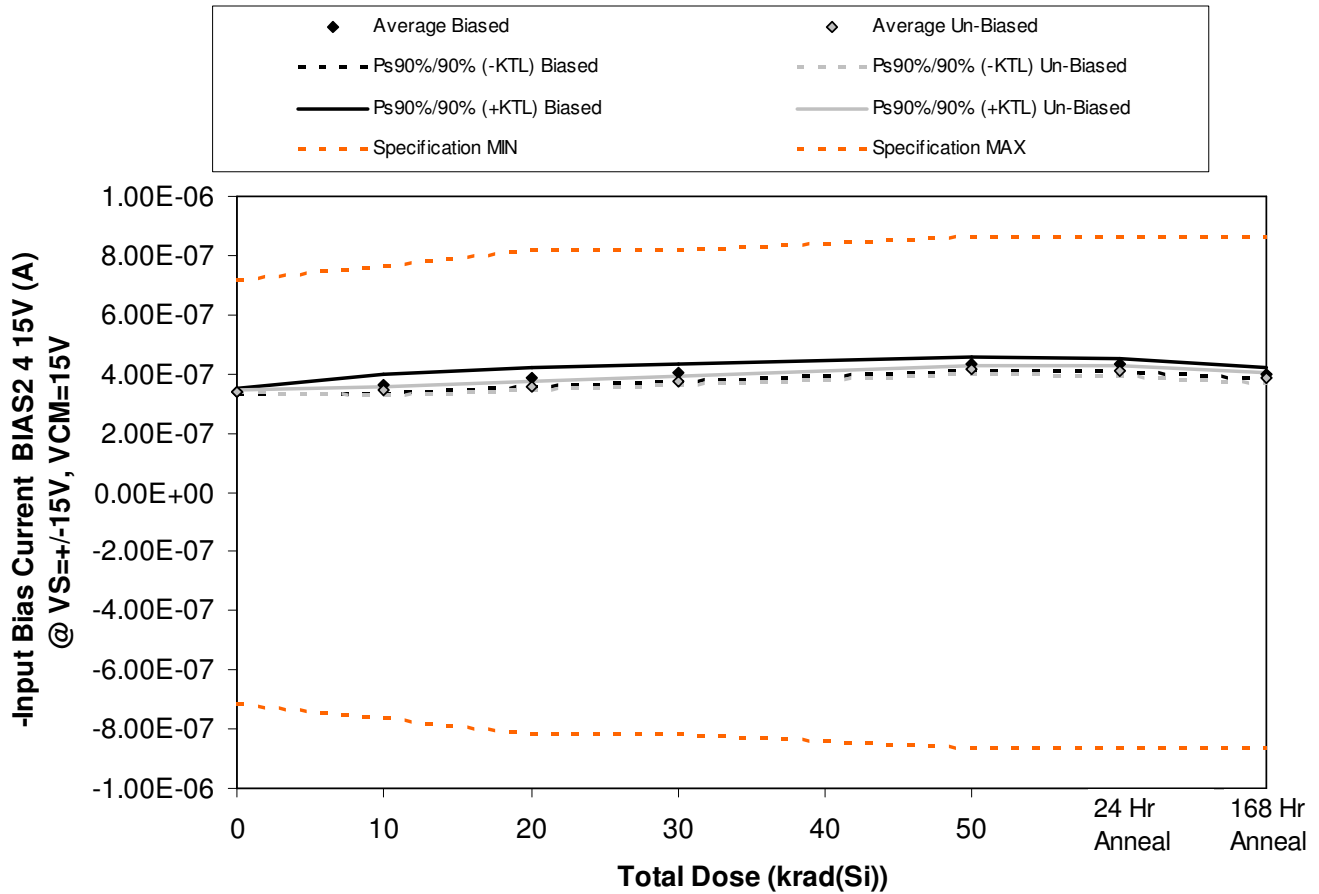


Figure 5.34. Plot of -Input Bias Current BIAS2 4 15V (A) @ VS=+-15V, VCM=15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.34. Raw data for -Input Bias Current BIAS2 4 15V (A) @ VS=+/-15V, VCM=15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS2 4 15V (A) @ VS=+/-15V, VCM=15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.38E-07	3.47E-07	3.69E-07	3.86E-07	4.21E-07	4.20E-07	3.90E-07
563	3.39E-07	3.64E-07	3.85E-07	3.99E-07	4.30E-07	4.28E-07	3.98E-07
564	3.42E-07	3.70E-07	3.92E-07	4.04E-07	4.34E-07	4.34E-07	4.02E-07
567	3.44E-07	3.71E-07	3.94E-07	4.08E-07	4.37E-07	4.33E-07	4.04E-07
569	3.45E-07	3.75E-07	3.99E-07	4.14E-07	4.43E-07	4.41E-07	4.09E-07
570	3.40E-07	3.47E-07	3.61E-07	3.78E-07	4.13E-07	4.11E-07	3.85E-07
571	3.40E-07	3.42E-07	3.56E-07	3.74E-07	4.11E-07	4.11E-07	3.85E-07
572	3.41E-07	3.50E-07	3.67E-07	3.86E-07	4.22E-07	4.22E-07	3.98E-07
573	3.41E-07	3.37E-07	3.54E-07	3.75E-07	4.11E-07	4.08E-07	3.83E-07
574	3.39E-07	3.37E-07	3.53E-07	3.71E-07	4.10E-07	4.07E-07	3.81E-07
584	3.32E-07	3.31E-07	3.31E-07	3.31E-07	3.33E-07	3.34E-07	3.33E-07
585	3.45E-07	3.48E-07	3.44E-07	3.50E-07	3.51E-07	3.54E-07	3.48E-07
<b>Biased Statistics</b>							
Average Biased	3.41E-07	3.65E-07	3.88E-07	4.02E-07	4.33E-07	4.31E-07	4.00E-07
Std Dev Biased	3.02E-09	1.10E-08	1.18E-08	1.07E-08	8.35E-09	7.70E-09	7.13E-09
Ps90%/90% (+KTL) Biased	3.50E-07	3.96E-07	4.20E-07	4.31E-07	4.56E-07	4.52E-07	4.20E-07
Ps90%/90% (-KTL) Biased	3.33E-07	3.35E-07	3.56E-07	3.73E-07	4.10E-07	4.10E-07	3.81E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.40E-07	3.43E-07	3.58E-07	3.77E-07	4.14E-07	4.12E-07	3.86E-07
Std Dev Un-Biased	8.25E-10	5.76E-09	5.84E-09	5.64E-09	4.81E-09	5.96E-09	6.61E-09
Ps90%/90% (+KTL) Un-Biased	3.42E-07	3.58E-07	3.74E-07	3.92E-07	4.27E-07	4.28E-07	4.05E-07
Ps90%/90% (-KTL) Un-Biased	3.38E-07	3.27E-07	3.42E-07	3.61E-07	4.00E-07	3.95E-07	3.68E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



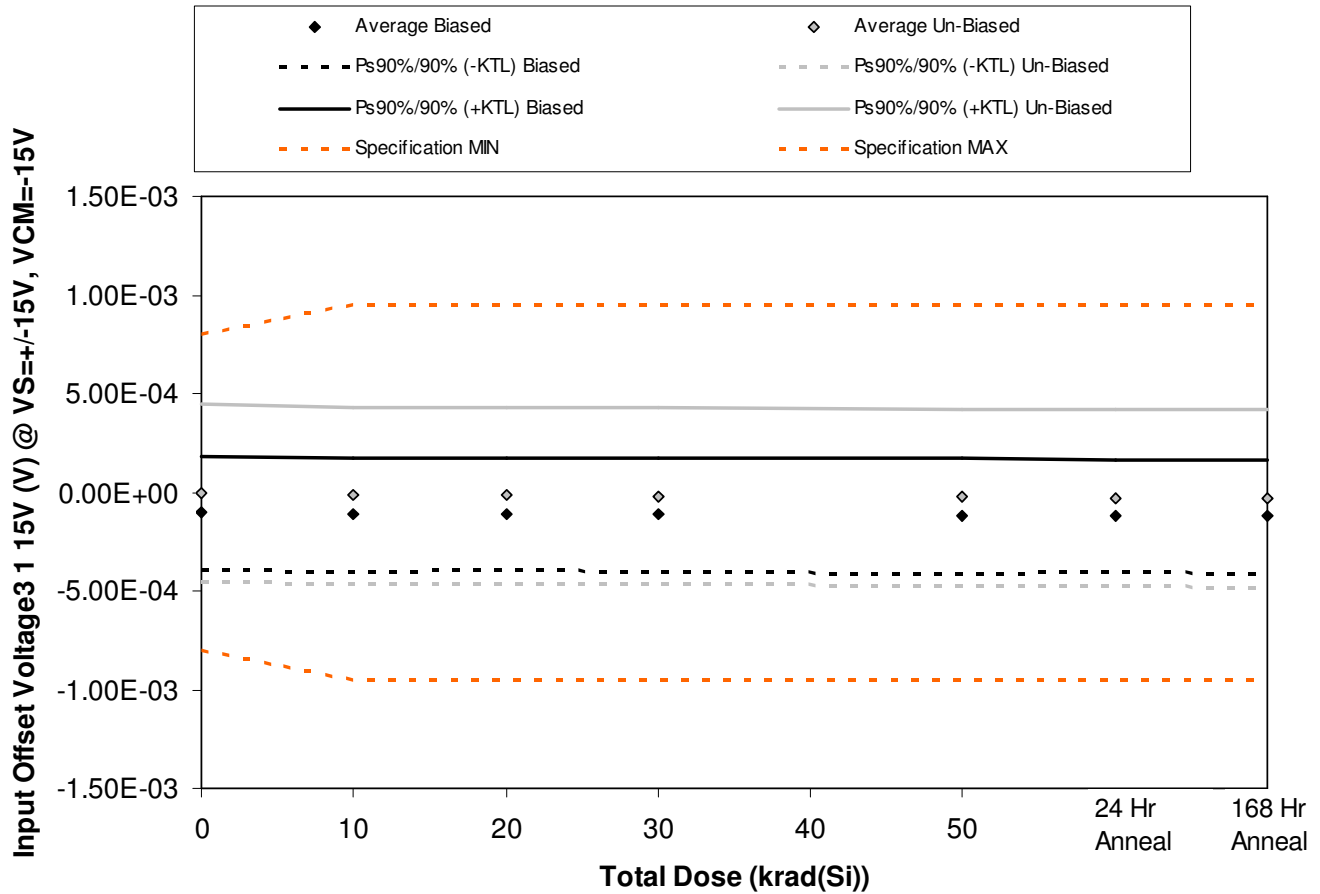


Figure 5.35. Plot of Input Offset Voltage3 1 15V (V) @ VS=+-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.35. Raw data for Input Offset Voltage3 1 15V (V) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage3 1 15V (V) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.06E-04	-2.15E-04	-2.16E-04	-2.19E-04	-2.27E-04	-2.24E-04	-2.20E-04
563	-1.55E-04	-1.61E-04	-1.64E-04	-1.65E-04	-1.70E-04	-1.70E-04	-1.86E-04
564	-4.30E-07	-7.68E-06	-7.80E-06	-5.50E-06	-1.33E-05	-1.55E-05	-1.25E-05
567	1.41E-05	4.52E-06	1.14E-06	2.46E-06	1.75E-06	1.39E-06	-2.36E-06
569	-1.79E-04	-1.88E-04	-1.85E-04	-1.85E-04	-1.88E-04	-1.90E-04	-1.89E-04
570	9.51E-05	8.35E-05	8.14E-05	7.84E-05	7.09E-05	6.78E-05	7.23E-05
571	-2.68E-04	-2.76E-04	-2.79E-04	-2.80E-04	-2.84E-04	-2.85E-04	-2.90E-04
572	1.63E-04	1.50E-04	1.47E-04	1.47E-04	1.44E-04	1.43E-04	1.37E-04
573	6.93E-06	1.98E-06	4.10E-07	-3.45E-06	-9.48E-06	-1.08E-05	-2.10E-05
574	-3.11E-05	-4.02E-05	-3.88E-05	-4.14E-05	-4.87E-05	-5.10E-05	-5.07E-05
584	-4.62E-04	-4.62E-04	-4.63E-04	-4.63E-04	-4.65E-04	-4.66E-04	-4.65E-04
585	1.27E-04	1.21E-04	1.27E-04	1.22E-04	1.23E-04	1.18E-04	1.21E-04
<b>Biased Statistics</b>							
Average Biased	-1.05E-04	-1.13E-04	-1.14E-04	-1.14E-04	-1.19E-04	-1.20E-04	-1.22E-04
Std Dev Biased	1.04E-04	1.04E-04	1.03E-04	1.05E-04	1.06E-04	1.05E-04	1.05E-04
Ps90%/90% (+KTL) Biased	1.80E-04	1.72E-04	1.68E-04	1.73E-04	1.71E-04	1.67E-04	1.67E-04
Ps90%/90% (-KTL) Biased	-3.91E-04	-3.99E-04	-3.97E-04	-4.02E-04	-4.09E-04	-4.06E-04	-4.11E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	-6.93E-06	-1.61E-05	-1.77E-05	-1.99E-05	-2.56E-05	-2.72E-05	-3.05E-05
Std Dev Un-Biased	1.65E-04	1.63E-04	1.63E-04	1.63E-04	1.62E-04	1.62E-04	1.63E-04
Ps90%/90% (+KTL) Un-Biased	4.44E-04	4.31E-04	4.28E-04	4.26E-04	4.20E-04	4.17E-04	4.17E-04
Ps90%/90% (-KTL) Un-Biased	-4.58E-04	-4.63E-04	-4.64E-04	-4.66E-04	-4.71E-04	-4.72E-04	-4.78E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

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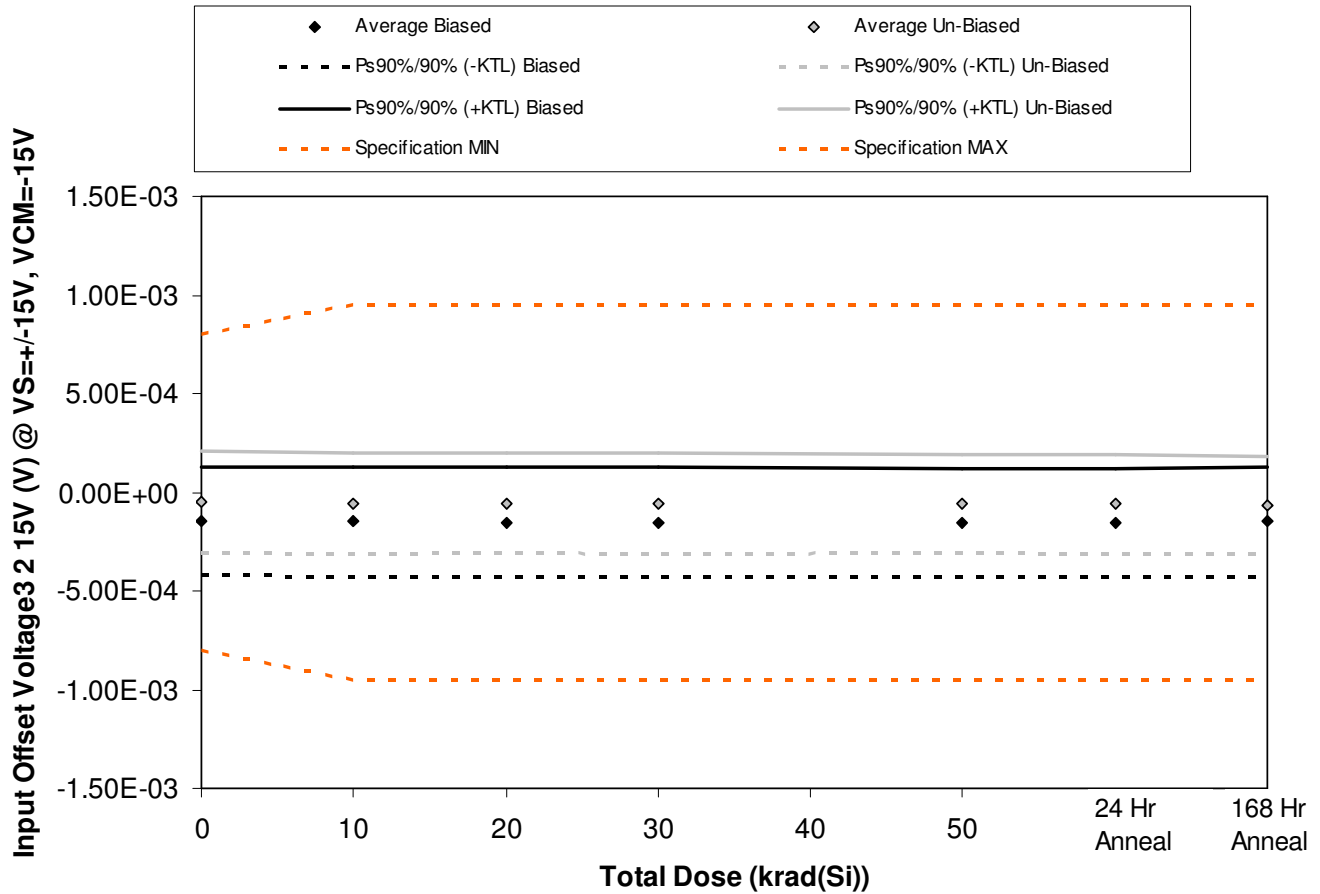


Figure 5.36. Plot of Input Offset Voltage3 2 15V (V) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.36. Raw data for Input Offset Voltage3 2 15V (V) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage3 2 15V (V) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.51E-04	-2.58E-04	-2.59E-04	-2.57E-04	-2.61E-04	-2.62E-04	-2.66E-04
563	-2.25E-04	-2.32E-04	-2.33E-04	-2.35E-04	-2.37E-04	-2.33E-04	-2.28E-04
564	-2.45E-05	-3.04E-05	-2.91E-05	-2.89E-05	-3.68E-05	-3.41E-05	-2.72E-05
567	-1.65E-04	-1.67E-04	-1.69E-04	-1.68E-04	-1.75E-04	-1.77E-04	-1.57E-04
569	-6.25E-05	-6.35E-05	-6.62E-05	-6.59E-05	-6.55E-05	-6.45E-05	-7.05E-05
570	-6.85E-05	-7.55E-05	-7.75E-05	-7.82E-05	-8.07E-05	-8.07E-05	-7.93E-05
571	4.98E-05	4.79E-05	4.57E-05	4.80E-05	4.61E-05	4.57E-05	3.24E-05
572	1.09E-05	-4.17E-06	-5.02E-06	-7.68E-06	-1.11E-05	-1.08E-05	-1.41E-05
573	-1.95E-04	-2.01E-04	-1.99E-04	-2.01E-04	-1.98E-04	-2.01E-04	-2.07E-04
574	-3.68E-05	-4.33E-05	-4.29E-05	-4.50E-05	-4.97E-05	-4.88E-05	-4.87E-05
584	-3.34E-04	-3.35E-04	-3.37E-04	-3.35E-04	-3.35E-04	-3.33E-04	-3.35E-04
585	-3.10E-07	-4.42E-06	-3.45E-06	-5.87E-06	5.40E-07	-6.22E-06	-3.45E-06
<b>Biased Statistics</b>							
Average Biased	-1.46E-04	-1.50E-04	-1.51E-04	-1.51E-04	-1.55E-04	-1.54E-04	-1.50E-04
Std Dev Biased	9.92E-05	1.01E-04	1.01E-04	1.01E-04	1.00E-04	1.01E-04	1.01E-04
Ps90%/90% (+KTL) Biased	1.27E-04	1.26E-04	1.26E-04	1.26E-04	1.20E-04	1.23E-04	1.28E-04
Ps90%/90% (-KTL) Biased	-4.18E-04	-4.26E-04	-4.28E-04	-4.28E-04	-4.30E-04	-4.31E-04	-4.27E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	-4.80E-05	-5.52E-05	-5.58E-05	-5.68E-05	-5.86E-05	-5.91E-05	-6.34E-05
Std Dev Un-Biased	9.40E-05	9.35E-05	9.23E-05	9.34E-05	9.11E-05	9.21E-05	9.06E-05
Ps90%/90% (+KTL) Un-Biased	2.10E-04	2.01E-04	1.97E-04	1.99E-04	1.91E-04	1.93E-04	1.85E-04
Ps90%/90% (-KTL) Un-Biased	-3.06E-04	-3.11E-04	-3.09E-04	-3.13E-04	-3.08E-04	-3.12E-04	-3.12E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

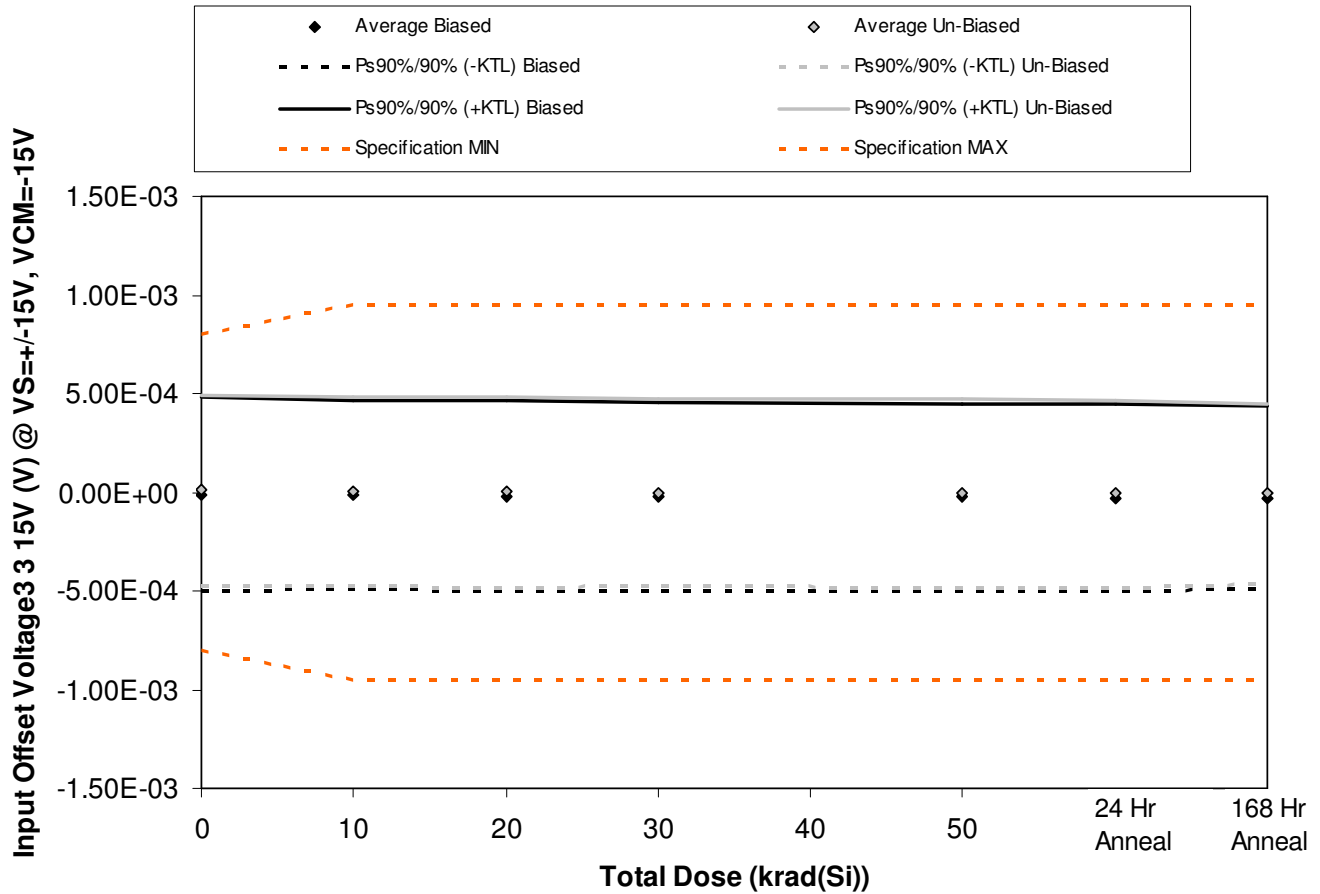


Figure 5.37. Plot of Input Offset Voltage3 3 15V (V) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.37. Raw data for Input Offset Voltage3 3 15V (V) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage3 3 15V (V) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.94E-04	2.83E-04	2.80E-04	2.73E-04	2.67E-04	2.65E-04	2.61E-04
563	-7.27E-05	-7.93E-05	-8.07E-05	-8.56E-05	-8.43E-05	-8.38E-05	-7.98E-05
564	-5.73E-05	-6.14E-05	-6.80E-05	-6.80E-05	-7.34E-05	-7.83E-05	-8.24E-05
567	-3.29E-05	-3.40E-05	-4.08E-05	-4.32E-05	-4.50E-05	-4.63E-05	-5.07E-05
569	-1.77E-04	-1.80E-04	-1.85E-04	-1.89E-04	-1.91E-04	-1.96E-04	-1.88E-04
570	-1.82E-04	-1.88E-04	-1.89E-04	-1.92E-04	-1.96E-04	-1.98E-04	-1.93E-04
571	-1.55E-04	-1.64E-04	-1.66E-04	-1.68E-04	-1.77E-04	-1.77E-04	-1.64E-04
572	2.30E-04	2.20E-04	2.16E-04	2.10E-04	2.05E-04	2.02E-04	1.91E-04
573	5.52E-05	5.09E-05	5.09E-05	4.98E-05	4.28E-05	4.34E-05	3.98E-05
574	1.08E-04	1.02E-04	1.00E-04	9.46E-05	8.89E-05	8.86E-05	8.35E-05
584	3.61E-04	3.64E-04	3.63E-04	3.63E-04	3.62E-04	3.59E-04	3.60E-04
585	3.75E-05	3.63E-05	3.48E-05	3.22E-05	3.74E-05	2.90E-05	3.28E-05
<b>Biased Statistics</b>							
Average Biased	-9.18E-06	-1.44E-05	-1.90E-05	-2.26E-05	-2.53E-05	-2.79E-05	-2.80E-05
Std Dev Biased	1.78E-04	1.75E-04	1.76E-04	1.75E-04	1.72E-04	1.73E-04	1.69E-04
Ps90%/90% (+KTL) Biased	4.79E-04	4.66E-04	4.63E-04	4.56E-04	4.47E-04	4.48E-04	4.37E-04
Ps90%/90% (-KTL) Biased	-4.97E-04	-4.95E-04	-5.01E-04	-5.01E-04	-4.98E-04	-5.04E-04	-4.93E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.11E-05	4.25E-06	2.42E-06	-1.23E-06	-7.14E-06	-8.05E-06	-8.49E-06
Std Dev Un-Biased	1.76E-04	1.76E-04	1.75E-04	1.74E-04	1.74E-04	1.74E-04	1.65E-04
Ps90%/90% (+KTL) Un-Biased	4.94E-04	4.86E-04	4.83E-04	4.75E-04	4.70E-04	4.68E-04	4.43E-04
Ps90%/90% (-KTL) Un-Biased	-4.72E-04	-4.77E-04	-4.78E-04	-4.77E-04	-4.85E-04	-4.84E-04	-4.60E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

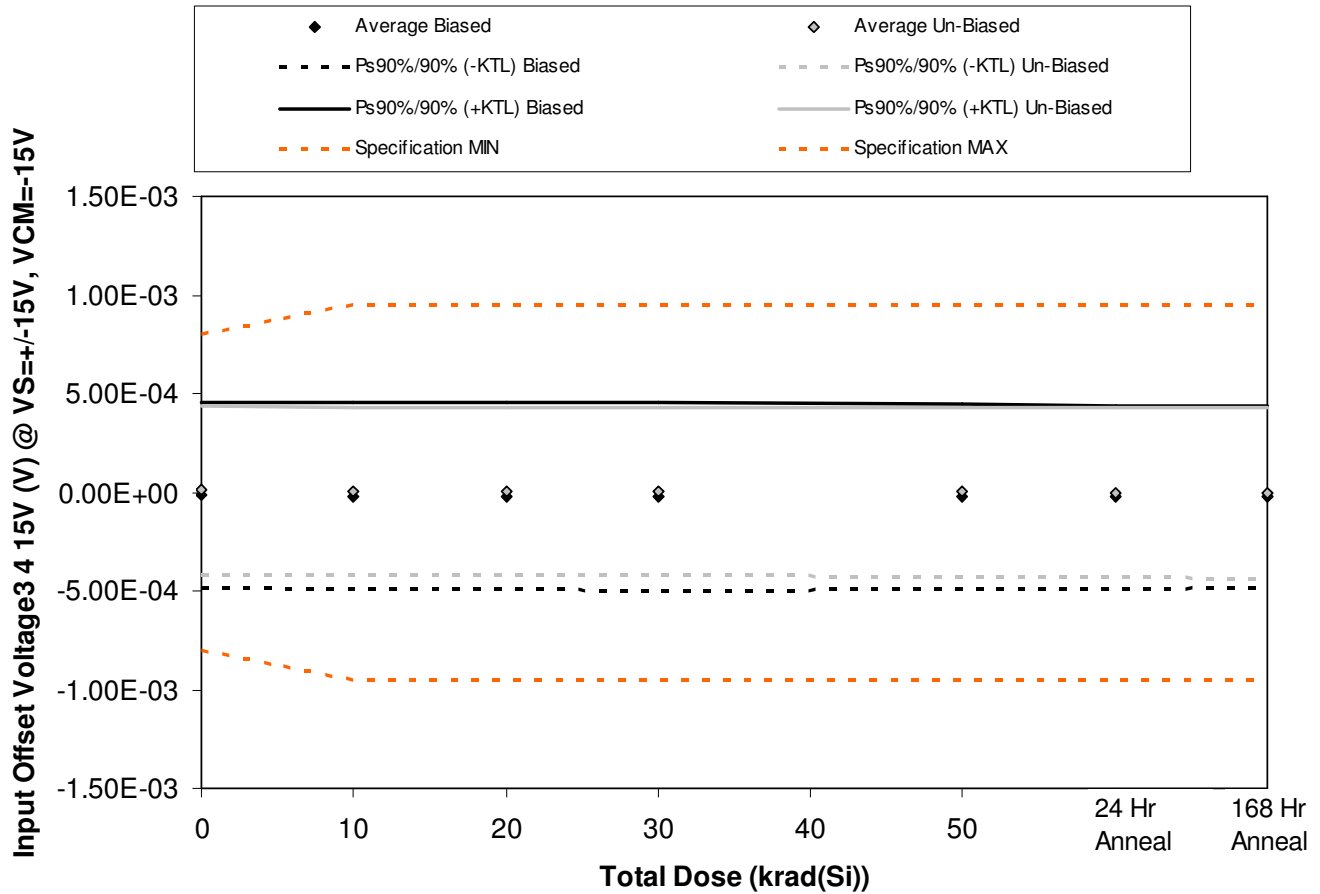


Figure 5.38. Plot of Input Offset Voltage3 4 15V (V) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.38. Raw data for Input Offset Voltage3 4 15V (V) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage3 4 15V (V) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-6.17E-05	-7.15E-05	-7.35E-05	-7.48E-05	-8.08E-05	-8.11E-05	-7.70E-05
563	2.39E-05	1.48E-05	1.35E-05	1.49E-05	8.27E-06	5.85E-06	1.59E-05
564	1.26E-04	1.22E-04	1.22E-04	1.23E-04	1.17E-04	1.13E-04	1.15E-04
567	1.35E-04	1.31E-04	1.30E-04	1.31E-04	1.26E-04	1.25E-04	1.24E-04
569	-2.83E-04	-2.86E-04	-2.87E-04	-2.92E-04	-2.88E-04	-2.89E-04	-2.85E-04
570	8.81E-05	7.85E-05	7.84E-05	8.17E-05	8.59E-05	8.18E-05	7.66E-05
571	1.60E-04	1.52E-04	1.51E-04	1.51E-04	1.48E-04	1.45E-04	1.47E-04
572	-1.18E-05	-2.28E-05	-2.56E-05	-2.51E-05	-2.99E-05	-3.28E-05	-2.60E-05
573	6.08E-05	5.47E-05	5.79E-05	6.04E-05	6.10E-05	5.64E-05	4.67E-05
574	-2.46E-04	-2.53E-04	-2.52E-04	-2.51E-04	-2.53E-04	-2.54E-04	-2.62E-04
584	9.33E-05	9.27E-05	9.25E-05	9.27E-05	8.93E-05	8.64E-05	8.87E-05
585	-1.80E-04	-1.82E-04	-1.80E-04	-1.80E-04	-1.79E-04	-1.83E-04	-1.82E-04
<b>Biased Statistics</b>							
Average Biased	-1.18E-05	-1.80E-05	-1.89E-05	-1.94E-05	-2.36E-05	-2.53E-05	-2.15E-05
Std Dev Biased	1.72E-04	1.71E-04	1.72E-04	1.74E-04	1.71E-04	1.70E-04	1.69E-04
Ps90%/90% (+KTL) Biased	4.59E-04	4.52E-04	4.52E-04	4.58E-04	4.44E-04	4.40E-04	4.41E-04
Ps90%/90% (-KTL) Biased	-4.82E-04	-4.88E-04	-4.90E-04	-4.97E-04	-4.92E-04	-4.91E-04	-4.84E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.00E-05	1.84E-06	1.93E-06	3.55E-06	2.42E-06	-6.18E-07	-3.62E-06
Std Dev Un-Biased	1.56E-04	1.55E-04	1.55E-04	1.55E-04	1.56E-04	1.55E-04	1.57E-04
Ps90%/90% (+KTL) Un-Biased	4.38E-04	4.28E-04	4.28E-04	4.30E-04	4.31E-04	4.25E-04	4.28E-04
Ps90%/90% (-KTL) Un-Biased	-4.18E-04	-4.24E-04	-4.24E-04	-4.22E-04	-4.27E-04	-4.26E-04	-4.35E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



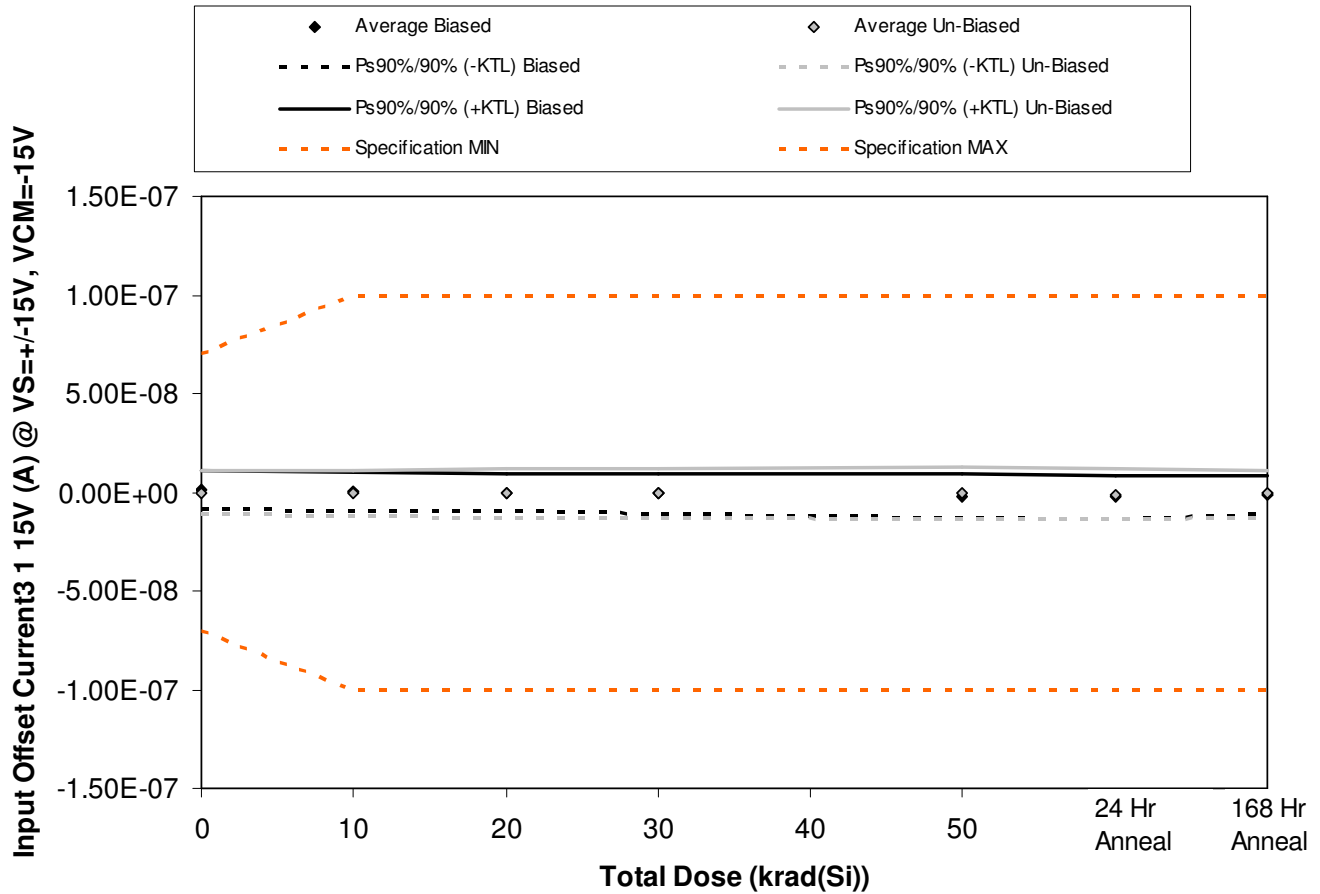


Figure 5.39. Plot of Input Offset Current3 1 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.39. Raw data for Input Offset Current3 1 15V (A) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current3 1 15V (A) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.35E-09	2.17E-09	1.32E-09	9.70E-10	-3.80E-10	-1.27E-09	2.20E-10
563	-4.26E-09	-4.85E-09	-4.90E-09	-5.62E-09	-6.94E-09	-7.63E-09	-6.07E-09
564	-3.30E-10	-5.20E-10	-1.47E-09	-2.02E-09	-3.91E-09	-4.57E-09	-3.03E-09
567	5.37E-09	5.02E-09	4.50E-09	4.61E-09	3.96E-09	3.27E-09	3.14E-09
569	1.69E-09	5.00E-10	-1.80E-10	-1.03E-09	-2.61E-09	-2.86E-09	-1.39E-09
570	-1.30E-10	-4.00E-10	-6.00E-11	-1.10E-10	3.40E-10	1.10E-10	-2.40E-10
571	-5.52E-09	-5.73E-09	-6.40E-09	-6.67E-09	-6.72E-09	-7.75E-09	-6.45E-09
572	2.33E-09	2.22E-09	2.25E-09	2.25E-09	2.42E-09	1.24E-09	1.49E-09
573	-2.36E-09	-2.56E-09	-2.74E-09	-2.85E-09	-2.92E-09	-3.84E-09	-3.12E-09
574	5.13E-09	4.94E-09	5.10E-09	4.72E-09	5.83E-09	4.37E-09	4.91E-09
584	-8.69E-09	-9.31E-09	-9.69E-09	-1.00E-08	-1.02E-08	-1.04E-08	-1.06E-08
585	1.49E-09	-2.20E-10	-2.90E-10	-2.50E-10	-3.80E-10	-4.50E-10	-5.90E-10
<b>Biased Statistics</b>							
Average Biased	9.64E-10	4.64E-10	-1.46E-10	-6.18E-10	-1.98E-09	-2.61E-09	-1.43E-09
Std Dev Biased	3.56E-09	3.64E-09	3.47E-09	3.78E-09	4.08E-09	4.05E-09	3.45E-09
Ps90%/90% (+KTL) Biased	1.07E-08	1.04E-08	9.36E-09	9.73E-09	9.21E-09	8.48E-09	8.04E-09
Ps90%/90% (-KTL) Biased	-8.81E-09	-9.51E-09	-9.65E-09	-1.10E-08	-1.32E-08	-1.37E-08	-1.09E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	-1.10E-10	-3.06E-10	-3.70E-10	-5.32E-10	-2.10E-10	-1.17E-09	-6.82E-10
Std Dev Un-Biased	4.12E-09	4.14E-09	4.44E-09	4.43E-09	4.83E-09	4.71E-09	4.34E-09
Ps90%/90% (+KTL) Un-Biased	1.12E-08	1.10E-08	1.18E-08	1.16E-08	1.30E-08	1.17E-08	1.12E-08
Ps90%/90% (-KTL) Un-Biased	-1.14E-08	-1.16E-08	-1.25E-08	-1.27E-08	-1.35E-08	-1.41E-08	-1.26E-08
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

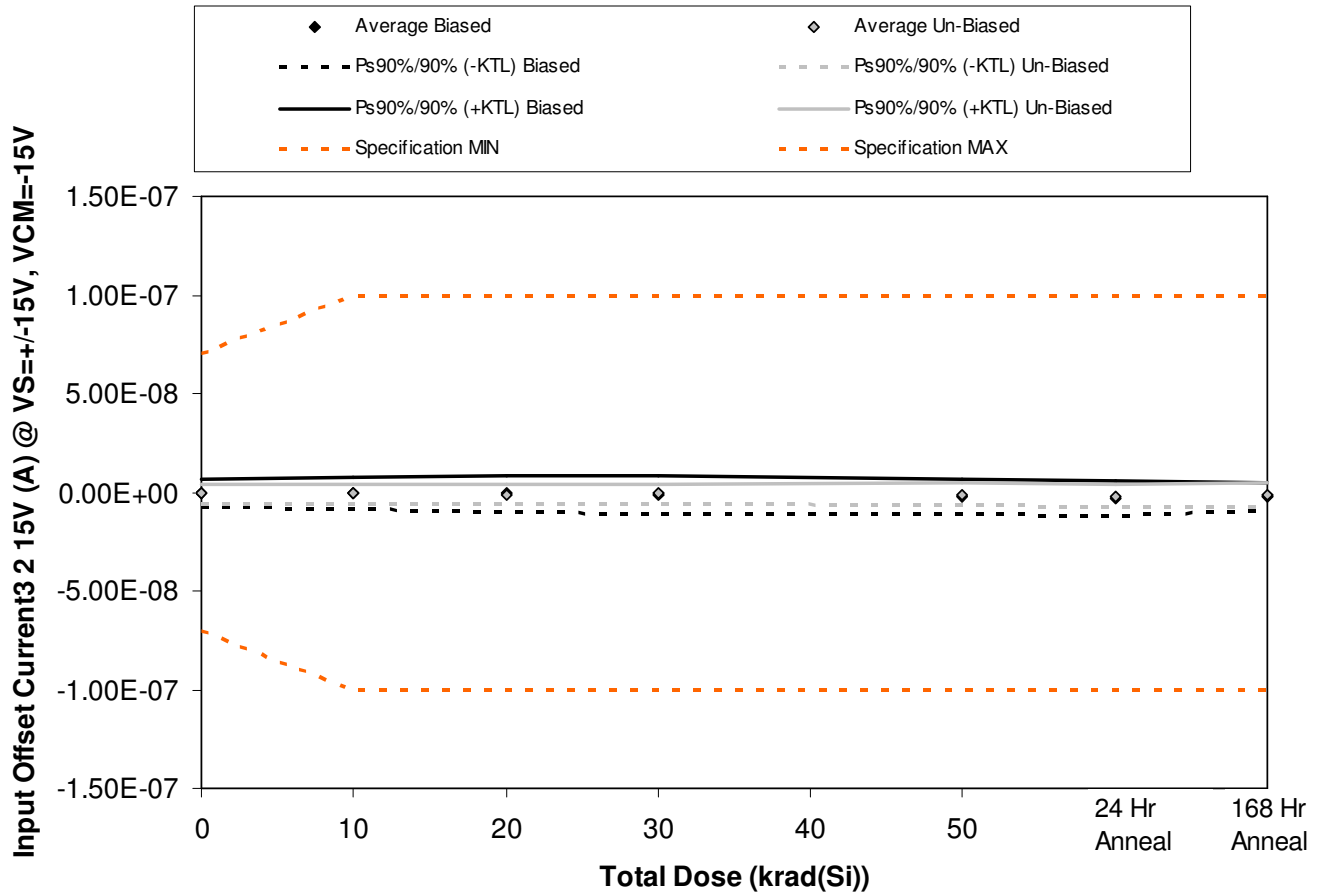


Figure 5.40. Plot of Input Offset Current3 2 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.40. Raw data for Input Offset Current3 2 15V (A) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current3 2 15V (A) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.91E-09	1.89E-09	1.69E-09	1.32E-09	-5.60E-10	-1.14E-09	-1.40E-10
563	-2.90E-09	-3.24E-09	-3.80E-09	-4.47E-09	-5.04E-09	-5.66E-09	-4.43E-09
564	-2.91E-09	-3.89E-09	-4.56E-09	-5.11E-09	-5.63E-09	-6.19E-09	-4.73E-09
567	-1.90E-10	-7.20E-10	-4.70E-10	-1.15E-09	-1.79E-09	-2.61E-09	-2.19E-09
569	2.12E-09	2.55E-09	2.78E-09	2.69E-09	2.09E-09	1.57E-09	9.40E-10
570	-2.44E-09	-2.25E-09	-2.58E-09	-2.57E-09	-2.79E-09	-3.43E-09	-3.03E-09
571	-1.22E-09	-1.56E-09	-1.45E-09	-8.20E-10	-1.90E-09	-3.00E-09	-2.56E-09
572	1.59E-09	1.70E-09	1.80E-09	2.02E-09	2.58E-09	1.47E-09	2.02E-09
573	2.40E-10	8.00E-11	-2.50E-10	-3.50E-10	-3.60E-10	-9.70E-10	-2.90E-10
574	-2.16E-09	-2.13E-09	-2.35E-09	-2.55E-09	-2.16E-09	-3.05E-09	-2.56E-09
584	2.42E-09	2.12E-09	1.64E-09	1.39E-09	1.27E-09	1.07E-09	9.30E-10
585	1.39E-09	-1.40E-10	-1.90E-10	-2.30E-10	-1.20E-10	-1.50E-10	-2.50E-10
<b>Biased Statistics</b>							
Average Biased	-3.94E-10	-6.82E-10	-8.72E-10	-1.34E-09	-2.19E-09	-2.81E-09	-2.11E-09
Std Dev Biased	2.46E-09	2.91E-09	3.25E-09	3.44E-09	3.21E-09	3.22E-09	2.52E-09
Ps90%/90% (+KTL) Biased	6.36E-09	7.30E-09	8.04E-09	8.09E-09	6.60E-09	6.03E-09	4.80E-09
Ps90%/90% (-KTL) Biased	-7.15E-09	-8.66E-09	-9.78E-09	-1.08E-08	-1.10E-08	-1.16E-08	-9.02E-09
<b>Un-Biased Statistics</b>							
Average Un-Biased	-7.98E-10	-8.32E-10	-9.66E-10	-8.54E-10	-9.26E-10	-1.80E-09	-1.28E-09
Std Dev Un-Biased	1.70E-09	1.69E-09	1.80E-09	1.89E-09	2.15E-09	2.06E-09	2.13E-09
Ps90%/90% (+KTL) Un-Biased	3.85E-09	3.81E-09	3.96E-09	4.34E-09	4.98E-09	3.86E-09	4.57E-09
Ps90%/90% (-KTL) Un-Biased	-5.45E-09	-5.47E-09	-5.89E-09	-6.05E-09	-6.83E-09	-7.46E-09	-7.13E-09
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

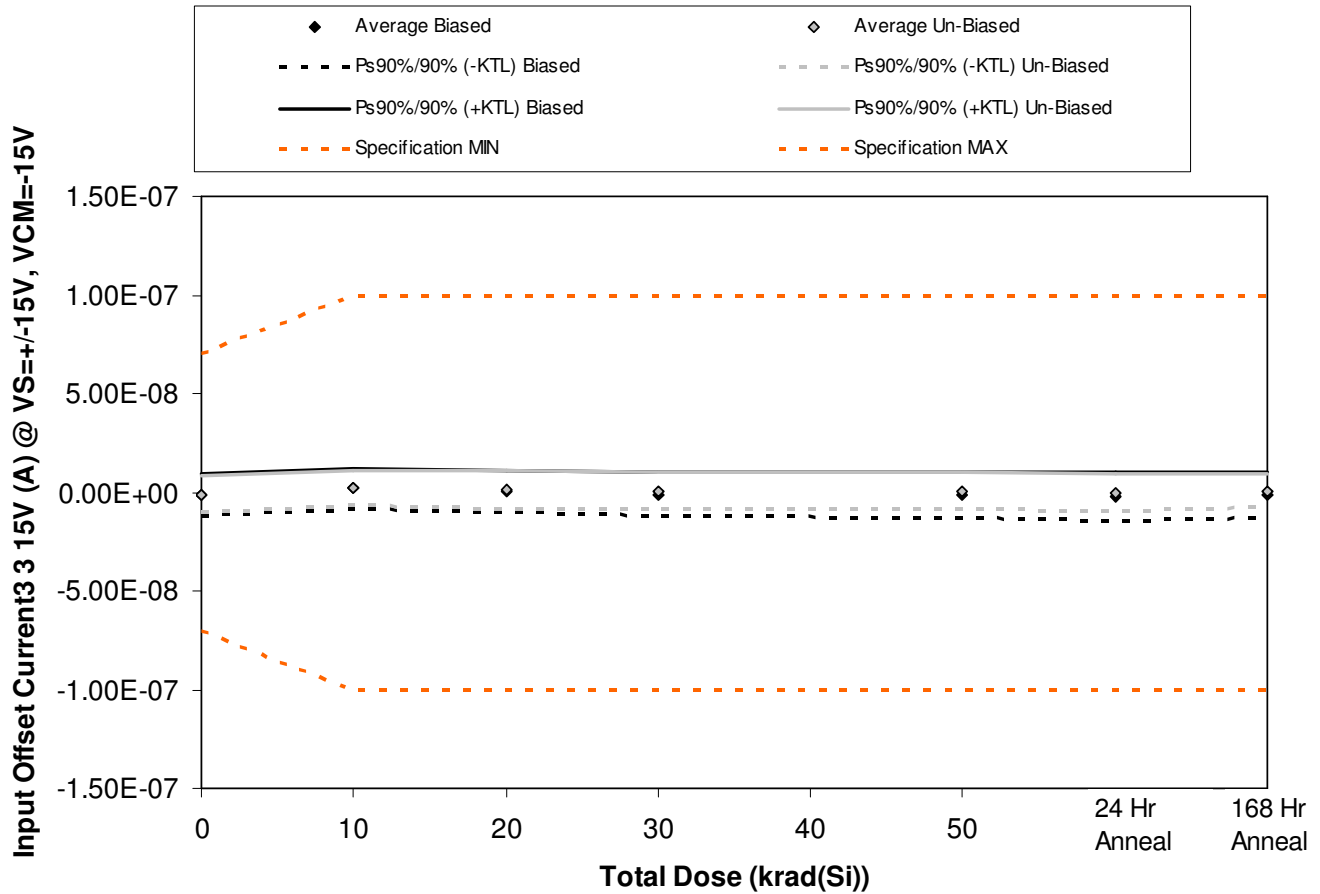


Figure 5.41. Plot of Input Offset Current3 3 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.41. Raw data for Input Offset Current3 3 15V (A) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current3 3 15V (A) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-1.82E-09	1.15E-09	-7.00E-11	-1.53E-09	-2.00E-09	-2.66E-09	-1.54E-09
563	-1.19E-09	2.61E-09	8.00E-10	-6.90E-10	-9.40E-10	-2.08E-09	-1.65E-09
564	-2.38E-09	2.10E-10	-1.52E-09	-2.40E-09	-2.77E-09	-3.19E-09	-3.26E-09
567	5.34E-09	7.81E-09	6.34E-09	5.52E-09	5.17E-09	5.11E-09	5.62E-09
569	-5.30E-09	-2.59E-09	-4.17E-09	-5.70E-09	-6.68E-09	-7.18E-09	-5.31E-09
570	1.73E-09	4.79E-09	3.90E-09	3.27E-09	3.27E-09	2.49E-09	2.73E-09
571	-3.95E-09	-7.40E-10	-1.71E-09	-1.74E-09	-2.46E-09	-3.33E-09	-1.95E-09
572	-2.10E-10	2.98E-09	2.11E-09	8.40E-10	1.61E-09	3.00E-10	1.25E-09
573	2.70E-09	5.80E-09	4.82E-09	4.37E-09	4.50E-09	3.69E-09	4.38E-09
574	-5.02E-09	-1.86E-09	-3.08E-09	-3.78E-09	-3.11E-09	-3.77E-09	-2.98E-09
584	-1.00E-10	3.16E-09	1.94E-09	1.16E-09	1.35E-09	1.20E-09	9.30E-10
585	-6.94E-09	-4.92E-09	-5.85E-09	-6.48E-09	-6.19E-09	-6.36E-09	-6.50E-09
<b>Biased Statistics</b>							
Average Biased	-1.07E-09	1.84E-09	2.76E-10	-9.60E-10	-1.44E-09	-2.00E-09	-1.23E-09
Std Dev Biased	3.91E-09	3.84E-09	3.88E-09	4.09E-09	4.29E-09	4.45E-09	4.12E-09
Ps90%/90% (+KTL) Biased	9.66E-09	1.24E-08	1.09E-08	1.03E-08	1.03E-08	1.02E-08	1.01E-08
Ps90%/90% (-KTL) Biased	-1.18E-08	-8.69E-09	-1.04E-08	-1.22E-08	-1.32E-08	-1.42E-08	-1.25E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	-9.50E-10	2.19E-09	1.21E-09	5.92E-10	7.62E-10	-1.24E-10	6.86E-10
Std Dev Un-Biased	3.41E-09	3.37E-09	3.46E-09	3.39E-09	3.40E-09	3.36E-09	3.10E-09
Ps90%/90% (+KTL) Un-Biased	8.41E-09	1.14E-08	1.07E-08	9.90E-09	1.01E-08	9.09E-09	9.20E-09
Ps90%/90% (-KTL) Un-Biased	-1.03E-08	-7.04E-09	-8.29E-09	-8.71E-09	-8.57E-09	-9.33E-09	-7.82E-09
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

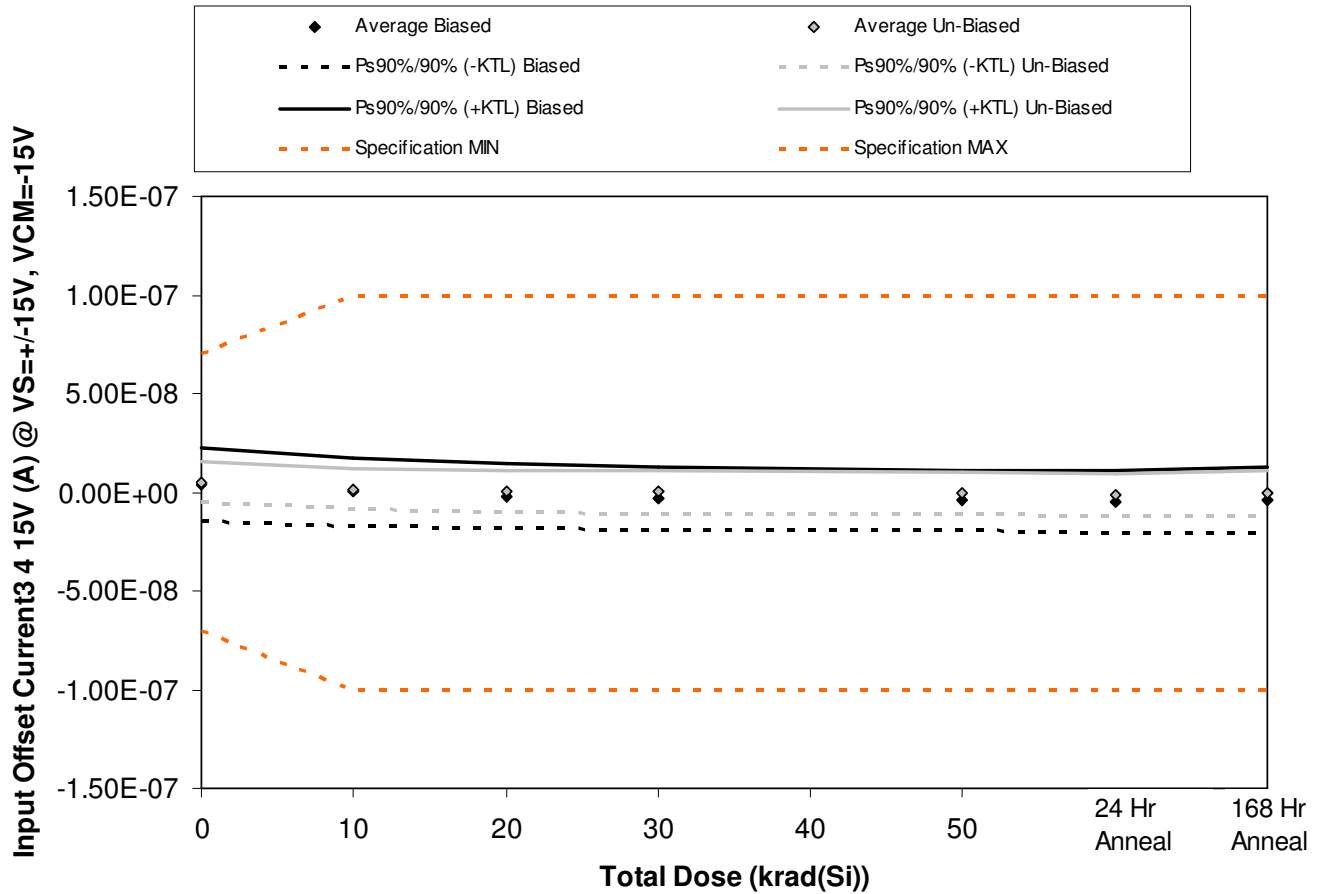


Figure 5.42. Plot of Input Offset Current3 4 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.42. Raw data for Input Offset Current3 4 15V (A) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current3 4 15V (A) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.13E-09	-2.12E-09	-3.68E-09	-4.90E-09	-5.82E-09	-6.39E-09	-5.48E-09
563	-6.80E-10	-5.11E-09	-7.10E-09	-7.68E-09	-9.01E-09	-1.06E-08	-9.10E-09
564	1.42E-08	9.81E-09	6.91E-09	5.61E-09	4.22E-09	3.60E-09	5.05E-09
567	7.26E-09	2.97E-09	6.30E-10	-4.00E-10	-2.09E-09	-1.89E-09	-1.24E-09
569	-2.67E-09	-5.38E-09	-6.95E-09	-8.32E-09	-8.61E-09	-9.16E-09	-9.57E-09
570	4.25E-09	7.40E-10	-9.60E-10	-1.07E-09	-1.16E-09	-2.20E-09	-1.38E-09
571	7.99E-09	4.41E-09	3.08E-09	2.67E-09	2.08E-09	1.53E-09	2.33E-09
572	1.01E-09	-2.59E-09	-3.82E-09	-4.75E-09	-4.36E-09	-5.45E-09	-4.94E-09
573	1.00E-08	6.64E-09	5.70E-09	5.32E-09	4.70E-09	3.64E-09	5.01E-09
574	2.66E-09	-5.10E-10	-1.93E-09	-2.06E-09	-3.32E-09	-3.80E-09	-3.27E-09
584	3.23E-09	-2.00E-11	-1.49E-09	-2.22E-09	-2.74E-09	-2.80E-09	-3.09E-09
585	-1.52E-09	-6.16E-09	-7.27E-09	-7.69E-09	-8.36E-09	-8.54E-09	-8.45E-09
<b>Biased Statistics</b>							
Average Biased	4.06E-09	3.40E-11	-2.04E-09	-3.14E-09	-4.26E-09	-4.88E-09	-4.07E-09
Std Dev Biased	6.81E-09	6.41E-09	5.91E-09	5.80E-09	5.49E-09	5.78E-09	6.10E-09
Ps90%/90% (+KTL) Biased	2.27E-08	1.76E-08	1.42E-08	1.28E-08	1.08E-08	1.10E-08	1.27E-08
Ps90%/90% (-KTL) Biased	-1.46E-08	-1.76E-08	-1.82E-08	-1.90E-08	-1.93E-08	-2.07E-08	-2.08E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.19E-09	1.74E-09	4.14E-10	2.20E-11	-4.12E-10	-1.26E-09	-4.50E-10
Std Dev Un-Biased	3.75E-09	3.74E-09	3.88E-09	3.98E-09	3.77E-09	3.76E-09	4.08E-09
Ps90%/90% (+KTL) Un-Biased	1.55E-08	1.20E-08	1.11E-08	1.09E-08	9.93E-09	9.07E-09	1.07E-08
Ps90%/90% (-KTL) Un-Biased	-5.08E-09	-8.52E-09	-1.02E-08	-1.09E-08	-1.08E-08	-1.16E-08	-1.16E-08
<b>Specification MIN</b>	<b>-7.00E-08</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>	<b>-1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.00E-08</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>	<b>1.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



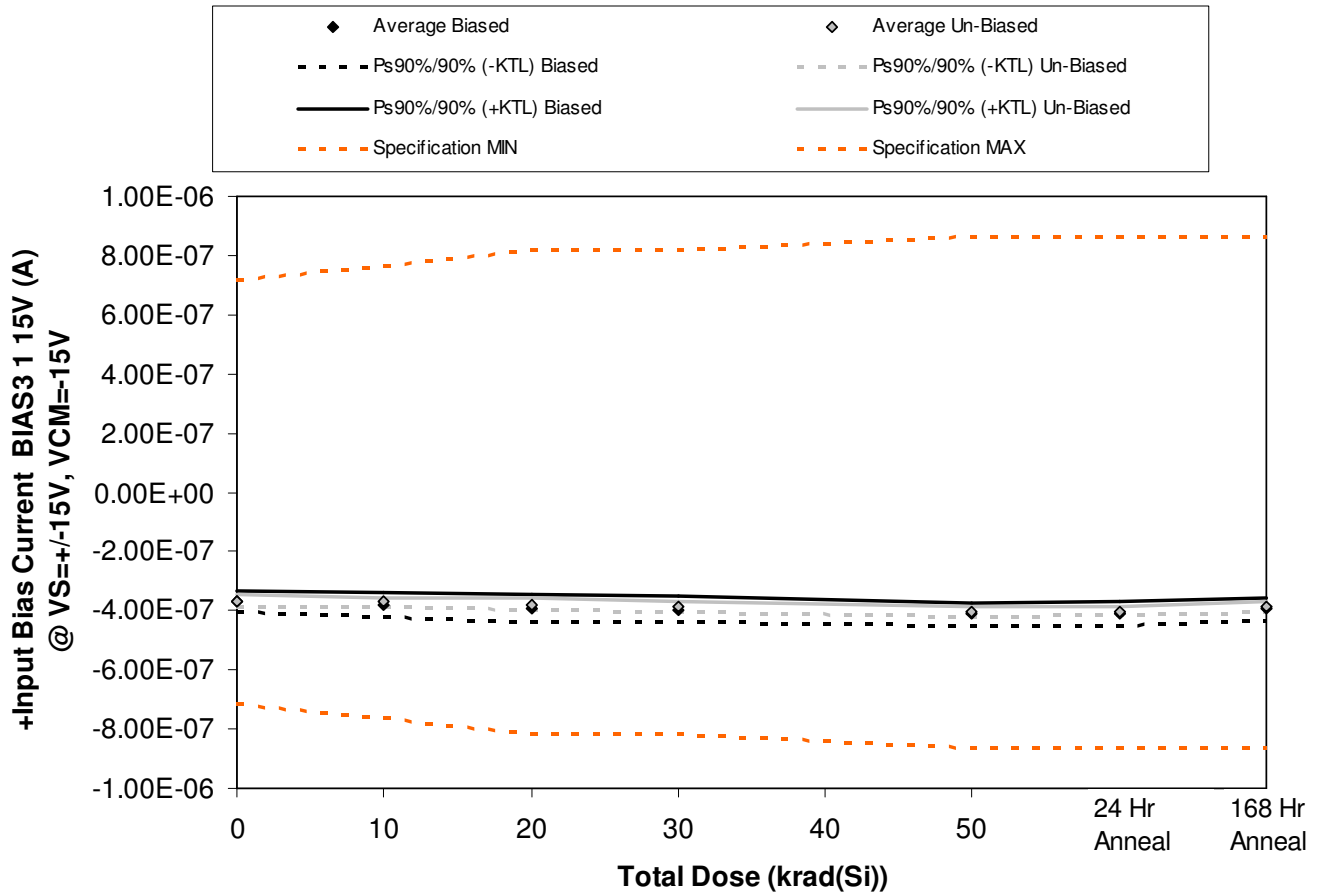


Figure 5.43. Plot of +Input Bias Current BIAS3 1 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.43. Raw data for +Input Bias Current BIAS3 1 15V (A) @ VS=+-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS3 1 15V (A) @ VS=+-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.48E-07	-3.58E-07	-3.63E-07	-3.71E-07	-3.88E-07	-3.87E-07	-3.73E-07
563	-3.67E-07	-3.80E-07	-3.87E-07	-3.92E-07	-4.09E-07	-4.10E-07	-3.91E-07
564	-3.73E-07	-3.86E-07	-3.97E-07	-4.01E-07	-4.18E-07	-4.18E-07	-3.99E-07
567	-3.84E-07	-3.98E-07	-4.09E-07	-4.11E-07	-4.25E-07	-4.27E-07	-4.09E-07
569	-3.72E-07	-3.86E-07	-3.98E-07	-4.03E-07	-4.16E-07	-4.15E-07	-3.99E-07
570	-3.81E-07	-3.82E-07	-3.91E-07	-3.97E-07	-4.13E-07	-4.13E-07	-3.98E-07
571	-3.64E-07	-3.69E-07	-3.77E-07	-3.85E-07	-4.02E-07	-4.03E-07	-3.84E-07
572	-3.62E-07	-3.67E-07	-3.72E-07	-3.79E-07	-4.00E-07	-3.99E-07	-3.83E-07
573	-3.68E-07	-3.72E-07	-3.78E-07	-3.85E-07	-4.02E-07	-4.02E-07	-3.86E-07
574	-3.66E-07	-3.69E-07	-3.77E-07	-3.84E-07	-4.00E-07	-4.02E-07	-3.85E-07
584	-3.48E-07	-3.45E-07	-3.46E-07	-3.48E-07	-3.51E-07	-3.52E-07	-3.52E-07
585	-3.58E-07	-3.59E-07	-3.55E-07	-3.58E-07	-3.55E-07	-3.59E-07	-3.61E-07
<b>Biased Statistics</b>							
Average Biased	-3.69E-07	-3.82E-07	-3.91E-07	-3.96E-07	-4.11E-07	-4.12E-07	-3.94E-07
Std Dev Biased	1.34E-08	1.45E-08	1.74E-08	1.54E-08	1.40E-08	1.49E-08	1.35E-08
Ps90%/90% (+KTL) Biased	-3.32E-07	-3.42E-07	-3.43E-07	-3.53E-07	-3.73E-07	-3.71E-07	-3.57E-07
Ps90%/90% (-KTL) Biased	-4.05E-07	-4.21E-07	-4.38E-07	-4.38E-07	-4.50E-07	-4.53E-07	-4.31E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.68E-07	-3.72E-07	-3.79E-07	-3.86E-07	-4.03E-07	-4.03E-07	-3.87E-07
Std Dev Un-Biased	7.49E-09	6.09E-09	7.01E-09	6.70E-09	5.62E-09	5.24E-09	6.10E-09
Ps90%/90% (+KTL) Un-Biased	-3.48E-07	-3.55E-07	-3.60E-07	-3.68E-07	-3.88E-07	-3.89E-07	-3.70E-07
Ps90%/90% (-KTL) Un-Biased	-3.89E-07	-3.88E-07	-3.98E-07	-4.04E-07	-4.19E-07	-4.18E-07	-4.04E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

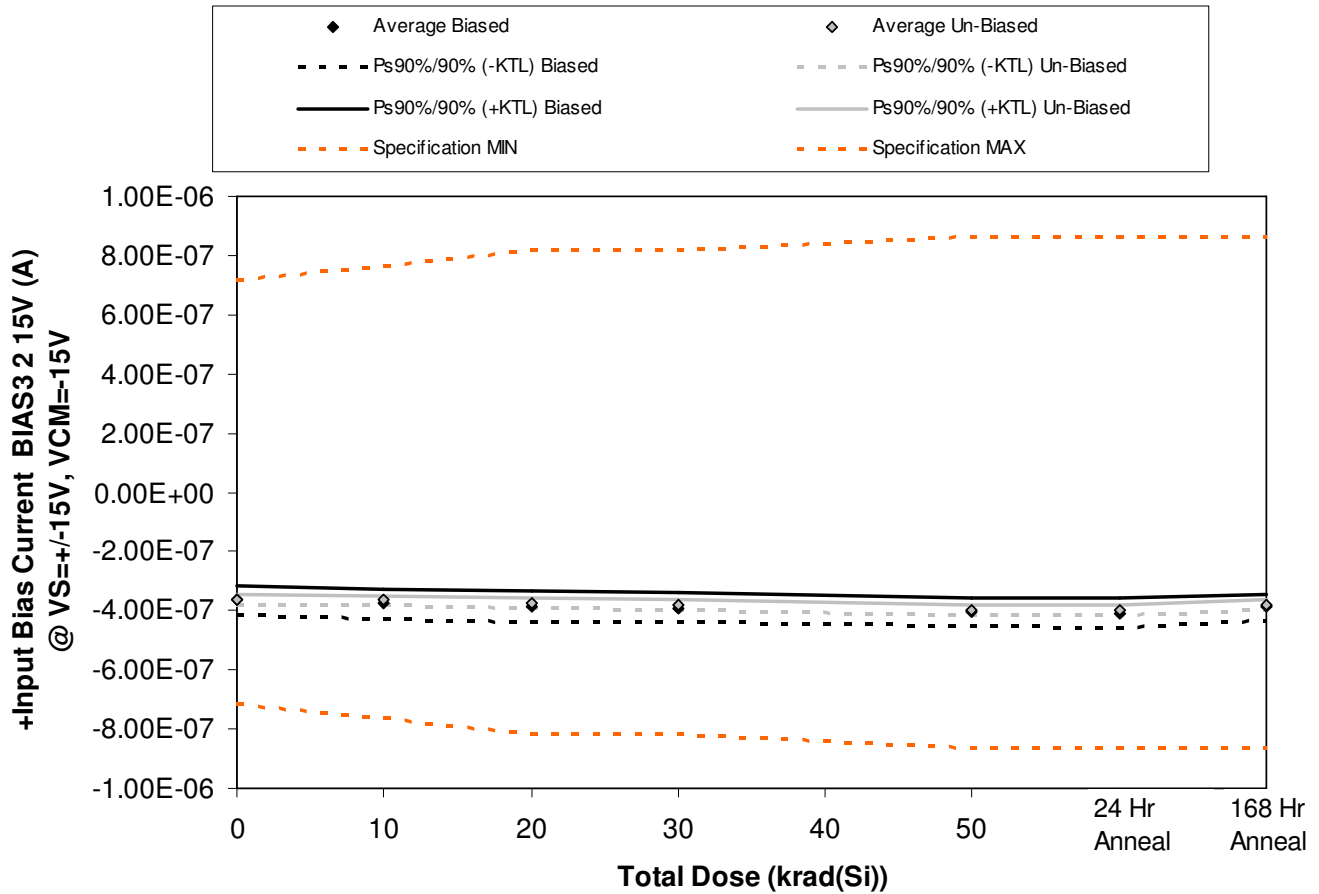


Figure 5.44. Plot of +Input Bias Current BIAS3 2 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.44. Raw data for +Input Bias Current BIAS3 2 15V (A) @ VS=+-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS3 2 15V (A) @ VS=+-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.38E-07	-3.50E-07	-3.56E-07	-3.64E-07	-3.81E-07	-3.82E-07	-3.65E-07
563	-3.88E-07	-4.00E-07	-4.08E-07	-4.13E-07	-4.27E-07	-4.28E-07	-4.09E-07
564	-3.69E-07	-3.84E-07	-3.95E-07	-3.98E-07	-4.13E-07	-4.15E-07	-3.95E-07
567	-3.71E-07	-3.84E-07	-3.94E-07	-3.98E-07	-4.11E-07	-4.14E-07	-3.96E-07
569	-3.55E-07	-3.69E-07	-3.79E-07	-3.83E-07	-3.97E-07	-3.98E-07	-3.80E-07
570	-3.70E-07	-3.72E-07	-3.81E-07	-3.88E-07	-4.05E-07	-4.05E-07	-3.89E-07
571	-3.66E-07	-3.68E-07	-3.78E-07	-3.84E-07	-4.02E-07	-4.01E-07	-3.85E-07
572	-3.58E-07	-3.61E-07	-3.68E-07	-3.76E-07	-3.96E-07	-3.95E-07	-3.78E-07
573	-3.55E-07	-3.58E-07	-3.66E-07	-3.70E-07	-3.88E-07	-3.88E-07	-3.73E-07
574	-3.62E-07	-3.65E-07	-3.73E-07	-3.79E-07	-3.99E-07	-4.00E-07	-3.81E-07
584	-3.69E-07	-3.64E-07	-3.67E-07	-3.67E-07	-3.71E-07	-3.72E-07	-3.71E-07
585	-3.66E-07	-3.70E-07	-3.66E-07	-3.67E-07	-3.66E-07	-3.68E-07	-3.71E-07
<b>Biased Statistics</b>							
Average Biased	-3.64E-07	-3.77E-07	-3.86E-07	-3.91E-07	-4.06E-07	-4.07E-07	-3.89E-07
Std Dev Biased	1.87E-08	1.89E-08	1.97E-08	1.84E-08	1.72E-08	1.78E-08	1.69E-08
Ps90%/90% (+KTL) Biased	-3.13E-07	-3.26E-07	-3.32E-07	-3.41E-07	-3.58E-07	-3.59E-07	-3.43E-07
Ps90%/90% (-KTL) Biased	-4.16E-07	-4.29E-07	-4.40E-07	-4.42E-07	-4.53E-07	-4.56E-07	-4.35E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.62E-07	-3.65E-07	-3.73E-07	-3.80E-07	-3.98E-07	-3.98E-07	-3.81E-07
Std Dev Un-Biased	5.97E-09	5.53E-09	6.61E-09	6.79E-09	6.36E-09	6.42E-09	6.26E-09
Ps90%/90% (+KTL) Un-Biased	-3.45E-07	-3.50E-07	-3.55E-07	-3.61E-07	-3.80E-07	-3.80E-07	-3.64E-07
Ps90%/90% (-KTL) Un-Biased	-3.78E-07	-3.80E-07	-3.91E-07	-3.98E-07	-4.15E-07	-4.15E-07	-3.98E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

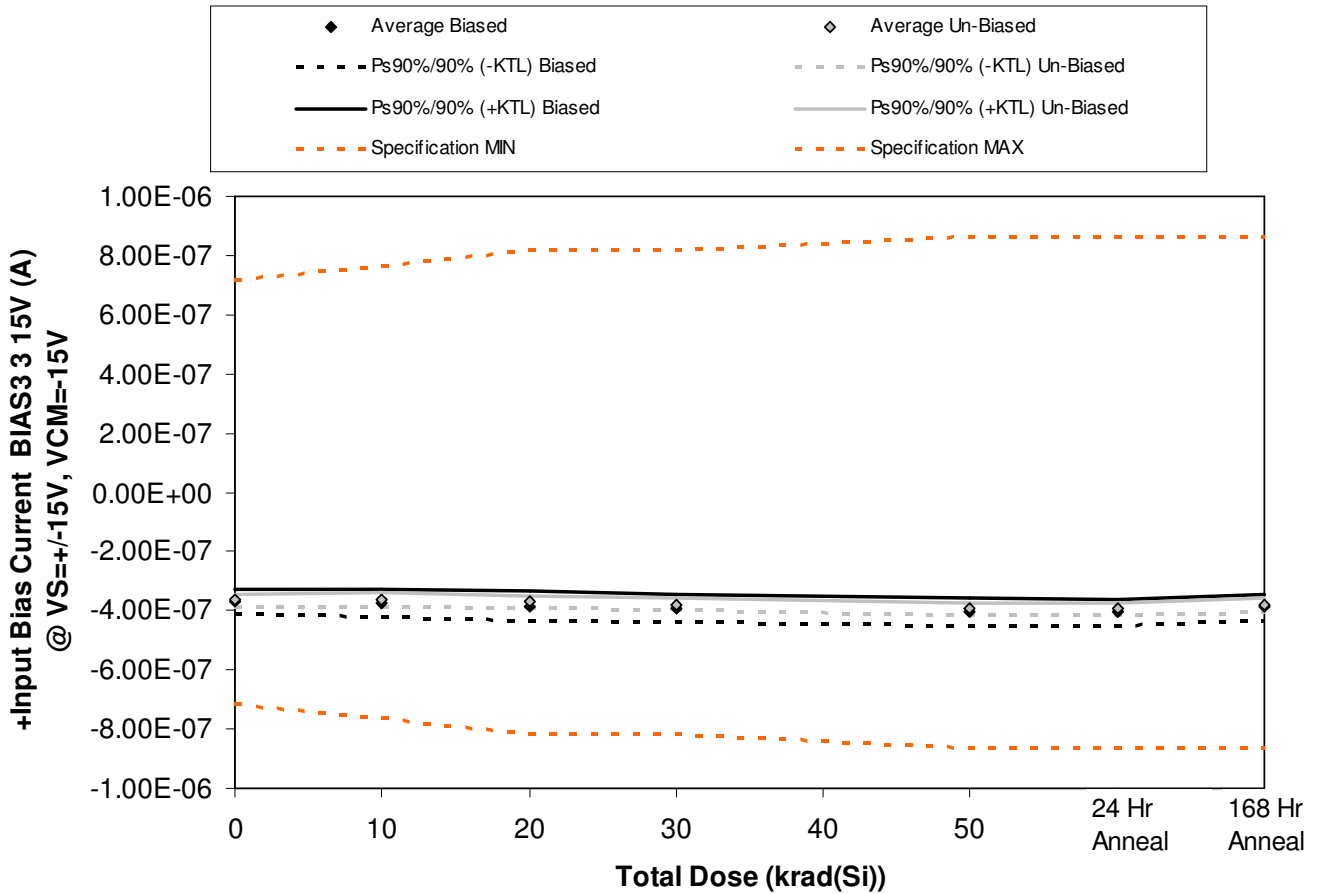


Figure 5.45. Plot of +Input Bias Current BIAS3 3 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.45. Raw data for +Input Bias Current BIAS3 3 15V (A) @ VS=+-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS3 3 15V (A) @ VS=+-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.46E-07	-3.51E-07	-3.56E-07	-3.64E-07	-3.79E-07	-3.80E-07	-3.65E-07
563	-3.86E-07	-3.92E-07	-4.02E-07	-4.06E-07	-4.19E-07	-4.22E-07	-4.04E-07
564	-3.79E-07	-3.88E-07	-3.97E-07	-4.02E-07	-4.17E-07	-4.17E-07	-3.99E-07
567	-3.73E-07	-3.81E-07	-3.92E-07	-3.95E-07	-4.08E-07	-4.11E-07	-3.92E-07
569	-3.60E-07	-3.69E-07	-3.79E-07	-3.84E-07	-3.98E-07	-3.98E-07	-3.81E-07
570	-3.74E-07	-3.72E-07	-3.78E-07	-3.88E-07	-4.04E-07	-4.03E-07	-3.90E-07
571	-3.70E-07	-3.66E-07	-3.76E-07	-3.81E-07	-3.97E-07	-3.98E-07	-3.83E-07
572	-3.62E-07	-3.60E-07	-3.68E-07	-3.76E-07	-3.92E-07	-3.93E-07	-3.77E-07
573	-3.54E-07	-3.51E-07	-3.59E-07	-3.65E-07	-3.82E-07	-3.82E-07	-3.66E-07
574	-3.68E-07	-3.64E-07	-3.73E-07	-3.81E-07	-3.97E-07	-3.98E-07	-3.82E-07
584	-3.74E-07	-3.64E-07	-3.66E-07	-3.68E-07	-3.71E-07	-3.72E-07	-3.72E-07
585	-3.83E-07	-3.79E-07	-3.77E-07	-3.77E-07	-3.74E-07	-3.78E-07	-3.81E-07
<b>Biased Statistics</b>							
Average Biased	-3.69E-07	-3.76E-07	-3.85E-07	-3.90E-07	-4.04E-07	-4.06E-07	-3.88E-07
Std Dev Biased	1.59E-08	1.67E-08	1.84E-08	1.70E-08	1.63E-08	1.66E-08	1.58E-08
Ps90%/90% (+KTL) Biased	-3.25E-07	-3.30E-07	-3.35E-07	-3.43E-07	-3.60E-07	-3.60E-07	-3.45E-07
Ps90%/90% (-KTL) Biased	-4.12E-07	-4.22E-07	-4.35E-07	-4.37E-07	-4.49E-07	-4.51E-07	-4.31E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.65E-07	-3.63E-07	-3.71E-07	-3.78E-07	-3.95E-07	-3.95E-07	-3.79E-07
Std Dev Un-Biased	7.65E-09	7.61E-09	7.74E-09	8.28E-09	8.17E-09	7.97E-09	8.96E-09
Ps90%/90% (+KTL) Un-Biased	-3.44E-07	-3.42E-07	-3.50E-07	-3.55E-07	-3.72E-07	-3.73E-07	-3.55E-07
Ps90%/90% (-KTL) Un-Biased	-3.86E-07	-3.83E-07	-3.92E-07	-4.01E-07	-4.17E-07	-4.17E-07	-4.04E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

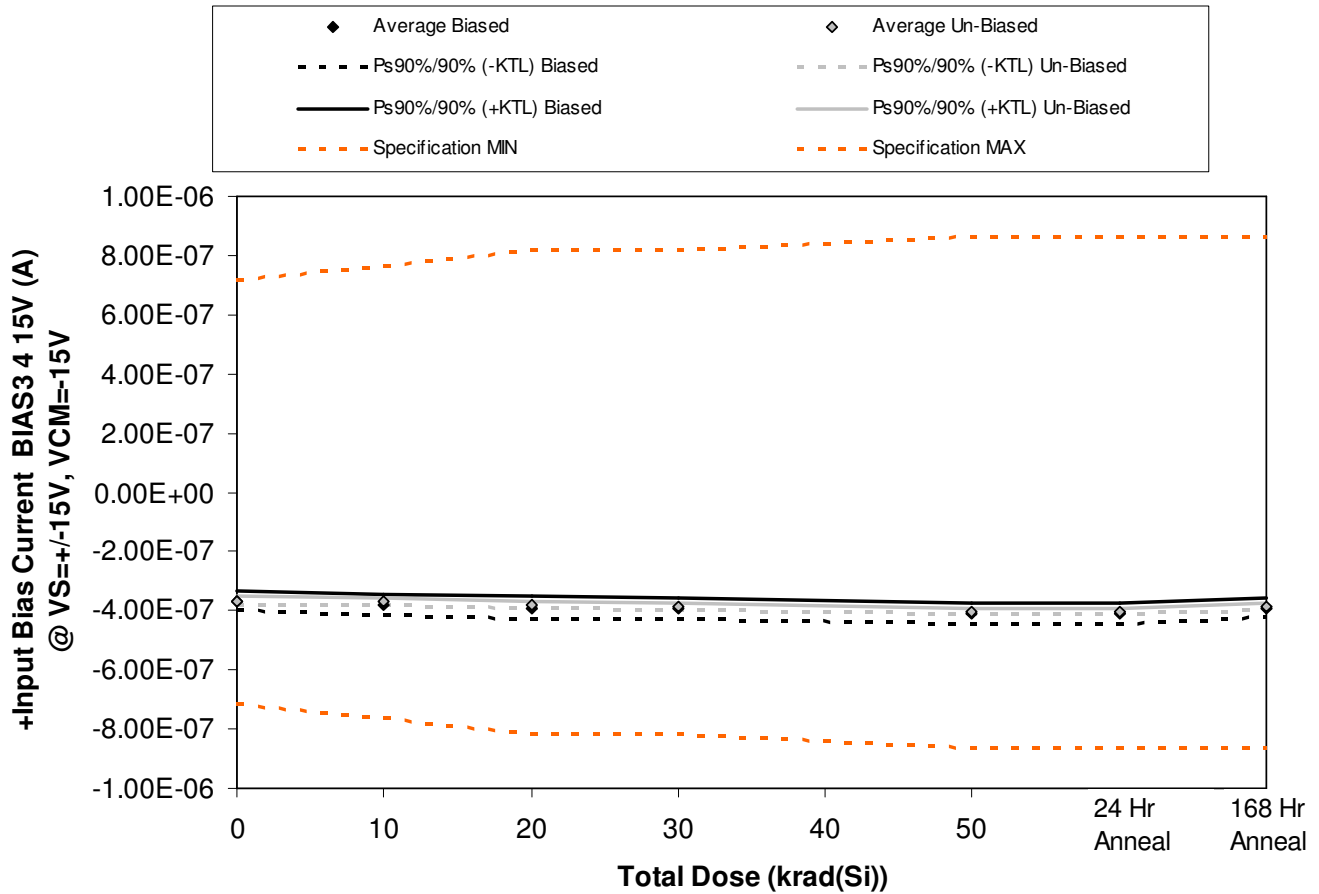


Figure 5.46. Plot of +Input Bias Current BIAS3 4 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.46. Raw data for +Input Bias Current BIAS3 4 15V (A) @ VS=+-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS3 4 15V (A) @ VS=+-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.50E-07	-3.60E-07	-3.68E-07	-3.74E-07	-3.91E-07	-3.91E-07	-3.74E-07
563	-3.66E-07	-3.77E-07	-3.87E-07	-3.93E-07	-4.08E-07	-4.10E-07	-3.89E-07
564	-3.62E-07	-3.78E-07	-3.88E-07	-3.92E-07	-4.08E-07	-4.09E-07	-3.90E-07
567	-3.81E-07	-3.95E-07	-4.06E-07	-4.08E-07	-4.24E-07	-4.25E-07	-4.06E-07
569	-3.74E-07	-3.88E-07	-3.99E-07	-4.03E-07	-4.18E-07	-4.17E-07	-3.99E-07
570	-3.74E-07	-3.76E-07	-3.84E-07	-3.90E-07	-4.06E-07	-4.05E-07	-3.92E-07
571	-3.60E-07	-3.63E-07	-3.73E-07	-3.80E-07	-3.99E-07	-3.98E-07	-3.80E-07
572	-3.66E-07	-3.69E-07	-3.77E-07	-3.86E-07	-4.05E-07	-4.04E-07	-3.88E-07
573	-3.68E-07	-3.72E-07	-3.78E-07	-3.84E-07	-4.03E-07	-4.03E-07	-3.87E-07
574	-3.66E-07	-3.70E-07	-3.76E-07	-3.83E-07	-4.01E-07	-4.03E-07	-3.87E-07
584	-3.35E-07	-3.34E-07	-3.35E-07	-3.35E-07	-3.38E-07	-3.39E-07	-3.38E-07
585	-3.55E-07	-3.57E-07	-3.54E-07	-3.55E-07	-3.54E-07	-3.57E-07	-3.60E-07
<b>Biased Statistics</b>							
Average Biased	-3.67E-07	-3.80E-07	-3.89E-07	-3.94E-07	-4.10E-07	-4.10E-07	-3.92E-07
Std Dev Biased	1.17E-08	1.32E-08	1.45E-08	1.31E-08	1.26E-08	1.27E-08	1.21E-08
Ps90%/90% (+KTL) Biased	-3.34E-07	-3.43E-07	-3.50E-07	-3.58E-07	-3.75E-07	-3.75E-07	-3.58E-07
Ps90%/90% (-KTL) Biased	-3.99E-07	-4.16E-07	-4.29E-07	-4.30E-07	-4.44E-07	-4.45E-07	-4.25E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.67E-07	-3.70E-07	-3.78E-07	-3.85E-07	-4.03E-07	-4.02E-07	-3.87E-07
Std Dev Un-Biased	4.96E-09	4.77E-09	4.31E-09	3.91E-09	3.08E-09	2.70E-09	4.27E-09
Ps90%/90% (+KTL) Un-Biased	-3.53E-07	-3.57E-07	-3.66E-07	-3.74E-07	-3.94E-07	-3.95E-07	-3.75E-07
Ps90%/90% (-KTL) Un-Biased	-3.80E-07	-3.83E-07	-3.90E-07	-3.95E-07	-4.11E-07	-4.10E-07	-3.98E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

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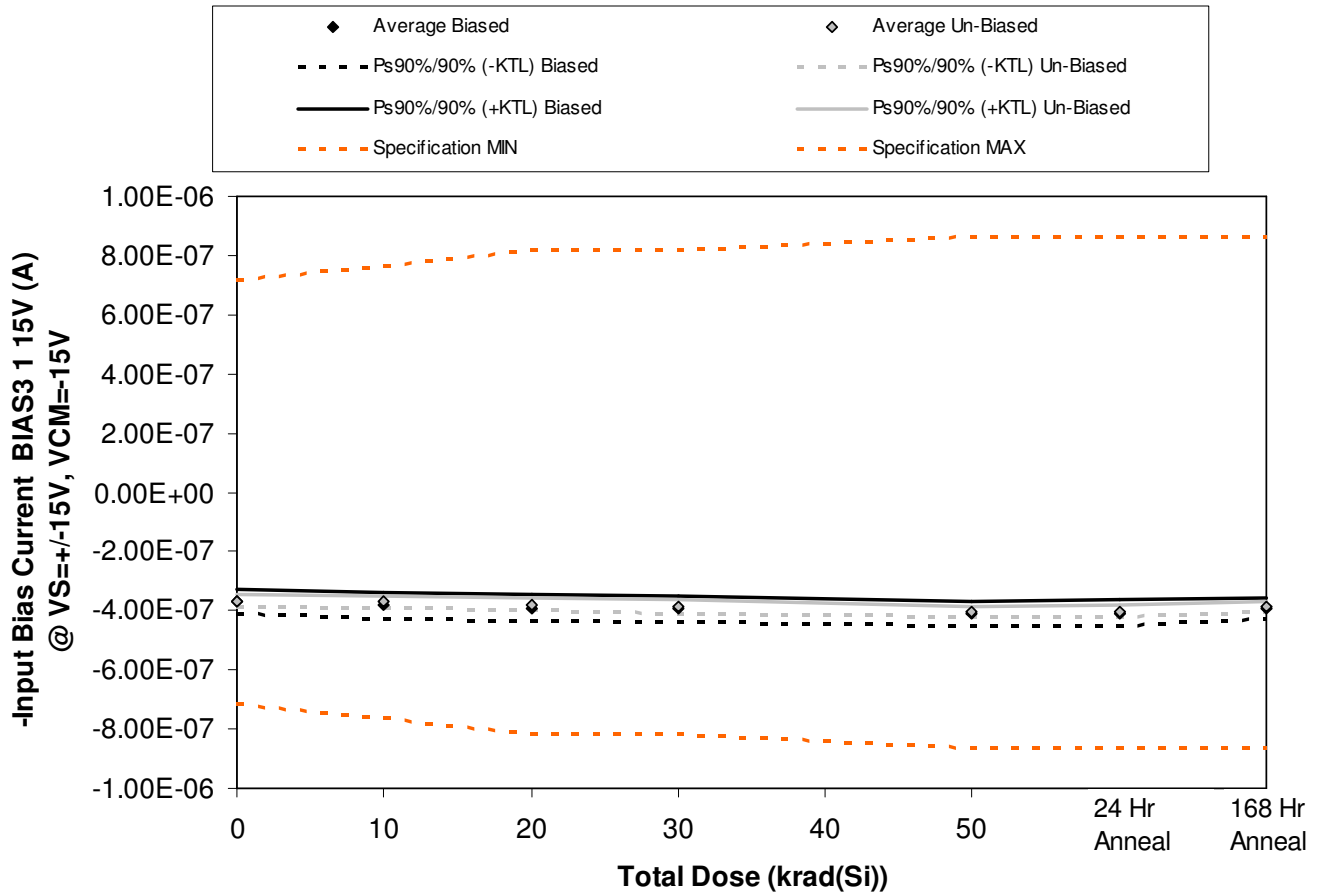


Figure 5.47. Plot of -Input Bias Current BIAS3 1 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.47. Raw data for -Input Bias Current BIAS3 1 15V (A) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS3 1 15V (A) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.51E-07	-3.60E-07	-3.64E-07	-3.72E-07	-3.87E-07	-3.85E-07	-3.74E-07
563	-3.62E-07	-3.74E-07	-3.83E-07	-3.87E-07	-4.02E-07	-4.02E-07	-3.85E-07
564	-3.72E-07	-3.88E-07	-3.95E-07	-3.98E-07	-4.14E-07	-4.12E-07	-3.96E-07
567	-3.89E-07	-4.04E-07	-4.10E-07	-4.16E-07	-4.29E-07	-4.29E-07	-4.11E-07
569	-3.74E-07	-3.87E-07	-3.96E-07	-4.00E-07	-4.15E-07	-4.14E-07	-3.97E-07
570	-3.78E-07	-3.83E-07	-3.89E-07	-3.98E-07	-4.13E-07	-4.12E-07	-3.97E-07
571	-3.59E-07	-3.61E-07	-3.71E-07	-3.76E-07	-3.94E-07	-3.94E-07	-3.78E-07
572	-3.65E-07	-3.67E-07	-3.74E-07	-3.81E-07	-4.02E-07	-4.00E-07	-3.86E-07
573	-3.65E-07	-3.69E-07	-3.74E-07	-3.81E-07	-4.00E-07	-3.98E-07	-3.83E-07
574	-3.71E-07	-3.75E-07	-3.81E-07	-3.87E-07	-4.05E-07	-4.05E-07	-3.90E-07
584	-3.35E-07	-3.33E-07	-3.34E-07	-3.33E-07	-3.36E-07	-3.37E-07	-3.36E-07
585	-3.60E-07	-3.58E-07	-3.55E-07	-3.57E-07	-3.54E-07	-3.58E-07	-3.61E-07
<b>Biased Statistics</b>							
Average Biased	-3.70E-07	-3.83E-07	-3.90E-07	-3.95E-07	-4.09E-07	-4.08E-07	-3.92E-07
Std Dev Biased	1.44E-08	1.67E-08	1.71E-08	1.62E-08	1.57E-08	1.62E-08	1.40E-08
Ps90%/90% (+KTL) Biased	-3.30E-07	-3.37E-07	-3.43E-07	-3.50E-07	-3.66E-07	-3.64E-07	-3.54E-07
Ps90%/90% (-KTL) Biased	-4.09E-07	-4.28E-07	-4.37E-07	-4.39E-07	-4.52E-07	-4.53E-07	-4.31E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.68E-07	-3.71E-07	-3.78E-07	-3.85E-07	-4.03E-07	-4.02E-07	-3.87E-07
Std Dev Un-Biased	7.20E-09	8.12E-09	7.34E-09	8.24E-09	7.01E-09	6.91E-09	7.30E-09
Ps90%/90% (+KTL) Un-Biased	-3.48E-07	-3.49E-07	-3.58E-07	-3.62E-07	-3.84E-07	-3.83E-07	-3.67E-07
Ps90%/90% (-KTL) Un-Biased	-3.88E-07	-3.93E-07	-3.98E-07	-4.07E-07	-4.22E-07	-4.21E-07	-4.07E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

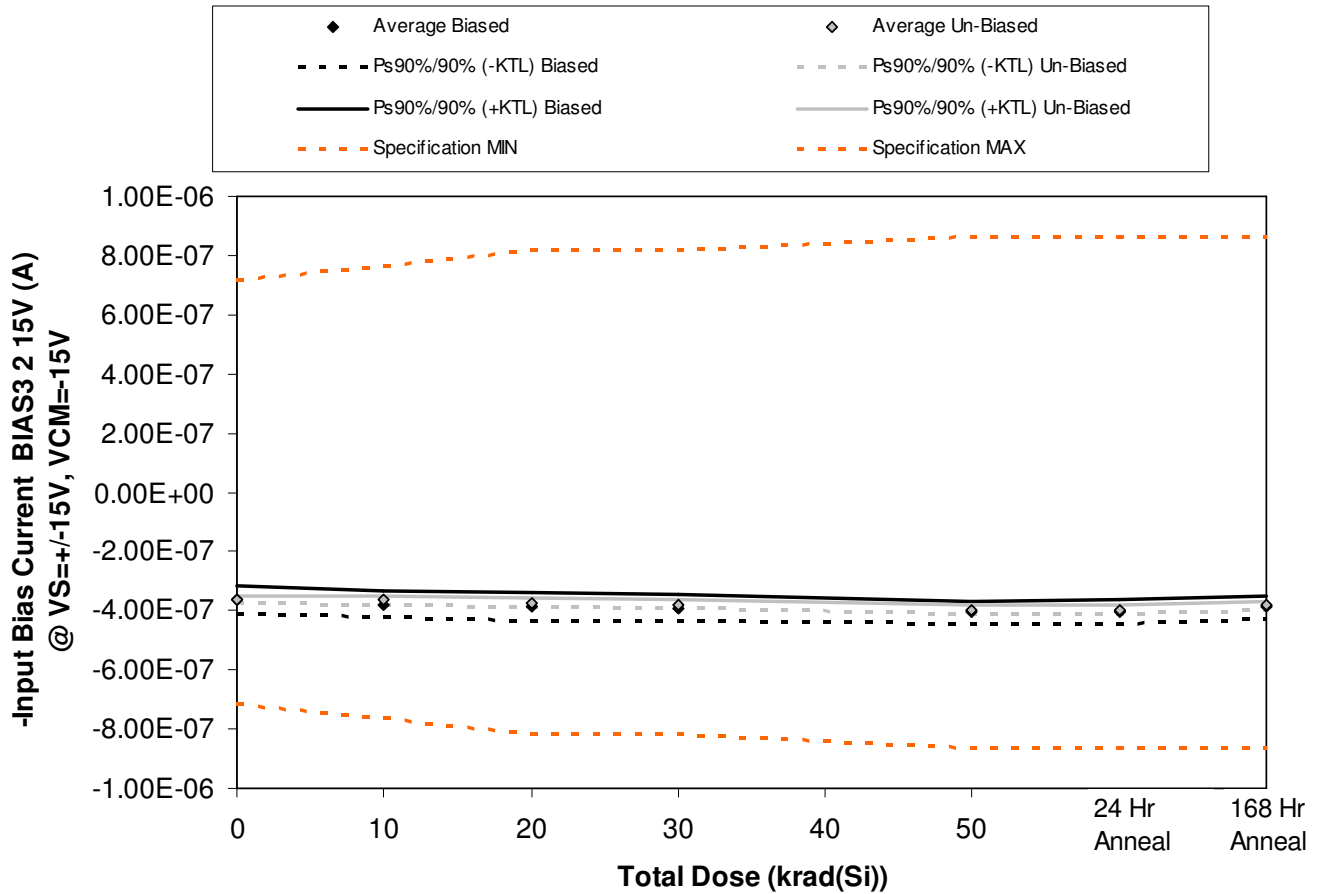


Figure 5.48. Plot of -Input Bias Current BIAS3 2 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.48. Raw data for -Input Bias Current BIAS3 2 15V (A) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS3 2 15V (A) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.40E-07	-3.54E-07	-3.60E-07	-3.66E-07	-3.84E-07	-3.83E-07	-3.67E-07
563	-3.86E-07	-3.98E-07	-4.05E-07	-4.09E-07	-4.23E-07	-4.24E-07	-4.06E-07
564	-3.68E-07	-3.83E-07	-3.90E-07	-3.96E-07	-4.07E-07	-4.08E-07	-3.92E-07
567	-3.72E-07	-3.84E-07	-3.94E-07	-3.99E-07	-4.10E-07	-4.13E-07	-3.94E-07
569	-3.59E-07	-3.73E-07	-3.83E-07	-3.87E-07	-4.03E-07	-4.00E-07	-3.82E-07
570	-3.69E-07	-3.72E-07	-3.79E-07	-3.87E-07	-4.03E-07	-4.03E-07	-3.88E-07
571	-3.64E-07	-3.67E-07	-3.76E-07	-3.83E-07	-4.02E-07	-4.00E-07	-3.83E-07
572	-3.59E-07	-3.64E-07	-3.71E-07	-3.79E-07	-3.98E-07	-3.97E-07	-3.82E-07
573	-3.57E-07	-3.61E-07	-3.65E-07	-3.72E-07	-3.89E-07	-3.88E-07	-3.74E-07
574	-3.60E-07	-3.63E-07	-3.71E-07	-3.77E-07	-3.96E-07	-3.97E-07	-3.80E-07
584	-3.73E-07	-3.69E-07	-3.69E-07	-3.71E-07	-3.74E-07	-3.74E-07	-3.72E-07
585	-3.69E-07	-3.70E-07	-3.67E-07	-3.68E-07	-3.66E-07	-3.69E-07	-3.74E-07
<b>Biased Statistics</b>							
Average Biased	-3.65E-07	-3.78E-07	-3.86E-07	-3.91E-07	-4.05E-07	-4.06E-07	-3.88E-07
Std Dev Biased	1.72E-08	1.63E-08	1.65E-08	1.60E-08	1.42E-08	1.52E-08	1.46E-08
Ps90%/90% (+KTL) Biased	-3.18E-07	-3.33E-07	-3.41E-07	-3.47E-07	-3.66E-07	-3.64E-07	-3.48E-07
Ps90%/90% (-KTL) Biased	-4.12E-07	-4.23E-07	-4.32E-07	-4.35E-07	-4.44E-07	-4.47E-07	-4.28E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.62E-07	-3.66E-07	-3.73E-07	-3.80E-07	-3.98E-07	-3.97E-07	-3.81E-07
Std Dev Un-Biased	4.70E-09	4.54E-09	5.49E-09	5.68E-09	5.44E-09	5.36E-09	5.27E-09
Ps90%/90% (+KTL) Un-Biased	-3.49E-07	-3.53E-07	-3.57E-07	-3.64E-07	-3.83E-07	-3.82E-07	-3.67E-07
Ps90%/90% (-KTL) Un-Biased	-3.75E-07	-3.78E-07	-3.88E-07	-3.95E-07	-4.13E-07	-4.12E-07	-3.96E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

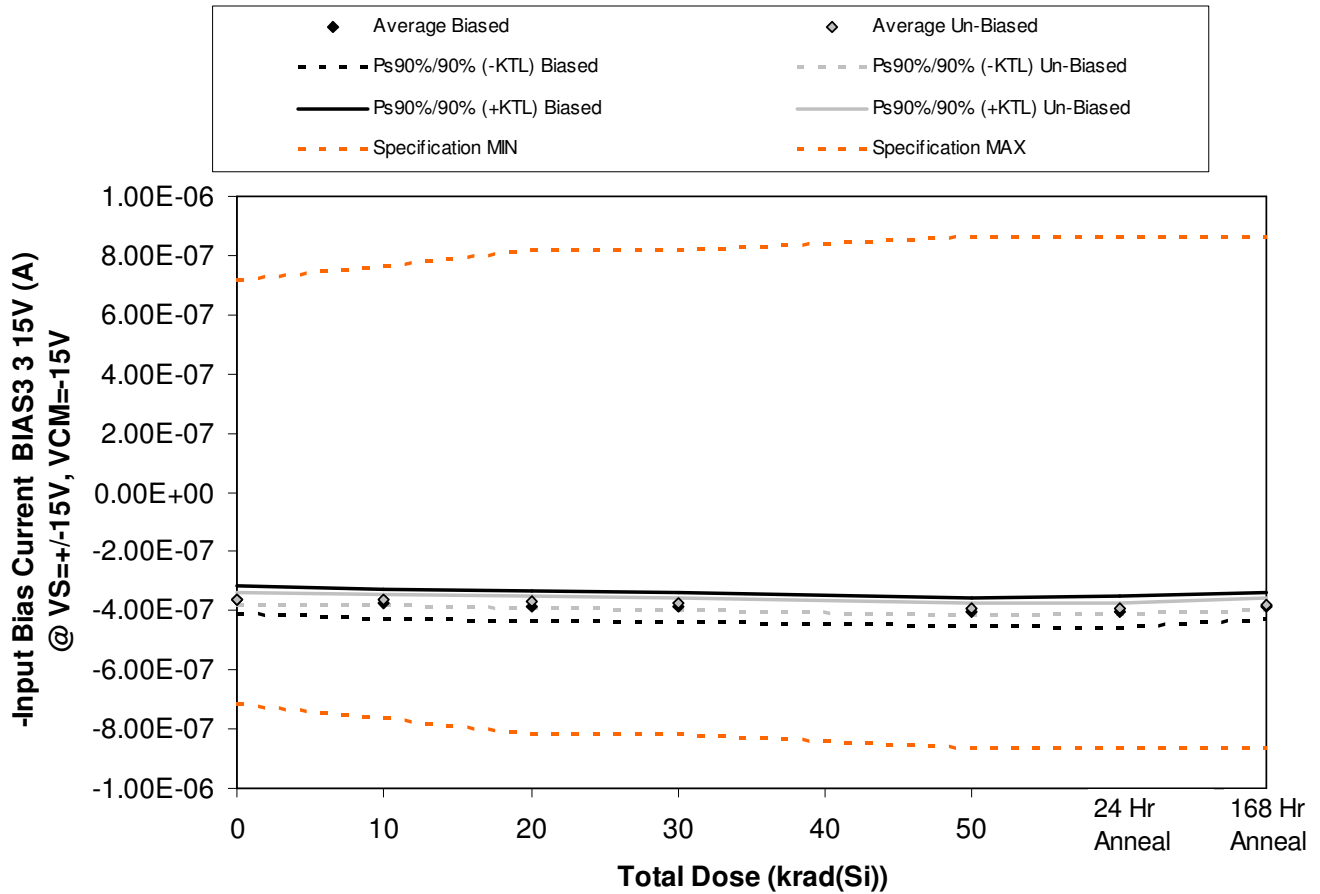


Figure 5.49. Plot of -Input Bias Current BIAS3 3 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.49. Raw data for -Input Bias Current BIAS3 3 15V (A) @ VS=+/-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS3 3 15V (A) @ VS=+/-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.38E-07	-3.50E-07	-3.56E-07	-3.62E-07	-3.77E-07	-3.76E-07	-3.63E-07
563	-3.80E-07	-3.94E-07	-4.00E-07	-4.04E-07	-4.17E-07	-4.20E-07	-4.00E-07
564	-3.71E-07	-3.86E-07	-3.93E-07	-3.98E-07	-4.12E-07	-4.14E-07	-3.94E-07
567	-3.73E-07	-3.85E-07	-3.97E-07	-3.99E-07	-4.13E-07	-4.15E-07	-3.96E-07
569	-3.51E-07	-3.65E-07	-3.73E-07	-3.77E-07	-3.90E-07	-3.90E-07	-3.76E-07
570	-3.71E-07	-3.75E-07	-3.81E-07	-3.90E-07	-4.06E-07	-4.04E-07	-3.91E-07
571	-3.62E-07	-3.65E-07	-3.72E-07	-3.79E-07	-3.96E-07	-3.94E-07	-3.80E-07
572	-3.58E-07	-3.62E-07	-3.69E-07	-3.74E-07	-3.92E-07	-3.92E-07	-3.78E-07
573	-3.54E-07	-3.57E-07	-3.61E-07	-3.68E-07	-3.86E-07	-3.84E-07	-3.70E-07
574	-3.58E-07	-3.61E-07	-3.68E-07	-3.75E-07	-3.94E-07	-3.94E-07	-3.79E-07
584	-3.69E-07	-3.67E-07	-3.67E-07	-3.67E-07	-3.72E-07	-3.73E-07	-3.72E-07
585	-3.71E-07	-3.71E-07	-3.68E-07	-3.70E-07	-3.68E-07	-3.71E-07	-3.72E-07
<b>Biased Statistics</b>							
Average Biased	-3.63E-07	-3.76E-07	-3.84E-07	-3.88E-07	-4.02E-07	-4.03E-07	-3.86E-07
Std Dev Biased	1.76E-08	1.79E-08	1.89E-08	1.79E-08	1.72E-08	1.88E-08	1.59E-08
Ps90%/90% (+KTL) Biased	-3.14E-07	-3.27E-07	-3.32E-07	-3.39E-07	-3.55E-07	-3.51E-07	-3.42E-07
Ps90%/90% (-KTL) Biased	-4.11E-07	-4.25E-07	-4.36E-07	-4.37E-07	-4.49E-07	-4.54E-07	-4.30E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.60E-07	-3.64E-07	-3.70E-07	-3.77E-07	-3.95E-07	-3.94E-07	-3.80E-07
Std Dev Un-Biased	6.75E-09	6.96E-09	7.17E-09	7.83E-09	7.47E-09	6.96E-09	7.35E-09
Ps90%/90% (+KTL) Un-Biased	-3.42E-07	-3.45E-07	-3.51E-07	-3.56E-07	-3.74E-07	-3.75E-07	-3.59E-07
Ps90%/90% (-KTL) Un-Biased	-3.79E-07	-3.83E-07	-3.90E-07	-3.99E-07	-4.15E-07	-4.13E-07	-4.00E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

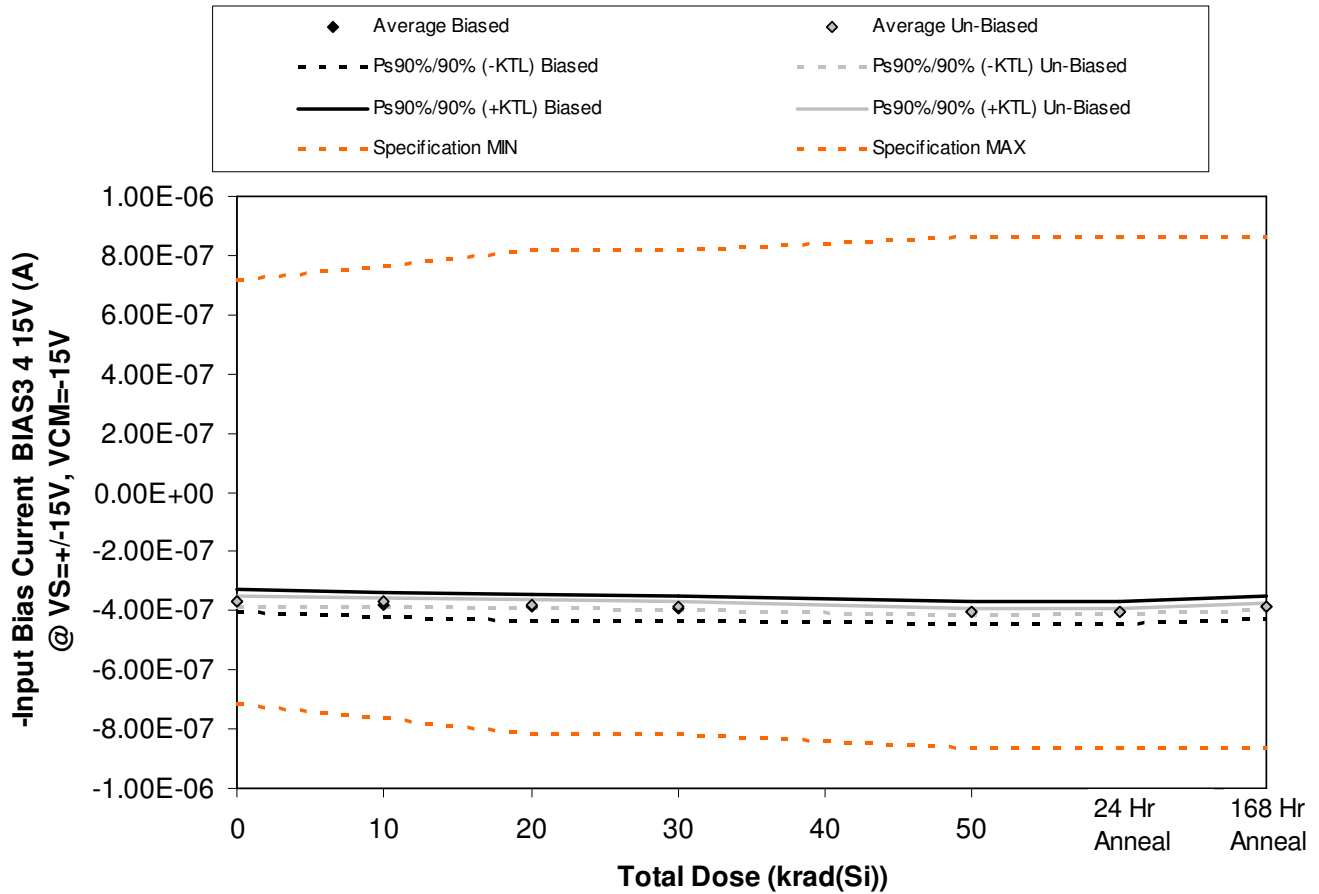


Figure 5.50. Plot of -Input Bias Current BIAS3 4 15V (A) @ VS=+/-15V, VCM=-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.50. Raw data for -Input Bias Current BIAS3 4 15V (A) @ VS=+-15V, VCM=-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS3 4 15V (A) @ VS=+-15V, VCM=-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.48E-07	-3.57E-07	-3.62E-07	-3.70E-07	-3.88E-07	-3.86E-07	-3.70E-07
563	-3.61E-07	-3.72E-07	-3.81E-07	-3.86E-07	-4.00E-07	-4.00E-07	-3.82E-07
564	-3.74E-07	-3.87E-07	-3.94E-07	-3.98E-07	-4.12E-07	-4.12E-07	-3.96E-07
567	-3.85E-07	-3.96E-07	-4.05E-07	-4.09E-07	-4.25E-07	-4.25E-07	-4.05E-07
569	-3.68E-07	-3.81E-07	-3.92E-07	-3.95E-07	-4.11E-07	-4.09E-07	-3.91E-07
570	-3.73E-07	-3.74E-07	-3.84E-07	-3.90E-07	-4.06E-07	-4.04E-07	-3.90E-07
571	-3.63E-07	-3.66E-07	-3.76E-07	-3.82E-07	-4.01E-07	-4.01E-07	-3.82E-07
572	-3.63E-07	-3.67E-07	-3.73E-07	-3.81E-07	-4.00E-07	-3.99E-07	-3.84E-07
573	-3.75E-07	-3.78E-07	-3.85E-07	-3.91E-07	-4.09E-07	-4.07E-07	-3.93E-07
574	-3.66E-07	-3.69E-07	-3.75E-07	-3.82E-07	-3.99E-07	-4.00E-07	-3.84E-07
584	-3.34E-07	-3.32E-07	-3.33E-07	-3.32E-07	-3.35E-07	-3.36E-07	-3.35E-07
585	-3.51E-07	-3.50E-07	-3.46E-07	-3.49E-07	-3.47E-07	-3.50E-07	-3.52E-07
<b>Biased Statistics</b>							
Average Biased	-3.67E-07	-3.79E-07	-3.87E-07	-3.92E-07	-4.07E-07	-4.06E-07	-3.89E-07
Std Dev Biased	1.38E-08	1.47E-08	1.62E-08	1.46E-08	1.39E-08	1.48E-08	1.32E-08
Ps90%/90% (+KTL) Biased	-3.29E-07	-3.38E-07	-3.43E-07	-3.52E-07	-3.69E-07	-3.66E-07	-3.53E-07
Ps90%/90% (-KTL) Biased	-4.05E-07	-4.19E-07	-4.31E-07	-4.32E-07	-4.45E-07	-4.47E-07	-4.25E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.68E-07	-3.71E-07	-3.79E-07	-3.85E-07	-4.03E-07	-4.02E-07	-3.87E-07
Std Dev Un-Biased	5.86E-09	4.90E-09	5.32E-09	5.01E-09	4.12E-09	3.37E-09	4.78E-09
Ps90%/90% (+KTL) Un-Biased	-3.52E-07	-3.57E-07	-3.64E-07	-3.71E-07	-3.92E-07	-3.93E-07	-3.74E-07
Ps90%/90% (-KTL) Un-Biased	-3.84E-07	-3.84E-07	-3.93E-07	-3.99E-07	-4.14E-07	-4.11E-07	-4.00E-07
<b>Specification MIN</b>	<b>-7.15E-07</b>	<b>-7.65E-07</b>	<b>-8.15E-07</b>	<b>-8.15E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>	<b>-8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>7.15E-07</b>	<b>7.65E-07</b>	<b>8.15E-07</b>	<b>8.15E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>	<b>8.65E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



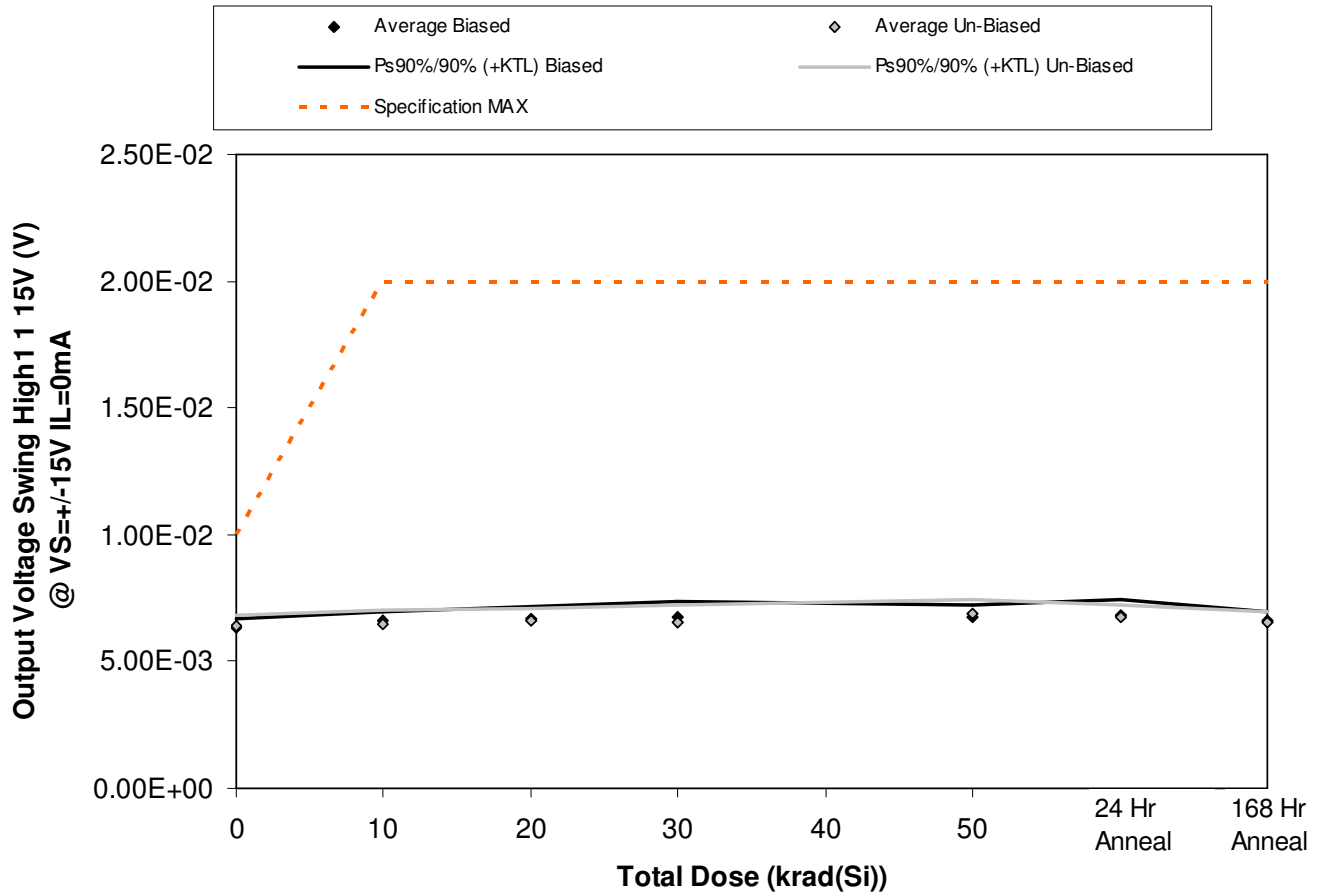


Figure 5.51. Plot of Output Voltage Swing High1 1 15V (V) @ VS=+-15V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.51. Raw data for Output Voltage Swing High1 1 15V (V) @ VS=+/-15V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High1 1 15V (V) @ VS=+/-15V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.22E-03	6.53E-03	6.42E-03	6.60E-03	6.56E-03	6.37E-03	6.50E-03
563	6.24E-03	6.71E-03	6.84E-03	6.62E-03	6.79E-03	6.87E-03	6.67E-03
564	6.44E-03	6.45E-03	6.77E-03	7.10E-03	6.86E-03	6.87E-03	6.70E-03
567	6.41E-03	6.77E-03	6.77E-03	6.87E-03	7.00E-03	7.01E-03	6.77E-03
569	6.51E-03	6.46E-03	6.72E-03	6.51E-03	6.69E-03	6.80E-03	6.47E-03
570	6.27E-03	6.53E-03	6.55E-03	6.72E-03	7.10E-03	6.75E-03	6.69E-03
571	6.30E-03	6.41E-03	6.66E-03	6.41E-03	7.01E-03	6.67E-03	6.54E-03
572	6.51E-03	6.60E-03	6.60E-03	6.53E-03	6.83E-03	6.75E-03	6.62E-03
573	6.63E-03	6.71E-03	6.89E-03	6.87E-03	6.90E-03	7.01E-03	6.59E-03
574	6.29E-03	6.21E-03	6.49E-03	6.30E-03	6.54E-03	6.53E-03	6.32E-03
584	6.15E-03	6.41E-03	6.47E-03	6.21E-03	6.34E-03	6.40E-03	6.27E-03
585	6.14E-03	6.39E-03	6.40E-03	6.50E-03	6.85E-03	6.40E-03	6.27E-03
<b>Biased Statistics</b>							
Average Biased	6.36E-03	6.58E-03	6.70E-03	6.74E-03	6.78E-03	6.78E-03	6.62E-03
Std Dev Biased	1.28E-04	1.47E-04	1.64E-04	2.42E-04	1.67E-04	2.44E-04	1.31E-04
Ps90%/90% (+KTL) Biased	6.71E-03	6.99E-03	7.15E-03	7.40E-03	7.24E-03	7.45E-03	6.98E-03
Ps90%/90% (-KTL) Biased	6.01E-03	6.18E-03	6.25E-03	6.08E-03	6.32E-03	6.12E-03	6.26E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.40E-03	6.49E-03	6.64E-03	6.57E-03	6.88E-03	6.74E-03	6.55E-03
Std Dev Un-Biased	1.61E-04	1.92E-04	1.54E-04	2.30E-04	2.14E-04	1.75E-04	1.41E-04
Ps90%/90% (+KTL) Un-Biased	6.84E-03	7.02E-03	7.06E-03	7.20E-03	7.46E-03	7.22E-03	6.94E-03
Ps90%/90% (-KTL) Un-Biased	5.96E-03	5.97E-03	6.22E-03	5.93E-03	6.29E-03	6.26E-03	6.17E-03
<b>Specification MAX</b>	<b>1.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

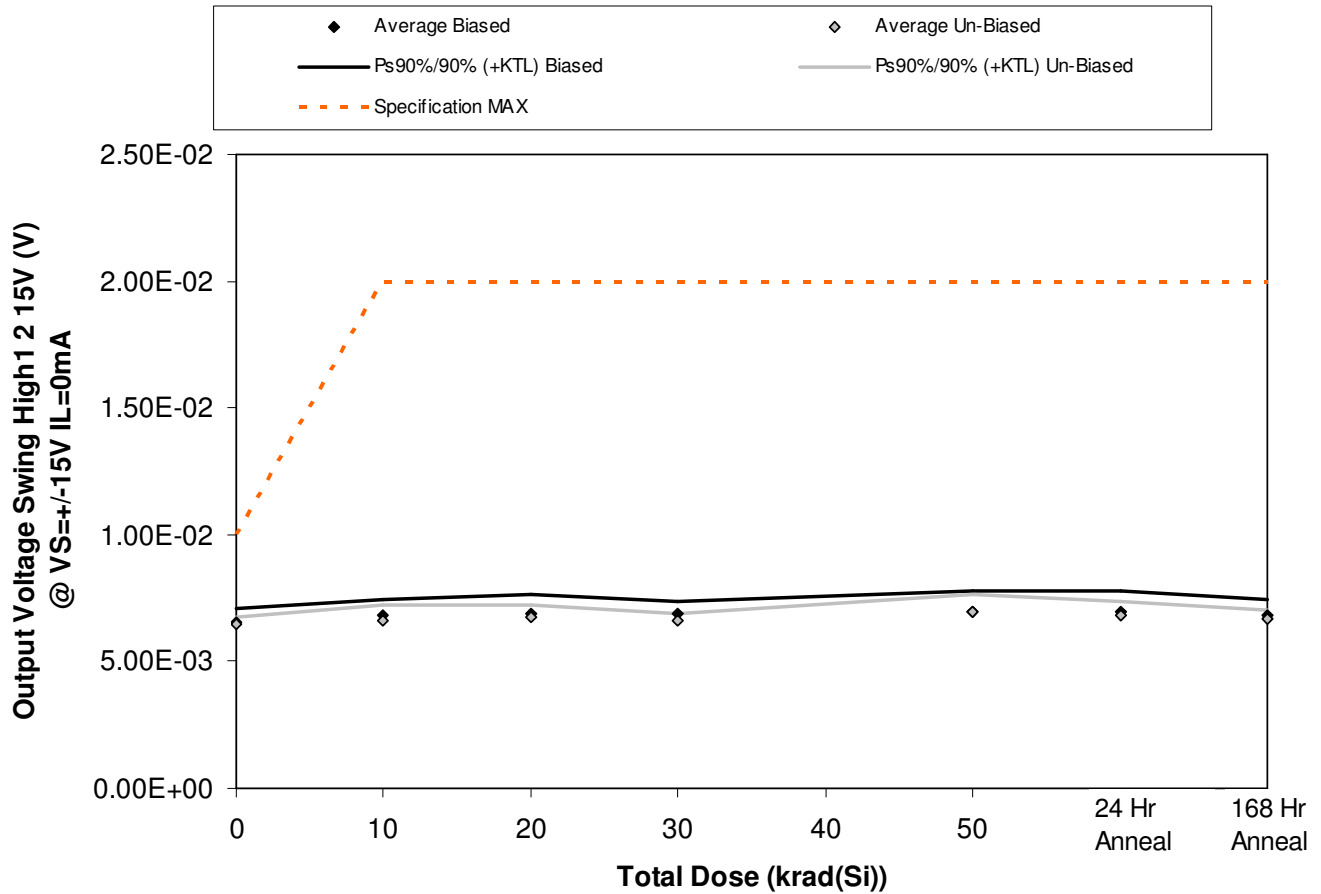


Figure 5.52. Plot of Output Voltage Swing High1 2 15V (V) @ VS=+-15V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.52. Raw data for Output Voltage Swing High1 2 15V (V) @ VS=+/-15V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High1 2 15V (V) @ VS=+/-15V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.19E-03	6.48E-03	6.55E-03	6.70E-03	6.47E-03	6.42E-03	6.50E-03
563	6.68E-03	7.02E-03	7.16E-03	6.88E-03	7.20E-03	7.12E-03	7.09E-03
564	6.73E-03	6.78E-03	7.14E-03	7.19E-03	7.01E-03	7.12E-03	6.87E-03
567	6.52E-03	7.03E-03	6.98E-03	6.90E-03	7.13E-03	7.14E-03	6.87E-03
569	6.44E-03	6.65E-03	6.74E-03	6.78E-03	7.00E-03	6.85E-03	6.64E-03
570	6.52E-03	6.80E-03	6.81E-03	6.62E-03	7.15E-03	6.87E-03	6.72E-03
571	6.49E-03	6.45E-03	6.64E-03	6.50E-03	7.11E-03	6.77E-03	6.57E-03
572	6.51E-03	6.56E-03	6.62E-03	6.60E-03	6.85E-03	6.69E-03	6.65E-03
573	6.64E-03	6.87E-03	7.03E-03	6.73E-03	7.13E-03	7.11E-03	6.87E-03
574	6.37E-03	6.38E-03	6.74E-03	6.46E-03	6.61E-03	6.57E-03	6.54E-03
584	6.69E-03	6.95E-03	6.86E-03	6.65E-03	6.90E-03	6.70E-03	6.67E-03
585	6.59E-03	6.85E-03	6.87E-03	6.82E-03	7.08E-03	6.79E-03	6.62E-03
<b>Biased Statistics</b>							
Average Biased	6.51E-03	6.79E-03	6.91E-03	6.89E-03	6.96E-03	6.93E-03	6.79E-03
Std Dev Biased	2.15E-04	2.38E-04	2.64E-04	1.86E-04	2.88E-04	3.09E-04	2.29E-04
Ps90%/90% (+KTL) Biased	7.10E-03	7.44E-03	7.64E-03	7.40E-03	7.75E-03	7.78E-03	7.42E-03
Ps90%/90% (-KTL) Biased	5.92E-03	6.14E-03	6.19E-03	6.38E-03	6.17E-03	6.08E-03	6.17E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.51E-03	6.61E-03	6.77E-03	6.58E-03	6.97E-03	6.80E-03	6.67E-03
Std Dev Un-Biased	9.61E-05	2.15E-04	1.65E-04	1.06E-04	2.35E-04	2.04E-04	1.32E-04
Ps90%/90% (+KTL) Un-Biased	6.77E-03	7.20E-03	7.22E-03	6.87E-03	7.62E-03	7.36E-03	7.03E-03
Ps90%/90% (-KTL) Un-Biased	6.24E-03	6.02E-03	6.31E-03	6.29E-03	6.32E-03	6.24E-03	6.31E-03
<b>Specification MAX</b>	<b>1.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

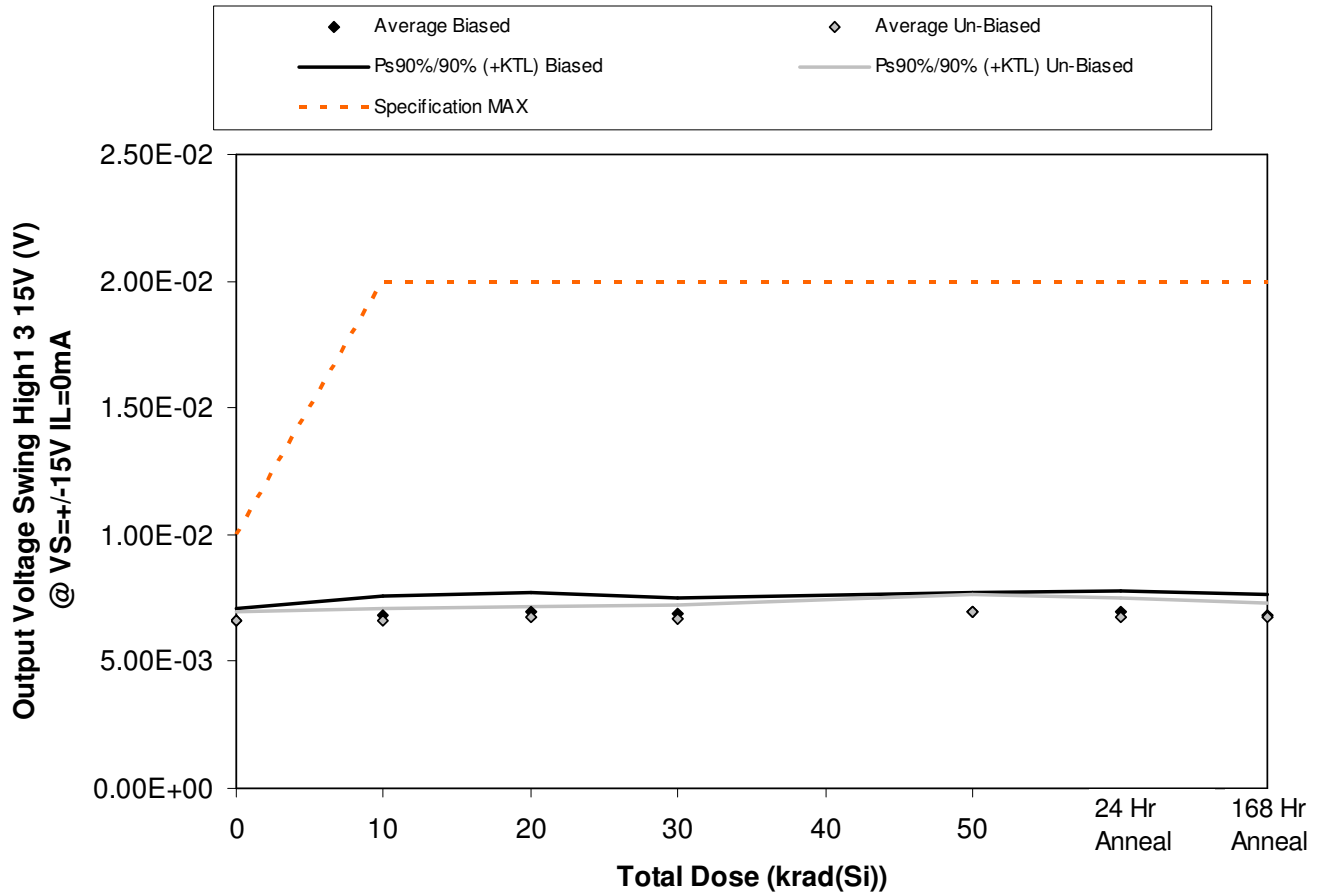


Figure 5.53. Plot of Output Voltage Swing High1 3 15V (V) @ VS=+-15V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.53. Raw data for Output Voltage Swing High1 3 15V (V) @ VS=+/-15V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High1 3 15V (V) @ VS=+/-15V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.32E-03	6.43E-03	6.44E-03	6.65E-03	6.54E-03	6.55E-03	6.43E-03
563	6.64E-03	7.22E-03	7.19E-03	6.97E-03	7.23E-03	7.33E-03	7.14E-03
564	6.78E-03	6.85E-03	7.03E-03	7.22E-03	7.05E-03	7.04E-03	6.99E-03
567	6.71E-03	6.83E-03	7.09E-03	6.82E-03	7.13E-03	7.06E-03	6.94E-03
569	6.56E-03	6.75E-03	6.86E-03	6.75E-03	6.91E-03	6.85E-03	6.64E-03
570	6.78E-03	6.75E-03	6.66E-03	6.77E-03	7.11E-03	6.85E-03	6.99E-03
571	6.52E-03	6.50E-03	6.55E-03	6.60E-03	7.10E-03	6.67E-03	6.67E-03
572	6.54E-03	6.61E-03	6.69E-03	6.62E-03	6.85E-03	6.69E-03	6.55E-03
573	6.66E-03	6.87E-03	7.01E-03	7.00E-03	7.13E-03	7.21E-03	6.87E-03
574	6.49E-03	6.48E-03	6.71E-03	6.48E-03	6.56E-03	6.48E-03	6.50E-03
584	6.74E-03	6.85E-03	7.01E-03	6.67E-03	6.83E-03	6.75E-03	6.79E-03
585	6.84E-03	6.97E-03	6.81E-03	6.85E-03	7.15E-03	6.69E-03	6.74E-03
<b>Biased Statistics</b>							
Average Biased	6.60E-03	6.82E-03	6.92E-03	6.88E-03	6.97E-03	6.97E-03	6.83E-03
Std Dev Biased	1.78E-04	2.82E-04	2.95E-04	2.22E-04	2.68E-04	2.89E-04	2.87E-04
Ps90%/90% (+KTL) Biased	7.09E-03	7.59E-03	7.73E-03	7.49E-03	7.71E-03	7.76E-03	7.62E-03
Ps90%/90% (-KTL) Biased	6.12E-03	6.04E-03	6.11E-03	6.27E-03	6.24E-03	6.17E-03	6.04E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.60E-03	6.64E-03	6.72E-03	6.69E-03	6.95E-03	6.78E-03	6.72E-03
Std Dev Un-Biased	1.20E-04	1.67E-04	1.71E-04	2.00E-04	2.46E-04	2.74E-04	2.09E-04
Ps90%/90% (+KTL) Un-Biased	6.93E-03	7.10E-03	7.19E-03	7.24E-03	7.63E-03	7.53E-03	7.29E-03
Ps90%/90% (-KTL) Un-Biased	6.27E-03	6.19E-03	6.25E-03	6.15E-03	6.27E-03	6.03E-03	6.14E-03
<b>Specification MAX</b>	<b>1.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

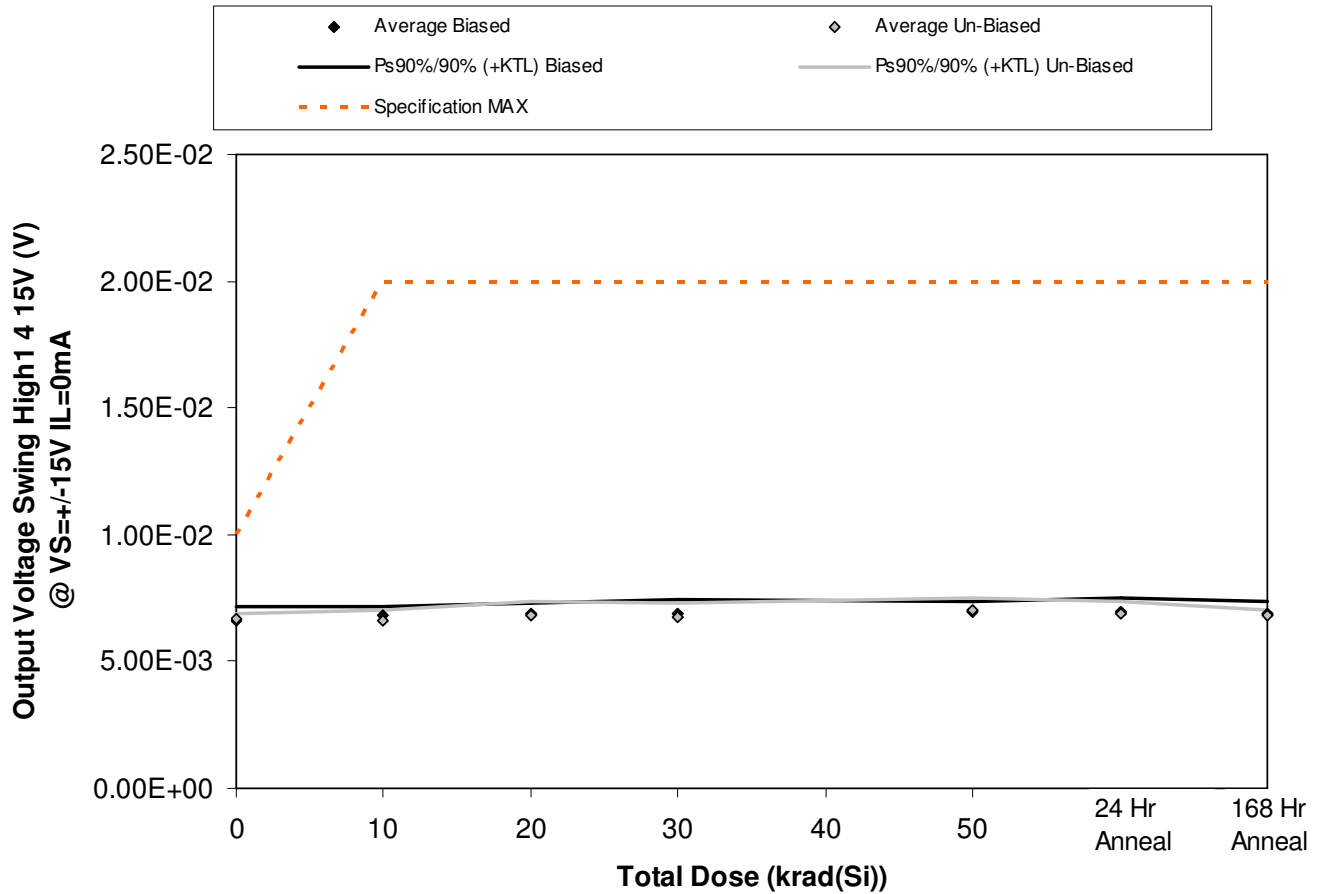


Figure 5.54. Plot of Output Voltage Swing High1 4 15V (V) @ VS=+-15V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.54. Raw data for Output Voltage Swing High1 4 15V (V) @ VS=+/-15V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High1 4 15V (V) @ VS=+/-15V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.31E-03	6.65E-03	6.72E-03	6.75E-03	6.73E-03	6.58E-03	6.62E-03
563	6.64E-03	6.92E-03	6.91E-03	6.63E-03	6.95E-03	7.01E-03	7.01E-03
564	6.78E-03	6.85E-03	7.06E-03	7.17E-03	7.17E-03	7.14E-03	7.06E-03
567	6.83E-03	6.92E-03	7.06E-03	7.00E-03	6.93E-03	7.06E-03	6.86E-03
569	6.56E-03	6.73E-03	6.79E-03	6.77E-03	7.01E-03	6.85E-03	6.77E-03
570	6.66E-03	6.63E-03	6.84E-03	6.65E-03	7.17E-03	6.79E-03	6.92E-03
571	6.61E-03	6.48E-03	6.52E-03	6.58E-03	7.08E-03	6.80E-03	6.75E-03
572	6.59E-03	6.75E-03	6.84E-03	6.94E-03	7.03E-03	6.79E-03	6.81E-03
573	6.81E-03	6.80E-03	7.06E-03	6.99E-03	7.15E-03	7.19E-03	6.84E-03
574	6.63E-03	6.53E-03	6.69E-03	6.65E-03	6.71E-03	6.72E-03	6.67E-03
584	6.56E-03	6.65E-03	6.60E-03	6.51E-03	6.56E-03	6.48E-03	6.35E-03
585	6.46E-03	6.53E-03	6.47E-03	6.50E-03	6.80E-03	6.67E-03	6.40E-03
<b>Biased Statistics</b>							
Average Biased	6.62E-03	6.81E-03	6.91E-03	6.86E-03	6.96E-03	6.93E-03	6.86E-03
Std Dev Biased	2.06E-04	1.20E-04	1.54E-04	2.17E-04	1.58E-04	2.22E-04	1.79E-04
Ps90%/90% (+KTL) Biased	7.19E-03	7.14E-03	7.33E-03	7.46E-03	7.39E-03	7.54E-03	7.35E-03
Ps90%/90% (-KTL) Biased	6.06E-03	6.48E-03	6.48E-03	6.27E-03	6.52E-03	6.32E-03	6.37E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.66E-03	6.64E-03	6.79E-03	6.76E-03	7.03E-03	6.86E-03	6.80E-03
Std Dev Un-Biased	8.77E-05	1.37E-04	2.00E-04	1.88E-04	1.86E-04	1.88E-04	9.42E-05
Ps90%/90% (+KTL) Un-Biased	6.90E-03	7.01E-03	7.34E-03	7.28E-03	7.54E-03	7.37E-03	7.06E-03
Ps90%/90% (-KTL) Un-Biased	6.42E-03	6.26E-03	6.24E-03	6.25E-03	6.52E-03	6.34E-03	6.54E-03
<b>Specification MAX</b>	<b>1.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



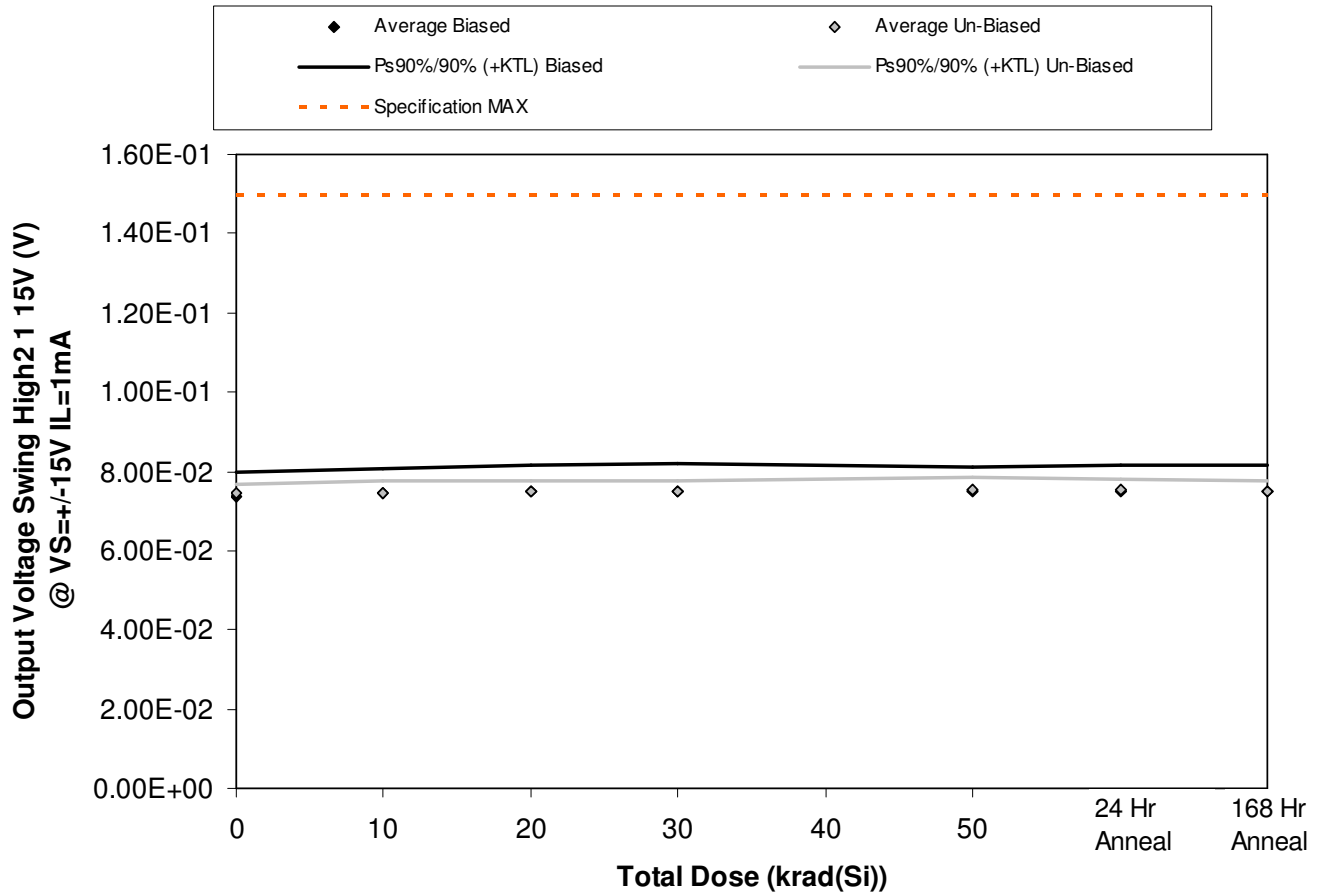


Figure 5.55. Plot of Output Voltage Swing High2 1 15V (V) @ VS=+-15V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.55. Raw data for Output Voltage Swing High2 1 15V (V) @ VS=+/-15V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High2 1 15V (V) @ VS=+/-15V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	7.01E-02	7.05E-02	7.07E-02	7.11E-02	7.12E-02	7.10E-02	7.10E-02
563	7.44E-02	7.51E-02	7.54E-02	7.54E-02	7.54E-02	7.57E-02	7.56E-02
564	7.55E-02	7.61E-02	7.66E-02	7.73E-02	7.69E-02	7.70E-02	7.68E-02
567	7.54E-02	7.61E-02	7.66E-02	7.69E-02	7.67E-02	7.68E-02	7.65E-02
569	7.37E-02	7.45E-02	7.49E-02	7.50E-02	7.50E-02	7.49E-02	7.48E-02
570	7.47E-02	7.47E-02	7.51E-02	7.53E-02	7.59E-02	7.55E-02	7.52E-02
571	7.41E-02	7.41E-02	7.45E-02	7.48E-02	7.57E-02	7.50E-02	7.49E-02
572	7.42E-02	7.44E-02	7.51E-02	7.52E-02	7.56E-02	7.50E-02	7.51E-02
573	7.55E-02	7.60E-02	7.62E-02	7.63E-02	7.66E-02	7.67E-02	7.61E-02
574	7.32E-02	7.30E-02	7.37E-02	7.38E-02	7.39E-02	7.38E-02	7.37E-02
584	7.10E-02	7.14E-02	7.13E-02	7.10E-02	7.09E-02	7.07E-02	7.07E-02
585	7.09E-02	7.08E-02	7.15E-02	7.10E-02	7.11E-02	7.04E-02	7.07E-02
<b>Biased Statistics</b>							
Average Biased	7.38E-02	7.44E-02	7.48E-02	7.51E-02	7.51E-02	7.51E-02	7.50E-02
Std Dev Biased	2.21E-03	2.29E-03	2.45E-03	2.45E-03	2.27E-03	2.44E-03	2.32E-03
Ps90%/90% (+KTL) Biased	7.99E-02	8.07E-02	8.16E-02	8.18E-02	8.13E-02	8.17E-02	8.13E-02
Ps90%/90% (-KTL) Biased	6.77E-02	6.82E-02	6.81E-02	6.84E-02	6.88E-02	6.84E-02	6.86E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.43E-02	7.44E-02	7.49E-02	7.51E-02	7.56E-02	7.52E-02	7.50E-02
Std Dev Un-Biased	8.47E-04	1.07E-03	9.26E-04	9.21E-04	1.01E-03	1.03E-03	8.78E-04
Ps90%/90% (+KTL) Un-Biased	7.67E-02	7.74E-02	7.75E-02	7.76E-02	7.83E-02	7.80E-02	7.74E-02
Ps90%/90% (-KTL) Un-Biased	7.20E-02	7.15E-02	7.24E-02	7.26E-02	7.28E-02	7.23E-02	7.26E-02
<b>Specification MAX</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

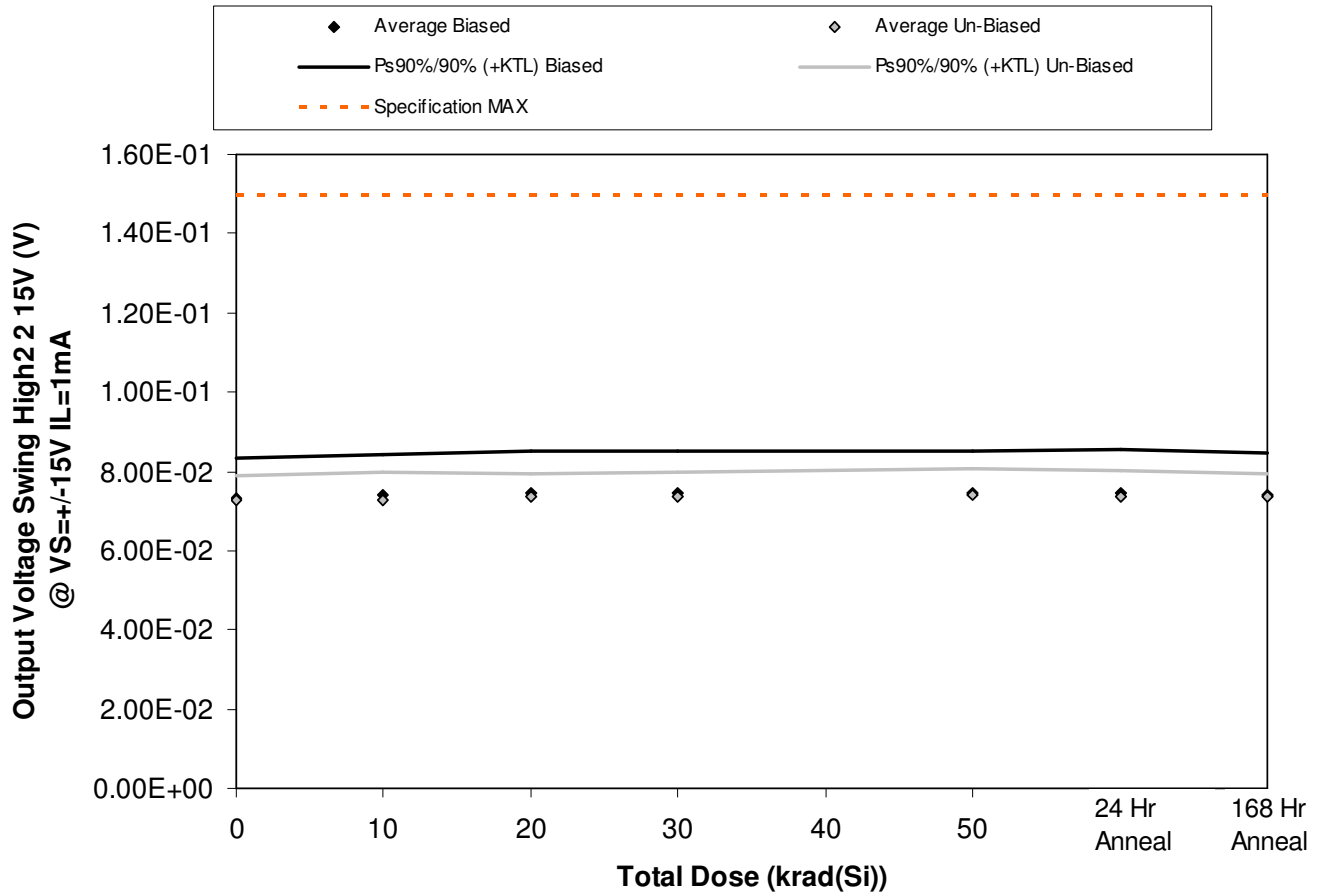


Figure 5.56. Plot of Output Voltage Swing High 2 2 15V (V) @ VS=+-15V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.56. Raw data for Output Voltage Swing High2 2 15V (V) @ VS=+/-15V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High2 2 15V (V) @ VS=+/-15V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.71E-02	6.76E-02	6.79E-02	6.82E-02	6.84E-02	6.79E-02	6.80E-02
563	7.57E-02	7.62E-02	7.66E-02	7.68E-02	7.68E-02	7.68E-02	7.67E-02
564	7.51E-02	7.57E-02	7.64E-02	7.70E-02	7.68E-02	7.67E-02	7.64E-02
567	7.58E-02	7.67E-02	7.71E-02	7.71E-02	7.73E-02	7.73E-02	7.68E-02
569	7.26E-02	7.33E-02	7.38E-02	7.39E-02	7.39E-02	7.39E-02	7.34E-02
570	7.45E-02	7.46E-02	7.49E-02	7.51E-02	7.57E-02	7.54E-02	7.51E-02
571	7.31E-02	7.29E-02	7.33E-02	7.38E-02	7.45E-02	7.37E-02	7.35E-02
572	7.11E-02	7.09E-02	7.16E-02	7.18E-02	7.20E-02	7.18E-02	7.15E-02
573	7.55E-02	7.60E-02	7.63E-02	7.64E-02	7.69E-02	7.66E-02	7.60E-02
574	7.03E-02	7.03E-02	7.12E-02	7.11E-02	7.14E-02	7.11E-02	7.12E-02
584	7.44E-02	7.49E-02	7.49E-02	7.47E-02	7.43E-02	7.40E-02	7.40E-02
585	7.47E-02	7.46E-02	7.50E-02	7.49E-02	7.51E-02	7.40E-02	7.44E-02
<b>Biased Statistics</b>							
Average Biased	7.33E-02	7.39E-02	7.44E-02	7.46E-02	7.46E-02	7.45E-02	7.43E-02
Std Dev Biased	3.68E-03	3.76E-03	3.86E-03	3.80E-03	3.73E-03	3.94E-03	3.75E-03
Ps90%/90% (+KTL) Biased	8.34E-02	8.42E-02	8.49E-02	8.50E-02	8.49E-02	8.53E-02	8.45E-02
Ps90%/90% (-KTL) Biased	6.32E-02	6.36E-02	6.38E-02	6.42E-02	6.44E-02	6.37E-02	6.40E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.29E-02	7.29E-02	7.35E-02	7.36E-02	7.41E-02	7.37E-02	7.35E-02
Std Dev Un-Biased	2.20E-03	2.42E-03	2.16E-03	2.21E-03	2.35E-03	2.35E-03	2.12E-03
Ps90%/90% (+KTL) Un-Biased	7.89E-02	7.96E-02	7.94E-02	7.97E-02	8.05E-02	8.02E-02	7.93E-02
Ps90%/90% (-KTL) Un-Biased	6.69E-02	6.63E-02	6.75E-02	6.76E-02	6.77E-02	6.73E-02	6.76E-02
<b>Specification MAX</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

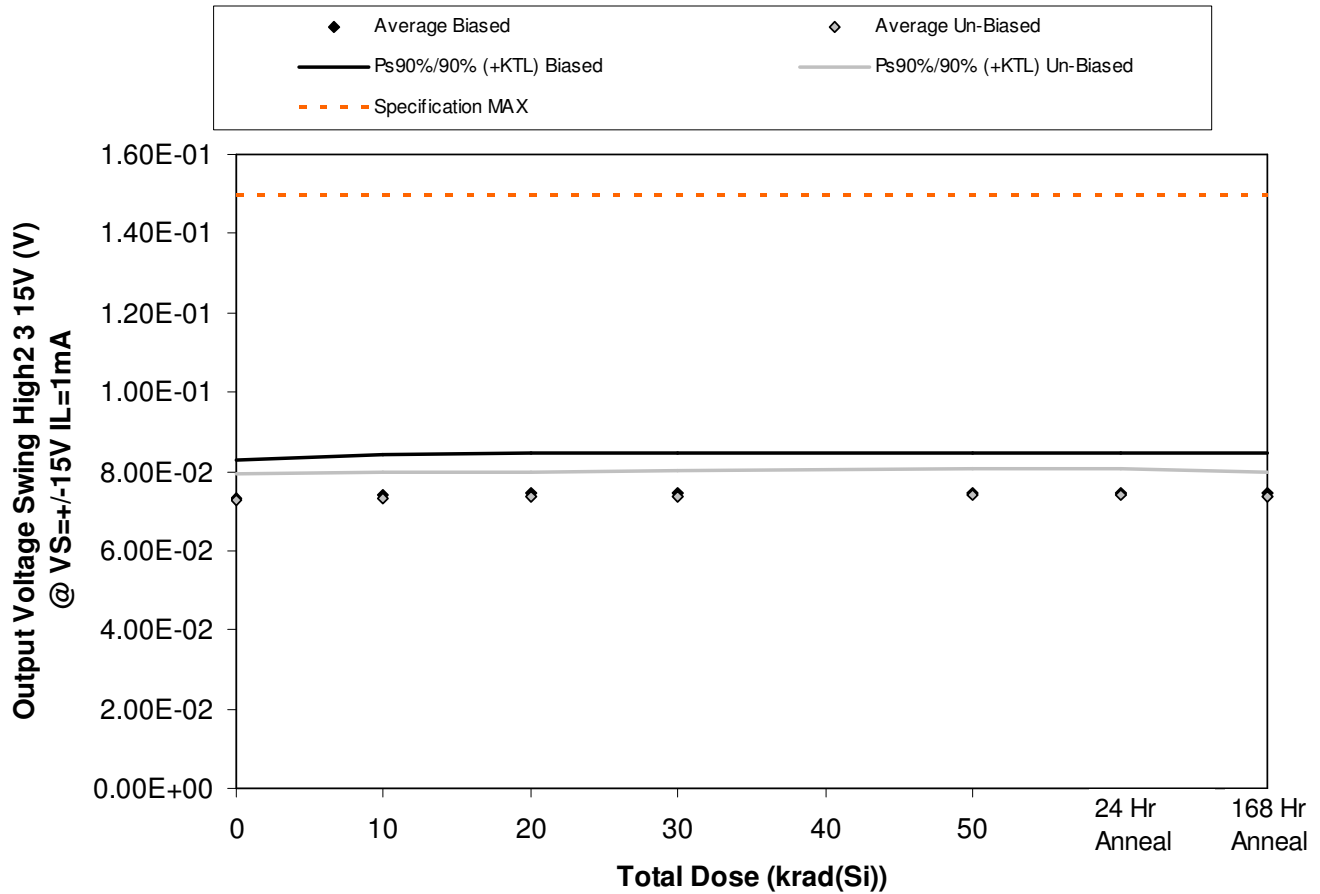


Figure 5.57. Plot of Output Voltage Swing High2 3 15V (V) @ VS=+-15V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.57. Raw data for Output Voltage Swing High2 3 15V (V) @ VS=+/-15V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High2 3 15V (V) @ VS=+/-15V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.76E-02	6.79E-02	6.81E-02	6.86E-02	6.85E-02	6.84E-02	6.83E-02
563	7.60E-02	7.67E-02	7.69E-02	7.71E-02	7.73E-02	7.73E-02	7.72E-02
564	7.49E-02	7.56E-02	7.62E-02	7.67E-02	7.64E-02	7.64E-02	7.62E-02
567	7.56E-02	7.64E-02	7.69E-02	7.72E-02	7.72E-02	7.70E-02	7.68E-02
569	7.25E-02	7.33E-02	7.36E-02	7.38E-02	7.40E-02	7.39E-02	7.35E-02
570	7.47E-02	7.48E-02	7.47E-02	7.56E-02	7.57E-02	7.56E-02	7.54E-02
571	7.27E-02	7.28E-02	7.32E-02	7.35E-02	7.43E-02	7.37E-02	7.36E-02
572	7.11E-02	7.11E-02	7.18E-02	7.19E-02	7.21E-02	7.18E-02	7.17E-02
573	7.58E-02	7.60E-02	7.65E-02	7.66E-02	7.71E-02	7.69E-02	7.62E-02
574	7.03E-02	7.01E-02	7.08E-02	7.11E-02	7.11E-02	7.13E-02	7.08E-02
584	7.48E-02	7.52E-02	7.47E-02	7.50E-02	7.46E-02	7.43E-02	7.43E-02
585	7.44E-02	7.45E-02	7.49E-02	7.48E-02	7.47E-02	7.39E-02	7.43E-02
<b>Biased Statistics</b>							
Average Biased	7.33E-02	7.40E-02	7.43E-02	7.47E-02	7.47E-02	7.46E-02	7.44E-02
Std Dev Biased	3.46E-03	3.66E-03	3.74E-03	3.68E-03	3.69E-03	3.69E-03	3.68E-03
Ps90%/90% (+KTL) Biased	8.28E-02	8.40E-02	8.46E-02	8.48E-02	8.48E-02	8.47E-02	8.45E-02
Ps90%/90% (-KTL) Biased	6.38E-02	6.39E-02	6.41E-02	6.46E-02	6.45E-02	6.45E-02	6.43E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.29E-02	7.30E-02	7.34E-02	7.38E-02	7.41E-02	7.39E-02	7.35E-02
Std Dev Un-Biased	2.30E-03	2.46E-03	2.28E-03	2.36E-03	2.48E-03	2.42E-03	2.34E-03
Ps90%/90% (+KTL) Un-Biased	7.92E-02	7.97E-02	7.96E-02	8.02E-02	8.08E-02	8.05E-02	8.00E-02
Ps90%/90% (-KTL) Un-Biased	6.66E-02	6.62E-02	6.71E-02	6.73E-02	6.73E-02	6.72E-02	6.71E-02
<b>Specification MAX</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

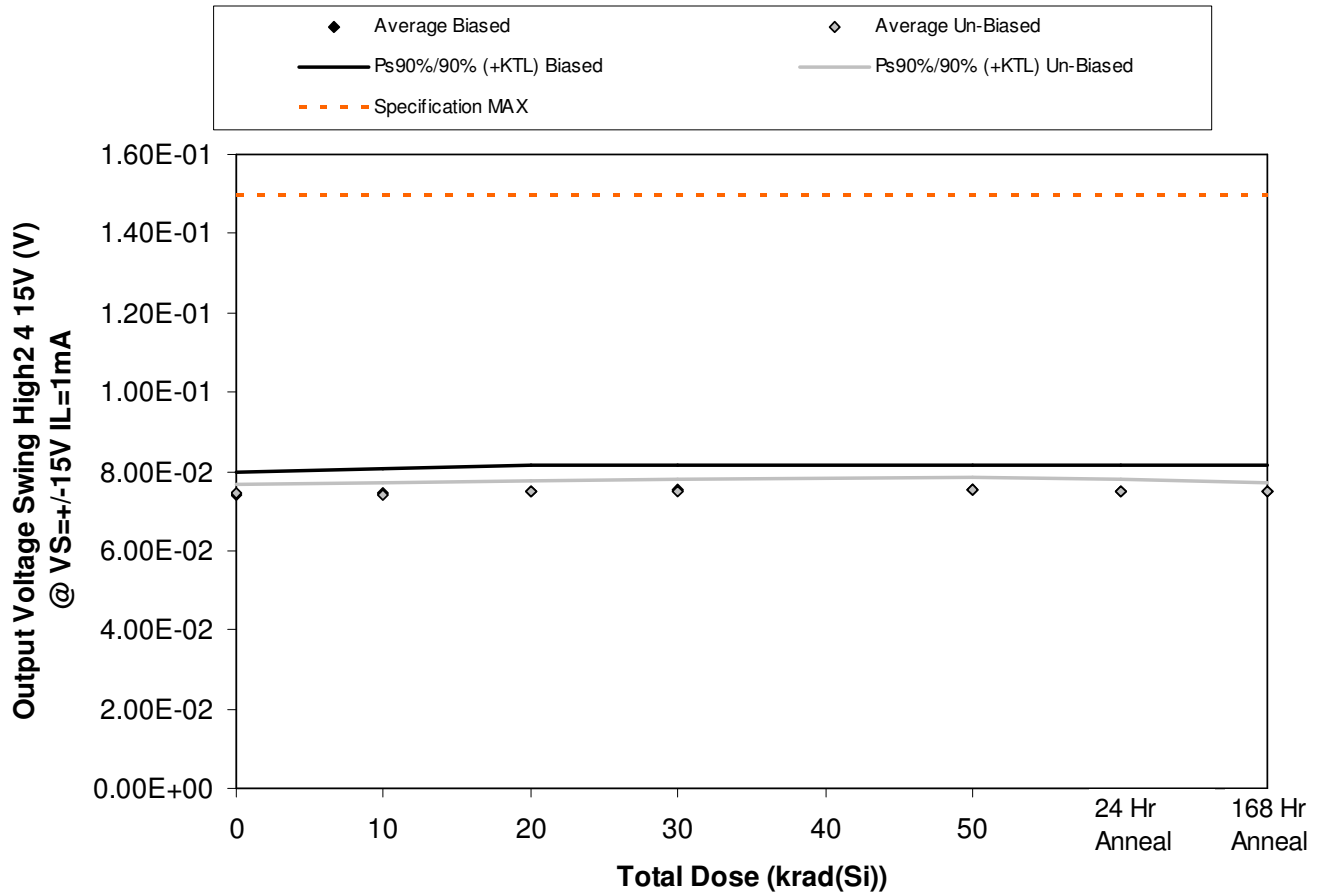


Figure 5.58. Plot of Output Voltage Swing High 2 4 15V (V) @ VS=+-15V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.58. Raw data for Output Voltage Swing High2 4 15V (V) @ VS=+/-15V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High2 4 15V (V) @ VS=+/-15V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	7.02E-02	7.07E-02	7.09E-02	7.13E-02	7.14E-02	7.10E-02	7.10E-02
563	7.43E-02	7.49E-02	7.54E-02	7.55E-02	7.56E-02	7.56E-02	7.54E-02
564	7.55E-02	7.63E-02	7.67E-02	7.74E-02	7.72E-02	7.69E-02	7.70E-02
567	7.54E-02	7.62E-02	7.68E-02	7.68E-02	7.67E-02	7.67E-02	7.65E-02
569	7.39E-02	7.45E-02	7.50E-02	7.50E-02	7.52E-02	7.50E-02	7.47E-02
570	7.45E-02	7.47E-02	7.49E-02	7.52E-02	7.56E-02	7.53E-02	7.51E-02
571	7.42E-02	7.40E-02	7.47E-02	7.50E-02	7.56E-02	7.48E-02	7.47E-02
572	7.43E-02	7.42E-02	7.49E-02	7.51E-02	7.56E-02	7.51E-02	7.48E-02
573	7.54E-02	7.57E-02	7.62E-02	7.64E-02	7.69E-02	7.67E-02	7.59E-02
574	7.30E-02	7.27E-02	7.33E-02	7.35E-02	7.37E-02	7.37E-02	7.34E-02
584	7.11E-02	7.15E-02	7.15E-02	7.13E-02	7.11E-02	7.08E-02	7.09E-02
585	7.10E-02	7.08E-02	7.13E-02	7.09E-02	7.10E-02	7.03E-02	7.06E-02
<b>Biased Statistics</b>							
Average Biased	7.39E-02	7.45E-02	7.50E-02	7.52E-02	7.52E-02	7.50E-02	7.49E-02
Std Dev Biased	2.17E-03	2.27E-03	2.43E-03	2.40E-03	2.30E-03	2.37E-03	2.36E-03
Ps90%/90% (+KTL) Biased	7.98E-02	8.07E-02	8.16E-02	8.17E-02	8.15E-02	8.15E-02	8.14E-02
Ps90%/90% (-KTL) Biased	6.79E-02	6.83E-02	6.83E-02	6.86E-02	6.89E-02	6.85E-02	6.84E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.43E-02	7.43E-02	7.48E-02	7.50E-02	7.55E-02	7.51E-02	7.48E-02
Std Dev Un-Biased	8.40E-04	1.08E-03	1.05E-03	1.02E-03	1.16E-03	1.09E-03	8.94E-04
Ps90%/90% (+KTL) Un-Biased	7.66E-02	7.72E-02	7.77E-02	7.78E-02	7.87E-02	7.81E-02	7.72E-02
Ps90%/90% (-KTL) Un-Biased	7.20E-02	7.13E-02	7.19E-02	7.22E-02	7.23E-02	7.21E-02	7.23E-02
<b>Specification MAX</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



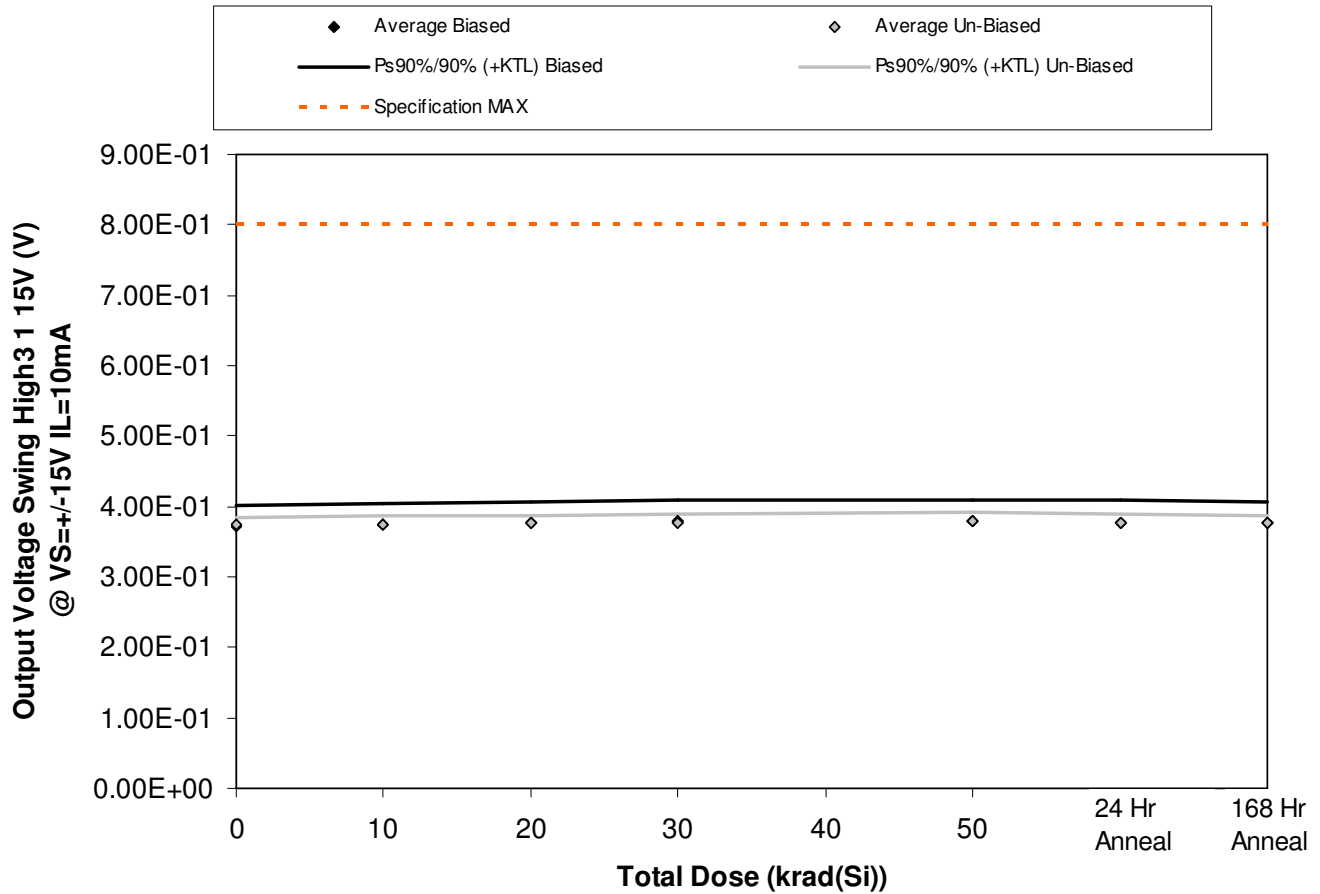


Figure 5.59. Plot of Output Voltage Swing High3 1 15V (V) @ VS=+-15V IL=10mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.59. Raw data for Output Voltage Swing High3 1 15V (V) @ VS=+/-15V IL=10mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High3 1 15V (V) @ VS=+/-15V IL=10mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.56E-01	3.57E-01	3.58E-01	3.59E-01	3.59E-01	3.59E-01	3.58E-01
563	3.76E-01	3.78E-01	3.79E-01	3.80E-01	3.81E-01	3.80E-01	3.80E-01
564	3.81E-01	3.84E-01	3.86E-01	3.88E-01	3.88E-01	3.86E-01	3.86E-01
567	3.79E-01	3.83E-01	3.84E-01	3.86E-01	3.86E-01	3.85E-01	3.84E-01
569	3.73E-01	3.76E-01	3.77E-01	3.78E-01	3.79E-01	3.78E-01	3.77E-01
570	3.75E-01	3.76E-01	3.77E-01	3.78E-01	3.79E-01	3.78E-01	3.77E-01
571	3.74E-01	3.73E-01	3.75E-01	3.77E-01	3.79E-01	3.77E-01	3.76E-01
572	3.77E-01	3.77E-01	3.78E-01	3.80E-01	3.81E-01	3.79E-01	3.79E-01
573	3.79E-01	3.80E-01	3.81E-01	3.82E-01	3.84E-01	3.83E-01	3.81E-01
574	3.68E-01	3.68E-01	3.70E-01	3.71E-01	3.72E-01	3.71E-01	3.70E-01
584	3.60E-01	3.62E-01	3.61E-01	3.62E-01	3.60E-01	3.58E-01	3.60E-01
585	3.59E-01	3.59E-01	3.62E-01	3.60E-01	3.60E-01	3.58E-01	3.59E-01
<b>Biased Statistics</b>							
Average Biased	3.73E-01	3.75E-01	3.77E-01	3.78E-01	3.78E-01	3.78E-01	3.77E-01
Std Dev Biased	1.01E-02	1.09E-02	1.12E-02	1.13E-02	1.13E-02	1.12E-02	1.11E-02
Ps90%/90% (+KTL) Biased	4.01E-01	4.05E-01	4.07E-01	4.09E-01	4.09E-01	4.08E-01	4.07E-01
Ps90%/90% (-KTL) Biased	3.45E-01	3.45E-01	3.46E-01	3.47E-01	3.47E-01	3.47E-01	3.46E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.74E-01	3.75E-01	3.76E-01	3.78E-01	3.79E-01	3.78E-01	3.77E-01
Std Dev Un-Biased	3.91E-03	4.60E-03	4.07E-03	4.20E-03	4.29E-03	4.25E-03	4.01E-03
Ps90%/90% (+KTL) Un-Biased	3.85E-01	3.87E-01	3.87E-01	3.89E-01	3.91E-01	3.89E-01	3.88E-01
Ps90%/90% (-KTL) Un-Biased	3.64E-01	3.62E-01	3.65E-01	3.66E-01	3.67E-01	3.66E-01	3.66E-01
<b>Specification MAX</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

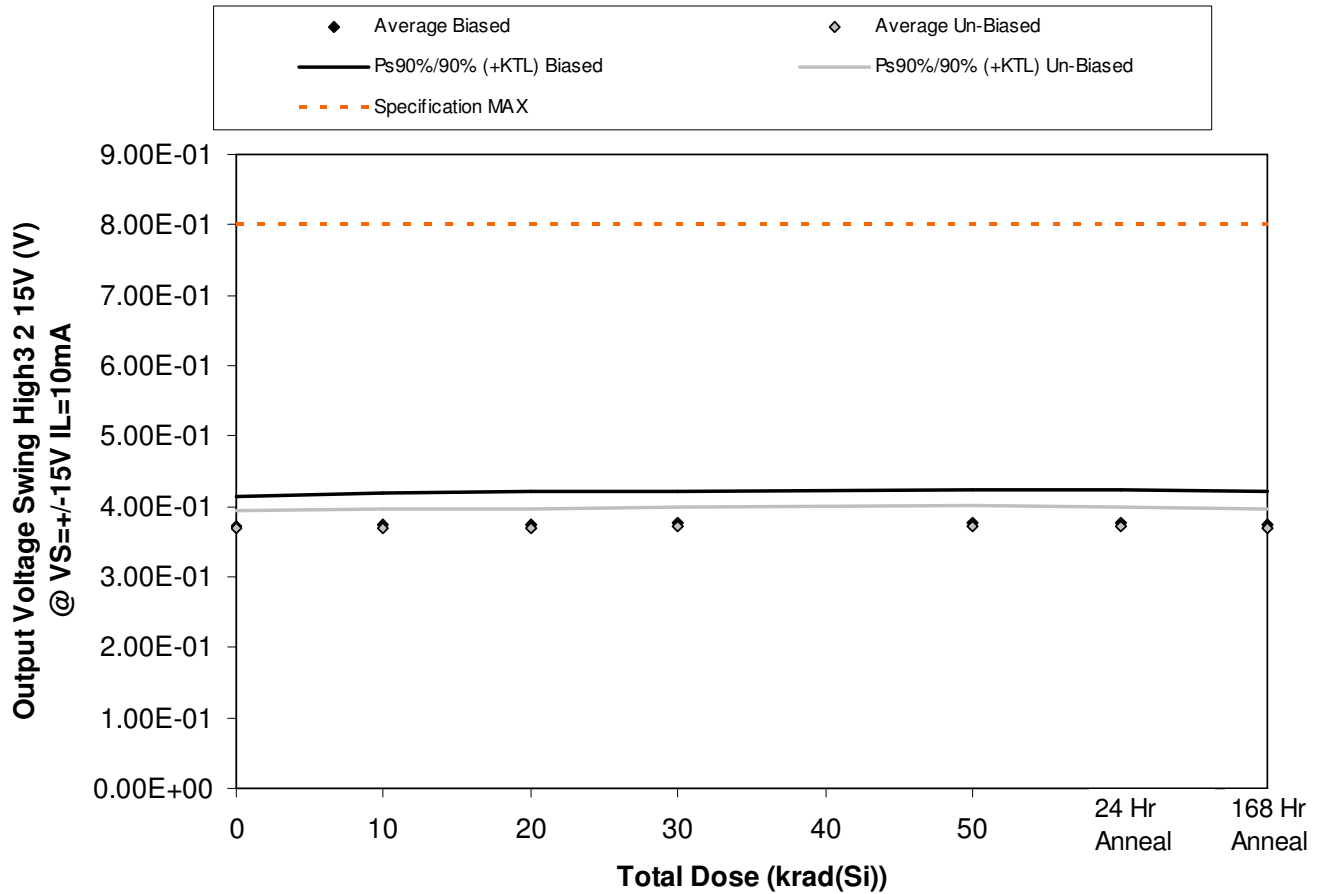


Figure 5.60. Plot of Output Voltage Swing High3 2 15V (V) @ VS=+-15V IL=10mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.60. Raw data for Output Voltage Swing High3 2 15V (V) @ VS=+/-15V IL=10mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High3 2 15V (V) @ VS=+/-15V IL=10mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.46E-01	3.46E-01	3.47E-01	3.49E-01	3.48E-01	3.47E-01	3.47E-01
563	3.81E-01	3.82E-01	3.84E-01	3.85E-01	3.86E-01	3.86E-01	3.85E-01
564	3.81E-01	3.84E-01	3.85E-01	3.88E-01	3.88E-01	3.86E-01	3.85E-01
567	3.82E-01	3.85E-01	3.87E-01	3.88E-01	3.88E-01	3.88E-01	3.86E-01
569	3.69E-01	3.72E-01	3.72E-01	3.74E-01	3.74E-01	3.73E-01	3.72E-01
570	3.75E-01	3.76E-01	3.78E-01	3.79E-01	3.80E-01	3.79E-01	3.78E-01
571	3.68E-01	3.68E-01	3.70E-01	3.71E-01	3.73E-01	3.71E-01	3.70E-01
572	3.60E-01	3.59E-01	3.61E-01	3.62E-01	3.64E-01	3.62E-01	3.61E-01
573	3.80E-01	3.81E-01	3.82E-01	3.84E-01	3.85E-01	3.85E-01	3.82E-01
574	3.58E-01	3.58E-01	3.60E-01	3.61E-01	3.61E-01	3.60E-01	3.60E-01
584	3.76E-01	3.78E-01	3.78E-01	3.77E-01	3.76E-01	3.74E-01	3.75E-01
585	3.76E-01	3.76E-01	3.79E-01	3.77E-01	3.78E-01	3.74E-01	3.75E-01
<b>Biased Statistics</b>							
Average Biased	3.72E-01	3.74E-01	3.75E-01	3.77E-01	3.77E-01	3.76E-01	3.75E-01
Std Dev Biased	1.55E-02	1.64E-02	1.69E-02	1.68E-02	1.70E-02	1.71E-02	1.66E-02
Ps90%/90% (+KTL) Biased	4.14E-01	4.19E-01	4.21E-01	4.22E-01	4.24E-01	4.23E-01	4.21E-01
Ps90%/90% (-KTL) Biased	3.29E-01	3.29E-01	3.29E-01	3.31E-01	3.30E-01	3.29E-01	3.30E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.68E-01	3.68E-01	3.70E-01	3.71E-01	3.73E-01	3.71E-01	3.70E-01
Std Dev Un-Biased	9.34E-03	1.01E-02	9.90E-03	9.83E-03	1.02E-02	1.04E-02	9.92E-03
Ps90%/90% (+KTL) Un-Biased	3.94E-01	3.96E-01	3.97E-01	3.98E-01	4.01E-01	4.00E-01	3.97E-01
Ps90%/90% (-KTL) Un-Biased	3.43E-01	3.41E-01	3.43E-01	3.44E-01	3.45E-01	3.43E-01	3.43E-01
<b>Specification MAX</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

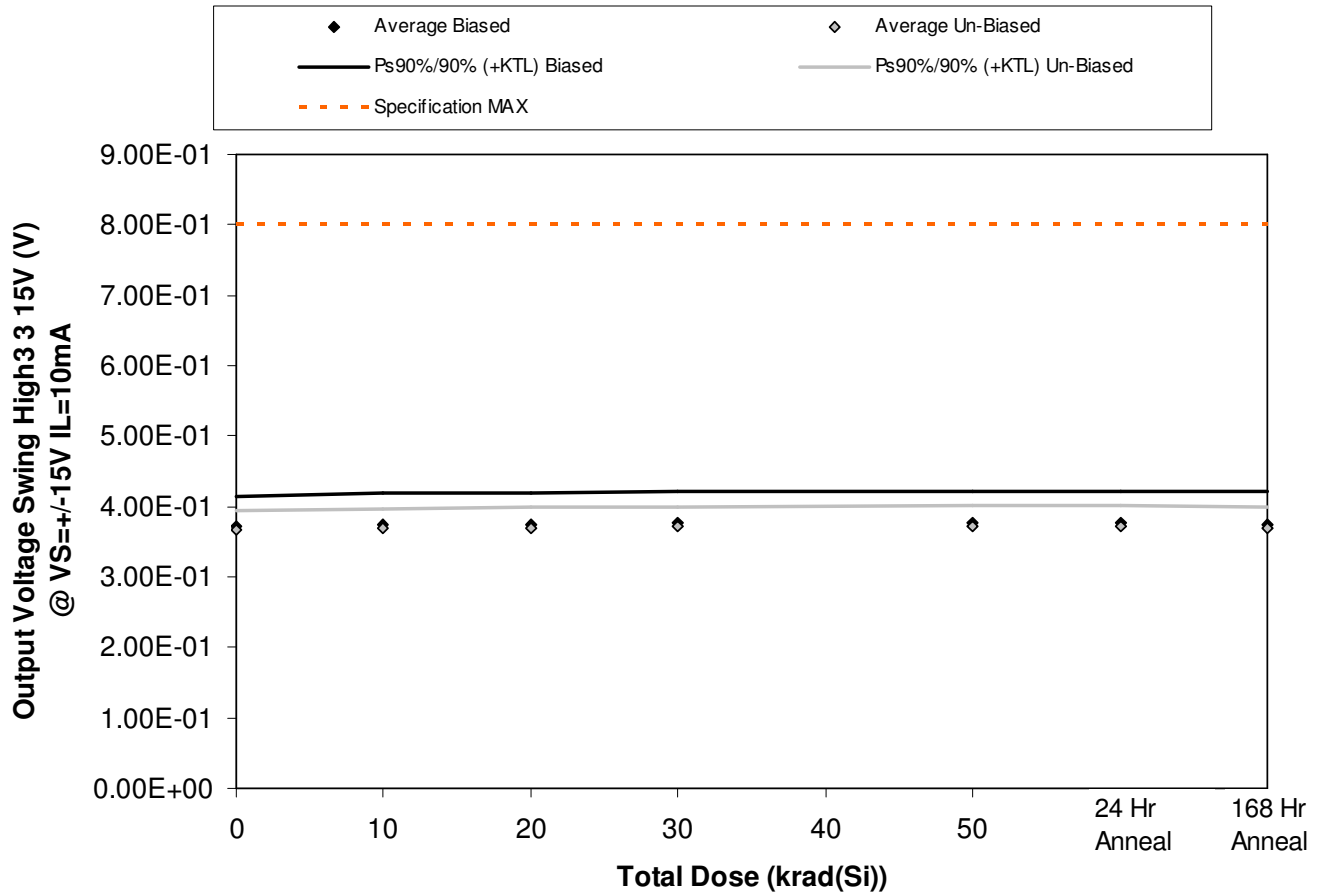


Figure 5.61. Plot of Output Voltage Swing High3 3 15V (V) @ VS=+-15V IL=10mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.61. Raw data for Output Voltage Swing High3 3 15V (V) @ VS=+/-15V IL=10mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High3 3 15V (V) @ VS=+/-15V IL=10mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.46E-01	3.47E-01	3.48E-01	3.49E-01	3.49E-01	3.48E-01	3.48E-01
563	3.83E-01	3.86E-01	3.87E-01	3.88E-01	3.89E-01	3.88E-01	3.87E-01
564	3.79E-01	3.82E-01	3.84E-01	3.86E-01	3.86E-01	3.85E-01	3.85E-01
567	3.81E-01	3.84E-01	3.86E-01	3.87E-01	3.87E-01	3.87E-01	3.85E-01
569	3.68E-01	3.72E-01	3.73E-01	3.73E-01	3.74E-01	3.73E-01	3.72E-01
570	3.76E-01	3.77E-01	3.78E-01	3.79E-01	3.81E-01	3.80E-01	3.78E-01
571	3.67E-01	3.67E-01	3.69E-01	3.70E-01	3.73E-01	3.70E-01	3.69E-01
572	3.60E-01	3.60E-01	3.61E-01	3.63E-01	3.64E-01	3.62E-01	3.61E-01
573	3.80E-01	3.81E-01	3.83E-01	3.84E-01	3.86E-01	3.85E-01	3.83E-01
574	3.57E-01	3.57E-01	3.59E-01	3.59E-01	3.60E-01	3.60E-01	3.59E-01
584	3.77E-01	3.79E-01	3.78E-01	3.78E-01	3.77E-01	3.76E-01	3.76E-01
585	3.76E-01	3.76E-01	3.78E-01	3.76E-01	3.77E-01	3.74E-01	3.75E-01
<b>Biased Statistics</b>							
Average Biased	3.71E-01	3.74E-01	3.75E-01	3.77E-01	3.77E-01	3.76E-01	3.75E-01
Std Dev Biased	1.53E-02	1.62E-02	1.63E-02	1.65E-02	1.67E-02	1.67E-02	1.65E-02
Ps90%/90% (+KTL) Biased	4.13E-01	4.18E-01	4.20E-01	4.22E-01	4.23E-01	4.22E-01	4.21E-01
Ps90%/90% (-KTL) Biased	3.30E-01	3.30E-01	3.31E-01	3.31E-01	3.31E-01	3.30E-01	3.30E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.68E-01	3.68E-01	3.70E-01	3.71E-01	3.73E-01	3.71E-01	3.70E-01
Std Dev Un-Biased	1.00E-02	1.06E-02	1.05E-02	1.05E-02	1.09E-02	1.09E-02	1.06E-02
Ps90%/90% (+KTL) Un-Biased	3.95E-01	3.97E-01	3.99E-01	4.00E-01	4.02E-01	4.01E-01	3.99E-01
Ps90%/90% (-KTL) Un-Biased	3.40E-01	3.39E-01	3.41E-01	3.42E-01	3.43E-01	3.42E-01	3.41E-01
<b>Specification MAX</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

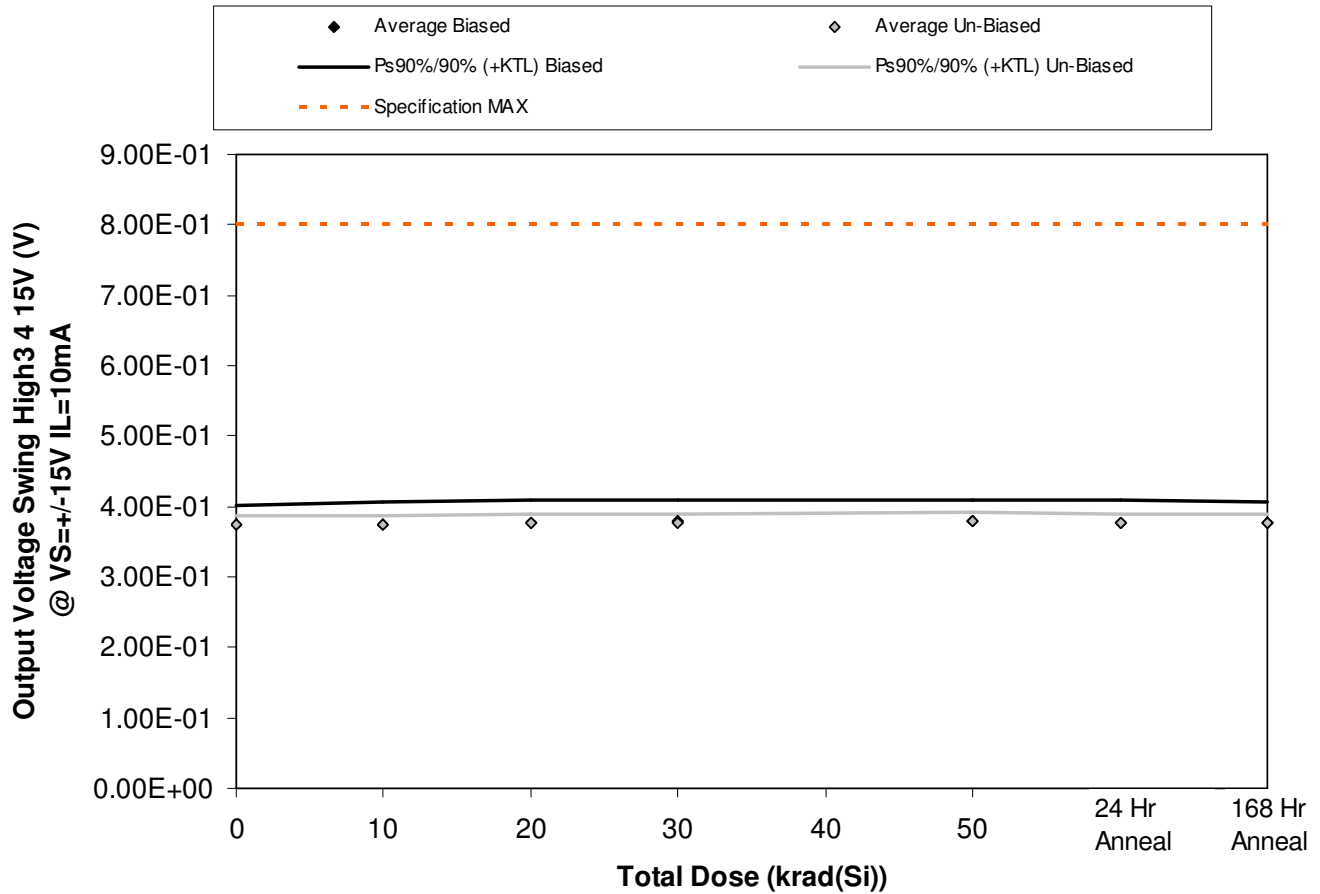


Figure 5.62. Plot of Output Voltage Swing High3 4 15V (V) @ VS=+-15V IL=10mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.62. Raw data for Output Voltage Swing High3 4 15V (V) @ VS=+/-15V IL=10mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High3 4 15V (V) @ VS=+/-15V IL=10mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.56E-01	3.57E-01	3.58E-01	3.59E-01	3.60E-01	3.59E-01	3.58E-01
563	3.76E-01	3.77E-01	3.79E-01	3.80E-01	3.81E-01	3.80E-01	3.79E-01
564	3.82E-01	3.85E-01	3.87E-01	3.89E-01	3.89E-01	3.87E-01	3.87E-01
567	3.79E-01	3.83E-01	3.84E-01	3.85E-01	3.86E-01	3.85E-01	3.84E-01
569	3.73E-01	3.76E-01	3.77E-01	3.78E-01	3.79E-01	3.78E-01	3.77E-01
570	3.75E-01	3.75E-01	3.76E-01	3.78E-01	3.79E-01	3.78E-01	3.77E-01
571	3.74E-01	3.74E-01	3.76E-01	3.77E-01	3.80E-01	3.77E-01	3.76E-01
572	3.76E-01	3.76E-01	3.78E-01	3.79E-01	3.80E-01	3.79E-01	3.78E-01
573	3.79E-01	3.80E-01	3.82E-01	3.83E-01	3.85E-01	3.83E-01	3.82E-01
574	3.67E-01	3.67E-01	3.70E-01	3.70E-01	3.71E-01	3.70E-01	3.70E-01
584	3.60E-01	3.62E-01	3.61E-01	3.61E-01	3.60E-01	3.59E-01	3.60E-01
585	3.59E-01	3.59E-01	3.62E-01	3.60E-01	3.60E-01	3.57E-01	3.59E-01
<b>Biased Statistics</b>							
Average Biased	3.73E-01	3.76E-01	3.77E-01	3.78E-01	3.79E-01	3.78E-01	3.77E-01
Std Dev Biased	1.01E-02	1.10E-02	1.15E-02	1.14E-02	1.14E-02	1.14E-02	1.12E-02
Ps90%/90% (+KTL) Biased	4.01E-01	4.06E-01	4.08E-01	4.09E-01	4.10E-01	4.09E-01	4.08E-01
Ps90%/90% (-KTL) Biased	3.46E-01	3.45E-01	3.46E-01	3.47E-01	3.48E-01	3.47E-01	3.46E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.74E-01	3.75E-01	3.76E-01	3.77E-01	3.79E-01	3.78E-01	3.76E-01
Std Dev Un-Biased	4.34E-03	4.78E-03	4.33E-03	4.58E-03	4.74E-03	4.67E-03	4.33E-03
Ps90%/90% (+KTL) Un-Biased	3.86E-01	3.88E-01	3.88E-01	3.90E-01	3.92E-01	3.90E-01	3.88E-01
Ps90%/90% (-KTL) Un-Biased	3.62E-01	3.62E-01	3.64E-01	3.65E-01	3.66E-01	3.65E-01	3.65E-01
<b>Specification MAX</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>	<b>8.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



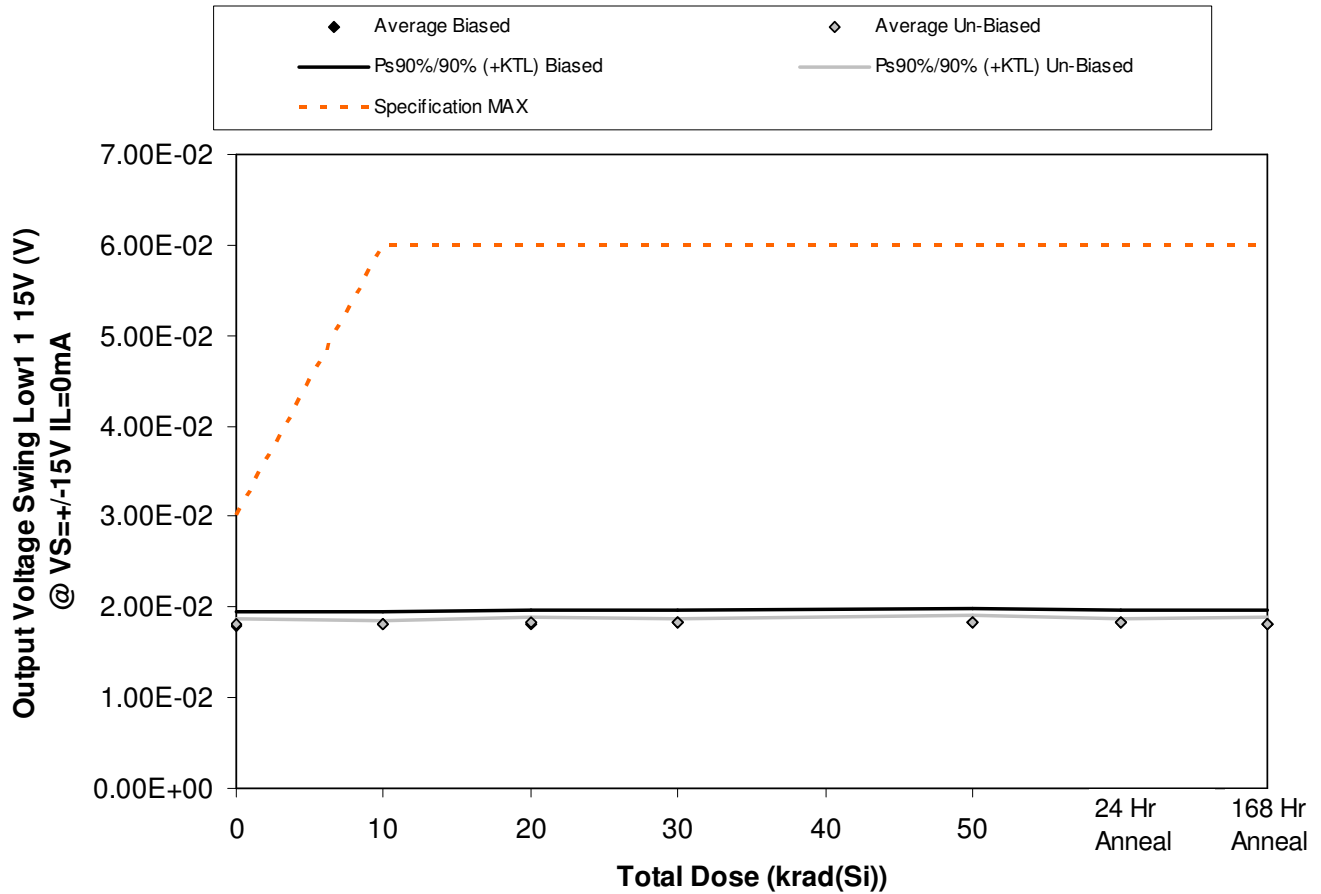


Figure 5.63. Plot of Output Voltage Swing Low1 1 15V (V) @ VS=+-15V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.63. Raw data for Output Voltage Swing Low1 1 15V (V) @ VS=+/-15V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low1 1 15V (V) @ VS=+/-15V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.89E-02	1.90E-02	1.91E-02	1.92E-02	1.93E-02	1.92E-02	1.92E-02
563	1.79E-02	1.79E-02	1.80E-02	1.81E-02	1.83E-02	1.82E-02	1.81E-02
564	1.77E-02	1.78E-02	1.79E-02	1.81E-02	1.82E-02	1.80E-02	1.79E-02
567	1.75E-02	1.77E-02	1.79E-02	1.80E-02	1.80E-02	1.80E-02	1.78E-02
569	1.76E-02	1.78E-02	1.79E-02	1.79E-02	1.81E-02	1.80E-02	1.79E-02
570	1.77E-02	1.79E-02	1.80E-02	1.79E-02	1.80E-02	1.82E-02	1.79E-02
571	1.82E-02	1.80E-02	1.83E-02	1.83E-02	1.86E-02	1.84E-02	1.82E-02
572	1.83E-02	1.82E-02	1.85E-02	1.83E-02	1.85E-02	1.84E-02	1.85E-02
573	1.78E-02	1.82E-02	1.81E-02	1.82E-02	1.83E-02	1.83E-02	1.81E-02
574	1.82E-02	1.81E-02	1.84E-02	1.84E-02	1.86E-02	1.85E-02	1.83E-02
584	1.87E-02	1.88E-02	1.91E-02	1.89E-02	1.88E-02	1.89E-02	1.87E-02
585	1.86E-02	1.87E-02	1.90E-02	1.88E-02	1.87E-02	1.85E-02	1.85E-02
<b>Biased Statistics</b>							
Average Biased	1.79E-02	1.80E-02	1.81E-02	1.83E-02	1.84E-02	1.83E-02	1.82E-02
Std Dev Biased	5.75E-04	5.20E-04	5.23E-04	5.17E-04	5.11E-04	5.40E-04	5.66E-04
Ps90%/90% (+KTL) Biased	1.95E-02	1.95E-02	1.96E-02	1.97E-02	1.98E-02	1.98E-02	1.97E-02
Ps90%/90% (-KTL) Biased	1.63E-02	1.66E-02	1.67E-02	1.68E-02	1.70E-02	1.68E-02	1.66E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.80E-02	1.81E-02	1.83E-02	1.82E-02	1.84E-02	1.84E-02	1.82E-02
Std Dev Un-Biased	2.66E-04	1.43E-04	2.26E-04	1.84E-04	2.48E-04	1.11E-04	2.35E-04
Ps90%/90% (+KTL) Un-Biased	1.88E-02	1.85E-02	1.89E-02	1.87E-02	1.91E-02	1.87E-02	1.88E-02
Ps90%/90% (-KTL) Un-Biased	1.73E-02	1.77E-02	1.76E-02	1.77E-02	1.77E-02	1.80E-02	1.76E-02
<b>Specification MAX</b>	<b>3.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

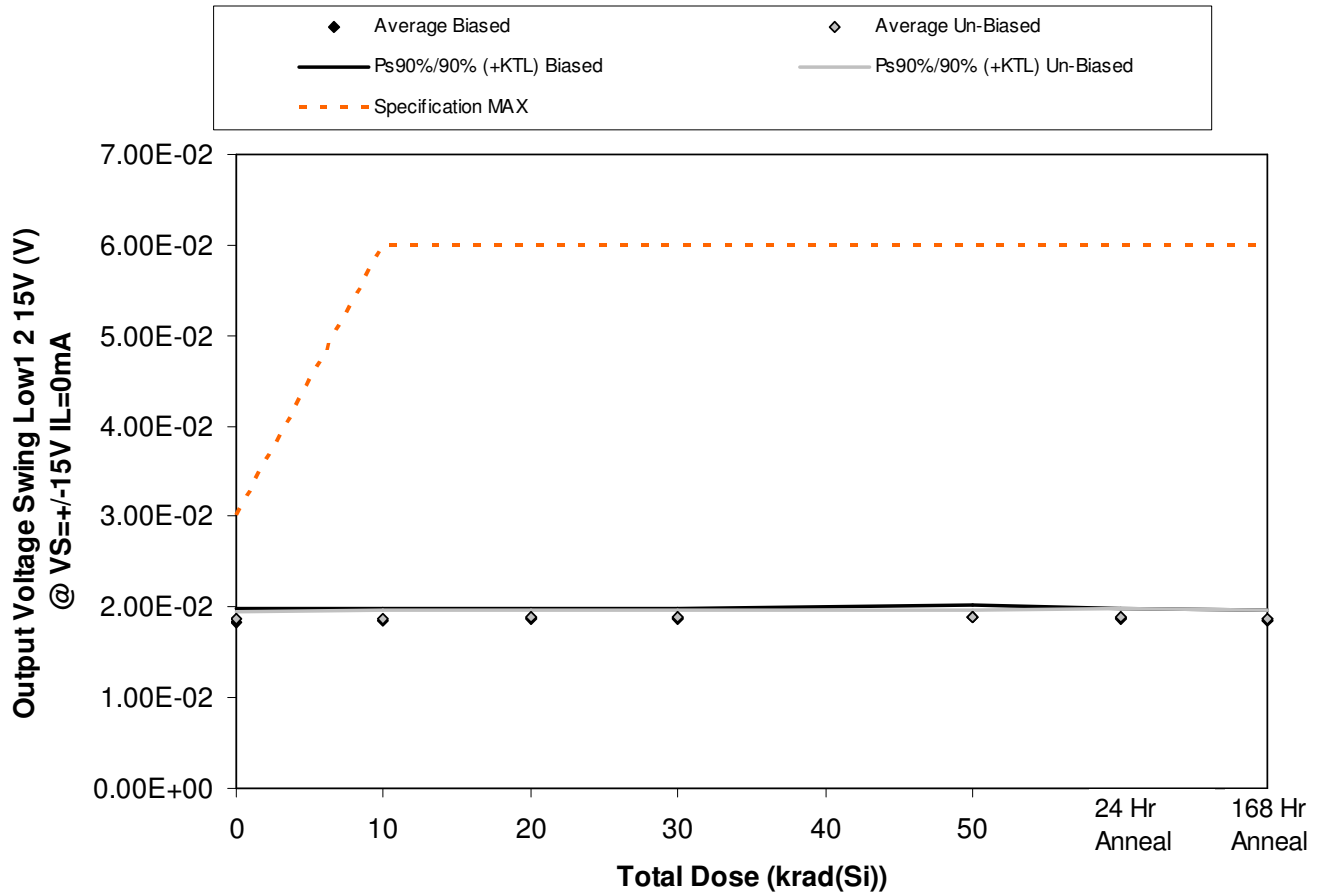


Figure 5.64. Plot of Output Voltage Swing Low1 2 15V (V) @ VS=+-15V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.64. Raw data for Output Voltage Swing Low1 2 15V (V) @ VS=+/-15V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low1 2 15V (V) @ VS=+/-15V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.91E-02	1.92E-02	1.94E-02	1.94E-02	1.95E-02	1.92E-02	1.91E-02
563	1.80E-02	1.83E-02	1.84E-02	1.84E-02	1.85E-02	1.85E-02	1.83E-02
564	1.79E-02	1.83E-02	1.87E-02	1.86E-02	1.87E-02	1.85E-02	1.85E-02
567	1.78E-02	1.82E-02	1.85E-02	1.84E-02	1.83E-02	1.84E-02	1.81E-02
569	1.87E-02	1.89E-02	1.90E-02	1.90E-02	1.92E-02	1.92E-02	1.89E-02
570	1.84E-02	1.83E-02	1.86E-02	1.85E-02	1.85E-02	1.86E-02	1.84E-02
571	1.83E-02	1.84E-02	1.87E-02	1.86E-02	1.87E-02	1.86E-02	1.85E-02
572	1.88E-02	1.88E-02	1.89E-02	1.89E-02	1.90E-02	1.91E-02	1.90E-02
573	1.91E-02	1.91E-02	1.94E-02	1.92E-02	1.93E-02	1.93E-02	1.90E-02
574	1.88E-02	1.88E-02	1.89E-02	1.91E-02	1.89E-02	1.91E-02	1.89E-02
584	1.83E-02	1.84E-02	1.85E-02	1.85E-02	1.83E-02	1.83E-02	1.82E-02
585	1.84E-02	1.83E-02	1.88E-02	1.87E-02	1.85E-02	1.82E-02	1.83E-02
<b>Biased Statistics</b>							
Average Biased	1.83E-02	1.86E-02	1.88E-02	1.88E-02	1.88E-02	1.88E-02	1.86E-02
Std Dev Biased	5.54E-04	4.42E-04	4.05E-04	4.15E-04	5.03E-04	4.04E-04	4.29E-04
Ps90%/90% (+KTL) Biased	1.98E-02	1.98E-02	1.99E-02	1.99E-02	2.02E-02	1.99E-02	1.98E-02
Ps90%/90% (-KTL) Biased	1.68E-02	1.74E-02	1.77E-02	1.76E-02	1.74E-02	1.76E-02	1.74E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.87E-02	1.87E-02	1.89E-02	1.89E-02	1.89E-02	1.89E-02	1.88E-02
Std Dev Un-Biased	3.25E-04	3.45E-04	3.09E-04	3.06E-04	3.20E-04	3.29E-04	2.98E-04
Ps90%/90% (+KTL) Un-Biased	1.96E-02	1.96E-02	1.97E-02	1.97E-02	1.98E-02	1.98E-02	1.96E-02
Ps90%/90% (-KTL) Un-Biased	1.78E-02	1.77E-02	1.80E-02	1.80E-02	1.80E-02	1.80E-02	1.79E-02
<b>Specification MAX</b>	<b>3.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

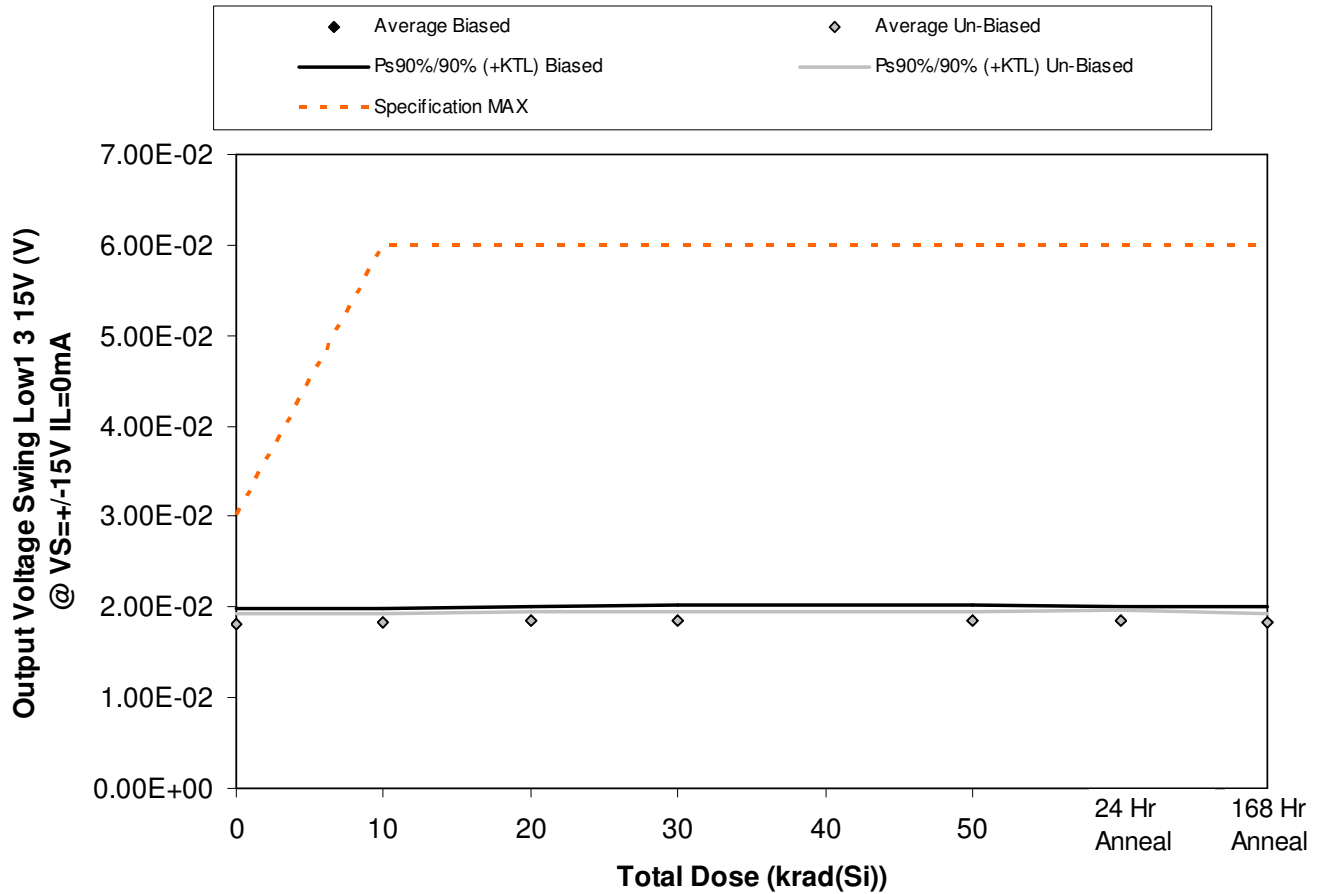


Figure 5.65. Plot of Output Voltage Swing Low1 3 15V (V) @ VS=+-15V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.65. Raw data for Output Voltage Swing Low1 3 15V (V) @ VS=+/-15V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low1 3 15V (V) @ VS=+/-15V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.89E-02	1.89E-02	1.91E-02	1.93E-02	1.93E-02	1.93E-02	1.90E-02
563	1.77E-02	1.78E-02	1.80E-02	1.81E-02	1.81E-02	1.82E-02	1.78E-02
564	1.79E-02	1.79E-02	1.82E-02	1.84E-02	1.82E-02	1.82E-02	1.82E-02
567	1.74E-02	1.79E-02	1.78E-02	1.78E-02	1.81E-02	1.79E-02	1.78E-02
569	1.86E-02	1.88E-02	1.91E-02	1.90E-02	1.91E-02	1.90E-02	1.90E-02
570	1.76E-02	1.77E-02	1.78E-02	1.79E-02	1.79E-02	1.79E-02	1.78E-02
571	1.83E-02	1.83E-02	1.86E-02	1.85E-02	1.86E-02	1.85E-02	1.84E-02
572	1.82E-02	1.86E-02	1.86E-02	1.84E-02	1.86E-02	1.86E-02	1.84E-02
573	1.83E-02	1.83E-02	1.85E-02	1.87E-02	1.86E-02	1.86E-02	1.84E-02
574	1.86E-02	1.86E-02	1.88E-02	1.89E-02	1.89E-02	1.90E-02	1.87E-02
584	1.81E-02	1.81E-02	1.82E-02	1.81E-02	1.79E-02	1.79E-02	1.78E-02
585	1.81E-02	1.82E-02	1.87E-02	1.83E-02	1.83E-02	1.80E-02	1.81E-02
<b>Biased Statistics</b>							
Average Biased	1.81E-02	1.83E-02	1.84E-02	1.85E-02	1.86E-02	1.85E-02	1.84E-02
Std Dev Biased	6.13E-04	5.54E-04	6.04E-04	6.17E-04	6.06E-04	5.94E-04	6.09E-04
Ps90%/90% (+KTL) Biased	1.98E-02	1.98E-02	2.01E-02	2.02E-02	2.02E-02	2.02E-02	2.00E-02
Ps90%/90% (-KTL) Biased	1.64E-02	1.67E-02	1.68E-02	1.68E-02	1.69E-02	1.69E-02	1.67E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.82E-02	1.83E-02	1.85E-02	1.85E-02	1.85E-02	1.85E-02	1.83E-02
Std Dev Un-Biased	3.62E-04	3.78E-04	4.03E-04	3.88E-04	3.85E-04	4.03E-04	3.47E-04
Ps90%/90% (+KTL) Un-Biased	1.92E-02	1.93E-02	1.96E-02	1.95E-02	1.96E-02	1.96E-02	1.93E-02
Ps90%/90% (-KTL) Un-Biased	1.72E-02	1.72E-02	1.74E-02	1.74E-02	1.74E-02	1.74E-02	1.74E-02
<b>Specification MAX</b>	<b>3.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

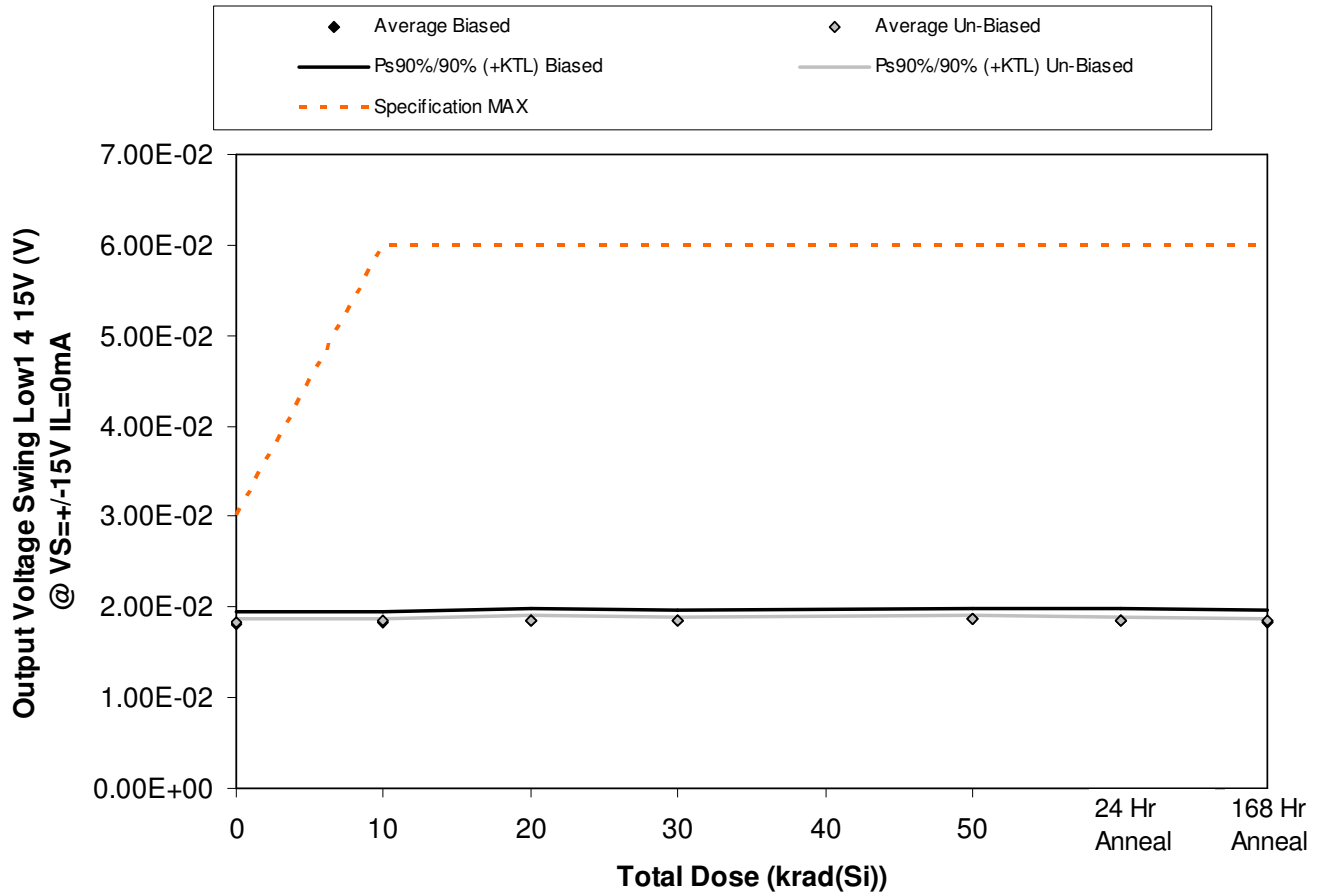


Figure 5.66. Plot of Output Voltage Swing Low1 4 15V (V) @ VS=+-15V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.66. Raw data for Output Voltage Swing Low1 4 15V (V) @ VS=+/-15V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low1 4 15V (V) @ VS=+/-15V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.90E-02	1.91E-02	1.95E-02	1.92E-02	1.94E-02	1.93E-02	1.92E-02
563	1.81E-02	1.82E-02	1.83E-02	1.85E-02	1.85E-02	1.85E-02	1.83E-02
564	1.81E-02	1.83E-02	1.84E-02	1.87E-02	1.85E-02	1.85E-02	1.82E-02
567	1.78E-02	1.81E-02	1.82E-02	1.81E-02	1.83E-02	1.83E-02	1.81E-02
569	1.80E-02	1.83E-02	1.84E-02	1.83E-02	1.83E-02	1.81E-02	1.83E-02
570	1.84E-02	1.84E-02	1.84E-02	1.85E-02	1.85E-02	1.85E-02	1.84E-02
571	1.85E-02	1.86E-02	1.88E-02	1.87E-02	1.88E-02	1.87E-02	1.85E-02
572	1.84E-02	1.84E-02	1.84E-02	1.84E-02	1.88E-02	1.86E-02	1.85E-02
573	1.84E-02	1.85E-02	1.86E-02	1.87E-02	1.87E-02	1.87E-02	1.86E-02
574	1.82E-02	1.83E-02	1.84E-02	1.85E-02	1.85E-02	1.85E-02	1.83E-02
584	1.88E-02	1.89E-02	1.90E-02	1.90E-02	1.88E-02	1.88E-02	1.89E-02
585	1.89E-02	1.89E-02	1.93E-02	1.89E-02	1.88E-02	1.88E-02	1.87E-02
<b>Biased Statistics</b>							
Average Biased	1.82E-02	1.84E-02	1.85E-02	1.86E-02	1.86E-02	1.85E-02	1.84E-02
Std Dev Biased	4.83E-04	4.23E-04	5.15E-04	3.95E-04	4.54E-04	4.69E-04	4.65E-04
Ps90%/90% (+KTL) Biased	1.95E-02	1.96E-02	2.00E-02	1.97E-02	1.99E-02	1.98E-02	1.97E-02
Ps90%/90% (-KTL) Biased	1.69E-02	1.72E-02	1.71E-02	1.75E-02	1.74E-02	1.73E-02	1.71E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.84E-02	1.84E-02	1.85E-02	1.86E-02	1.87E-02	1.86E-02	1.85E-02
Std Dev Un-Biased	1.28E-04	1.18E-04	1.79E-04	1.36E-04	1.35E-04	9.82E-05	1.16E-04
Ps90%/90% (+KTL) Un-Biased	1.87E-02	1.87E-02	1.90E-02	1.89E-02	1.90E-02	1.89E-02	1.88E-02
Ps90%/90% (-KTL) Un-Biased	1.80E-02	1.81E-02	1.80E-02	1.82E-02	1.83E-02	1.83E-02	1.81E-02
<b>Specification MAX</b>	<b>3.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



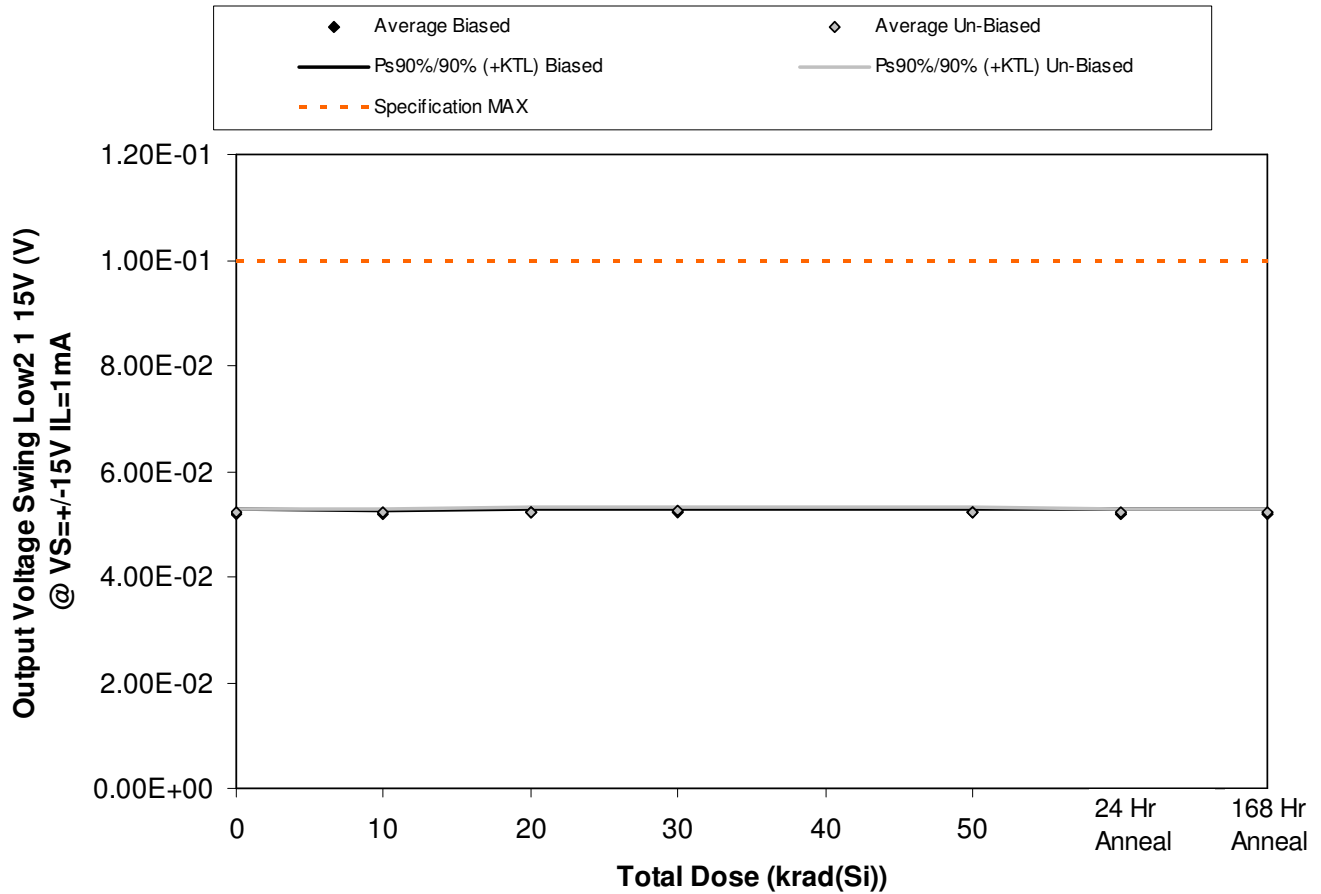


Figure 5.67. Plot of Output Voltage Swing Low2 1 15V (V) @ VS=+-15V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.67. Raw data for Output Voltage Swing Low2 1 15V (V) @ VS=+/-15V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low2 1 15V (V) @ VS=+/-15V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.24E-02	5.24E-02	5.26E-02	5.26E-02	5.26E-02	5.25E-02	5.26E-02
563	5.19E-02	5.19E-02	5.22E-02	5.23E-02	5.23E-02	5.20E-02	5.19E-02
564	5.18E-02	5.20E-02	5.22E-02	5.24E-02	5.23E-02	5.20E-02	5.22E-02
567	5.16E-02	5.20E-02	5.22E-02	5.22E-02	5.22E-02	5.20E-02	5.17E-02
569	5.17E-02	5.19E-02	5.19E-02	5.20E-02	5.21E-02	5.18E-02	5.18E-02
570	5.18E-02	5.20E-02	5.19E-02	5.21E-02	5.18E-02	5.19E-02	5.17E-02
571	5.23E-02	5.23E-02	5.26E-02	5.26E-02	5.26E-02	5.25E-02	5.22E-02
572	5.25E-02	5.24E-02	5.26E-02	5.25E-02	5.26E-02	5.25E-02	5.25E-02
573	5.23E-02	5.24E-02	5.24E-02	5.27E-02	5.25E-02	5.24E-02	5.22E-02
574	5.22E-02	5.21E-02	5.24E-02	5.22E-02	5.25E-02	5.22E-02	5.21E-02
584	5.25E-02	5.27E-02	5.29E-02	5.26E-02	5.24E-02	5.22E-02	5.22E-02
585	5.22E-02	5.25E-02	5.29E-02	5.25E-02	5.23E-02	5.21E-02	5.22E-02
<b>Biased Statistics</b>							
Average Biased	5.19E-02	5.20E-02	5.22E-02	5.23E-02	5.23E-02	5.21E-02	5.20E-02
Std Dev Biased	3.27E-04	1.93E-04	2.31E-04	2.35E-04	1.97E-04	2.47E-04	3.60E-04
Ps90%/90% (+KTL) Biased	5.28E-02	5.26E-02	5.29E-02	5.30E-02	5.28E-02	5.27E-02	5.30E-02
Ps90%/90% (-KTL) Biased	5.10E-02	5.15E-02	5.16E-02	5.17E-02	5.17E-02	5.14E-02	5.11E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.22E-02	5.22E-02	5.24E-02	5.24E-02	5.24E-02	5.23E-02	5.21E-02
Std Dev Un-Biased	2.82E-04	1.95E-04	2.92E-04	2.59E-04	3.51E-04	2.58E-04	2.65E-04
Ps90%/90% (+KTL) Un-Biased	5.30E-02	5.28E-02	5.32E-02	5.32E-02	5.33E-02	5.30E-02	5.29E-02
Ps90%/90% (-KTL) Un-Biased	5.14E-02	5.17E-02	5.16E-02	5.17E-02	5.14E-02	5.16E-02	5.14E-02
<b>Specification MAX</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

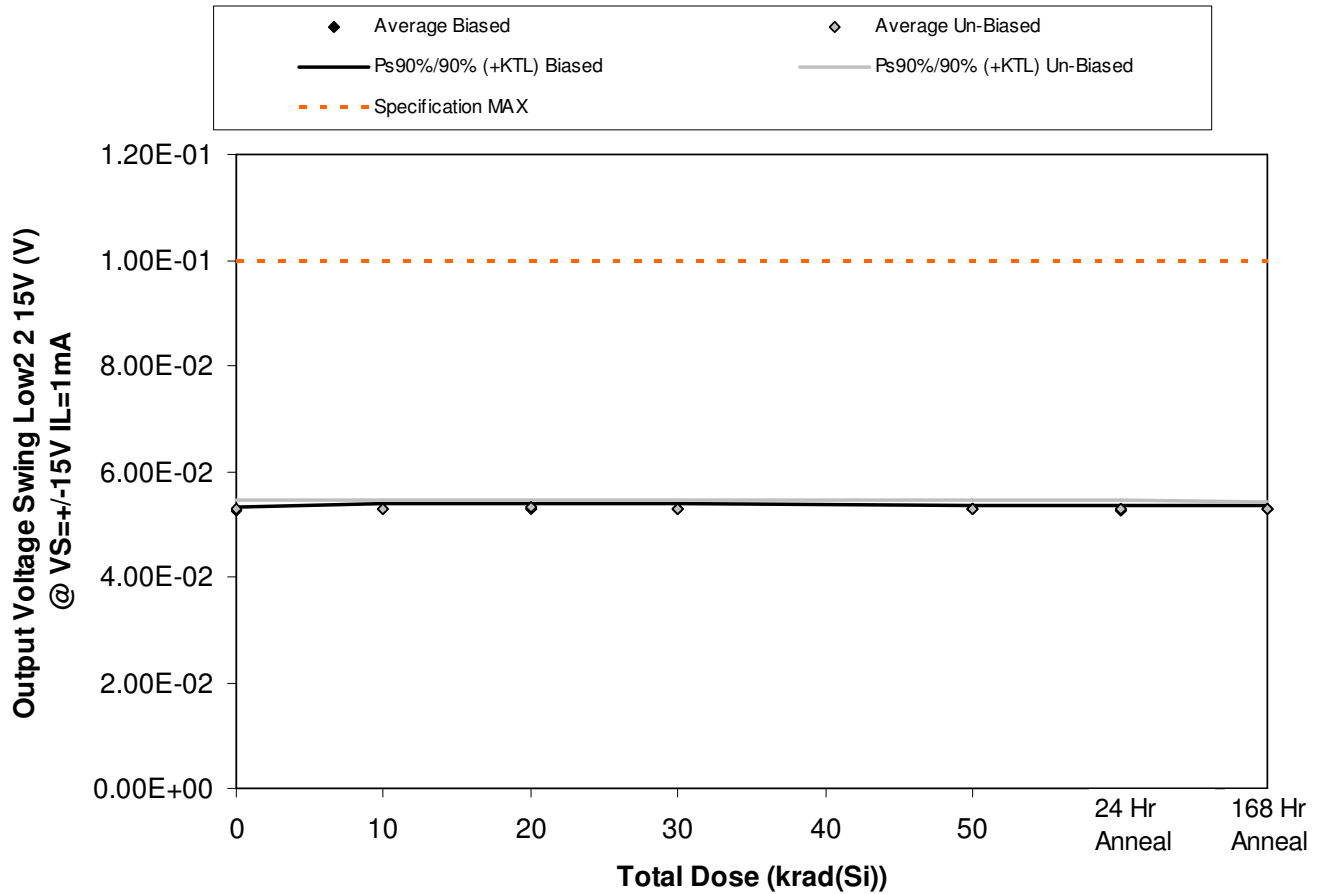


Figure 5.68. Plot of Output Voltage Swing Low2 2 15V (V) @ VS=+-15V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.68. Raw data for Output Voltage Swing Low2 2 15V (V) @ VS=+-15V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low2 2 15V (V) @ VS=+-15V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.23E-02	5.24E-02	5.23E-02	5.25E-02	5.25E-02	5.23E-02	5.25E-02
563	5.25E-02	5.25E-02	5.28E-02	5.30E-02	5.29E-02	5.25E-02	5.28E-02
564	5.27E-02	5.30E-02	5.31E-02	5.35E-02	5.32E-02	5.27E-02	5.30E-02
567	5.27E-02	5.29E-02	5.30E-02	5.30E-02	5.31E-02	5.29E-02	5.28E-02
569	5.28E-02	5.32E-02	5.33E-02	5.31E-02	5.31E-02	5.30E-02	5.31E-02
570	5.27E-02	5.31E-02	5.30E-02	5.29E-02	5.29E-02	5.31E-02	5.27E-02
571	5.26E-02	5.27E-02	5.30E-02	5.29E-02	5.28E-02	5.26E-02	5.24E-02
572	5.27E-02	5.26E-02	5.30E-02	5.27E-02	5.28E-02	5.25E-02	5.26E-02
573	5.39E-02	5.39E-02	5.41E-02	5.41E-02	5.40E-02	5.38E-02	5.37E-02
574	5.22E-02	5.23E-02	5.25E-02	5.26E-02	5.25E-02	5.22E-02	5.24E-02
584	5.26E-02	5.28E-02	5.27E-02	5.28E-02	5.25E-02	5.24E-02	5.24E-02
585	5.26E-02	5.28E-02	5.32E-02	5.30E-02	5.30E-02	5.26E-02	5.25E-02
<b>Biased Statistics</b>							
Average Biased	5.26E-02	5.28E-02	5.29E-02	5.30E-02	5.29E-02	5.27E-02	5.28E-02
Std Dev Biased	2.26E-04	3.30E-04	3.57E-04	3.51E-04	2.61E-04	2.91E-04	2.55E-04
Ps90%/90% (+KTL) Biased	5.32E-02	5.37E-02	5.39E-02	5.40E-02	5.37E-02	5.35E-02	5.35E-02
Ps90%/90% (-KTL) Biased	5.20E-02	5.19E-02	5.19E-02	5.20E-02	5.22E-02	5.19E-02	5.21E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.28E-02	5.29E-02	5.31E-02	5.30E-02	5.30E-02	5.28E-02	5.27E-02
Std Dev Un-Biased	6.33E-04	6.28E-04	5.71E-04	6.09E-04	5.76E-04	6.09E-04	5.30E-04
Ps90%/90% (+KTL) Un-Biased	5.45E-02	5.46E-02	5.47E-02	5.47E-02	5.46E-02	5.45E-02	5.42E-02
Ps90%/90% (-KTL) Un-Biased	5.11E-02	5.12E-02	5.15E-02	5.14E-02	5.14E-02	5.12E-02	5.13E-02
<b>Specification MAX</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

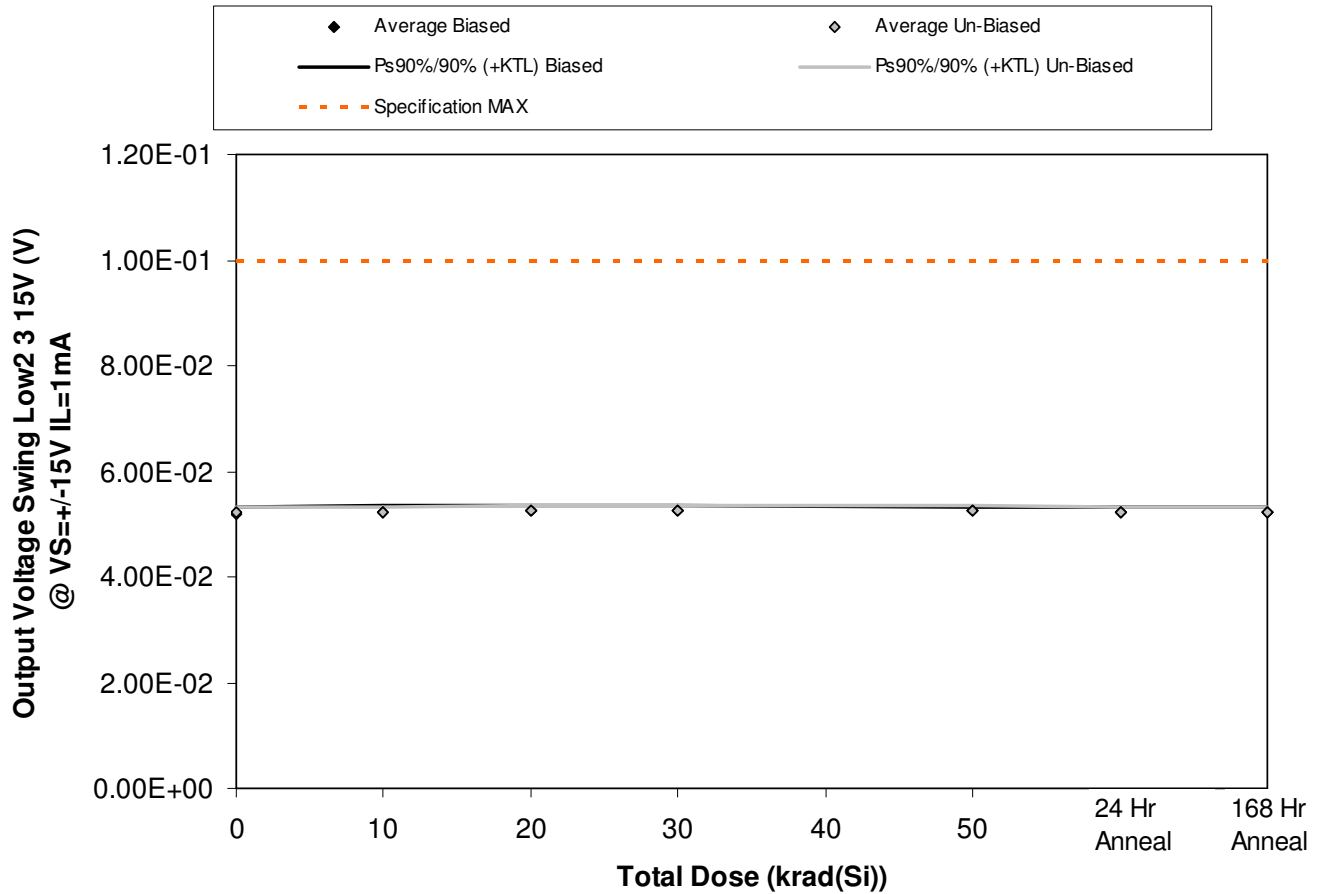


Figure 5.69. Plot of Output Voltage Swing Low2 3 15V (V) @ VS=+-15V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.69. Raw data for Output Voltage Swing Low2 3 15V (V) @ VS=+/-15V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low2 3 15V (V) @ VS=+/-15V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.18E-02	5.20E-02	5.21E-02	5.21E-02	5.22E-02	5.20E-02	5.19E-02
563	5.20E-02	5.20E-02	5.23E-02	5.25E-02	5.23E-02	5.23E-02	5.22E-02
564	5.21E-02	5.22E-02	5.24E-02	5.27E-02	5.25E-02	5.24E-02	5.23E-02
567	5.17E-02	5.22E-02	5.24E-02	5.25E-02	5.23E-02	5.23E-02	5.22E-02
569	5.27E-02	5.30E-02	5.31E-02	5.31E-02	5.29E-02	5.30E-02	5.30E-02
570	5.18E-02	5.18E-02	5.20E-02	5.19E-02	5.20E-02	5.20E-02	5.17E-02
571	5.23E-02	5.23E-02	5.25E-02	5.27E-02	5.26E-02	5.25E-02	5.24E-02
572	5.20E-02	5.22E-02	5.22E-02	5.23E-02	5.23E-02	5.21E-02	5.23E-02
573	5.27E-02	5.28E-02	5.31E-02	5.30E-02	5.30E-02	5.29E-02	5.27E-02
574	5.20E-02	5.21E-02	5.24E-02	5.23E-02	5.22E-02	5.22E-02	5.21E-02
584	5.19E-02	5.20E-02	5.22E-02	5.22E-02	5.19E-02	5.16E-02	5.17E-02
585	5.22E-02	5.22E-02	5.30E-02	5.26E-02	5.24E-02	5.20E-02	5.22E-02
<b>Biased Statistics</b>							
Average Biased	5.21E-02	5.23E-02	5.25E-02	5.26E-02	5.24E-02	5.24E-02	5.23E-02
Std Dev Biased	4.08E-04	4.24E-04	3.55E-04	3.42E-04	2.78E-04	3.66E-04	3.87E-04
Ps90%/90% (+KTL) Biased	5.32E-02	5.34E-02	5.34E-02	5.35E-02	5.32E-02	5.34E-02	5.34E-02
Ps90%/90% (-KTL) Biased	5.09E-02	5.11E-02	5.15E-02	5.16E-02	5.17E-02	5.14E-02	5.12E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.22E-02	5.22E-02	5.24E-02	5.25E-02	5.24E-02	5.23E-02	5.22E-02
Std Dev Un-Biased	3.48E-04	3.60E-04	3.94E-04	4.24E-04	4.01E-04	3.64E-04	3.58E-04
Ps90%/90% (+KTL) Un-Biased	5.31E-02	5.32E-02	5.35E-02	5.36E-02	5.35E-02	5.33E-02	5.32E-02
Ps90%/90% (-KTL) Un-Biased	5.12E-02	5.12E-02	5.14E-02	5.13E-02	5.13E-02	5.13E-02	5.12E-02
<b>Specification MAX</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

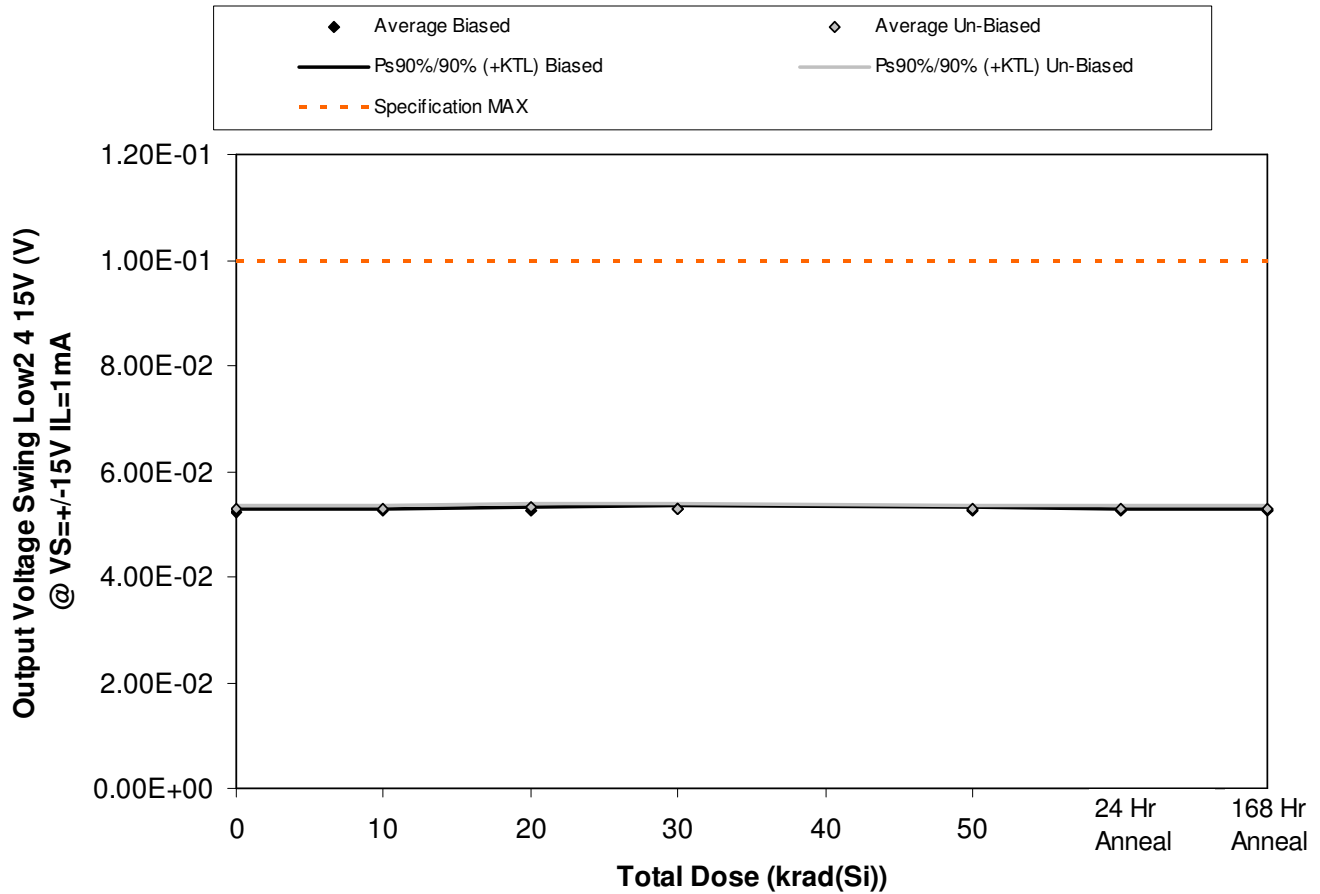


Figure 5.70. Plot of Output Voltage Swing Low2 4 15V (V) @ VS=+-15V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.70. Raw data for Output Voltage Swing Low2 4 15V (V) @ VS=+/-15V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low2 4 15V (V) @ VS=+/-15V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.26E-02	5.26E-02	5.27E-02	5.30E-02	5.29E-02	5.27E-02	5.26E-02
563	5.24E-02	5.24E-02	5.26E-02	5.29E-02	5.27E-02	5.26E-02	5.27E-02
564	5.24E-02	5.27E-02	5.30E-02	5.30E-02	5.28E-02	5.26E-02	5.27E-02
567	5.23E-02	5.25E-02	5.27E-02	5.27E-02	5.27E-02	5.26E-02	5.23E-02
569	5.21E-02	5.25E-02	5.25E-02	5.25E-02	5.24E-02	5.23E-02	5.24E-02
570	5.28E-02	5.28E-02	5.30E-02	5.28E-02	5.27E-02	5.28E-02	5.26E-02
571	5.30E-02	5.28E-02	5.33E-02	5.32E-02	5.31E-02	5.31E-02	5.30E-02
572	5.29E-02	5.28E-02	5.31E-02	5.32E-02	5.31E-02	5.28E-02	5.29E-02
573	5.32E-02	5.31E-02	5.34E-02	5.33E-02	5.32E-02	5.33E-02	5.31E-02
574	5.25E-02	5.25E-02	5.27E-02	5.27E-02	5.26E-02	5.25E-02	5.25E-02
584	5.28E-02	5.29E-02	5.30E-02	5.29E-02	5.27E-02	5.25E-02	5.26E-02
585	5.28E-02	5.29E-02	5.34E-02	5.30E-02	5.30E-02	5.25E-02	5.27E-02
<b>Biased Statistics</b>							
Average Biased	5.23E-02	5.25E-02	5.27E-02	5.28E-02	5.27E-02	5.26E-02	5.25E-02
Std Dev Biased	1.66E-04	9.43E-05	1.89E-04	2.18E-04	1.78E-04	1.44E-04	1.88E-04
Ps90%/90% (+KTL) Biased	5.28E-02	5.28E-02	5.32E-02	5.34E-02	5.32E-02	5.30E-02	5.30E-02
Ps90%/90% (-KTL) Biased	5.19E-02	5.23E-02	5.22E-02	5.22E-02	5.22E-02	5.22E-02	5.20E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.29E-02	5.28E-02	5.31E-02	5.30E-02	5.29E-02	5.29E-02	5.28E-02
Std Dev Un-Biased	2.54E-04	2.18E-04	2.70E-04	2.75E-04	2.60E-04	2.94E-04	2.50E-04
Ps90%/90% (+KTL) Un-Biased	5.36E-02	5.34E-02	5.38E-02	5.38E-02	5.36E-02	5.37E-02	5.35E-02
Ps90%/90% (-KTL) Un-Biased	5.22E-02	5.22E-02	5.23E-02	5.23E-02	5.22E-02	5.21E-02	5.21E-02
<b>Specification MAX</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



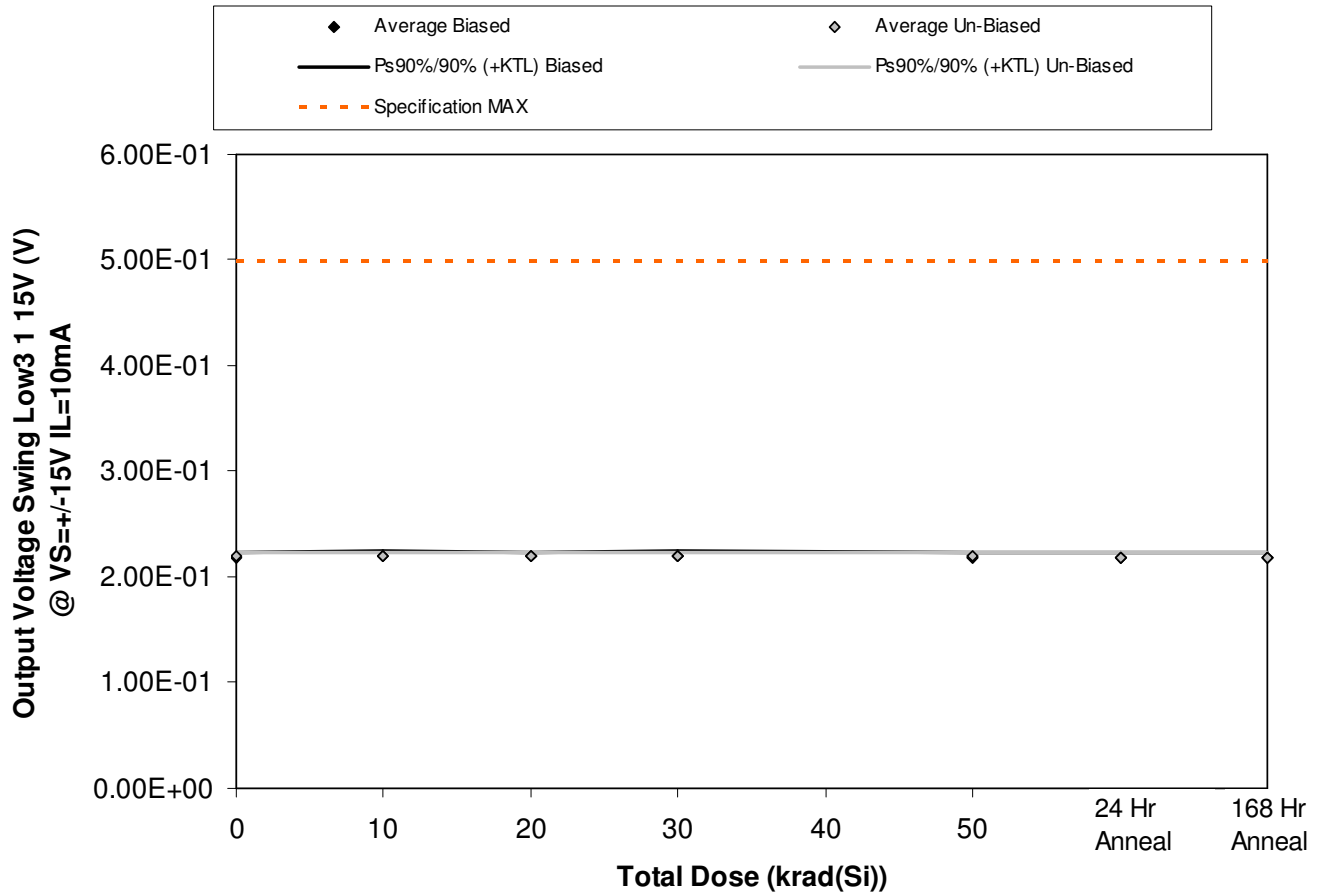


Figure 5.71. Plot of Output Voltage Swing Low3 1 15V (V) @ VS=+-15V IL=10mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.71. Raw data for Output Voltage Swing Low3 1 15V (V) @ VS=+-15V IL=10mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low3 1 15V (V) @ VS=+-15V IL=10mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.17E-01	2.17E-01	2.17E-01	2.17E-01	2.17E-01	2.16E-01	2.16E-01
563	2.19E-01	2.18E-01	2.19E-01	2.19E-01	2.19E-01	2.18E-01	2.18E-01
564	2.20E-01	2.21E-01	2.21E-01	2.22E-01	2.21E-01	2.20E-01	2.21E-01
567	2.20E-01	2.21E-01	2.21E-01	2.21E-01	2.20E-01	2.20E-01	2.20E-01
569	2.18E-01	2.19E-01	2.19E-01	2.19E-01	2.18E-01	2.18E-01	2.18E-01
570	2.18E-01	2.18E-01	2.19E-01	2.19E-01	2.18E-01	2.18E-01	2.17E-01
571	2.20E-01	2.20E-01	2.20E-01	2.20E-01	2.20E-01	2.19E-01	2.19E-01
572	2.22E-01	2.21E-01	2.22E-01	2.22E-01	2.21E-01	2.21E-01	2.21E-01
573	2.20E-01	2.20E-01	2.21E-01	2.21E-01	2.20E-01	2.20E-01	2.20E-01
574	2.18E-01	2.18E-01	2.19E-01	2.19E-01	2.18E-01	2.18E-01	2.18E-01
584	2.17E-01	2.18E-01	2.18E-01	2.18E-01	2.17E-01	2.16E-01	2.17E-01
585	2.18E-01	2.19E-01	2.20E-01	2.19E-01	2.19E-01	2.17E-01	2.18E-01
<b>Biased Statistics</b>							
Average Biased	2.19E-01	2.19E-01	2.19E-01	2.20E-01	2.19E-01	2.18E-01	2.19E-01
Std Dev Biased	1.47E-03	1.78E-03	1.64E-03	1.82E-03	1.68E-03	1.60E-03	1.66E-03
Ps90%/90% (+KTL) Biased	2.23E-01	2.24E-01	2.24E-01	2.25E-01	2.24E-01	2.23E-01	2.23E-01
Ps90%/90% (-KTL) Biased	2.15E-01	2.14E-01	2.15E-01	2.15E-01	2.14E-01	2.14E-01	2.14E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	2.20E-01	2.20E-01	2.20E-01	2.20E-01	2.19E-01	2.19E-01	2.19E-01
Std Dev Un-Biased	1.45E-03	1.36E-03	1.20E-03	1.35E-03	1.34E-03	1.26E-03	1.43E-03
Ps90%/90% (+KTL) Un-Biased	2.24E-01	2.23E-01	2.23E-01	2.24E-01	2.23E-01	2.22E-01	2.23E-01
Ps90%/90% (-KTL) Un-Biased	2.16E-01	2.16E-01	2.17E-01	2.16E-01	2.16E-01	2.15E-01	2.15E-01
<b>Specification MAX</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

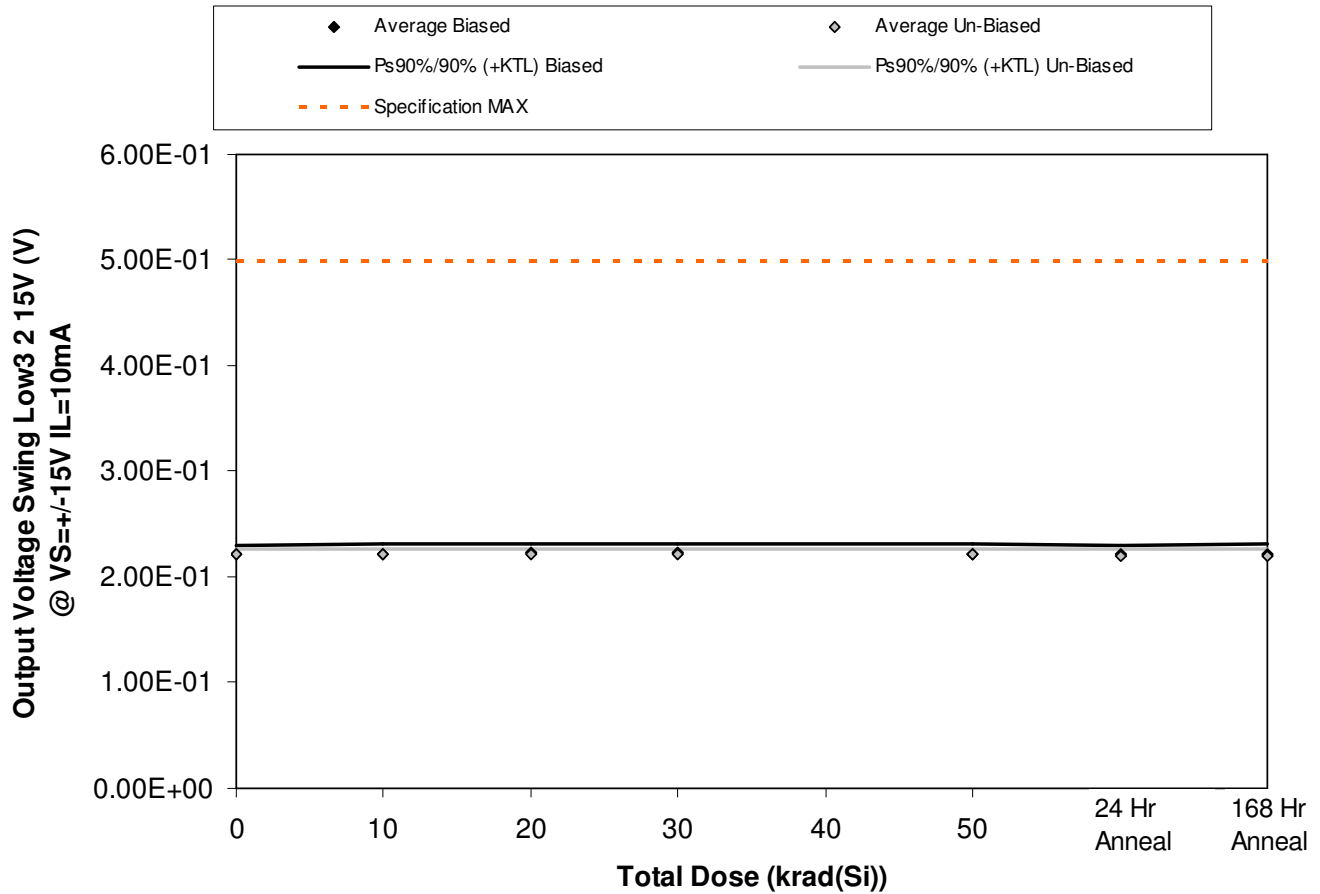


Figure 5.72. Plot of Output Voltage Swing Low3 2 15V (V) @ VS=+-15V IL=10mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.72. Raw data for Output Voltage Swing Low3 2 15V (V) @ VS=+-15V IL=10mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low3 2 15V (V) @ VS=+-15V IL=10mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.16E-01	2.16E-01	2.17E-01	2.17E-01	2.17E-01	2.16E-01	2.16E-01
563	2.24E-01	2.23E-01	2.24E-01	2.24E-01	2.24E-01	2.23E-01	2.24E-01
564	2.23E-01	2.24E-01	2.24E-01	2.25E-01	2.24E-01	2.23E-01	2.24E-01
567	2.22E-01	2.24E-01	2.24E-01	2.24E-01	2.23E-01	2.23E-01	2.23E-01
569	2.22E-01	2.23E-01	2.23E-01	2.23E-01	2.22E-01	2.21E-01	2.22E-01
570	2.23E-01	2.23E-01	2.23E-01	2.23E-01	2.22E-01	2.22E-01	2.22E-01
571	2.21E-01	2.20E-01	2.21E-01	2.21E-01	2.21E-01	2.20E-01	2.20E-01
572	2.20E-01	2.20E-01	2.20E-01	2.20E-01	2.19E-01	2.19E-01	2.19E-01
573	2.24E-01	2.24E-01	2.24E-01	2.24E-01	2.23E-01	2.23E-01	2.23E-01
574	2.19E-01	2.18E-01	2.19E-01	2.20E-01	2.19E-01	2.18E-01	2.18E-01
584	2.23E-01	2.24E-01	2.24E-01	2.24E-01	2.23E-01	2.22E-01	2.23E-01
585	2.23E-01	2.23E-01	2.25E-01	2.24E-01	2.24E-01	2.22E-01	2.22E-01
<b>Biased Statistics</b>							
Average Biased	2.22E-01	2.22E-01	2.22E-01	2.23E-01	2.22E-01	2.21E-01	2.22E-01
Std Dev Biased	2.92E-03	3.30E-03	3.08E-03	3.21E-03	3.13E-03	2.96E-03	3.23E-03
Ps90%/90% (+KTL) Biased	2.30E-01	2.31E-01	2.31E-01	2.31E-01	2.31E-01	2.29E-01	2.31E-01
Ps90%/90% (-KTL) Biased	2.14E-01	2.13E-01	2.14E-01	2.14E-01	2.13E-01	2.13E-01	2.13E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	2.21E-01	2.21E-01	2.22E-01	2.22E-01	2.21E-01	2.20E-01	2.20E-01
Std Dev Un-Biased	2.03E-03	2.25E-03	2.01E-03	1.95E-03	2.00E-03	2.09E-03	2.03E-03
Ps90%/90% (+KTL) Un-Biased	2.27E-01	2.27E-01	2.27E-01	2.27E-01	2.26E-01	2.26E-01	2.26E-01
Ps90%/90% (-KTL) Un-Biased	2.16E-01	2.15E-01	2.16E-01	2.16E-01	2.15E-01	2.15E-01	2.15E-01
<b>Specification MAX</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

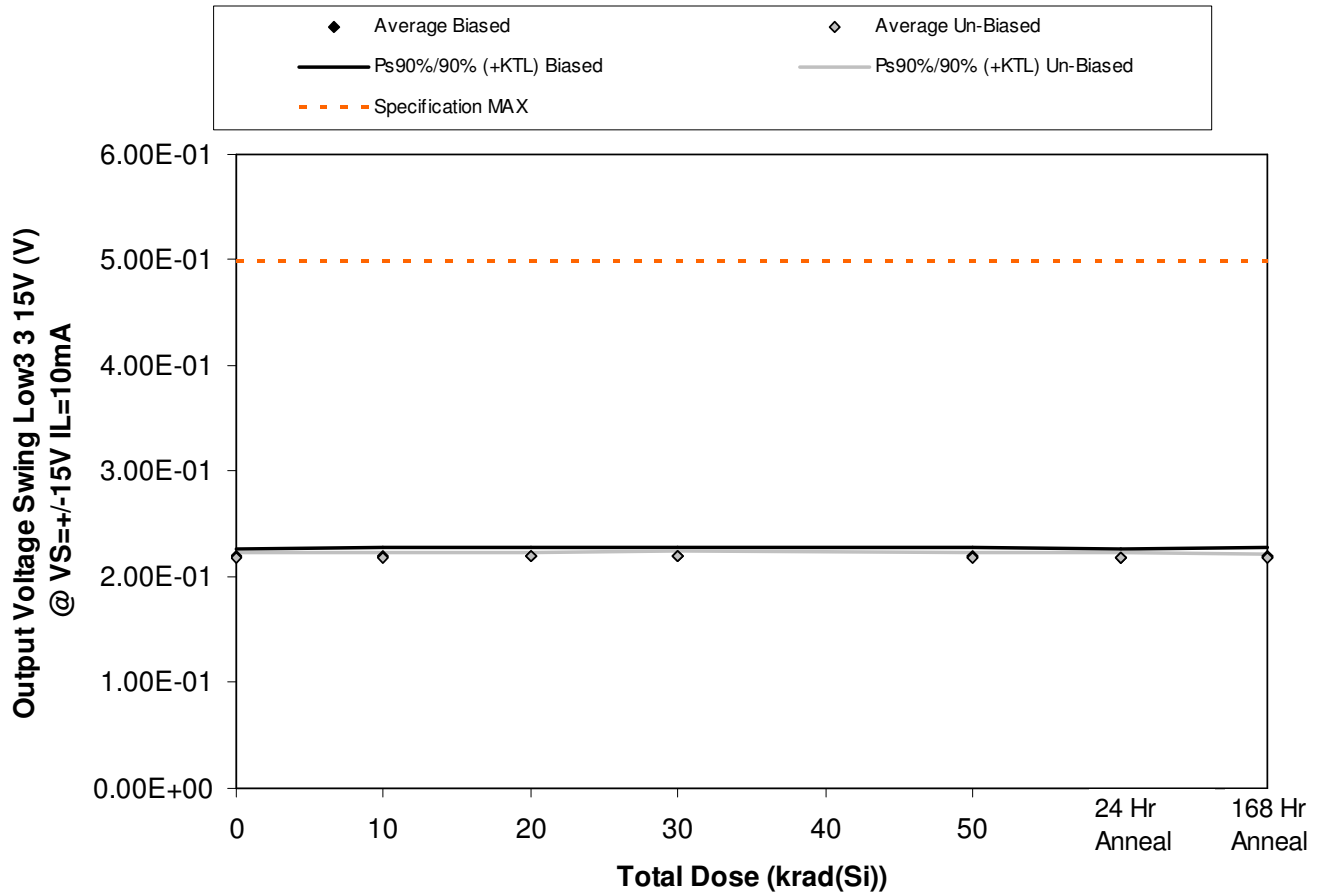


Figure 5.73. Plot of Output Voltage Swing Low3 3 15V (V) @ VS=+-15V IL=10mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.73. Raw data for Output Voltage Swing Low3 3 15V (V) @ VS=+/-15V IL=10mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low3 3 15V (V) @ VS=+/-15V IL=10mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.14E-01	2.15E-01	2.15E-01	2.15E-01	2.15E-01	2.14E-01	2.14E-01
563	2.21E-01	2.22E-01	2.21E-01	2.22E-01	2.21E-01	2.20E-01	2.21E-01
564	2.21E-01	2.22E-01	2.22E-01	2.22E-01	2.22E-01	2.21E-01	2.22E-01
567	2.20E-01	2.21E-01	2.21E-01	2.21E-01	2.21E-01	2.20E-01	2.20E-01
569	2.20E-01	2.21E-01	2.21E-01	2.21E-01	2.20E-01	2.20E-01	2.20E-01
570	2.20E-01	2.20E-01	2.20E-01	2.20E-01	2.19E-01	2.19E-01	2.19E-01
571	2.19E-01	2.19E-01	2.19E-01	2.20E-01	2.20E-01	2.18E-01	2.18E-01
572	2.18E-01	2.17E-01	2.18E-01	2.18E-01	2.17E-01	2.16E-01	2.17E-01
573	2.20E-01	2.21E-01	2.21E-01	2.22E-01	2.21E-01	2.21E-01	2.20E-01
574	2.17E-01	2.17E-01	2.17E-01	2.17E-01	2.17E-01	2.16E-01	2.16E-01
584	2.20E-01	2.21E-01	2.21E-01	2.21E-01	2.20E-01	2.19E-01	2.19E-01
585	2.20E-01	2.20E-01	2.22E-01	2.21E-01	2.21E-01	2.20E-01	2.20E-01
<b>Biased Statistics</b>							
Average Biased	2.19E-01	2.20E-01	2.20E-01	2.20E-01	2.20E-01	2.19E-01	2.19E-01
Std Dev Biased	2.88E-03	3.00E-03	3.02E-03	3.19E-03	2.92E-03	2.96E-03	3.16E-03
Ps90%/90% (+KTL) Biased	2.27E-01	2.28E-01	2.28E-01	2.29E-01	2.28E-01	2.27E-01	2.28E-01
Ps90%/90% (-KTL) Biased	2.11E-01	2.12E-01	2.12E-01	2.11E-01	2.12E-01	2.11E-01	2.11E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	2.19E-01	2.19E-01	2.19E-01	2.19E-01	2.19E-01	2.18E-01	2.18E-01
Std Dev Un-Biased	1.52E-03	1.67E-03	1.59E-03	1.74E-03	1.65E-03	1.82E-03	1.53E-03
Ps90%/90% (+KTL) Un-Biased	2.23E-01	2.23E-01	2.24E-01	2.24E-01	2.23E-01	2.23E-01	2.22E-01
Ps90%/90% (-KTL) Un-Biased	2.14E-01	2.14E-01	2.15E-01	2.14E-01	2.14E-01	2.13E-01	2.14E-01
<b>Specification MAX</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

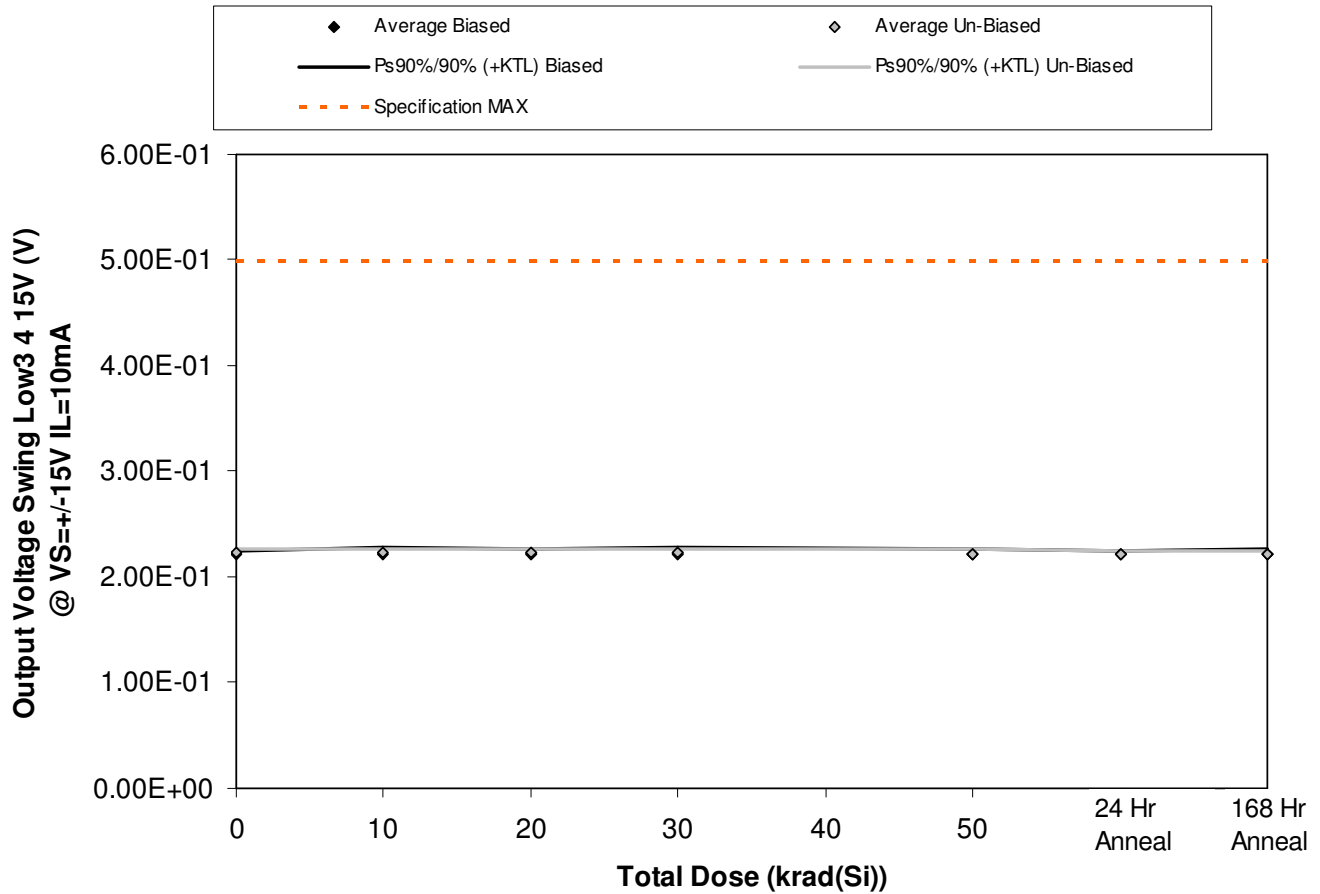


Figure 5.74. Plot of Output Voltage Swing Low3 4 15V (V) @ VS=+-15V IL=10mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.74. Raw data for Output Voltage Swing Low3 4 15V (V) @ VS=+-15V IL=10mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low3 4 15V (V) @ VS=+-15V IL=10mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.19E-01	2.18E-01	2.19E-01	2.19E-01	2.18E-01	2.18E-01	2.18E-01
563	2.21E-01	2.21E-01	2.21E-01	2.22E-01	2.21E-01	2.21E-01	2.21E-01
564	2.22E-01	2.23E-01	2.24E-01	2.24E-01	2.23E-01	2.22E-01	2.23E-01
567	2.22E-01	2.24E-01	2.23E-01	2.24E-01	2.23E-01	2.22E-01	2.23E-01
569	2.21E-01	2.22E-01	2.22E-01	2.22E-01	2.21E-01	2.21E-01	2.21E-01
570	2.22E-01	2.22E-01	2.22E-01	2.22E-01	2.21E-01	2.21E-01	2.21E-01
571	2.22E-01	2.22E-01	2.23E-01	2.23E-01	2.22E-01	2.21E-01	2.22E-01
572	2.24E-01	2.24E-01	2.25E-01	2.24E-01	2.24E-01	2.23E-01	2.24E-01
573	2.23E-01	2.24E-01	2.24E-01	2.24E-01	2.23E-01	2.22E-01	2.22E-01
574	2.21E-01	2.21E-01	2.22E-01	2.21E-01	2.21E-01	2.20E-01	2.21E-01
584	2.19E-01	2.20E-01	2.20E-01	2.20E-01	2.20E-01	2.18E-01	2.19E-01
585	2.21E-01	2.21E-01	2.23E-01	2.22E-01	2.21E-01	2.20E-01	2.21E-01
<b>Biased Statistics</b>							
Average Biased	2.21E-01	2.22E-01	2.22E-01	2.22E-01	2.21E-01	2.21E-01	2.21E-01
Std Dev Biased	1.58E-03	2.07E-03	1.95E-03	2.03E-03	2.14E-03	1.67E-03	1.98E-03
Ps90%/90% (+KTL) Biased	2.25E-01	2.27E-01	2.27E-01	2.28E-01	2.27E-01	2.25E-01	2.27E-01
Ps90%/90% (-KTL) Biased	2.17E-01	2.16E-01	2.16E-01	2.17E-01	2.16E-01	2.16E-01	2.16E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	2.23E-01	2.23E-01	2.23E-01	2.23E-01	2.22E-01	2.22E-01	2.22E-01
Std Dev Un-Biased	1.26E-03	1.34E-03	1.20E-03	1.30E-03	1.29E-03	1.04E-03	1.17E-03
Ps90%/90% (+KTL) Un-Biased	2.26E-01	2.26E-01	2.26E-01	2.26E-01	2.26E-01	2.24E-01	2.25E-01
Ps90%/90% (-KTL) Un-Biased	2.19E-01	2.19E-01	2.20E-01	2.19E-01	2.19E-01	2.19E-01	2.19E-01
<b>Specification MAX</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>	<b>5.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



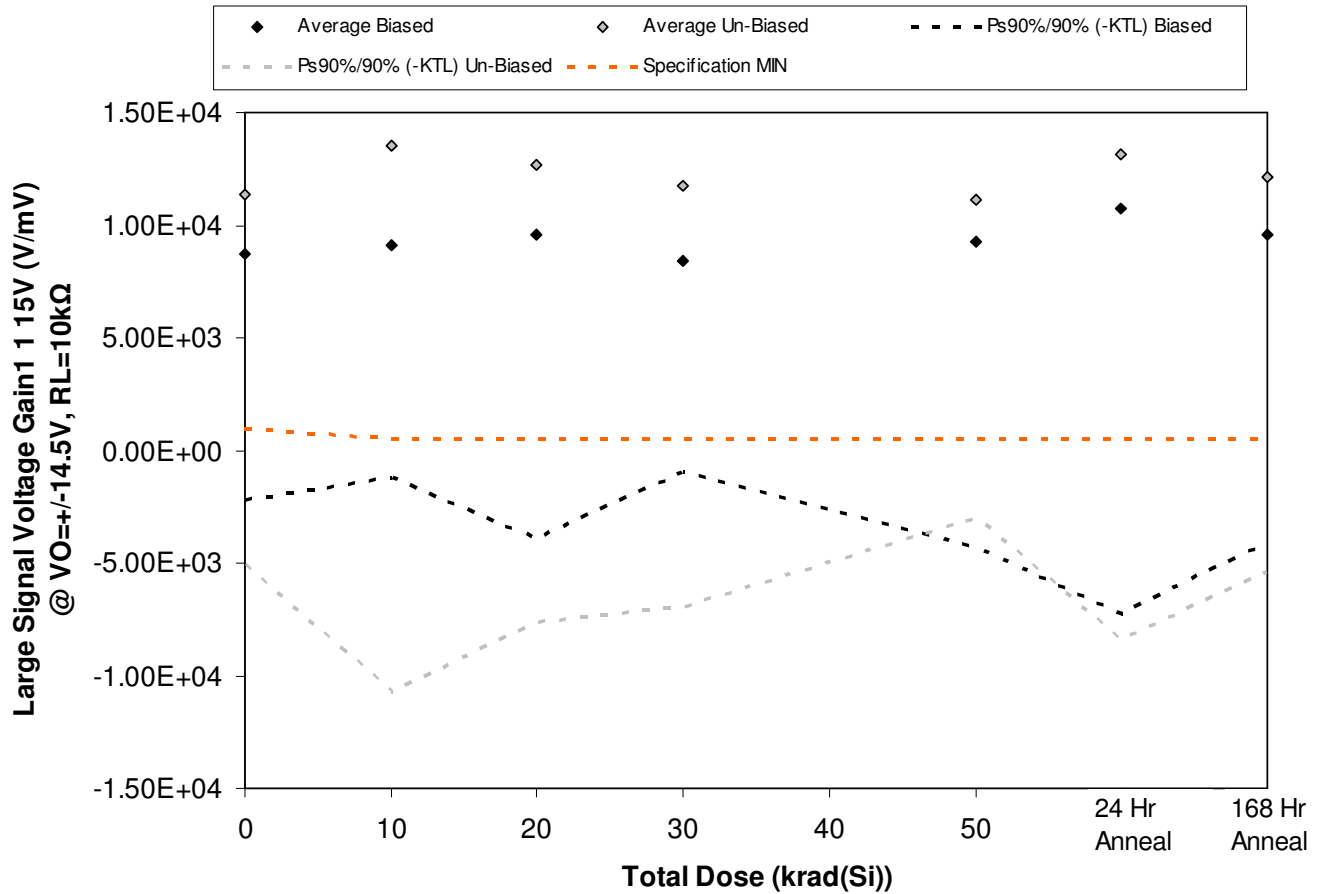


Figure 5.75. Plot of Large Signal Voltage Gain1 1 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.75. Raw data for Large Signal Voltage Gain1 1 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain1 1 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	9.12E+03	1.06E+04	9.89E+03	9.65E+03	8.97E+03	9.92E+03	9.10E+03
563	6.54E+03	6.82E+03	6.69E+03	6.25E+03	7.06E+03	7.83E+03	7.06E+03
564	6.24E+03	6.63E+03	6.56E+03	6.24E+03	6.21E+03	6.98E+03	6.78E+03
567	6.32E+03	6.43E+03	6.79E+03	6.07E+03	6.14E+03	6.59E+03	6.55E+03
569	1.56E+04	1.51E+04	1.81E+04	1.39E+04	1.78E+04	2.22E+04	1.83E+04
570	6.24E+03	6.06E+03	6.31E+03	5.93E+03	6.41E+03	6.36E+03	6.62E+03
571	1.00E+04	1.15E+04	1.14E+04	9.22E+03	9.67E+03	1.04E+04	1.15E+04
572	6.19E+03	5.81E+03	6.15E+03	7.49E+03	7.14E+03	6.55E+03	5.88E+03
573	2.04E+04	2.69E+04	2.40E+04	2.30E+04	1.89E+04	2.45E+04	2.13E+04
574	1.41E+04	1.71E+04	1.56E+04	1.33E+04	1.33E+04	1.78E+04	1.52E+04
584	2.53E+04	3.30E+04	3.34E+04	2.94E+04	5.68E+04	5.24E+04	3.33E+04
585	5.76E+03	5.98E+03	5.80E+03	5.69E+03	6.68E+03	6.60E+03	5.94E+03
<b>Biased Statistics</b>							
Average Biased	8.75E+03	9.11E+03	9.60E+03	8.42E+03	9.24E+03	1.07E+04	9.55E+03
Std Dev Biased	3.99E+03	3.76E+03	4.93E+03	3.41E+03	4.94E+03	6.55E+03	4.98E+03
Ps90%/90% (+KTL) Biased	1.97E+04	1.94E+04	2.31E+04	1.78E+04	2.28E+04	2.87E+04	2.32E+04
Ps90%/90% (-KTL) Biased	-2.18E+03	-1.19E+03	-3.92E+03	-9.37E+02	-4.30E+03	-7.26E+03	-4.10E+03
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.14E+04	1.35E+04	1.27E+04	1.18E+04	1.11E+04	1.31E+04	1.21E+04
Std Dev Un-Biased	6.01E+03	8.84E+03	7.42E+03	6.83E+03	5.15E+03	7.85E+03	6.39E+03
Ps90%/90% (+KTL) Un-Biased	2.79E+04	3.77E+04	3.30E+04	3.05E+04	2.52E+04	3.46E+04	2.96E+04
Ps90%/90% (-KTL) Un-Biased	-5.08E+03	-1.07E+04	-7.67E+03	-6.95E+03	-3.02E+03	-8.40E+03	-5.40E+03
<b>Specification MIN</b>	<b>1.00E+03</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

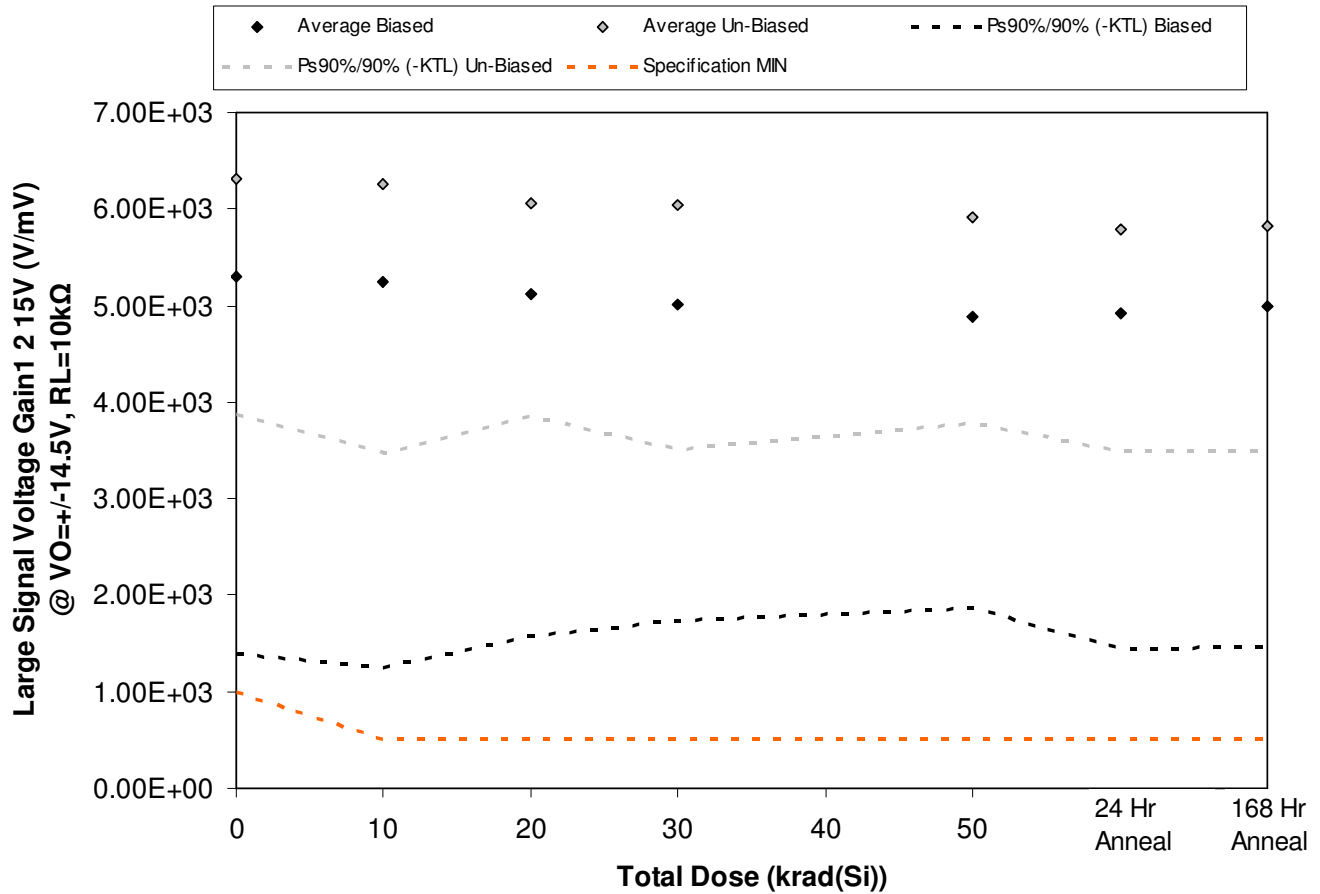


Figure 5.76. Plot of Large Signal Voltage Gain1 2 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.76. Raw data for Large Signal Voltage Gain1 2 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain1 2 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.74E+03	3.70E+03	3.67E+03	3.68E+03	3.82E+03	3.48E+03	3.59E+03
563	6.62E+03	5.95E+03	6.01E+03	5.87E+03	5.75E+03	5.84E+03	5.82E+03
564	5.82E+03	6.18E+03	6.19E+03	5.92E+03	5.77E+03	6.08E+03	5.97E+03
567	6.52E+03	6.73E+03	5.99E+03	5.88E+03	5.53E+03	5.58E+03	6.03E+03
569	3.82E+03	3.65E+03	3.75E+03	3.74E+03	3.55E+03	3.61E+03	3.60E+03
570	6.54E+03	6.49E+03	6.46E+03	6.29E+03	6.10E+03	6.06E+03	5.93E+03
571	6.62E+03	6.90E+03	6.24E+03	6.33E+03	6.36E+03	5.92E+03	6.21E+03
572	4.74E+03	4.48E+03	4.64E+03	4.43E+03	4.54E+03	4.33E+03	4.36E+03
573	6.88E+03	6.51E+03	6.37E+03	6.44E+03	6.17E+03	6.19E+03	6.08E+03
574	6.80E+03	6.91E+03	6.58E+03	6.76E+03	6.39E+03	6.45E+03	6.56E+03
584	5.55E+03	3.70E+03	3.71E+03	3.71E+03	3.70E+03	3.34E+03	3.67E+03
585	3.74E+03	3.67E+03	3.66E+03	3.65E+03	3.68E+03	3.65E+03	3.64E+03
<b>Biased Statistics</b>							
Average Biased	5.30E+03	5.24E+03	5.12E+03	5.02E+03	4.88E+03	4.92E+03	5.00E+03
Std Dev Biased	1.42E+03	1.46E+03	1.29E+03	1.20E+03	1.10E+03	1.27E+03	1.29E+03
Ps90%/90% (+KTL) Biased	9.21E+03	9.23E+03	8.66E+03	8.30E+03	7.91E+03	8.39E+03	8.53E+03
Ps90%/90% (-KTL) Biased	1.40E+03	1.25E+03	1.58E+03	1.74E+03	1.86E+03	1.44E+03	1.47E+03
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.31E+03	6.26E+03	6.06E+03	6.05E+03	5.91E+03	5.79E+03	5.83E+03
Std Dev Un-Biased	8.90E+02	1.02E+03	8.03E+02	9.26E+02	7.78E+02	8.41E+02	8.53E+02
Ps90%/90% (+KTL) Un-Biased	8.75E+03	9.05E+03	8.26E+03	8.59E+03	8.05E+03	8.10E+03	8.17E+03
Ps90%/90% (-KTL) Un-Biased	3.87E+03	3.47E+03	3.85E+03	3.51E+03	3.78E+03	3.48E+03	3.49E+03
<b>Specification MIN</b>	<b>1.00E+03</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

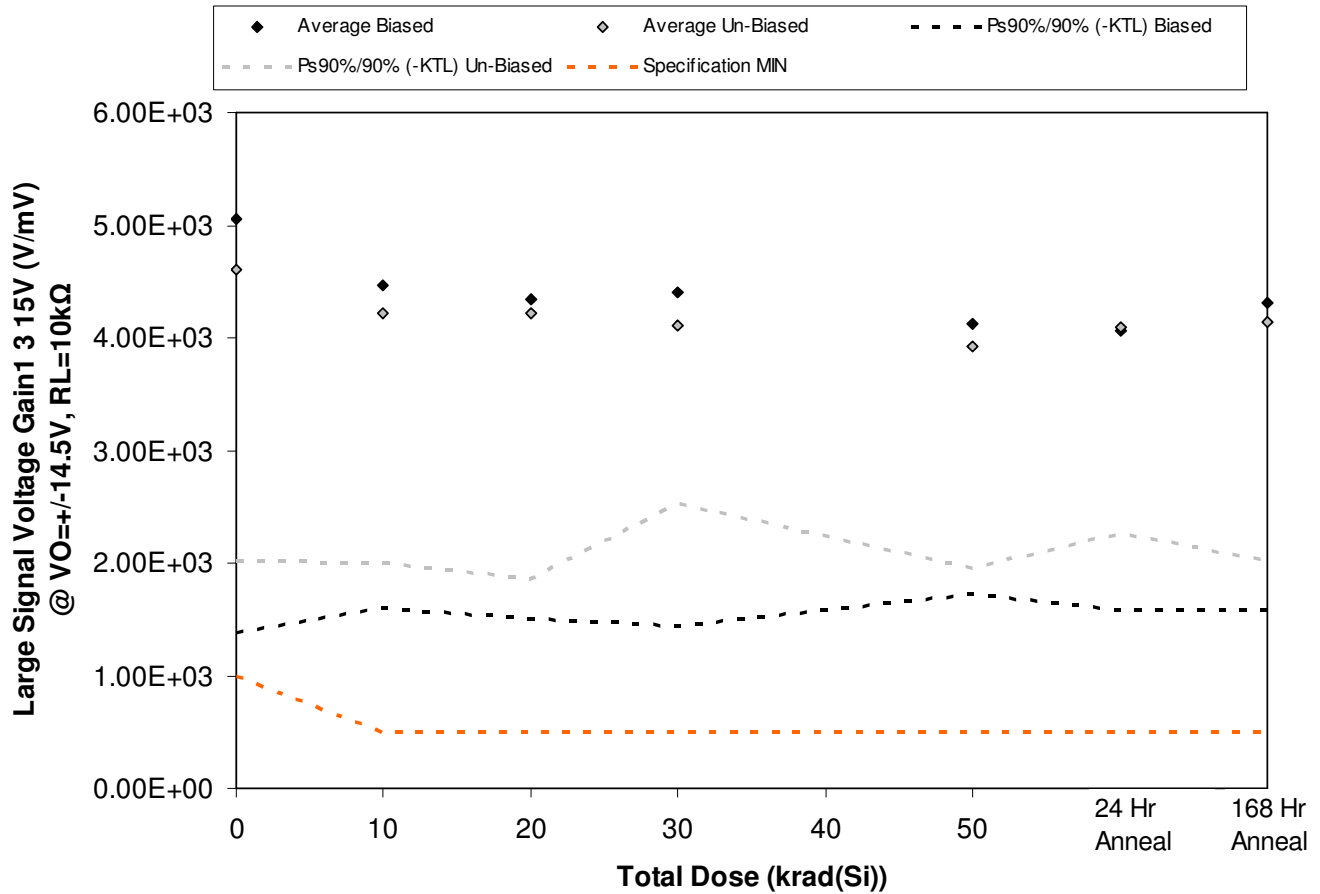


Figure 5.77. Plot of Large Signal Voltage Gain1 3 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.77. Raw data for Large Signal Voltage Gain1 3 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain1 3 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.99E+03	3.67E+03	3.65E+03	3.65E+03	3.54E+03	3.42E+03	3.52E+03
563	4.02E+03	3.55E+03	3.39E+03	3.56E+03	3.41E+03	3.33E+03	3.51E+03
564	4.44E+03	4.06E+03	3.91E+03	3.85E+03	3.65E+03	3.61E+03	3.89E+03
567	5.70E+03	5.02E+03	4.88E+03	4.83E+03	4.59E+03	4.51E+03	4.82E+03
569	7.09E+03	6.03E+03	5.90E+03	6.11E+03	5.46E+03	5.46E+03	5.82E+03
570	4.20E+03	3.78E+03	3.83E+03	3.93E+03	3.63E+03	3.83E+03	3.73E+03
571	4.15E+03	3.91E+03	3.68E+03	3.81E+03	3.48E+03	3.84E+03	3.85E+03
572	4.22E+03	3.78E+03	3.88E+03	3.81E+03	3.68E+03	3.71E+03	3.78E+03
573	4.18E+03	3.97E+03	3.95E+03	3.84E+03	3.62E+03	3.81E+03	3.81E+03
574	6.30E+03	5.65E+03	5.74E+03	5.13E+03	5.21E+03	5.29E+03	5.52E+03
584	7.16E+03	6.34E+03	6.31E+03	6.23E+03	6.31E+03	6.19E+03	6.06E+03
585	4.00E+03	3.82E+03	3.84E+03	3.78E+03	3.68E+03	3.74E+03	3.76E+03
<b>Biased Statistics</b>							
Average Biased	5.05E+03	4.46E+03	4.34E+03	4.40E+03	4.13E+03	4.07E+03	4.31E+03
Std Dev Biased	1.34E+03	1.05E+03	1.03E+03	1.08E+03	8.76E+02	9.08E+02	9.96E+02
Ps90%/90% (+KTL) Biased	8.71E+03	7.34E+03	7.18E+03	7.36E+03	6.53E+03	6.56E+03	7.04E+03
Ps90%/90% (-KTL) Biased	1.38E+03	1.59E+03	1.51E+03	1.44E+03	1.73E+03	1.58E+03	1.58E+03
<b>Un-Biased Statistics</b>							
Average Un-Biased	4.61E+03	4.22E+03	4.22E+03	4.10E+03	3.92E+03	4.10E+03	4.14E+03
Std Dev Un-Biased	9.46E+02	8.06E+02	8.60E+02	5.75E+02	7.21E+02	6.70E+02	7.73E+02
Ps90%/90% (+KTL) Un-Biased	7.20E+03	6.43E+03	6.57E+03	5.68E+03	5.90E+03	5.93E+03	6.26E+03
Ps90%/90% (-KTL) Un-Biased	2.02E+03	2.01E+03	1.86E+03	2.53E+03	1.95E+03	2.26E+03	2.02E+03
<b>Specification MIN</b>	<b>1.00E+03</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

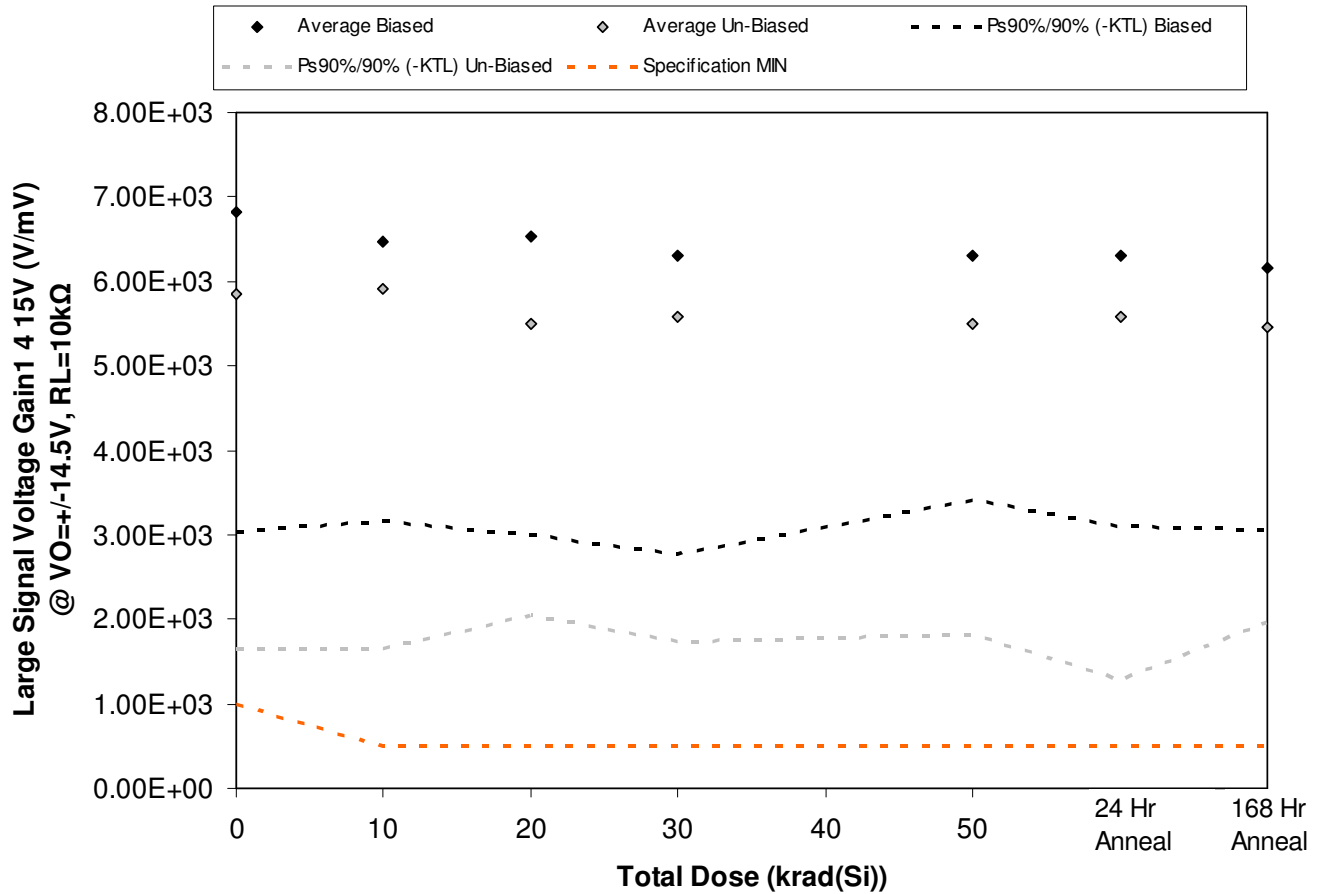


Figure 5.78. Plot of Large Signal Voltage Gain1 4 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.78. Raw data for Large Signal Voltage Gain1 4 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain1 4 15V (V/mV) @ VO=+/-14.5V, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	7.10E+03	6.78E+03	6.71E+03	7.09E+03	6.37E+03	6.81E+03	6.41E+03
563	7.76E+03	7.29E+03	7.61E+03	7.14E+03	6.97E+03	6.92E+03	6.59E+03
564	4.39E+03	4.34E+03	4.31E+03	4.04E+03	4.50E+03	4.22E+03	4.17E+03
567	7.41E+03	7.05E+03	7.21E+03	6.61E+03	7.15E+03	6.69E+03	6.98E+03
569	7.41E+03	6.88E+03	6.86E+03	6.63E+03	6.55E+03	6.93E+03	6.64E+03
570	6.90E+03	6.96E+03	6.58E+03	6.54E+03	6.71E+03	6.77E+03	6.69E+03
571	4.24E+03	4.34E+03	4.15E+03	4.07E+03	3.95E+03	3.88E+03	4.08E+03
572	7.34E+03	7.22E+03	6.20E+03	6.56E+03	6.51E+03	7.15E+03	6.10E+03
573	4.17E+03	4.08E+03	4.13E+03	4.03E+03	4.15E+03	3.93E+03	4.09E+03
574	6.64E+03	6.91E+03	6.49E+03	6.71E+03	6.18E+03	6.16E+03	6.36E+03
584	4.56E+03	4.32E+03	4.32E+03	4.42E+03	4.48E+03	4.46E+03	4.44E+03
585	4.03E+03	3.99E+03	3.99E+03	3.95E+03	4.09E+03	4.18E+03	3.97E+03
<b>Biased Statistics</b>							
Average Biased	6.81E+03	6.47E+03	6.54E+03	6.30E+03	6.31E+03	6.31E+03	6.16E+03
Std Dev Biased	1.38E+03	1.21E+03	1.29E+03	1.29E+03	1.06E+03	1.17E+03	1.13E+03
Ps90%/90% (+KTL) Biased	1.06E+04	9.77E+03	1.01E+04	9.83E+03	9.21E+03	9.53E+03	9.26E+03
Ps90%/90% (-KTL) Biased	3.04E+03	3.16E+03	2.99E+03	2.77E+03	3.40E+03	3.10E+03	3.06E+03
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.86E+03	5.90E+03	5.51E+03	5.58E+03	5.50E+03	5.58E+03	5.46E+03
Std Dev Un-Biased	1.53E+03	1.55E+03	1.26E+03	1.40E+03	1.34E+03	1.57E+03	1.28E+03
Ps90%/90% (+KTL) Un-Biased	1.01E+04	1.02E+04	8.96E+03	9.42E+03	9.17E+03	9.88E+03	8.97E+03
Ps90%/90% (-KTL) Un-Biased	1.66E+03	1.65E+03	2.05E+03	1.75E+03	1.83E+03	1.28E+03	1.96E+03
<b>Specification MIN</b>	<b>1.00E+03</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>	<b>5.00E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



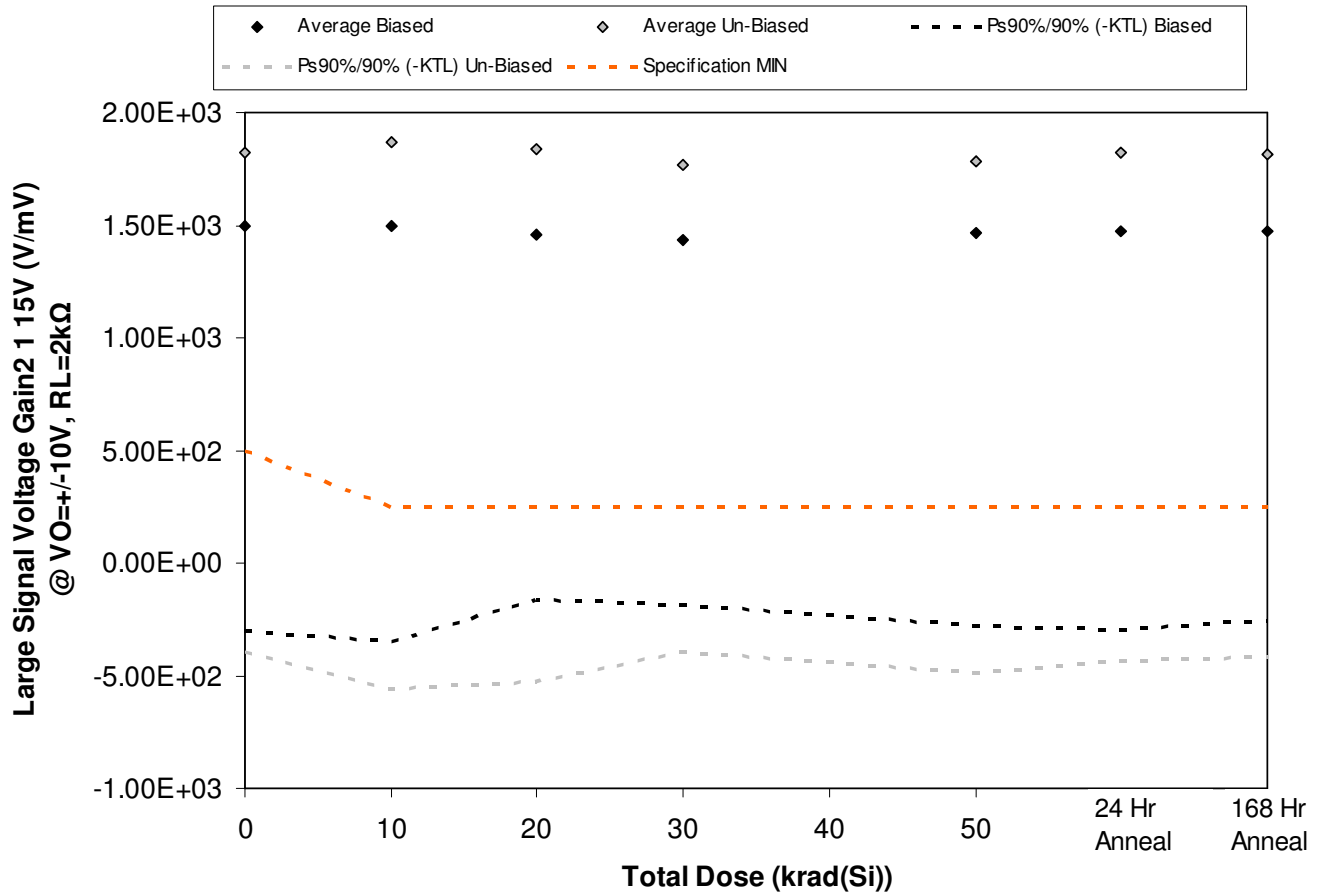


Figure 5.79. Plot of Large Signal Voltage Gain2 1 15V (V/mV) @ VO=+-10V, RL=2kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.79. Raw data for Large Signal Voltage Gain2 1 15V (V/mV) @ VO=+/-10V, RL=2kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain2 1 15V (V/mV) @ VO=+/-10V, RL=2kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.50E+03	1.51E+03	1.50E+03	1.46E+03	1.47E+03	1.46E+03	1.49E+03
563	1.11E+03	1.10E+03	1.10E+03	1.08E+03	1.08E+03	1.09E+03	1.10E+03
564	1.12E+03	1.11E+03	1.12E+03	1.11E+03	1.10E+03	1.11E+03	1.12E+03
567	1.12E+03	1.11E+03	1.09E+03	1.08E+03	1.10E+03	1.10E+03	1.10E+03
569	2.63E+03	2.67E+03	2.46E+03	2.46E+03	2.56E+03	2.59E+03	2.56E+03
570	1.08E+03	1.10E+03	1.09E+03	1.09E+03	1.07E+03	1.08E+03	1.09E+03
571	1.60E+03	1.63E+03	1.62E+03	1.59E+03	1.57E+03	1.63E+03	1.61E+03
572	1.08E+03	1.01E+03	9.94E+02	9.68E+02	9.75E+02	1.03E+03	1.03E+03
573	2.77E+03	2.86E+03	2.81E+03	2.65E+03	2.76E+03	2.74E+03	2.74E+03
574	2.58E+03	2.73E+03	2.69E+03	2.53E+03	2.56E+03	2.62E+03	2.60E+03
584	3.02E+03	3.09E+03	3.15E+03	3.09E+03	3.39E+03	3.19E+03	3.16E+03
585	1.00E+03	1.01E+03	1.01E+03	1.01E+03	1.04E+03	1.04E+03	1.01E+03
<b>Biased Statistics</b>							
Average Biased	1.50E+03	1.50E+03	1.45E+03	1.44E+03	1.46E+03	1.47E+03	1.47E+03
Std Dev Biased	6.57E+02	6.75E+02	5.91E+02	5.92E+02	6.35E+02	6.45E+02	6.30E+02
Ps90%/90% (+KTL) Biased	3.30E+03	3.35E+03	3.07E+03	3.06E+03	3.20E+03	3.24E+03	3.20E+03
Ps90%/90% (-KTL) Biased	-3.05E+02	-3.50E+02	-1.66E+02	-1.89E+02	-2.80E+02	-2.98E+02	-2.52E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.82E+03	1.87E+03	1.84E+03	1.77E+03	1.79E+03	1.82E+03	1.81E+03
Std Dev Un-Biased	8.09E+02	8.82E+02	8.63E+02	7.88E+02	8.28E+02	8.22E+02	8.13E+02
Ps90%/90% (+KTL) Un-Biased	4.04E+03	4.28E+03	4.21E+03	3.93E+03	4.06E+03	4.07E+03	4.04E+03
Ps90%/90% (-KTL) Un-Biased	-3.95E+02	-5.54E+02	-5.29E+02	-3.95E+02	-4.85E+02	-4.32E+02	-4.15E+02
<b>Specification MIN</b>	<b>5.00E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

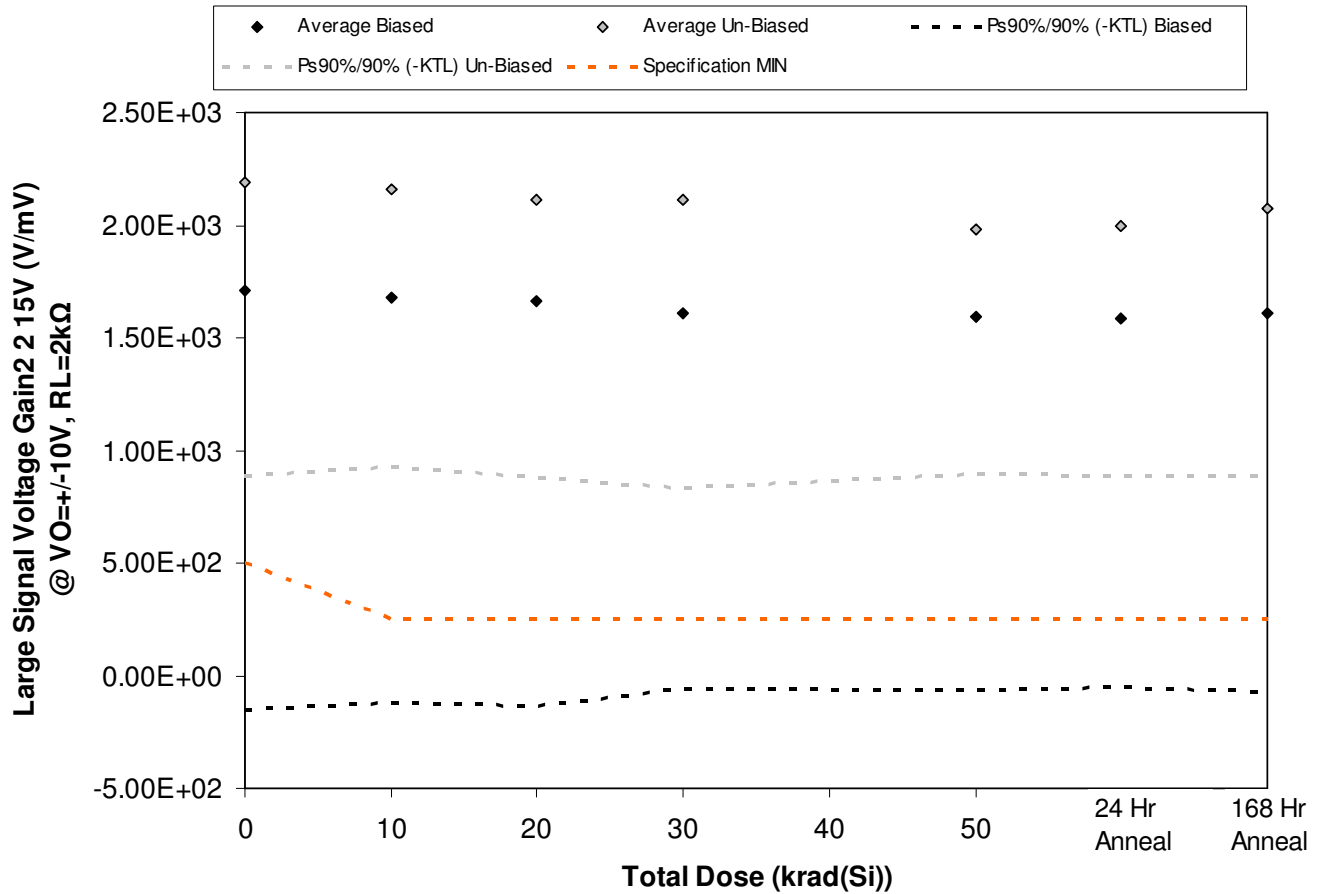


Figure 5.80. Plot of Large Signal Voltage Gain2 2 15V (V/mV) @ VO=+-10V, RL=2kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.80. Raw data for Large Signal Voltage Gain2 2 15V (V/mV) @ VO=+/-10V, RL=2kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain2 2 15V (V/mV) @ VO=+/-10V, RL=2kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	9.79E+02	9.69E+02	9.60E+02	9.54E+02	9.28E+02	9.44E+02	9.45E+02
563	2.20E+03	2.12E+03	2.08E+03	2.10E+03	2.10E+03	2.02E+03	2.08E+03
564	2.18E+03	2.16E+03	2.12E+03	1.98E+03	2.02E+03	2.03E+03	2.01E+03
567	2.23E+03	2.19E+03	2.23E+03	2.07E+03	1.97E+03	2.03E+03	2.07E+03
569	9.55E+02	9.48E+02	9.33E+02	9.33E+02	9.31E+02	9.21E+02	9.25E+02
570	2.40E+03	2.33E+03	2.31E+03	2.22E+03	2.12E+03	2.21E+03	2.31E+03
571	2.38E+03	2.36E+03	2.28E+03	2.48E+03	2.19E+03	2.10E+03	2.17E+03
572	1.34E+03	1.36E+03	1.31E+03	1.30E+03	1.27E+03	1.28E+03	1.31E+03
573	2.44E+03	2.36E+03	2.34E+03	2.30E+03	2.14E+03	2.19E+03	2.30E+03
574	2.39E+03	2.40E+03	2.30E+03	2.27E+03	2.16E+03	2.18E+03	2.28E+03
584	9.64E+02	9.66E+02	9.61E+02	1.01E+03	9.63E+02	9.60E+02	9.66E+02
585	9.48E+02	9.40E+02	9.33E+02	9.41E+02	9.43E+02	9.44E+02	9.46E+02
<b>Biased Statistics</b>							
Average Biased	1.71E+03	1.68E+03	1.66E+03	1.61E+03	1.59E+03	1.59E+03	1.61E+03
Std Dev Biased	6.78E+02	6.57E+02	6.58E+02	6.06E+02	6.05E+02	5.97E+02	6.13E+02
Ps90%/90% (+KTL) Biased	3.57E+03	3.48E+03	3.47E+03	3.27E+03	3.25E+03	3.22E+03	3.29E+03
Ps90%/90% (-KTL) Biased	-1.49E+02	-1.23E+02	-1.39E+02	-5.63E+01	-6.77E+01	-5.06E+01	-7.54E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	2.19E+03	2.16E+03	2.11E+03	2.11E+03	1.98E+03	1.99E+03	2.07E+03
Std Dev Un-Biased	4.74E+02	4.49E+02	4.49E+02	4.65E+02	3.96E+02	4.02E+02	4.30E+02
Ps90%/90% (+KTL) Un-Biased	3.49E+03	3.39E+03	3.34E+03	3.39E+03	3.06E+03	3.09E+03	3.25E+03
Ps90%/90% (-KTL) Un-Biased	8.89E+02	9.30E+02	8.79E+02	8.36E+02	8.93E+02	8.91E+02	8.91E+02
<b>Specification MIN</b>	<b>5.00E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

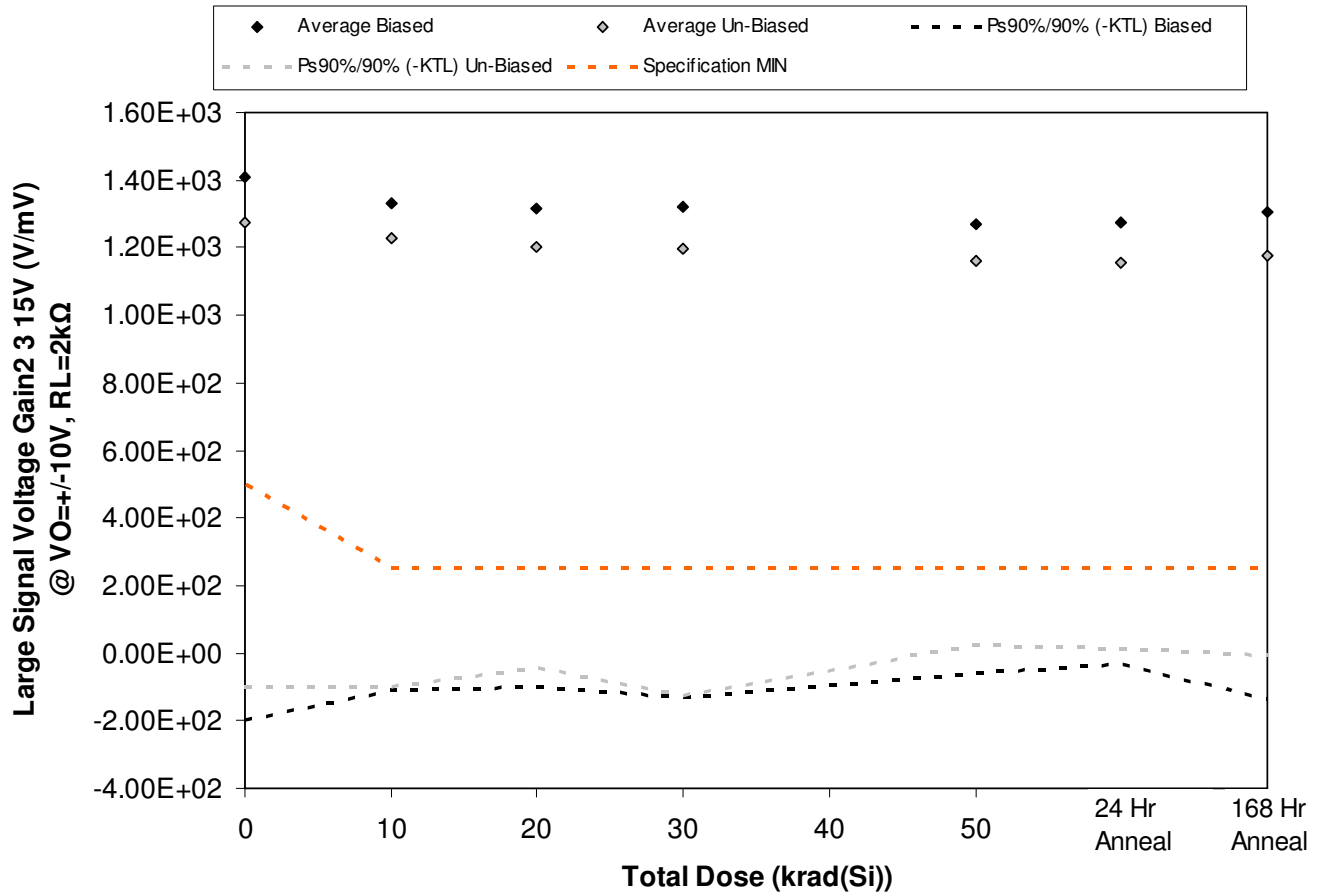


Figure 5.81. Plot of Large Signal Voltage Gain2 3 15V (V/mV) @ VO=+-10V, RL=2kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.81. Raw data for Large Signal Voltage Gain2 3 15V (V/mV) @ VO=+/-10V, RL=2kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain2 3 15V (V/mV) @ VO=+/-10V, RL=2kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.03E+03	1.01E+03	9.96E+02	9.70E+02	9.57E+02	9.62E+02	9.85E+02
563	9.72E+02	9.41E+02	9.29E+02	9.37E+02	9.24E+02	9.22E+02	9.13E+02
564	1.12E+03	1.07E+03	1.07E+03	1.06E+03	1.03E+03	1.04E+03	1.04E+03
567	1.54E+03	1.43E+03	1.41E+03	1.44E+03	1.37E+03	1.38E+03	1.41E+03
569	2.38E+03	2.21E+03	2.18E+03	2.20E+03	2.08E+03	2.06E+03	2.18E+03
570	1.06E+03	1.02E+03	9.96E+02	9.59E+02	9.71E+02	9.81E+02	9.77E+02
571	1.03E+03	1.00E+03	9.85E+02	9.88E+02	9.62E+02	9.54E+02	9.80E+02
572	1.07E+03	1.04E+03	1.03E+03	1.01E+03	1.01E+03	9.95E+02	1.01E+03
573	1.03E+03	9.92E+02	9.93E+02	9.72E+02	9.59E+02	9.52E+02	9.77E+02
574	2.17E+03	2.10E+03	2.02E+03	2.06E+03	1.90E+03	1.90E+03	1.95E+03
584	2.46E+03	2.32E+03	2.31E+03	2.30E+03	2.32E+03	2.29E+03	2.30E+03
585	9.82E+02	9.64E+02	9.65E+02	9.70E+02	9.71E+02	9.62E+02	9.70E+02
<b>Biased Statistics</b>							
Average Biased	1.41E+03	1.33E+03	1.32E+03	1.32E+03	1.27E+03	1.27E+03	1.31E+03
Std Dev Biased	5.86E+02	5.25E+02	5.15E+02	5.31E+02	4.84E+02	4.77E+02	5.25E+02
Ps90%/90% (+KTL) Biased	3.01E+03	2.77E+03	2.73E+03	2.78E+03	2.60E+03	2.58E+03	2.75E+03
Ps90%/90% (-KTL) Biased	-1.99E+02	-1.09E+02	-9.83E+01	-1.34E+02	-5.68E+01	-3.52E+01	-1.34E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.27E+03	1.23E+03	1.20E+03	1.20E+03	1.16E+03	1.16E+03	1.18E+03
Std Dev Un-Biased	5.01E+02	4.84E+02	4.55E+02	4.82E+02	4.16E+02	4.17E+02	4.32E+02
Ps90%/90% (+KTL) Un-Biased	2.65E+03	2.56E+03	2.45E+03	2.52E+03	2.30E+03	2.30E+03	2.36E+03
Ps90%/90% (-KTL) Un-Biased	-1.01E+02	-9.82E+01	-4.40E+01	-1.26E+02	2.21E+01	1.45E+01	-6.84E+00
<b>Specification MIN</b>	<b>5.00E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

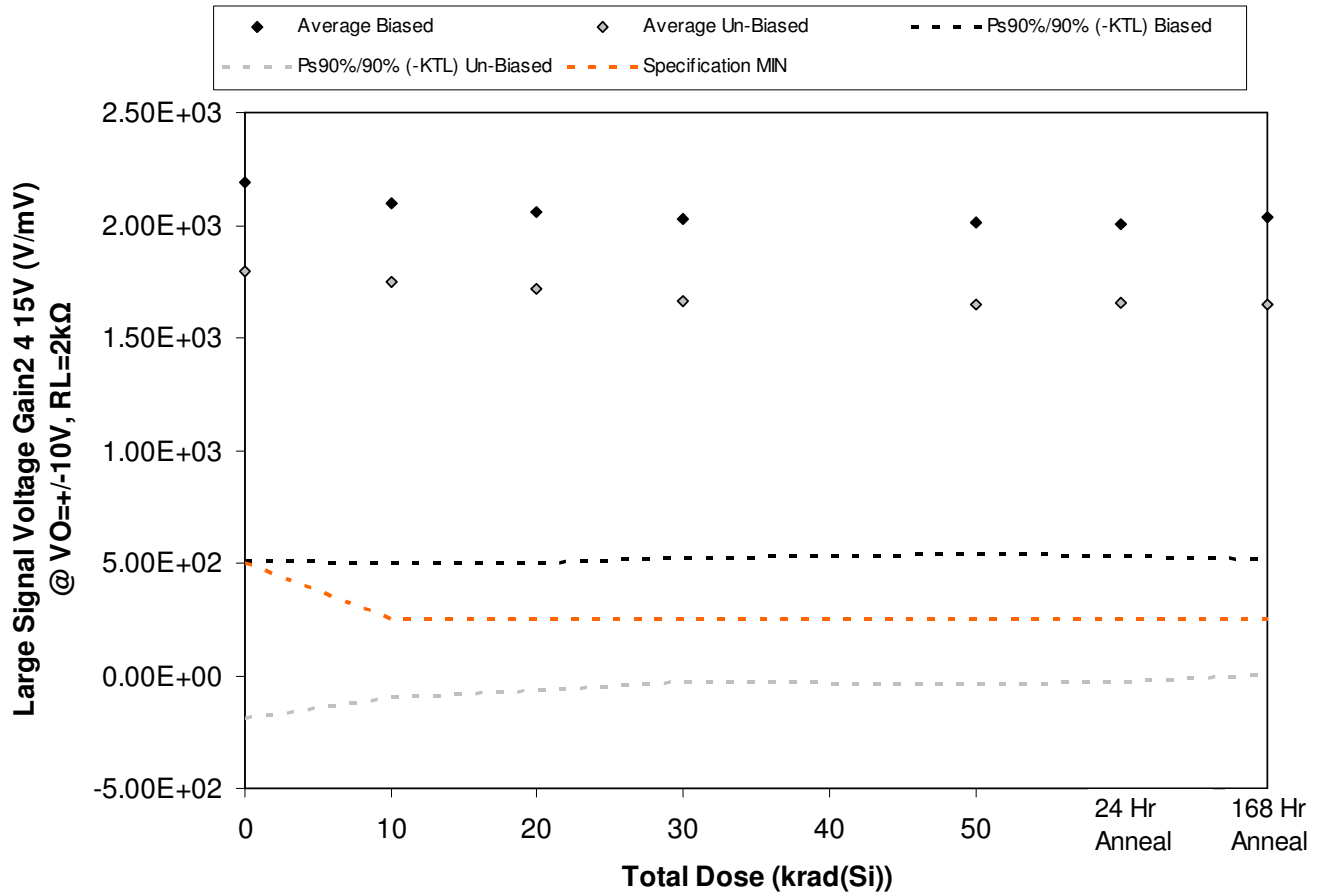


Figure 5.82. Plot of Large Signal Voltage Gain2 4 15V (V/mV) @ VO=+-10V, RL=2kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.82. Raw data for Large Signal Voltage Gain2 4 15V (V/mV) @ VO=+/-10V, RL=2kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain2 4 15V (V/mV) @ VO=+/-10V, RL=2kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.40E+03	2.34E+03	2.27E+03	2.24E+03	2.20E+03	2.24E+03	2.27E+03
563	2.53E+03	2.40E+03	2.39E+03	2.34E+03	2.29E+03	2.22E+03	2.30E+03
564	1.09E+03	1.06E+03	1.05E+03	1.05E+03	1.05E+03	1.05E+03	1.05E+03
567	2.42E+03	2.38E+03	2.24E+03	2.22E+03	2.28E+03	2.24E+03	2.29E+03
569	2.49E+03	2.30E+03	2.33E+03	2.29E+03	2.25E+03	2.28E+03	2.28E+03
570	2.42E+03	2.29E+03	2.21E+03	2.15E+03	2.12E+03	2.13E+03	2.03E+03
571	1.03E+03	1.04E+03	1.03E+03	1.02E+03	1.01E+03	1.01E+03	1.02E+03
572	2.36E+03	2.24E+03	2.29E+03	2.17E+03	2.12E+03	2.16E+03	2.17E+03
573	9.85E+02	9.91E+02	9.88E+02	9.59E+02	9.49E+02	9.60E+02	9.68E+02
574	2.18E+03	2.18E+03	2.08E+03	2.03E+03	2.05E+03	2.01E+03	2.03E+03
584	1.08E+03	1.07E+03	1.07E+03	1.06E+03	1.08E+03	1.08E+03	1.07E+03
585	9.62E+02	9.62E+02	9.60E+02	9.64E+02	9.66E+02	9.76E+02	9.64E+02
<b>Biased Statistics</b>							
Average Biased	2.19E+03	2.10E+03	2.06E+03	2.03E+03	2.01E+03	2.01E+03	2.04E+03
Std Dev Biased	6.14E+02	5.81E+02	5.66E+02	5.49E+02	5.38E+02	5.37E+02	5.55E+02
Ps90%/90% (+KTL) Biased	3.87E+03	3.69E+03	3.61E+03	3.53E+03	3.49E+03	3.48E+03	3.56E+03
Ps90%/90% (-KTL) Biased	5.04E+02	5.03E+02	5.03E+02	5.22E+02	5.38E+02	5.34E+02	5.16E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.79E+03	1.75E+03	1.72E+03	1.67E+03	1.65E+03	1.65E+03	1.65E+03
Std Dev Un-Biased	7.24E+02	6.72E+02	6.52E+02	6.19E+02	6.15E+02	6.13E+02	5.98E+02
Ps90%/90% (+KTL) Un-Biased	3.78E+03	3.59E+03	3.51E+03	3.36E+03	3.34E+03	3.33E+03	3.28E+03
Ps90%/90% (-KTL) Un-Biased	-1.91E+02	-9.33E+01	-6.83E+01	-3.06E+01	-3.60E+01	-2.70E+01	5.92E+00
<b>Specification MIN</b>	<b>5.00E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>	<b>2.50E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



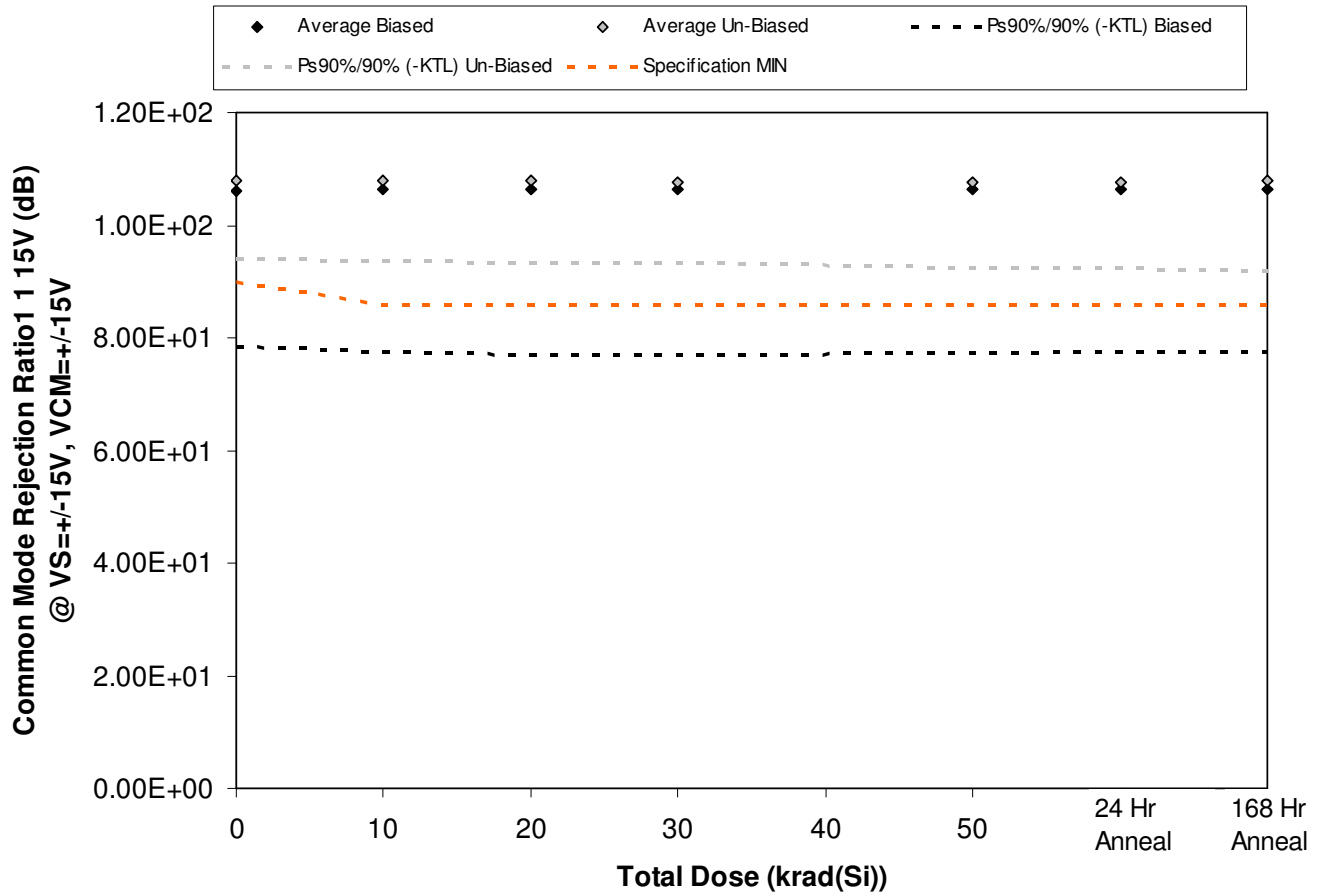


Figure 5.83. Plot of Common Mode Rejection Ratio 1 15V (dB) @ VS= $\pm$ 15V, VCM= $\pm$ 15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.83. Raw data for Common Mode Rejection Ratio1 1 15V (dB) @ VS=+/-15V, VCM=+/-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Common Mode Rejection Ratio1 1 15V (dB) @ VS=+/-15V, VCM=+/-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.01E+02
563	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02
564	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
567	1.23E+02	1.24E+02	1.25E+02	1.25E+02	1.25E+02	1.24E+02	1.24E+02
569	9.85E+01	9.85E+01	9.85E+01	9.85E+01	9.84E+01	9.84E+01	9.85E+01
570	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.12E+02	1.12E+02	1.13E+02
571	1.04E+02	1.04E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02
572	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.01E+02	1.01E+02	1.02E+02
573	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.14E+02	1.14E+02	1.15E+02
574	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.07E+02	1.07E+02
584	1.04E+02	1.04E+02	1.04E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02
585	1.09E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02
<b>Biased Statistics</b>							
Average Biased	1.06E+02	1.06E+02	1.06E+02	1.07E+02	1.06E+02	1.06E+02	1.06E+02
Std Dev Biased	1.01E+01	1.05E+01	1.08E+01	1.08E+01	1.06E+01	1.04E+01	1.05E+01
Ps90%/90% (+KTL) Biased	1.34E+02	1.35E+02	1.36E+02	1.36E+02	1.36E+02	1.35E+02	1.35E+02
Ps90%/90% (-KTL) Biased	7.85E+01	7.76E+01	7.68E+01	7.68E+01	7.72E+01	7.76E+01	7.75E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02
Std Dev Un-Biased	5.13E+00	5.20E+00	5.22E+00	5.29E+00	5.53E+00	5.55E+00	5.97E+00
Ps90%/90% (+KTL) Un-Biased	1.22E+02	1.22E+02	1.22E+02	1.22E+02	1.23E+02	1.23E+02	1.24E+02
Ps90%/90% (-KTL) Un-Biased	9.38E+01	9.36E+01	9.34E+01	9.32E+01	9.25E+01	9.24E+01	9.16E+01
<b>Specification MIN</b>	<b>9.00E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

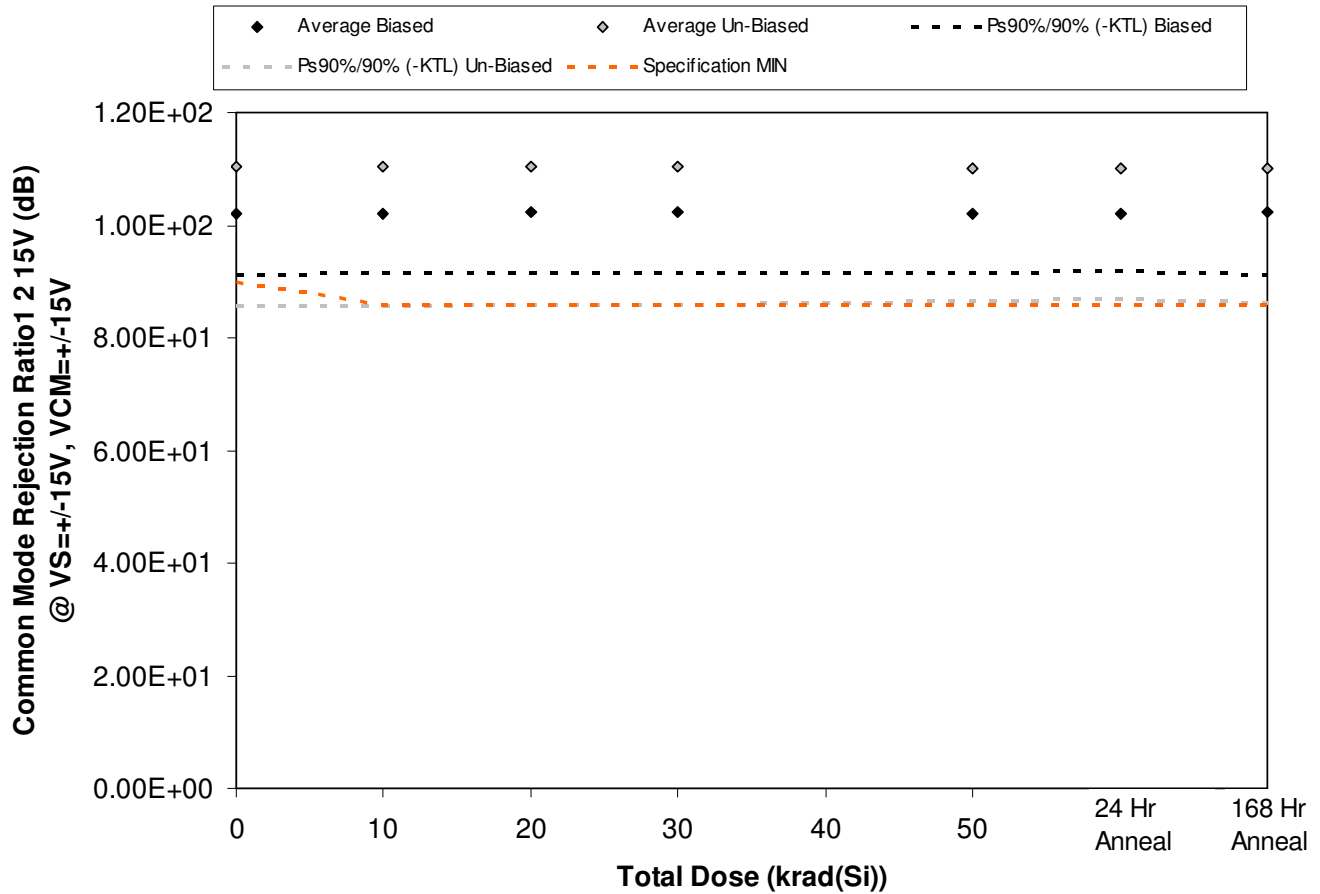


Figure 5.84. Plot of Common Mode Rejection Ratio 1 2 15V (dB) @ VS=+-15V, VCM=+-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.84. Raw data for Common Mode Rejection Ratio1 2 15V (dB) @ VS=+/-15V, VCM=+/-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Common Mode Rejection Ratio1 2 15V (dB) @ VS=+/-15V, VCM=+/-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	9.96E+01	9.96E+01	9.96E+01	9.97E+01	9.97E+01	9.97E+01	9.96E+01
563	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.08E+02
564	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02
567	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
569	9.74E+01	9.74E+01	9.75E+01	9.75E+01	9.75E+01	9.75E+01	9.76E+01
570	1.19E+02	1.19E+02	1.19E+02	1.18E+02	1.17E+02	1.17E+02	1.18E+02
571	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.17E+02	1.17E+02	1.17E+02
572	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
573	1.00E+02	9.99E+01	9.99E+01	9.98E+01	9.97E+01	9.97E+01	9.98E+01
574	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.14E+02	1.15E+02	1.14E+02
584	9.70E+01	9.69E+01	9.69E+01	9.69E+01	9.69E+01	9.69E+01	9.69E+01
585	9.94E+01	9.93E+01	9.93E+01	9.93E+01	9.93E+01	9.92E+01	9.93E+01
<b>Biased Statistics</b>							
Average Biased	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
Std Dev Biased	3.96E+00	3.90E+00	3.89E+00	3.89E+00	3.83E+00	3.82E+00	4.06E+00
Ps90%/90% (+KTL) Biased	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.14E+02
Ps90%/90% (-KTL) Biased	9.13E+01	9.14E+01	9.15E+01	9.15E+01	9.16E+01	9.16E+01	9.12E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.11E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
Std Dev Un-Biased	9.07E+00	9.01E+00	8.95E+00	8.86E+00	8.53E+00	8.46E+00	8.70E+00
Ps90%/90% (+KTL) Un-Biased	1.35E+02	1.35E+02	1.35E+02	1.35E+02	1.33E+02	1.33E+02	1.34E+02
Ps90%/90% (-KTL) Un-Biased	8.56E+01	8.57E+01	8.58E+01	8.60E+01	8.66E+01	8.67E+01	8.63E+01
<b>Specification MIN</b>	<b>9.00E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

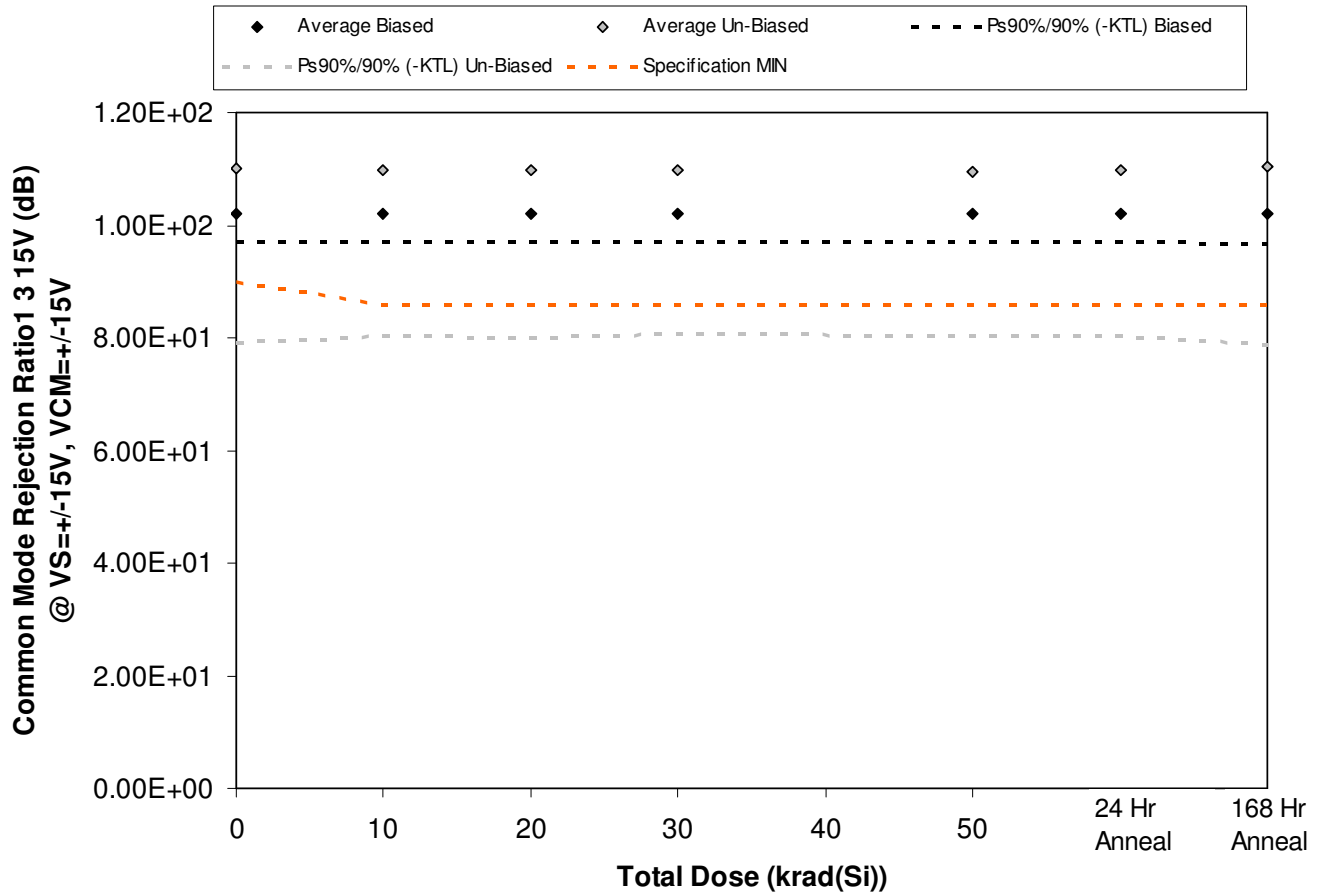


Figure 5.85. Plot of Common Mode Rejection Ratio 1 3 15V (dB) @ VS= $\pm$ 15V, VCM= $\pm$ 15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.85. Raw data for Common Mode Rejection Ratio1 3 15V (dB) @ VS=+/-15V, VCM=+/-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Common Mode Rejection Ratio1 3 15V (dB) @ VS=+/-15V, VCM=+/-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02
563	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
564	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02
567	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
569	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02
570	9.86E+01	9.85E+01	9.85E+01	9.85E+01	9.85E+01	9.85E+01	9.88E+01
571	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02
572	1.26E+02	1.23E+02	1.23E+02	1.22E+02	1.20E+02	1.20E+02	1.20E+02
573	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.07E+02	1.07E+02	1.07E+02
574	1.18E+02	1.18E+02	1.19E+02	1.19E+02	1.21E+02	1.21E+02	1.25E+02
584	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.16E+02	1.16E+02	1.16E+02
585	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02
<b>Biased Statistics</b>							
Average Biased	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
Std Dev Biased	1.85E+00	1.84E+00	1.83E+00	1.85E+00	1.84E+00	1.83E+00	1.96E+00
Ps90%/90% (+KTL) Biased	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02
Ps90%/90% (-KTL) Biased	9.69E+01	9.70E+01	9.70E+01	9.70E+01	9.70E+01	9.70E+01	9.68E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
Std Dev Un-Biased	1.14E+01	1.08E+01	1.08E+01	1.07E+01	1.06E+01	1.07E+01	1.15E+01
Ps90%/90% (+KTL) Un-Biased	1.41E+02	1.39E+02	1.40E+02	1.39E+02	1.39E+02	1.39E+02	1.42E+02
Ps90%/90% (-KTL) Un-Biased	7.90E+01	8.03E+01	8.01E+01	8.05E+01	8.05E+01	8.02E+01	7.88E+01
<b>Specification MIN</b>	<b>9.00E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

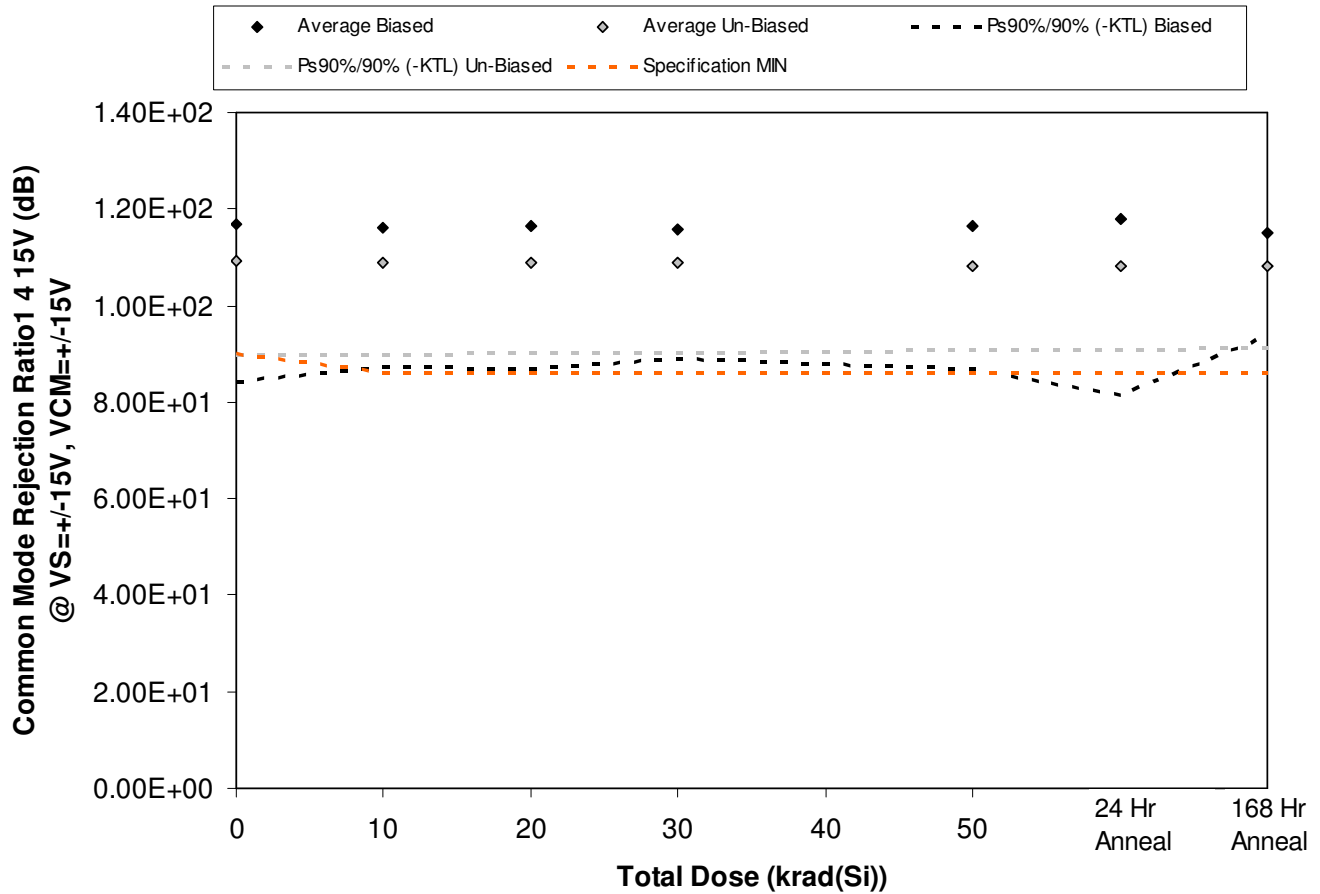


Figure 5.86. Plot of Common Mode Rejection Ratio1 4 15V (dB) @ VS=+-15V, VCM=+-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.86. Raw data for Common Mode Rejection Ratio1 4 15V (dB) @ VS=+/-15V, VCM=+/-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Common Mode Rejection Ratio1 4 15V (dB) @ VS=+/-15V, VCM=+/-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.07E+02	1.07E+02
563	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.09E+02	1.09E+02	1.10E+02
564	1.35E+02	1.32E+02	1.32E+02	1.30E+02	1.32E+02	1.38E+02	1.25E+02
567	1.23E+02	1.23E+02	1.23E+02	1.23E+02	1.24E+02	1.25E+02	1.22E+02
569	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.13E+02
570	1.19E+02	1.19E+02	1.18E+02	1.18E+02	1.17E+02	1.17E+02	1.16E+02
571	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02
572	1.09E+02	1.08E+02	1.08E+02	1.08E+02	1.07E+02	1.07E+02	1.08E+02
573	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.11E+02
574	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02
584	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
585	1.04E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02
<b>Biased Statistics</b>							
Average Biased	1.17E+02	1.16E+02	1.16E+02	1.16E+02	1.17E+02	1.18E+02	1.15E+02
Std Dev Biased	1.20E+01	1.06E+01	1.08E+01	9.87E+00	1.08E+01	1.33E+01	7.91E+00
Ps90%/90% (+KTL) Biased	1.50E+02	1.45E+02	1.46E+02	1.43E+02	1.46E+02	1.54E+02	1.37E+02
Ps90%/90% (-KTL) Biased	8.42E+01	8.72E+01	8.68E+01	8.89E+01	8.69E+01	8.14E+01	9.35E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.08E+02	1.08E+02	1.08E+02
Std Dev Un-Biased	7.01E+00	6.96E+00	6.77E+00	6.81E+00	6.38E+00	6.39E+00	6.11E+00
Ps90%/90% (+KTL) Un-Biased	1.28E+02	1.28E+02	1.27E+02	1.27E+02	1.26E+02	1.26E+02	1.25E+02
Ps90%/90% (-KTL) Un-Biased	8.99E+01	8.99E+01	9.02E+01	9.00E+01	9.07E+01	9.07E+01	9.13E+01
<b>Specification MIN</b>	<b>9.00E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>	<b>8.60E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



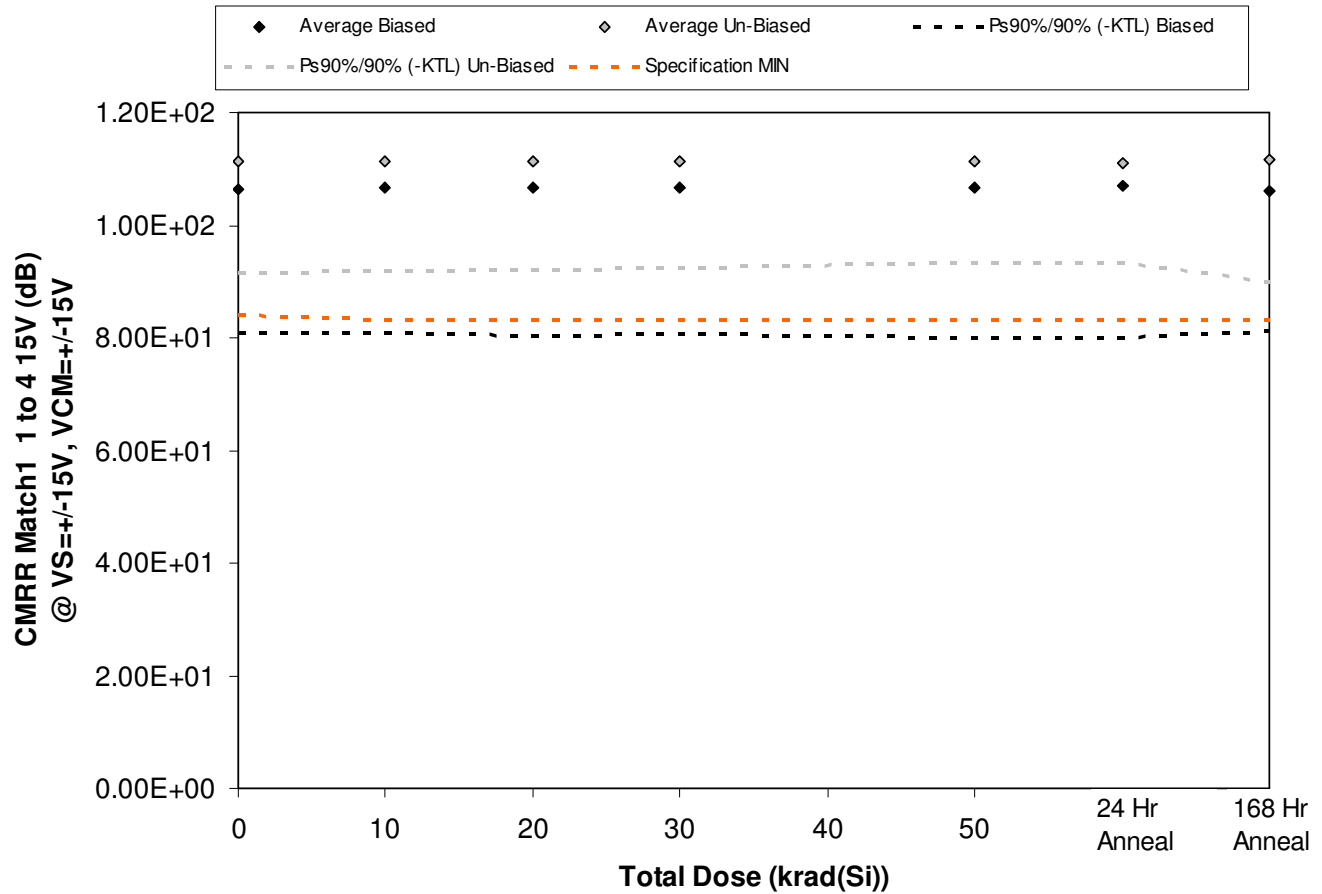


Figure 5.87. Plot of CMRR Match1 1 to 4 15V (dB) @ VS=+-15V, VCM=+-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.87. Raw data for CMRR Match1 1 to 4 15V (dB) @ VS=+/-15V, VCM=+/-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

CMRR Match1 1 to 4 15V (dB) @ VS=+/-15V, VCM=+/-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	9.67E+01	9.68E+01	9.68E+01	9.68E+01	9.69E+01	9.70E+01	9.70E+01
563	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.14E+02
564	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
567	1.17E+02	1.17E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.17E+02
569	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.00E+02
570	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.24E+02
571	1.19E+02	1.19E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.15E+02
572	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.08E+02	1.07E+02	1.08E+02
573	1.06E+02	1.06E+02	1.06E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02
574	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02
584	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02
585	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
<b>Biased Statistics</b>							
Average Biased	1.06E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.06E+02
Std Dev Biased	9.30E+00	9.38E+00	9.56E+00	9.52E+00	9.69E+00	9.81E+00	9.01E+00
Ps90%/90% (+KTL) Biased	1.32E+02	1.32E+02	1.33E+02	1.33E+02	1.33E+02	1.34E+02	1.31E+02
Ps90%/90% (-KTL) Biased	8.10E+01	8.08E+01	8.04E+01	8.05E+01	8.02E+01	8.00E+01	8.14E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.12E+02
Std Dev Un-Biased	7.25E+00	7.10E+00	7.00E+00	6.89E+00	6.59E+00	6.52E+00	7.92E+00
Ps90%/90% (+KTL) Un-Biased	1.31E+02	1.31E+02	1.30E+02	1.30E+02	1.29E+02	1.29E+02	1.33E+02
Ps90%/90% (-KTL) Un-Biased	9.15E+01	9.18E+01	9.21E+01	9.24E+01	9.32E+01	9.33E+01	8.99E+01
<b>Specification MIN</b>	<b>8.40E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

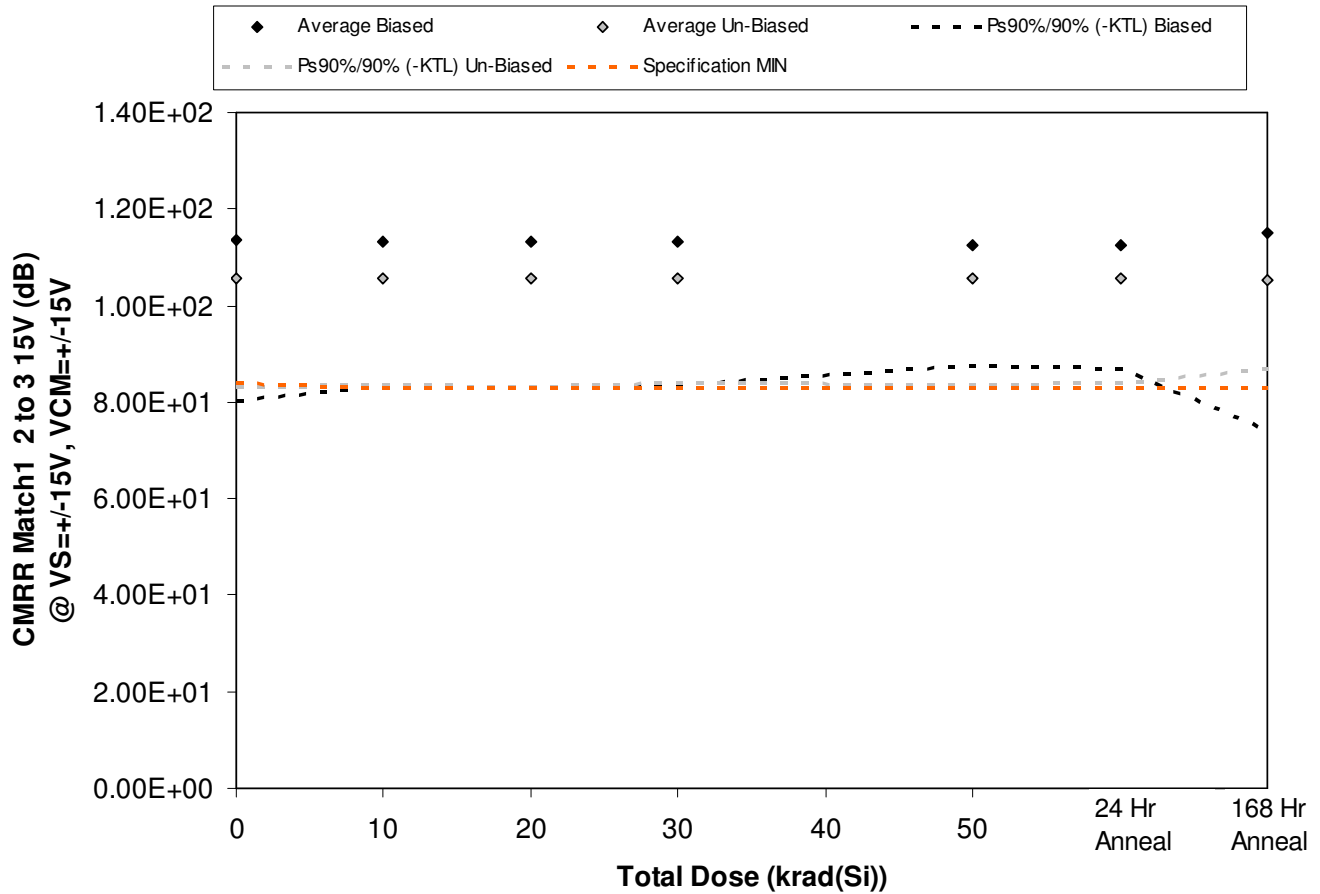


Figure 5.88. Plot of CMRR Match1 2 to 3 15V (dB) @ VS=+-15V, VCM=+-15V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.88. Raw data for CMRR Match1 2 to 3 15V (dB) @ VS=+/-15V, VCM=+/-15V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

CMRR Match1 2 to 3 15V (dB) @ VS=+/-15V, VCM=+/-15V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.16E+02	1.16E+02	1.17E+02	1.17E+02	1.18E+02	1.18E+02	1.17E+02
563	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02
564	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.08E+02
567	1.33E+02	1.30E+02	1.31E+02	1.30E+02	1.25E+02	1.26E+02	1.40E+02
569	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
570	9.94E+01	9.94E+01	9.94E+01	9.94E+01	9.96E+01	9.96E+01	9.98E+01
571	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
572	1.03E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02
573	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.05E+02
574	1.20E+02	1.20E+02	1.20E+02	1.19E+02	1.20E+02	1.20E+02	1.17E+02
584	9.79E+01	9.79E+01	9.78E+01	9.78E+01	9.79E+01	9.79E+01	9.79E+01
585	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02
<b>Biased Statistics</b>							
Average Biased	1.14E+02	1.13E+02	1.13E+02	1.13E+02	1.12E+02	1.13E+02	1.15E+02
Std Dev Biased	1.21E+01	1.09E+01	1.10E+01	1.08E+01	9.10E+00	9.34E+00	1.48E+01
Ps90%/90% (+KTL) Biased	1.47E+02	1.43E+02	1.43E+02	1.43E+02	1.37E+02	1.38E+02	1.56E+02
Ps90%/90% (-KTL) Biased	8.04E+01	8.32E+01	8.30E+01	8.35E+01	8.75E+01	8.70E+01	7.42E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.05E+02
Std Dev Un-Biased	8.24E+00	8.11E+00	8.17E+00	7.89E+00	8.15E+00	8.02E+00	6.83E+00
Ps90%/90% (+KTL) Un-Biased	1.28E+02	1.28E+02	1.28E+02	1.27E+02	1.28E+02	1.28E+02	1.24E+02
Ps90%/90% (-KTL) Un-Biased	8.32E+01	8.34E+01	8.33E+01	8.39E+01	8.34E+01	8.38E+01	8.67E+01
<b>Specification MIN</b>	<b>8.40E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

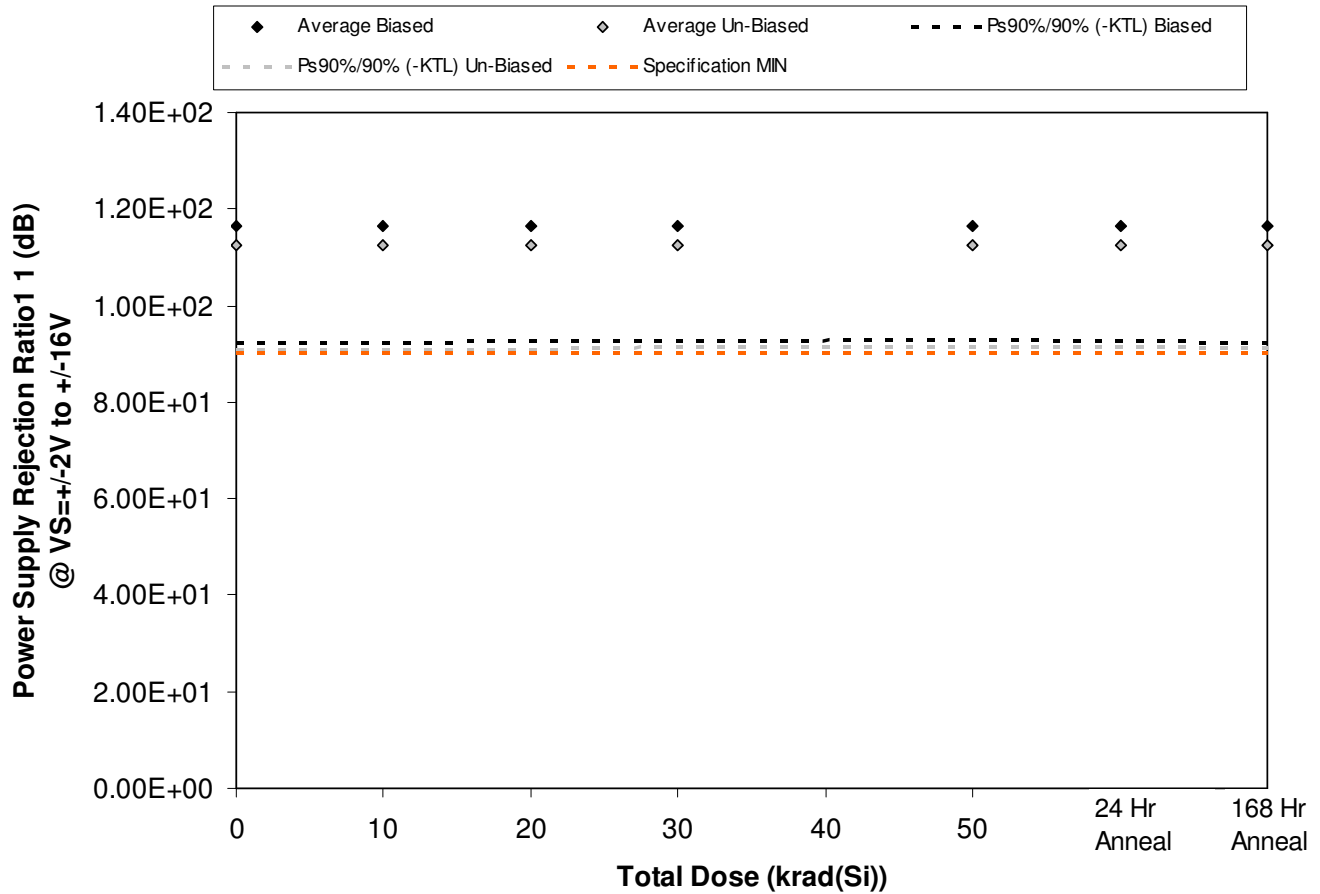


Figure 5.89. Plot of Power Supply Rejection Ratio1 1 (dB) @ VS=+-2V to +/-16V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.89. Raw data for Power Supply Rejection Ratio1 1 (dB) @ VS=+-2V to +/-16V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Power Supply Rejection Ratio1 1 (dB) @ VS=+-2V to +/-16V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02
563	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.08E+02	1.08E+02	1.07E+02
564	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02
567	1.30E+02	1.30E+02	1.30E+02	1.30E+02	1.30E+02	1.30E+02	1.31E+02
569	1.18E+02	1.18E+02	1.18E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02
570	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02
571	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
572	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
573	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02
574	1.26E+02	1.26E+02	1.26E+02	1.26E+02	1.26E+02	1.26E+02	1.26E+02
584	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02
585	1.24E+02	1.24E+02	1.24E+02	1.24E+02	1.24E+02	1.25E+02	1.24E+02
<b>Biased Statistics</b>							
Average Biased	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.17E+02	1.16E+02
Std Dev Biased	8.78E+00	8.74E+00	8.73E+00	8.70E+00	8.59E+00	8.73E+00	8.84E+00
Ps90%/90% (+KTL) Biased	1.40E+02	1.40E+02	1.40E+02	1.40E+02	1.40E+02	1.40E+02	1.41E+02
Ps90%/90% (-KTL) Biased	9.23E+01	9.24E+01	9.24E+01	9.25E+01	9.28E+01	9.26E+01	9.22E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.13E+02	1.12E+02	1.13E+02
Std Dev Un-Biased	7.87E+00	7.88E+00	7.85E+00	7.67E+00	7.70E+00	7.59E+00	7.74E+00
Ps90%/90% (+KTL) Un-Biased	1.34E+02	1.34E+02	1.34E+02	1.33E+02	1.34E+02	1.33E+02	1.34E+02
Ps90%/90% (-KTL) Un-Biased	9.08E+01	9.09E+01	9.10E+01	9.13E+01	9.14E+01	9.17E+01	9.13E+01
<b>Specification MIN</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

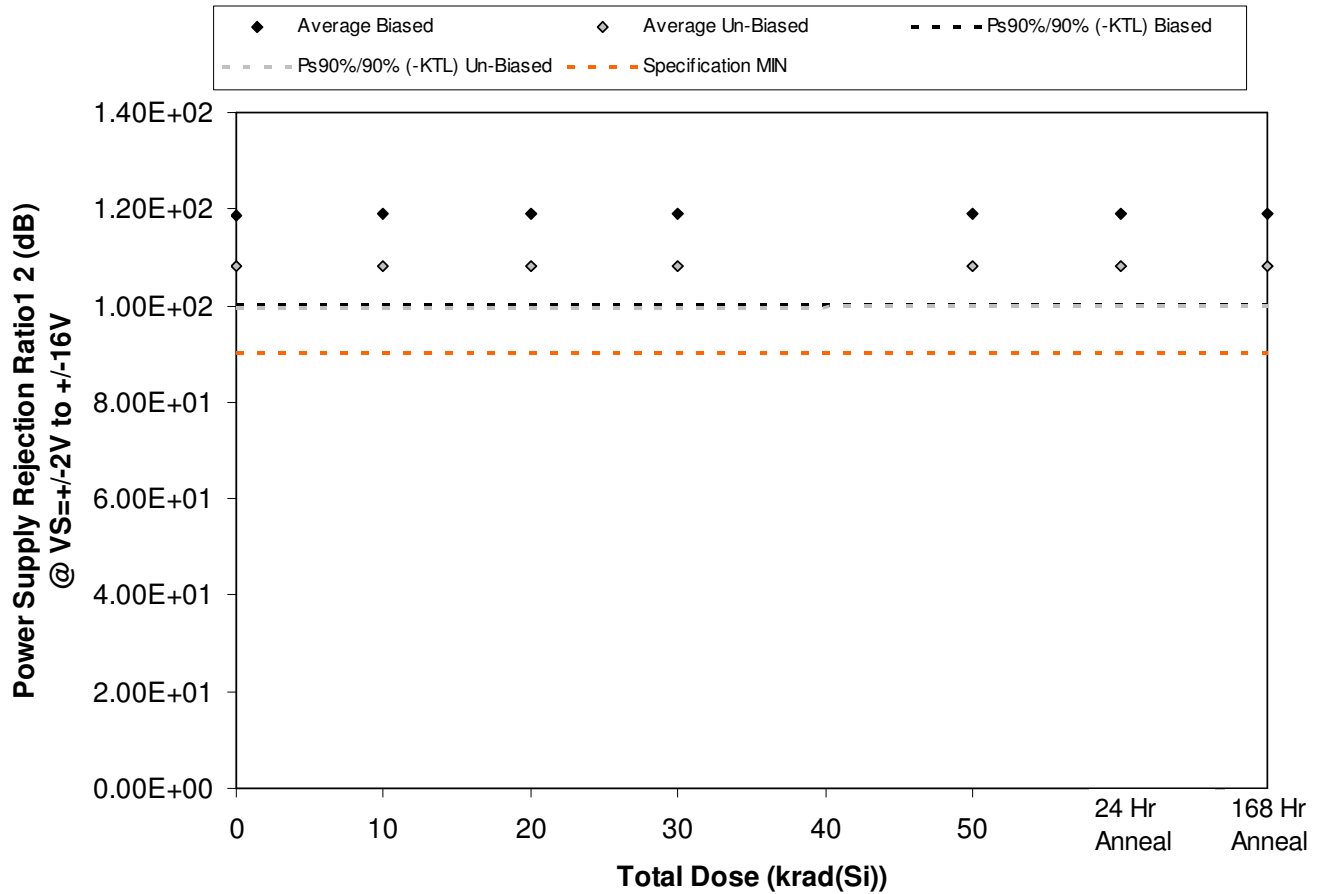


Figure 5.90. Plot of Power Supply Rejection Ratio1 2 (dB) @ VS=+-2V to +/-16V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.90. Raw data for Power Supply Rejection Ratio1 2 (dB) @ VS=+-2V to +/-16V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Power Supply Rejection Ratio1 2 (dB) @ VS=+-2V to +/-16V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.27E+02	1.28E+02	1.27E+02	1.28E+02	1.28E+02	1.27E+02	1.28E+02
563	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02
564	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02
567	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02
569	1.24E+02	1.25E+02	1.25E+02	1.25E+02	1.25E+02	1.25E+02	1.25E+02
570	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02
571	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02
572	1.13E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.13E+02	1.14E+02
573	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.07E+02	1.07E+02	1.07E+02
574	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.05E+02	1.06E+02	1.06E+02
584	1.35E+02	1.35E+02	1.35E+02	1.35E+02	1.36E+02	1.35E+02	1.36E+02
585	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02
<b>Biased Statistics</b>							
Average Biased	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02
Std Dev Biased	6.74E+00	6.84E+00	6.77E+00	6.90E+00	6.90E+00	6.83E+00	6.81E+00
Ps90%/90% (+KTL) Biased	1.37E+02	1.38E+02	1.37E+02	1.38E+02	1.38E+02	1.38E+02	1.38E+02
Ps90%/90% (-KTL) Biased	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02
Std Dev Un-Biased	3.12E+00	3.12E+00	3.15E+00	3.16E+00	3.13E+00	3.07E+00	3.11E+00
Ps90%/90% (+KTL) Un-Biased	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02
Ps90%/90% (-KTL) Un-Biased	9.96E+01	9.97E+01	9.96E+01	9.95E+01	9.97E+01	9.99E+01	9.97E+01
<b>Specification MIN</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



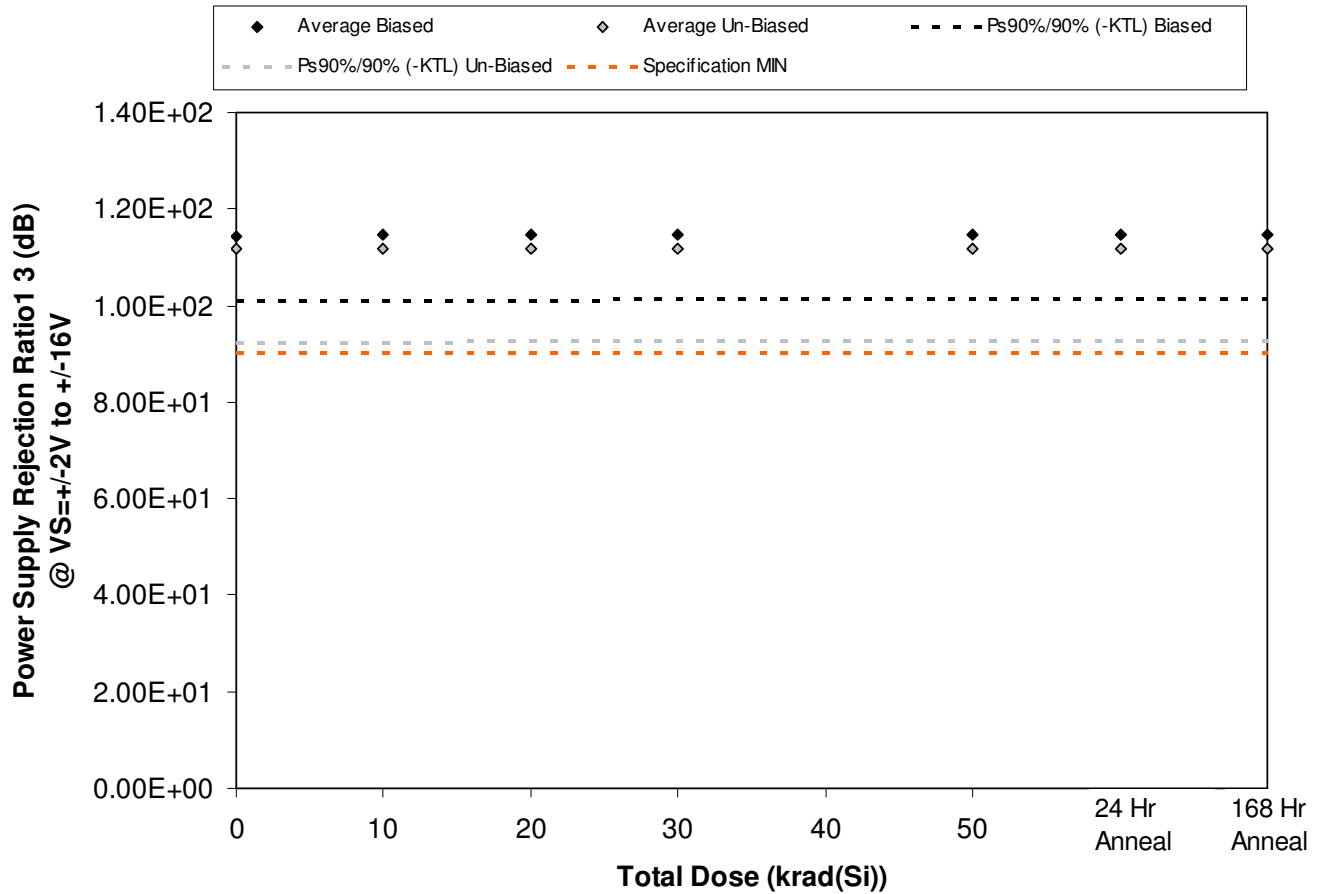


Figure 5.91. Plot of Power Supply Rejection Ratio1 3 (dB) @ VS=+-2V to +/-16V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.91. Raw data for Power Supply Rejection Ratio1 3 (dB) @ VS=+-2V to +/-16V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Power Supply Rejection Ratio1 3 (dB) @ VS=+-2V to +/-16V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.09E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
563	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02
564	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.14E+02	1.14E+02	1.13E+02
567	1.21E+02	1.21E+02	1.21E+02	1.21E+02	1.21E+02	1.21E+02	1.21E+02
569	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.11E+02	1.11E+02	1.10E+02
570	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02
571	1.03E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02
572	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.13E+02	1.13E+02	1.12E+02
573	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02
574	1.22E+02	1.22E+02	1.22E+02	1.22E+02	1.22E+02	1.22E+02	1.22E+02
584	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02
585	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02
<b>Biased Statistics</b>							
Average Biased	1.14E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02
Std Dev Biased	4.92E+00	4.94E+00	4.93E+00	4.87E+00	4.87E+00	4.84E+00	4.90E+00
Ps90%/90% (+KTL) Biased	1.28E+02	1.28E+02	1.28E+02	1.28E+02	1.28E+02	1.28E+02	1.28E+02
Ps90%/90% (-KTL) Biased	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02
Std Dev Un-Biased	7.16E+00	7.07E+00	7.02E+00	7.02E+00	6.98E+00	7.02E+00	7.01E+00
Ps90%/90% (+KTL) Un-Biased	1.31E+02	1.31E+02	1.31E+02	1.31E+02	1.31E+02	1.31E+02	1.31E+02
Ps90%/90% (-KTL) Un-Biased	9.21E+01	9.24E+01	9.25E+01	9.25E+01	9.27E+01	9.27E+01	9.26E+01
<b>Specification MIN</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

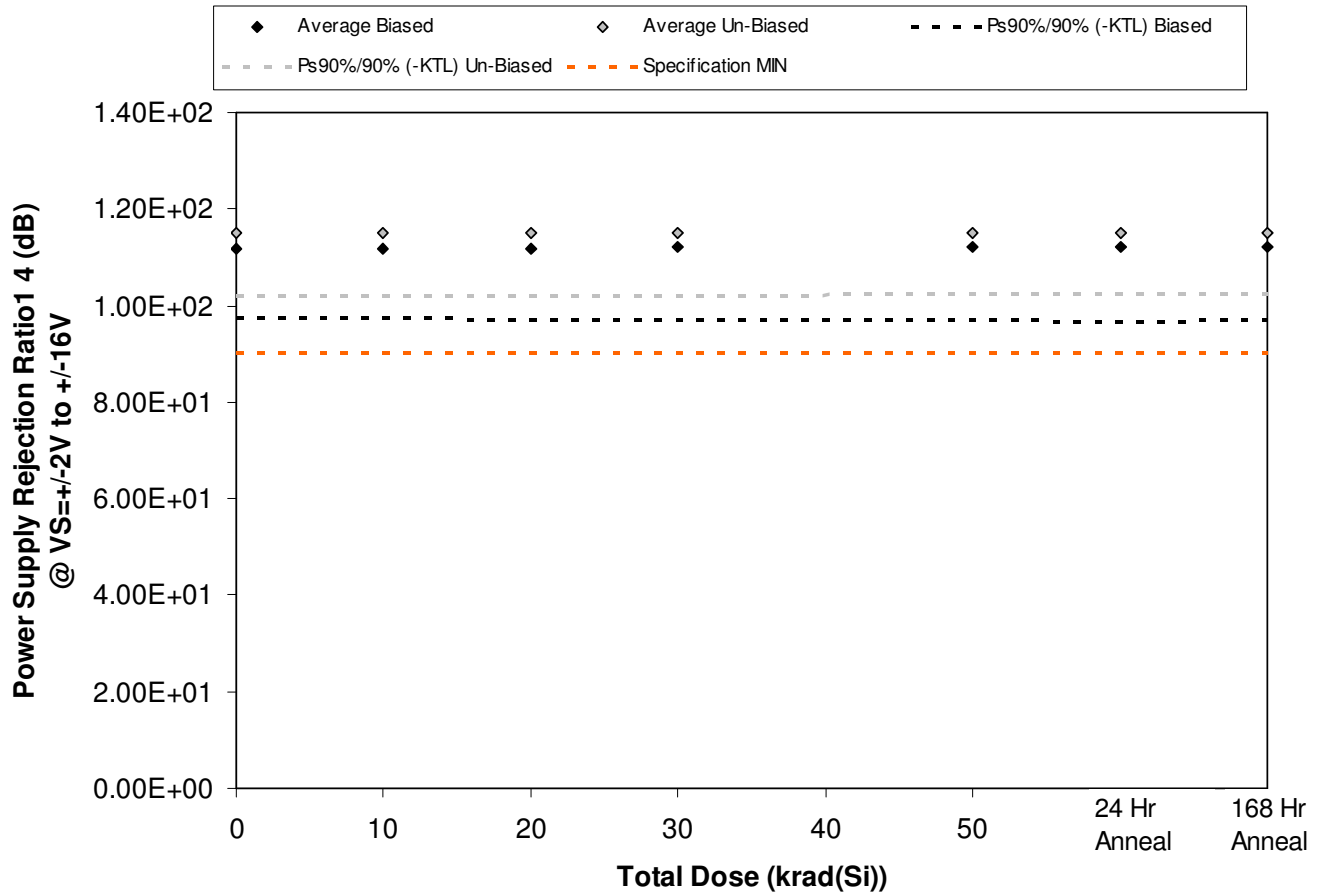


Figure 5.92. Plot of Power Supply Rejection Ratio1 4 (dB) @ VS=+-2V to +/-16V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.92. Raw data for Power Supply Rejection Ratio1 4 (dB) @ VS=+-2V to +/-16V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Power Supply Rejection Ratio1 4 (dB) @ VS=+-2V to +/-16V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
563	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02
564	1.20E+02	1.20E+02	1.21E+02	1.21E+02	1.21E+02	1.21E+02	1.21E+02
567	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02
569	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02
570	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
571	1.20E+02	1.20E+02	1.20E+02	1.20E+02	1.20E+02	1.20E+02	1.20E+02
572	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.11E+02	1.11E+02	1.11E+02
573	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02
574	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02
584	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02
585	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02
<b>Biased Statistics</b>							
Average Biased	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02
Std Dev Biased	5.35E+00	5.38E+00	5.45E+00	5.52E+00	5.56E+00	5.63E+00	5.44E+00
Ps90%/90% (+KTL) Biased	1.27E+02	1.27E+02	1.27E+02	1.27E+02	1.27E+02	1.28E+02	1.27E+02
Ps90%/90% (-KTL) Biased	9.72E+01	9.72E+01	9.70E+01	9.69E+01	9.69E+01	9.67E+01	9.71E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02
Std Dev Un-Biased	4.71E+00	4.69E+00	4.65E+00	4.66E+00	4.61E+00	4.56E+00	4.64E+00
Ps90%/90% (+KTL) Un-Biased	1.28E+02	1.28E+02	1.28E+02	1.28E+02	1.28E+02	1.28E+02	1.28E+02
Ps90%/90% (-KTL) Un-Biased	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02	1.02E+02
<b>Specification MIN</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>	<b>9.00E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

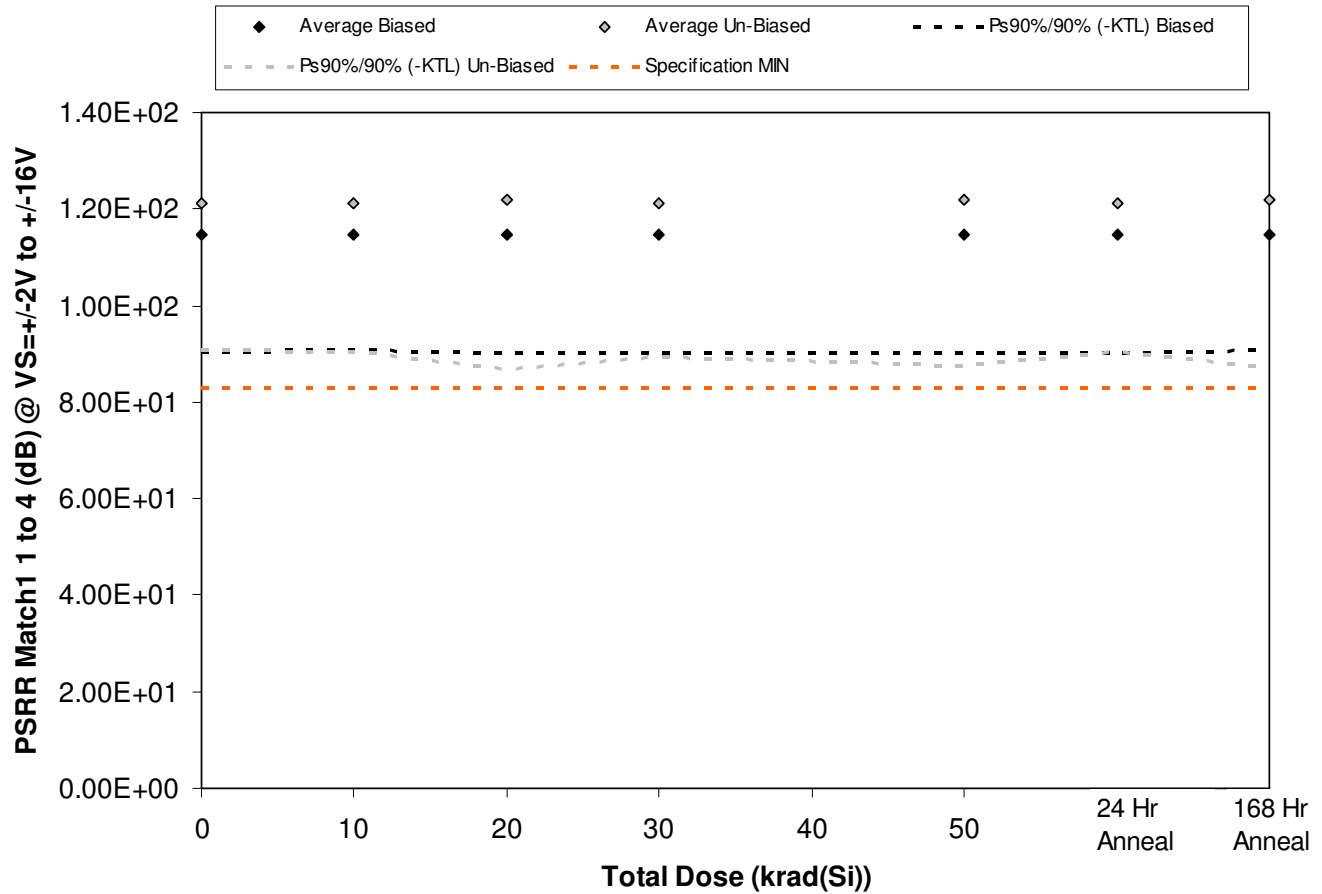


Figure 5.93. Plot of PSRR Match1 1 to 4 (dB) @ VS=+-2V to +/-16V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.93. Raw data for PSRR Match1 1 to 4 (dB) @ VS=+/-2V to +/-16V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

PSRR Match1 1 to 4 (dB) @ VS=+/-2V to +/-16V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02
563	1.29E+02	1.29E+02	1.29E+02	1.29E+02	1.30E+02	1.29E+02	1.28E+02
564	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02
567	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02
569	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
570	1.27E+02	1.27E+02	1.27E+02	1.27E+02	1.28E+02	1.27E+02	1.28E+02
571	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.14E+02	1.13E+02
572	1.37E+02	1.38E+02	1.42E+02	1.39E+02	1.41E+02	1.38E+02	1.42E+02
573	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02
574	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02
584	1.14E+02	1.13E+02	1.14E+02	1.13E+02	1.14E+02	1.14E+02	1.14E+02
585	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02
<b>Biased Statistics</b>							
Average Biased	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02
Std Dev Biased	8.89E+00	8.72E+00	9.01E+00	9.01E+00	9.04E+00	9.03E+00	8.64E+00
Ps90%/90% (+KTL) Biased	1.39E+02	1.38E+02	1.39E+02	1.39E+02	1.40E+02	1.40E+02	1.38E+02
Ps90%/90% (-KTL) Biased	9.03E+01	9.06E+01	9.00E+01	9.00E+01	9.00E+01	9.01E+01	9.09E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.21E+02	1.21E+02	1.22E+02	1.21E+02	1.22E+02	1.21E+02	1.22E+02
Std Dev Un-Biased	1.10E+01	1.12E+01	1.29E+01	1.16E+01	1.25E+01	1.13E+01	1.27E+01
Ps90%/90% (+KTL) Un-Biased	1.51E+02	1.52E+02	1.57E+02	1.53E+02	1.56E+02	1.52E+02	1.57E+02
Ps90%/90% (-KTL) Un-Biased	9.09E+01	9.05E+01	8.67E+01	8.95E+01	8.77E+01	9.03E+01	8.71E+01
<b>Specification MIN</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

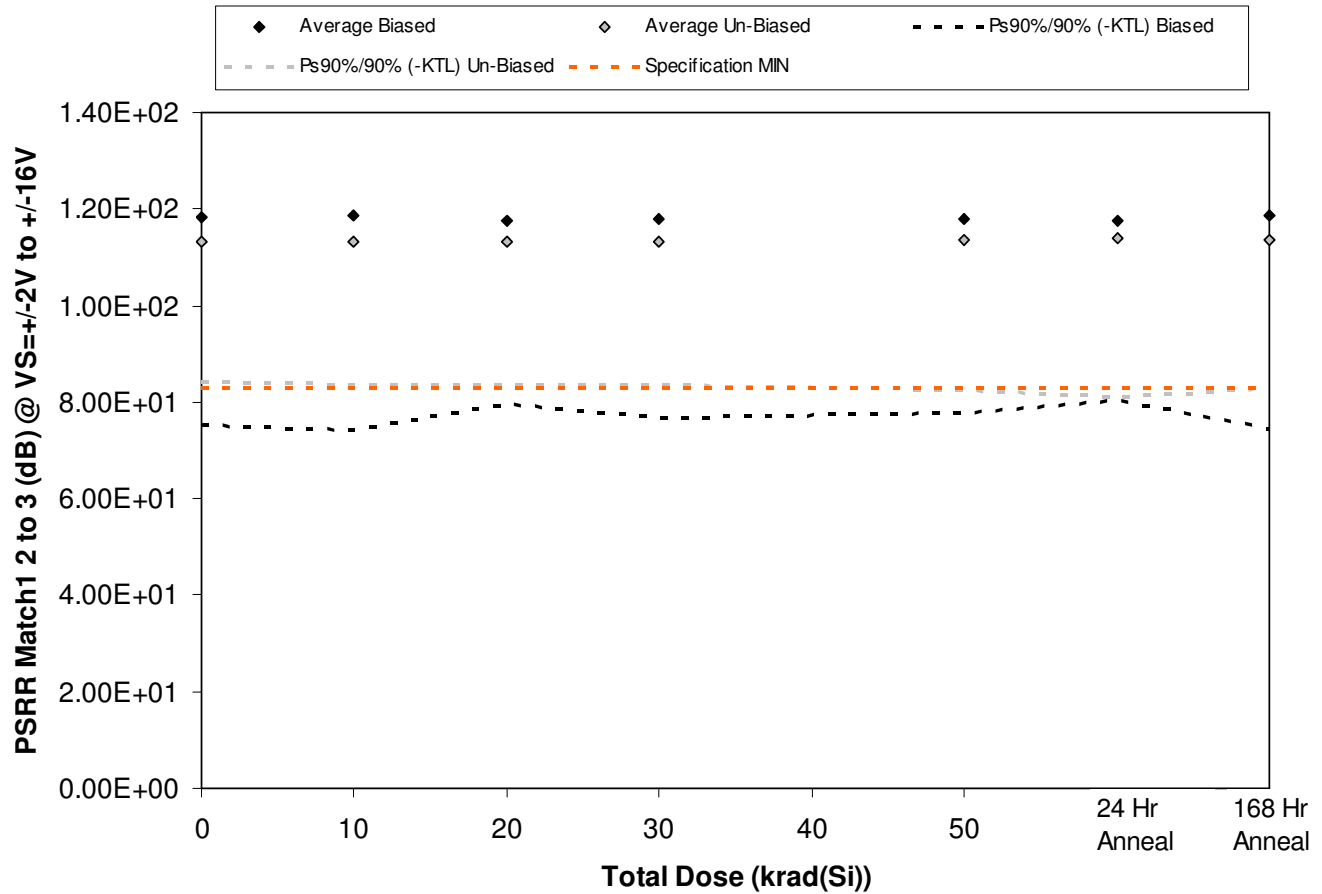


Figure 5.94. Plot of PSRR Match1 2 to 3 (dB) @ VS=+-2V to +/-16V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the measured data points for the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.94. Raw data for PSRR Match1 2 to 3 (dB) @ VS=+/-2V to +/-16V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

PSRR Match1 2 to 3 (dB) @ VS=+/-2V to +/-16V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.08E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02
563	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02
564	1.45E+02	1.47E+02	1.41E+02	1.44E+02	1.43E+02	1.41E+02	1.47E+02
567	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02
569	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02
570	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02
571	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
572	1.29E+02	1.29E+02	1.29E+02	1.29E+02	1.31E+02	1.33E+02	1.31E+02
573	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02
574	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02	1.04E+02
584	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02
585	1.30E+02	1.30E+02	1.28E+02	1.30E+02	1.30E+02	1.29E+02	1.29E+02
<b>Biased Statistics</b>							
Average Biased	1.18E+02	1.19E+02	1.17E+02	1.18E+02	1.18E+02	1.17E+02	1.19E+02
Std Dev Biased	1.56E+01	1.63E+01	1.38E+01	1.51E+01	1.46E+01	1.36E+01	1.61E+01
Ps90%/90% (+KTL) Biased	1.61E+02	1.63E+02	1.55E+02	1.60E+02	1.58E+02	1.55E+02	1.63E+02
Ps90%/90% (-KTL) Biased	7.54E+01	7.40E+01	7.96E+01	7.66E+01	7.78E+01	8.03E+01	7.44E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.14E+02	1.14E+02	1.14E+02
Std Dev Un-Biased	1.06E+01	1.08E+01	1.08E+01	1.08E+01	1.15E+01	1.21E+01	1.12E+01
Ps90%/90% (+KTL) Un-Biased	1.42E+02	1.43E+02	1.43E+02	1.43E+02	1.45E+02	1.47E+02	1.44E+02
Ps90%/90% (-KTL) Un-Biased	8.42E+01	8.37E+01	8.37E+01	8.37E+01	8.23E+01	8.09E+01	8.28E+01
<b>Specification MIN</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>	<b>8.30E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



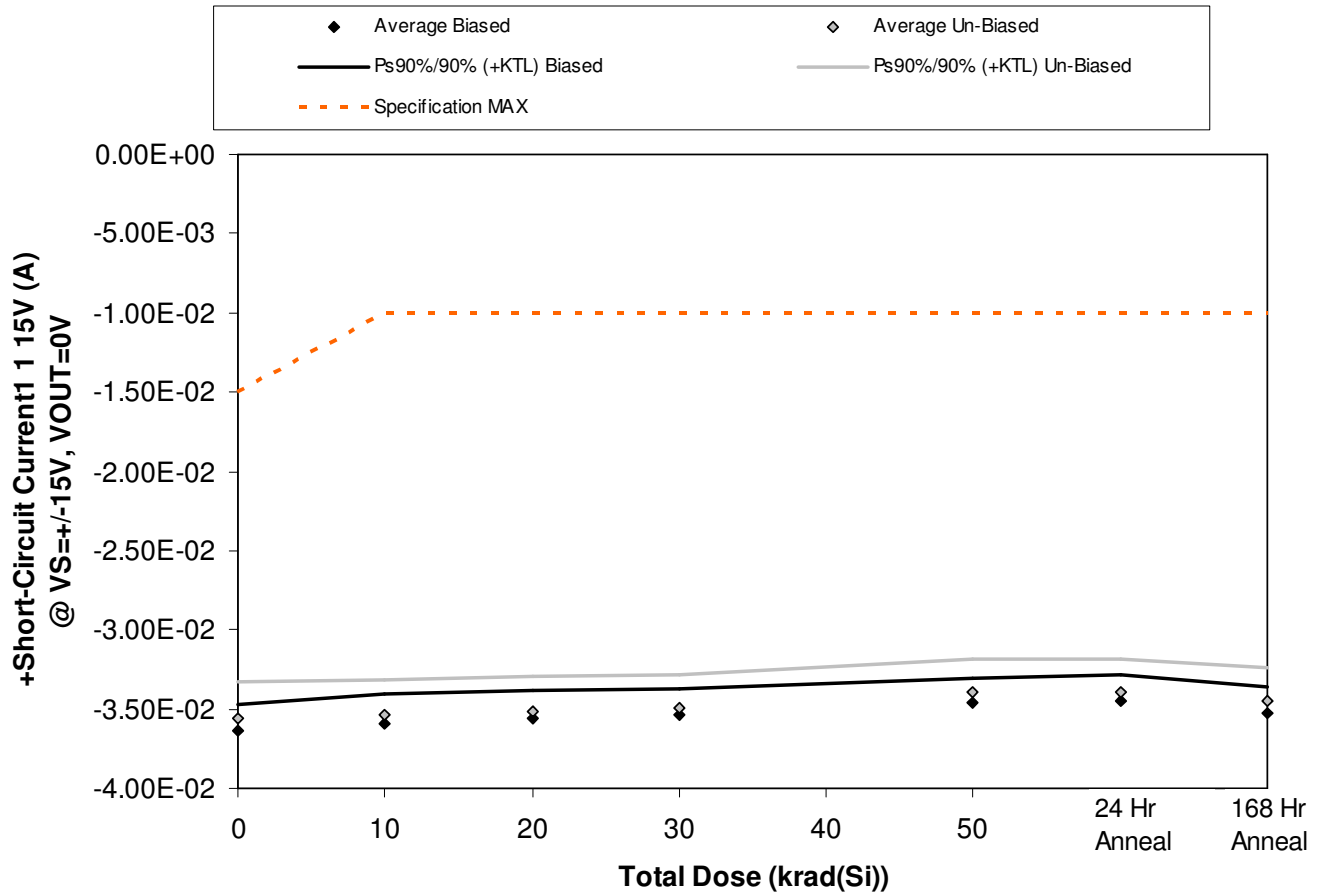


Figure 5.95. Plot of +Short-Circuit Current1 1 15V (A) @ VS=+-15V, VOUT=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.95. Raw data for +Short-Circuit Current1 1 15V (A) @ VS=+/-15V, VOUT=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Short-Circuit Current1 1 15V (A) @ VS=+/-15V, VOUT=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.71E-02	-3.67E-02	-3.64E-02	-3.62E-02	-3.53E-02	-3.52E-02	-3.59E-02
563	-3.59E-02	-3.53E-02	-3.50E-02	-3.49E-02	-3.42E-02	-3.40E-02	-3.47E-02
564	-3.58E-02	-3.53E-02	-3.50E-02	-3.49E-02	-3.42E-02	-3.39E-02	-3.47E-02
567	-3.61E-02	-3.57E-02	-3.53E-02	-3.52E-02	-3.44E-02	-3.43E-02	-3.50E-02
569	-3.70E-02	-3.66E-02	-3.61E-02	-3.60E-02	-3.51E-02	-3.51E-02	-3.58E-02
570	-3.53E-02	-3.52E-02	-3.50E-02	-3.48E-02	-3.38E-02	-3.38E-02	-3.43E-02
571	-3.54E-02	-3.52E-02	-3.50E-02	-3.48E-02	-3.38E-02	-3.38E-02	-3.43E-02
572	-3.70E-02	-3.66E-02	-3.65E-02	-3.62E-02	-3.52E-02	-3.51E-02	-3.57E-02
573	-3.47E-02	-3.44E-02	-3.43E-02	-3.41E-02	-3.31E-02	-3.31E-02	-3.36E-02
574	-3.55E-02	-3.54E-02	-3.52E-02	-3.50E-02	-3.40E-02	-3.39E-02	-3.45E-02
584	-3.63E-02	-3.64E-02	-3.65E-02	-3.66E-02	-3.62E-02	-3.61E-02	-3.63E-02
585	-3.73E-02	-3.74E-02	-3.76E-02	-3.74E-02	-3.71E-02	-3.69E-02	-3.73E-02
<b>Biased Statistics</b>							
Average Biased	-3.64E-02	-3.59E-02	-3.56E-02	-3.54E-02	-3.46E-02	-3.45E-02	-3.52E-02
Std Dev Biased	6.14E-04	6.85E-04	6.31E-04	6.07E-04	5.53E-04	6.20E-04	5.72E-04
Ps90%/90% (+KTL) Biased	-3.47E-02	-3.40E-02	-3.38E-02	-3.38E-02	-3.31E-02	-3.28E-02	-3.37E-02
Ps90%/90% (-KTL) Biased	-3.80E-02	-3.78E-02	-3.73E-02	-3.71E-02	-3.61E-02	-3.62E-02	-3.68E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.56E-02	-3.54E-02	-3.52E-02	-3.49E-02	-3.40E-02	-3.39E-02	-3.45E-02
Std Dev Un-Biased	8.50E-04	8.11E-04	8.09E-04	7.82E-04	7.67E-04	7.48E-04	7.70E-04
Ps90%/90% (+KTL) Un-Biased	-3.32E-02	-3.32E-02	-3.30E-02	-3.28E-02	-3.19E-02	-3.19E-02	-3.24E-02
Ps90%/90% (-KTL) Un-Biased	-3.79E-02	-3.76E-02	-3.74E-02	-3.71E-02	-3.61E-02	-3.60E-02	-3.66E-02
<b>Specification MAX</b>	<b>-1.50E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

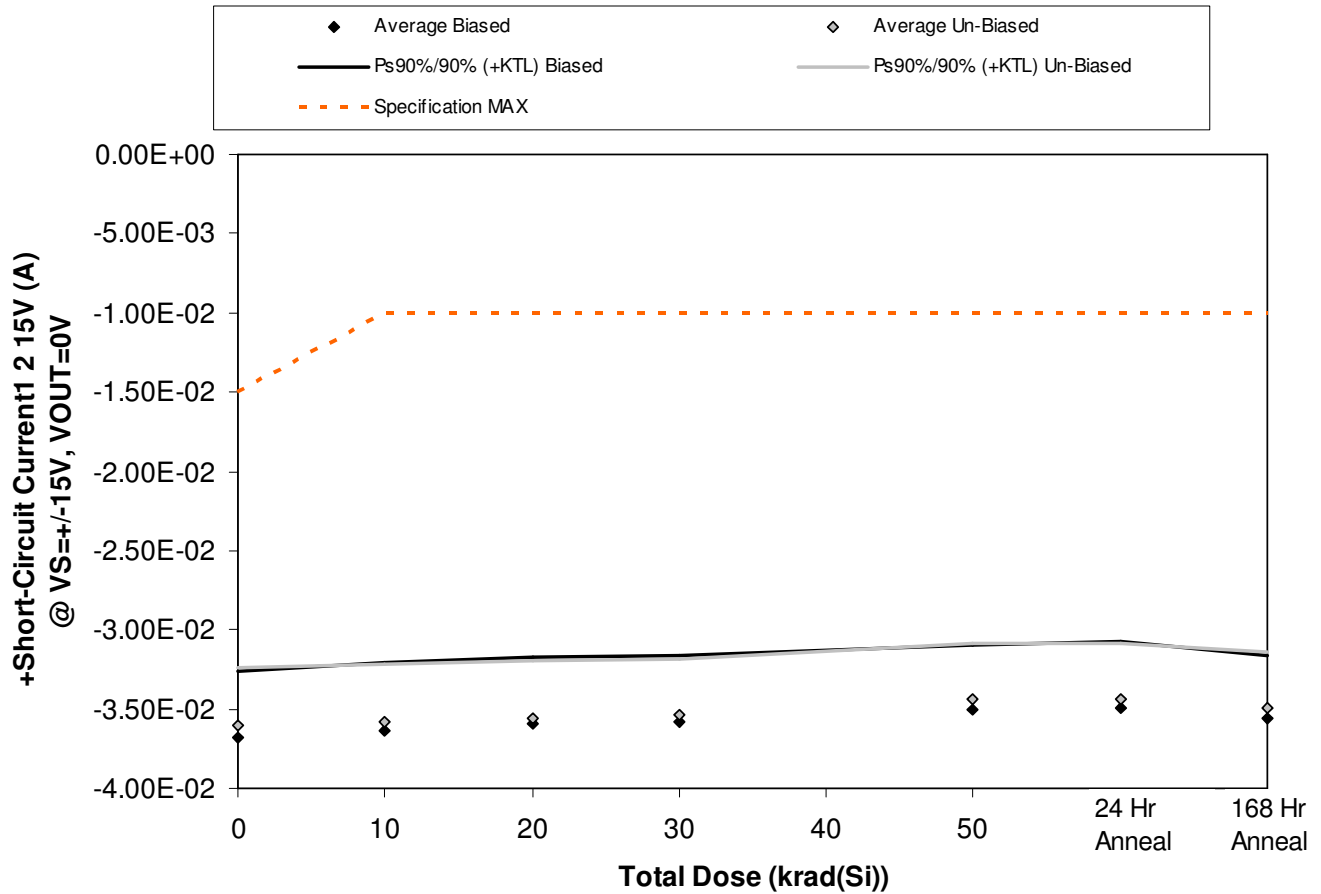


Figure 5.96. Plot of +Short-Circuit Current1 2 15V (A) @ VS=+-15V, VOUT=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.96. Raw data for +Short-Circuit Current1 2 15V (A) @ VS=+/-15V, VOUT=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Short-Circuit Current1 2 15V (A) @ VS=+/-15V, VOUT=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.95E-02	-3.91E-02	-3.87E-02	-3.85E-02	-3.76E-02	-3.75E-02	-3.82E-02
563	-3.63E-02	-3.57E-02	-3.55E-02	-3.54E-02	-3.46E-02	-3.44E-02	-3.52E-02
564	-3.63E-02	-3.58E-02	-3.54E-02	-3.53E-02	-3.46E-02	-3.44E-02	-3.52E-02
567	-3.58E-02	-3.54E-02	-3.49E-02	-3.48E-02	-3.39E-02	-3.39E-02	-3.46E-02
569	-3.62E-02	-3.58E-02	-3.53E-02	-3.52E-02	-3.43E-02	-3.43E-02	-3.50E-02
570	-3.63E-02	-3.61E-02	-3.58E-02	-3.56E-02	-3.46E-02	-3.46E-02	-3.52E-02
571	-3.55E-02	-3.53E-02	-3.51E-02	-3.48E-02	-3.38E-02	-3.38E-02	-3.44E-02
572	-3.73E-02	-3.70E-02	-3.68E-02	-3.65E-02	-3.55E-02	-3.55E-02	-3.61E-02
573	-3.41E-02	-3.38E-02	-3.37E-02	-3.34E-02	-3.24E-02	-3.24E-02	-3.30E-02
574	-3.72E-02	-3.70E-02	-3.68E-02	-3.65E-02	-3.56E-02	-3.55E-02	-3.61E-02
584	-3.64E-02	-3.65E-02	-3.65E-02	-3.66E-02	-3.62E-02	-3.61E-02	-3.64E-02
585	-3.59E-02	-3.60E-02	-3.61E-02	-3.60E-02	-3.56E-02	-3.54E-02	-3.58E-02
<b>Biased Statistics</b>							
Average Biased	-3.68E-02	-3.63E-02	-3.60E-02	-3.58E-02	-3.50E-02	-3.49E-02	-3.56E-02
Std Dev Biased	1.52E-03	1.55E-03	1.55E-03	1.53E-03	1.48E-03	1.49E-03	1.47E-03
Ps90%/90% (+KTL) Biased	-3.26E-02	-3.21E-02	-3.17E-02	-3.17E-02	-3.10E-02	-3.08E-02	-3.16E-02
Ps90%/90% (-KTL) Biased	-4.10E-02	-4.06E-02	-4.02E-02	-4.00E-02	-3.91E-02	-3.90E-02	-3.97E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.61E-02	-3.58E-02	-3.56E-02	-3.54E-02	-3.44E-02	-3.44E-02	-3.49E-02
Std Dev Un-Biased	1.33E-03	1.35E-03	1.33E-03	1.31E-03	1.30E-03	1.28E-03	1.29E-03
Ps90%/90% (+KTL) Un-Biased	-3.24E-02	-3.21E-02	-3.20E-02	-3.18E-02	-3.08E-02	-3.08E-02	-3.14E-02
Ps90%/90% (-KTL) Un-Biased	-3.97E-02	-3.95E-02	-3.93E-02	-3.90E-02	-3.80E-02	-3.79E-02	-3.85E-02
<b>Specification MAX</b>	<b>-1.50E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

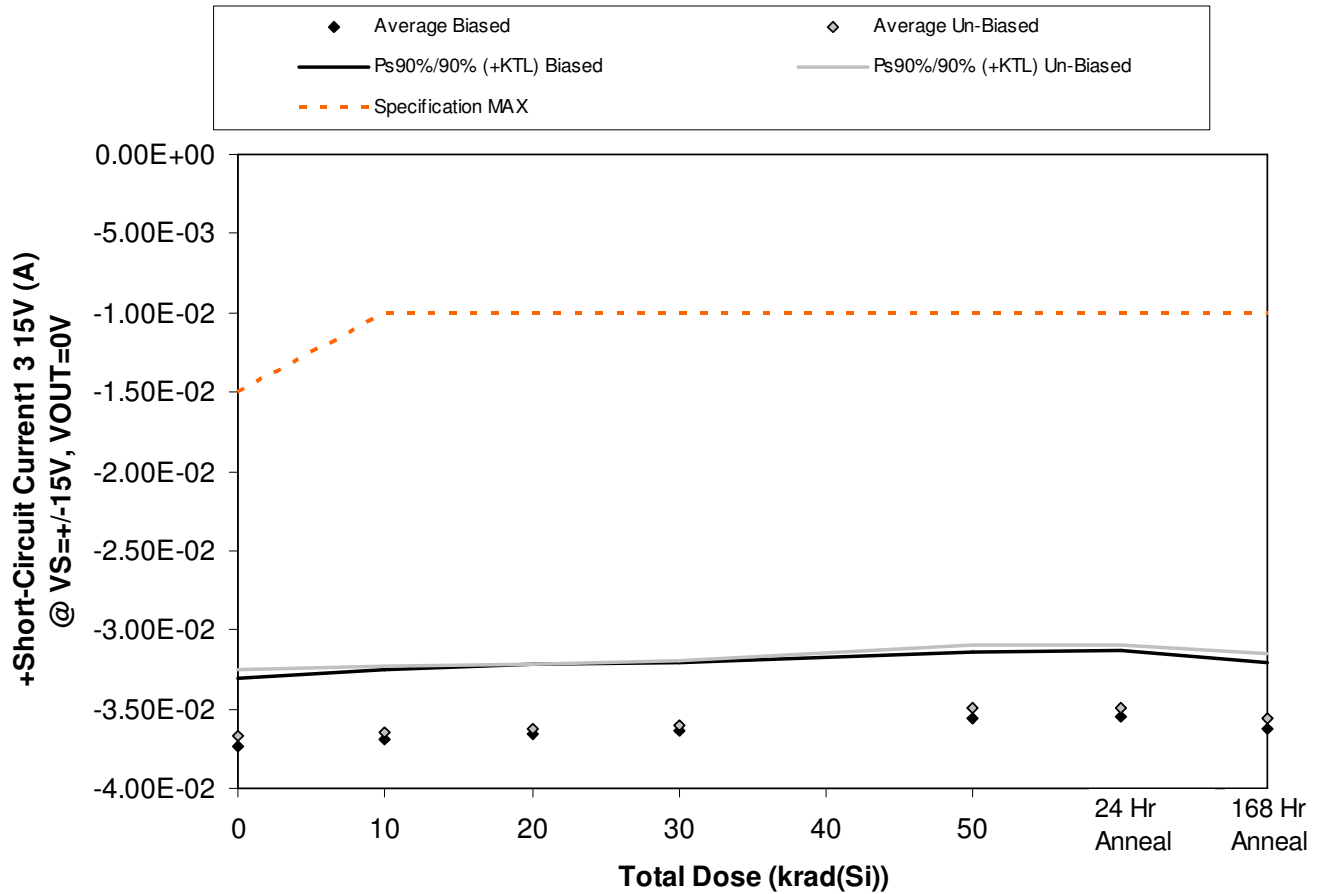


Figure 5.97. Plot of +Short-Circuit Current1 3 15V (A) @ VS=+-15V, VOUT=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.97. Raw data for +Short-Circuit Current1 3 15V (A) @ VS=+/-15V, VOUT=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Short-Circuit Current1 3 15V (A) @ VS=+/-15V, VOUT=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-4.01E-02	-3.97E-02	-3.93E-02	-3.92E-02	-3.82E-02	-3.81E-02	-3.88E-02
563	-3.62E-02	-3.56E-02	-3.54E-02	-3.52E-02	-3.45E-02	-3.43E-02	-3.51E-02
564	-3.71E-02	-3.67E-02	-3.63E-02	-3.62E-02	-3.55E-02	-3.52E-02	-3.60E-02
567	-3.66E-02	-3.62E-02	-3.58E-02	-3.56E-02	-3.48E-02	-3.47E-02	-3.54E-02
569	-3.69E-02	-3.64E-02	-3.59E-02	-3.58E-02	-3.50E-02	-3.49E-02	-3.57E-02
570	-3.65E-02	-3.64E-02	-3.61E-02	-3.59E-02	-3.48E-02	-3.48E-02	-3.54E-02
571	-3.63E-02	-3.61E-02	-3.59E-02	-3.56E-02	-3.46E-02	-3.46E-02	-3.52E-02
572	-3.80E-02	-3.76E-02	-3.75E-02	-3.72E-02	-3.61E-02	-3.61E-02	-3.67E-02
573	-3.44E-02	-3.42E-02	-3.40E-02	-3.38E-02	-3.28E-02	-3.28E-02	-3.34E-02
574	-3.82E-02	-3.81E-02	-3.79E-02	-3.76E-02	-3.66E-02	-3.65E-02	-3.71E-02
584	-3.65E-02	-3.66E-02	-3.66E-02	-3.67E-02	-3.63E-02	-3.63E-02	-3.65E-02
585	-3.64E-02	-3.66E-02	-3.67E-02	-3.66E-02	-3.62E-02	-3.60E-02	-3.64E-02
<b>Biased Statistics</b>							
Average Biased	-3.74E-02	-3.69E-02	-3.65E-02	-3.64E-02	-3.56E-02	-3.55E-02	-3.62E-02
Std Dev Biased	1.57E-03	1.62E-03	1.59E-03	1.58E-03	1.51E-03	1.53E-03	1.50E-03
Ps90%/90% (+KTL) Biased	-3.31E-02	-3.25E-02	-3.22E-02	-3.21E-02	-3.14E-02	-3.13E-02	-3.21E-02
Ps90%/90% (-KTL) Biased	-4.17E-02	-4.14E-02	-4.09E-02	-4.07E-02	-3.97E-02	-3.97E-02	-4.03E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.67E-02	-3.65E-02	-3.63E-02	-3.60E-02	-3.50E-02	-3.49E-02	-3.55E-02
Std Dev Un-Biased	1.51E-03	1.53E-03	1.51E-03	1.48E-03	1.48E-03	1.45E-03	1.46E-03
Ps90%/90% (+KTL) Un-Biased	-3.25E-02	-3.23E-02	-3.21E-02	-3.19E-02	-3.09E-02	-3.10E-02	-3.15E-02
Ps90%/90% (-KTL) Un-Biased	-4.08E-02	-4.06E-02	-4.04E-02	-4.01E-02	-3.90E-02	-3.89E-02	-3.96E-02
<b>Specification MAX</b>	<b>-1.50E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

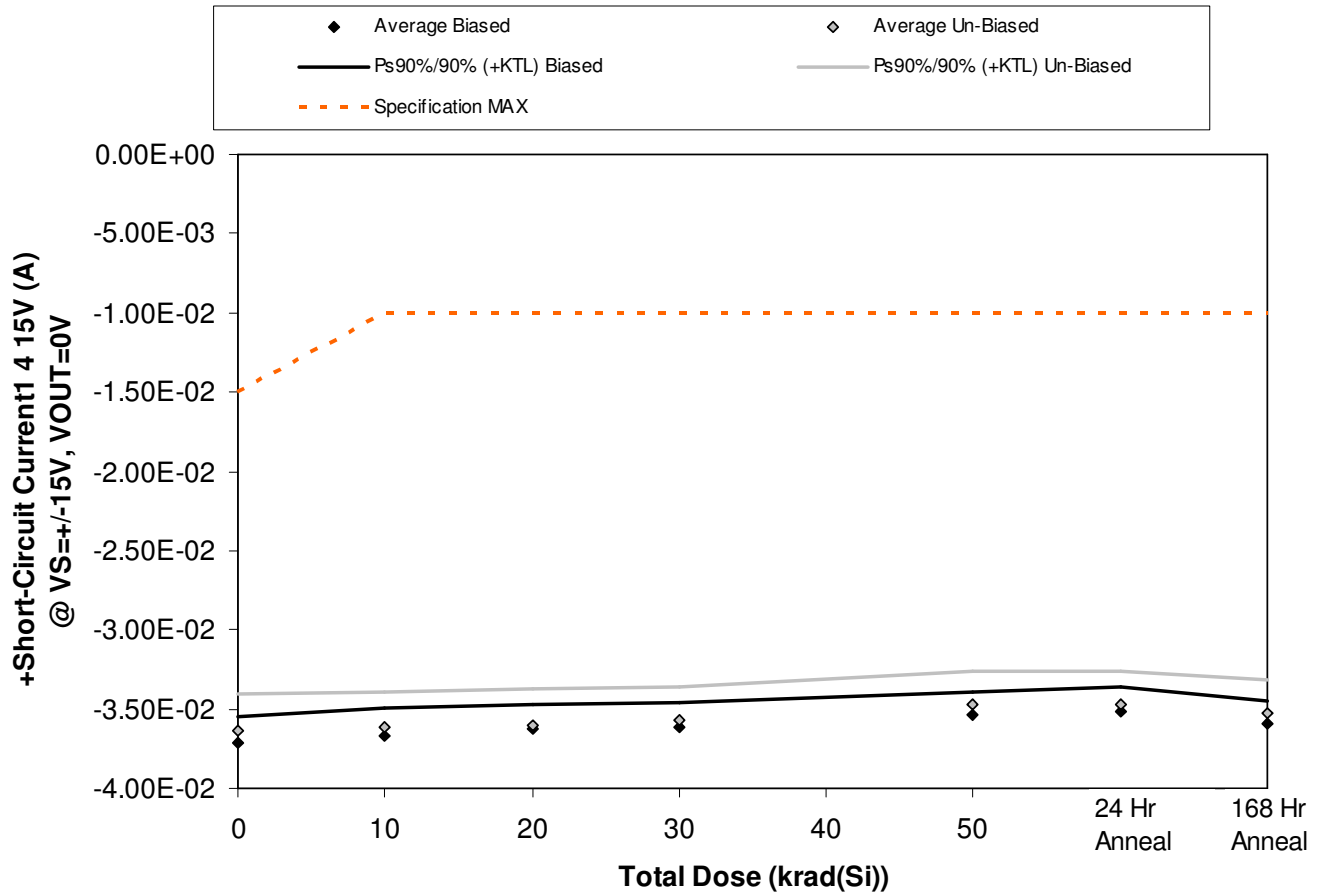


Figure 5.98. Plot of +Short-Circuit Current1 4 15V (A) @ VS=+-15V, VOUT=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.98. Raw data for +Short-Circuit Current1 4 15V (A) @ VS=+/-15V, VOUT=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Short-Circuit Current1 4 15V (A) @ VS=+/-15V, VOUT=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.77E-02	-3.73E-02	-3.70E-02	-3.68E-02	-3.59E-02	-3.59E-02	-3.65E-02
563	-3.67E-02	-3.60E-02	-3.58E-02	-3.57E-02	-3.49E-02	-3.47E-02	-3.55E-02
564	-3.64E-02	-3.60E-02	-3.56E-02	-3.55E-02	-3.48E-02	-3.45E-02	-3.53E-02
567	-3.71E-02	-3.67E-02	-3.63E-02	-3.61E-02	-3.53E-02	-3.52E-02	-3.59E-02
569	-3.76E-02	-3.72E-02	-3.67E-02	-3.66E-02	-3.57E-02	-3.57E-02	-3.64E-02
570	-3.63E-02	-3.62E-02	-3.59E-02	-3.57E-02	-3.47E-02	-3.47E-02	-3.53E-02
571	-3.62E-02	-3.60E-02	-3.57E-02	-3.55E-02	-3.45E-02	-3.45E-02	-3.50E-02
572	-3.76E-02	-3.73E-02	-3.72E-02	-3.69E-02	-3.58E-02	-3.58E-02	-3.64E-02
573	-3.53E-02	-3.50E-02	-3.49E-02	-3.47E-02	-3.37E-02	-3.37E-02	-3.43E-02
574	-3.64E-02	-3.63E-02	-3.61E-02	-3.59E-02	-3.49E-02	-3.48E-02	-3.54E-02
584	-3.71E-02	-3.72E-02	-3.72E-02	-3.74E-02	-3.69E-02	-3.69E-02	-3.71E-02
585	-3.83E-02	-3.84E-02	-3.86E-02	-3.84E-02	-3.81E-02	-3.79E-02	-3.82E-02
<b>Biased Statistics</b>							
Average Biased	-3.71E-02	-3.66E-02	-3.63E-02	-3.61E-02	-3.53E-02	-3.52E-02	-3.59E-02
Std Dev Biased	5.71E-04	6.42E-04	5.82E-04	5.58E-04	4.98E-04	5.74E-04	5.26E-04
Ps90%/90% (+KTL) Biased	-3.55E-02	-3.49E-02	-3.47E-02	-3.46E-02	-3.40E-02	-3.36E-02	-3.45E-02
Ps90%/90% (-KTL) Biased	-3.87E-02	-3.84E-02	-3.79E-02	-3.77E-02	-3.67E-02	-3.68E-02	-3.74E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.64E-02	-3.62E-02	-3.60E-02	-3.57E-02	-3.47E-02	-3.47E-02	-3.53E-02
Std Dev Un-Biased	8.34E-04	8.15E-04	8.05E-04	7.81E-04	7.67E-04	7.57E-04	7.64E-04
Ps90%/90% (+KTL) Un-Biased	-3.41E-02	-3.39E-02	-3.38E-02	-3.36E-02	-3.26E-02	-3.26E-02	-3.32E-02
Ps90%/90% (-KTL) Un-Biased	-3.87E-02	-3.84E-02	-3.82E-02	-3.79E-02	-3.68E-02	-3.68E-02	-3.74E-02
<b>Specification MAX</b>	<b>-1.50E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>	<b>-1.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



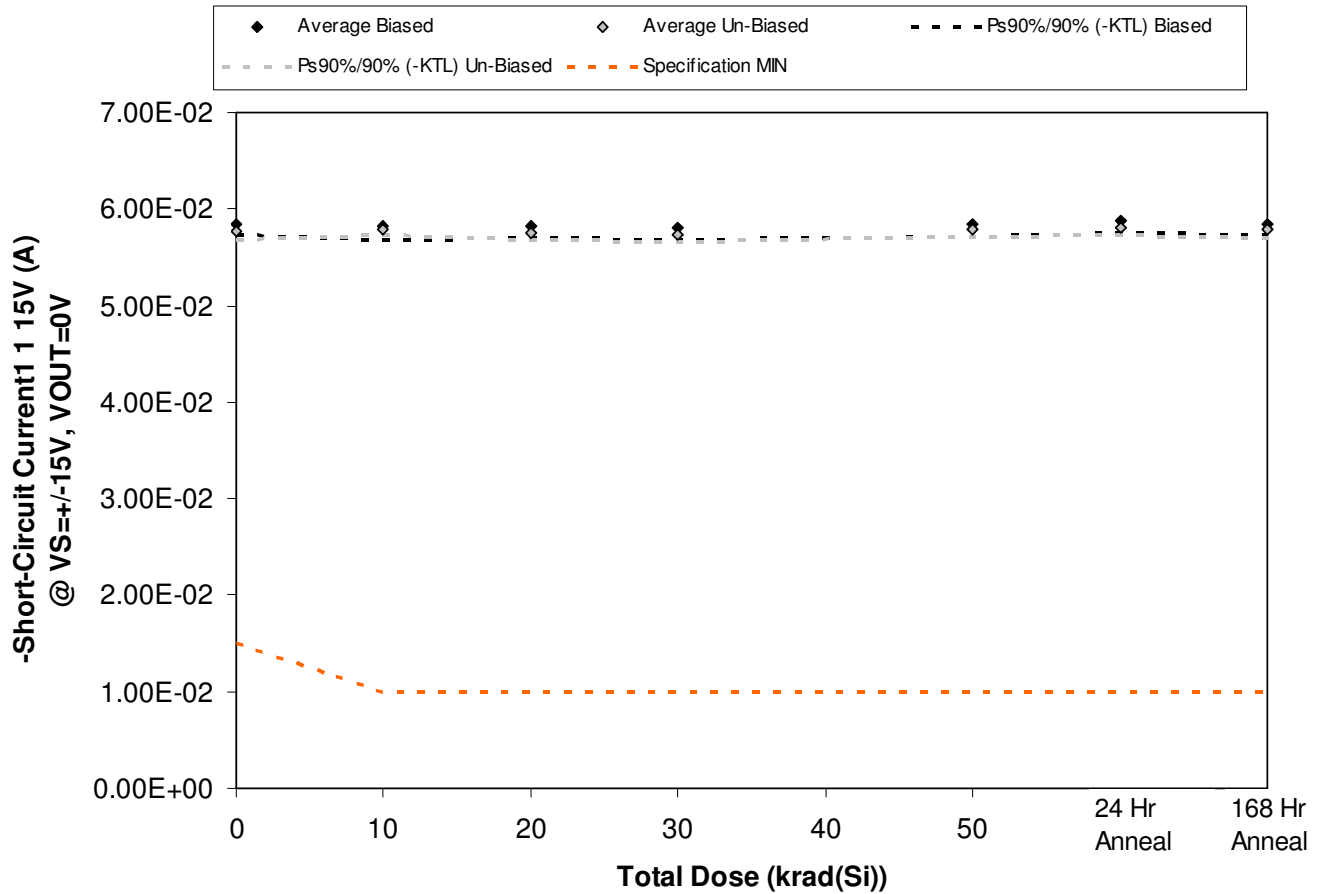


Figure 5.99. Plot of -Short-Circuit Current1 1 15V (A) @ VS=+-15V, VOUT=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.99. Raw data for -Short-Circuit Current1 1 15V (A) @ VS=+/-15V, VOUT=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Short-Circuit Current1 1 15V (A) @ VS=+/-15V, VOUT=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.83E-02	5.84E-02	5.83E-02	5.81E-02	5.86E-02	5.87E-02	5.85E-02
563	5.88E-02	5.90E-02	5.87E-02	5.85E-02	5.89E-02	5.92E-02	5.88E-02
564	5.81E-02	5.79E-02	5.78E-02	5.75E-02	5.79E-02	5.83E-02	5.79E-02
567	5.81E-02	5.77E-02	5.77E-02	5.76E-02	5.81E-02	5.83E-02	5.80E-02
569	5.88E-02	5.85E-02	5.86E-02	5.84E-02	5.90E-02	5.91E-02	5.88E-02
570	5.81E-02	5.80E-02	5.79E-02	5.77E-02	5.83E-02	5.83E-02	5.81E-02
571	5.79E-02	5.80E-02	5.78E-02	5.76E-02	5.81E-02	5.82E-02	5.80E-02
572	5.73E-02	5.76E-02	5.72E-02	5.71E-02	5.76E-02	5.77E-02	5.75E-02
573	5.75E-02	5.78E-02	5.73E-02	5.72E-02	5.77E-02	5.78E-02	5.76E-02
574	5.80E-02	5.80E-02	5.77E-02	5.75E-02	5.80E-02	5.82E-02	5.79E-02
584	5.82E-02	5.80E-02	5.80E-02	5.78E-02	5.85E-02	5.86E-02	5.82E-02
585	5.79E-02	5.77E-02	5.74E-02	5.77E-02	5.82E-02	5.86E-02	5.80E-02
<b>Biased Statistics</b>							
Average Biased	5.84E-02	5.83E-02	5.82E-02	5.80E-02	5.85E-02	5.87E-02	5.84E-02
Std Dev Biased	3.67E-04	5.16E-04	4.58E-04	4.46E-04	4.82E-04	4.45E-04	4.12E-04
Ps90%/90% (+KTL) Biased	5.94E-02	5.97E-02	5.95E-02	5.93E-02	5.98E-02	5.99E-02	5.95E-02
Ps90%/90% (-KTL) Biased	5.74E-02	5.69E-02	5.70E-02	5.68E-02	5.71E-02	5.75E-02	5.73E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.77E-02	5.79E-02	5.76E-02	5.74E-02	5.79E-02	5.80E-02	5.78E-02
Std Dev Un-Biased	3.58E-04	1.96E-04	3.07E-04	2.74E-04	3.04E-04	2.61E-04	2.90E-04
Ps90%/90% (+KTL) Un-Biased	5.87E-02	5.84E-02	5.84E-02	5.82E-02	5.88E-02	5.88E-02	5.86E-02
Ps90%/90% (-KTL) Un-Biased	5.68E-02	5.73E-02	5.67E-02	5.67E-02	5.71E-02	5.73E-02	5.70E-02
<b>Specification MIN</b>	<b>1.50E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

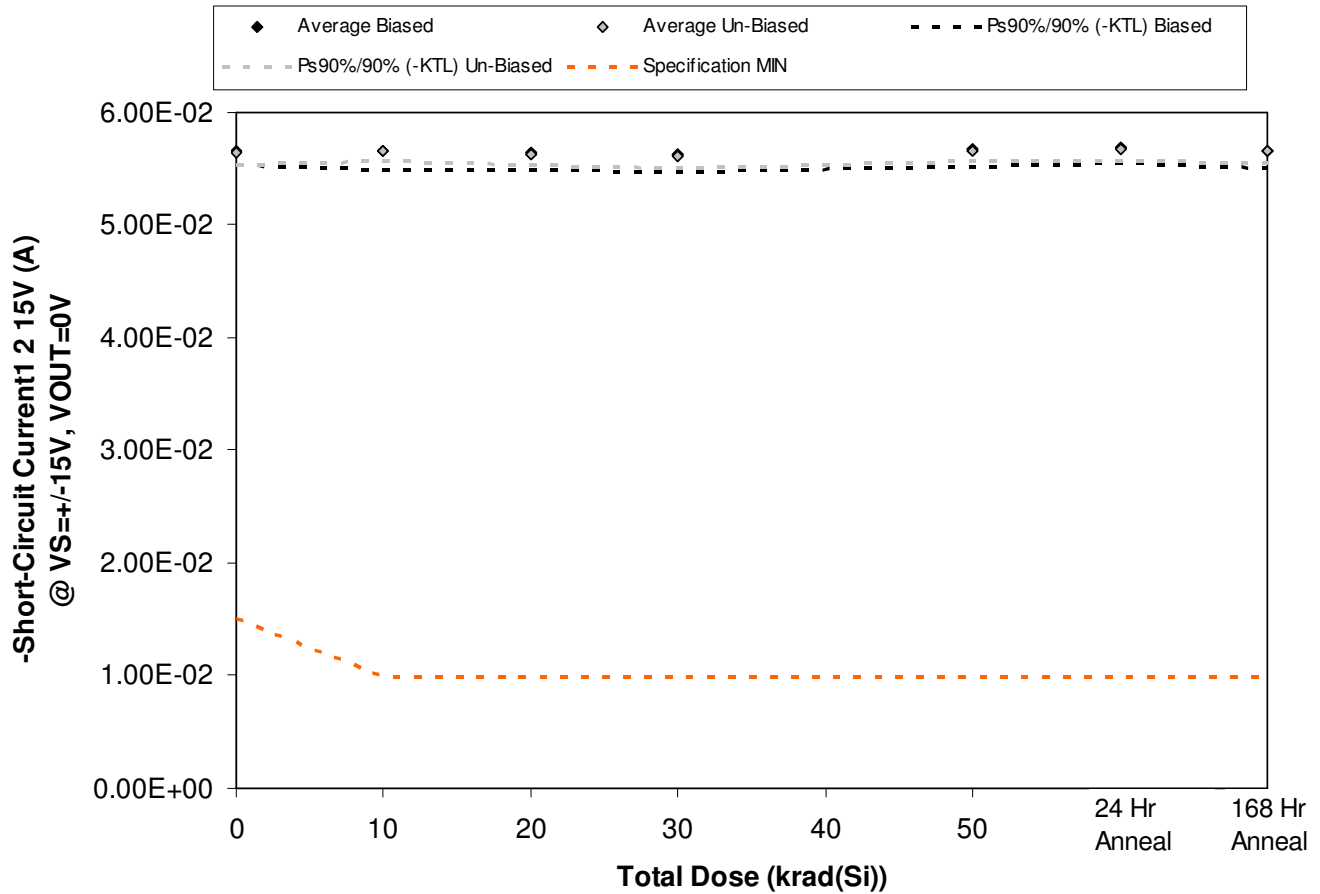


Figure 5.100. Plot of -Short-Circuit Current1 2 15V (A) @ VS=+-15V, VOUT=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.100. Raw data for -Short-Circuit Current1 2 15V (A) @ VS=+/-15V, VOUT=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Short-Circuit Current1 2 15V (A) @ VS=+/-15V, VOUT=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.73E-02	5.74E-02	5.73E-02	5.71E-02	5.76E-02	5.77E-02	5.75E-02
563	5.65E-02	5.67E-02	5.64E-02	5.62E-02	5.66E-02	5.69E-02	5.64E-02
564	5.64E-02	5.61E-02	5.60E-02	5.58E-02	5.61E-02	5.66E-02	5.62E-02
567	5.68E-02	5.65E-02	5.65E-02	5.64E-02	5.69E-02	5.71E-02	5.68E-02
569	5.62E-02	5.58E-02	5.59E-02	5.58E-02	5.63E-02	5.64E-02	5.61E-02
570	5.65E-02	5.65E-02	5.63E-02	5.61E-02	5.68E-02	5.68E-02	5.66E-02
571	5.63E-02	5.64E-02	5.62E-02	5.60E-02	5.65E-02	5.65E-02	5.64E-02
572	5.66E-02	5.69E-02	5.65E-02	5.64E-02	5.69E-02	5.71E-02	5.68E-02
573	5.59E-02	5.61E-02	5.57E-02	5.55E-02	5.61E-02	5.62E-02	5.59E-02
574	5.69E-02	5.70E-02	5.67E-02	5.65E-02	5.70E-02	5.72E-02	5.69E-02
584	5.62E-02	5.61E-02	5.61E-02	5.59E-02	5.65E-02	5.66E-02	5.62E-02
585	5.64E-02	5.62E-02	5.60E-02	5.62E-02	5.67E-02	5.70E-02	5.65E-02
<b>Biased Statistics</b>							
Average Biased	5.66E-02	5.65E-02	5.64E-02	5.63E-02	5.67E-02	5.69E-02	5.66E-02
Std Dev Biased	4.48E-04	5.86E-04	5.51E-04	5.39E-04	5.65E-04	5.04E-04	5.60E-04
Ps90%/90% (+KTL) Biased	5.79E-02	5.81E-02	5.79E-02	5.78E-02	5.82E-02	5.83E-02	5.81E-02
Ps90%/90% (-KTL) Biased	5.54E-02	5.49E-02	5.49E-02	5.48E-02	5.51E-02	5.55E-02	5.51E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.64E-02	5.66E-02	5.63E-02	5.61E-02	5.66E-02	5.67E-02	5.65E-02
Std Dev Un-Biased	3.86E-04	3.61E-04	3.63E-04	3.83E-04	3.65E-04	4.18E-04	3.85E-04
Ps90%/90% (+KTL) Un-Biased	5.75E-02	5.76E-02	5.73E-02	5.72E-02	5.76E-02	5.79E-02	5.76E-02
Ps90%/90% (-KTL) Un-Biased	5.54E-02	5.56E-02	5.53E-02	5.51E-02	5.56E-02	5.56E-02	5.55E-02
<b>Specification MIN</b>	<b>1.50E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

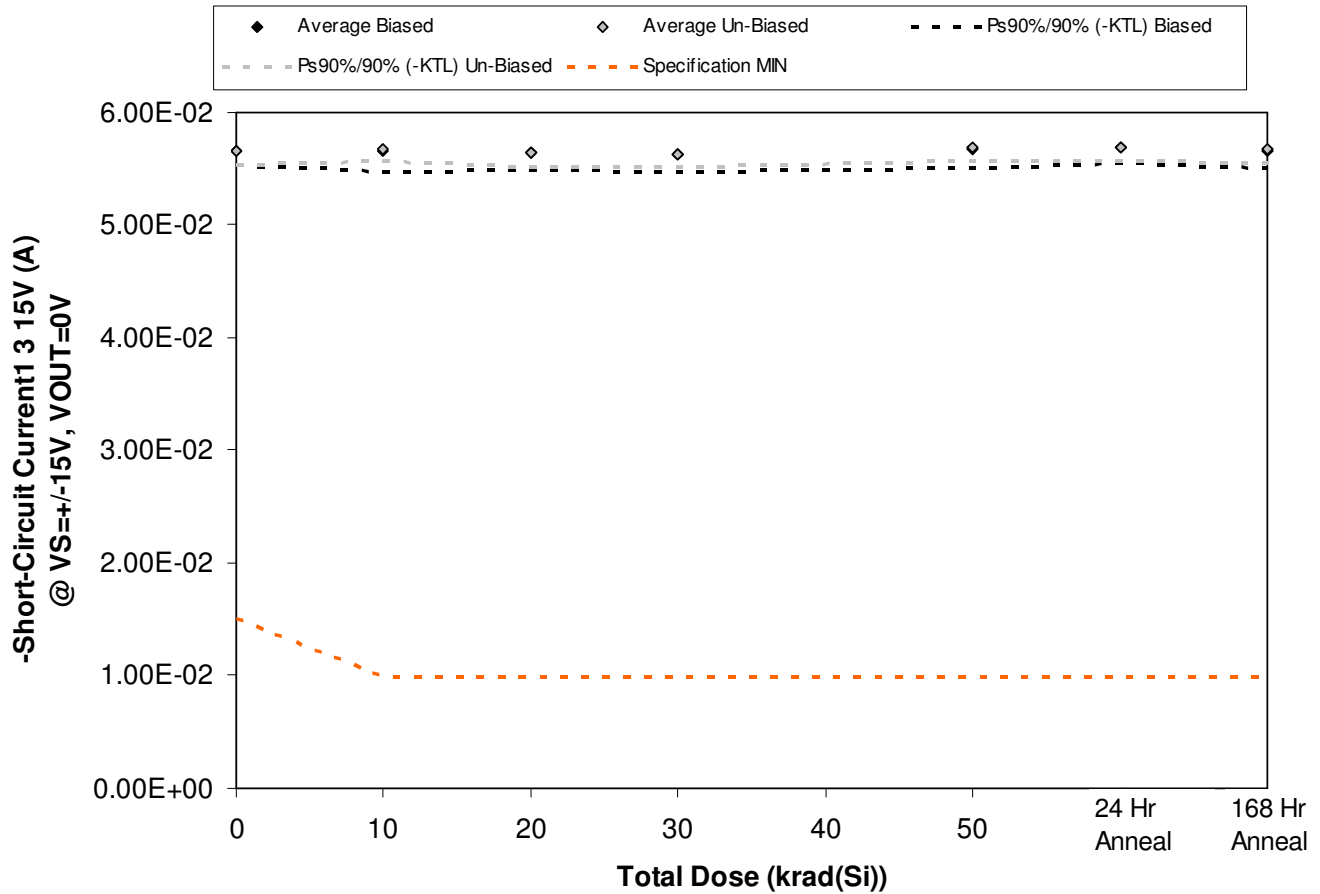


Figure 5.101. Plot of -Short-Circuit Current1 3 15V (A) @ VS=+-15V, VOUT=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.101. Raw data for -Short-Circuit Current1 3 15V (A) @ VS=+/-15V, VOUT=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Short-Circuit Current1 3 15V (A) @ VS=+/-15V, VOUT=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.73E-02	5.74E-02	5.73E-02	5.72E-02	5.76E-02	5.78E-02	5.74E-02
563	5.66E-02	5.68E-02	5.65E-02	5.63E-02	5.67E-02	5.69E-02	5.66E-02
564	5.64E-02	5.62E-02	5.61E-02	5.59E-02	5.62E-02	5.66E-02	5.62E-02
567	5.68E-02	5.65E-02	5.65E-02	5.64E-02	5.69E-02	5.70E-02	5.68E-02
569	5.61E-02	5.57E-02	5.58E-02	5.57E-02	5.62E-02	5.64E-02	5.60E-02
570	5.68E-02	5.67E-02	5.66E-02	5.64E-02	5.70E-02	5.70E-02	5.68E-02
571	5.66E-02	5.67E-02	5.65E-02	5.63E-02	5.68E-02	5.68E-02	5.67E-02
572	5.68E-02	5.71E-02	5.67E-02	5.66E-02	5.71E-02	5.72E-02	5.70E-02
573	5.58E-02	5.62E-02	5.57E-02	5.56E-02	5.61E-02	5.62E-02	5.60E-02
574	5.71E-02	5.72E-02	5.69E-02	5.67E-02	5.72E-02	5.74E-02	5.71E-02
584	5.64E-02	5.62E-02	5.62E-02	5.60E-02	5.67E-02	5.67E-02	5.64E-02
585	5.66E-02	5.63E-02	5.61E-02	5.64E-02	5.68E-02	5.72E-02	5.66E-02
<b>Biased Statistics</b>							
Average Biased	5.66E-02	5.65E-02	5.64E-02	5.63E-02	5.67E-02	5.69E-02	5.66E-02
Std Dev Biased	4.59E-04	6.26E-04	5.73E-04	5.65E-04	5.80E-04	5.32E-04	5.63E-04
Ps90%/90% (+KTL) Biased	5.79E-02	5.82E-02	5.80E-02	5.78E-02	5.83E-02	5.84E-02	5.81E-02
Ps90%/90% (-KTL) Biased	5.54E-02	5.48E-02	5.49E-02	5.47E-02	5.51E-02	5.55E-02	5.50E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.66E-02	5.68E-02	5.65E-02	5.63E-02	5.68E-02	5.69E-02	5.67E-02
Std Dev Un-Biased	4.84E-04	4.03E-04	4.43E-04	4.33E-04	4.44E-04	4.60E-04	4.42E-04
Ps90%/90% (+KTL) Un-Biased	5.79E-02	5.79E-02	5.77E-02	5.75E-02	5.80E-02	5.82E-02	5.79E-02
Ps90%/90% (-KTL) Un-Biased	5.53E-02	5.57E-02	5.53E-02	5.51E-02	5.56E-02	5.57E-02	5.55E-02
<b>Specification MIN</b>	<b>1.50E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

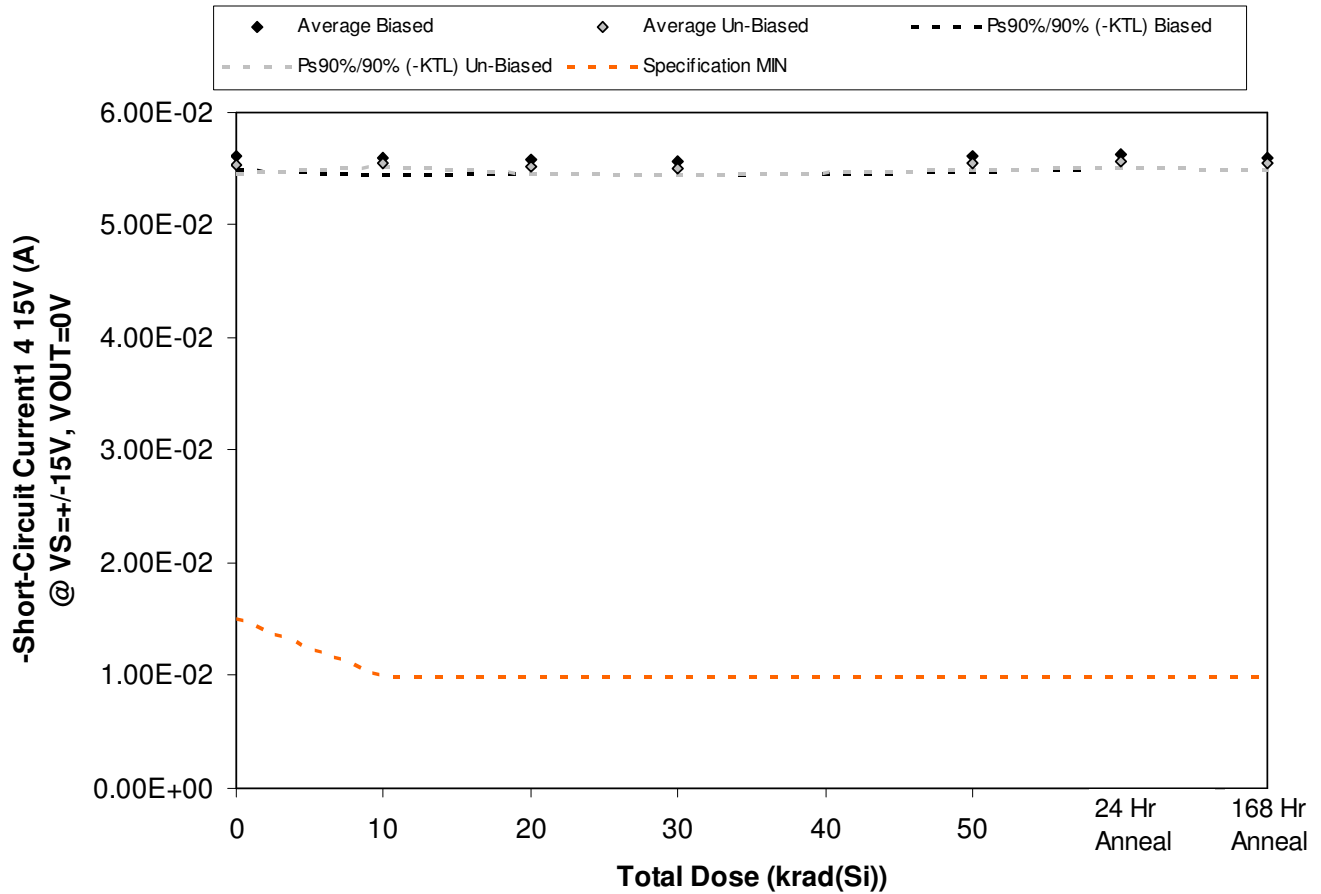


Figure 5.102. Plot of -Short-Circuit Current1 4 15V (A) @ VS=+-15V, VOUT=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.102. Raw data for -Short-Circuit Current1 4 15V (A) @ VS=+/-15V, VOUT=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Short-Circuit Current1 4 15V (A) @ VS=+/-15V, VOUT=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.59E-02	5.60E-02	5.60E-02	5.58E-02	5.62E-02	5.63E-02	5.61E-02
563	5.65E-02	5.67E-02	5.64E-02	5.62E-02	5.65E-02	5.69E-02	5.64E-02
564	5.58E-02	5.55E-02	5.54E-02	5.52E-02	5.55E-02	5.60E-02	5.56E-02
567	5.56E-02	5.53E-02	5.53E-02	5.52E-02	5.57E-02	5.58E-02	5.56E-02
569	5.65E-02	5.61E-02	5.62E-02	5.61E-02	5.66E-02	5.67E-02	5.63E-02
570	5.57E-02	5.56E-02	5.55E-02	5.53E-02	5.59E-02	5.59E-02	5.57E-02
571	5.55E-02	5.56E-02	5.54E-02	5.52E-02	5.57E-02	5.57E-02	5.56E-02
572	5.51E-02	5.54E-02	5.50E-02	5.49E-02	5.54E-02	5.55E-02	5.53E-02
573	5.51E-02	5.54E-02	5.50E-02	5.48E-02	5.53E-02	5.54E-02	5.52E-02
574	5.56E-02	5.56E-02	5.54E-02	5.53E-02	5.56E-02	5.59E-02	5.56E-02
584	5.57E-02	5.55E-02	5.55E-02	5.53E-02	5.60E-02	5.60E-02	5.57E-02
585	5.54E-02	5.51E-02	5.49E-02	5.51E-02	5.56E-02	5.59E-02	5.54E-02
<b>Biased Statistics</b>							
Average Biased	5.61E-02	5.59E-02	5.59E-02	5.57E-02	5.61E-02	5.63E-02	5.60E-02
Std Dev Biased	4.01E-04	5.37E-04	4.72E-04	4.55E-04	4.90E-04	4.68E-04	4.16E-04
Ps90%/90% (+KTL) Biased	5.72E-02	5.74E-02	5.72E-02	5.69E-02	5.74E-02	5.76E-02	5.71E-02
Ps90%/90% (-KTL) Biased	5.50E-02	5.45E-02	5.46E-02	5.44E-02	5.48E-02	5.51E-02	5.49E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.54E-02	5.55E-02	5.53E-02	5.51E-02	5.56E-02	5.57E-02	5.55E-02
Std Dev Un-Biased	2.85E-04	1.31E-04	2.45E-04	2.32E-04	2.50E-04	2.27E-04	2.25E-04
Ps90%/90% (+KTL) Un-Biased	5.62E-02	5.59E-02	5.59E-02	5.57E-02	5.63E-02	5.63E-02	5.61E-02
Ps90%/90% (-KTL) Un-Biased	5.46E-02	5.52E-02	5.46E-02	5.45E-02	5.49E-02	5.51E-02	5.49E-02
<b>Specification MIN</b>	<b>1.50E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>	<b>1.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



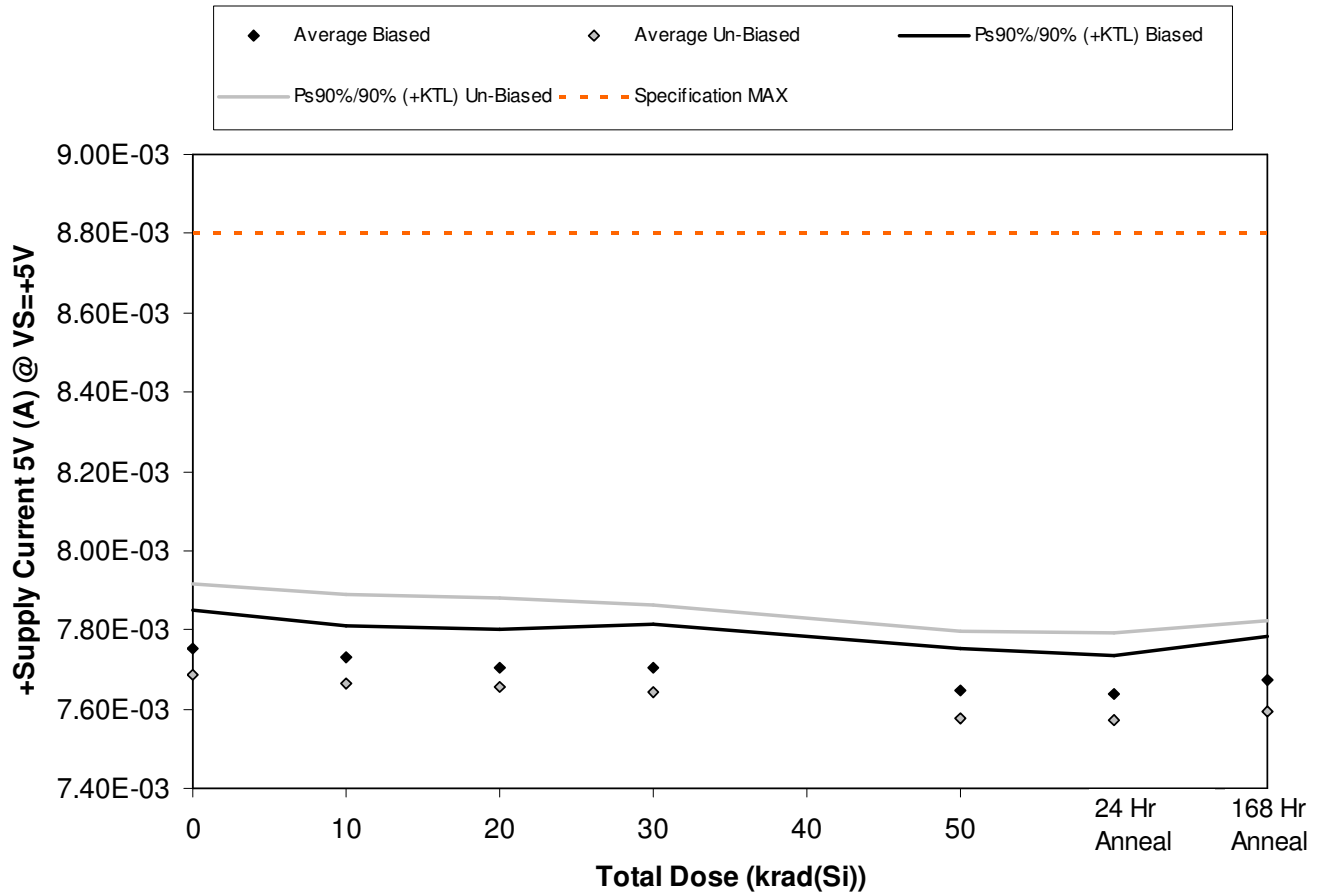


Figure 5.103. Plot of +Supply Current 5V (A) @ VS=+5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.103. Raw data for +Supply Current 5V (A) @ VS=+5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Supply Current 5V (A) @ VS=+5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	7.72E-03	7.70E-03	7.68E-03	7.67E-03	7.62E-03	7.61E-03	7.63E-03
563	7.79E-03	7.75E-03	7.74E-03	7.74E-03	7.68E-03	7.67E-03	7.71E-03
564	7.79E-03	7.77E-03	7.75E-03	7.76E-03	7.70E-03	7.68E-03	7.72E-03
567	7.73E-03	7.72E-03	7.69E-03	7.69E-03	7.63E-03	7.62E-03	7.65E-03
569	7.73E-03	7.71E-03	7.68E-03	7.67E-03	7.62E-03	7.61E-03	7.64E-03
570	7.72E-03	7.71E-03	7.69E-03	7.68E-03	7.61E-03	7.61E-03	7.64E-03
571	7.63E-03	7.60E-03	7.59E-03	7.59E-03	7.53E-03	7.51E-03	7.53E-03
572	7.79E-03	7.76E-03	7.75E-03	7.74E-03	7.67E-03	7.66E-03	7.69E-03
573	7.58E-03	7.57E-03	7.55E-03	7.54E-03	7.47E-03	7.47E-03	7.49E-03
574	7.71E-03	7.69E-03	7.69E-03	7.67E-03	7.61E-03	7.60E-03	7.63E-03
584	7.70E-03	7.71E-03	7.71E-03	7.71E-03	7.68E-03	7.66E-03	7.68E-03
585	7.76E-03	7.76E-03	7.80E-03	7.76E-03	7.74E-03	7.71E-03	7.74E-03
<b>Biased Statistics</b>							
Average Biased	7.75E-03	7.73E-03	7.71E-03	7.71E-03	7.65E-03	7.64E-03	7.67E-03
Std Dev Biased	3.57E-05	3.01E-05	3.44E-05	4.03E-05	3.90E-05	3.56E-05	4.13E-05
Ps90%/90% (+KTL) Biased	7.85E-03	7.81E-03	7.80E-03	7.82E-03	7.75E-03	7.73E-03	7.78E-03
Ps90%/90% (-KTL) Biased	7.65E-03	7.65E-03	7.61E-03	7.60E-03	7.54E-03	7.54E-03	7.56E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.69E-03	7.67E-03	7.65E-03	7.64E-03	7.58E-03	7.57E-03	7.60E-03
Std Dev Un-Biased	8.32E-05	8.14E-05	8.18E-05	8.03E-05	7.98E-05	8.07E-05	8.26E-05
Ps90%/90% (+KTL) Un-Biased	7.91E-03	7.89E-03	7.88E-03	7.86E-03	7.80E-03	7.79E-03	7.82E-03
Ps90%/90% (-KTL) Un-Biased	7.46E-03	7.44E-03	7.43E-03	7.42E-03	7.36E-03	7.35E-03	7.37E-03
<b>Specification MAX</b>	<b>8.80E-03</b>	<b>8.80E-03</b>	<b>8.80E-03</b>	<b>8.80E-03</b>	<b>8.80E-03</b>	<b>8.80E-03</b>	<b>8.80E-03</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

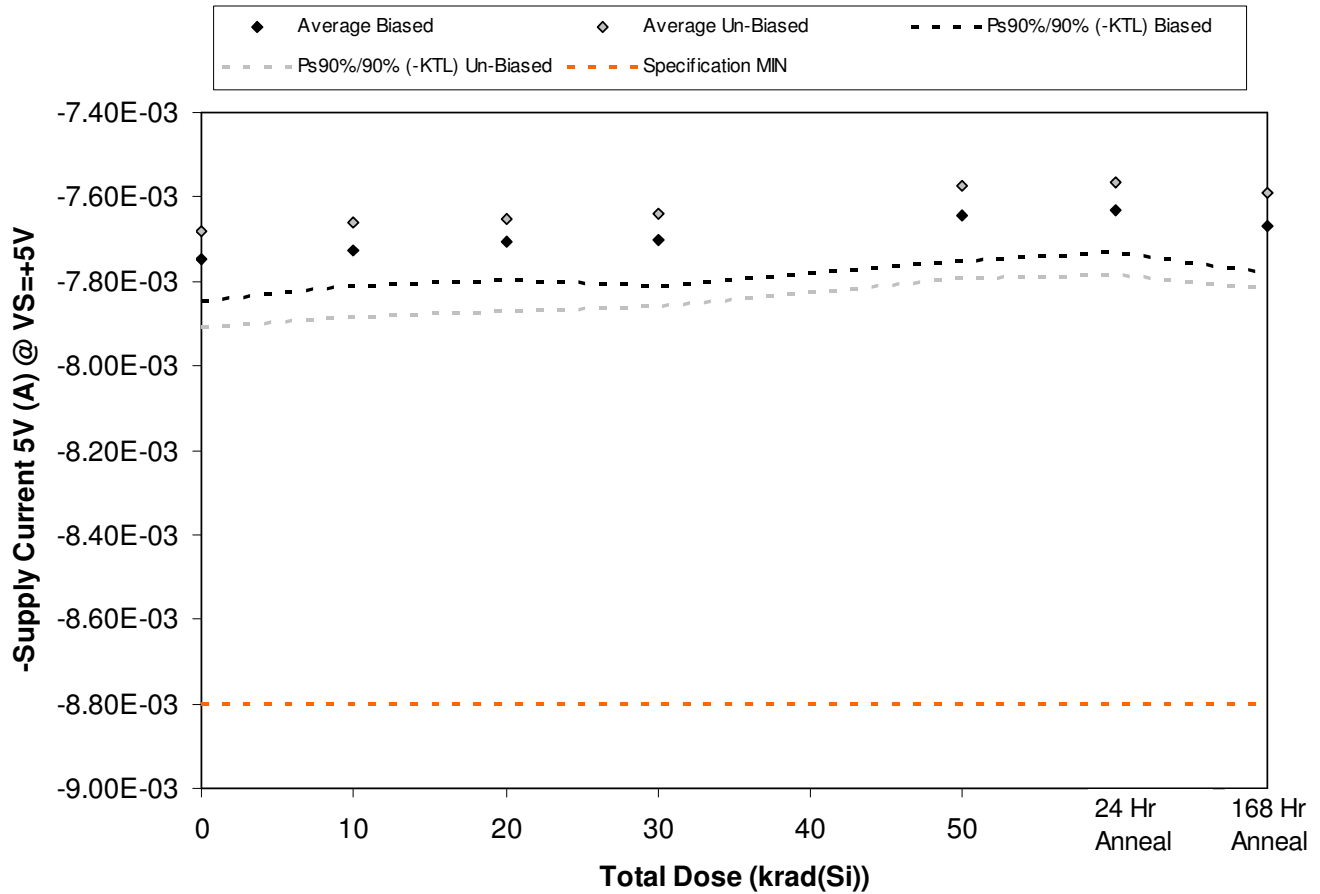


Figure 5.104. Plot of -Supply Current 5V (A) @ VS=+5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.104. Raw data for -Supply Current 5V (A) @ VS=+5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Supply Current 5V (A) @ VS=+5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-7.72E-03	-7.69E-03	-7.68E-03	-7.67E-03	-7.61E-03	-7.61E-03	-7.63E-03
563	-7.79E-03	-7.75E-03	-7.74E-03	-7.73E-03	-7.68E-03	-7.67E-03	-7.71E-03
564	-7.79E-03	-7.77E-03	-7.75E-03	-7.75E-03	-7.70E-03	-7.67E-03	-7.72E-03
567	-7.73E-03	-7.72E-03	-7.69E-03	-7.68E-03	-7.62E-03	-7.61E-03	-7.64E-03
569	-7.72E-03	-7.70E-03	-7.68E-03	-7.67E-03	-7.61E-03	-7.60E-03	-7.64E-03
570	-7.72E-03	-7.71E-03	-7.69E-03	-7.68E-03	-7.61E-03	-7.61E-03	-7.63E-03
571	-7.62E-03	-7.60E-03	-7.59E-03	-7.58E-03	-7.53E-03	-7.51E-03	-7.53E-03
572	-7.78E-03	-7.76E-03	-7.75E-03	-7.74E-03	-7.67E-03	-7.66E-03	-7.69E-03
573	-7.58E-03	-7.56E-03	-7.55E-03	-7.54E-03	-7.47E-03	-7.46E-03	-7.48E-03
574	-7.71E-03	-7.68E-03	-7.69E-03	-7.67E-03	-7.61E-03	-7.60E-03	-7.62E-03
584	-7.70E-03	-7.71E-03	-7.71E-03	-7.72E-03	-7.68E-03	-7.66E-03	-7.68E-03
585	-7.76E-03	-7.75E-03	-7.80E-03	-7.76E-03	-7.74E-03	-7.71E-03	-7.74E-03
<b>Biased Statistics</b>							
Average Biased	-7.75E-03	-7.72E-03	-7.70E-03	-7.70E-03	-7.64E-03	-7.63E-03	-7.67E-03
Std Dev Biased	3.60E-05	3.07E-05	3.42E-05	3.98E-05	3.95E-05	3.53E-05	4.11E-05
Ps90%/90% (+KTL) Biased	-7.65E-03	-7.64E-03	-7.61E-03	-7.59E-03	-7.54E-03	-7.54E-03	-7.56E-03
Ps90%/90% (-KTL) Biased	-7.85E-03	-7.81E-03	-7.80E-03	-7.81E-03	-7.75E-03	-7.73E-03	-7.78E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	-7.68E-03	-7.66E-03	-7.65E-03	-7.64E-03	-7.58E-03	-7.57E-03	-7.59E-03
Std Dev Un-Biased	8.20E-05	8.05E-05	8.06E-05	8.02E-05	7.90E-05	7.99E-05	8.15E-05
Ps90%/90% (+KTL) Un-Biased	-7.46E-03	-7.44E-03	-7.43E-03	-7.42E-03	-7.36E-03	-7.35E-03	-7.37E-03
Ps90%/90% (-KTL) Un-Biased	-7.91E-03	-7.88E-03	-7.87E-03	-7.86E-03	-7.79E-03	-7.79E-03	-7.82E-03
<b>Specification MIN</b>	<b>-8.80E-03</b>	<b>-8.80E-03</b>	<b>-8.80E-03</b>	<b>-8.80E-03</b>	<b>-8.80E-03</b>	<b>-8.80E-03</b>	<b>-8.80E-03</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

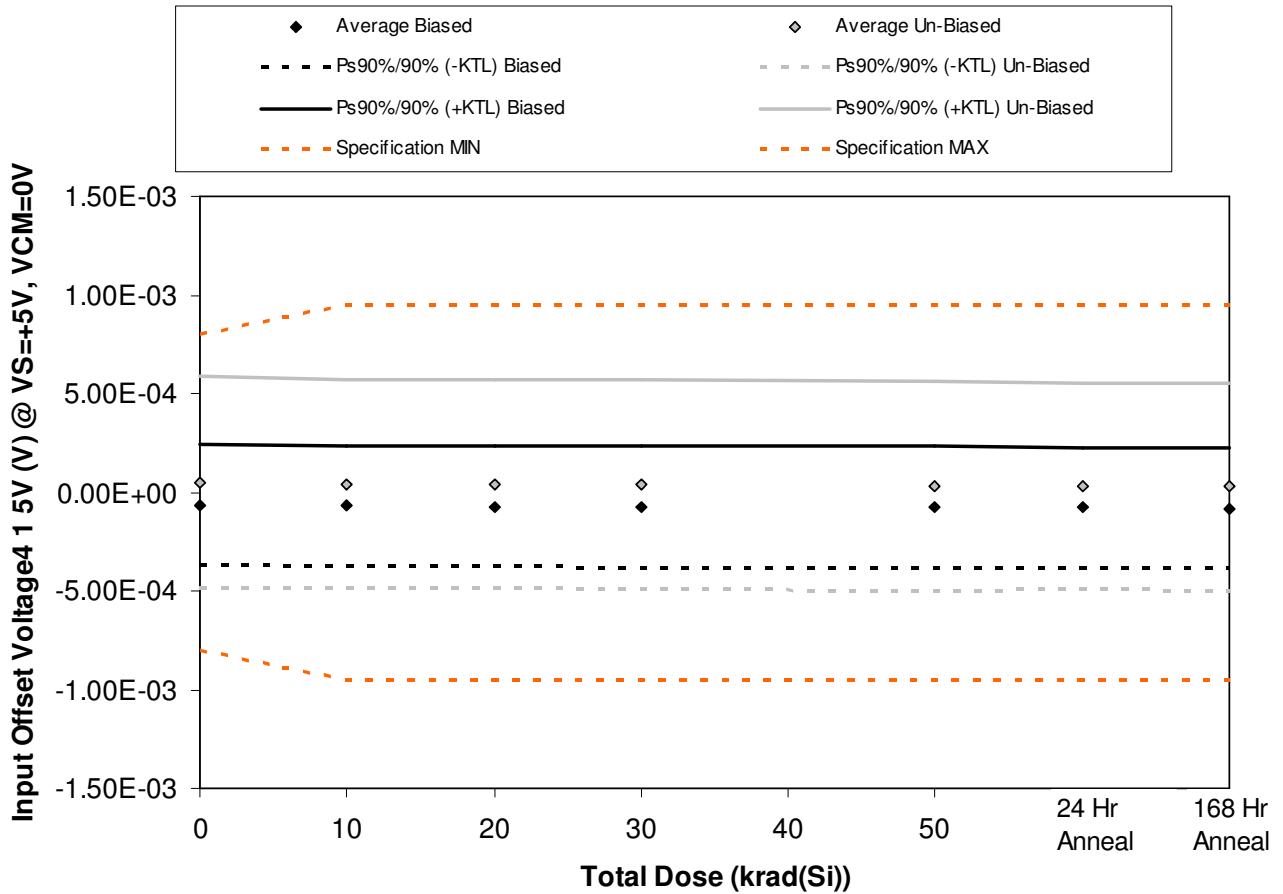


Figure 5.105. Plot of Input Offset Voltage4 1 5V (V) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.105. Raw data for Input Offset Voltage4 1 5V (V) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage4 1 5V (V) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-1.97E-04	-2.05E-04	-2.07E-04	-2.11E-04	-2.17E-04	-2.15E-04	-2.11E-04
563	-7.81E-05	-8.42E-05	-8.65E-05	-8.74E-05	-9.49E-05	-9.35E-05	-1.09E-04
564	4.79E-05	3.98E-05	4.09E-05	4.26E-05	3.34E-05	3.12E-05	3.53E-05
567	5.03E-05	4.15E-05	3.76E-05	3.93E-05	3.93E-05	3.76E-05	3.47E-05
569	-1.40E-04	-1.44E-04	-1.47E-04	-1.47E-04	-1.51E-04	-1.52E-04	-1.50E-04
570	1.82E-04	1.71E-04	1.68E-04	1.66E-04	1.57E-04	1.54E-04	1.59E-04
571	-2.52E-04	-2.58E-04	-2.60E-04	-2.62E-04	-2.68E-04	-2.67E-04	-2.71E-04
572	2.48E-04	2.35E-04	2.33E-04	2.33E-04	2.28E-04	2.24E-04	2.22E-04
573	8.94E-05	8.42E-05	8.18E-05	7.99E-05	7.30E-05	7.06E-05	6.11E-05
574	-7.19E-06	-1.59E-05	-1.37E-05	-1.65E-05	-2.70E-05	-2.69E-05	-2.66E-05
584	-3.53E-04	-3.53E-04	-3.54E-04	-3.54E-04	-3.55E-04	-3.58E-04	-3.57E-04
585	1.81E-04	1.75E-04	1.81E-04	1.77E-04	1.75E-04	1.71E-04	1.75E-04
<b>Biased Statistics</b>							
Average Biased	-6.34E-05	-7.06E-05	-7.25E-05	-7.27E-05	-7.80E-05	-7.83E-05	-7.99E-05
Std Dev Biased	1.11E-04	1.10E-04	1.10E-04	1.13E-04	1.13E-04	1.11E-04	1.11E-04
Ps90%/90% (+KTL) Biased	2.41E-04	2.32E-04	2.30E-04	2.36E-04	2.32E-04	2.27E-04	2.24E-04
Ps90%/90% (-KTL) Biased	-3.68E-04	-3.73E-04	-3.75E-04	-3.81E-04	-3.88E-04	-3.84E-04	-3.84E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.21E-05	4.32E-05	4.19E-05	4.01E-05	3.26E-05	3.09E-05	2.91E-05
Std Dev Un-Biased	1.95E-04	1.93E-04	1.93E-04	1.93E-04	1.93E-04	1.91E-04	1.93E-04
Ps90%/90% (+KTL) Un-Biased	5.87E-04	5.73E-04	5.70E-04	5.69E-04	5.62E-04	5.54E-04	5.57E-04
Ps90%/90% (-KTL) Un-Biased	-4.83E-04	-4.86E-04	-4.86E-04	-4.89E-04	-4.96E-04	-4.93E-04	-4.99E-04
Specification MIN	-8.00E-04	-9.50E-04	-9.50E-04	-9.50E-04	-9.50E-04	-9.50E-04	-9.50E-04
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
Specification MAX	8.00E-04	9.50E-04	9.50E-04	9.50E-04	9.50E-04	9.50E-04	9.50E-04
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

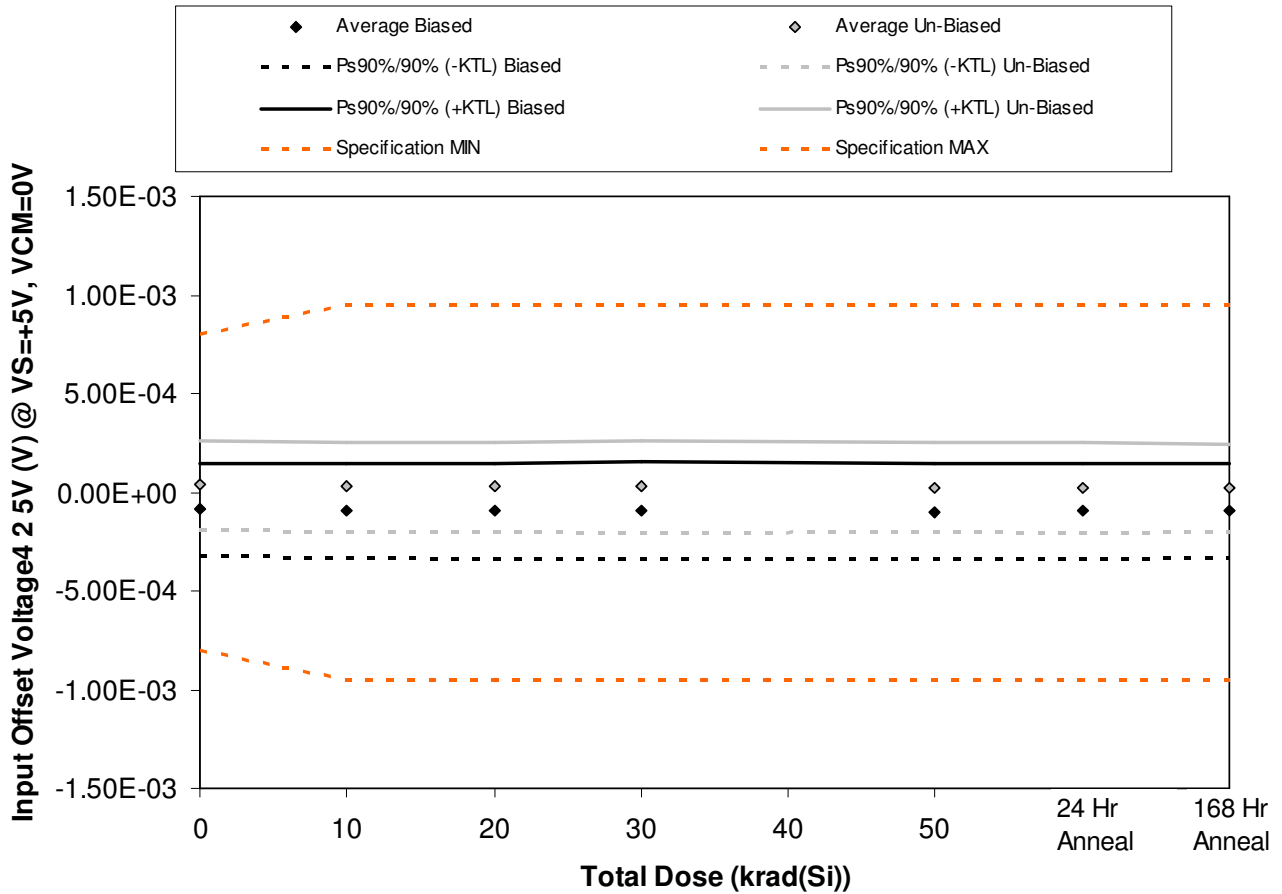


Figure 5.106. Plot of Input Offset Voltage4 2 5V (V) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.106. Raw data for Input Offset Voltage4 2 5V (V) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage4 2 5V (V) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-1.64E-04	-1.71E-04	-1.72E-04	-1.71E-04	-1.72E-04	-1.72E-04	-1.79E-04
563	-1.81E-04	-1.89E-04	-1.89E-04	-1.92E-04	-1.93E-04	-1.89E-04	-1.84E-04
564	1.65E-05	9.83E-06	1.12E-05	1.20E-05	3.44E-06	6.58E-06	1.27E-05
567	-9.45E-05	-9.73E-05	-9.94E-05	-9.73E-05	-1.05E-04	-1.07E-04	-8.70E-05
569	-1.82E-05	-1.95E-05	-2.10E-05	-2.04E-05	-1.99E-05	-2.07E-05	-2.61E-05
570	4.40E-06	-3.45E-06	-4.54E-06	-5.62E-06	-7.91E-06	-9.60E-06	-6.83E-06
571	1.49E-04	1.43E-04	1.43E-04	1.46E-04	1.42E-04	1.43E-04	1.28E-04
572	4.59E-05	3.05E-05	2.96E-05	2.76E-05	2.42E-05	2.37E-05	2.05E-05
573	-7.76E-05	-8.36E-05	-8.25E-05	-8.48E-05	-8.33E-05	-8.49E-05	-9.13E-05
574	6.20E-05	5.49E-05	5.51E-05	5.43E-05	4.62E-05	4.97E-05	4.96E-05
584	-2.91E-04	-2.92E-04	-2.95E-04	-2.93E-04	-2.93E-04	-2.89E-04	-2.91E-04
585	9.88E-05	9.35E-05	9.48E-05	9.27E-05	9.88E-05	9.06E-05	9.53E-05
<b>Biased Statistics</b>							
Average Biased	-8.83E-05	-9.33E-05	-9.40E-05	-9.37E-05	-9.74E-05	-9.65E-05	-9.26E-05
Std Dev Biased	8.70E-05	8.83E-05	8.87E-05	8.97E-05	8.81E-05	8.77E-05	8.85E-05
Ps90%/90% (+KTL) Biased	1.50E-04	1.49E-04	1.49E-04	1.52E-04	1.44E-04	1.44E-04	1.50E-04
Ps90%/90% (-KTL) Biased	-3.27E-04	-3.35E-04	-3.37E-04	-3.40E-04	-3.39E-04	-3.37E-04	-3.35E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.68E-05	2.83E-05	2.81E-05	2.74E-05	2.43E-05	2.43E-05	1.99E-05
Std Dev Un-Biased	8.28E-05	8.29E-05	8.24E-05	8.43E-05	8.22E-05	8.33E-05	7.99E-05
Ps90%/90% (+KTL) Un-Biased	2.64E-04	2.56E-04	2.54E-04	2.59E-04	2.50E-04	2.53E-04	2.39E-04
Ps90%/90% (-KTL) Un-Biased	-1.90E-04	-1.99E-04	-1.98E-04	-2.04E-04	-2.01E-04	-2.04E-04	-1.99E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



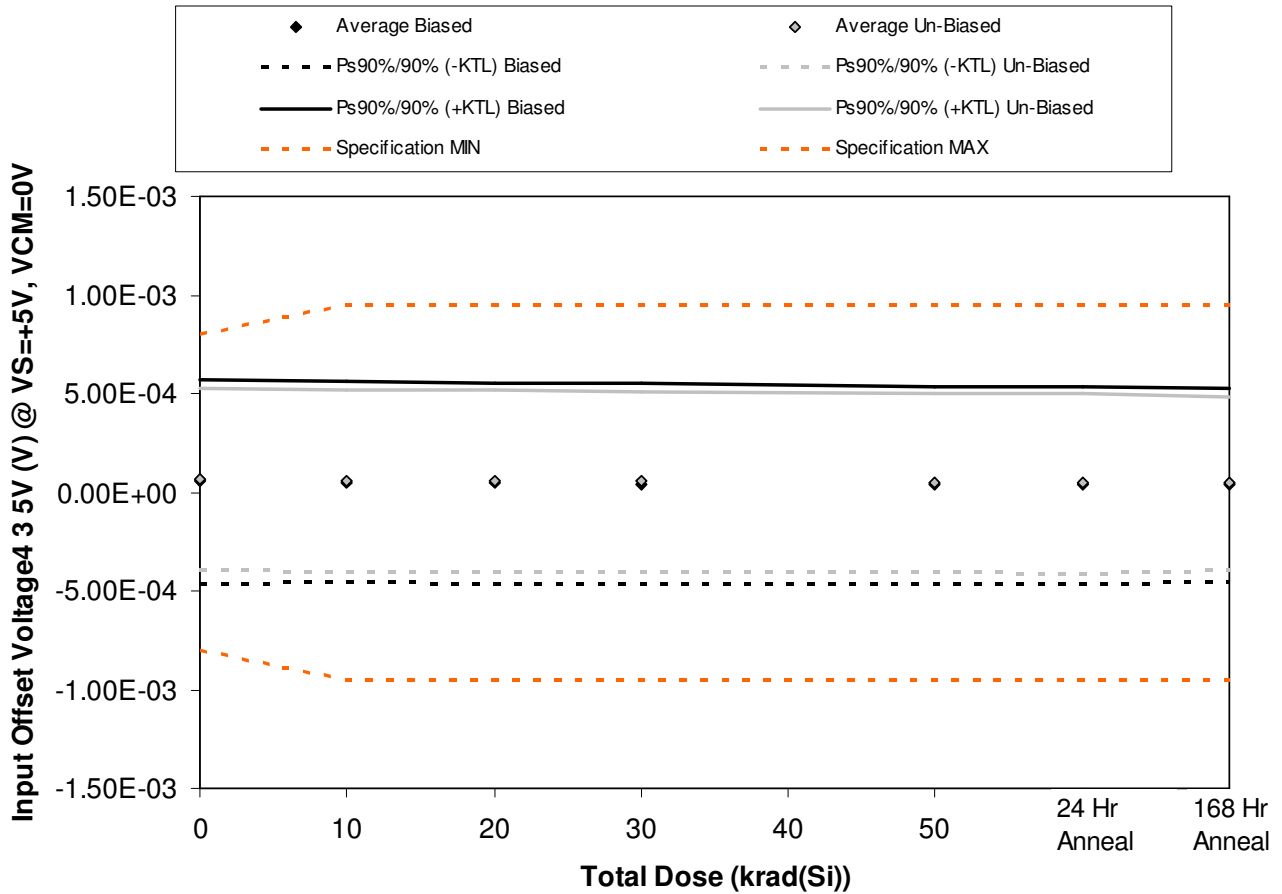


Figure 5.107. Plot of Input Offset Voltage4 3 5V (V) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.107. Raw data for Input Offset Voltage4 3 5V (V) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage4 3 5V (V) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.74E-04	3.64E-04	3.60E-04	3.53E-04	3.45E-04	3.43E-04	3.41E-04
563	-7.14E-05	-7.67E-05	-7.95E-05	-8.57E-05	-8.25E-05	-8.25E-05	-7.89E-05
564	2.52E-05	2.03E-05	1.39E-05	1.25E-05	5.97E-06	2.47E-06	-3.33E-06
567	5.23E-05	5.08E-05	4.52E-05	4.04E-05	3.83E-05	3.62E-05	3.28E-05
569	-9.87E-05	-1.03E-04	-1.07E-04	-1.13E-04	-1.14E-04	-1.22E-04	-1.12E-04
570	-1.65E-04	-1.72E-04	-1.74E-04	-1.75E-04	-1.80E-04	-1.82E-04	-1.77E-04
571	-1.90E-07	-9.97E-06	-1.25E-05	-1.72E-05	-2.47E-05	-2.45E-05	-1.21E-05
572	2.74E-04	2.65E-04	2.60E-04	2.54E-04	2.45E-04	2.44E-04	2.34E-04
573	1.74E-04	1.70E-04	1.69E-04	1.68E-04	1.59E-04	1.60E-04	1.57E-04
574	5.02E-05	4.52E-05	4.24E-05	3.78E-05	3.17E-05	3.04E-05	2.49E-05
584	4.19E-04	4.22E-04	4.21E-04	4.21E-04	4.20E-04	4.17E-04	4.19E-04
585	8.34E-05	8.19E-05	7.95E-05	7.66E-05	8.17E-05	7.21E-05	7.84E-05
<b>Biased Statistics</b>							
Average Biased	5.64E-05	5.10E-05	4.65E-05	4.15E-05	3.86E-05	3.54E-05	3.59E-05
Std Dev Biased	1.89E-04	1.86E-04	1.86E-04	1.85E-04	1.82E-04	1.83E-04	1.80E-04
Ps90%/90% (+KTL) Biased	5.74E-04	5.61E-04	5.58E-04	5.50E-04	5.38E-04	5.38E-04	5.30E-04
Ps90%/90% (-KTL) Biased	-4.61E-04	-4.59E-04	-4.65E-04	-4.67E-04	-4.61E-04	-4.67E-04	-4.58E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.66E-05	5.97E-05	5.70E-05	5.35E-05	4.62E-05	4.57E-05	4.52E-05
Std Dev Un-Biased	1.68E-04	1.68E-04	1.67E-04	1.66E-04	1.65E-04	1.65E-04	1.59E-04
Ps90%/90% (+KTL) Un-Biased	5.28E-04	5.20E-04	5.16E-04	5.10E-04	4.98E-04	4.99E-04	4.81E-04
Ps90%/90% (-KTL) Un-Biased	-3.95E-04	-4.01E-04	-4.02E-04	-4.03E-04	-4.06E-04	-4.07E-04	-3.90E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

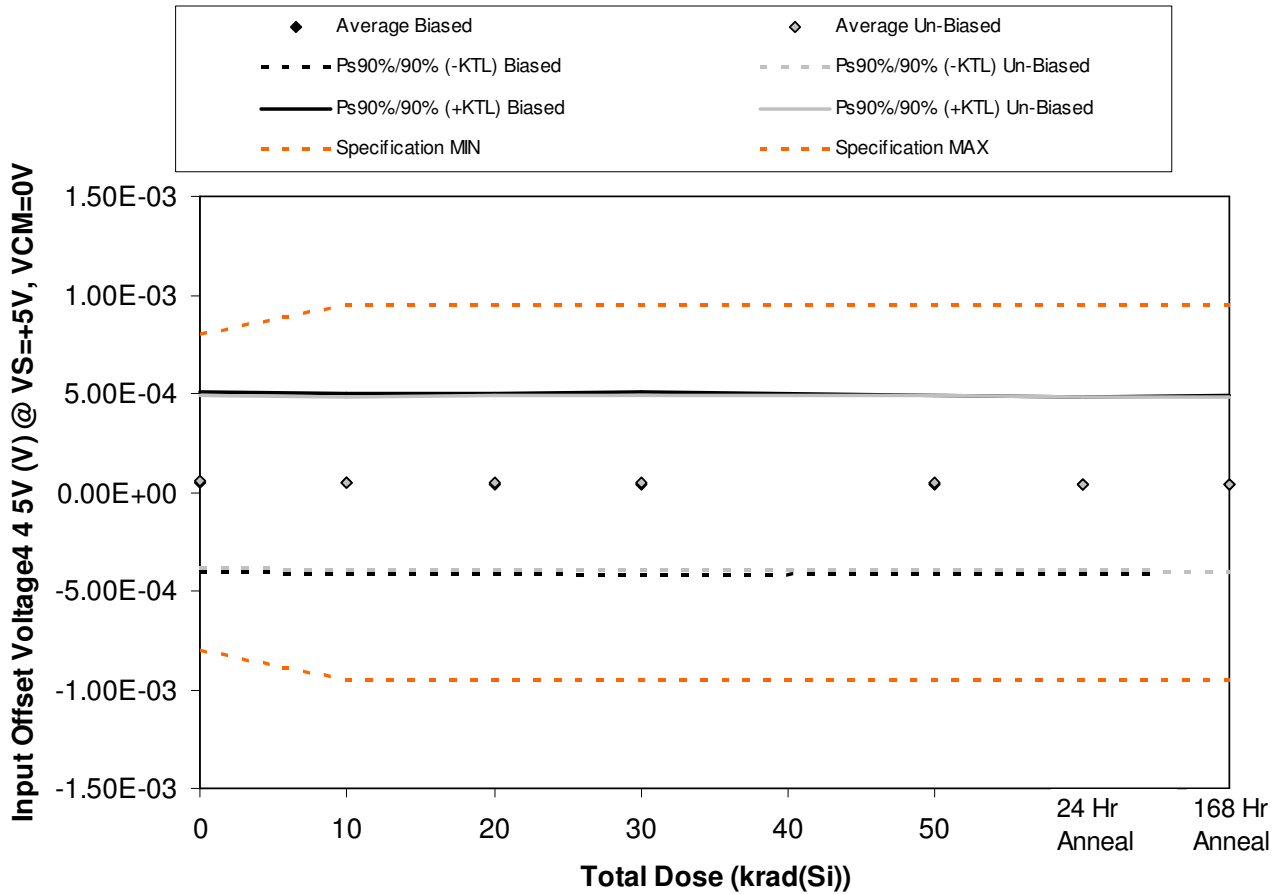


Figure 5.108. Plot of Input Offset Voltage4 4 5V (V) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.108. Raw data for Input Offset Voltage4 4 5V (V) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage4 4 5V (V) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	8.92E-06	-1.16E-06	-3.45E-06	-4.90E-06	-1.03E-05	-1.19E-05	-6.35E-06
563	7.00E-05	6.11E-05	5.88E-05	5.98E-05	5.36E-05	5.05E-05	6.13E-05
564	1.88E-04	1.83E-04	1.85E-04	1.84E-04	1.75E-04	1.70E-04	1.75E-04
567	1.99E-04	1.94E-04	1.94E-04	1.95E-04	1.89E-04	1.86E-04	1.87E-04
569	-2.09E-04	-2.12E-04	-2.14E-04	-2.19E-04	-2.14E-04	-2.16E-04	-2.13E-04
570	1.41E-04	1.30E-04	1.30E-04	1.32E-04	1.37E-04	1.33E-04	1.29E-04
571	1.75E-04	1.67E-04	1.69E-04	1.66E-04	1.63E-04	1.59E-04	1.63E-04
572	3.74E-05	2.60E-05	2.25E-05	2.28E-05	1.65E-05	1.46E-05	2.08E-05
573	1.41E-04	1.34E-04	1.37E-04	1.40E-04	1.40E-04	1.35E-04	1.26E-04
574	-2.16E-04	-2.23E-04	-2.22E-04	-2.22E-04	-2.21E-04	-2.23E-04	-2.33E-04
584	2.38E-04	2.37E-04	2.38E-04	2.38E-04	2.34E-04	2.30E-04	2.34E-04
585	-1.22E-04	-1.22E-04	-1.21E-04	-1.20E-04	-1.21E-04	-1.24E-04	-1.22E-04
<b>Biased Statistics</b>							
Average Biased	5.13E-05	4.50E-05	4.41E-05	4.29E-05	3.87E-05	3.58E-05	4.10E-05
Std Dev Biased	1.66E-04	1.66E-04	1.67E-04	1.69E-04	1.64E-04	1.63E-04	1.63E-04
Ps90%/90% (+KTL) Biased	5.07E-04	5.00E-04	5.01E-04	5.06E-04	4.88E-04	4.84E-04	4.88E-04
Ps90%/90% (-KTL) Biased	-4.05E-04	-4.10E-04	-4.13E-04	-4.20E-04	-4.11E-04	-4.12E-04	-4.07E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.56E-05	4.68E-05	4.72E-05	4.81E-05	4.71E-05	4.35E-05	4.12E-05
Std Dev Un-Biased	1.60E-04	1.60E-04	1.61E-04	1.60E-04	1.60E-04	1.59E-04	1.62E-04
Ps90%/90% (+KTL) Un-Biased	4.95E-04	4.86E-04	4.87E-04	4.88E-04	4.87E-04	4.80E-04	4.86E-04
Ps90%/90% (-KTL) Un-Biased	-3.84E-04	-3.92E-04	-3.93E-04	-3.92E-04	-3.93E-04	-3.93E-04	-4.03E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

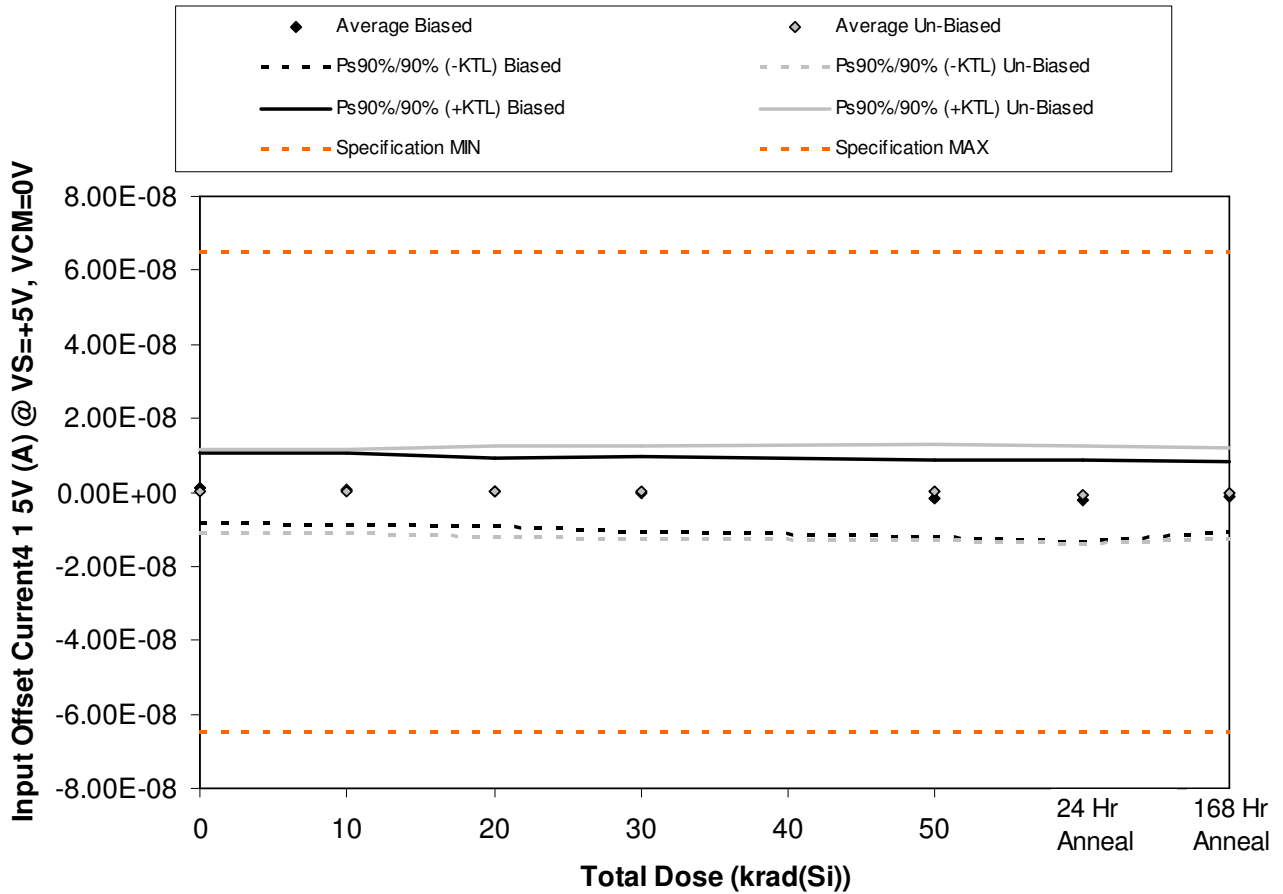


Figure 5.109. Plot of Input Offset Current4 1 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.109. Raw data for Input Offset Current<sub>4</sub> 1 5V (A) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current <sub>4</sub> 1 5V (A) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.39E-09	2.13E-09	1.30E-09	8.90E-10	-3.00E-10	-1.28E-09	2.80E-10
563	-3.77E-09	-4.36E-09	-4.45E-09	-5.06E-09	-6.30E-09	-7.04E-09	-5.72E-09
564	3.00E-11	-1.70E-10	-1.01E-09	-1.93E-09	-3.25E-09	-4.45E-09	-2.63E-09
567	5.62E-09	5.36E-09	4.73E-09	5.01E-09	3.99E-09	3.68E-09	3.48E-09
569	1.96E-09	7.40E-10	1.40E-10	-7.20E-10	-2.13E-09	-2.59E-09	-1.16E-09
570	5.10E-10	3.70E-10	7.70E-10	7.60E-10	7.60E-10	5.40E-10	5.50E-10
571	-5.46E-09	-5.73E-09	-6.33E-09	-6.59E-09	-6.70E-09	-7.64E-09	-6.39E-09
572	2.93E-09	2.85E-09	2.77E-09	3.26E-09	2.80E-09	2.00E-09	1.96E-09
573	-1.83E-09	-1.81E-09	-1.98E-09	-1.94E-09	-2.05E-09	-3.22E-09	-2.41E-09
574	5.34E-09	5.08E-09	5.26E-09	4.76E-09	5.49E-09	4.55E-09	5.35E-09
584	-7.95E-09	-8.68E-09	-9.01E-09	-9.38E-09	-9.57E-09	-9.76E-09	-9.83E-09
585	1.96E-09	1.60E-10	1.30E-10	1.20E-10	4.00E-11	-9.00E-11	-2.50E-10
<b>Biased Statistics</b>							
Average Biased	1.25E-09	7.40E-10	1.42E-10	-3.62E-10	-1.60E-09	-2.34E-09	-1.15E-09
Std Dev Biased	3.45E-09	3.54E-09	3.35E-09	3.71E-09	3.81E-09	4.00E-09	3.41E-09
Ps90%/90% (+KTL) Biased	1.07E-08	1.04E-08	9.32E-09	9.81E-09	8.85E-09	8.63E-09	8.20E-09
Ps90%/90% (-KTL) Biased	-8.21E-09	-8.97E-09	-9.03E-09	-1.05E-08	-1.20E-08	-1.33E-08	-1.05E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	2.98E-10	1.52E-10	9.80E-11	5.00E-11	6.00E-11	-7.54E-10	-1.88E-10
Std Dev Un-Biased	4.19E-09	4.19E-09	4.47E-09	4.50E-09	4.68E-09	4.77E-09	4.45E-09
Ps90%/90% (+KTL) Un-Biased	1.18E-08	1.16E-08	1.24E-08	1.24E-08	1.29E-08	1.23E-08	1.20E-08
Ps90%/90% (-KTL) Un-Biased	-1.12E-08	-1.13E-08	-1.22E-08	-1.23E-08	-1.28E-08	-1.38E-08	-1.24E-08
<b>Specification MIN</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

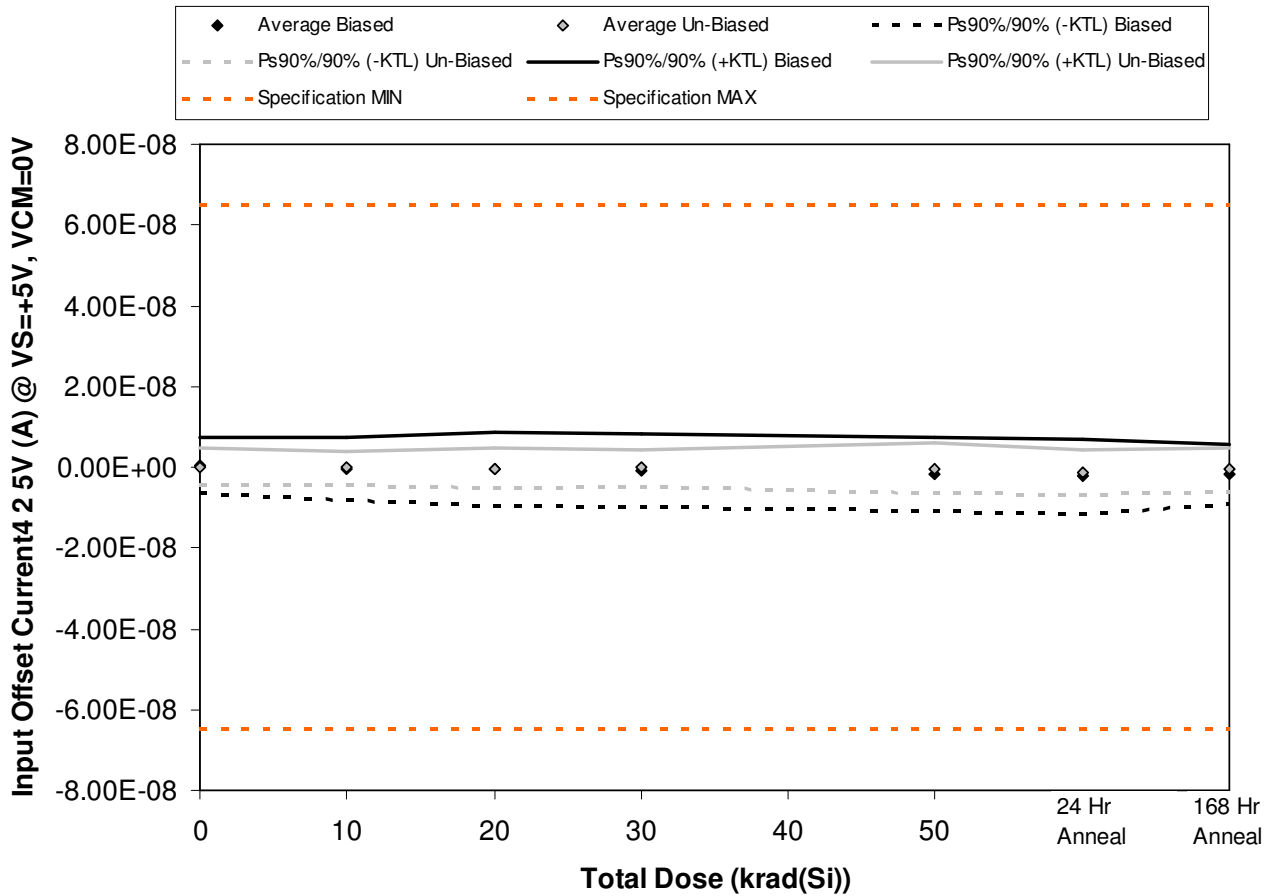


Figure 5.110. Plot of Input Offset Current4 2 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.110. Raw data for Input Offset Current<sub>4 2 5V (A)</sub> @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current <sub>4 2 5V (A)</sub> @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.81E-09	2.38E-09	2.05E-09	1.68E-09	7.30E-10	-2.10E-10	4.50E-10
563	-2.27E-09	-2.88E-09	-3.24E-09	-3.88E-09	-4.26E-09	-5.31E-09	-4.16E-09
564	-2.33E-09	-3.31E-09	-4.18E-09	-4.80E-09	-5.29E-09	-6.13E-09	-4.67E-09
567	6.50E-10	-3.30E-10	-1.80E-10	-7.90E-10	-1.69E-09	-2.16E-09	-1.76E-09
569	2.72E-09	2.78E-09	3.30E-09	2.80E-09	2.65E-09	2.11E-09	1.37E-09
570	-1.63E-09	-1.53E-09	-2.10E-09	-1.94E-09	-2.62E-09	-3.06E-09	-2.47E-09
571	-1.60E-10	-8.60E-10	-8.80E-10	-1.20E-10	-1.29E-09	-2.42E-09	-1.83E-09
572	2.20E-09	1.91E-09	2.23E-09	1.94E-09	2.97E-09	1.84E-09	2.16E-09
573	1.46E-09	1.08E-09	8.00E-10	8.30E-10	1.00E-09	1.00E-10	6.60E-10
574	-1.14E-09	-1.25E-09	-1.55E-09	-1.52E-09	-1.32E-09	-2.12E-09	-1.75E-09
584	3.03E-09	2.52E-09	1.98E-09	1.74E-09	1.64E-09	1.41E-09	1.22E-09
585	2.51E-09	7.50E-10	6.50E-10	6.20E-10	6.00E-10	5.70E-10	5.20E-10
<b>Biased Statistics</b>							
Average Biased	3.16E-10	-2.72E-10	-4.50E-10	-9.98E-10	-1.57E-09	-2.34E-09	-1.75E-09
Std Dev Biased	2.54E-09	2.85E-09	3.24E-09	3.33E-09	3.32E-09	3.45E-09	2.69E-09
Ps90%/90% (+KTL) Biased	7.28E-09	7.53E-09	8.44E-09	8.14E-09	7.54E-09	7.11E-09	5.62E-09
Ps90%/90% (-KTL) Biased	-6.65E-09	-8.07E-09	-9.34E-09	-1.01E-08	-1.07E-08	-1.18E-08	-9.13E-09
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.46E-10	-1.30E-10	-3.00E-10	-1.62E-10	-2.52E-10	-1.13E-09	-6.46E-10
Std Dev Un-Biased	1.65E-09	1.53E-09	1.79E-09	1.61E-09	2.22E-09	2.04E-09	1.97E-09
Ps90%/90% (+KTL) Un-Biased	4.66E-09	4.07E-09	4.60E-09	4.26E-09	5.84E-09	4.47E-09	4.76E-09
Ps90%/90% (-KTL) Un-Biased	-4.37E-09	-4.33E-09	-5.20E-09	-4.59E-09	-6.35E-09	-6.74E-09	-6.05E-09
<b>Specification MIN</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



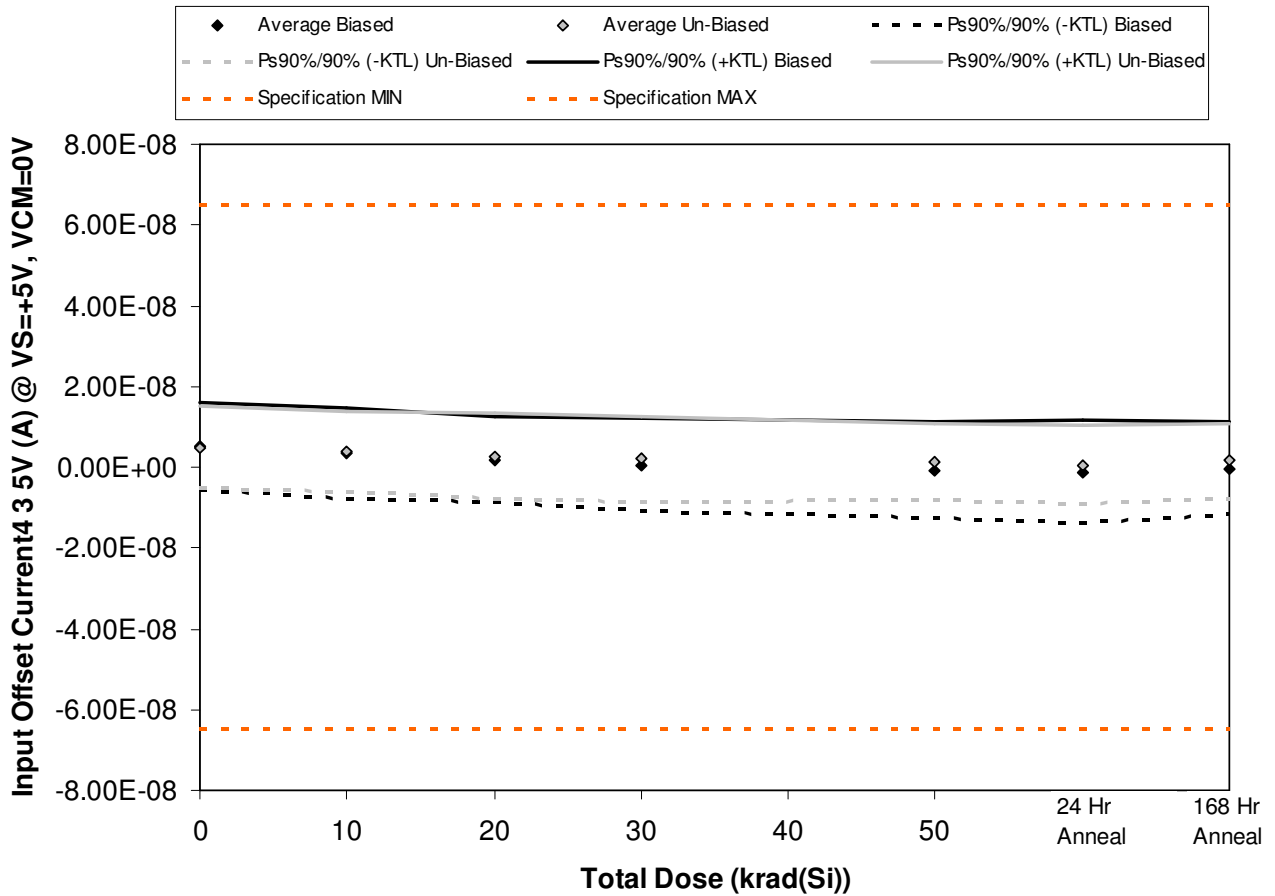


Figure 5.111. Plot of Input Offset Current4 3 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.111. Raw data for Input Offset Current<sub>4 3 5V (A)</sub> @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current <sub>4 3 5V (A)</sub> @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	4.73E-09	2.83E-09	1.70E-09	3.40E-10	-1.56E-09	-2.08E-09	-4.50E-10
563	4.55E-09	3.34E-09	1.54E-09	3.90E-10	-8.90E-10	-1.85E-09	-1.33E-09
564	3.99E-09	1.70E-09	2.80E-10	-8.50E-10	-1.84E-09	-2.01E-09	-2.21E-09
567	1.15E-08	1.01E-08	8.22E-09	7.45E-09	6.40E-09	6.26E-09	6.65E-09
569	7.50E-10	-7.10E-10	-2.06E-09	-4.13E-09	-5.63E-09	-6.56E-09	-4.48E-09
570	7.39E-09	6.22E-09	5.05E-09	4.49E-09	3.93E-09	3.00E-09	3.38E-09
571	2.69E-09	1.66E-09	4.20E-10	5.30E-10	-9.30E-10	-1.81E-09	-2.30E-10
572	5.46E-09	4.37E-09	3.47E-09	2.62E-09	2.10E-09	1.01E-09	1.86E-09
573	9.14E-09	7.97E-09	7.10E-09	6.52E-09	5.33E-09	4.88E-09	5.86E-09
574	-1.70E-10	-1.23E-09	-2.67E-09	-3.54E-09	-3.18E-09	-4.08E-09	-3.08E-09
584	5.95E-09	4.83E-09	3.44E-09	2.61E-09	2.01E-09	1.89E-09	1.79E-09
585	-9.40E-10	-3.33E-09	-4.36E-09	-5.04E-09	-5.68E-09	-5.80E-09	-5.77E-09
<b>Biased Statistics</b>							
Average Biased	5.11E-09	3.45E-09	1.94E-09	6.40E-10	-7.04E-10	-1.25E-09	-3.64E-10
Std Dev Biased	3.94E-09	4.03E-09	3.82E-09	4.23E-09	4.38E-09	4.64E-09	4.20E-09
Ps90%/90% (+KTL) Biased	1.59E-08	1.45E-08	1.24E-08	1.22E-08	1.13E-08	1.15E-08	1.11E-08
Ps90%/90% (-KTL) Biased	-5.69E-09	-7.61E-09	-8.54E-09	-1.10E-08	-1.27E-08	-1.40E-08	-1.19E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	4.90E-09	3.80E-09	2.67E-09	2.12E-09	1.45E-09	6.00E-10	1.56E-09
Std Dev Un-Biased	3.71E-09	3.66E-09	3.86E-09	3.87E-09	3.49E-09	3.60E-09	3.41E-09
Ps90%/90% (+KTL) Un-Biased	1.51E-08	1.38E-08	1.33E-08	1.27E-08	1.10E-08	1.05E-08	1.09E-08
Ps90%/90% (-KTL) Un-Biased	-5.27E-09	-6.23E-09	-7.90E-09	-8.48E-09	-8.12E-09	-9.28E-09	-7.80E-09
<b>Specification MIN</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

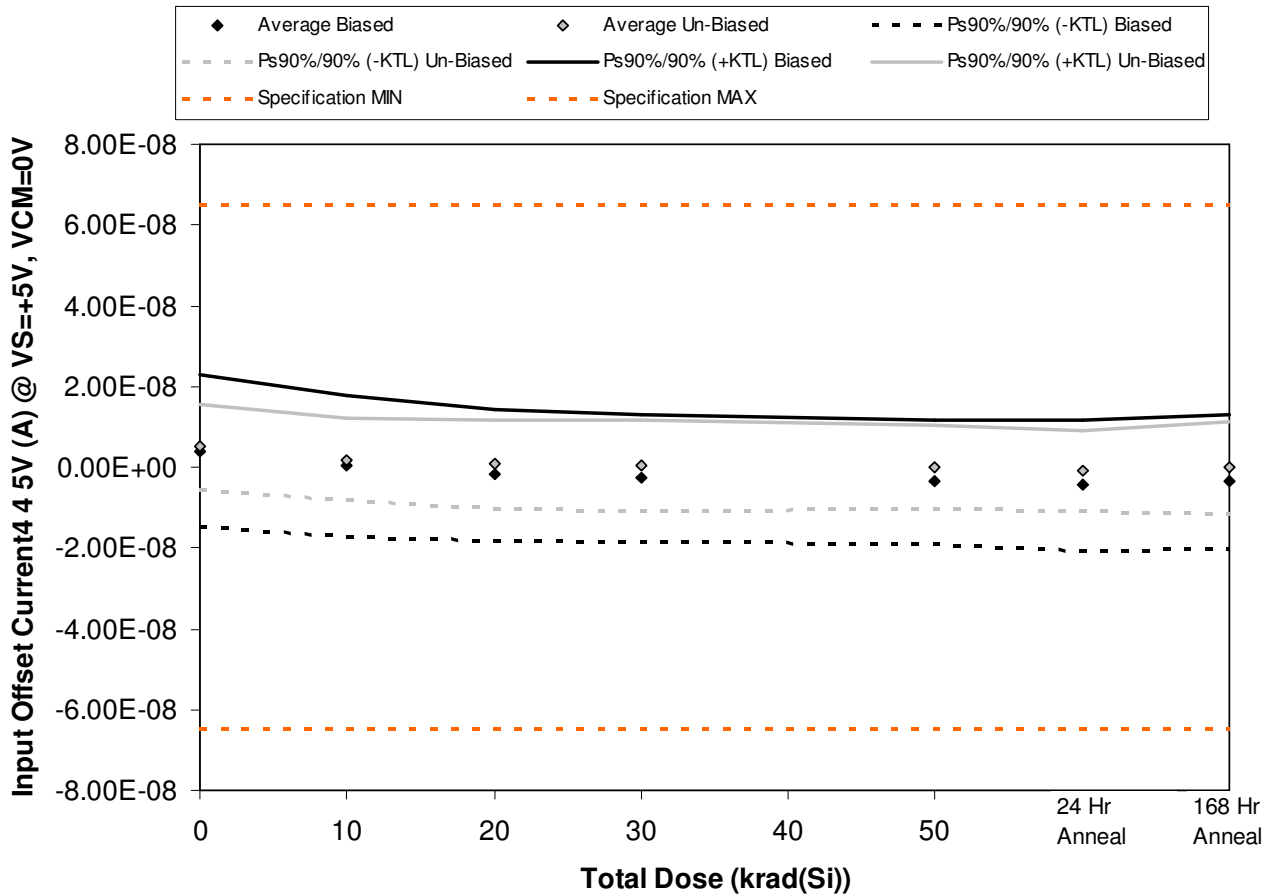


Figure 5.112. Plot of Input Offset Current 4 4 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.112. Raw data for Input Offset Current4 4 5V (A) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current4 4 5V (A) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	2.12E-09	-1.99E-09	-3.40E-09	-4.58E-09	-5.16E-09	-5.89E-09	-5.05E-09
563	-1.00E-09	-4.87E-09	-7.08E-09	-7.34E-09	-8.75E-09	-1.02E-08	-8.85E-09
564	1.42E-08	1.00E-08	6.98E-09	6.03E-09	4.88E-09	4.26E-09	5.46E-09
567	7.32E-09	3.42E-09	1.16E-09	2.10E-10	-1.07E-09	-1.56E-09	-7.20E-10
569	-2.74E-09	-4.97E-09	-6.57E-09	-7.50E-09	-8.09E-09	-9.08E-09	-9.07E-09
570	4.05E-09	8.70E-10	-5.00E-10	-5.20E-10	-1.01E-09	-1.67E-09	-9.50E-10
571	7.65E-09	4.31E-09	3.14E-09	2.73E-09	2.57E-09	1.36E-09	2.25E-09
572	7.90E-10	-2.28E-09	-3.66E-09	-4.53E-09	-3.73E-09	-4.75E-09	-4.74E-09
573	1.02E-08	7.08E-09	6.28E-09	6.05E-09	5.41E-09	4.14E-09	5.62E-09
574	2.44E-09	-4.40E-10	-1.79E-09	-1.97E-09	-2.70E-09	-3.73E-09	-3.26E-09
584	3.78E-09	8.50E-10	-5.70E-10	-1.25E-09	-1.73E-09	-1.89E-09	-2.12E-09
585	-1.65E-09	-5.97E-09	-6.95E-09	-7.47E-09	-8.06E-09	-8.23E-09	-8.19E-09
<b>Biased Statistics</b>							
Average Biased	3.98E-09	3.26E-10	-1.78E-09	-2.64E-09	-3.64E-09	-4.50E-09	-3.65E-09
Std Dev Biased	6.87E-09	6.41E-09	5.90E-09	5.76E-09	5.64E-09	5.94E-09	6.12E-09
Ps90%/90% (+KTL) Biased	2.28E-08	1.79E-08	1.44E-08	1.32E-08	1.18E-08	1.18E-08	1.31E-08
Ps90%/90% (-KTL) Biased	-1.49E-08	-1.72E-08	-1.79E-08	-1.84E-08	-1.91E-08	-2.08E-08	-2.04E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.02E-09	1.91E-09	6.94E-10	3.52E-10	1.08E-10	-9.30E-10	-2.16E-10
Std Dev Un-Biased	3.84E-09	3.76E-09	3.99E-09	4.13E-09	3.81E-09	3.67E-09	4.20E-09
Ps90%/90% (+KTL) Un-Biased	1.56E-08	1.22E-08	1.16E-08	1.17E-08	1.06E-08	9.14E-09	1.13E-08
Ps90%/90% (-KTL) Un-Biased	-5.51E-09	-8.41E-09	-1.03E-08	-1.10E-08	-1.03E-08	-1.10E-08	-1.17E-08
<b>Specification MIN</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

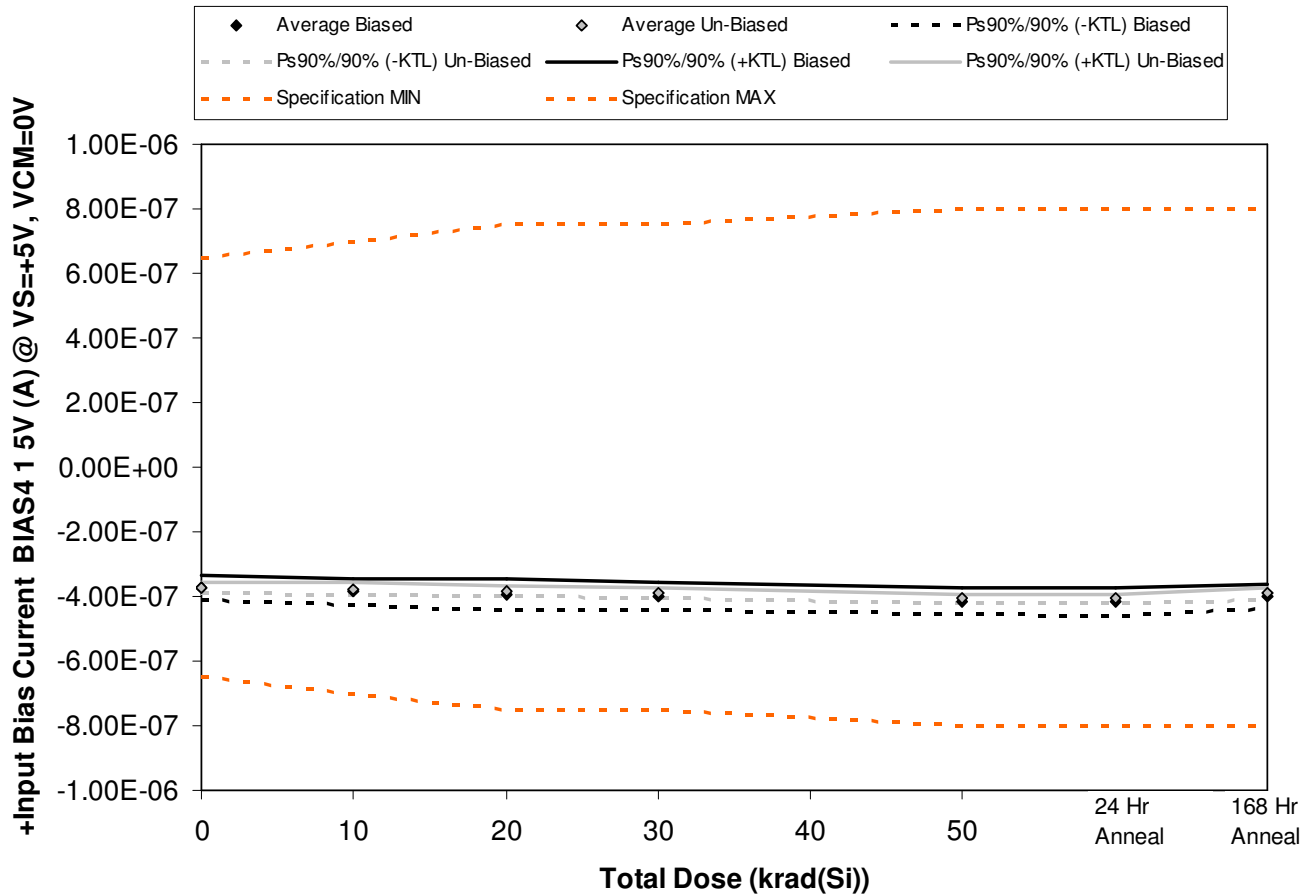


Figure 5.113. Plot of +Input Bias Current BIAS4 1 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.113. Raw data for +Input Bias Current BIAS4 1 5V (A) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS4 1 5V (A) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.51E-07	-3.62E-07	-3.68E-07	-3.74E-07	-3.91E-07	-3.90E-07	-3.75E-07
563	-3.72E-07	-3.86E-07	-3.93E-07	-3.97E-07	-4.13E-07	-4.15E-07	-3.95E-07
564	-3.78E-07	-3.92E-07	-4.01E-07	-4.04E-07	-4.20E-07	-4.21E-07	-4.03E-07
567	-3.88E-07	-4.01E-07	-4.13E-07	-4.16E-07	-4.30E-07	-4.30E-07	-4.12E-07
569	-3.76E-07	-3.90E-07	-4.01E-07	-4.05E-07	-4.20E-07	-4.19E-07	-4.03E-07
570	-3.84E-07	-3.87E-07	-3.93E-07	-4.01E-07	-4.17E-07	-4.15E-07	-4.03E-07
571	-3.72E-07	-3.74E-07	-3.83E-07	-3.89E-07	-4.07E-07	-4.07E-07	-3.91E-07
572	-3.66E-07	-3.71E-07	-3.78E-07	-3.86E-07	-4.04E-07	-4.02E-07	-3.86E-07
573	-3.72E-07	-3.76E-07	-3.83E-07	-3.89E-07	-4.06E-07	-4.05E-07	-3.90E-07
574	-3.71E-07	-3.74E-07	-3.81E-07	-3.88E-07	-4.04E-07	-4.06E-07	-3.89E-07
584	-3.55E-07	-3.52E-07	-3.53E-07	-3.55E-07	-3.57E-07	-3.58E-07	-3.58E-07
585	-3.63E-07	-3.64E-07	-3.62E-07	-3.63E-07	-3.62E-07	-3.65E-07	-3.67E-07
<b>Biased Statistics</b>							
Average Biased	-3.73E-07	-3.86E-07	-3.95E-07	-3.99E-07	-4.15E-07	-4.15E-07	-3.98E-07
Std Dev Biased	1.36E-08	1.48E-08	1.69E-08	1.54E-08	1.48E-08	1.53E-08	1.40E-08
Ps90%/90% (+KTL) Biased	-3.36E-07	-3.45E-07	-3.49E-07	-3.57E-07	-3.74E-07	-3.73E-07	-3.59E-07
Ps90%/90% (-KTL) Biased	-4.10E-07	-4.27E-07	-4.42E-07	-4.42E-07	-4.55E-07	-4.57E-07	-4.36E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.73E-07	-3.76E-07	-3.84E-07	-3.91E-07	-4.08E-07	-4.07E-07	-3.92E-07
Std Dev Un-Biased	6.62E-09	6.38E-09	5.62E-09	5.78E-09	5.24E-09	4.82E-09	6.22E-09
Ps90%/90% (+KTL) Un-Biased	-3.55E-07	-3.59E-07	-3.68E-07	-3.75E-07	-3.93E-07	-3.94E-07	-3.75E-07
Ps90%/90% (-KTL) Un-Biased	-3.91E-07	-3.94E-07	-3.99E-07	-4.06E-07	-4.22E-07	-4.20E-07	-4.09E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

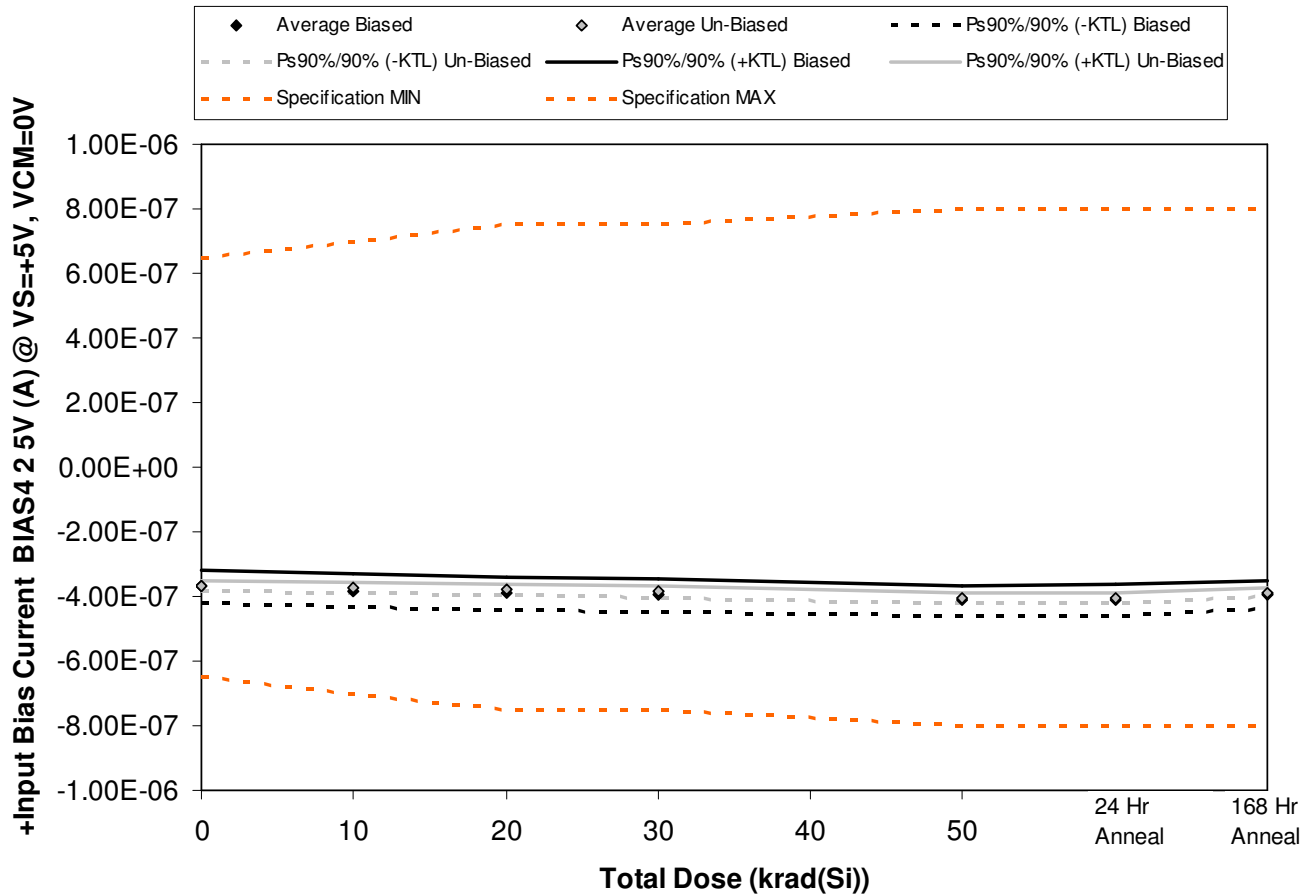


Figure 5.114. Plot of +Input Bias Current BIAS4 2 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.114. Raw data for +Input Bias Current BIAS4 2 5V (A) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS4 2 5V (A) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.44E-07	-3.54E-07	-3.62E-07	-3.68E-07	-3.86E-07	-3.85E-07	-3.70E-07
563	-3.92E-07	-4.03E-07	-4.11E-07	-4.17E-07	-4.31E-07	-4.32E-07	-4.13E-07
564	-3.77E-07	-3.90E-07	-4.00E-07	-4.03E-07	-4.18E-07	-4.21E-07	-4.00E-07
567	-3.74E-07	-3.87E-07	-3.96E-07	-4.01E-07	-4.15E-07	-4.16E-07	-3.97E-07
569	-3.61E-07	-3.75E-07	-3.84E-07	-3.90E-07	-4.05E-07	-4.05E-07	-3.87E-07
570	-3.77E-07	-3.80E-07	-3.87E-07	-3.94E-07	-4.12E-07	-4.10E-07	-3.95E-07
571	-3.71E-07	-3.75E-07	-3.83E-07	-3.90E-07	-4.08E-07	-4.07E-07	-3.89E-07
572	-3.64E-07	-3.67E-07	-3.74E-07	-3.81E-07	-4.01E-07	-4.00E-07	-3.83E-07
573	-3.64E-07	-3.66E-07	-3.73E-07	-3.79E-07	-3.96E-07	-3.95E-07	-3.81E-07
574	-3.68E-07	-3.70E-07	-3.78E-07	-3.84E-07	-4.04E-07	-4.05E-07	-3.86E-07
584	-3.74E-07	-3.73E-07	-3.72E-07	-3.74E-07	-3.76E-07	-3.79E-07	-3.78E-07
585	-3.73E-07	-3.75E-07	-3.72E-07	-3.72E-07	-3.71E-07	-3.75E-07	-3.76E-07
<b>Biased Statistics</b>							
Average Biased	-3.69E-07	-3.82E-07	-3.91E-07	-3.96E-07	-4.11E-07	-4.12E-07	-3.93E-07
Std Dev Biased	1.81E-08	1.83E-08	1.89E-08	1.83E-08	1.68E-08	1.79E-08	1.63E-08
Ps90%/90% (+KTL) Biased	-3.20E-07	-3.32E-07	-3.39E-07	-3.46E-07	-3.65E-07	-3.63E-07	-3.49E-07
Ps90%/90% (-KTL) Biased	-4.19E-07	-4.32E-07	-4.42E-07	-4.46E-07	-4.57E-07	-4.61E-07	-4.38E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.69E-07	-3.72E-07	-3.79E-07	-3.86E-07	-4.04E-07	-4.03E-07	-3.87E-07
Std Dev Un-Biased	5.51E-09	5.68E-09	5.91E-09	6.28E-09	5.97E-09	5.74E-09	5.62E-09
Ps90%/90% (+KTL) Un-Biased	-3.54E-07	-3.56E-07	-3.63E-07	-3.68E-07	-3.88E-07	-3.88E-07	-3.71E-07
Ps90%/90% (-KTL) Un-Biased	-3.84E-07	-3.87E-07	-3.95E-07	-4.03E-07	-4.21E-07	-4.19E-07	-4.02E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



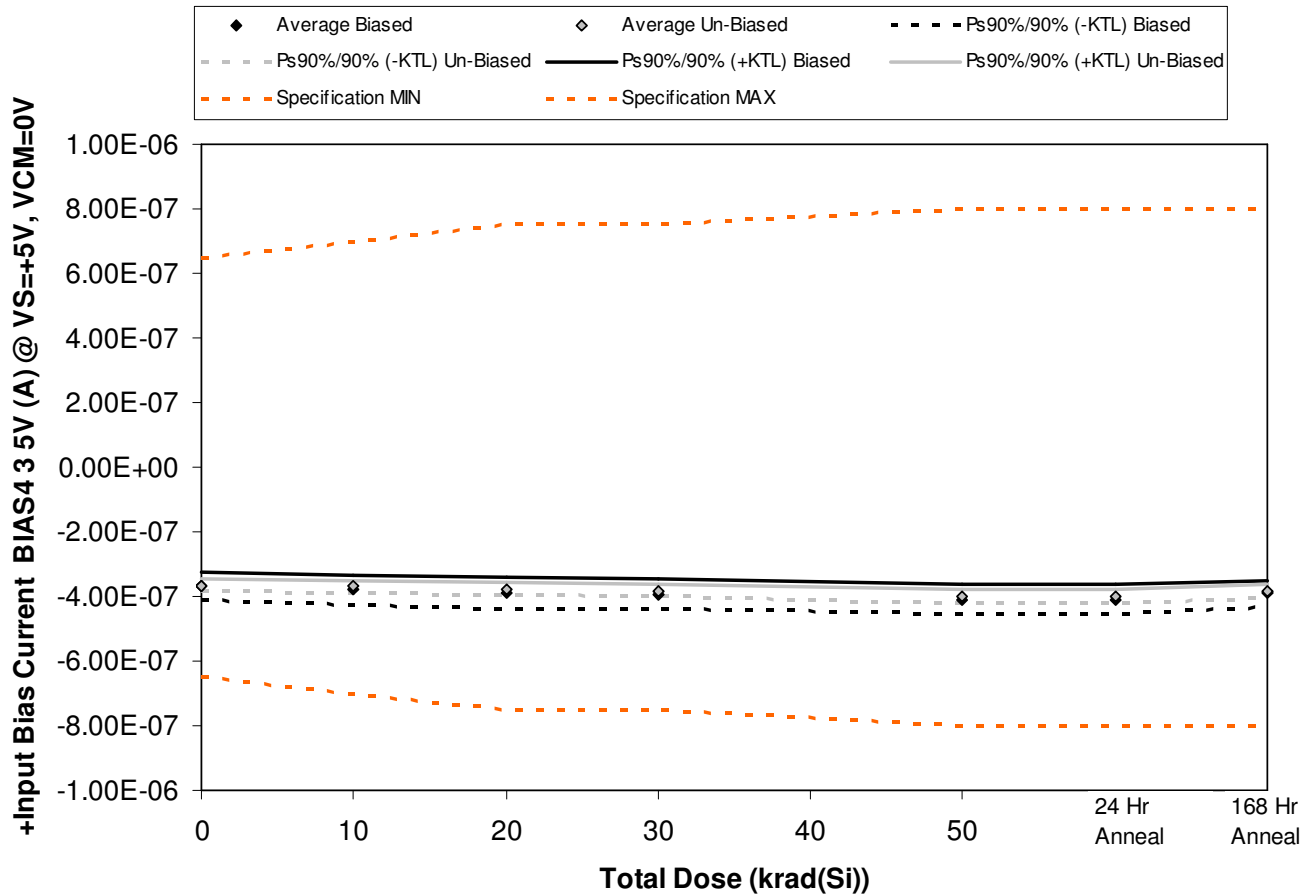


Figure 5.115. Plot of +Input Bias Current BIAS4 3 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.115. Raw data for +Input Bias Current BIAS4 3 5V (A) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS4 3 5V (A) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.45E-07	-3.54E-07	-3.60E-07	-3.67E-07	-3.83E-07	-3.83E-07	-3.68E-07
563	-3.85E-07	-3.96E-07	-4.04E-07	-4.09E-07	-4.23E-07	-4.26E-07	-4.06E-07
564	-3.79E-07	-3.92E-07	-4.01E-07	-4.06E-07	-4.22E-07	-4.22E-07	-4.03E-07
567	-3.70E-07	-3.81E-07	-3.92E-07	-3.97E-07	-4.11E-07	-4.11E-07	-3.93E-07
569	-3.62E-07	-3.73E-07	-3.85E-07	-3.89E-07	-4.04E-07	-4.04E-07	-3.86E-07
570	-3.75E-07	-3.76E-07	-3.84E-07	-3.90E-07	-4.09E-07	-4.08E-07	-3.94E-07
571	-3.71E-07	-3.72E-07	-3.80E-07	-3.87E-07	-4.03E-07	-4.04E-07	-3.87E-07
572	-3.64E-07	-3.66E-07	-3.72E-07	-3.80E-07	-3.97E-07	-3.97E-07	-3.82E-07
573	-3.56E-07	-3.59E-07	-3.65E-07	-3.71E-07	-3.90E-07	-3.89E-07	-3.73E-07
574	-3.68E-07	-3.70E-07	-3.77E-07	-3.84E-07	-4.01E-07	-4.02E-07	-3.86E-07
584	-3.76E-07	-3.72E-07	-3.73E-07	-3.74E-07	-3.77E-07	-3.79E-07	-3.78E-07
585	-3.84E-07	-3.83E-07	-3.81E-07	-3.82E-07	-3.81E-07	-3.84E-07	-3.86E-07
<b>Biased Statistics</b>							
Average Biased	-3.68E-07	-3.79E-07	-3.88E-07	-3.94E-07	-4.09E-07	-4.09E-07	-3.91E-07
Std Dev Biased	1.58E-08	1.68E-08	1.76E-08	1.69E-08	1.64E-08	1.72E-08	1.53E-08
Ps90%/90% (+KTL) Biased	-3.25E-07	-3.33E-07	-3.40E-07	-3.47E-07	-3.64E-07	-3.62E-07	-3.50E-07
Ps90%/90% (-KTL) Biased	-4.12E-07	-4.25E-07	-4.37E-07	-4.40E-07	-4.53E-07	-4.56E-07	-4.33E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.67E-07	-3.69E-07	-3.76E-07	-3.82E-07	-4.00E-07	-4.00E-07	-3.84E-07
Std Dev Un-Biased	7.15E-09	6.78E-09	7.13E-09	7.38E-09	7.14E-09	7.34E-09	7.74E-09
Ps90%/90% (+KTL) Un-Biased	-3.47E-07	-3.50E-07	-3.56E-07	-3.62E-07	-3.80E-07	-3.80E-07	-3.63E-07
Ps90%/90% (-KTL) Un-Biased	-3.86E-07	-3.87E-07	-3.95E-07	-4.03E-07	-4.20E-07	-4.20E-07	-4.06E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

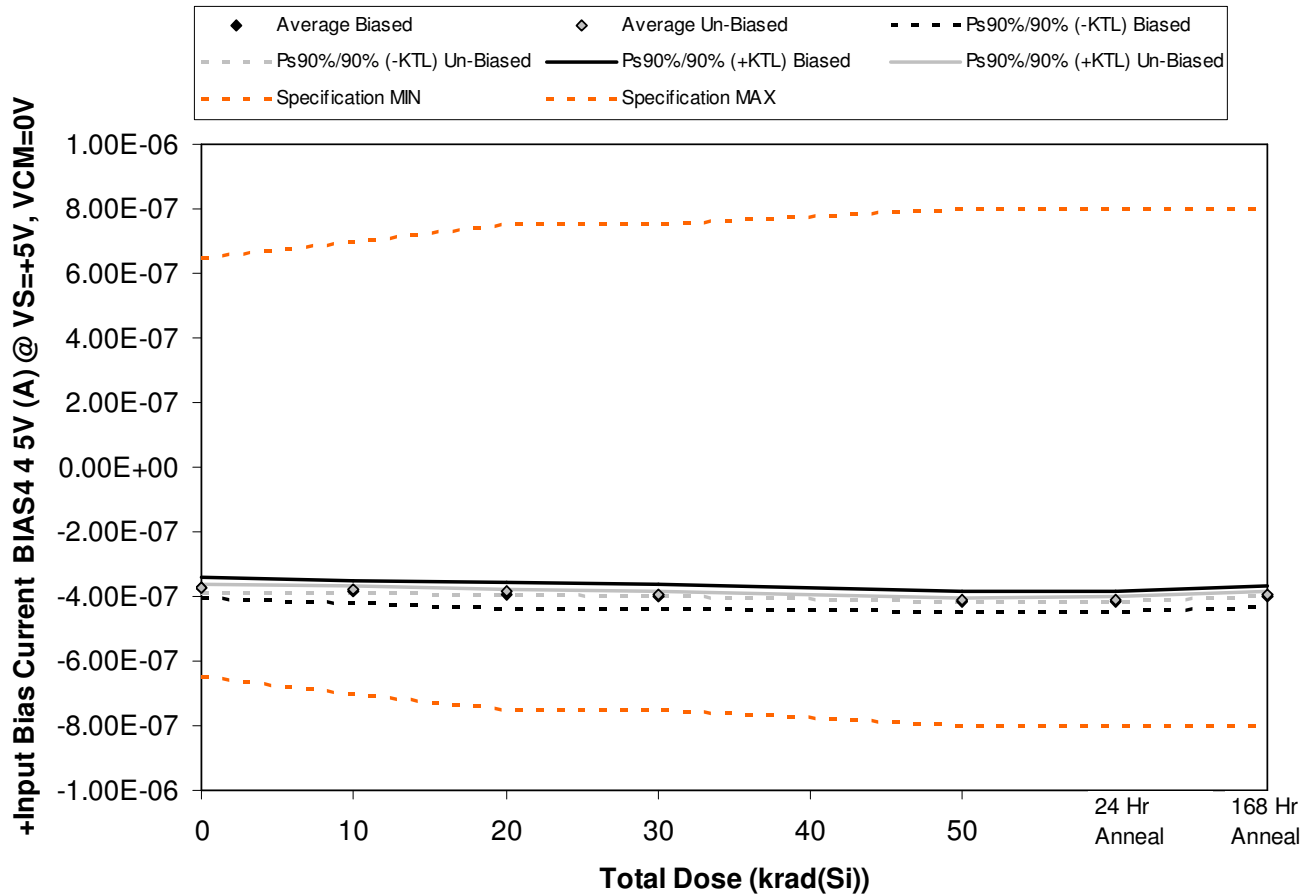


Figure 5.116. Plot of +Input Bias Current BIAS4 4 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.116. Raw data for +Input Bias Current BIAS4 4 5V (A) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS4 4 5V (A) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.56E-07	-3.66E-07	-3.72E-07	-3.80E-07	-3.98E-07	-3.98E-07	-3.81E-07
563	-3.74E-07	-3.86E-07	-3.96E-07	-4.00E-07	-4.15E-07	-4.18E-07	-3.98E-07
564	-3.71E-07	-3.85E-07	-3.96E-07	-4.00E-07	-4.13E-07	-4.15E-07	-3.96E-07
567	-3.89E-07	-4.02E-07	-4.12E-07	-4.16E-07	-4.30E-07	-4.32E-07	-4.13E-07
569	-3.81E-07	-3.93E-07	-4.04E-07	-4.09E-07	-4.25E-07	-4.22E-07	-4.05E-07
570	-3.81E-07	-3.83E-07	-3.90E-07	-3.96E-07	-4.13E-07	-4.11E-07	-3.98E-07
571	-3.70E-07	-3.72E-07	-3.82E-07	-3.89E-07	-4.07E-07	-4.05E-07	-3.89E-07
572	-3.73E-07	-3.76E-07	-3.84E-07	-3.93E-07	-4.12E-07	-4.11E-07	-3.95E-07
573	-3.78E-07	-3.80E-07	-3.89E-07	-3.93E-07	-4.10E-07	-4.09E-07	-3.94E-07
574	-3.75E-07	-3.78E-07	-3.84E-07	-3.90E-07	-4.08E-07	-4.10E-07	-3.93E-07
584	-3.50E-07	-3.46E-07	-3.47E-07	-3.49E-07	-3.51E-07	-3.53E-07	-3.51E-07
585	-3.65E-07	-3.66E-07	-3.62E-07	-3.64E-07	-3.64E-07	-3.66E-07	-3.67E-07
<b>Biased Statistics</b>							
Average Biased	-3.74E-07	-3.86E-07	-3.96E-07	-4.01E-07	-4.16E-07	-4.17E-07	-3.98E-07
Std Dev Biased	1.21E-08	1.29E-08	1.48E-08	1.35E-08	1.24E-08	1.24E-08	1.19E-08
Ps90%/90% (+KTL) Biased	-3.41E-07	-3.51E-07	-3.55E-07	-3.64E-07	-3.82E-07	-3.83E-07	-3.66E-07
Ps90%/90% (-KTL) Biased	-4.07E-07	-4.22E-07	-4.36E-07	-4.38E-07	-4.50E-07	-4.51E-07	-4.31E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.75E-07	-3.78E-07	-3.86E-07	-3.92E-07	-4.10E-07	-4.09E-07	-3.94E-07
Std Dev Un-Biased	4.09E-09	3.96E-09	3.63E-09	2.69E-09	2.63E-09	2.54E-09	3.11E-09
Ps90%/90% (+KTL) Un-Biased	-3.64E-07	-3.67E-07	-3.76E-07	-3.85E-07	-4.03E-07	-4.02E-07	-3.85E-07
Ps90%/90% (-KTL) Un-Biased	-3.87E-07	-3.89E-07	-3.96E-07	-3.99E-07	-4.17E-07	-4.16E-07	-4.02E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

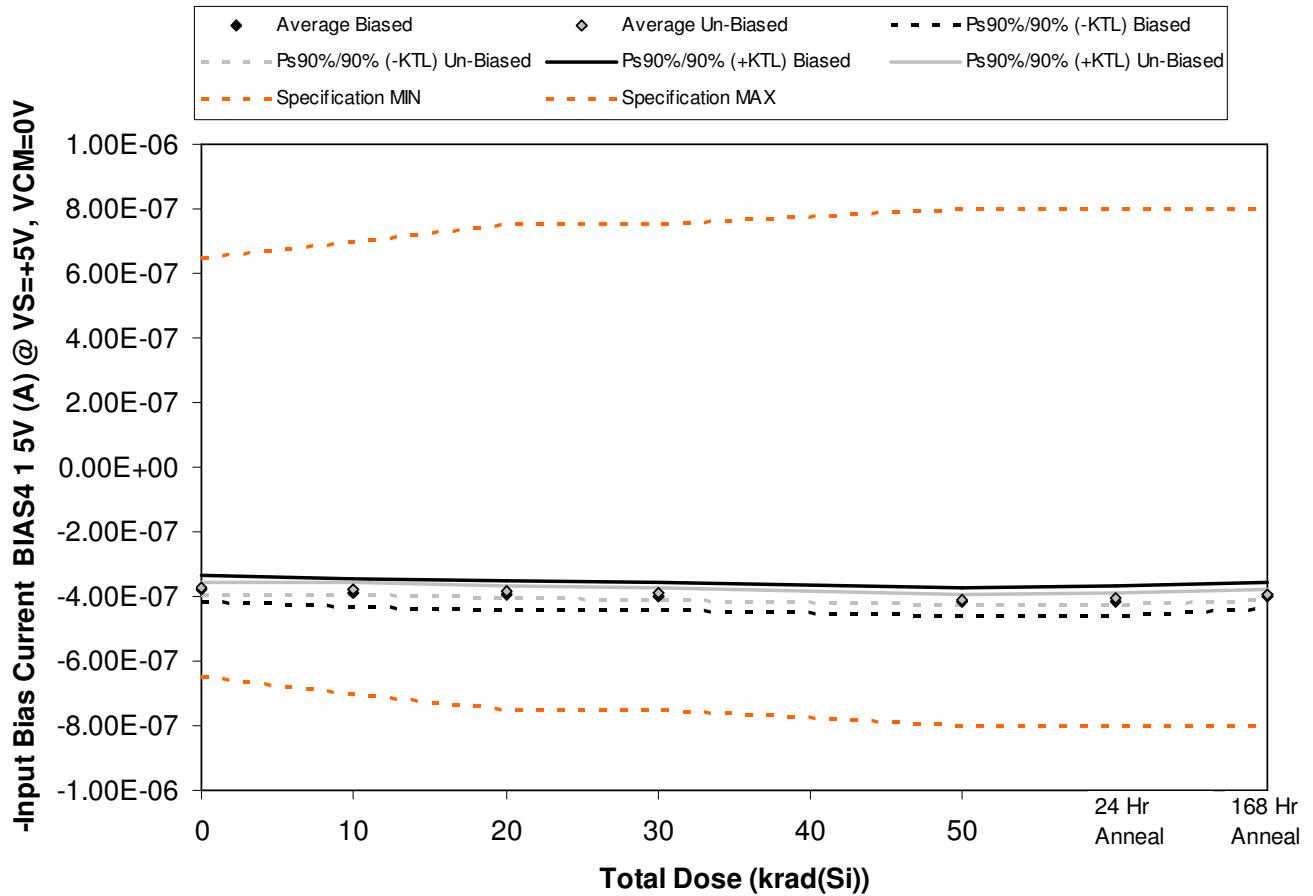


Figure 5.117. Plot of -Input Bias Current BIAS4 1 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.117. Raw data for -Input Bias Current BIAS4 1 5V (A) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS4 1 5V (A) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.57E-07	-3.65E-07	-3.71E-07	-3.78E-07	-3.91E-07	-3.91E-07	-3.77E-07
563	-3.70E-07	-3.82E-07	-3.90E-07	-3.94E-07	-4.08E-07	-4.08E-07	-3.92E-07
564	-3.78E-07	-3.93E-07	-4.01E-07	-4.04E-07	-4.20E-07	-4.18E-07	-4.02E-07
567	-3.97E-07	-4.09E-07	-4.18E-07	-4.22E-07	-4.35E-07	-4.35E-07	-4.18E-07
569	-3.81E-07	-3.93E-07	-4.03E-07	-4.07E-07	-4.20E-07	-4.20E-07	-4.02E-07
570	-3.85E-07	-3.87E-07	-3.95E-07	-4.03E-07	-4.19E-07	-4.16E-07	-4.02E-07
571	-3.69E-07	-3.70E-07	-3.77E-07	-3.85E-07	-4.04E-07	-4.01E-07	-3.88E-07
572	-3.72E-07	-3.74E-07	-3.80E-07	-3.88E-07	-4.08E-07	-4.05E-07	-3.90E-07
573	-3.72E-07	-3.76E-07	-3.82E-07	-3.88E-07	-4.06E-07	-4.03E-07	-3.90E-07
574	-3.80E-07	-3.82E-07	-3.89E-07	-3.94E-07	-4.12E-07	-4.11E-07	-3.96E-07
584	-3.50E-07	-3.46E-07	-3.45E-07	-3.48E-07	-3.50E-07	-3.51E-07	-3.49E-07
585	-3.66E-07	-3.66E-07	-3.63E-07	-3.64E-07	-3.63E-07	-3.65E-07	-3.67E-07
<b>Biased Statistics</b>							
Average Biased	-3.77E-07	-3.88E-07	-3.96E-07	-4.01E-07	-4.15E-07	-4.15E-07	-3.98E-07
Std Dev Biased	1.47E-08	1.61E-08	1.72E-08	1.63E-08	1.62E-08	1.62E-08	1.50E-08
Ps90%/90% (+KTL) Biased	-3.36E-07	-3.44E-07	-3.49E-07	-3.56E-07	-3.70E-07	-3.70E-07	-3.57E-07
Ps90%/90% (-KTL) Biased	-4.17E-07	-4.33E-07	-4.44E-07	-4.46E-07	-4.59E-07	-4.59E-07	-4.39E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.75E-07	-3.78E-07	-3.85E-07	-3.91E-07	-4.10E-07	-4.07E-07	-3.93E-07
Std Dev Un-Biased	6.68E-09	6.91E-09	7.14E-09	7.04E-09	5.98E-09	6.23E-09	5.96E-09
Ps90%/90% (+KTL) Un-Biased	-3.57E-07	-3.59E-07	-3.65E-07	-3.72E-07	-3.93E-07	-3.90E-07	-3.77E-07
Ps90%/90% (-KTL) Un-Biased	-3.94E-07	-3.97E-07	-4.04E-07	-4.11E-07	-4.26E-07	-4.24E-07	-4.10E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

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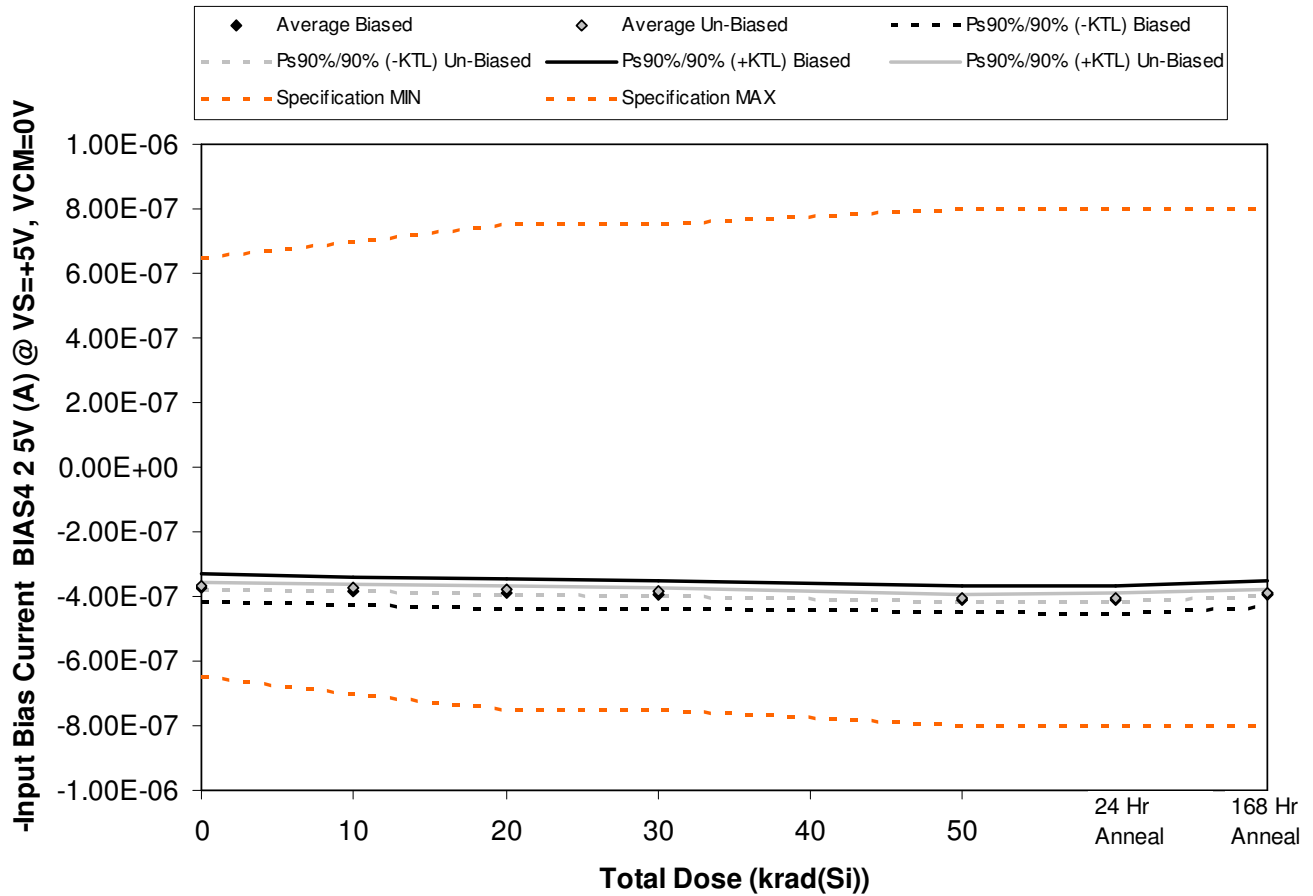


Figure 5.118. Plot of -Input Bias Current BIAS4 2.5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.118. Raw data for -Input Bias Current BIAS4 2 5V (A) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS4 2 5V (A) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.50E-07	-3.59E-07	-3.65E-07	-3.72E-07	-3.87E-07	-3.88E-07	-3.71E-07
563	-3.92E-07	-4.03E-07	-4.10E-07	-4.14E-07	-4.28E-07	-4.28E-07	-4.11E-07
564	-3.76E-07	-3.89E-07	-3.97E-07	-4.00E-07	-4.14E-07	-4.14E-07	-3.98E-07
567	-3.75E-07	-3.87E-07	-3.98E-07	-4.00E-07	-4.14E-07	-4.15E-07	-3.96E-07
569	-3.66E-07	-3.78E-07	-3.89E-07	-3.93E-07	-4.09E-07	-4.07E-07	-3.90E-07
570	-3.76E-07	-3.79E-07	-3.87E-07	-3.93E-07	-4.11E-07	-4.08E-07	-3.95E-07
571	-3.72E-07	-3.75E-07	-3.83E-07	-3.90E-07	-4.08E-07	-4.06E-07	-3.91E-07
572	-3.67E-07	-3.71E-07	-3.77E-07	-3.84E-07	-4.06E-07	-4.04E-07	-3.87E-07
573	-3.66E-07	-3.69E-07	-3.76E-07	-3.81E-07	-3.99E-07	-3.97E-07	-3.84E-07
574	-3.67E-07	-3.70E-07	-3.76E-07	-3.84E-07	-4.05E-07	-4.03E-07	-3.86E-07
584	-3.81E-07	-3.77E-07	-3.78E-07	-3.78E-07	-3.77E-07	-3.81E-07	-3.80E-07
585	-3.77E-07	-3.76E-07	-3.74E-07	-3.75E-07	-3.74E-07	-3.77E-07	-3.78E-07
<b>Biased Statistics</b>							
Average Biased	-3.72E-07	-3.83E-07	-3.92E-07	-3.96E-07	-4.10E-07	-4.11E-07	-3.93E-07
Std Dev Biased	1.55E-08	1.63E-08	1.66E-08	1.56E-08	1.49E-08	1.49E-08	1.47E-08
Ps90%/90% (+KTL) Biased	-3.30E-07	-3.39E-07	-3.46E-07	-3.53E-07	-3.70E-07	-3.70E-07	-3.53E-07
Ps90%/90% (-KTL) Biased	-4.14E-07	-4.28E-07	-4.37E-07	-4.39E-07	-4.51E-07	-4.51E-07	-4.34E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.69E-07	-3.73E-07	-3.80E-07	-3.86E-07	-4.05E-07	-4.04E-07	-3.89E-07
Std Dev Un-Biased	4.17E-09	4.30E-09	4.90E-09	5.00E-09	4.40E-09	4.30E-09	4.51E-09
Ps90%/90% (+KTL) Un-Biased	-3.58E-07	-3.61E-07	-3.66E-07	-3.73E-07	-3.93E-07	-3.92E-07	-3.76E-07
Ps90%/90% (-KTL) Un-Biased	-3.81E-07	-3.85E-07	-3.93E-07	-4.00E-07	-4.18E-07	-4.15E-07	-4.01E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



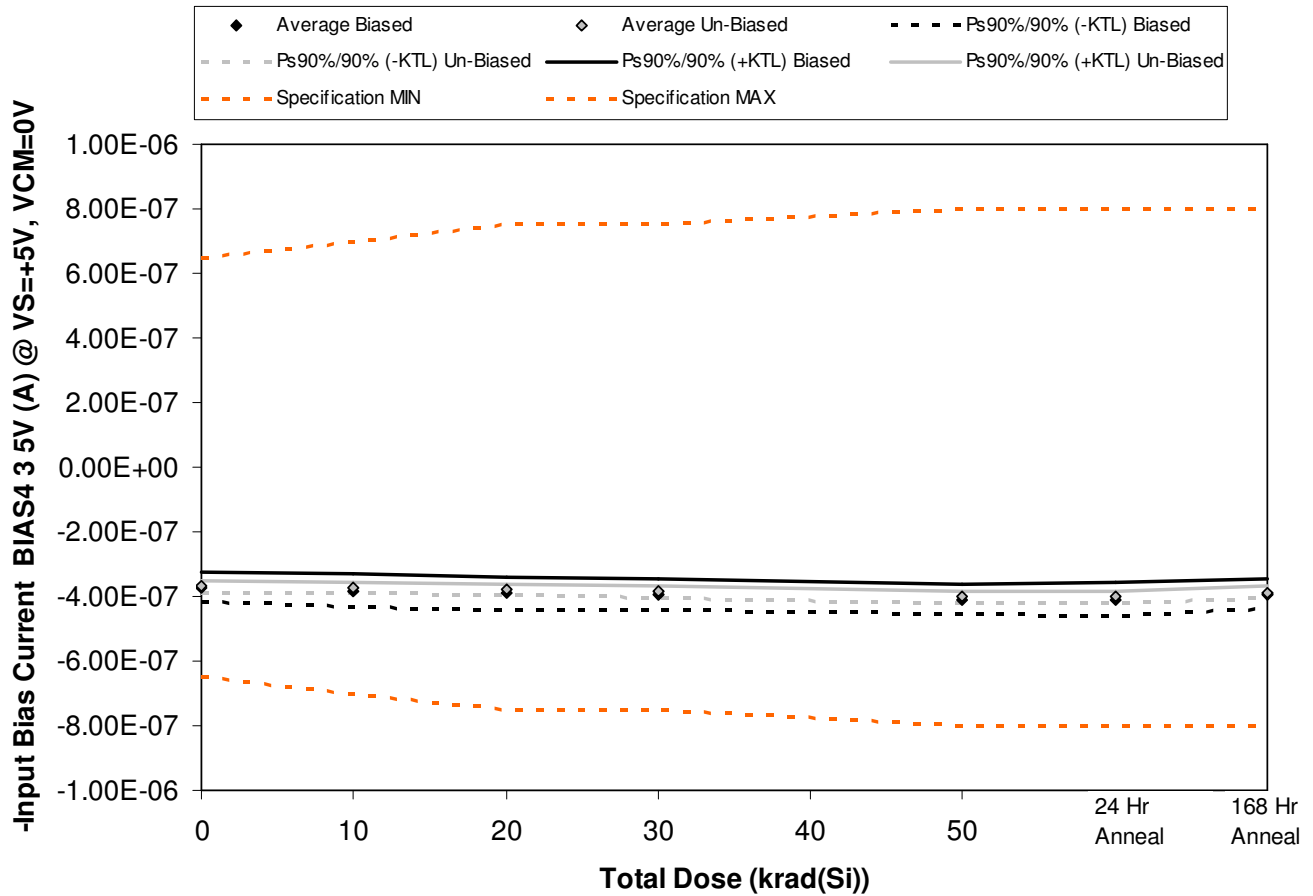


Figure 5.119. Plot of -Input Bias Current BIAS4 3 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.119. Raw data for -Input Bias Current BIAS4 3 5V (A) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS4 3 5V (A) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.47E-07	-3.56E-07	-3.62E-07	-3.68E-07	-3.83E-07	-3.82E-07	-3.68E-07
563	-3.88E-07	-4.01E-07	-4.07E-07	-4.11E-07	-4.25E-07	-4.25E-07	-4.07E-07
564	-3.79E-07	-3.95E-07	-4.01E-07	-4.05E-07	-4.19E-07	-4.20E-07	-4.03E-07
567	-3.78E-07	-3.92E-07	-4.00E-07	-4.04E-07	-4.18E-07	-4.19E-07	-4.00E-07
569	-3.61E-07	-3.72E-07	-3.82E-07	-3.85E-07	-4.00E-07	-3.98E-07	-3.83E-07
570	-3.80E-07	-3.83E-07	-3.89E-07	-3.97E-07	-4.14E-07	-4.12E-07	-3.99E-07
571	-3.71E-07	-3.73E-07	-3.81E-07	-3.88E-07	-4.03E-07	-4.03E-07	-3.89E-07
572	-3.65E-07	-3.70E-07	-3.74E-07	-3.82E-07	-3.99E-07	-3.98E-07	-3.84E-07
573	-3.64E-07	-3.67E-07	-3.73E-07	-3.79E-07	-3.96E-07	-3.94E-07	-3.80E-07
574	-3.66E-07	-3.68E-07	-3.75E-07	-3.80E-07	-4.00E-07	-3.98E-07	-3.85E-07
584	-3.80E-07	-3.77E-07	-3.77E-07	-3.77E-07	-3.79E-07	-3.80E-07	-3.80E-07
585	-3.81E-07	-3.80E-07	-3.76E-07	-3.77E-07	-3.76E-07	-3.80E-07	-3.81E-07
<b>Biased Statistics</b>							
Average Biased	-3.70E-07	-3.83E-07	-3.90E-07	-3.95E-07	-4.09E-07	-4.09E-07	-3.92E-07
Std Dev Biased	1.63E-08	1.88E-08	1.84E-08	1.79E-08	1.74E-08	1.82E-08	1.63E-08
Ps90%/90% (+KTL) Biased	-3.26E-07	-3.31E-07	-3.40E-07	-3.46E-07	-3.61E-07	-3.59E-07	-3.48E-07
Ps90%/90% (-KTL) Biased	-4.15E-07	-4.35E-07	-4.41E-07	-4.44E-07	-4.57E-07	-4.59E-07	-4.37E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.69E-07	-3.72E-07	-3.78E-07	-3.85E-07	-4.02E-07	-4.01E-07	-3.87E-07
Std Dev Un-Biased	6.64E-09	6.32E-09	6.49E-09	7.41E-09	6.93E-09	6.71E-09	7.36E-09
Ps90%/90% (+KTL) Un-Biased	-3.51E-07	-3.55E-07	-3.61E-07	-3.65E-07	-3.83E-07	-3.83E-07	-3.67E-07
Ps90%/90% (-KTL) Un-Biased	-3.88E-07	-3.89E-07	-3.96E-07	-4.06E-07	-4.21E-07	-4.19E-07	-4.08E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

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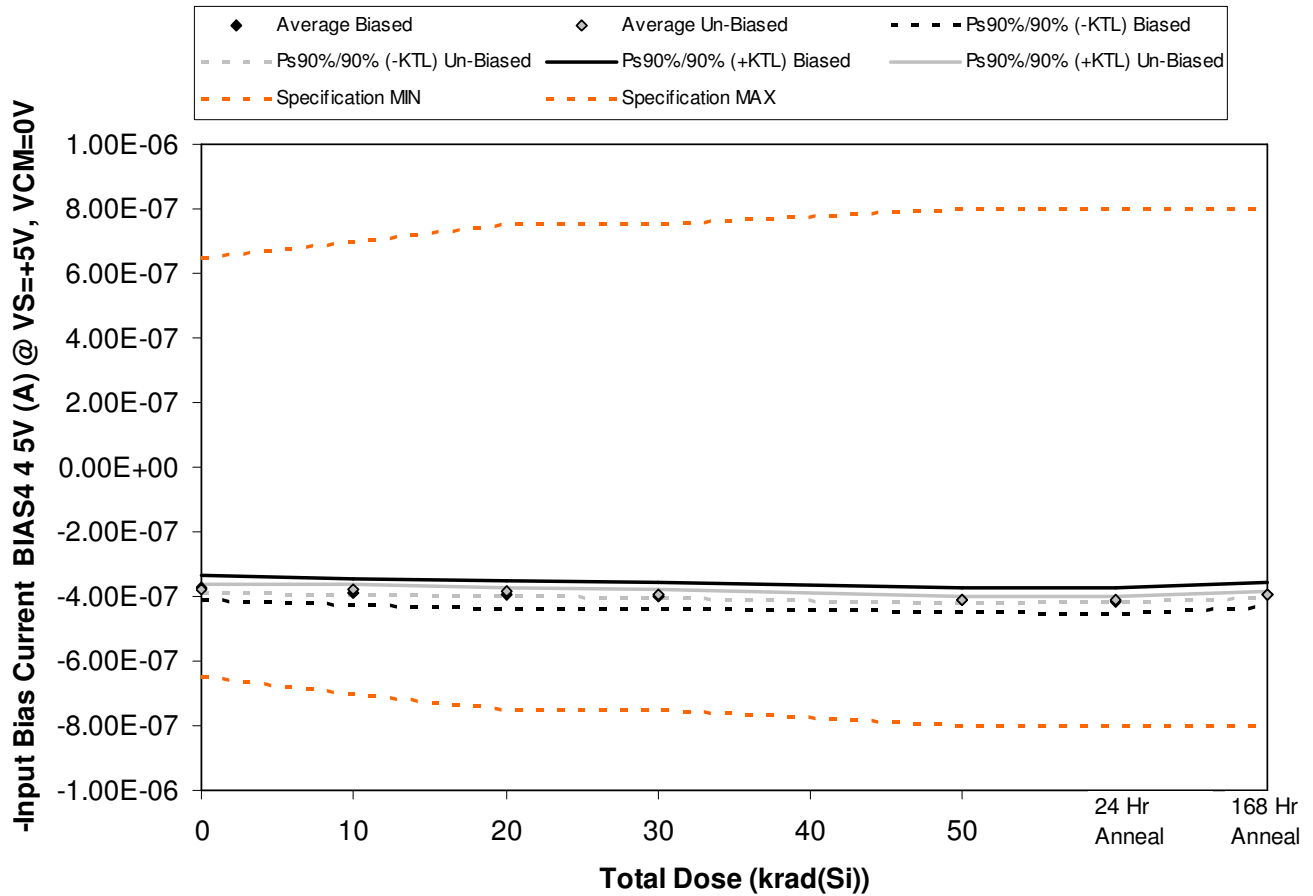


Figure 5.120. Plot of -Input Bias Current BIAS4 4 5V (A) @ VS=+5V, VCM=0V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.120. Raw data for -Input Bias Current BIAS4 4 5V (A) @ VS=+5V, VCM=0V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS4 4 5V (A) @ VS=+5V, VCM=0V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-3.55E-07	-3.64E-07	-3.71E-07	-3.76E-07	-3.93E-07	-3.93E-07	-3.76E-07
563	-3.69E-07	-3.81E-07	-3.89E-07	-3.95E-07	-4.08E-07	-4.08E-07	-3.89E-07
564	-3.81E-07	-3.95E-07	-4.02E-07	-4.06E-07	-4.18E-07	-4.21E-07	-4.02E-07
567	-3.92E-07	-4.04E-07	-4.12E-07	-4.15E-07	-4.30E-07	-4.31E-07	-4.14E-07
569	-3.75E-07	-3.88E-07	-3.98E-07	-4.02E-07	-4.16E-07	-4.16E-07	-3.98E-07
570	-3.81E-07	-3.84E-07	-3.90E-07	-3.96E-07	-4.13E-07	-4.10E-07	-3.97E-07
571	-3.74E-07	-3.76E-07	-3.84E-07	-3.92E-07	-4.12E-07	-4.07E-07	-3.92E-07
572	-3.71E-07	-3.75E-07	-3.80E-07	-3.88E-07	-4.09E-07	-4.08E-07	-3.91E-07
573	-3.84E-07	-3.88E-07	-3.93E-07	-3.99E-07	-4.16E-07	-4.15E-07	-4.00E-07
574	-3.74E-07	-3.78E-07	-3.82E-07	-3.90E-07	-4.08E-07	-4.08E-07	-3.92E-07
584	-3.50E-07	-3.48E-07	-3.47E-07	-3.48E-07	-3.50E-07	-3.51E-07	-3.50E-07
585	-3.59E-07	-3.59E-07	-3.55E-07	-3.58E-07	-3.56E-07	-3.58E-07	-3.61E-07
<b>Biased Statistics</b>							
Average Biased	-3.74E-07	-3.87E-07	-3.94E-07	-3.99E-07	-4.13E-07	-4.14E-07	-3.96E-07
Std Dev Biased	1.36E-08	1.51E-08	1.57E-08	1.45E-08	1.38E-08	1.43E-08	1.42E-08
Ps90%/90% (+KTL) Biased	-3.37E-07	-3.45E-07	-3.51E-07	-3.59E-07	-3.75E-07	-3.74E-07	-3.57E-07
Ps90%/90% (-KTL) Biased	-4.11E-07	-4.28E-07	-4.37E-07	-4.39E-07	-4.51E-07	-4.53E-07	-4.35E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.77E-07	-3.80E-07	-3.86E-07	-3.93E-07	-4.11E-07	-4.09E-07	-3.94E-07
Std Dev Un-Biased	5.37E-09	5.55E-09	5.62E-09	4.56E-09	3.43E-09	3.08E-09	3.95E-09
Ps90%/90% (+KTL) Un-Biased	-3.62E-07	-3.65E-07	-3.70E-07	-3.80E-07	-4.02E-07	-4.01E-07	-3.84E-07
Ps90%/90% (-KTL) Un-Biased	-3.91E-07	-3.95E-07	-4.01E-07	-4.06E-07	-4.21E-07	-4.18E-07	-4.05E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

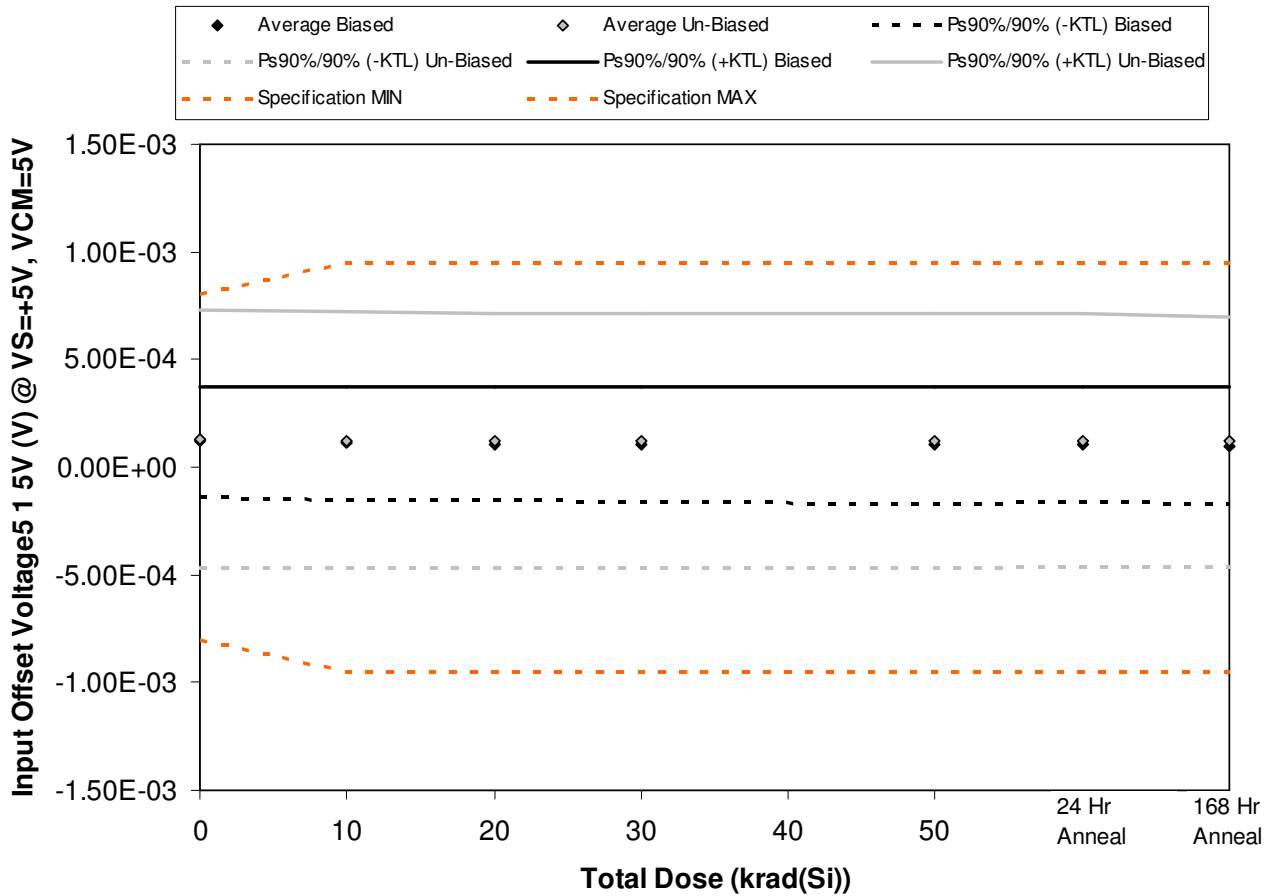


Figure 5.121. Plot of Input Offset Voltage5 1 5V (V) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.121. Raw data for Input Offset Voltage5 1 5V (V) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage5 1 5V (V) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	7.15E-05	6.07E-05	5.76E-05	5.22E-05	4.15E-05	4.61E-05	4.79E-05
563	3.80E-05	3.27E-05	2.90E-05	2.73E-05	2.34E-05	2.57E-05	1.91E-05
564	2.51E-04	2.42E-04	2.42E-04	2.43E-04	2.39E-04	2.38E-04	2.38E-04
567	4.70E-05	3.51E-05	3.05E-05	3.06E-05	3.11E-05	3.19E-05	2.88E-05
569	1.84E-04	1.78E-04	1.77E-04	1.79E-04	1.76E-04	1.77E-04	1.73E-04
570	2.16E-04	2.07E-04	2.06E-04	2.06E-04	2.02E-04	2.03E-04	1.95E-04
571	-9.73E-05	-1.01E-04	-9.86E-05	-9.79E-05	-9.76E-05	-9.60E-05	-9.63E-05
572	4.61E-04	4.53E-04	4.53E-04	4.54E-04	4.52E-04	4.50E-04	4.41E-04
573	-1.30E-05	-1.79E-05	-1.64E-05	-1.69E-05	-1.69E-05	-1.66E-05	-2.24E-05
574	7.93E-05	7.29E-05	7.55E-05	7.42E-05	7.06E-05	7.18E-05	7.38E-05
584	-1.49E-04	-1.47E-04	-1.45E-04	-1.45E-04	-1.44E-04	-1.46E-04	-1.44E-04
585	2.61E-04	2.62E-04	2.67E-04	2.65E-04	2.63E-04	2.61E-04	2.64E-04
<b>Biased Statistics</b>							
Average Biased	1.18E-04	1.10E-04	1.07E-04	1.06E-04	1.02E-04	1.04E-04	1.01E-04
Std Dev Biased	9.43E-05	9.50E-05	9.67E-05	9.85E-05	9.87E-05	9.73E-05	9.83E-05
Ps90%/90% (+KTL) Biased	3.77E-04	3.70E-04	3.72E-04	3.76E-04	3.73E-04	3.70E-04	3.71E-04
Ps90%/90% (-KTL) Biased	-1.40E-04	-1.51E-04	-1.58E-04	-1.64E-04	-1.69E-04	-1.63E-04	-1.68E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.29E-04	1.23E-04	1.24E-04	1.24E-04	1.22E-04	1.22E-04	1.18E-04
Std Dev Un-Biased	2.19E-04	2.17E-04	2.16E-04	2.16E-04	2.15E-04	2.14E-04	2.11E-04
Ps90%/90% (+KTL) Un-Biased	7.30E-04	7.18E-04	7.16E-04	7.17E-04	7.12E-04	7.10E-04	6.97E-04
Ps90%/90% (-KTL) Un-Biased	-4.71E-04	-4.73E-04	-4.68E-04	-4.69E-04	-4.68E-04	-4.65E-04	-4.60E-04
Specification MIN	-8.00E-04	-9.50E-04	-9.50E-04	-9.50E-04	-9.50E-04	-9.50E-04	-9.50E-04
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
Specification MAX	8.00E-04	9.50E-04	9.50E-04	9.50E-04	9.50E-04	9.50E-04	9.50E-04
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

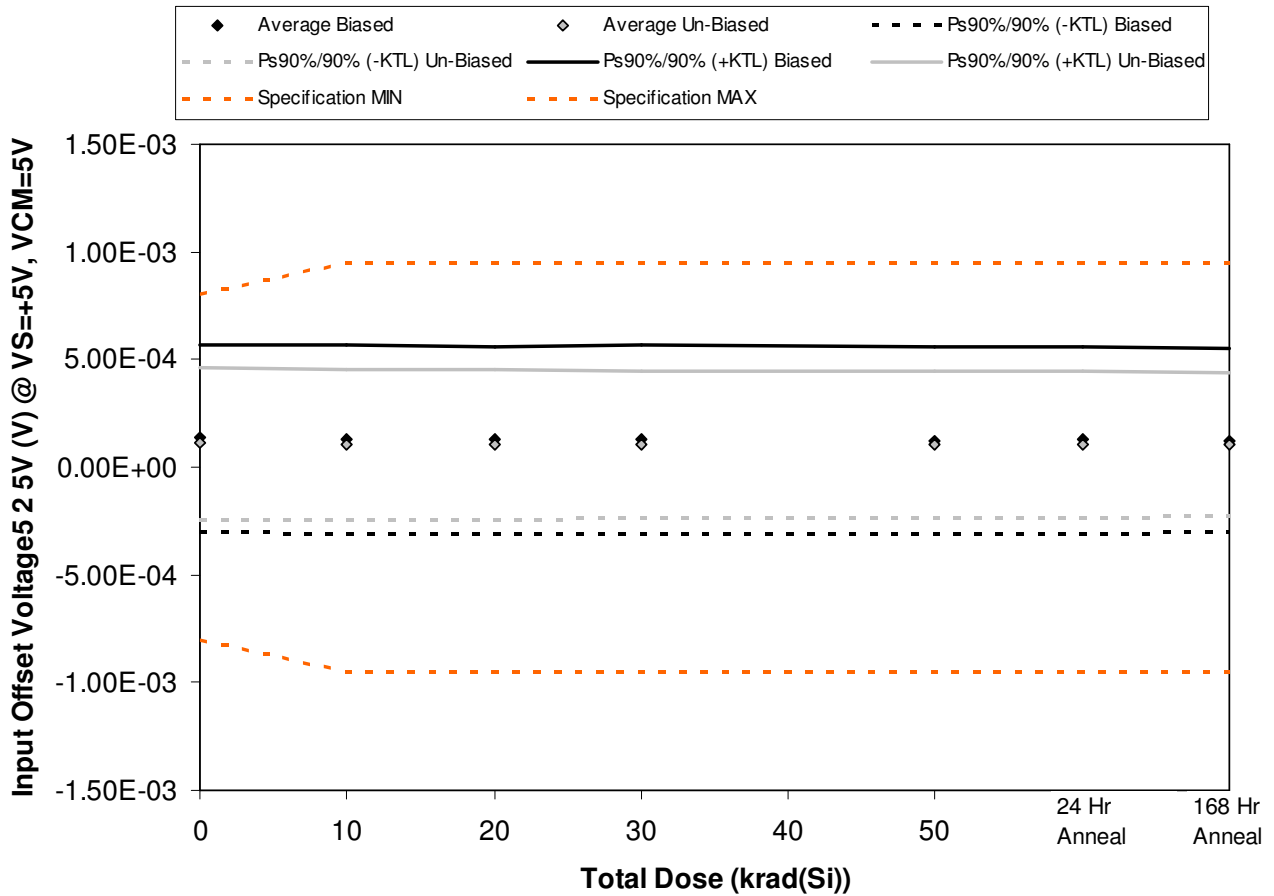


Figure 5.122. Plot of Input Offset Voltage5 2 5V (V) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.122. Raw data for Input Offset Voltage5 2 5V (V) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage5 2 5V (V) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.27E-04	1.17E-04	1.15E-04	1.14E-04	1.11E-04	1.13E-04	1.11E-04
563	-8.36E-05	-8.95E-05	-8.98E-05	-9.41E-05	-9.39E-05	-8.90E-05	-9.19E-05
564	1.54E-04	1.47E-04	1.47E-04	1.48E-04	1.43E-04	1.48E-04	1.46E-04
567	1.20E-04	1.13E-04	1.11E-04	1.14E-04	1.09E-04	1.11E-04	1.17E-04
569	3.64E-04	3.59E-04	3.55E-04	3.55E-04	3.52E-04	3.55E-04	3.47E-04
570	-2.36E-06	-8.76E-06	-8.16E-06	-5.99E-06	-2.84E-06	-1.75E-06	-5.98E-06
571	1.52E-04	1.49E-04	1.48E-04	1.49E-04	1.51E-04	1.55E-04	1.42E-04
572	2.54E-04	2.41E-04	2.40E-04	2.38E-04	2.34E-04	2.37E-04	2.30E-04
573	1.92E-04	1.88E-04	1.92E-04	1.91E-04	1.95E-04	1.95E-04	1.88E-04
574	-4.63E-05	-4.99E-05	-4.69E-05	-4.79E-05	-4.93E-05	-4.33E-05	-4.55E-05
584	1.10E-04	1.11E-04	1.11E-04	1.14E-04	1.13E-04	1.15E-04	1.16E-04
585	3.90E-04	3.91E-04	3.93E-04	3.91E-04	3.95E-04	3.88E-04	3.93E-04
<b>Biased Statistics</b>							
Average Biased	1.36E-04	1.29E-04	1.28E-04	1.27E-04	1.24E-04	1.27E-04	1.26E-04
Std Dev Biased	1.59E-04	1.59E-04	1.58E-04	1.59E-04	1.58E-04	1.58E-04	1.56E-04
Ps90%/90% (+KTL) Biased	5.72E-04	5.65E-04	5.61E-04	5.64E-04	5.58E-04	5.59E-04	5.52E-04
Ps90%/90% (-KTL) Biased	-2.99E-04	-3.07E-04	-3.05E-04	-3.10E-04	-3.10E-04	-3.05E-04	-3.01E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.10E-04	1.04E-04	1.05E-04	1.05E-04	1.06E-04	1.08E-04	1.02E-04
Std Dev Un-Biased	1.29E-04	1.27E-04	1.26E-04	1.25E-04	1.25E-04	1.24E-04	1.21E-04
Ps90%/90% (+KTL) Un-Biased	4.62E-04	4.52E-04	4.51E-04	4.48E-04	4.48E-04	4.48E-04	4.34E-04
Ps90%/90% (-KTL) Un-Biased	-2.43E-04	-2.44E-04	-2.41E-04	-2.38E-04	-2.37E-04	-2.31E-04	-2.31E-04
Specification MIN	-8.00E-04	-9.50E-04	-9.50E-04	-9.50E-04	-9.50E-04	-9.50E-04	-9.50E-04
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
Specification MAX	8.00E-04	9.50E-04	9.50E-04	9.50E-04	9.50E-04	9.50E-04	9.50E-04
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



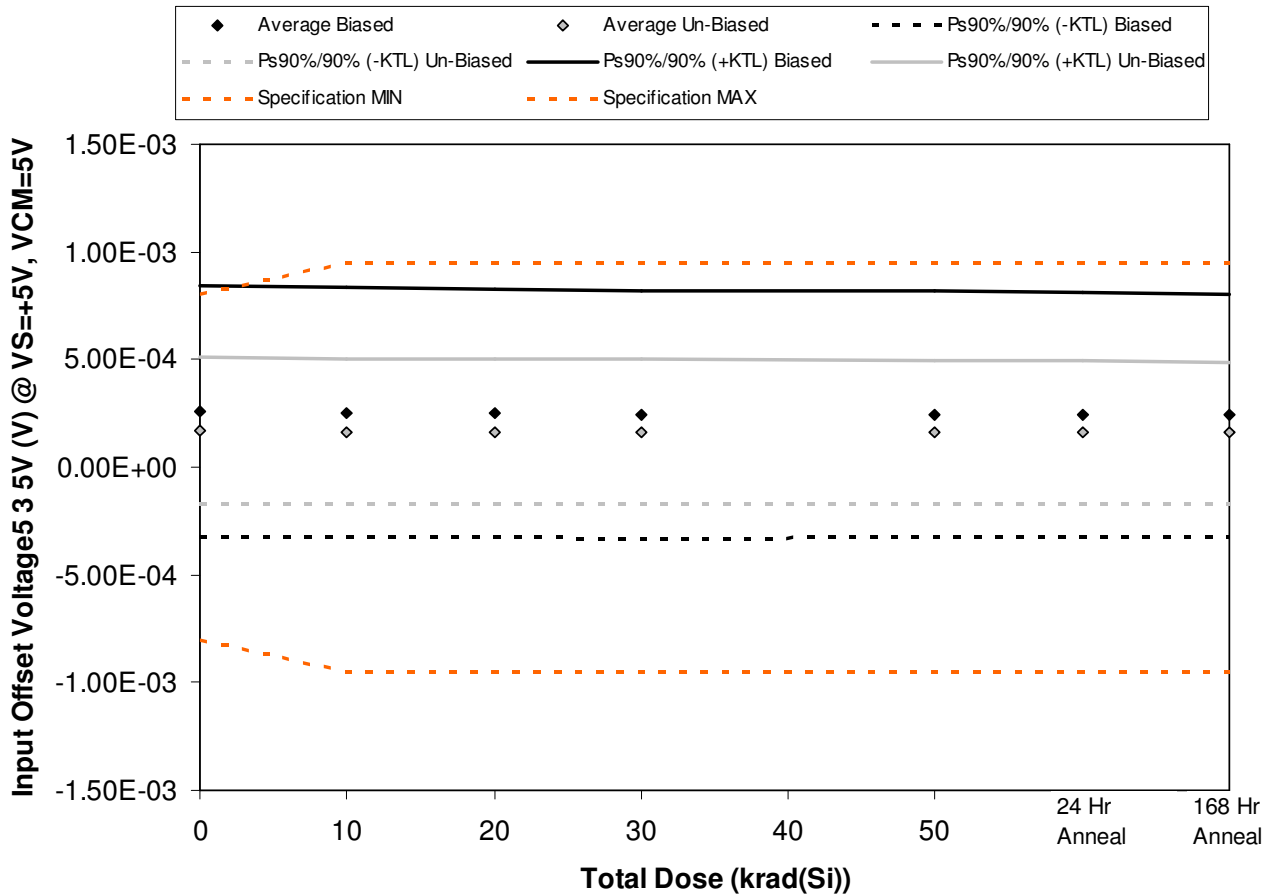


Figure 5.123. Plot of Input Offset Voltage5 3 5V (V) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.123. Raw data for Input Offset Voltage5 3 5V (V) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage5 3 5V (V) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.97E-04	5.87E-04	5.83E-04	5.77E-04	5.73E-04	5.72E-04	5.69E-04
563	1.41E-04	1.34E-04	1.33E-04	1.27E-04	1.29E-04	1.33E-04	1.32E-04
564	2.77E-04	2.72E-04	2.66E-04	2.65E-04	2.61E-04	2.58E-04	2.49E-04
567	2.61E-04	2.55E-04	2.49E-04	2.43E-04	2.40E-04	2.39E-04	2.35E-04
569	3.02E-05	2.54E-05	2.12E-05	1.68E-05	1.64E-05	1.36E-05	1.45E-05
570	1.58E-04	1.52E-04	1.51E-04	1.51E-04	1.47E-04	1.47E-04	1.36E-04
571	2.23E-04	2.16E-04	2.18E-04	2.15E-04	2.10E-04	2.13E-04	2.17E-04
572	2.49E-04	2.45E-04	2.41E-04	2.39E-04	2.34E-04	2.36E-04	2.24E-04
573	2.60E-04	2.57E-04	2.57E-04	2.57E-04	2.52E-04	2.55E-04	2.58E-04
574	-3.79E-05	-4.06E-05	-4.18E-05	-4.34E-05	-4.50E-05	-4.16E-05	-3.86E-05
584	4.16E-04	4.20E-04	4.21E-04	4.22E-04	4.24E-04	4.22E-04	4.24E-04
585	1.93E-04	1.99E-04	1.95E-04	1.94E-04	1.99E-04	1.93E-04	1.96E-04
<b>Biased Statistics</b>							
Average Biased	2.61E-04	2.55E-04	2.50E-04	2.46E-04	2.44E-04	2.43E-04	2.40E-04
Std Dev Biased	2.13E-04	2.11E-04	2.10E-04	2.10E-04	2.08E-04	2.08E-04	2.07E-04
Ps90%/90% (+KTL) Biased	8.45E-04	8.33E-04	8.27E-04	8.23E-04	8.15E-04	8.14E-04	8.06E-04
Ps90%/90% (-KTL) Biased	-3.22E-04	-3.23E-04	-3.26E-04	-3.31E-04	-3.27E-04	-3.28E-04	-3.27E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.70E-04	1.66E-04	1.65E-04	1.64E-04	1.60E-04	1.62E-04	1.59E-04
Std Dev Un-Biased	1.23E-04	1.22E-04	1.22E-04	1.22E-04	1.21E-04	1.21E-04	1.19E-04
Ps90%/90% (+KTL) Un-Biased	5.08E-04	5.01E-04	5.01E-04	4.99E-04	4.92E-04	4.93E-04	4.86E-04
Ps90%/90% (-KTL) Un-Biased	-1.67E-04	-1.69E-04	-1.71E-04	-1.72E-04	-1.72E-04	-1.69E-04	-1.68E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

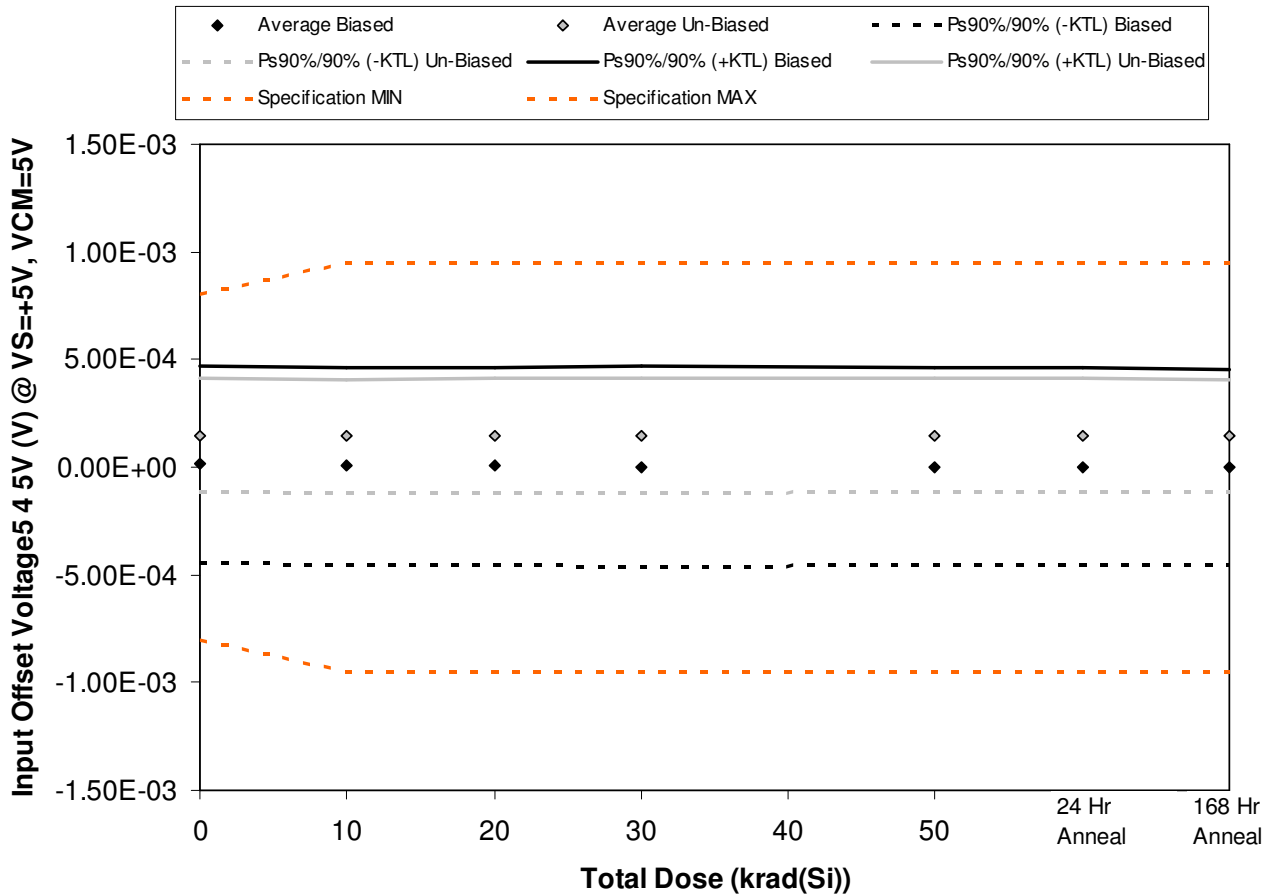


Figure 5.124. Plot of Input Offset Voltage5 4 5V (V) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.124. Raw data for Input Offset Voltage5 4 5V (V) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Voltage5 4 5V (V) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-1.77E-04	-1.86E-04	-1.89E-04	-1.90E-04	-1.94E-04	-1.92E-04	-1.85E-04
563	1.19E-04	1.10E-04	1.09E-04	1.08E-04	1.05E-04	1.06E-04	1.10E-04
564	1.49E-04	1.41E-04	1.42E-04	1.40E-04	1.34E-04	1.35E-04	1.24E-04
567	1.37E-04	1.30E-04	1.30E-04	1.30E-04	1.29E-04	1.31E-04	1.25E-04
569	-1.61E-04	-1.69E-04	-1.70E-04	-1.74E-04	-1.69E-04	-1.68E-04	-1.80E-04
570	1.35E-04	1.26E-04	1.29E-04	1.31E-04	1.40E-04	1.37E-04	1.37E-04
571	2.94E-04	2.87E-04	2.91E-04	2.91E-04	2.91E-04	2.91E-04	2.81E-04
572	1.04E-04	9.72E-05	9.64E-05	9.92E-05	1.01E-04	1.01E-04	1.01E-04
573	1.83E-04	1.76E-04	1.79E-04	1.81E-04	1.85E-04	1.82E-04	1.79E-04
574	3.34E-05	2.69E-05	2.78E-05	2.96E-05	3.16E-05	3.30E-05	3.05E-05
584	4.24E-04	4.27E-04	4.27E-04	4.30E-04	4.27E-04	4.25E-04	4.28E-04
585	3.74E-05	4.41E-05	4.48E-05	4.48E-05	4.58E-05	4.35E-05	4.46E-05
<b>Biased Statistics</b>							
Average Biased	1.35E-05	5.29E-06	4.37E-06	2.80E-06	1.05E-06	2.21E-06	-1.18E-06
Std Dev Biased	1.67E-04	1.67E-04	1.68E-04	1.69E-04	1.67E-04	1.67E-04	1.66E-04
Ps90%/90% (+KTL) Biased	4.71E-04	4.63E-04	4.66E-04	4.67E-04	4.59E-04	4.60E-04	4.53E-04
Ps90%/90% (-KTL) Biased	-4.44E-04	-4.53E-04	-4.57E-04	-4.61E-04	-4.57E-04	-4.55E-04	-4.55E-04
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.50E-04	1.43E-04	1.45E-04	1.46E-04	1.50E-04	1.49E-04	1.46E-04
Std Dev Un-Biased	9.74E-05	9.72E-05	9.84E-05	9.78E-05	9.69E-05	9.63E-05	9.32E-05
Ps90%/90% (+KTL) Un-Biased	4.17E-04	4.09E-04	4.14E-04	4.14E-04	4.15E-04	4.13E-04	4.01E-04
Ps90%/90% (-KTL) Un-Biased	-1.17E-04	-1.24E-04	-1.25E-04	-1.22E-04	-1.16E-04	-1.15E-04	-1.10E-04
<b>Specification MIN</b>	<b>-8.00E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>	<b>-9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>8.00E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>	<b>9.50E-04</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

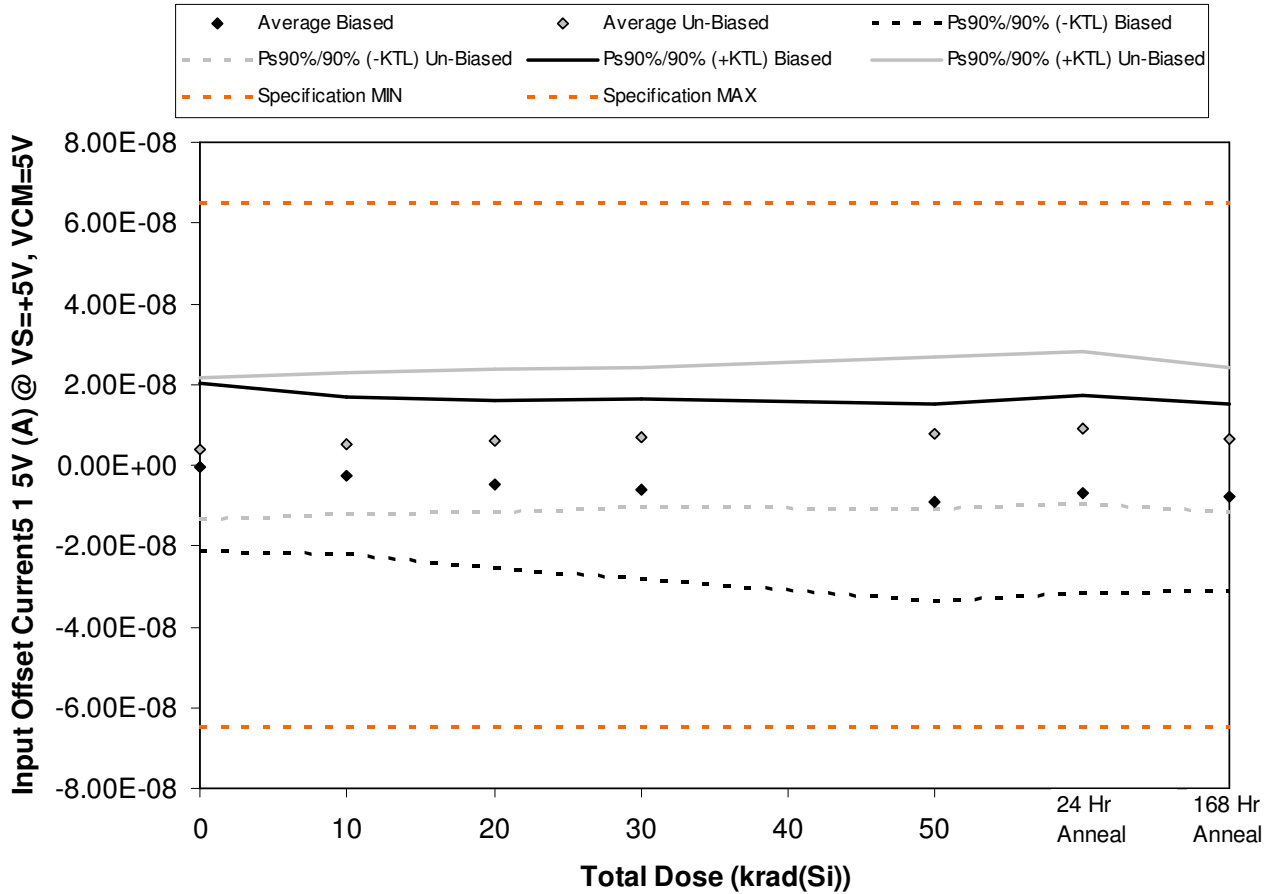


Figure 5.125. Plot of Input Offset Current5 1 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.125. Raw data for Input Offset Current5 1 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current5 1 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-9.15E-09	-1.07E-08	-1.35E-08	-1.54E-08	-2.15E-08	-1.88E-08	-1.85E-08
563	-3.30E-10	-2.45E-09	-4.59E-09	-7.14E-09	-9.79E-09	-8.09E-09	-8.88E-09
564	-2.76E-09	-4.75E-09	-7.30E-09	-6.96E-09	-8.90E-09	-7.30E-09	-8.93E-09
567	-1.57E-09	-4.30E-09	-6.31E-09	-7.34E-09	-1.00E-08	-7.51E-09	-8.62E-09
569	1.16E-08	8.75E-09	7.21E-09	7.16E-09	3.72E-09	6.40E-09	5.00E-09
570	-3.70E-10	6.10E-10	1.12E-09	1.30E-09	1.30E-09	3.45E-09	6.70E-10
571	1.11E-08	1.30E-08	1.41E-08	1.45E-08	1.60E-08	1.83E-08	1.37E-08
572	-4.60E-10	1.80E-09	2.49E-09	3.40E-09	4.37E-09	5.26E-09	3.46E-09
573	-1.05E-09	-2.80E-10	6.60E-10	2.10E-09	2.93E-09	4.17E-09	8.90E-10
574	1.09E-08	1.18E-08	1.22E-08	1.30E-08	1.44E-08	1.51E-08	1.33E-08
584	9.00E-11	3.15E-09	4.75E-09	5.69E-09	6.04E-09	6.68E-09	7.76E-09
585	1.37E-09	6.51E-09	7.58E-09	7.77E-09	7.36E-09	7.40E-09	8.15E-09
<b>Biased Statistics</b>							
Average Biased	-4.52E-10	-2.70E-09	-4.90E-09	-5.94E-09	-9.30E-09	-7.05E-09	-7.98E-09
Std Dev Biased	7.52E-09	7.11E-09	7.56E-09	8.16E-09	8.93E-09	8.94E-09	8.37E-09
Ps90%/90% (+KTL) Biased	2.02E-08	1.68E-08	1.58E-08	1.64E-08	1.52E-08	1.75E-08	1.50E-08
Ps90%/90% (-KTL) Biased	-2.11E-08	-2.22E-08	-2.56E-08	-2.83E-08	-3.38E-08	-3.16E-08	-3.09E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	4.03E-09	5.38E-09	6.11E-09	6.85E-09	7.80E-09	9.25E-09	6.39E-09
Std Dev Un-Biased	6.38E-09	6.45E-09	6.49E-09	6.34E-09	6.86E-09	6.91E-09	6.56E-09
Ps90%/90% (+KTL) Un-Biased	2.15E-08	2.31E-08	2.39E-08	2.42E-08	2.66E-08	2.82E-08	2.44E-08
Ps90%/90% (-KTL) Un-Biased	-1.35E-08	-1.23E-08	-1.17E-08	-1.05E-08	-1.10E-08	-9.69E-09	-1.16E-08
<b>Specification MIN</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

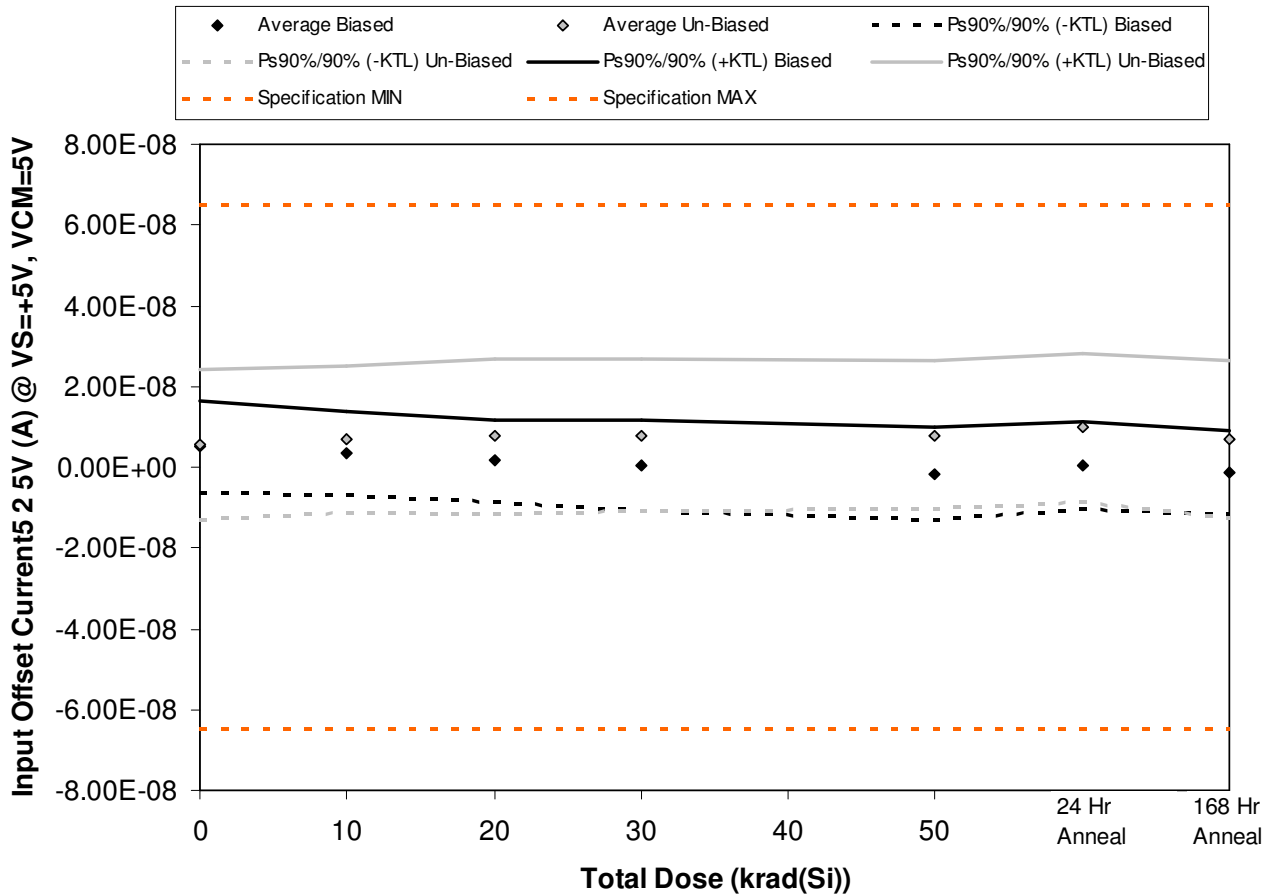


Figure 5.126. Plot of Input Offset Current 5 2 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.126. Raw data for Input Offset Current5 2 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current5 2 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.69E-09	4.59E-09	2.79E-09	1.20E-09	-1.26E-09	-2.50E-10	-6.90E-10
563	1.67E-09	9.60E-10	-2.40E-10	-2.09E-09	-3.88E-09	-2.08E-09	-4.04E-09
564	3.29E-09	1.87E-09	2.40E-10	-4.80E-10	-2.45E-09	-7.60E-10	-1.75E-09
567	1.22E-08	9.36E-09	7.33E-09	6.98E-09	5.17E-09	7.12E-09	4.72E-09
569	2.99E-09	1.60E-10	-2.55E-09	-3.36E-09	-5.70E-09	-2.63E-09	-4.74E-09
570	-2.01E-09	-1.12E-09	-7.20E-10	-9.20E-10	1.10E-10	1.74E-09	-7.80E-10
571	5.86E-09	6.84E-09	7.12E-09	8.05E-09	6.90E-09	8.66E-09	7.01E-09
572	2.48E-09	4.36E-09	4.76E-09	5.23E-09	4.67E-09	7.05E-09	2.53E-09
573	5.63E-09	6.97E-09	8.64E-09	9.07E-09	9.85E-09	1.17E-08	8.23E-09
574	1.62E-08	1.72E-08	1.84E-08	1.81E-08	1.82E-08	1.99E-08	1.79E-08
584	2.75E-09	5.23E-09	6.57E-09	7.52E-09	7.86E-09	8.53E-09	9.68E-09
585	1.40E-08	1.99E-08	2.01E-08	2.01E-08	2.02E-08	2.06E-08	2.10E-08
<b>Biased Statistics</b>							
Average Biased	5.16E-09	3.39E-09	1.51E-09	4.50E-10	-1.62E-09	2.80E-10	-1.30E-09
Std Dev Biased	4.17E-09	3.73E-09	3.76E-09	4.03E-09	4.14E-09	3.94E-09	3.75E-09
Ps90%/90% (+KTL) Biased	1.66E-08	1.36E-08	1.18E-08	1.15E-08	9.74E-09	1.11E-08	8.97E-09
Ps90%/90% (-KTL) Biased	-6.28E-09	-6.85E-09	-8.81E-09	-1.06E-08	-1.30E-08	-1.05E-08	-1.16E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.64E-09	6.86E-09	7.63E-09	7.91E-09	7.95E-09	9.80E-09	6.98E-09
Std Dev Un-Biased	6.72E-09	6.66E-09	6.97E-09	6.91E-09	6.75E-09	6.70E-09	7.08E-09
Ps90%/90% (+KTL) Un-Biased	2.41E-08	2.51E-08	2.67E-08	2.68E-08	2.64E-08	2.82E-08	2.64E-08
Ps90%/90% (-KTL) Un-Biased	-1.28E-08	-1.14E-08	-1.15E-08	-1.10E-08	-1.05E-08	-8.56E-09	-1.24E-08
<b>Specification MIN</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



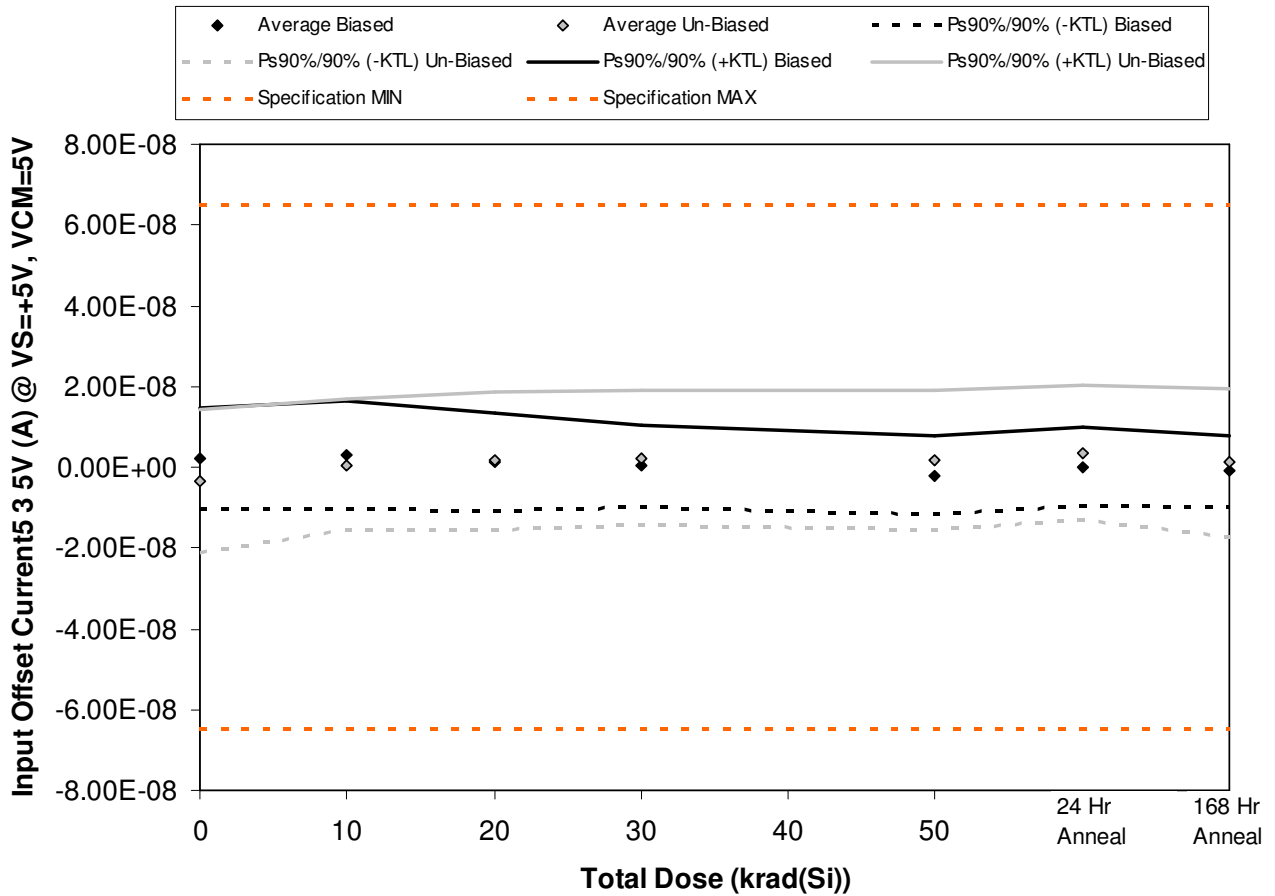


Figure 5.127. Plot of Input Offset Current 5 3 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.127. Raw data for Input Offset Current5 3 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current5 3 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.43E-09	8.56E-09	5.69E-09	3.87E-09	1.46E-09	3.19E-09	1.58E-09
563	1.70E-10	2.10E-09	1.72E-09	4.70E-10	-7.10E-10	1.03E-09	-2.40E-09
564	-2.68E-09	-1.96E-09	-3.67E-09	-3.38E-09	-5.97E-09	-3.53E-09	-2.04E-09
567	-1.06E-09	-1.11E-09	-2.53E-09	-3.33E-09	-5.69E-09	-3.69E-09	-5.25E-09
569	8.07E-09	7.67E-09	5.45E-09	4.17E-09	9.70E-10	3.76E-09	2.81E-09
570	2.26E-09	6.43E-09	7.88E-09	8.56E-09	8.72E-09	1.04E-08	8.02E-09
571	4.30E-10	4.14E-09	5.37E-09	6.11E-09	5.07E-09	6.59E-09	5.12E-09
572	-1.33E-08	-8.16E-09	-7.39E-09	-5.97E-09	-6.50E-09	-4.57E-09	-8.82E-09
573	-2.80E-10	3.49E-09	4.23E-09	4.94E-09	5.01E-09	6.23E-09	3.63E-09
574	-6.72E-09	-2.75E-09	-1.90E-09	-1.88E-09	-2.80E-09	-8.10E-10	-1.99E-09
584	1.04E-08	1.62E-08	1.77E-08	1.89E-08	1.92E-08	2.01E-08	2.10E-08
585	4.70E-10	1.02E-08	1.09E-08	1.11E-08	1.06E-08	1.10E-08	1.14E-08
<b>Biased Statistics</b>							
Average Biased	1.99E-09	3.05E-09	1.33E-09	3.60E-10	-1.99E-09	1.52E-10	-1.06E-09
Std Dev Biased	4.56E-09	4.87E-09	4.36E-09	3.69E-09	3.60E-09	3.58E-09	3.25E-09
Ps90%/90% (+KTL) Biased	1.45E-08	1.64E-08	1.33E-08	1.05E-08	7.88E-09	9.98E-09	7.85E-09
Ps90%/90% (-KTL) Biased	-1.05E-08	-1.03E-08	-1.06E-08	-9.76E-09	-1.19E-08	-9.67E-09	-9.97E-09
<b>Un-Biased Statistics</b>							
Average Un-Biased	-3.52E-09	6.30E-10	1.64E-09	2.35E-09	1.90E-09	3.57E-09	1.19E-09
Std Dev Un-Biased	6.42E-09	5.98E-09	6.20E-09	6.05E-09	6.30E-09	6.09E-09	6.68E-09
Ps90%/90% (+KTL) Un-Biased	1.41E-08	1.70E-08	1.86E-08	1.89E-08	1.92E-08	2.03E-08	1.95E-08
Ps90%/90% (-KTL) Un-Biased	-2.11E-08	-1.58E-08	-1.54E-08	-1.42E-08	-1.54E-08	-1.31E-08	-1.71E-08
<b>Specification MIN</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

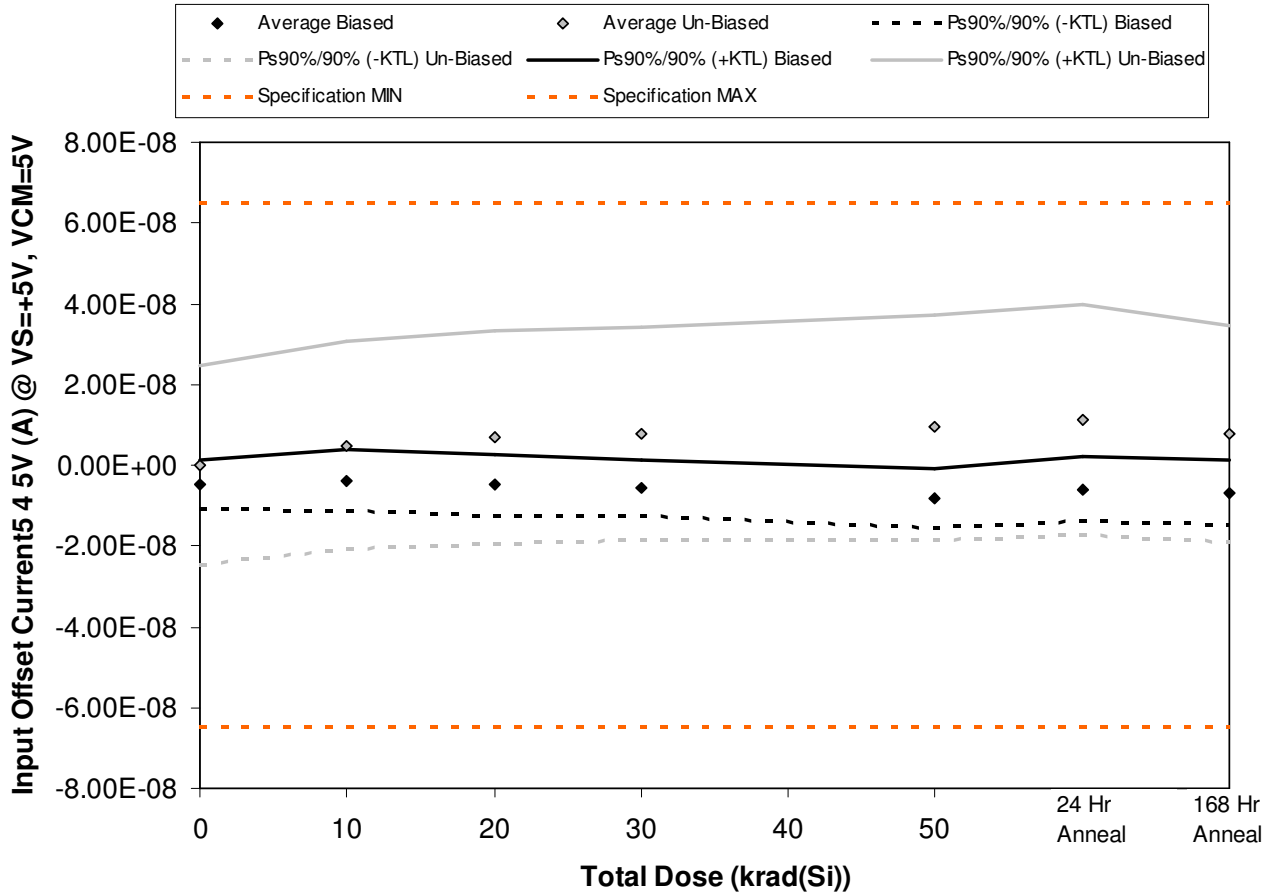


Figure 5.128. Plot of Input Offset Current5 4 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.128. Raw data for Input Offset Current5 4 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Input Offset Current5 4 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-4.60E-09	-1.98E-09	-3.14E-09	-4.19E-09	-8.36E-09	-6.05E-09	-7.08E-09
563	-6.21E-09	-4.65E-09	-5.14E-09	-6.69E-09	-8.88E-09	-7.05E-09	-6.92E-09
564	-3.07E-09	-2.33E-09	-3.67E-09	-4.56E-09	-6.63E-09	-4.58E-09	-5.67E-09
567	-2.15E-09	-1.45E-09	-2.98E-09	-3.60E-09	-4.77E-09	-2.02E-09	-3.31E-09
569	-7.48E-09	-8.13E-09	-9.67E-09	-9.73E-09	-1.19E-08	-9.93E-09	-1.13E-08
570	3.20E-09	7.33E-09	1.02E-08	1.10E-08	1.27E-08	1.38E-08	1.05E-08
571	-1.11E-08	-6.24E-09	-4.33E-09	-2.88E-09	-1.57E-09	3.30E-10	-3.15E-09
572	1.27E-08	1.89E-08	2.11E-08	2.23E-08	2.50E-08	2.74E-08	2.27E-08
573	-4.92E-09	0.00E+00	1.37E-09	2.04E-09	3.41E-09	4.69E-09	2.01E-09
574	-1.10E-10	4.69E-09	5.48E-09	6.23E-09	7.03E-09	9.09E-09	6.55E-09
584	-3.16E-09	3.14E-09	5.80E-09	7.34E-09	8.00E-09	8.49E-09	9.80E-09
585	-9.97E-09	9.00E-10	3.10E-09	3.37E-09	3.95E-09	3.90E-09	4.22E-09
<b>Biased Statistics</b>							
Average Biased	-4.70E-09	-3.71E-09	-4.92E-09	-5.75E-09	-8.11E-09	-5.93E-09	-6.85E-09
Std Dev Biased	2.19E-09	2.76E-09	2.79E-09	2.51E-09	2.67E-09	2.93E-09	2.90E-09
Ps90%/90% (+KTL) Biased	1.30E-09	3.85E-09	2.73E-09	1.13E-09	-7.91E-10	2.11E-09	1.10E-09
Ps90%/90% (-KTL) Biased	-1.07E-08	-1.13E-08	-1.26E-08	-1.26E-08	-1.54E-08	-1.40E-08	-1.48E-08
<b>Un-Biased Statistics</b>							
Average Un-Biased	-4.00E-11	4.94E-09	6.75E-09	7.74E-09	9.31E-09	1.11E-08	7.73E-09
Std Dev Un-Biased	8.95E-09	9.36E-09	9.61E-09	9.63E-09	1.02E-08	1.04E-08	9.82E-09
Ps90%/90% (+KTL) Un-Biased	2.45E-08	3.06E-08	3.31E-08	3.41E-08	3.72E-08	3.96E-08	3.46E-08
Ps90%/90% (-KTL) Un-Biased	-2.46E-08	-2.07E-08	-1.96E-08	-1.87E-08	-1.86E-08	-1.75E-08	-1.92E-08
<b>Specification MIN</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>	<b>-6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>	<b>6.50E-08</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

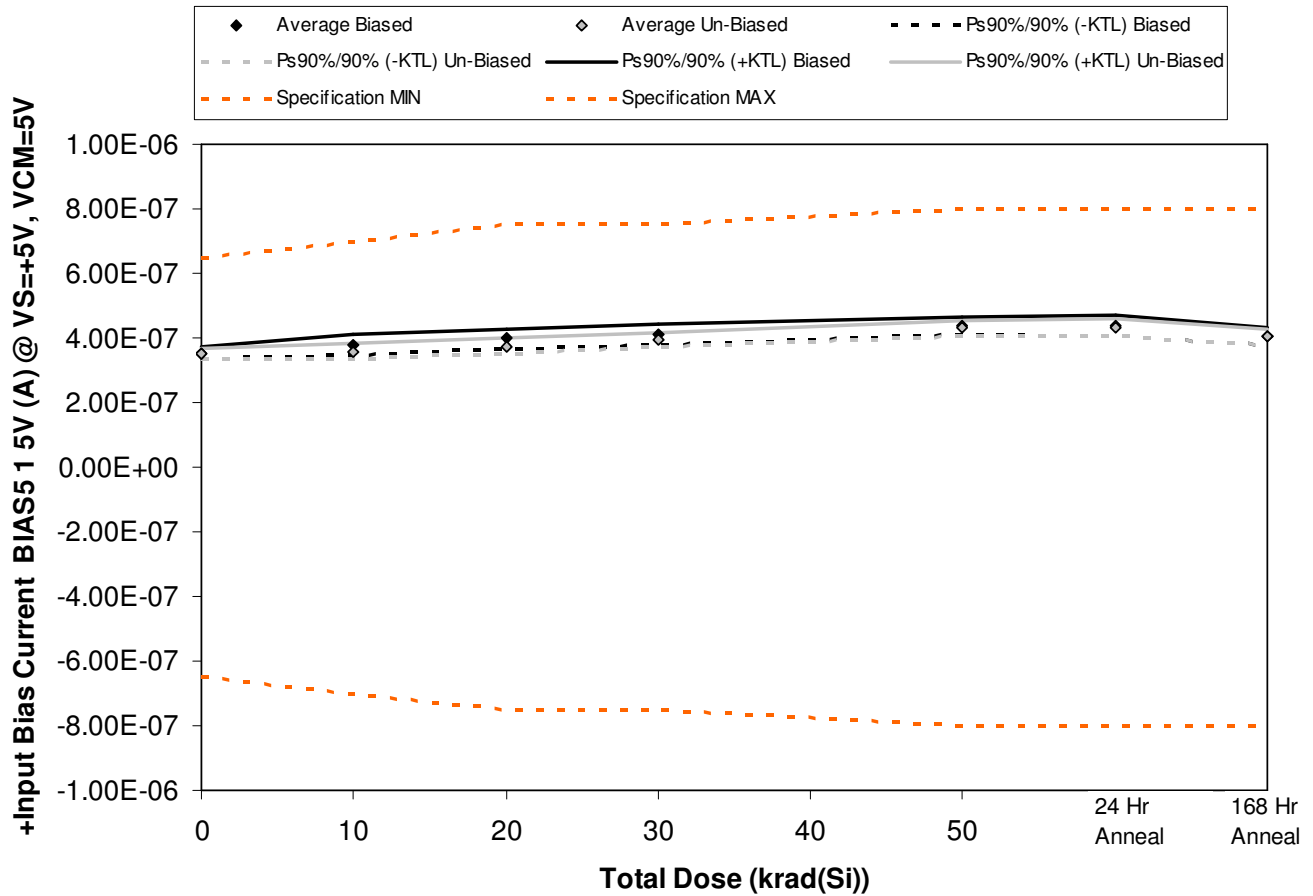


Figure 5.129. Plot of +Input Bias Current BIAS5 1 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.129. Raw data for +Input Bias Current BIAS5 1 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS5 1 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.50E-07	3.61E-07	3.83E-07	3.98E-07	4.28E-07	4.28E-07	4.00E-07
563	3.49E-07	3.71E-07	3.92E-07	4.04E-07	4.34E-07	4.31E-07	4.00E-07
564	3.58E-07	3.86E-07	4.06E-07	4.20E-07	4.46E-07	4.46E-07	4.13E-07
567	3.49E-07	3.75E-07	3.95E-07	4.07E-07	4.32E-07	4.33E-07	4.01E-07
569	3.62E-07	3.92E-07	4.12E-07	4.26E-07	4.54E-07	4.55E-07	4.20E-07
570	3.47E-07	3.55E-07	3.71E-07	3.89E-07	4.25E-07	4.25E-07	3.95E-07
571	3.55E-07	3.65E-07	3.80E-07	4.01E-07	4.37E-07	4.38E-07	4.09E-07
572	3.57E-07	3.68E-07	3.86E-07	4.06E-07	4.44E-07	4.44E-07	4.17E-07
573	3.42E-07	3.47E-07	3.65E-07	3.85E-07	4.22E-07	4.21E-07	3.94E-07
574	3.53E-07	3.58E-07	3.74E-07	3.95E-07	4.33E-07	4.32E-07	4.04E-07
584	3.37E-07	3.42E-07	3.43E-07	3.43E-07	3.44E-07	3.45E-07	3.46E-07
585	3.56E-07	3.64E-07	3.61E-07	3.66E-07	3.70E-07	3.70E-07	3.66E-07
<b>Biased Statistics</b>							
Average Biased	3.54E-07	3.77E-07	3.97E-07	4.11E-07	4.39E-07	4.38E-07	4.07E-07
Std Dev Biased	6.18E-09	1.20E-08	1.16E-08	1.16E-08	1.04E-08	1.14E-08	9.51E-09
Ps90%/90% (+KTL) Biased	3.70E-07	4.10E-07	4.29E-07	4.43E-07	4.67E-07	4.70E-07	4.33E-07
Ps90%/90% (-KTL) Biased	3.37E-07	3.44E-07	3.66E-07	3.79E-07	4.10E-07	4.07E-07	3.81E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.51E-07	3.58E-07	3.75E-07	3.95E-07	4.32E-07	4.32E-07	4.04E-07
Std Dev Un-Biased	5.89E-09	8.34E-09	8.20E-09	8.48E-09	8.79E-09	9.46E-09	9.38E-09
Ps90%/90% (+KTL) Un-Biased	3.67E-07	3.81E-07	3.98E-07	4.18E-07	4.56E-07	4.58E-07	4.29E-07
Ps90%/90% (-KTL) Un-Biased	3.35E-07	3.36E-07	3.53E-07	3.72E-07	4.08E-07	4.06E-07	3.78E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

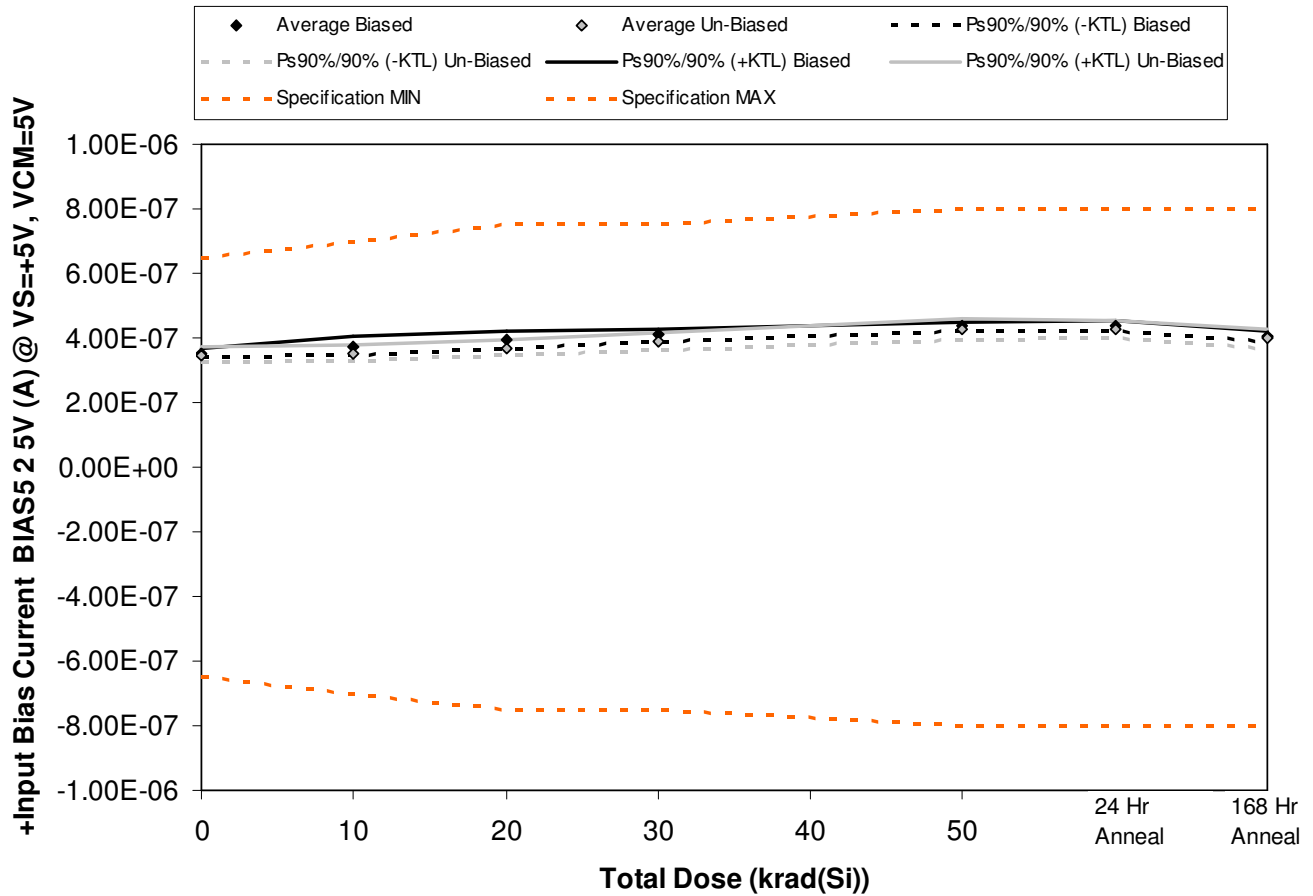


Figure 5.130. Plot of +Input Bias Current BIAS5 2 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.130. Raw data for +Input Bias Current BIAS5 2 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS5 2 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.46E-07	3.57E-07	3.80E-07	3.99E-07	4.31E-07	4.30E-07	3.97E-07
563	3.54E-07	3.76E-07	3.96E-07	4.07E-07	4.35E-07	4.36E-07	4.04E-07
564	3.58E-07	3.85E-07	4.06E-07	4.16E-07	4.45E-07	4.48E-07	4.13E-07
567	3.53E-07	3.78E-07	3.96E-07	4.09E-07	4.34E-07	4.35E-07	4.04E-07
569	3.47E-07	3.76E-07	3.98E-07	4.11E-07	4.35E-07	4.37E-07	4.04E-07
570	3.46E-07	3.55E-07	3.71E-07	3.92E-07	4.27E-07	4.28E-07	4.00E-07
571	3.43E-07	3.54E-07	3.69E-07	3.89E-07	4.23E-07	4.24E-07	3.96E-07
572	3.45E-07	3.50E-07	3.69E-07	3.87E-07	4.25E-07	4.25E-07	3.98E-07
573	3.37E-07	3.41E-07	3.58E-07	3.78E-07	4.13E-07	4.14E-07	3.87E-07
574	3.62E-07	3.68E-07	3.84E-07	4.06E-07	4.46E-07	4.43E-07	4.16E-07
584	3.51E-07	3.58E-07	3.62E-07	3.59E-07	3.61E-07	3.64E-07	3.62E-07
585	3.62E-07	3.70E-07	3.68E-07	3.71E-07	3.74E-07	3.76E-07	3.72E-07
<b>Biased Statistics</b>							
Average Biased	3.51E-07	3.74E-07	3.95E-07	4.09E-07	4.36E-07	4.37E-07	4.05E-07
Std Dev Biased	4.92E-09	1.03E-08	9.25E-09	6.15E-09	5.25E-09	6.37E-09	5.73E-09
Ps90%/90% (+KTL) Biased	3.65E-07	4.03E-07	4.20E-07	4.25E-07	4.50E-07	4.55E-07	4.20E-07
Ps90%/90% (-KTL) Biased	3.38E-07	3.46E-07	3.70E-07	3.92E-07	4.21E-07	4.20E-07	3.89E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.47E-07	3.54E-07	3.70E-07	3.90E-07	4.27E-07	4.27E-07	3.99E-07
Std Dev Un-Biased	9.07E-09	9.65E-09	9.34E-09	1.00E-08	1.22E-08	1.05E-08	1.07E-08
Ps90%/90% (+KTL) Un-Biased	3.72E-07	3.80E-07	3.96E-07	4.18E-07	4.60E-07	4.55E-07	4.29E-07
Ps90%/90% (-KTL) Un-Biased	3.22E-07	3.27E-07	3.45E-07	3.63E-07	3.93E-07	3.98E-07	3.70E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



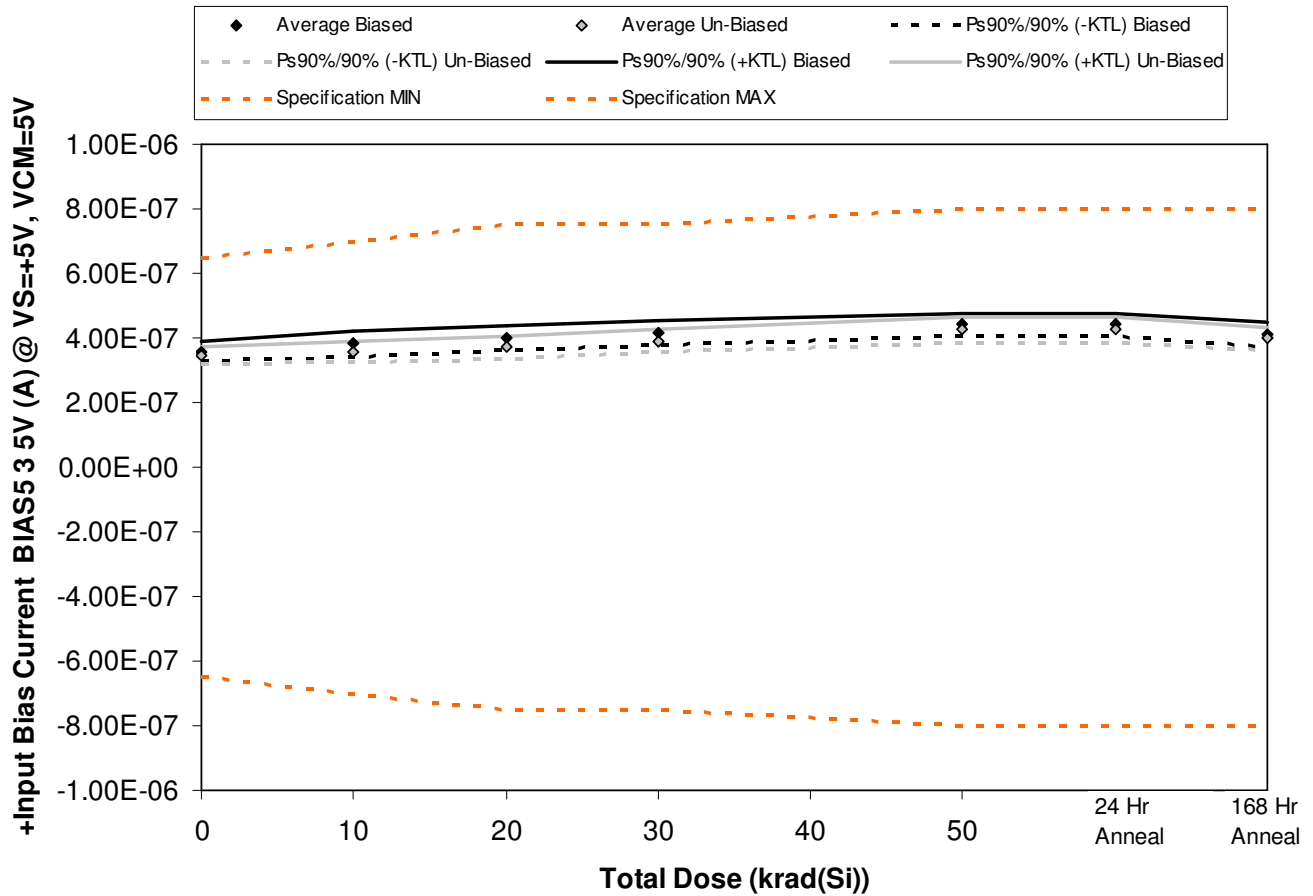


Figure 5.131. Plot of +Input Bias Current BIAS5 3 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.131. Raw data for +Input Bias Current BIAS5 3 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS5 3 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.54E-07	3.69E-07	3.90E-07	4.06E-07	4.39E-07	4.38E-07	4.07E-07
563	3.62E-07	3.86E-07	4.03E-07	4.15E-07	4.43E-07	4.40E-07	4.11E-07
564	3.72E-07	4.01E-07	4.21E-07	4.33E-07	4.60E-07	4.60E-07	4.27E-07
567	3.42E-07	3.65E-07	3.86E-07	3.97E-07	4.23E-07	4.25E-07	3.91E-07
569	3.59E-07	3.88E-07	4.07E-07	4.19E-07	4.43E-07	4.48E-07	4.15E-07
570	3.51E-07	3.59E-07	3.76E-07	3.96E-07	4.29E-07	4.28E-07	4.03E-07
571	3.39E-07	3.50E-07	3.64E-07	3.83E-07	4.18E-07	4.19E-07	3.89E-07
572	3.46E-07	3.58E-07	3.75E-07	3.94E-07	4.31E-07	4.32E-07	4.02E-07
573	3.37E-07	3.37E-07	3.53E-07	3.73E-07	4.06E-07	4.06E-07	3.81E-07
574	3.61E-07	3.69E-07	3.85E-07	4.06E-07	4.44E-07	4.45E-07	4.15E-07
584	3.62E-07	3.68E-07	3.68E-07	3.68E-07	3.69E-07	3.70E-07	3.69E-07
585	3.62E-07	3.72E-07	3.68E-07	3.71E-07	3.74E-07	3.76E-07	3.71E-07
<b>Biased Statistics</b>							
Average Biased	3.58E-07	3.82E-07	4.01E-07	4.14E-07	4.42E-07	4.42E-07	4.10E-07
Std Dev Biased	1.08E-08	1.47E-08	1.40E-08	1.38E-08	1.31E-08	1.29E-08	1.33E-08
Ps90%/90% (+KTL) Biased	3.87E-07	4.22E-07	4.40E-07	4.52E-07	4.78E-07	4.78E-07	4.47E-07
Ps90%/90% (-KTL) Biased	3.28E-07	3.42E-07	3.63E-07	3.76E-07	4.06E-07	4.07E-07	3.74E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.47E-07	3.55E-07	3.71E-07	3.90E-07	4.26E-07	4.26E-07	3.98E-07
Std Dev Un-Biased	9.66E-09	1.19E-08	1.23E-08	1.27E-08	1.44E-08	1.44E-08	1.34E-08
Ps90%/90% (+KTL) Un-Biased	3.73E-07	3.87E-07	4.04E-07	4.25E-07	4.65E-07	4.65E-07	4.35E-07
Ps90%/90% (-KTL) Un-Biased	3.20E-07	3.22E-07	3.37E-07	3.56E-07	3.86E-07	3.86E-07	3.61E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

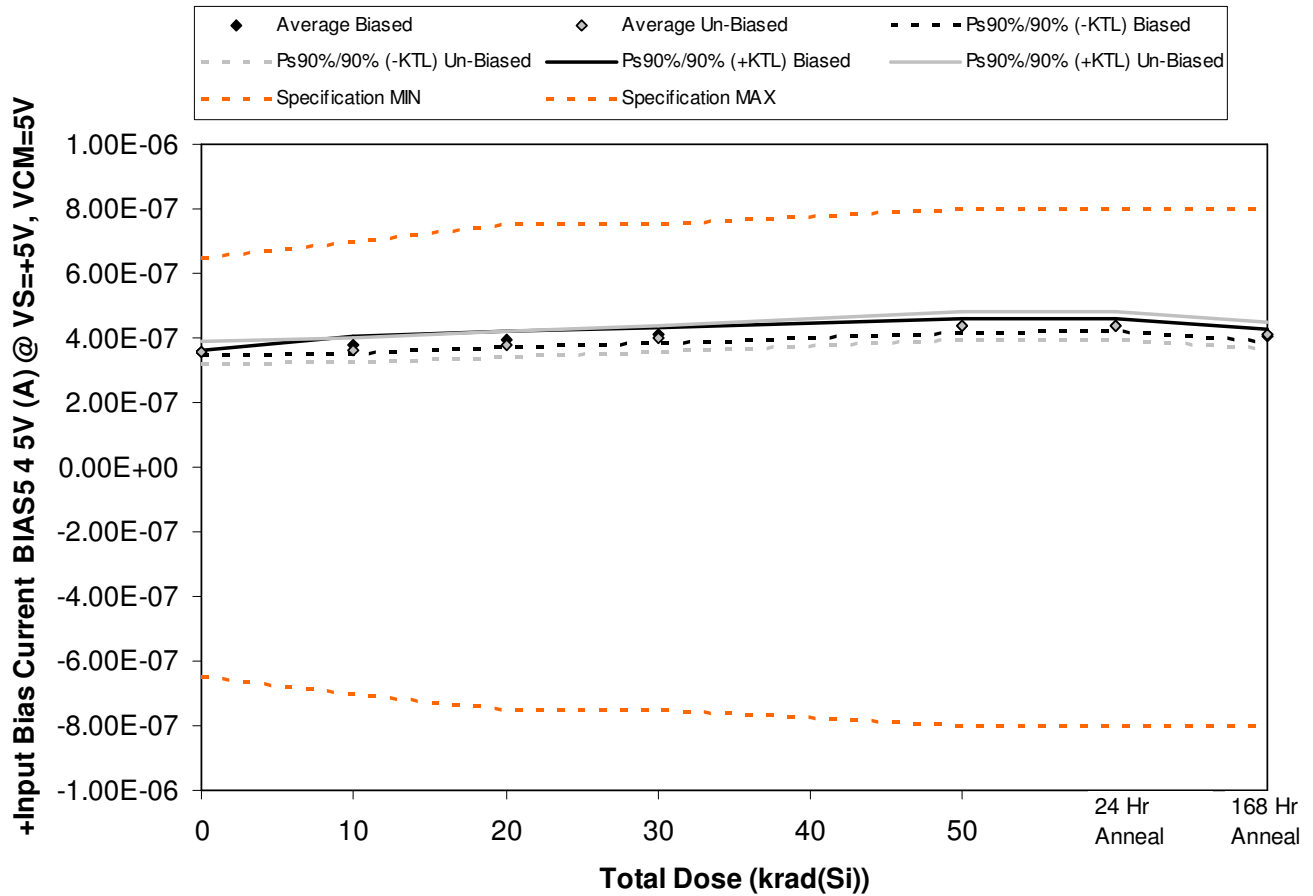


Figure 5.132. Plot of +Input Bias Current BIAS5 4 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.132. Raw data for +Input Bias Current BIAS5 4 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Input Bias Current BIAS5 4 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.48E-07	3.60E-07	3.81E-07	3.94E-07	4.26E-07	4.27E-07	3.96E-07
563	3.53E-07	3.76E-07	3.95E-07	4.08E-07	4.36E-07	4.36E-07	4.07E-07
564	3.56E-07	3.83E-07	4.01E-07	4.14E-07	4.41E-07	4.42E-07	4.09E-07
567	3.58E-07	3.84E-07	4.03E-07	4.16E-07	4.44E-07	4.44E-07	4.13E-07
569	3.56E-07	3.83E-07	4.03E-07	4.15E-07	4.43E-07	4.43E-07	4.10E-07
570	3.62E-07	3.68E-07	3.86E-07	4.02E-07	4.39E-07	4.37E-07	4.09E-07
571	3.42E-07	3.52E-07	3.69E-07	3.87E-07	4.25E-07	4.29E-07	3.97E-07
572	3.74E-07	3.85E-07	4.03E-07	4.23E-07	4.63E-07	4.64E-07	4.34E-07
573	3.47E-07	3.52E-07	3.70E-07	3.89E-07	4.25E-07	4.26E-07	3.98E-07
574	3.51E-07	3.57E-07	3.71E-07	3.93E-07	4.31E-07	4.31E-07	4.04E-07
584	3.42E-07	3.47E-07	3.47E-07	3.49E-07	3.49E-07	3.52E-07	3.52E-07
585	3.58E-07	3.64E-07	3.64E-07	3.67E-07	3.71E-07	3.71E-07	3.69E-07
<b>Biased Statistics</b>							
Average Biased	3.54E-07	3.77E-07	3.96E-07	4.10E-07	4.38E-07	4.38E-07	4.07E-07
Std Dev Biased	3.83E-09	1.02E-08	9.44E-09	9.13E-09	7.37E-09	7.00E-09	6.40E-09
Ps90%/90% (+KTL) Biased	3.65E-07	4.05E-07	4.22E-07	4.35E-07	4.58E-07	4.58E-07	4.24E-07
Ps90%/90% (-KTL) Biased	3.44E-07	3.49E-07	3.70E-07	3.85E-07	4.18E-07	4.19E-07	3.89E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.55E-07	3.63E-07	3.80E-07	3.99E-07	4.37E-07	4.37E-07	4.09E-07
Std Dev Un-Biased	1.28E-08	1.40E-08	1.45E-08	1.46E-08	1.58E-08	1.53E-08	1.52E-08
Ps90%/90% (+KTL) Un-Biased	3.90E-07	4.01E-07	4.20E-07	4.39E-07	4.80E-07	4.79E-07	4.50E-07
Ps90%/90% (-KTL) Un-Biased	3.20E-07	3.24E-07	3.40E-07	3.59E-07	3.93E-07	3.95E-07	3.67E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

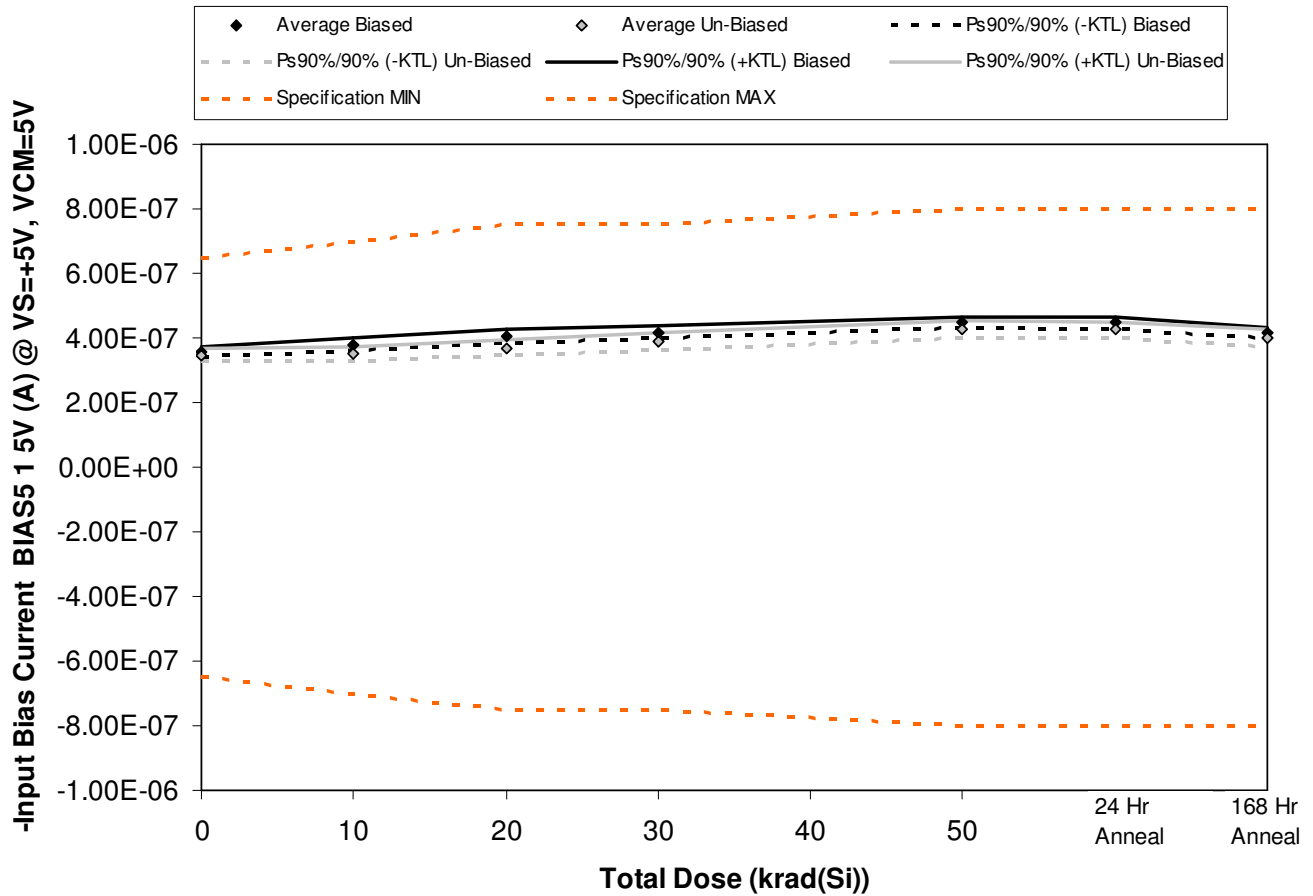


Figure 5.133. Plot of -Input Bias Current BIAS5 1 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.133. Raw data for -Input Bias Current BIAS5 1 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS5 1 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.60E-07	3.74E-07	3.97E-07	4.13E-07	4.52E-07	4.49E-07	4.20E-07
563	3.50E-07	3.76E-07	3.97E-07	4.13E-07	4.43E-07	4.41E-07	4.12E-07
564	3.63E-07	3.92E-07	4.16E-07	4.29E-07	4.56E-07	4.57E-07	4.24E-07
567	3.52E-07	3.78E-07	4.01E-07	4.16E-07	4.44E-07	4.40E-07	4.12E-07
569	3.53E-07	3.84E-07	4.07E-07	4.22E-07	4.50E-07	4.48E-07	4.17E-07
570	3.48E-07	3.54E-07	3.71E-07	3.90E-07	4.26E-07	4.24E-07	3.96E-07
571	3.45E-07	3.53E-07	3.68E-07	3.86E-07	4.22E-07	4.22E-07	3.97E-07
572	3.59E-07	3.67E-07	3.84E-07	4.05E-07	4.42E-07	4.41E-07	4.16E-07
573	3.44E-07	3.48E-07	3.64E-07	3.83E-07	4.19E-07	4.19E-07	3.94E-07
574	3.44E-07	3.48E-07	3.64E-07	3.82E-07	4.20E-07	4.18E-07	3.92E-07
584	3.37E-07	3.40E-07	3.39E-07	3.38E-07	3.39E-07	3.39E-07	3.37E-07
585	3.57E-07	3.59E-07	3.57E-07	3.60E-07	3.63E-07	3.64E-07	3.59E-07
<b>Biased Statistics</b>							
Average Biased	3.55E-07	3.81E-07	4.04E-07	4.19E-07	4.49E-07	4.47E-07	4.17E-07
Std Dev Biased	5.61E-09	7.30E-09	8.08E-09	6.82E-09	5.41E-09	6.96E-09	5.23E-09
Ps90%/90% (+KTL) Biased	3.71E-07	4.01E-07	4.26E-07	4.37E-07	4.64E-07	4.66E-07	4.31E-07
Ps90%/90% (-KTL) Biased	3.40E-07	3.61E-07	3.81E-07	4.00E-07	4.34E-07	4.28E-07	4.03E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.48E-07	3.54E-07	3.70E-07	3.89E-07	4.26E-07	4.25E-07	3.99E-07
Std Dev Un-Biased	6.42E-09	7.81E-09	8.47E-09	9.12E-09	9.62E-09	9.41E-09	9.53E-09
Ps90%/90% (+KTL) Un-Biased	3.66E-07	3.75E-07	3.93E-07	4.14E-07	4.52E-07	4.51E-07	4.25E-07
Ps90%/90% (-KTL) Un-Biased	3.31E-07	3.32E-07	3.47E-07	3.64E-07	3.99E-07	3.99E-07	3.73E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

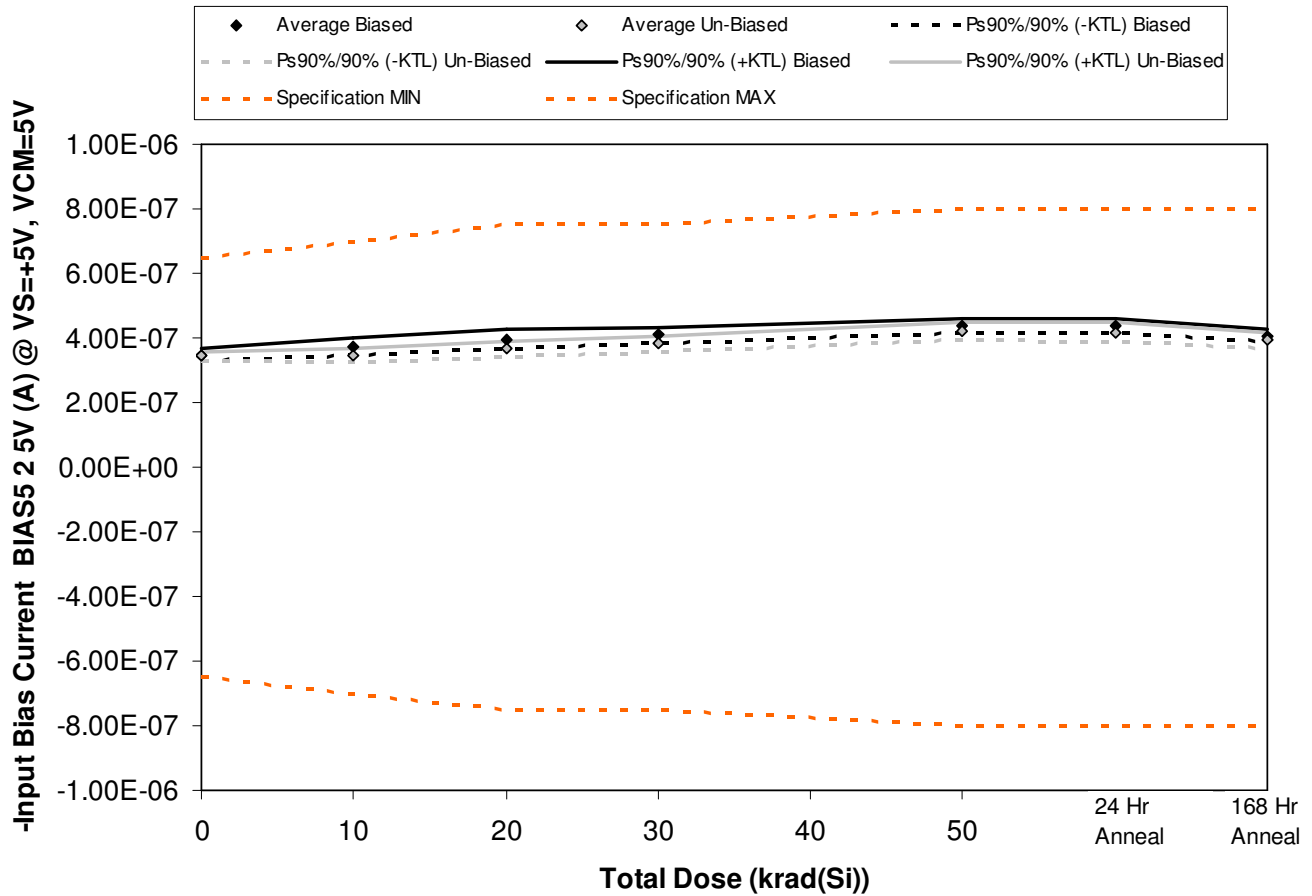


Figure 5.134. Plot of -Input Bias Current BIAS5 2.5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.134. Raw data for -Input Bias Current BIAS5 2 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS5 2 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.39E-07	3.57E-07	3.79E-07	3.98E-07	4.33E-07	4.30E-07	4.00E-07
563	3.53E-07	3.76E-07	3.96E-07	4.11E-07	4.40E-07	4.36E-07	4.08E-07
564	3.56E-07	3.85E-07	4.08E-07	4.20E-07	4.49E-07	4.48E-07	4.18E-07
567	3.41E-07	3.69E-07	3.91E-07	4.03E-07	4.31E-07	4.29E-07	4.01E-07
569	3.45E-07	3.75E-07	4.00E-07	4.11E-07	4.42E-07	4.40E-07	4.09E-07
570	3.52E-07	3.56E-07	3.74E-07	3.92E-07	4.27E-07	4.29E-07	4.02E-07
571	3.40E-07	3.49E-07	3.65E-07	3.81E-07	4.18E-07	4.17E-07	3.91E-07
572	3.42E-07	3.48E-07	3.66E-07	3.83E-07	4.22E-07	4.19E-07	3.95E-07
573	3.37E-07	3.35E-07	3.51E-07	3.68E-07	4.04E-07	4.03E-07	3.80E-07
574	3.46E-07	3.51E-07	3.68E-07	3.88E-07	4.28E-07	4.26E-07	3.99E-07
584	3.51E-07	3.54E-07	3.55E-07	3.53E-07	3.53E-07	3.54E-07	3.53E-07
585	3.50E-07	3.52E-07	3.50E-07	3.52E-07	3.56E-07	3.57E-07	3.51E-07
<b>Biased Statistics</b>							
Average Biased	3.47E-07	3.72E-07	3.95E-07	4.09E-07	4.39E-07	4.37E-07	4.07E-07
Std Dev Biased	7.21E-09	1.04E-08	1.09E-08	8.42E-09	7.43E-09	7.68E-09	7.34E-09
Ps90%/90% (+KTL) Biased	3.67E-07	4.01E-07	4.25E-07	4.32E-07	4.59E-07	4.58E-07	4.27E-07
Ps90%/90% (-KTL) Biased	3.27E-07	3.44E-07	3.65E-07	3.86E-07	4.19E-07	4.16E-07	3.87E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.43E-07	3.48E-07	3.65E-07	3.82E-07	4.20E-07	4.19E-07	3.93E-07
Std Dev Un-Biased	5.76E-09	7.85E-09	8.32E-09	9.16E-09	9.63E-09	1.01E-08	8.48E-09
Ps90%/90% (+KTL) Un-Biased	3.59E-07	3.69E-07	3.88E-07	4.08E-07	4.46E-07	4.46E-07	4.17E-07
Ps90%/90% (-KTL) Un-Biased	3.27E-07	3.26E-07	3.42E-07	3.57E-07	3.93E-07	3.91E-07	3.70E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



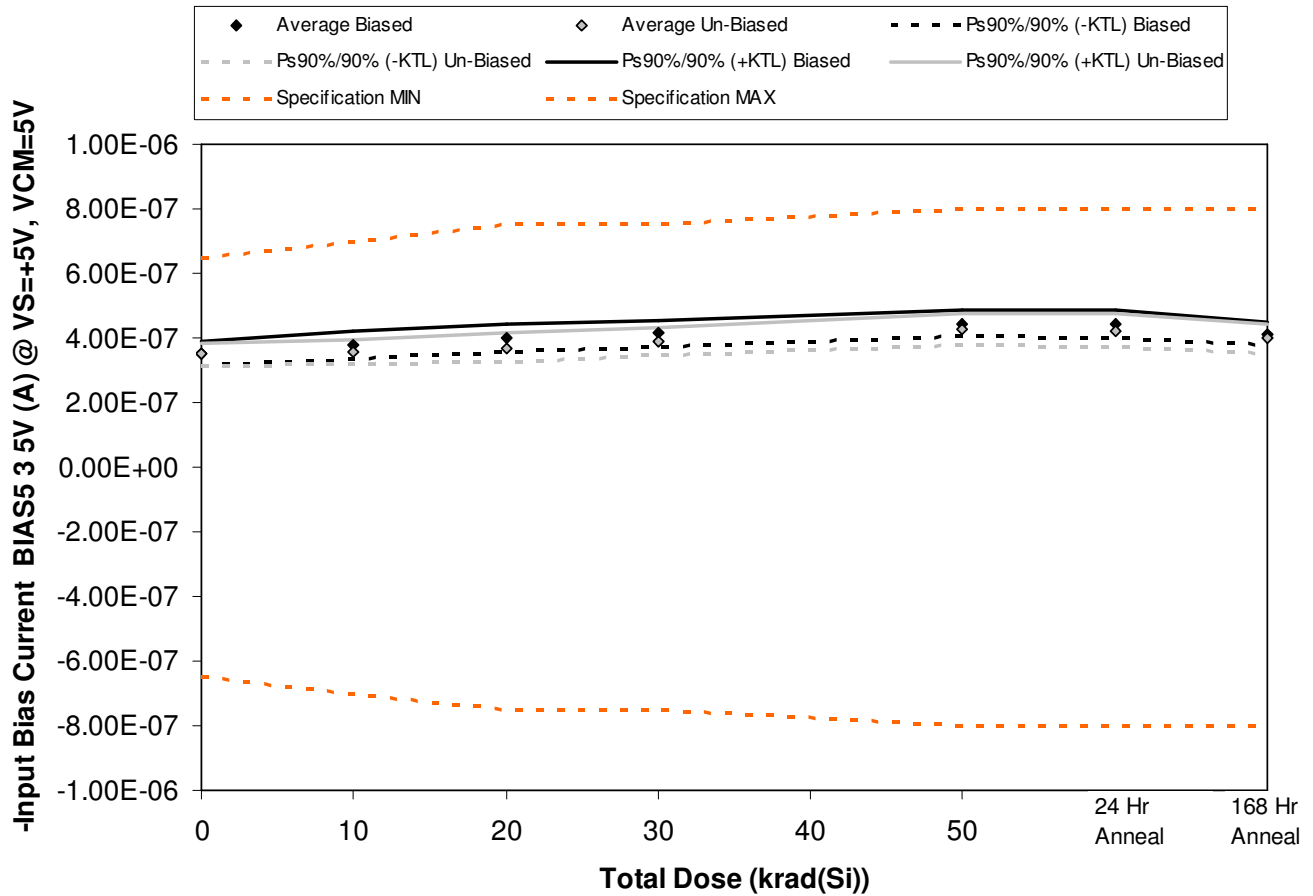


Figure 5.135. Plot of -Input Bias Current BIAS5 3 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.135. Raw data for -Input Bias Current BIAS5 3 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS5 3 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.46E-07	3.61E-07	3.83E-07	4.02E-07	4.37E-07	4.36E-07	4.05E-07
563	3.60E-07	3.82E-07	4.01E-07	4.15E-07	4.45E-07	4.41E-07	4.16E-07
564	3.73E-07	4.03E-07	4.25E-07	4.38E-07	4.68E-07	4.67E-07	4.33E-07
567	3.38E-07	3.67E-07	3.88E-07	4.02E-07	4.30E-07	4.26E-07	3.99E-07
569	3.48E-07	3.79E-07	4.02E-07	4.17E-07	4.44E-07	4.41E-07	4.12E-07
570	3.47E-07	3.53E-07	3.68E-07	3.87E-07	4.24E-07	4.21E-07	3.96E-07
571	3.38E-07	3.45E-07	3.60E-07	3.77E-07	4.13E-07	4.12E-07	3.87E-07
572	3.59E-07	3.67E-07	3.85E-07	4.02E-07	4.39E-07	4.38E-07	4.11E-07
573	3.35E-07	3.39E-07	3.49E-07	3.69E-07	4.04E-07	4.00E-07	3.78E-07
574	3.65E-07	3.71E-07	3.87E-07	4.07E-07	4.48E-07	4.46E-07	4.19E-07
584	3.50E-07	3.50E-07	3.51E-07	3.50E-07	3.49E-07	3.51E-07	3.50E-07
585	3.58E-07	3.61E-07	3.58E-07	3.61E-07	3.65E-07	3.66E-07	3.60E-07
<b>Biased Statistics</b>							
Average Biased	3.53E-07	3.78E-07	4.00E-07	4.15E-07	4.45E-07	4.42E-07	4.13E-07
Std Dev Biased	1.39E-08	1.62E-08	1.63E-08	1.48E-08	1.44E-08	1.53E-08	1.26E-08
Ps90%/90% (+KTL) Biased	3.91E-07	4.23E-07	4.45E-07	4.55E-07	4.84E-07	4.84E-07	4.48E-07
Ps90%/90% (-KTL) Biased	3.15E-07	3.34E-07	3.55E-07	3.74E-07	4.05E-07	4.00E-07	3.78E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.49E-07	3.55E-07	3.70E-07	3.88E-07	4.26E-07	4.24E-07	3.98E-07
Std Dev Un-Biased	1.32E-08	1.35E-08	1.62E-08	1.59E-08	1.79E-08	1.86E-08	1.67E-08
Ps90%/90% (+KTL) Un-Biased	3.85E-07	3.92E-07	4.14E-07	4.32E-07	4.75E-07	4.75E-07	4.44E-07
Ps90%/90% (-KTL) Un-Biased	3.13E-07	3.18E-07	3.25E-07	3.45E-07	3.76E-07	3.73E-07	3.52E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

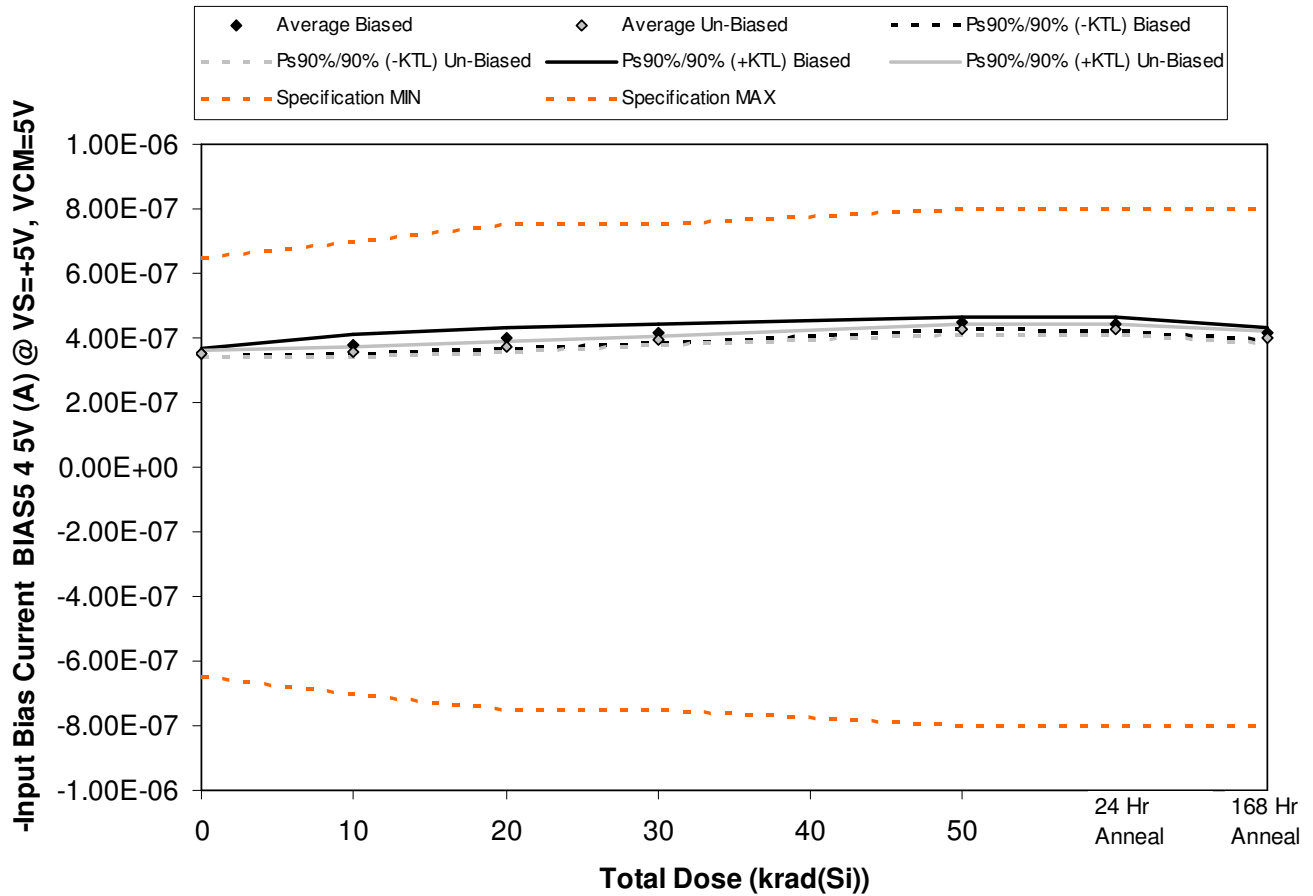


Figure 5.136. Plot of -Input Bias Current BIAS5 4 5V (A) @ VS=+5V, VCM=5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.136. Raw data for -Input Bias Current BIAS5 4 5V (A) @ VS=+5V, VCM=5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Input Bias Current BIAS5 4 5V (A) @ VS=+5V, VCM=5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.47E-07	3.60E-07	3.83E-07	3.98E-07	4.35E-07	4.33E-07	4.04E-07
563	3.54E-07	3.78E-07	4.00E-07	4.14E-07	4.47E-07	4.45E-07	4.15E-07
564	3.55E-07	3.83E-07	4.07E-07	4.18E-07	4.49E-07	4.48E-07	4.16E-07
567	3.57E-07	3.84E-07	4.08E-07	4.21E-07	4.50E-07	4.46E-07	4.16E-07
569	3.58E-07	3.89E-07	4.14E-07	4.26E-07	4.53E-07	4.54E-07	4.22E-07
570	3.54E-07	3.59E-07	3.76E-07	3.93E-07	4.27E-07	4.24E-07	3.98E-07
571	3.51E-07	3.58E-07	3.75E-07	3.91E-07	4.27E-07	4.29E-07	4.02E-07
572	3.57E-07	3.65E-07	3.83E-07	4.00E-07	4.38E-07	4.37E-07	4.12E-07
573	3.48E-07	3.52E-07	3.68E-07	3.89E-07	4.23E-07	4.24E-07	3.98E-07
574	3.48E-07	3.52E-07	3.69E-07	3.87E-07	4.25E-07	4.22E-07	3.95E-07
584	3.41E-07	3.43E-07	3.44E-07	3.42E-07	3.43E-07	3.43E-07	3.42E-07
585	3.62E-07	3.65E-07	3.61E-07	3.65E-07	3.68E-07	3.69E-07	3.61E-07
<b>Biased Statistics</b>							
Average Biased	3.54E-07	3.79E-07	4.02E-07	4.15E-07	4.47E-07	4.45E-07	4.15E-07
Std Dev Biased	4.39E-09	1.09E-08	1.20E-08	1.06E-08	7.09E-09	7.85E-09	6.33E-09
Ps90%/90% (+KTL) Biased	3.66E-07	4.09E-07	4.35E-07	4.45E-07	4.66E-07	4.67E-07	4.32E-07
Ps90%/90% (-KTL) Biased	3.42E-07	3.49E-07	3.69E-07	3.86E-07	4.27E-07	4.24E-07	3.97E-07
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.52E-07	3.57E-07	3.74E-07	3.92E-07	4.28E-07	4.27E-07	4.01E-07
Std Dev Un-Biased	4.10E-09	5.47E-09	5.94E-09	5.20E-09	5.86E-09	6.16E-09	6.88E-09
Ps90%/90% (+KTL) Un-Biased	3.63E-07	3.72E-07	3.90E-07	4.06E-07	4.44E-07	4.44E-07	4.20E-07
Ps90%/90% (-KTL) Un-Biased	3.40E-07	3.42E-07	3.58E-07	3.78E-07	4.12E-07	4.10E-07	3.82E-07
<b>Specification MIN</b>	<b>-6.50E-07</b>	<b>-7.00E-07</b>	<b>-7.50E-07</b>	<b>-7.50E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>	<b>-8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS
<b>Specification MAX</b>	<b>6.50E-07</b>	<b>7.00E-07</b>	<b>7.50E-07</b>	<b>7.50E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>	<b>8.00E-07</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

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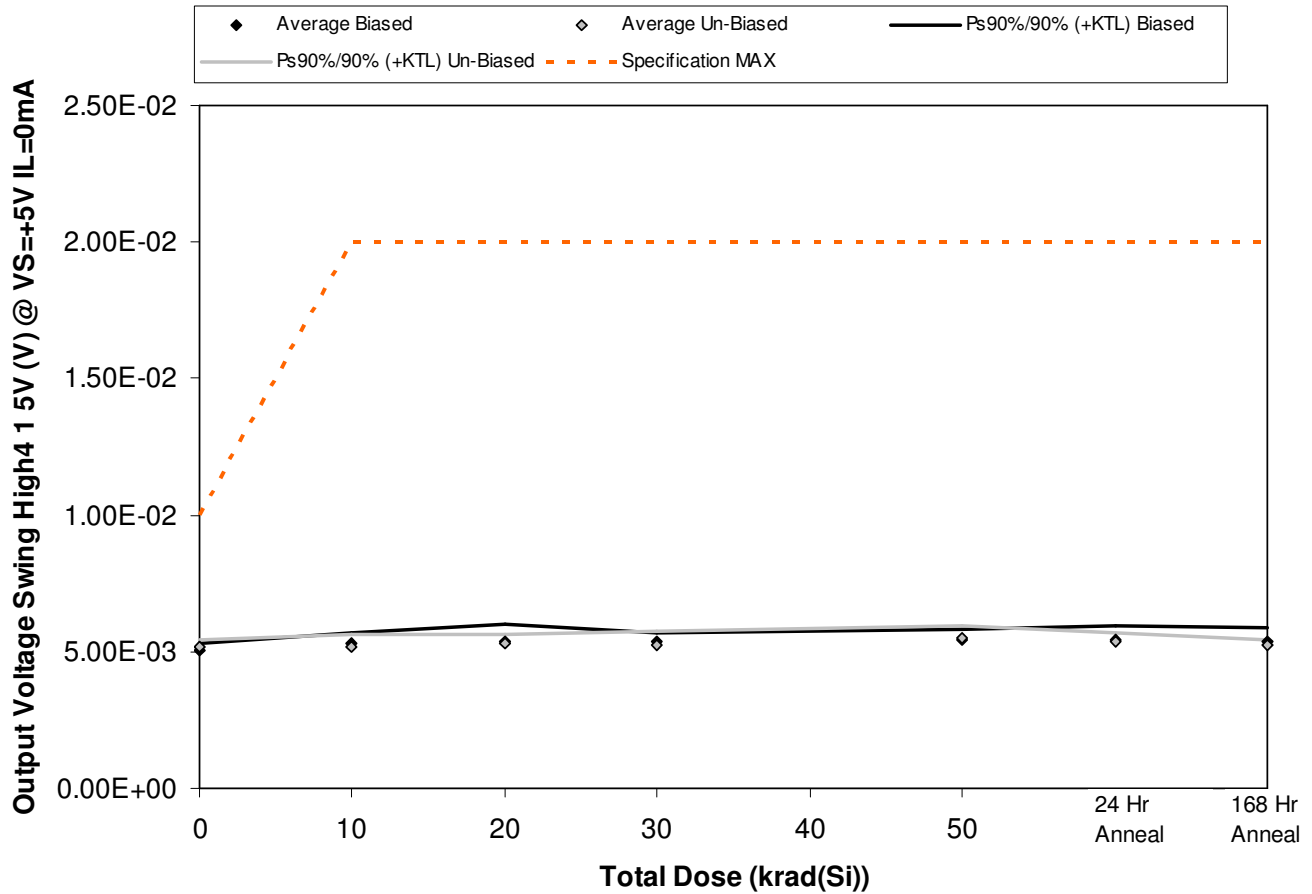


Figure 5.137. Plot of Output Voltage Swing High4 1 5V (V) @ VS=+5V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.137. Raw data for Output Voltage Swing High4 1 5V (V) @ VS=+5V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High4 1 5V (V) @ VS=+5V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	4.92E-03	5.10E-03	5.16E-03	5.28E-03	5.24E-03	5.20E-03	5.14E-03
563	5.04E-03	5.42E-03	5.31E-03	5.28E-03	5.46E-03	5.61E-03	5.46E-03
564	5.14E-03	5.30E-03	5.44E-03	5.57E-03	5.55E-03	5.46E-03	5.49E-03
567	5.16E-03	5.42E-03	5.73E-03	5.42E-03	5.45E-03	5.66E-03	5.61E-03
569	5.01E-03	5.23E-03	5.21E-03	5.28E-03	5.55E-03	5.39E-03	5.26E-03
570	5.14E-03	5.18E-03	5.19E-03	5.22E-03	5.60E-03	5.30E-03	5.22E-03
571	5.29E-03	5.00E-03	5.19E-03	5.22E-03	5.67E-03	5.20E-03	5.22E-03
572	5.28E-03	5.25E-03	5.34E-03	5.40E-03	5.50E-03	5.42E-03	5.34E-03
573	5.18E-03	5.42E-03	5.48E-03	5.42E-03	5.55E-03	5.51E-03	5.32E-03
574	5.06E-03	5.00E-03	5.26E-03	4.98E-03	5.28E-03	5.30E-03	5.15E-03
584	4.82E-03	5.28E-03	5.17E-03	4.98E-03	5.14E-03	5.07E-03	4.87E-03
585	5.08E-03	5.08E-03	5.14E-03	5.15E-03	5.33E-03	5.10E-03	5.17E-03
<b>Biased Statistics</b>							
Average Biased	5.05E-03	5.29E-03	5.37E-03	5.37E-03	5.45E-03	5.46E-03	5.39E-03
Std Dev Biased	9.84E-05	1.36E-04	2.28E-04	1.29E-04	1.27E-04	1.84E-04	1.89E-04
Ps90%/90% (+KTL) Biased	5.32E-03	5.67E-03	5.99E-03	5.72E-03	5.80E-03	5.97E-03	5.91E-03
Ps90%/90% (-KTL) Biased	4.78E-03	4.92E-03	4.75E-03	5.01E-03	5.10E-03	4.96E-03	4.87E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.19E-03	5.17E-03	5.29E-03	5.25E-03	5.52E-03	5.35E-03	5.25E-03
Std Dev Un-Biased	9.70E-05	1.78E-04	1.22E-04	1.78E-04	1.48E-04	1.20E-04	7.87E-05
Ps90%/90% (+KTL) Un-Biased	5.46E-03	5.66E-03	5.63E-03	5.73E-03	5.93E-03	5.68E-03	5.47E-03
Ps90%/90% (-KTL) Un-Biased	4.92E-03	4.68E-03	4.96E-03	4.76E-03	5.11E-03	5.02E-03	5.03E-03
<b>Specification MAX</b>	<b>1.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

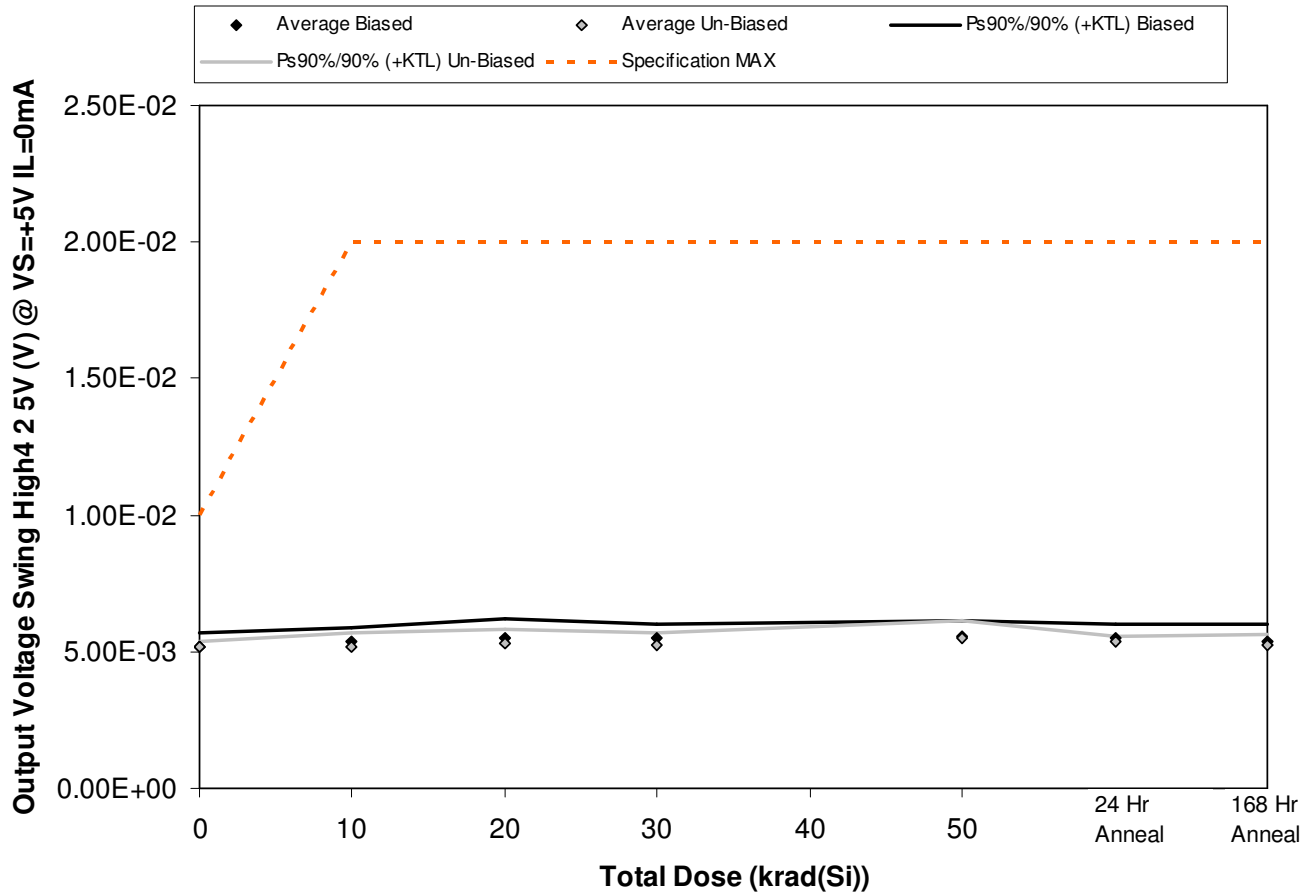


Figure 5.138. Plot of Output Voltage Swing High4 2 5V (V) @ VS=+5V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.138. Raw data for Output Voltage Swing High4 2 5V (V) @ VS=+5V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High4 2 5V (V) @ VS=+5V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	4.86E-03	5.17E-03	5.09E-03	5.30E-03	5.31E-03	5.17E-03	5.09E-03
563	5.21E-03	5.65E-03	5.71E-03	5.50E-03	5.82E-03	5.68E-03	5.66E-03
564	5.34E-03	5.40E-03	5.71E-03	5.76E-03	5.63E-03	5.59E-03	5.49E-03
567	5.29E-03	5.40E-03	5.56E-03	5.54E-03	5.67E-03	5.57E-03	5.44E-03
569	5.11E-03	5.20E-03	5.29E-03	5.34E-03	5.51E-03	5.46E-03	5.32E-03
570	5.24E-03	5.37E-03	5.37E-03	5.39E-03	5.70E-03	5.36E-03	5.46E-03
571	5.14E-03	4.96E-03	5.16E-03	5.12E-03	5.68E-03	5.36E-03	5.10E-03
572	5.11E-03	5.20E-03	5.22E-03	5.23E-03	5.58E-03	5.25E-03	5.24E-03
573	5.21E-03	5.33E-03	5.64E-03	5.39E-03	5.46E-03	5.47E-03	5.24E-03
574	5.04E-03	5.06E-03	5.29E-03	4.98E-03	5.14E-03	5.37E-03	5.09E-03
584	5.31E-03	5.67E-03	5.48E-03	5.34E-03	5.43E-03	5.52E-03	5.32E-03
585	5.26E-03	5.35E-03	5.44E-03	5.42E-03	5.72E-03	5.37E-03	5.29E-03
<b>Biased Statistics</b>							
Average Biased	5.16E-03	5.36E-03	5.47E-03	5.49E-03	5.59E-03	5.49E-03	5.40E-03
Std Dev Biased	1.90E-04	1.93E-04	2.74E-04	1.83E-04	1.91E-04	1.97E-04	2.12E-04
Ps90%/90% (+KTL) Biased	5.68E-03	5.89E-03	6.22E-03	5.99E-03	6.11E-03	6.04E-03	5.98E-03
Ps90%/90% (-KTL) Biased	4.64E-03	4.83E-03	4.72E-03	4.99E-03	5.06E-03	4.95E-03	4.82E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.15E-03	5.18E-03	5.34E-03	5.22E-03	5.51E-03	5.36E-03	5.23E-03
Std Dev Un-Biased	7.98E-05	1.74E-04	1.87E-04	1.77E-04	2.29E-04	7.79E-05	1.50E-04
Ps90%/90% (+KTL) Un-Biased	5.37E-03	5.66E-03	5.85E-03	5.71E-03	6.14E-03	5.58E-03	5.64E-03
Ps90%/90% (-KTL) Un-Biased	4.93E-03	4.71E-03	4.82E-03	4.74E-03	4.88E-03	5.15E-03	4.82E-03
<b>Specification MAX</b>	<b>1.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



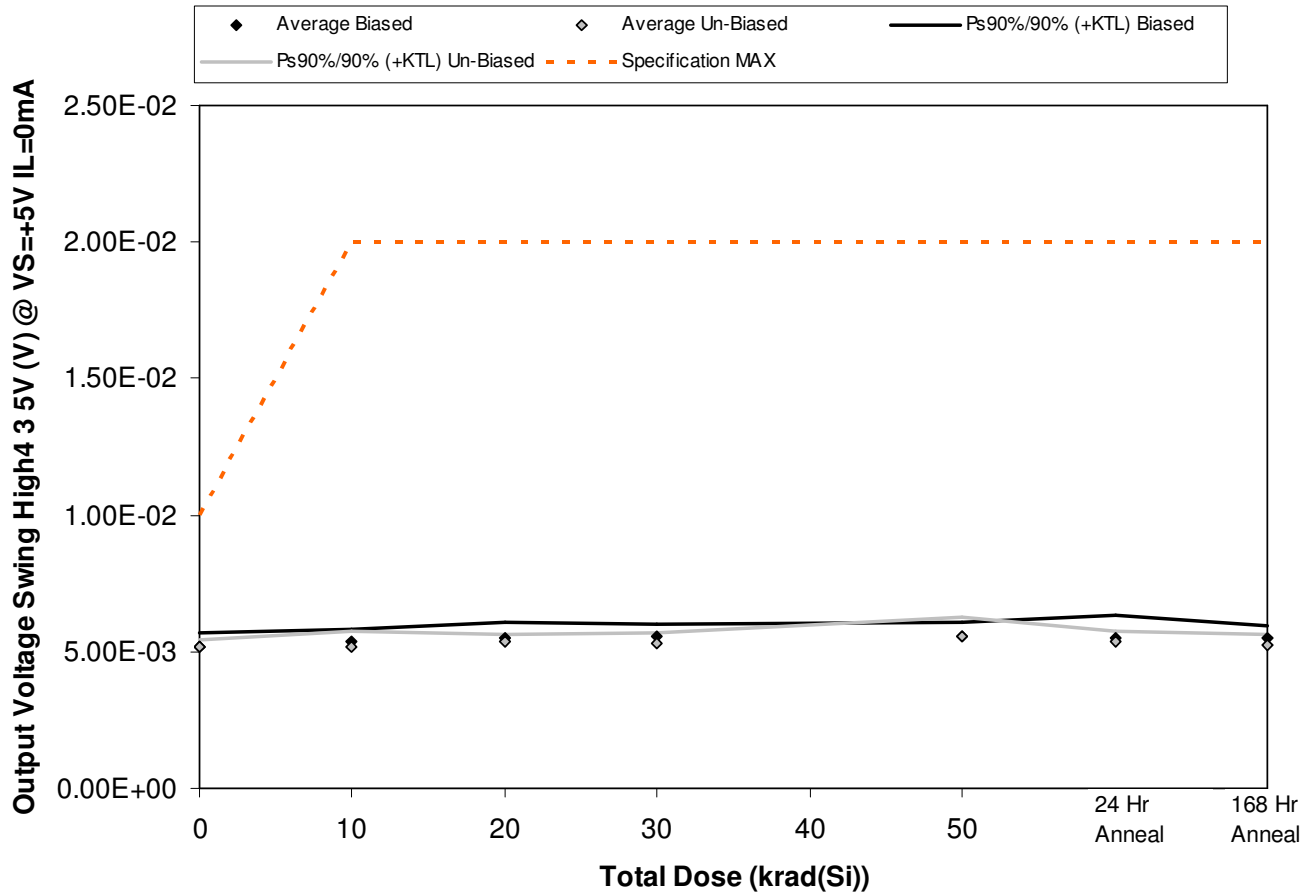


Figure 5.139. Plot of Output Voltage Swing High4 3 5V (V) @ VS=+5V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.139. Raw data for Output Voltage Swing High4 3 5V (V) @ VS=+5V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High4 3 5V (V) @ VS=+5V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	4.81E-03	5.37E-03	5.21E-03	5.44E-03	5.28E-03	5.12E-03	5.31E-03
563	5.24E-03	5.64E-03	5.66E-03	5.60E-03	5.77E-03	5.94E-03	5.71E-03
564	5.23E-03	5.28E-03	5.64E-03	5.79E-03	5.62E-03	5.61E-03	5.54E-03
567	5.31E-03	5.35E-03	5.63E-03	5.54E-03	5.68E-03	5.51E-03	5.53E-03
569	5.16E-03	5.25E-03	5.29E-03	5.30E-03	5.48E-03	5.44E-03	5.26E-03
570	5.28E-03	5.33E-03	5.24E-03	5.44E-03	5.75E-03	5.39E-03	5.41E-03
571	5.13E-03	5.03E-03	5.43E-03	5.12E-03	5.68E-03	5.37E-03	5.22E-03
572	5.11E-03	5.13E-03	5.31E-03	5.30E-03	5.58E-03	5.22E-03	5.29E-03
573	5.26E-03	5.50E-03	5.51E-03	5.40E-03	5.72E-03	5.56E-03	5.29E-03
574	5.09E-03	5.03E-03	5.37E-03	5.18E-03	5.16E-03	5.25E-03	5.07E-03
584	5.29E-03	5.57E-03	5.54E-03	5.30E-03	5.43E-03	5.37E-03	5.31E-03
585	5.28E-03	5.38E-03	5.41E-03	5.42E-03	5.58E-03	5.37E-03	5.26E-03
<b>Biased Statistics</b>							
Average Biased	5.15E-03	5.38E-03	5.49E-03	5.53E-03	5.57E-03	5.52E-03	5.47E-03
Std Dev Biased	1.97E-04	1.54E-04	2.18E-04	1.83E-04	1.92E-04	2.96E-04	1.84E-04
Ps90%/90% (+KTL) Biased	5.69E-03	5.80E-03	6.08E-03	6.03E-03	6.09E-03	6.34E-03	5.98E-03
Ps90%/90% (-KTL) Biased	4.61E-03	4.95E-03	4.89E-03	5.03E-03	5.04E-03	4.71E-03	4.96E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.17E-03	5.20E-03	5.37E-03	5.29E-03	5.58E-03	5.36E-03	5.26E-03
Std Dev Un-Biased	8.91E-05	2.06E-04	1.04E-04	1.38E-04	2.42E-04	1.35E-04	1.24E-04
Ps90%/90% (+KTL) Un-Biased	5.42E-03	5.77E-03	5.66E-03	5.67E-03	6.24E-03	5.73E-03	5.60E-03
Ps90%/90% (-KTL) Un-Biased	4.93E-03	4.64E-03	5.09E-03	4.91E-03	4.91E-03	4.99E-03	4.91E-03
<b>Specification MAX</b>	<b>1.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

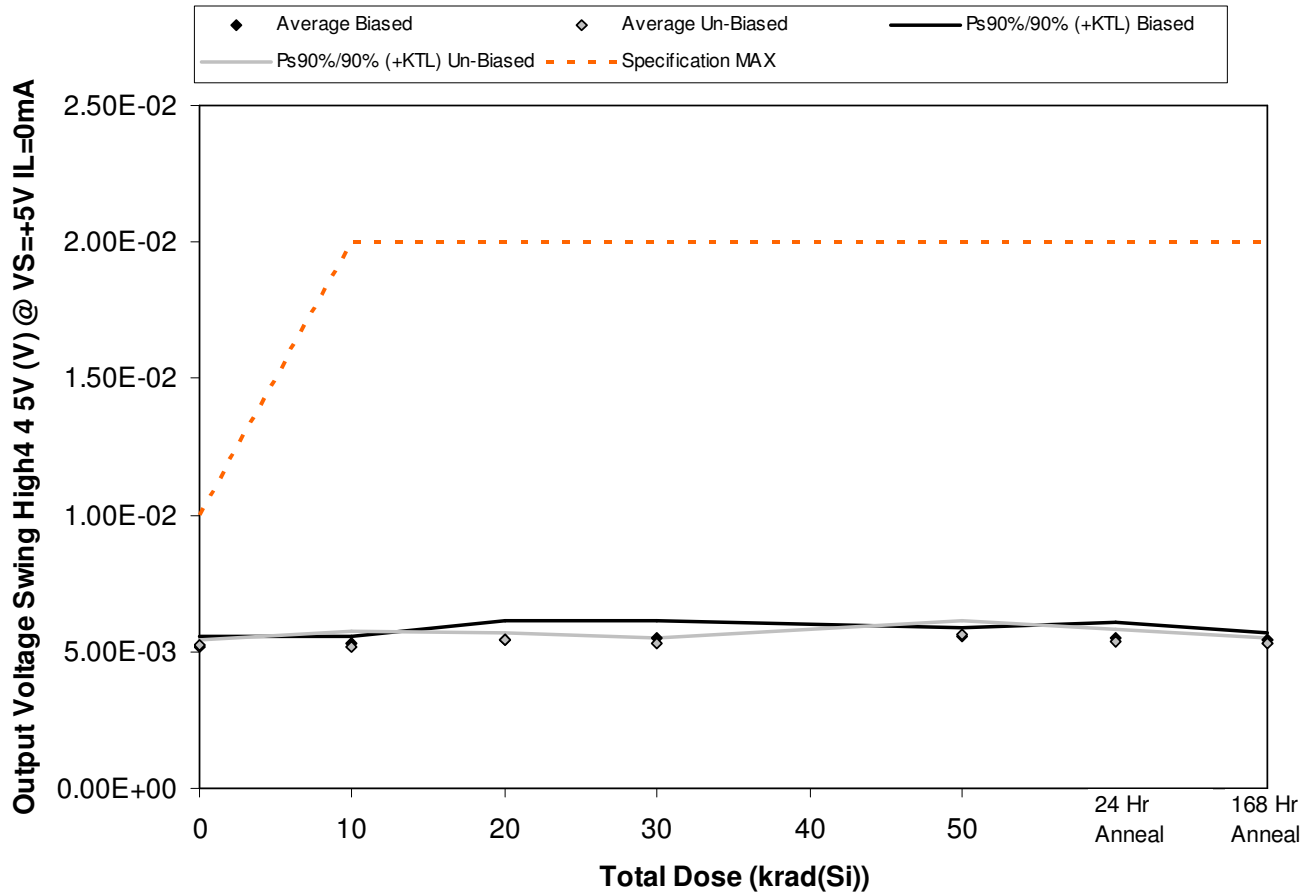


Figure 5.140. Plot of Output Voltage Swing High4 4 5V (V) @ VS=+5V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.140. Raw data for Output Voltage Swing High4 4 5V (V) @ VS=+5V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High4 4 5V (V) @ VS=+5V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	4.99E-03	5.23E-03	5.05E-03	5.30E-03	5.38E-03	5.15E-03	5.39E-03
563	5.08E-03	5.35E-03	5.39E-03	5.49E-03	5.50E-03	5.59E-03	5.46E-03
564	5.21E-03	5.32E-03	5.53E-03	5.86E-03	5.50E-03	5.62E-03	5.39E-03
567	5.24E-03	5.45E-03	5.75E-03	5.55E-03	5.75E-03	5.54E-03	5.54E-03
569	5.33E-03	5.27E-03	5.43E-03	5.23E-03	5.56E-03	5.64E-03	5.29E-03
570	5.26E-03	5.32E-03	5.34E-03	5.37E-03	5.75E-03	5.34E-03	5.29E-03
571	5.24E-03	5.03E-03	5.32E-03	5.25E-03	5.68E-03	5.37E-03	5.22E-03
572	5.28E-03	5.35E-03	5.51E-03	5.39E-03	5.60E-03	5.39E-03	5.41E-03
573	5.24E-03	5.37E-03	5.56E-03	5.34E-03	5.70E-03	5.66E-03	5.37E-03
574	5.06E-03	4.96E-03	5.39E-03	5.28E-03	5.28E-03	5.24E-03	5.31E-03
584	5.09E-03	5.23E-03	5.29E-03	5.07E-03	5.14E-03	5.22E-03	5.09E-03
585	5.09E-03	5.03E-03	5.09E-03	5.30E-03	5.50E-03	5.15E-03	5.15E-03
<b>Biased Statistics</b>							
Average Biased	5.17E-03	5.32E-03	5.43E-03	5.49E-03	5.54E-03	5.51E-03	5.41E-03
Std Dev Biased	1.35E-04	8.41E-05	2.54E-04	2.47E-04	1.35E-04	2.04E-04	9.29E-05
Ps90%/90% (+KTL) Biased	5.54E-03	5.55E-03	6.13E-03	6.16E-03	5.91E-03	6.07E-03	5.67E-03
Ps90%/90% (-KTL) Biased	4.80E-03	5.09E-03	4.73E-03	4.81E-03	5.17E-03	4.95E-03	5.16E-03
<b>Un-Biased Statistics</b>							
Average Un-Biased	5.22E-03	5.21E-03	5.42E-03	5.33E-03	5.60E-03	5.40E-03	5.32E-03
Std Dev Un-Biased	8.88E-05	1.95E-04	1.06E-04	5.94E-05	1.88E-04	1.56E-04	7.35E-05
Ps90%/90% (+KTL) Un-Biased	5.46E-03	5.74E-03	5.71E-03	5.49E-03	6.12E-03	5.83E-03	5.52E-03
Ps90%/90% (-KTL) Un-Biased	4.97E-03	4.67E-03	5.13E-03	5.16E-03	5.09E-03	4.97E-03	5.12E-03
<b>Specification MAX</b>	<b>1.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>	<b>2.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

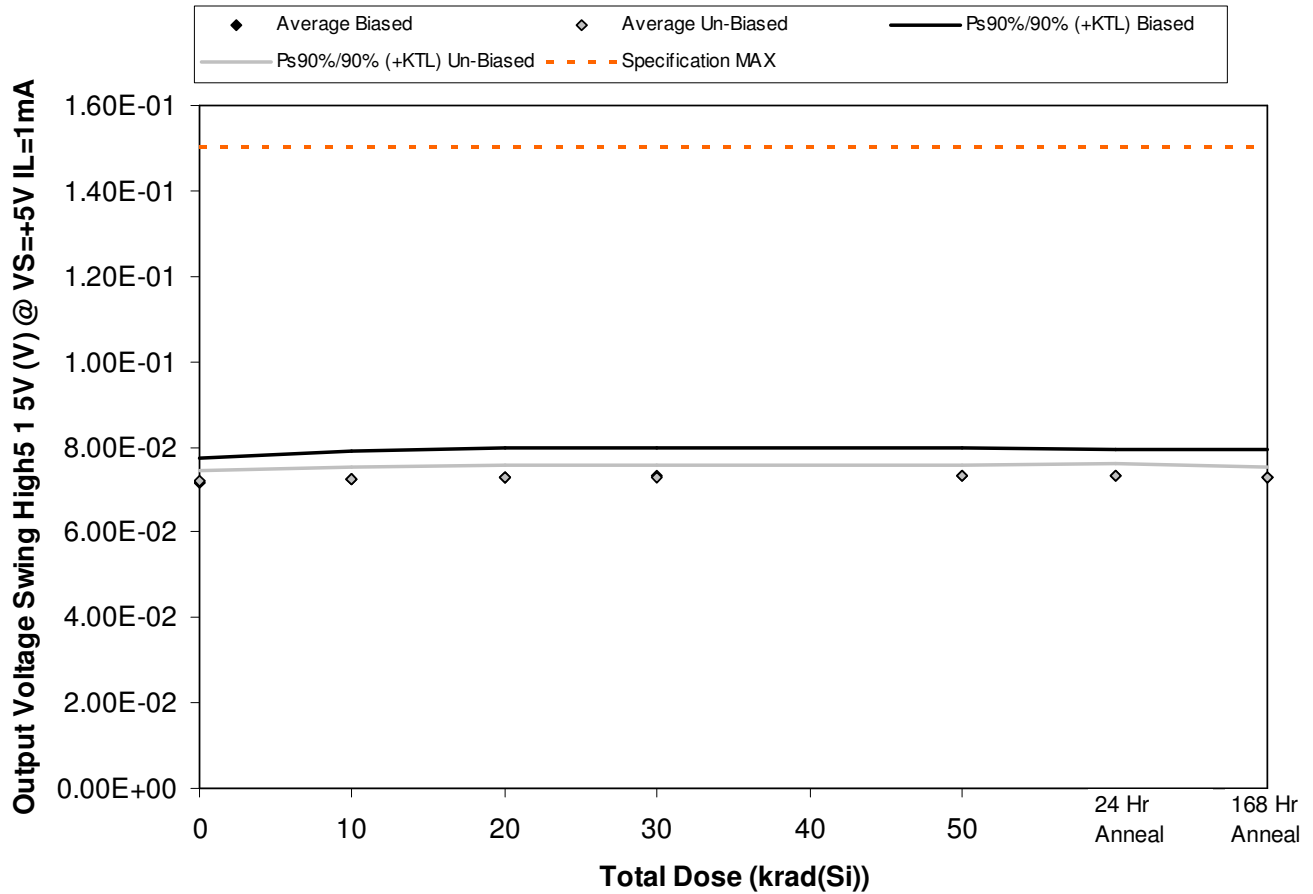


Figure 5.141. Plot of Output Voltage Swing High5 1 5V (V) @ VS=+5V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.141. Raw data for Output Voltage Swing High5 1 5V (V) @ VS=+5V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High5 1 5V (V) @ VS=+5V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.83E-02	6.84E-02	6.87E-02	6.93E-02	6.93E-02	6.92E-02	6.88E-02
563	7.21E-02	7.29E-02	7.32E-02	7.36E-02	7.36E-02	7.34E-02	7.35E-02
564	7.31E-02	7.40E-02	7.49E-02	7.52E-02	7.51E-02	7.48E-02	7.46E-02
567	7.35E-02	7.44E-02	7.46E-02	7.50E-02	7.49E-02	7.49E-02	7.46E-02
569	7.16E-02	7.22E-02	7.29E-02	7.31E-02	7.33E-02	7.31E-02	7.25E-02
570	7.24E-02	7.26E-02	7.33E-02	7.34E-02	7.37E-02	7.36E-02	7.32E-02
571	7.20E-02	7.21E-02	7.24E-02	7.27E-02	7.34E-02	7.30E-02	7.28E-02
572	7.21E-02	7.21E-02	7.24E-02	7.31E-02	7.34E-02	7.30E-02	7.30E-02
573	7.33E-02	7.39E-02	7.43E-02	7.42E-02	7.46E-02	7.47E-02	7.41E-02
574	7.11E-02	7.08E-02	7.16E-02	7.16E-02	7.21E-02	7.19E-02	7.15E-02
584	6.89E-02	6.91E-02	6.92E-02	6.89E-02	6.89E-02	6.85E-02	6.87E-02
585	6.87E-02	6.88E-02	6.90E-02	6.90E-02	6.90E-02	6.83E-02	6.86E-02
<b>Biased Statistics</b>							
Average Biased	7.17E-02	7.24E-02	7.28E-02	7.32E-02	7.32E-02	7.31E-02	7.28E-02
Std Dev Biased	2.07E-03	2.36E-03	2.49E-03	2.35E-03	2.35E-03	2.33E-03	2.40E-03
Ps90%/90% (+KTL) Biased	7.74E-02	7.88E-02	7.97E-02	7.97E-02	7.97E-02	7.94E-02	7.94E-02
Ps90%/90% (-KTL) Biased	6.61E-02	6.59E-02	6.60E-02	6.68E-02	6.68E-02	6.67E-02	6.62E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.22E-02	7.23E-02	7.28E-02	7.30E-02	7.35E-02	7.32E-02	7.29E-02
Std Dev Un-Biased	7.94E-04	1.11E-03	1.04E-03	9.84E-04	8.91E-04	1.03E-03	9.17E-04
Ps90%/90% (+KTL) Un-Biased	7.44E-02	7.53E-02	7.57E-02	7.57E-02	7.59E-02	7.60E-02	7.54E-02
Ps90%/90% (-KTL) Un-Biased	7.00E-02	6.92E-02	7.00E-02	7.03E-02	7.10E-02	7.04E-02	7.04E-02
<b>Specification MAX</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

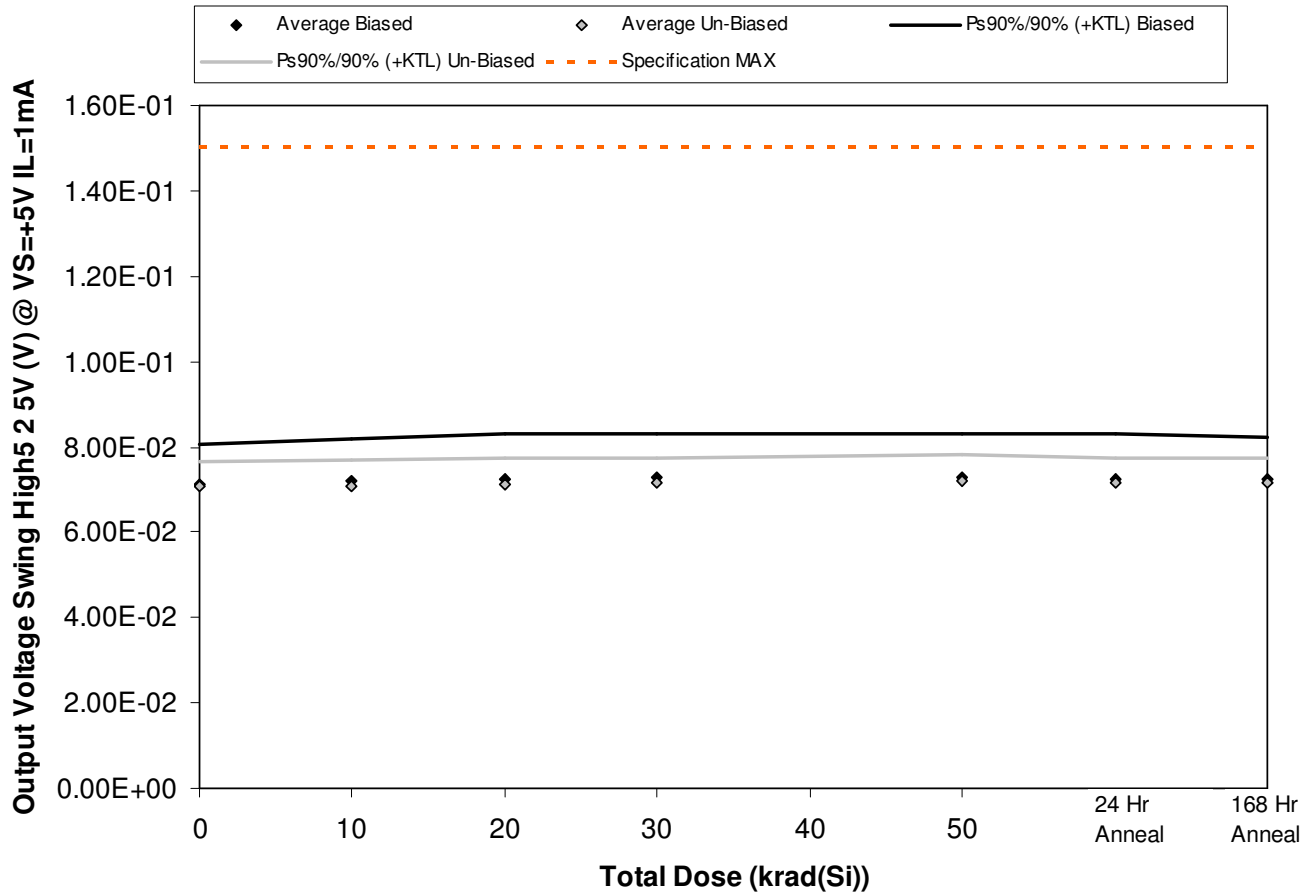


Figure 5.142. Plot of Output Voltage Swing High5 2 5V (V) @ VS=+5V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.142. Raw data for Output Voltage Swing High5 2 5V (V) @ VS=+5V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High5 2 5V (V) @ VS=+5V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.56E-02	6.60E-02	6.59E-02	6.65E-02	6.66E-02	6.62E-02	6.63E-02
563	7.36E-02	7.40E-02	7.44E-02	7.48E-02	7.51E-02	7.50E-02	7.47E-02
564	7.29E-02	7.37E-02	7.46E-02	7.49E-02	7.47E-02	7.45E-02	7.43E-02
567	7.39E-02	7.47E-02	7.53E-02	7.55E-02	7.54E-02	7.53E-02	7.51E-02
569	7.05E-02	7.14E-02	7.16E-02	7.17E-02	7.19E-02	7.18E-02	7.15E-02
570	7.21E-02	7.25E-02	7.28E-02	7.31E-02	7.36E-02	7.30E-02	7.30E-02
571	7.08E-02	7.09E-02	7.12E-02	7.16E-02	7.23E-02	7.18E-02	7.17E-02
572	6.88E-02	6.90E-02	6.94E-02	6.97E-02	7.01E-02	6.97E-02	6.97E-02
573	7.33E-02	7.37E-02	7.43E-02	7.42E-02	7.46E-02	7.45E-02	7.39E-02
574	6.85E-02	6.85E-02	6.89E-02	6.92E-02	6.95E-02	6.95E-02	6.90E-02
584	7.21E-02	7.27E-02	7.26E-02	7.26E-02	7.22E-02	7.20E-02	7.19E-02
585	7.23E-02	7.25E-02	7.28E-02	7.26E-02	7.29E-02	7.22E-02	7.24E-02
<b>Biased Statistics</b>							
Average Biased	7.13E-02	7.20E-02	7.23E-02	7.27E-02	7.28E-02	7.25E-02	7.24E-02
Std Dev Biased	3.46E-03	3.56E-03	3.86E-03	3.74E-03	3.70E-03	3.83E-03	3.68E-03
Ps90%/90% (+KTL) Biased	8.08E-02	8.17E-02	8.29E-02	8.29E-02	8.29E-02	8.31E-02	8.24E-02
Ps90%/90% (-KTL) Biased	6.18E-02	6.22E-02	6.17E-02	6.24E-02	6.26E-02	6.20E-02	6.23E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.07E-02	7.09E-02	7.13E-02	7.15E-02	7.20E-02	7.17E-02	7.15E-02
Std Dev Un-Biased	2.06E-03	2.22E-03	2.25E-03	2.16E-03	2.18E-03	2.12E-03	2.09E-03
Ps90%/90% (+KTL) Un-Biased	7.63E-02	7.70E-02	7.75E-02	7.74E-02	7.80E-02	7.75E-02	7.72E-02
Ps90%/90% (-KTL) Un-Biased	6.51E-02	6.48E-02	6.52E-02	6.56E-02	6.60E-02	6.59E-02	6.57E-02
<b>Specification MAX</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



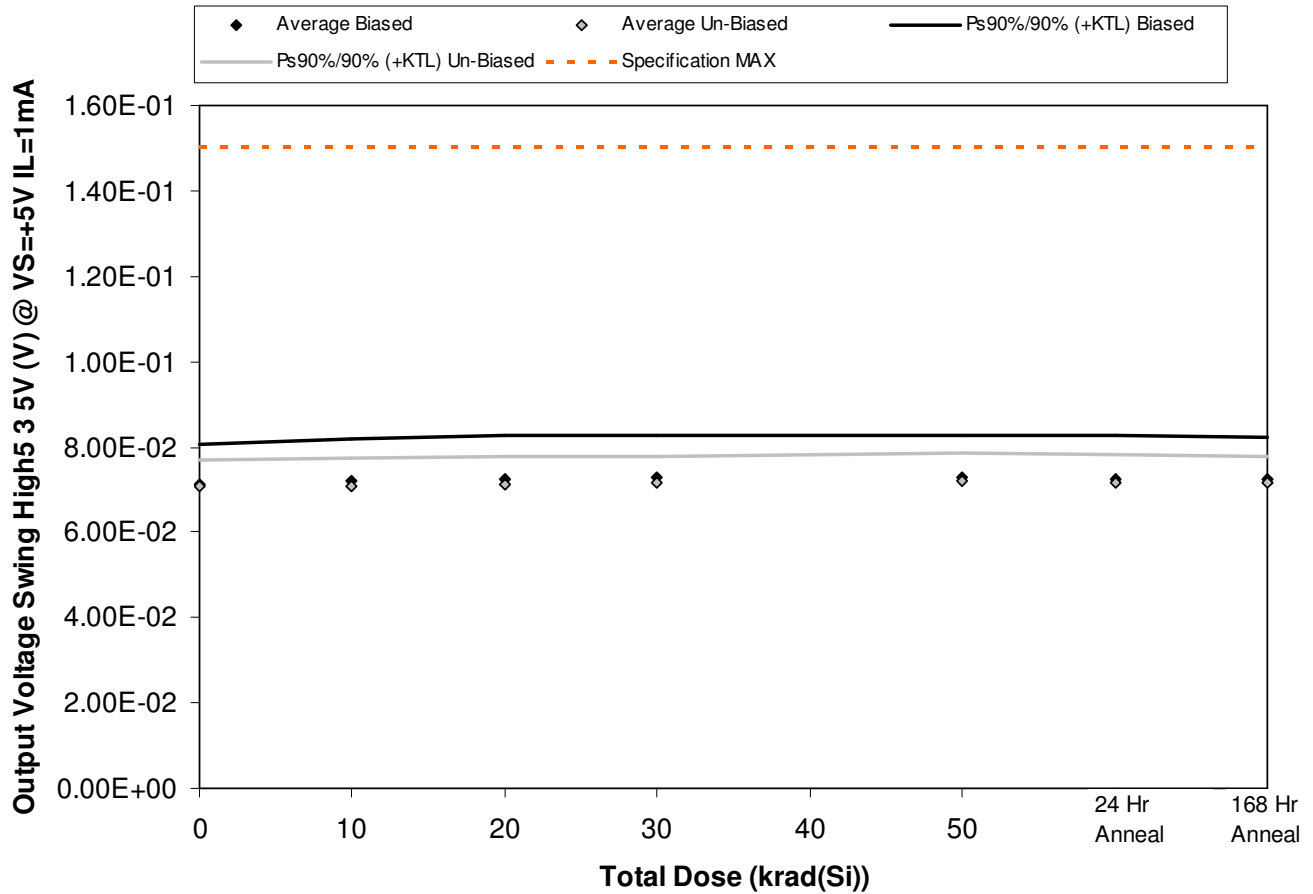


Figure 5.143. Plot of Output Voltage Swing High5 3 5V (V) @ VS=+5V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.143. Raw data for Output Voltage Swing High5 3 5V (V) @ VS=+5V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High5 3 5V (V) @ VS=+5V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.58E-02	6.60E-02	6.62E-02	6.67E-02	6.67E-02	6.65E-02	6.66E-02
563	7.40E-02	7.47E-02	7.50E-02	7.53E-02	7.54E-02	7.53E-02	7.53E-02
564	7.26E-02	7.34E-02	7.39E-02	7.47E-02	7.44E-02	7.42E-02	7.41E-02
567	7.37E-02	7.45E-02	7.51E-02	7.53E-02	7.53E-02	7.52E-02	7.49E-02
569	7.06E-02	7.12E-02	7.16E-02	7.16E-02	7.21E-02	7.19E-02	7.13E-02
570	7.23E-02	7.26E-02	7.30E-02	7.32E-02	7.38E-02	7.35E-02	7.34E-02
571	7.08E-02	7.07E-02	7.13E-02	7.16E-02	7.23E-02	7.18E-02	7.15E-02
572	6.88E-02	6.91E-02	6.95E-02	6.97E-02	7.01E-02	6.99E-02	6.97E-02
573	7.34E-02	7.35E-02	7.43E-02	7.43E-02	7.47E-02	7.45E-02	7.43E-02
574	6.83E-02	6.77E-02	6.89E-02	6.89E-02	6.93E-02	6.92E-02	6.89E-02
584	7.25E-02	7.29E-02	7.29E-02	7.26E-02	7.26E-02	7.21E-02	7.23E-02
585	7.22E-02	7.25E-02	7.28E-02	7.26E-02	7.24E-02	7.19E-02	7.23E-02
<b>Biased Statistics</b>							
Average Biased	7.13E-02	7.20E-02	7.24E-02	7.27E-02	7.28E-02	7.26E-02	7.25E-02
Std Dev Biased	3.40E-03	3.61E-03	3.70E-03	3.69E-03	3.63E-03	3.68E-03	3.64E-03
Ps90%/90% (+KTL) Biased	8.07E-02	8.19E-02	8.25E-02	8.28E-02	8.27E-02	8.27E-02	8.24E-02
Ps90%/90% (-KTL) Biased	6.20E-02	6.21E-02	6.22E-02	6.26E-02	6.28E-02	6.25E-02	6.25E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.07E-02	7.07E-02	7.14E-02	7.15E-02	7.20E-02	7.18E-02	7.15E-02
Std Dev Un-Biased	2.20E-03	2.38E-03	2.25E-03	2.27E-03	2.31E-03	2.27E-03	2.33E-03
Ps90%/90% (+KTL) Un-Biased	7.67E-02	7.72E-02	7.76E-02	7.78E-02	7.84E-02	7.80E-02	7.79E-02
Ps90%/90% (-KTL) Un-Biased	6.47E-02	6.42E-02	6.52E-02	6.53E-02	6.57E-02	6.55E-02	6.51E-02
<b>Specification MAX</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

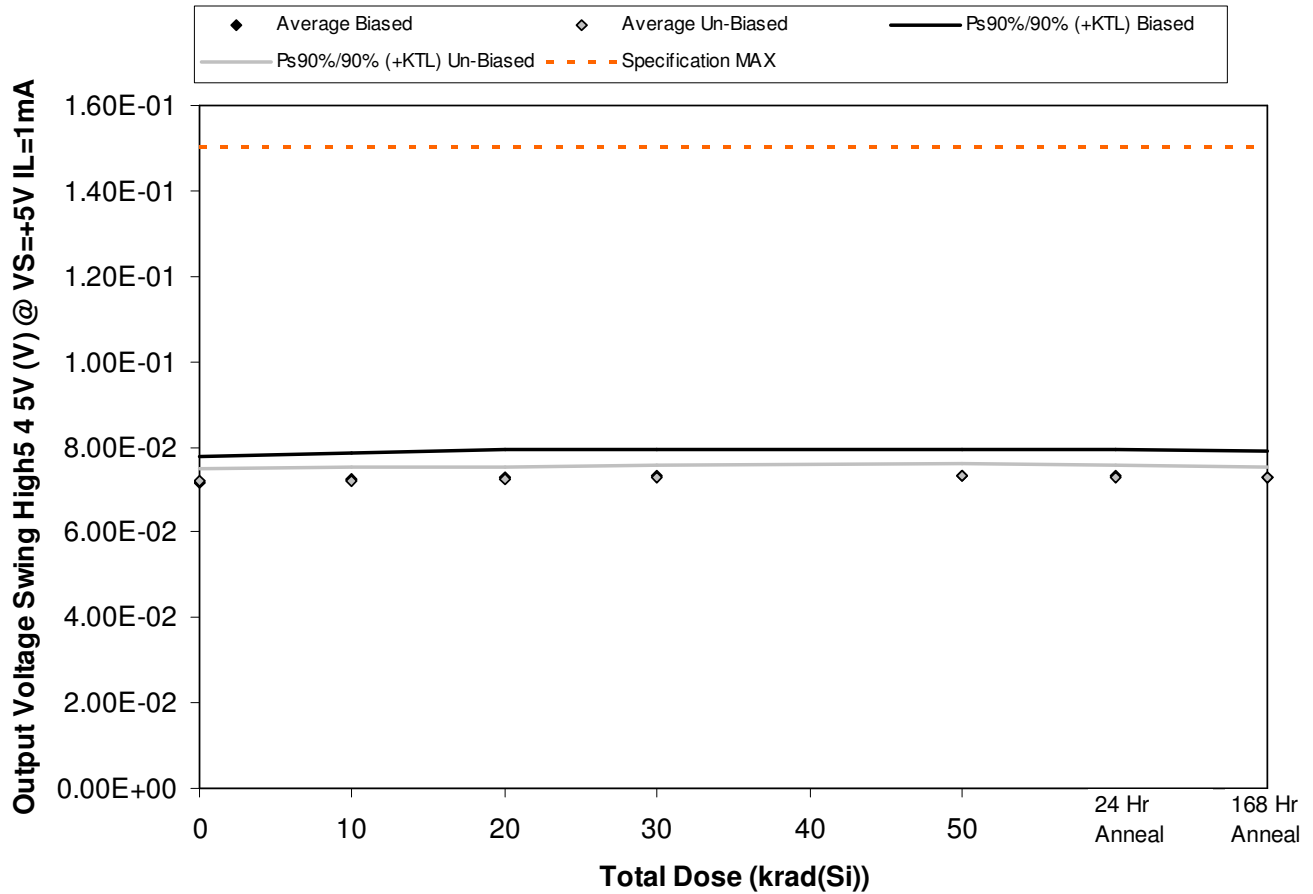


Figure 5.144. Plot of Output Voltage Swing High5 4 5V (V) @ VS=+5V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.144. Raw data for Output Voltage Swing High5 4 5V (V) @ VS=+5V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High5 4 5V (V) @ VS=+5V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.81E-02	6.86E-02	6.90E-02	6.94E-02	6.93E-02	6.92E-02	6.90E-02
563	7.21E-02	7.27E-02	7.32E-02	7.33E-02	7.36E-02	7.37E-02	7.32E-02
564	7.35E-02	7.41E-02	7.49E-02	7.54E-02	7.50E-02	7.48E-02	7.47E-02
567	7.32E-02	7.42E-02	7.47E-02	7.46E-02	7.47E-02	7.47E-02	7.44E-02
569	7.18E-02	7.25E-02	7.27E-02	7.29E-02	7.34E-02	7.30E-02	7.28E-02
570	7.23E-02	7.26E-02	7.30E-02	7.31E-02	7.36E-02	7.35E-02	7.32E-02
571	7.18E-02	7.20E-02	7.23E-02	7.27E-02	7.34E-02	7.30E-02	7.26E-02
572	7.22E-02	7.20E-02	7.24E-02	7.30E-02	7.34E-02	7.28E-02	7.28E-02
573	7.34E-02	7.36E-02	7.40E-02	7.43E-02	7.46E-02	7.43E-02	7.40E-02
574	7.08E-02	7.05E-02	7.14E-02	7.14E-02	7.18E-02	7.16E-02	7.14E-02
584	6.88E-02	6.93E-02	6.91E-02	6.90E-02	6.88E-02	6.85E-02	6.86E-02
585	6.85E-02	6.87E-02	6.89E-02	6.89E-02	6.88E-02	6.81E-02	6.84E-02
<b>Biased Statistics</b>							
Average Biased	7.17E-02	7.24E-02	7.29E-02	7.31E-02	7.32E-02	7.31E-02	7.28E-02
Std Dev Biased	2.16E-03	2.28E-03	2.39E-03	2.30E-03	2.28E-03	2.33E-03	2.27E-03
Ps90%/90% (+KTL) Biased	7.76E-02	7.87E-02	7.94E-02	7.94E-02	7.94E-02	7.95E-02	7.90E-02
Ps90%/90% (-KTL) Biased	6.58E-02	6.62E-02	6.64E-02	6.68E-02	6.69E-02	6.67E-02	6.66E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.21E-02	7.21E-02	7.26E-02	7.29E-02	7.34E-02	7.30E-02	7.28E-02
Std Dev Un-Biased	9.54E-04	1.11E-03	9.49E-04	1.07E-03	1.01E-03	1.01E-03	9.39E-04
Ps90%/90% (+KTL) Un-Biased	7.47E-02	7.52E-02	7.52E-02	7.58E-02	7.61E-02	7.58E-02	7.53E-02
Ps90%/90% (-KTL) Un-Biased	6.95E-02	6.91E-02	7.00E-02	7.00E-02	7.06E-02	7.03E-02	7.02E-02
<b>Specification MAX</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>	<b>1.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

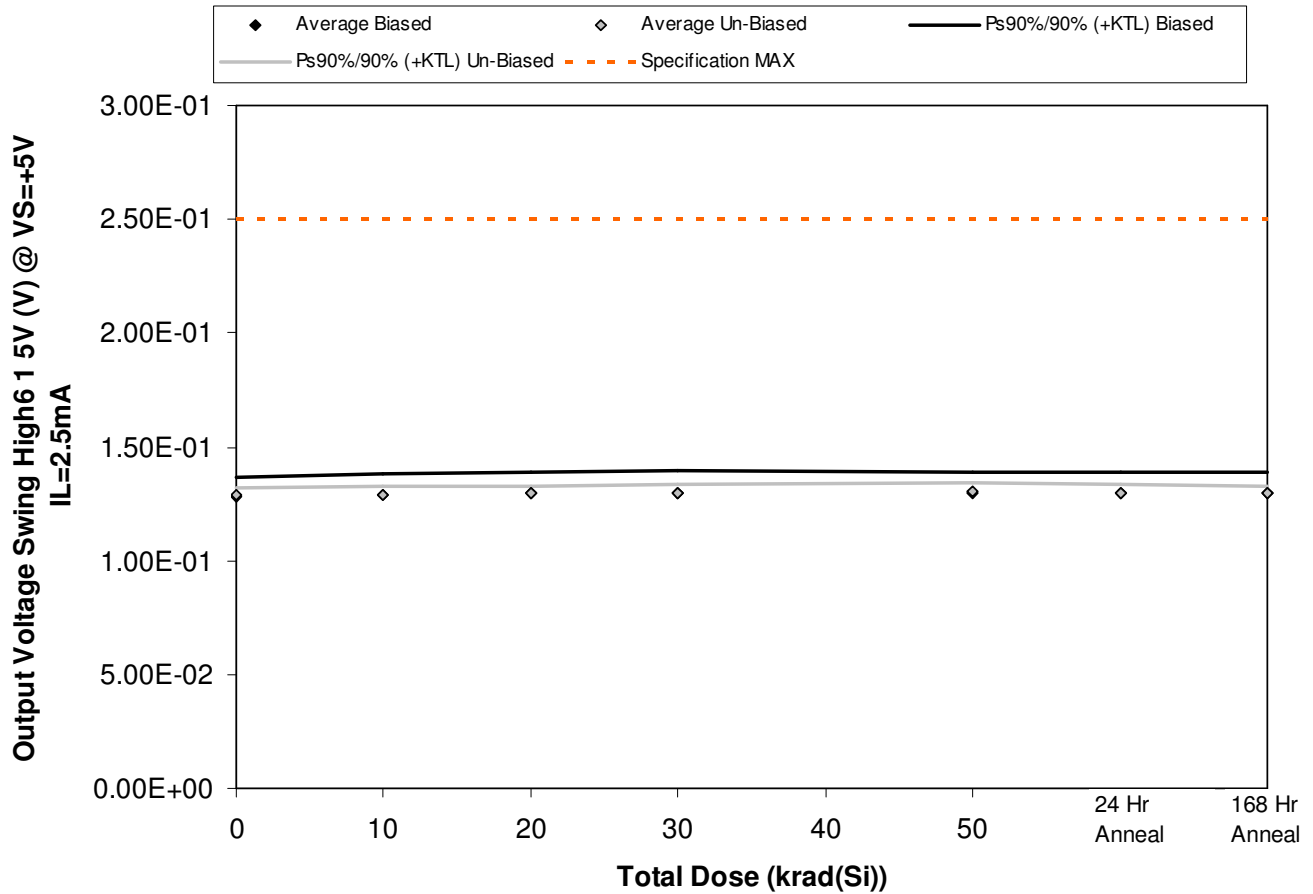


Figure 5.145. Plot of Output Voltage Swing High6 1 5V (V) @ VS=+5V IL=2.5mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.145. Raw data for Output Voltage Swing High6 1 5V (V) @ VS=+5V IL=2.5mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High6 1 5V (V) @ VS=+5V IL=2.5mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.23E-01	1.23E-01	1.24E-01	1.24E-01	1.24E-01	1.24E-01	1.24E-01
563	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01
564	1.31E-01	1.32E-01	1.32E-01	1.33E-01	1.32E-01	1.32E-01	1.32E-01
567	1.30E-01	1.31E-01	1.32E-01	1.32E-01	1.32E-01	1.32E-01	1.32E-01
569	1.28E-01	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01
570	1.29E-01	1.29E-01	1.30E-01	1.30E-01	1.31E-01	1.30E-01	1.30E-01
571	1.28E-01	1.28E-01	1.29E-01	1.29E-01	1.30E-01	1.29E-01	1.29E-01
572	1.29E-01	1.29E-01	1.30E-01	1.30E-01	1.31E-01	1.30E-01	1.30E-01
573	1.30E-01	1.31E-01	1.31E-01	1.31E-01	1.32E-01	1.31E-01	1.31E-01
574	1.27E-01	1.27E-01	1.28E-01	1.28E-01	1.28E-01	1.28E-01	1.28E-01
584	1.24E-01	1.24E-01	1.25E-01	1.24E-01	1.24E-01	1.24E-01	1.24E-01
585	1.24E-01	1.24E-01	1.25E-01	1.24E-01	1.24E-01	1.23E-01	1.24E-01
<b>Biased Statistics</b>							
Average Biased	1.28E-01	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01
Std Dev Biased	3.09E-03	3.36E-03	3.45E-03	3.45E-03	3.34E-03	3.34E-03	3.35E-03
Ps90%/90% (+KTL) Biased	1.37E-01	1.38E-01	1.39E-01	1.39E-01	1.39E-01	1.39E-01	1.39E-01
Ps90%/90% (-KTL) Biased	1.20E-01	1.20E-01	1.20E-01	1.21E-01	1.21E-01	1.20E-01	1.20E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.29E-01	1.29E-01	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01
Std Dev Un-Biased	1.27E-03	1.44E-03	1.30E-03	1.34E-03	1.37E-03	1.28E-03	1.18E-03
Ps90%/90% (+KTL) Un-Biased	1.32E-01	1.33E-01	1.33E-01	1.33E-01	1.34E-01	1.33E-01	1.33E-01
Ps90%/90% (-KTL) Un-Biased	1.25E-01	1.25E-01	1.26E-01	1.26E-01	1.26E-01	1.26E-01	1.26E-01
<b>Specification MAX</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

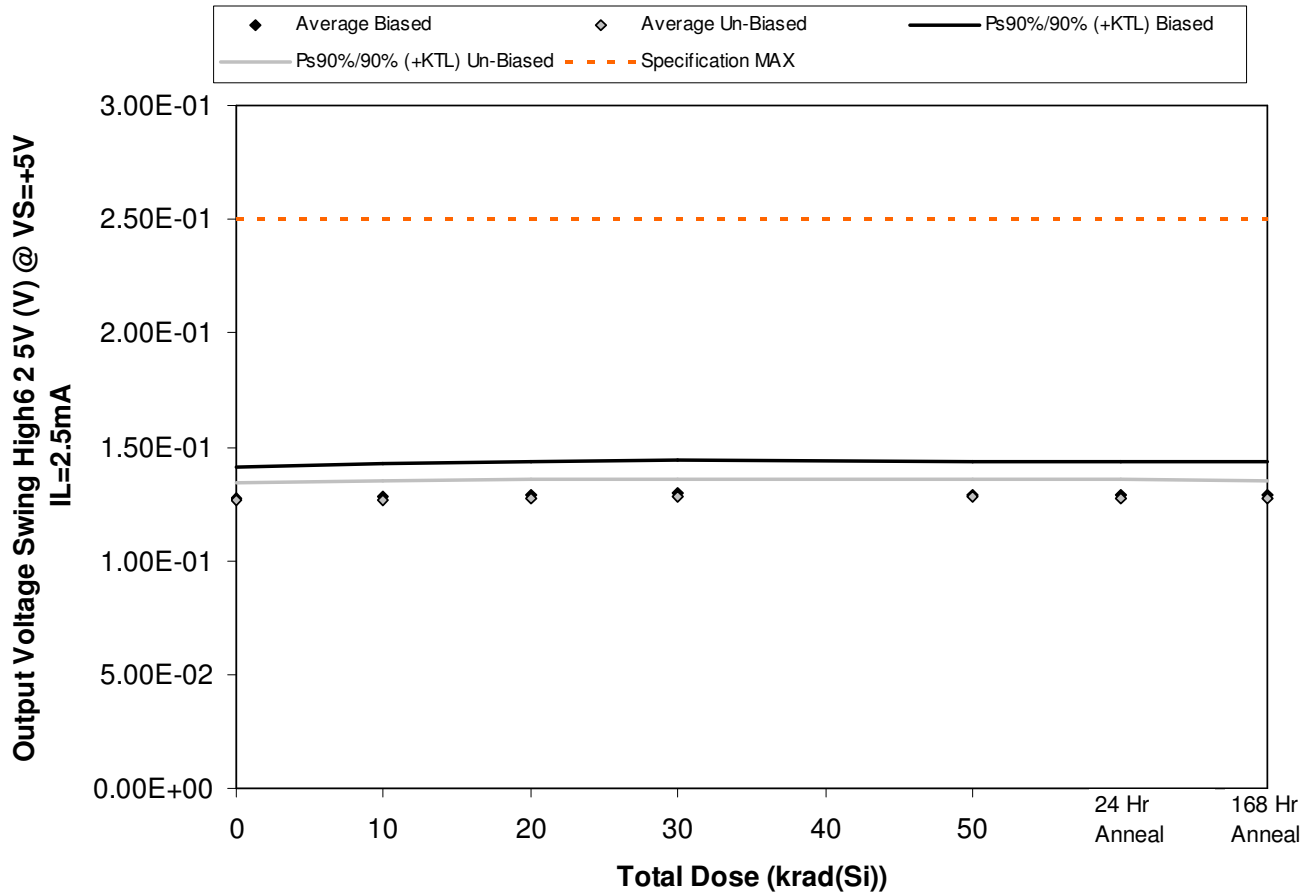


Figure 5.146. Plot of Output Voltage Swing High6 2.5V (V) @ VS=+5V IL=2.5mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.146. Raw data for Output Voltage Swing High6 2 5V (V) @ VS=+5V IL=2.5mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High6 2 5V (V) @ VS=+5V IL=2.5mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.19E-01	1.20E-01	1.20E-01	1.21E-01	1.21E-01	1.20E-01	1.20E-01
563	1.31E-01	1.32E-01	1.32E-01	1.32E-01	1.32E-01	1.32E-01	1.32E-01
564	1.30E-01	1.31E-01	1.32E-01	1.33E-01	1.32E-01	1.32E-01	1.32E-01
567	1.31E-01	1.32E-01	1.33E-01	1.33E-01	1.33E-01	1.33E-01	1.32E-01
569	1.27E-01	1.28E-01	1.28E-01	1.28E-01	1.28E-01	1.28E-01	1.28E-01
570	1.29E-01	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01
571	1.27E-01	1.27E-01	1.27E-01	1.28E-01	1.29E-01	1.28E-01	1.27E-01
572	1.24E-01	1.24E-01	1.25E-01	1.25E-01	1.26E-01	1.25E-01	1.25E-01
573	1.30E-01	1.30E-01	1.31E-01	1.31E-01	1.32E-01	1.31E-01	1.31E-01
574	1.23E-01	1.23E-01	1.24E-01	1.25E-01	1.25E-01	1.24E-01	1.24E-01
584	1.29E-01	1.30E-01	1.30E-01	1.29E-01	1.29E-01	1.28E-01	1.29E-01
585	1.29E-01	1.29E-01	1.30E-01	1.30E-01	1.29E-01	1.28E-01	1.29E-01
<b>Biased Statistics</b>							
Average Biased	1.28E-01	1.28E-01	1.29E-01	1.29E-01	1.29E-01	1.29E-01	1.29E-01
Std Dev Biased	5.03E-03	5.24E-03	5.29E-03	5.30E-03	5.22E-03	5.40E-03	5.27E-03
Ps90%/90% (+KTL) Biased	1.41E-01	1.43E-01	1.44E-01	1.44E-01	1.44E-01	1.44E-01	1.43E-01
Ps90%/90% (-KTL) Biased	1.14E-01	1.14E-01	1.14E-01	1.15E-01	1.15E-01	1.14E-01	1.14E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.27E-01	1.27E-01	1.27E-01	1.28E-01	1.28E-01	1.28E-01	1.27E-01
Std Dev Un-Biased	2.86E-03	3.05E-03	2.95E-03	2.87E-03	2.92E-03	3.06E-03	2.90E-03
Ps90%/90% (+KTL) Un-Biased	1.35E-01	1.35E-01	1.35E-01	1.36E-01	1.36E-01	1.36E-01	1.35E-01
Ps90%/90% (-KTL) Un-Biased	1.19E-01	1.18E-01	1.19E-01	1.20E-01	1.20E-01	1.19E-01	1.19E-01
<b>Specification MAX</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



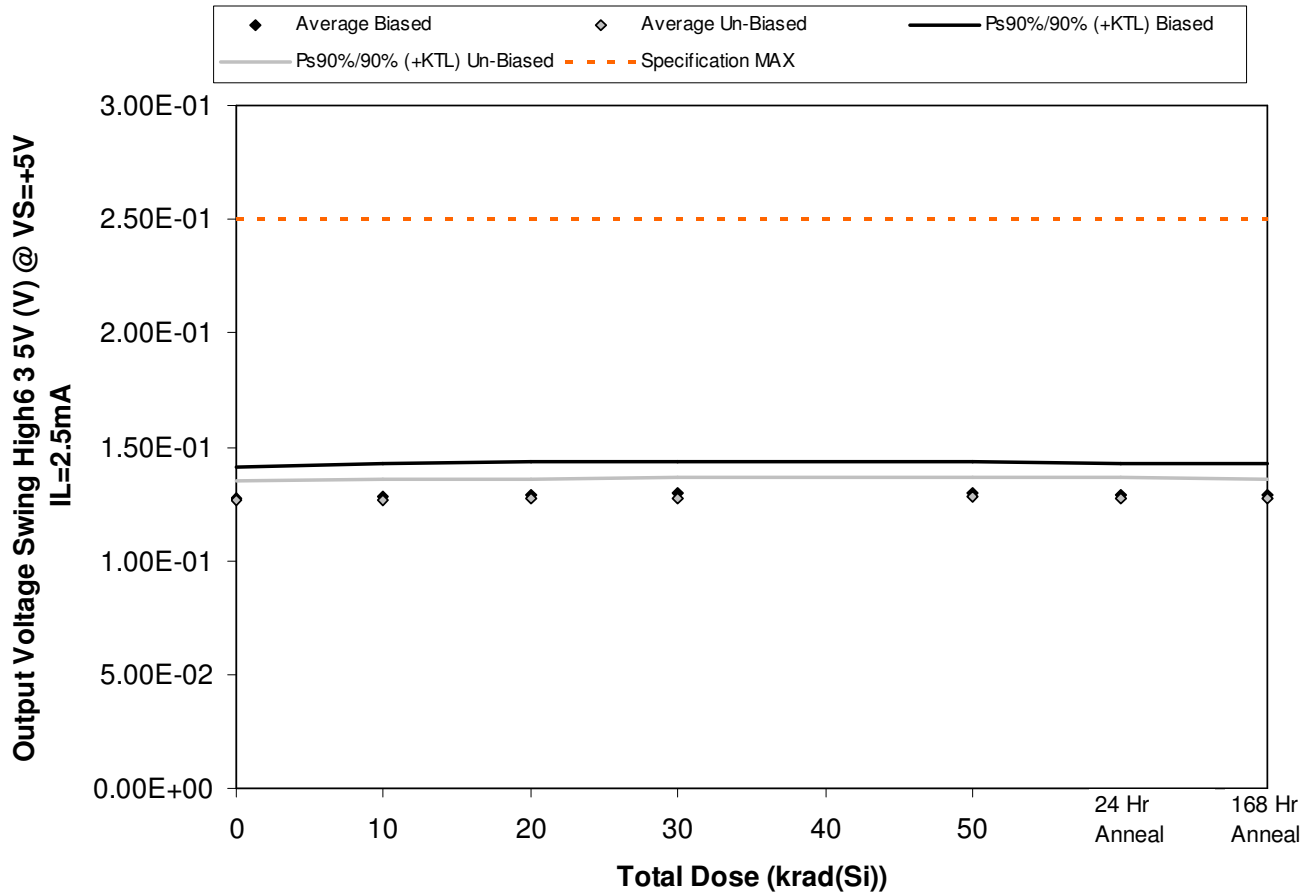


Figure 5.147. Plot of Output Voltage Swing High6 3 5V (V) @ VS=+5V IL=2.5mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.147. Raw data for Output Voltage Swing High6 3 5V (V) @ VS=+5V IL=2.5mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High6 3 5V (V) @ VS=+5V IL=2.5mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.20E-01	1.20E-01	1.21E-01	1.21E-01	1.21E-01	1.21E-01	1.21E-01
563	1.31E-01	1.32E-01	1.33E-01	1.33E-01	1.33E-01	1.33E-01	1.33E-01
564	1.30E-01	1.31E-01	1.32E-01	1.32E-01	1.32E-01	1.31E-01	1.31E-01
567	1.31E-01	1.32E-01	1.33E-01	1.33E-01	1.33E-01	1.32E-01	1.32E-01
569	1.26E-01	1.28E-01	1.28E-01	1.28E-01	1.28E-01	1.28E-01	1.28E-01
570	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.31E-01	1.30E-01	1.30E-01
571	1.26E-01	1.26E-01	1.27E-01	1.28E-01	1.28E-01	1.28E-01	1.27E-01
572	1.24E-01	1.24E-01	1.25E-01	1.25E-01	1.26E-01	1.25E-01	1.25E-01
573	1.30E-01	1.30E-01	1.31E-01	1.31E-01	1.32E-01	1.32E-01	1.31E-01
574	1.23E-01	1.23E-01	1.24E-01	1.24E-01	1.24E-01	1.24E-01	1.24E-01
584	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.29E-01	1.29E-01	1.29E-01
585	1.29E-01	1.29E-01	1.30E-01	1.29E-01	1.29E-01	1.28E-01	1.29E-01
<b>Biased Statistics</b>							
Average Biased	1.28E-01	1.29E-01	1.29E-01	1.29E-01	1.29E-01	1.29E-01	1.29E-01
Std Dev Biased	4.85E-03	5.10E-03	5.17E-03	5.14E-03	5.14E-03	5.11E-03	5.06E-03
Ps90%/90% (+KTL) Biased	1.41E-01	1.42E-01	1.43E-01	1.44E-01	1.43E-01	1.43E-01	1.43E-01
Ps90%/90% (-KTL) Biased	1.14E-01	1.15E-01	1.15E-01	1.15E-01	1.15E-01	1.15E-01	1.15E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.27E-01	1.27E-01	1.27E-01	1.28E-01	1.28E-01	1.28E-01	1.27E-01
Std Dev Un-Biased	3.08E-03	3.22E-03	2.93E-03	3.12E-03	3.22E-03	3.24E-03	3.13E-03
Ps90%/90% (+KTL) Un-Biased	1.35E-01	1.36E-01	1.35E-01	1.36E-01	1.37E-01	1.37E-01	1.36E-01
Ps90%/90% (-KTL) Un-Biased	1.18E-01	1.18E-01	1.19E-01	1.19E-01	1.19E-01	1.19E-01	1.19E-01
<b>Specification MAX</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

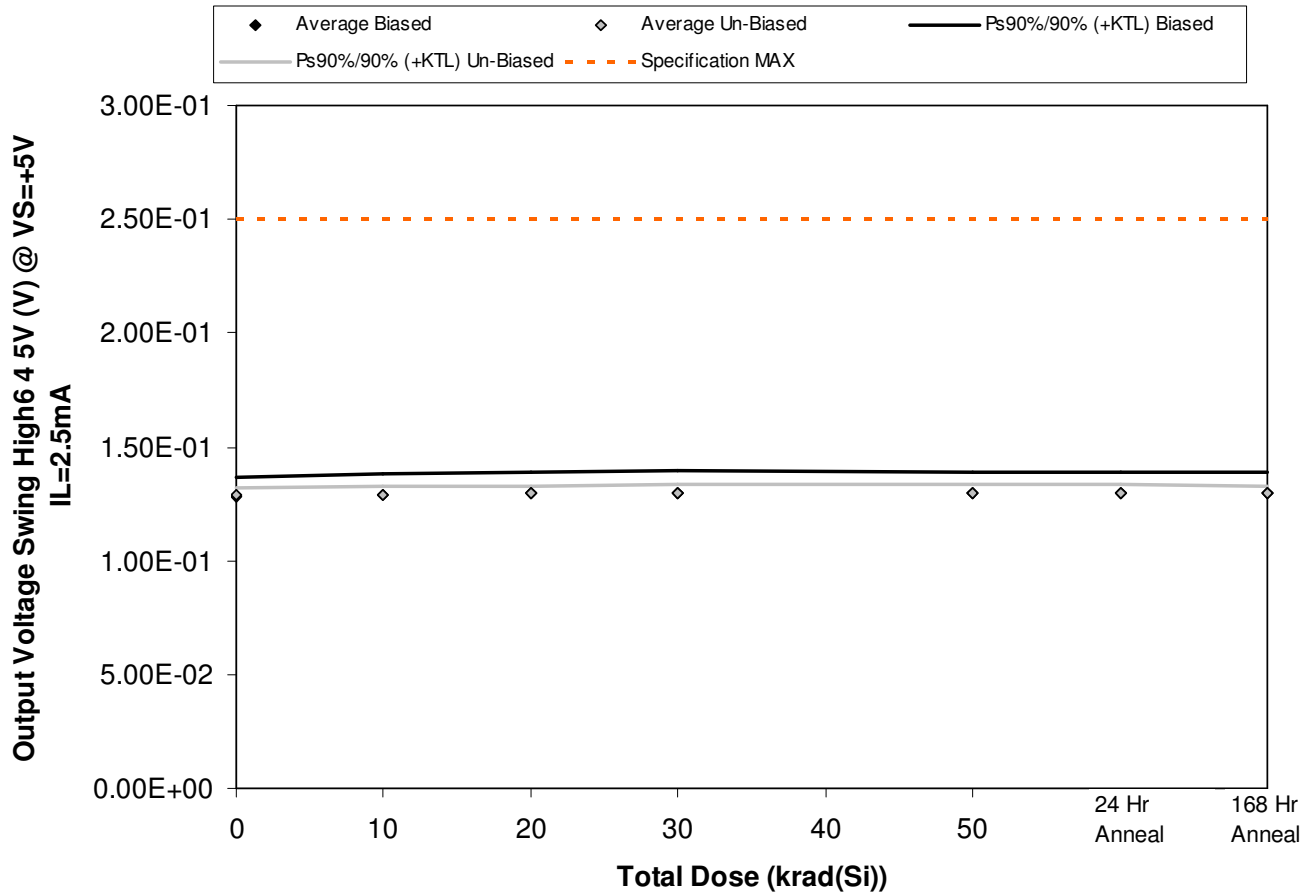


Figure 5.148. Plot of Output Voltage Swing High6 4 5V (V) @ VS=+5V IL=2.5mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.148. Raw data for Output Voltage Swing High6 4 5V (V) @ VS=+5V IL=2.5mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing High6 4 5V (V) @ VS=+5V IL=2.5mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.23E-01	1.23E-01	1.24E-01	1.24E-01	1.24E-01	1.24E-01	1.24E-01
563	1.29E-01	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01
564	1.31E-01	1.32E-01	1.32E-01	1.33E-01	1.33E-01	1.32E-01	1.32E-01
567	1.30E-01	1.32E-01	1.32E-01	1.32E-01	1.32E-01	1.32E-01	1.32E-01
569	1.28E-01	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01
570	1.29E-01	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01	1.30E-01
571	1.28E-01	1.28E-01	1.29E-01	1.29E-01	1.30E-01	1.29E-01	1.29E-01
572	1.29E-01	1.29E-01	1.30E-01	1.30E-01	1.30E-01	1.29E-01	1.30E-01
573	1.30E-01	1.30E-01	1.31E-01	1.32E-01	1.32E-01	1.31E-01	1.31E-01
574	1.27E-01	1.26E-01	1.27E-01	1.28E-01	1.28E-01	1.28E-01	1.27E-01
584	1.24E-01	1.24E-01	1.24E-01	1.24E-01	1.24E-01	1.23E-01	1.24E-01
585	1.24E-01	1.24E-01	1.25E-01	1.24E-01	1.24E-01	1.23E-01	1.24E-01
<b>Biased Statistics</b>							
Average Biased	1.28E-01	1.29E-01	1.29E-01	1.30E-01	1.30E-01	1.29E-01	1.29E-01
Std Dev Biased	3.13E-03	3.37E-03	3.54E-03	3.45E-03	3.45E-03	3.33E-03	3.41E-03
Ps90%/90% (+KTL) Biased	1.37E-01	1.38E-01	1.39E-01	1.39E-01	1.39E-01	1.39E-01	1.39E-01
Ps90%/90% (-KTL) Biased	1.20E-01	1.20E-01	1.20E-01	1.20E-01	1.20E-01	1.20E-01	1.20E-01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.29E-01	1.29E-01	1.29E-01	1.30E-01	1.30E-01	1.29E-01	1.29E-01
Std Dev Un-Biased	1.31E-03	1.47E-03	1.38E-03	1.46E-03	1.46E-03	1.33E-03	1.35E-03
Ps90%/90% (+KTL) Un-Biased	1.32E-01	1.33E-01	1.33E-01	1.34E-01	1.34E-01	1.33E-01	1.33E-01
Ps90%/90% (-KTL) Un-Biased	1.25E-01	1.25E-01	1.26E-01	1.26E-01	1.26E-01	1.26E-01	1.26E-01
<b>Specification MAX</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>	<b>2.50E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

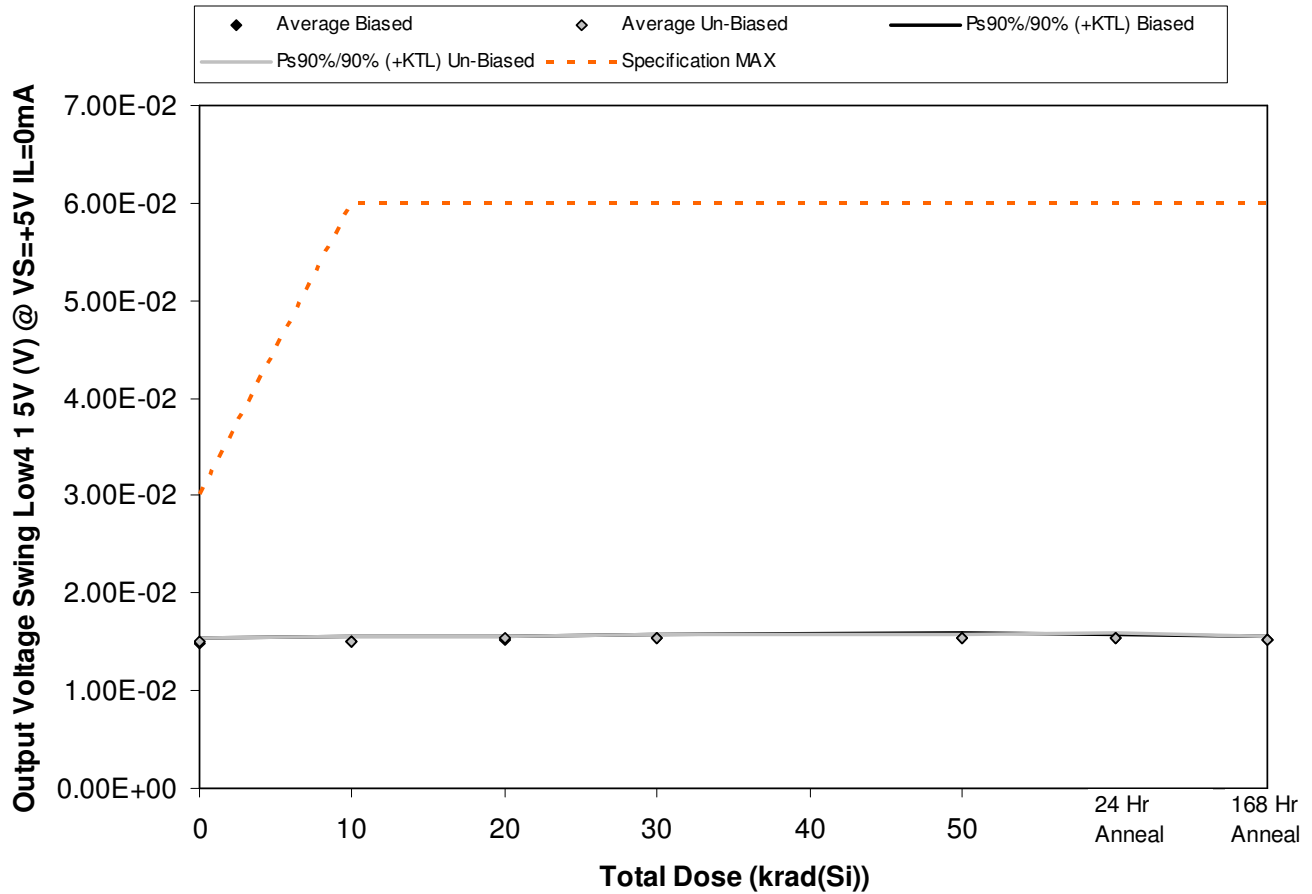


Figure 5.149. Plot of Output Voltage Swing Low4 1 5V (V) @ VS=+5V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.149. Raw data for Output Voltage Swing Low4 1 5V (V) @ VS=+5V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low4 1 5V (V) @ VS=+5V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.52E-02	1.53E-02	1.53E-02	1.56E-02	1.58E-02	1.56E-02	1.54E-02
563	1.49E-02	1.48E-02	1.51E-02	1.54E-02	1.54E-02	1.53E-02	1.51E-02
564	1.49E-02	1.51E-02	1.53E-02	1.54E-02	1.56E-02	1.53E-02	1.52E-02
567	1.49E-02	1.52E-02	1.53E-02	1.55E-02	1.55E-02	1.54E-02	1.53E-02
569	1.47E-02	1.50E-02	1.52E-02	1.52E-02	1.53E-02	1.53E-02	1.51E-02
570	1.50E-02	1.50E-02	1.52E-02	1.51E-02	1.53E-02	1.52E-02	1.51E-02
571	1.51E-02	1.51E-02	1.54E-02	1.54E-02	1.55E-02	1.54E-02	1.53E-02
572	1.52E-02	1.53E-02	1.55E-02	1.56E-02	1.57E-02	1.57E-02	1.54E-02
573	1.50E-02	1.51E-02	1.53E-02	1.53E-02	1.54E-02	1.53E-02	1.51E-02
574	1.50E-02	1.50E-02	1.52E-02	1.52E-02	1.55E-02	1.55E-02	1.51E-02
584	1.52E-02	1.53E-02	1.54E-02	1.52E-02	1.52E-02	1.51E-02	1.50E-02
585	1.51E-02	1.52E-02	1.56E-02	1.54E-02	1.54E-02	1.51E-02	1.50E-02
<b>Biased Statistics</b>							
Average Biased	1.49E-02	1.51E-02	1.53E-02	1.54E-02	1.55E-02	1.54E-02	1.52E-02
Std Dev Biased	2.07E-04	2.05E-04	9.76E-05	1.30E-04	1.79E-04	1.39E-04	1.38E-04
Ps90%/90% (+KTL) Biased	1.55E-02	1.57E-02	1.55E-02	1.58E-02	1.60E-02	1.58E-02	1.56E-02
Ps90%/90% (-KTL) Biased	1.43E-02	1.45E-02	1.50E-02	1.50E-02	1.50E-02	1.50E-02	1.49E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.51E-02	1.51E-02	1.53E-02	1.53E-02	1.55E-02	1.54E-02	1.52E-02
Std Dev Un-Biased	8.93E-05	1.36E-04	1.11E-04	1.72E-04	1.36E-04	1.89E-04	1.54E-04
Ps90%/90% (+KTL) Un-Biased	1.53E-02	1.55E-02	1.56E-02	1.58E-02	1.58E-02	1.59E-02	1.56E-02
Ps90%/90% (-KTL) Un-Biased	1.48E-02	1.47E-02	1.50E-02	1.49E-02	1.51E-02	1.49E-02	1.48E-02
<b>Specification MAX</b>	<b>3.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

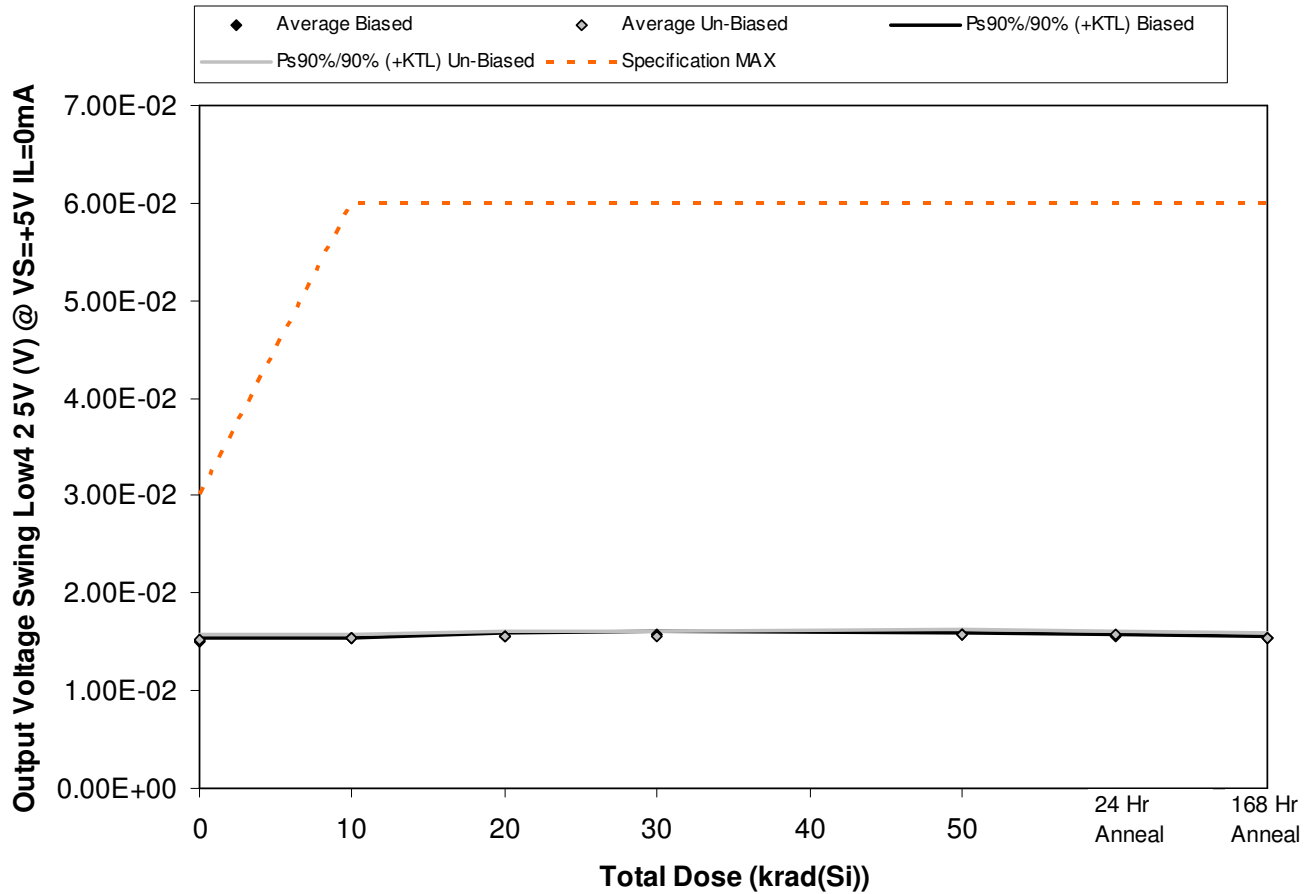


Figure 5.150. Plot of Output Voltage Swing Low4 2 5V (V) @ VS=+5V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.150. Raw data for Output Voltage Swing Low4 2 5V (V) @ VS=+5V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low4 2 5V (V) @ VS=+5V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.51E-02	1.53E-02	1.55E-02	1.55E-02	1.59E-02	1.55E-02	1.55E-02
563	1.52E-02	1.53E-02	1.56E-02	1.58E-02	1.57E-02	1.57E-02	1.55E-02
564	1.50E-02	1.54E-02	1.58E-02	1.58E-02	1.58E-02	1.55E-02	1.55E-02
567	1.51E-02	1.54E-02	1.56E-02	1.57E-02	1.57E-02	1.57E-02	1.54E-02
569	1.51E-02	1.54E-02	1.57E-02	1.59E-02	1.57E-02	1.56E-02	1.55E-02
570	1.52E-02	1.52E-02	1.54E-02	1.55E-02	1.58E-02	1.57E-02	1.53E-02
571	1.52E-02	1.52E-02	1.55E-02	1.55E-02	1.55E-02	1.55E-02	1.53E-02
572	1.52E-02	1.53E-02	1.55E-02	1.55E-02	1.57E-02	1.56E-02	1.56E-02
573	1.56E-02	1.56E-02	1.59E-02	1.59E-02	1.60E-02	1.60E-02	1.58E-02
574	1.52E-02	1.53E-02	1.55E-02	1.55E-02	1.56E-02	1.56E-02	1.54E-02
584	1.52E-02	1.52E-02	1.54E-02	1.55E-02	1.52E-02	1.51E-02	1.53E-02
585	1.52E-02	1.53E-02	1.57E-02	1.54E-02	1.55E-02	1.51E-02	1.52E-02
<b>Biased Statistics</b>							
Average Biased	1.51E-02	1.54E-02	1.56E-02	1.57E-02	1.58E-02	1.56E-02	1.55E-02
Std Dev Biased	8.72E-05	3.96E-05	1.17E-04	1.65E-04	8.38E-05	6.87E-05	6.62E-05
Ps90%/90% (+KTL) Biased	1.53E-02	1.55E-02	1.59E-02	1.62E-02	1.60E-02	1.58E-02	1.57E-02
Ps90%/90% (-KTL) Biased	1.49E-02	1.53E-02	1.53E-02	1.53E-02	1.55E-02	1.54E-02	1.53E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.53E-02	1.53E-02	1.55E-02	1.56E-02	1.57E-02	1.57E-02	1.55E-02
Std Dev Un-Biased	1.72E-04	1.76E-04	1.83E-04	1.72E-04	1.90E-04	1.92E-04	1.97E-04
Ps90%/90% (+KTL) Un-Biased	1.57E-02	1.58E-02	1.60E-02	1.60E-02	1.62E-02	1.62E-02	1.60E-02
Ps90%/90% (-KTL) Un-Biased	1.48E-02	1.48E-02	1.50E-02	1.51E-02	1.52E-02	1.51E-02	1.49E-02
<b>Specification MAX</b>	<b>3.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



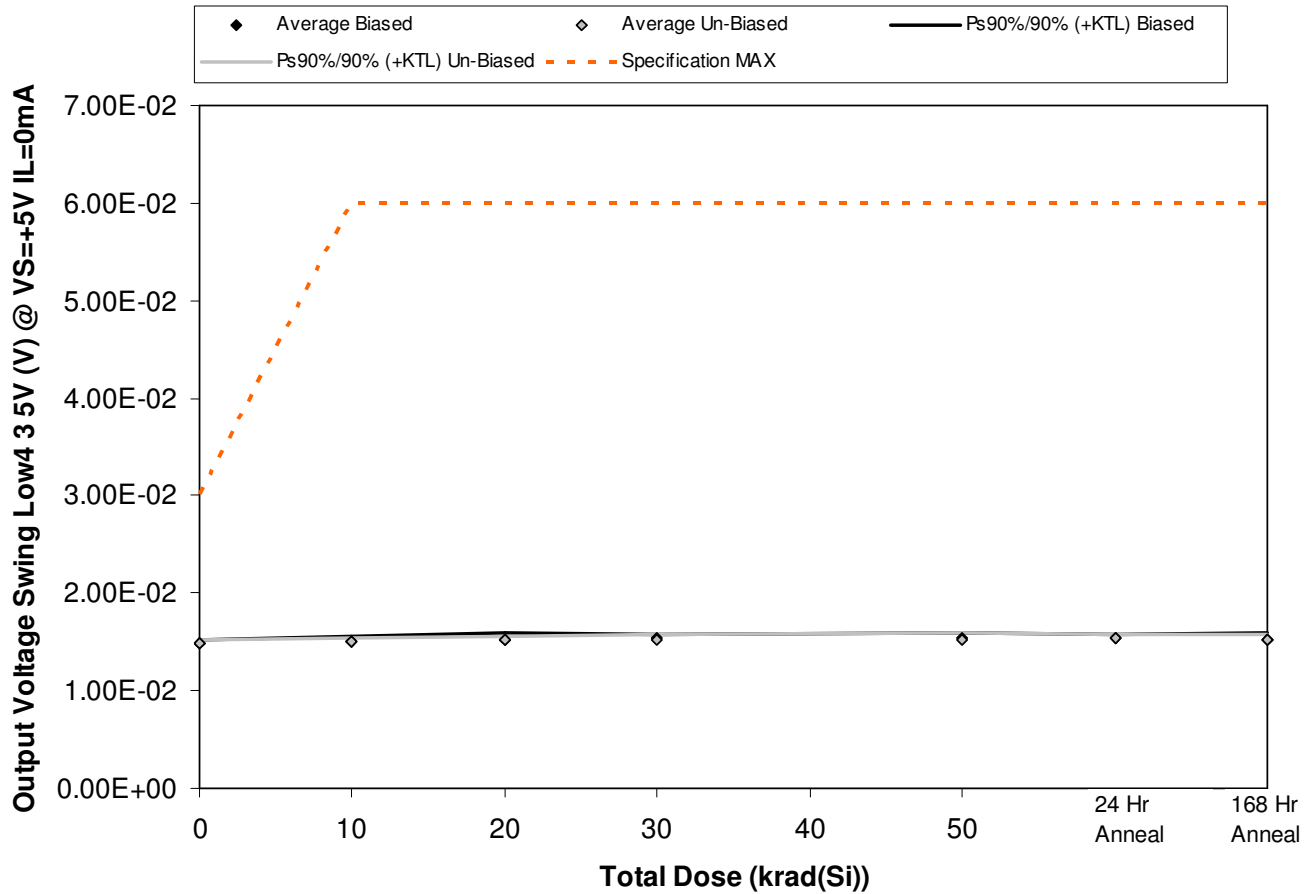


Figure 5.151. Plot of Output Voltage Swing Low4 3 5V (V) @ VS=+5V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.151. Raw data for Output Voltage Swing Low4 3 5V (V) @ VS=+5V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low4 3 5V (V) @ VS=+5V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.50E-02	1.50E-02	1.54E-02	1.52E-02	1.54E-02	1.53E-02	1.52E-02
563	1.49E-02	1.51E-02	1.51E-02	1.53E-02	1.54E-02	1.53E-02	1.51E-02
564	1.47E-02	1.51E-02	1.52E-02	1.53E-02	1.54E-02	1.53E-02	1.53E-02
567	1.47E-02	1.49E-02	1.51E-02	1.52E-02	1.52E-02	1.51E-02	1.49E-02
569	1.50E-02	1.53E-02	1.56E-02	1.56E-02	1.57E-02	1.55E-02	1.56E-02
570	1.47E-02	1.48E-02	1.50E-02	1.50E-02	1.49E-02	1.52E-02	1.49E-02
571	1.49E-02	1.52E-02	1.52E-02	1.53E-02	1.54E-02	1.54E-02	1.50E-02
572	1.48E-02	1.49E-02	1.52E-02	1.51E-02	1.52E-02	1.51E-02	1.51E-02
573	1.50E-02	1.51E-02	1.53E-02	1.54E-02	1.53E-02	1.54E-02	1.52E-02
574	1.50E-02	1.50E-02	1.53E-02	1.54E-02	1.56E-02	1.55E-02	1.54E-02
584	1.49E-02	1.49E-02	1.51E-02	1.52E-02	1.49E-02	1.49E-02	1.48E-02
585	1.49E-02	1.51E-02	1.54E-02	1.52E-02	1.52E-02	1.49E-02	1.49E-02
<b>Biased Statistics</b>							
Average Biased	1.49E-02	1.51E-02	1.53E-02	1.53E-02	1.54E-02	1.53E-02	1.52E-02
Std Dev Biased	1.57E-04	1.57E-04	2.19E-04	1.31E-04	1.88E-04	1.40E-04	2.35E-04
Ps90%/90% (+KTL) Biased	1.53E-02	1.55E-02	1.59E-02	1.57E-02	1.60E-02	1.57E-02	1.59E-02
Ps90%/90% (-KTL) Biased	1.44E-02	1.47E-02	1.47E-02	1.50E-02	1.49E-02	1.49E-02	1.46E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.49E-02	1.50E-02	1.52E-02	1.52E-02	1.53E-02	1.53E-02	1.51E-02
Std Dev Un-Biased	1.15E-04	1.54E-04	1.43E-04	1.74E-04	2.40E-04	1.61E-04	2.00E-04
Ps90%/90% (+KTL) Un-Biased	1.52E-02	1.54E-02	1.56E-02	1.57E-02	1.60E-02	1.58E-02	1.57E-02
Ps90%/90% (-KTL) Un-Biased	1.46E-02	1.46E-02	1.48E-02	1.47E-02	1.46E-02	1.49E-02	1.46E-02
<b>Specification MAX</b>	<b>3.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

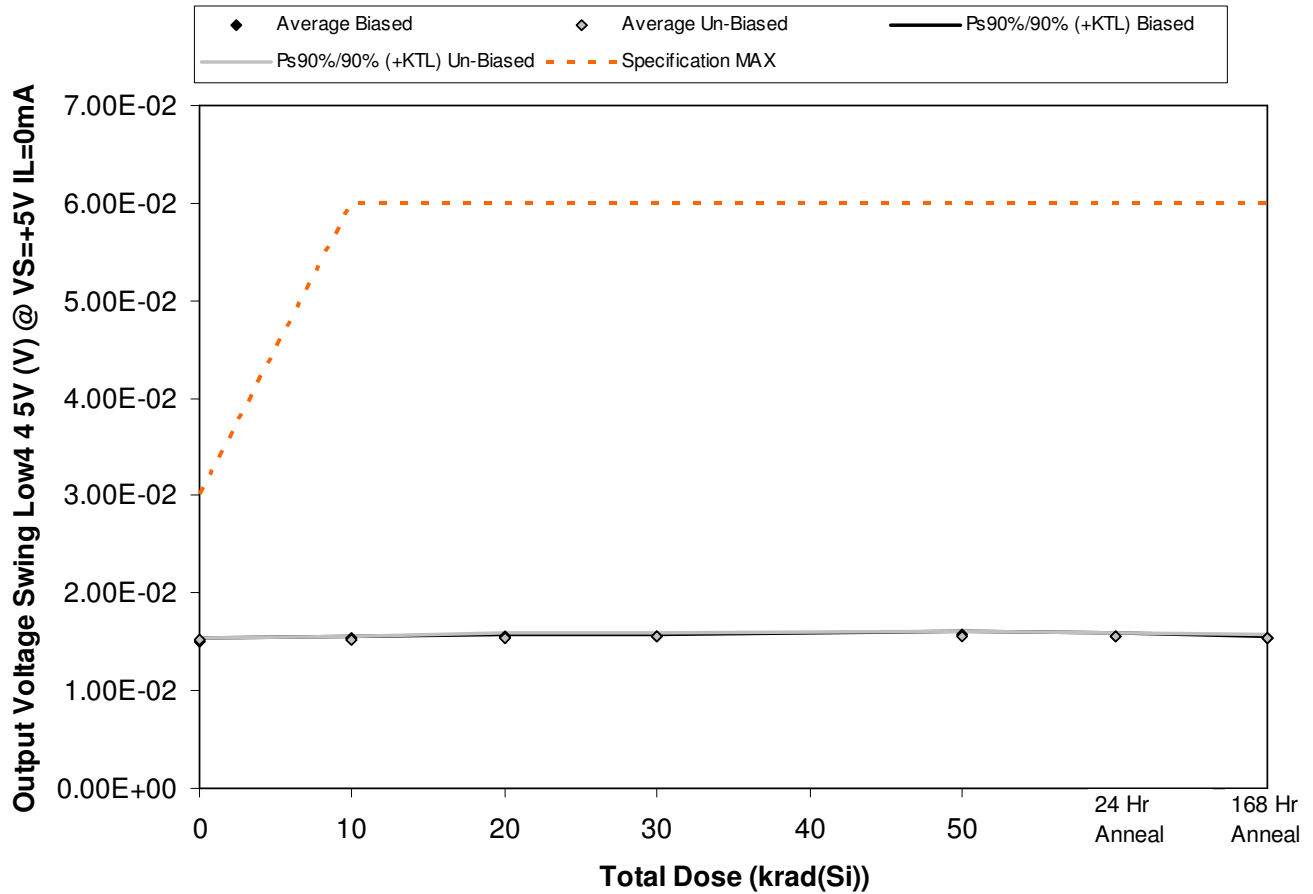


Figure 5.152. Plot of Output Voltage Swing Low4 4 5V (V) @ VS=+5V IL=0mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.152. Raw data for Output Voltage Swing Low4 4 5V (V) @ VS=+5V IL=0mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low4 4 5V (V) @ VS=+5V IL=0mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.52E-02	1.54E-02	1.56E-02	1.56E-02	1.60E-02	1.57E-02	1.55E-02
563	1.49E-02	1.52E-02	1.56E-02	1.55E-02	1.56E-02	1.54E-02	1.53E-02
564	1.50E-02	1.54E-02	1.56E-02	1.57E-02	1.58E-02	1.56E-02	1.55E-02
567	1.51E-02	1.53E-02	1.56E-02	1.55E-02	1.57E-02	1.57E-02	1.54E-02
569	1.50E-02	1.52E-02	1.54E-02	1.55E-02	1.56E-02	1.54E-02	1.54E-02
570	1.52E-02	1.53E-02	1.55E-02	1.56E-02	1.54E-02	1.56E-02	1.54E-02
571	1.52E-02	1.53E-02	1.56E-02	1.56E-02	1.58E-02	1.57E-02	1.55E-02
572	1.53E-02	1.54E-02	1.54E-02	1.54E-02	1.57E-02	1.57E-02	1.54E-02
573	1.53E-02	1.54E-02	1.57E-02	1.56E-02	1.57E-02	1.58E-02	1.55E-02
574	1.51E-02	1.51E-02	1.52E-02	1.52E-02	1.55E-02	1.55E-02	1.53E-02
584	1.52E-02	1.52E-02	1.52E-02	1.53E-02	1.50E-02	1.52E-02	1.50E-02
585	1.52E-02	1.53E-02	1.57E-02	1.54E-02	1.55E-02	1.53E-02	1.53E-02
<b>Biased Statistics</b>							
Average Biased	1.51E-02	1.53E-02	1.56E-02	1.55E-02	1.57E-02	1.56E-02	1.54E-02
Std Dev Biased	1.10E-04	1.02E-04	7.22E-05	8.50E-05	1.54E-04	1.56E-04	7.77E-05
Ps90%/90% (+KTL) Biased	1.54E-02	1.56E-02	1.58E-02	1.58E-02	1.61E-02	1.60E-02	1.56E-02
Ps90%/90% (-KTL) Biased	1.48E-02	1.50E-02	1.54E-02	1.53E-02	1.53E-02	1.51E-02	1.52E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.52E-02	1.53E-02	1.55E-02	1.55E-02	1.56E-02	1.57E-02	1.54E-02
Std Dev Un-Biased	9.71E-05	1.18E-04	1.93E-04	1.63E-04	1.52E-04	1.26E-04	9.72E-05
Ps90%/90% (+KTL) Un-Biased	1.55E-02	1.56E-02	1.60E-02	1.59E-02	1.60E-02	1.60E-02	1.57E-02
Ps90%/90% (-KTL) Un-Biased	1.49E-02	1.50E-02	1.49E-02	1.50E-02	1.52E-02	1.53E-02	1.51E-02
<b>Specification MAX</b>	<b>3.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>	<b>6.00E-02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

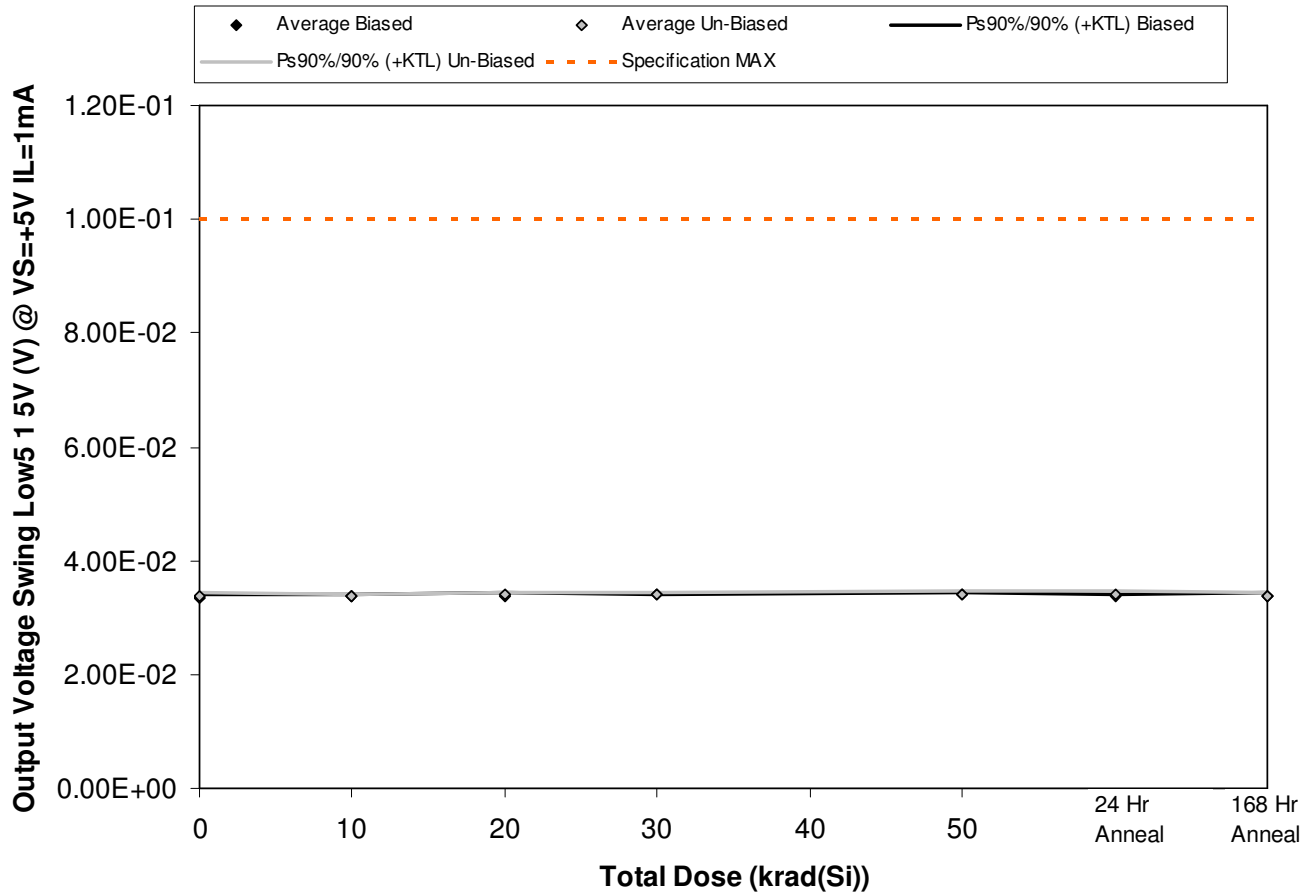


Figure 5.153. Plot of Output Voltage Swing Low5 1 5V (V) @ VS=+5V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.153. Raw data for Output Voltage Swing Low5 1 5V (V) @ VS=+5V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low5 1 5V (V) @ VS=+5V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.37E-02	3.39E-02	3.41E-02	3.41E-02	3.42E-02	3.40E-02	3.41E-02
563	3.33E-02	3.35E-02	3.38E-02	3.40E-02	3.39E-02	3.38E-02	3.37E-02
564	3.36E-02	3.37E-02	3.40E-02	3.40E-02	3.41E-02	3.39E-02	3.39E-02
567	3.34E-02	3.37E-02	3.39E-02	3.40E-02	3.40E-02	3.38E-02	3.38E-02
569	3.34E-02	3.36E-02	3.38E-02	3.39E-02	3.39E-02	3.37E-02	3.36E-02
570	3.34E-02	3.36E-02	3.37E-02	3.38E-02	3.38E-02	3.38E-02	3.36E-02
571	3.38E-02	3.38E-02	3.42E-02	3.41E-02	3.42E-02	3.41E-02	3.39E-02
572	3.39E-02	3.39E-02	3.40E-02	3.41E-02	3.41E-02	3.39E-02	3.40E-02
573	3.39E-02	3.39E-02	3.41E-02	3.42E-02	3.42E-02	3.43E-02	3.40E-02
574	3.37E-02	3.35E-02	3.39E-02	3.39E-02	3.41E-02	3.39E-02	3.38E-02
584	3.36E-02	3.37E-02	3.38E-02	3.39E-02	3.38E-02	3.37E-02	3.35E-02
585	3.38E-02	3.35E-02	3.40E-02	3.40E-02	3.37E-02	3.35E-02	3.36E-02
<b>Biased Statistics</b>							
Average Biased	3.35E-02	3.37E-02	3.39E-02	3.40E-02	3.40E-02	3.38E-02	3.38E-02
Std Dev Biased	1.76E-04	1.31E-04	1.44E-04	7.16E-05	1.39E-04	1.03E-04	1.95E-04
Ps90%/90% (+KTL) Biased	3.40E-02	3.40E-02	3.43E-02	3.42E-02	3.44E-02	3.41E-02	3.43E-02
Ps90%/90% (-KTL) Biased	3.30E-02	3.33E-02	3.35E-02	3.38E-02	3.36E-02	3.36E-02	3.33E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.37E-02	3.37E-02	3.40E-02	3.40E-02	3.41E-02	3.40E-02	3.38E-02
Std Dev Un-Biased	1.82E-04	1.67E-04	1.97E-04	1.28E-04	1.70E-04	2.02E-04	1.77E-04
Ps90%/90% (+KTL) Un-Biased	3.42E-02	3.42E-02	3.45E-02	3.44E-02	3.45E-02	3.45E-02	3.43E-02
Ps90%/90% (-KTL) Un-Biased	3.32E-02	3.33E-02	3.34E-02	3.37E-02	3.36E-02	3.34E-02	3.33E-02
<b>Specification MAX</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

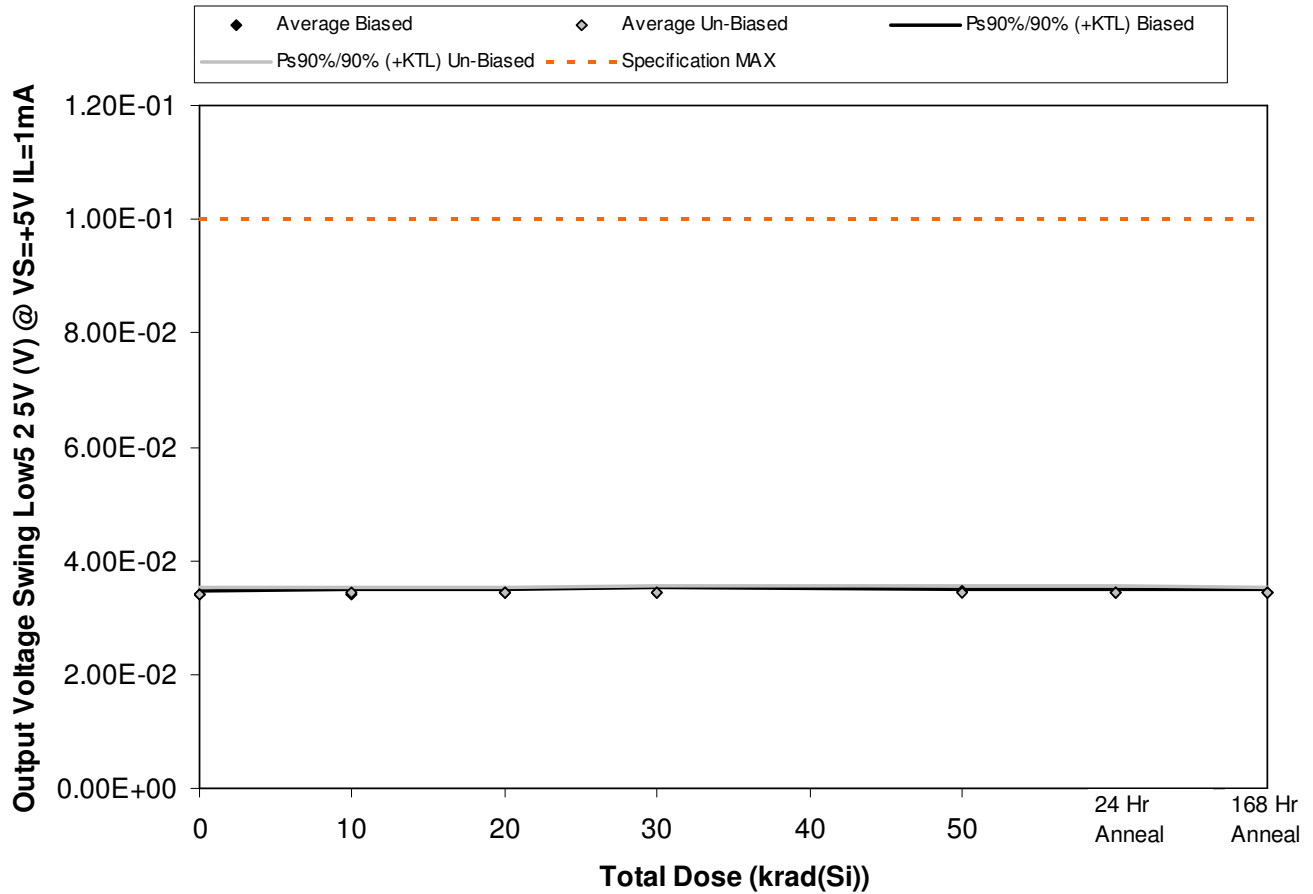


Figure 5.154. Plot of Output Voltage Swing Low5 2 5V (V) @ VS=+5V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.154. Raw data for Output Voltage Swing Low5 2 5V (V) @ VS=+5V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low5 2 5V (V) @ VS=+5V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.37E-02	3.37E-02	3.39E-02	3.41E-02	3.42E-02	3.40E-02	3.39E-02
563	3.41E-02	3.41E-02	3.42E-02	3.44E-02	3.46E-02	3.46E-02	3.44E-02
564	3.41E-02	3.44E-02	3.46E-02	3.47E-02	3.46E-02	3.44E-02	3.45E-02
567	3.41E-02	3.45E-02	3.45E-02	3.46E-02	3.47E-02	3.46E-02	3.45E-02
569	3.42E-02	3.43E-02	3.45E-02	3.46E-02	3.47E-02	3.44E-02	3.45E-02
570	3.42E-02	3.45E-02	3.44E-02	3.44E-02	3.44E-02	3.45E-02	3.44E-02
571	3.39E-02	3.41E-02	3.44E-02	3.44E-02	3.42E-02	3.43E-02	3.40E-02
572	3.40E-02	3.40E-02	3.42E-02	3.44E-02	3.43E-02	3.43E-02	3.41E-02
573	3.50E-02	3.48E-02	3.50E-02	3.51E-02	3.51E-02	3.51E-02	3.49E-02
574	3.38E-02	3.39E-02	3.41E-02	3.41E-02	3.41E-02	3.39E-02	3.39E-02
584	3.40E-02	3.40E-02	3.43E-02	3.41E-02	3.40E-02	3.39E-02	3.39E-02
585	3.41E-02	3.43E-02	3.46E-02	3.44E-02	3.42E-02	3.41E-02	3.41E-02
<b>Biased Statistics</b>							
Average Biased	3.40E-02	3.42E-02	3.43E-02	3.45E-02	3.45E-02	3.44E-02	3.44E-02
Std Dev Biased	2.17E-04	3.21E-04	2.87E-04	2.55E-04	1.82E-04	2.52E-04	2.72E-04
Ps90%/90% (+KTL) Biased	3.46E-02	3.51E-02	3.51E-02	3.52E-02	3.50E-02	3.51E-02	3.51E-02
Ps90%/90% (-KTL) Biased	3.34E-02	3.33E-02	3.36E-02	3.38E-02	3.40E-02	3.37E-02	3.36E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.42E-02	3.42E-02	3.44E-02	3.45E-02	3.44E-02	3.44E-02	3.43E-02
Std Dev Un-Biased	4.63E-04	3.78E-04	3.51E-04	3.80E-04	3.95E-04	4.41E-04	3.85E-04
Ps90%/90% (+KTL) Un-Biased	3.54E-02	3.53E-02	3.53E-02	3.55E-02	3.55E-02	3.56E-02	3.53E-02
Ps90%/90% (-KTL) Un-Biased	3.29E-02	3.32E-02	3.34E-02	3.34E-02	3.33E-02	3.32E-02	3.32E-02
<b>Specification MAX</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



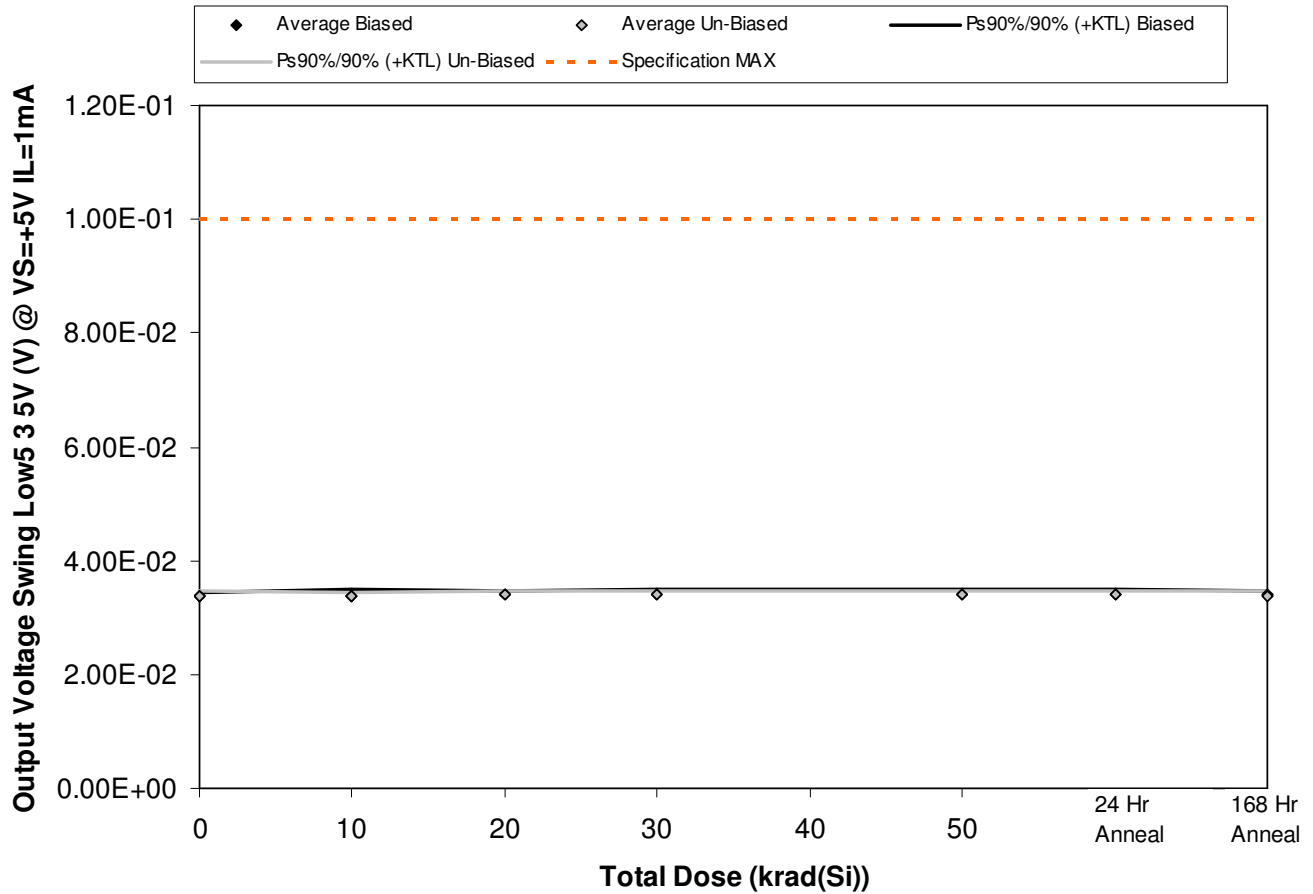


Figure 5.155. Plot of Output Voltage Swing Low5 3 5V (V) @ VS=+5V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.155. Raw data for Output Voltage Swing Low5 3 5V (V) @ VS=+5V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low5 3 5V (V) @ VS=+5V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.34E-02	3.33E-02	3.38E-02	3.36E-02	3.38E-02	3.37E-02	3.36E-02
563	3.35E-02	3.37E-02	3.39E-02	3.42E-02	3.41E-02	3.41E-02	3.40E-02
564	3.37E-02	3.39E-02	3.41E-02	3.41E-02	3.41E-02	3.38E-02	3.40E-02
567	3.37E-02	3.40E-02	3.42E-02	3.42E-02	3.41E-02	3.42E-02	3.39E-02
569	3.41E-02	3.44E-02	3.45E-02	3.45E-02	3.47E-02	3.44E-02	3.43E-02
570	3.31E-02	3.35E-02	3.38E-02	3.38E-02	3.38E-02	3.39E-02	3.36E-02
571	3.39E-02	3.39E-02	3.41E-02	3.41E-02	3.42E-02	3.40E-02	3.42E-02
572	3.37E-02	3.36E-02	3.38E-02	3.39E-02	3.39E-02	3.39E-02	3.38E-02
573	3.40E-02	3.41E-02	3.43E-02	3.44E-02	3.44E-02	3.44E-02	3.41E-02
574	3.36E-02	3.36E-02	3.40E-02	3.39E-02	3.40E-02	3.38E-02	3.38E-02
584	3.33E-02	3.37E-02	3.37E-02	3.37E-02	3.35E-02	3.34E-02	3.35E-02
585	3.38E-02	3.40E-02	3.41E-02	3.39E-02	3.38E-02	3.36E-02	3.37E-02
<b>Biased Statistics</b>							
Average Biased	3.37E-02	3.39E-02	3.41E-02	3.41E-02	3.41E-02	3.40E-02	3.39E-02
Std Dev Biased	2.62E-04	4.05E-04	2.57E-04	3.17E-04	3.17E-04	3.08E-04	2.60E-04
Ps90%/90% (+KTL) Biased	3.44E-02	3.50E-02	3.48E-02	3.50E-02	3.50E-02	3.49E-02	3.47E-02
Ps90%/90% (-KTL) Biased	3.30E-02	3.27E-02	3.34E-02	3.32E-02	3.33E-02	3.32E-02	3.32E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.37E-02	3.37E-02	3.40E-02	3.40E-02	3.41E-02	3.40E-02	3.39E-02
Std Dev Un-Biased	3.29E-04	2.66E-04	2.05E-04	2.57E-04	2.53E-04	2.35E-04	2.33E-04
Ps90%/90% (+KTL) Un-Biased	3.46E-02	3.45E-02	3.46E-02	3.47E-02	3.48E-02	3.47E-02	3.45E-02
Ps90%/90% (-KTL) Un-Biased	3.28E-02	3.30E-02	3.34E-02	3.33E-02	3.34E-02	3.34E-02	3.33E-02
<b>Specification MAX</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

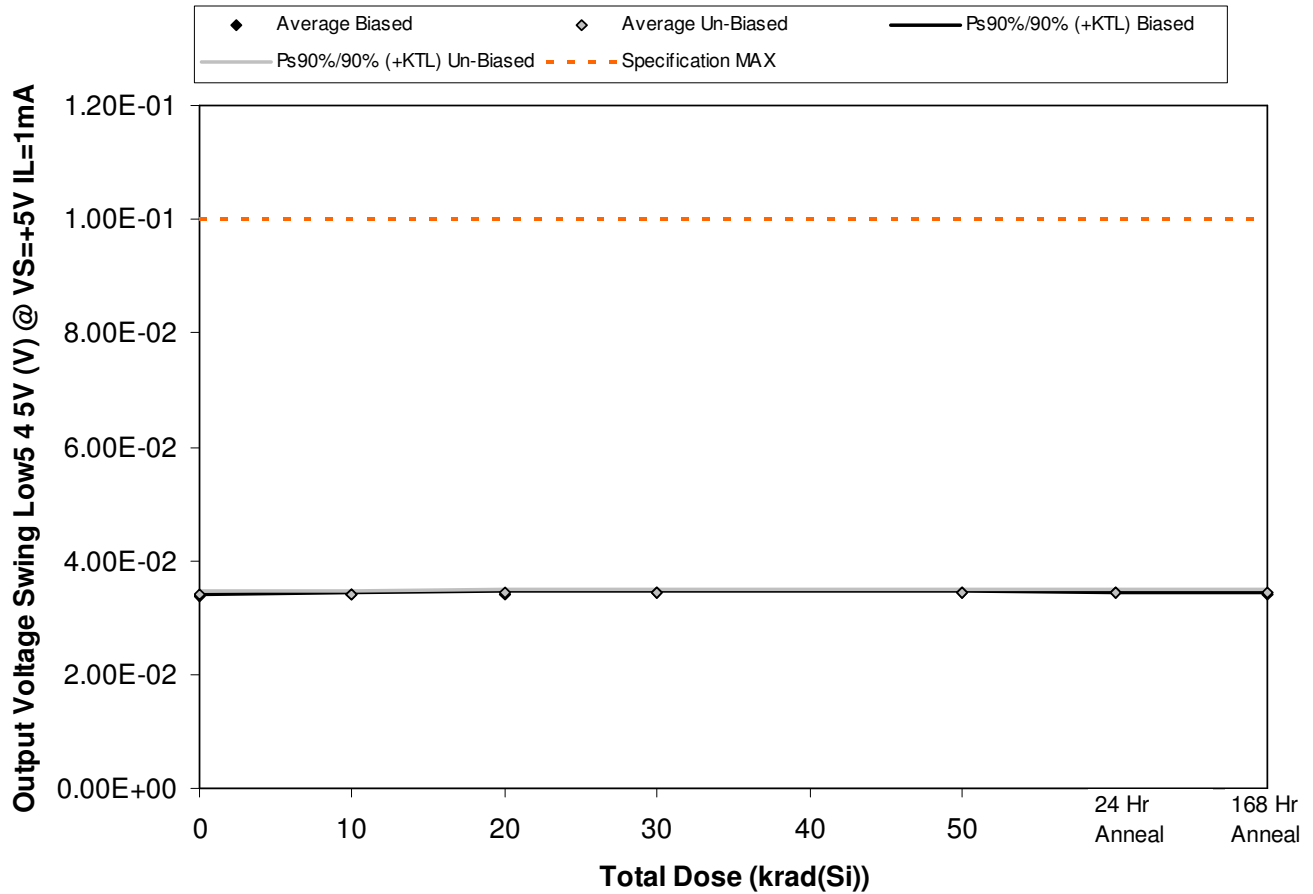


Figure 5.156. Plot of Output Voltage Swing Low5 4 5V (V) @ VS=+5V IL=1mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.156. Raw data for Output Voltage Swing Low5 4 5V (V) @ VS=+5V IL=1mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low5 4 5V (V) @ VS=+5V IL=1mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	3.39E-02	3.41E-02	3.41E-02	3.43E-02	3.44E-02	3.42E-02	3.41E-02
563	3.40E-02	3.39E-02	3.40E-02	3.43E-02	3.43E-02	3.42E-02	3.41E-02
564	3.38E-02	3.41E-02	3.44E-02	3.44E-02	3.45E-02	3.42E-02	3.44E-02
567	3.39E-02	3.42E-02	3.43E-02	3.43E-02	3.44E-02	3.44E-02	3.42E-02
569	3.38E-02	3.40E-02	3.42E-02	3.42E-02	3.41E-02	3.41E-02	3.42E-02
570	3.42E-02	3.41E-02	3.43E-02	3.45E-02	3.44E-02	3.44E-02	3.42E-02
571	3.40E-02	3.43E-02	3.45E-02	3.45E-02	3.46E-02	3.44E-02	3.43E-02
572	3.41E-02	3.42E-02	3.42E-02	3.44E-02	3.45E-02	3.44E-02	3.42E-02
573	3.43E-02	3.44E-02	3.46E-02	3.47E-02	3.47E-02	3.48E-02	3.47E-02
574	3.39E-02	3.40E-02	3.42E-02	3.41E-02	3.44E-02	3.42E-02	3.40E-02
584	3.39E-02	3.40E-02	3.42E-02	3.40E-02	3.40E-02	3.38E-02	3.39E-02
585	3.39E-02	3.40E-02	3.45E-02	3.42E-02	3.41E-02	3.40E-02	3.40E-02
<b>Biased Statistics</b>							
Average Biased	3.39E-02	3.41E-02	3.42E-02	3.43E-02	3.43E-02	3.42E-02	3.42E-02
Std Dev Biased	6.66E-05	1.03E-04	1.76E-04	9.76E-05	1.74E-04	8.73E-05	1.18E-04
Ps90%/90% (+KTL) Biased	3.40E-02	3.43E-02	3.47E-02	3.46E-02	3.48E-02	3.45E-02	3.45E-02
Ps90%/90% (-KTL) Biased	3.37E-02	3.38E-02	3.37E-02	3.40E-02	3.39E-02	3.40E-02	3.39E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.41E-02	3.42E-02	3.43E-02	3.45E-02	3.45E-02	3.44E-02	3.43E-02
Std Dev Un-Biased	1.60E-04	1.63E-04	1.94E-04	2.10E-04	1.27E-04	2.04E-04	2.68E-04
Ps90%/90% (+KTL) Un-Biased	3.46E-02	3.47E-02	3.49E-02	3.50E-02	3.49E-02	3.50E-02	3.50E-02
Ps90%/90% (-KTL) Un-Biased	3.37E-02	3.38E-02	3.38E-02	3.39E-02	3.42E-02	3.39E-02	3.35E-02
<b>Specification MAX</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>	<b>1.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

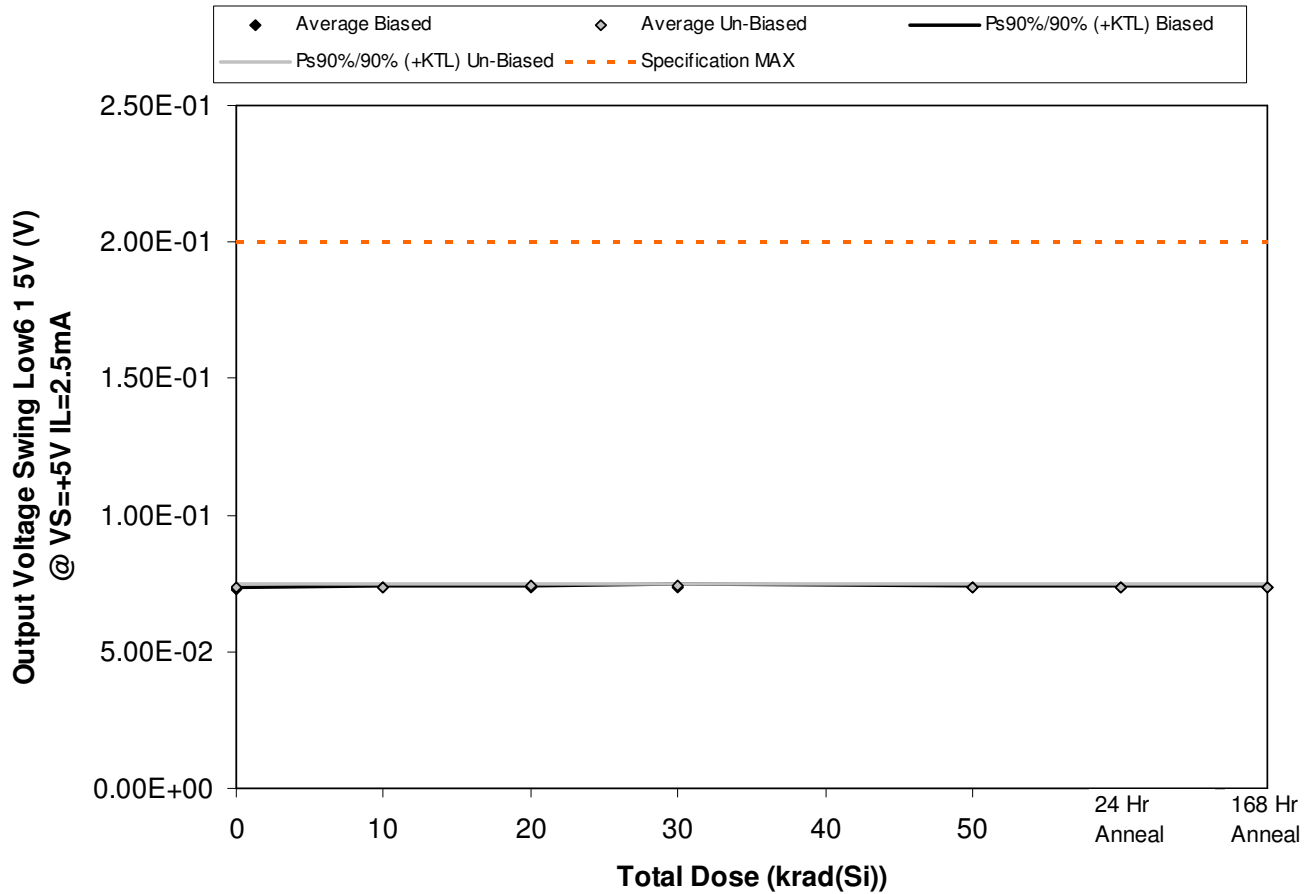


Figure 5.157. Plot of Output Voltage Swing Low6 1 5V (V) @ VS=+5V IL=2.5mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.157. Raw data for Output Voltage Swing Low6 1 5V (V) @ VS=+5V IL=2.5mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low6 1 5V (V) @ VS=+5V IL=2.5mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	7.31E-02	7.32E-02	7.34E-02	7.36E-02	7.35E-02	7.33E-02	7.34E-02
563	7.32E-02	7.32E-02	7.36E-02	7.38E-02	7.36E-02	7.34E-02	7.35E-02
564	7.34E-02	7.36E-02	7.39E-02	7.43E-02	7.39E-02	7.37E-02	7.38E-02
567	7.32E-02	7.37E-02	7.40E-02	7.38E-02	7.37E-02	7.35E-02	7.35E-02
569	7.31E-02	7.35E-02	7.35E-02	7.36E-02	7.35E-02	7.33E-02	7.34E-02
570	7.31E-02	7.31E-02	7.33E-02	7.34E-02	7.32E-02	7.34E-02	7.32E-02
571	7.37E-02	7.36E-02	7.40E-02	7.41E-02	7.40E-02	7.38E-02	7.37E-02
572	7.39E-02	7.38E-02	7.41E-02	7.40E-02	7.40E-02	7.39E-02	7.41E-02
573	7.40E-02	7.41E-02	7.43E-02	7.43E-02	7.41E-02	7.40E-02	7.39E-02
574	7.35E-02	7.32E-02	7.37E-02	7.38E-02	7.36E-02	7.34E-02	7.33E-02
584	7.30E-02	7.34E-02	7.35E-02	7.34E-02	7.31E-02	7.29E-02	7.31E-02
585	7.31E-02	7.33E-02	7.40E-02	7.35E-02	7.32E-02	7.29E-02	7.31E-02
<b>Biased Statistics</b>							
Average Biased	7.32E-02	7.34E-02	7.37E-02	7.38E-02	7.36E-02	7.34E-02	7.35E-02
Std Dev Biased	1.38E-04	2.29E-04	2.58E-04	2.68E-04	1.89E-04	1.53E-04	1.67E-04
Ps90%/90% (+KTL) Biased	7.36E-02	7.41E-02	7.44E-02	7.45E-02	7.42E-02	7.39E-02	7.39E-02
Ps90%/90% (-KTL) Biased	7.28E-02	7.28E-02	7.30E-02	7.31E-02	7.31E-02	7.30E-02	7.30E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.36E-02	7.36E-02	7.39E-02	7.39E-02	7.38E-02	7.37E-02	7.36E-02
Std Dev Un-Biased	3.52E-04	3.93E-04	3.58E-04	3.66E-04	3.50E-04	2.88E-04	3.75E-04
Ps90%/90% (+KTL) Un-Biased	7.46E-02	7.47E-02	7.48E-02	7.49E-02	7.47E-02	7.45E-02	7.47E-02
Ps90%/90% (-KTL) Un-Biased	7.27E-02	7.25E-02	7.29E-02	7.29E-02	7.28E-02	7.29E-02	7.26E-02
<b>Specification MAX</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

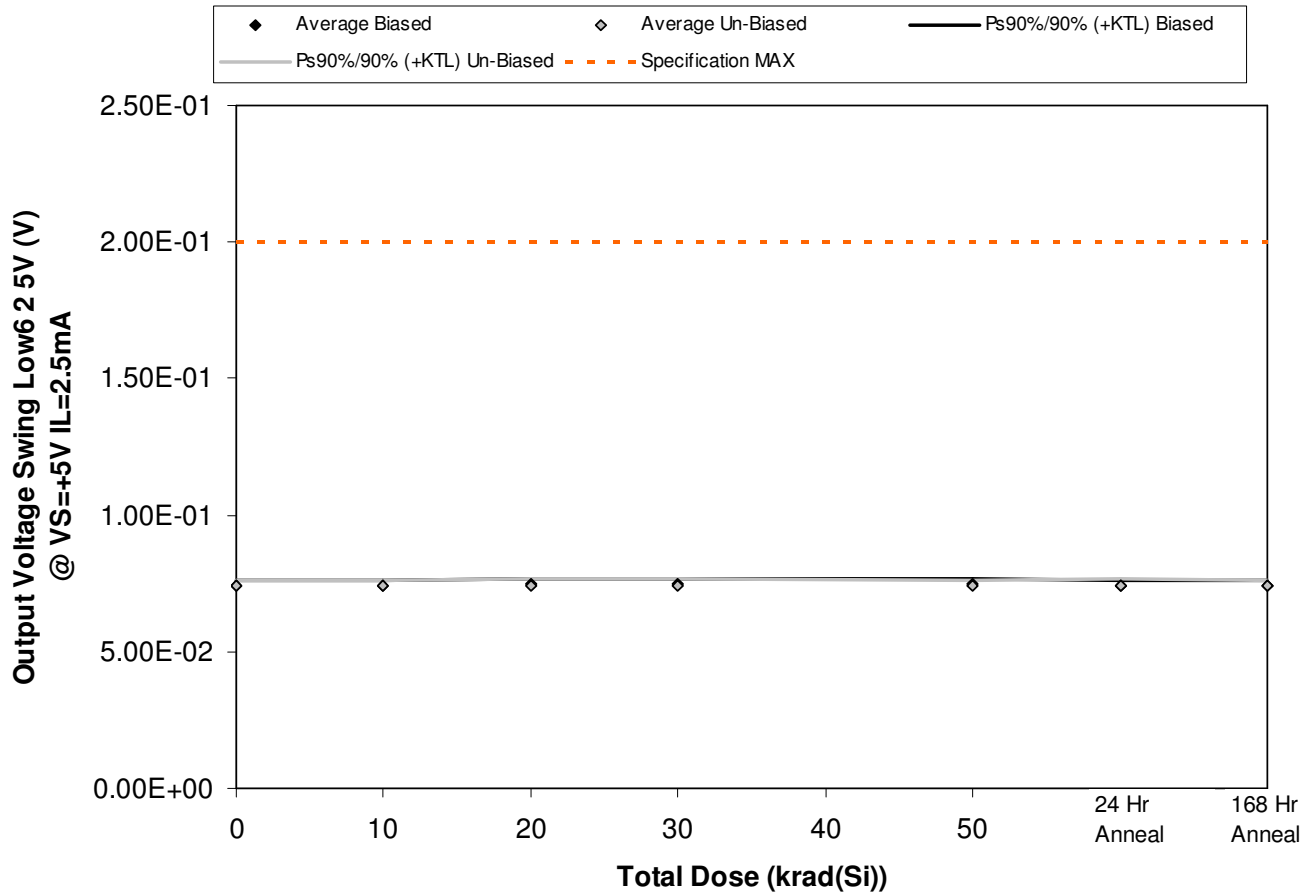


Figure 5.158. Plot of Output Voltage Swing Low6 2 5V (V) @ VS=+5V IL=2.5mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.158. Raw data for Output Voltage Swing Low6 2 5V (V) @ VS=+5V IL=2.5mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low6 2 5V (V) @ VS=+5V IL=2.5mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	7.29E-02	7.30E-02	7.32E-02	7.32E-02	7.33E-02	7.30E-02	7.31E-02
563	7.44E-02	7.44E-02	7.47E-02	7.48E-02	7.47E-02	7.45E-02	7.47E-02
564	7.46E-02	7.47E-02	7.50E-02	7.52E-02	7.51E-02	7.46E-02	7.48E-02
567	7.46E-02	7.49E-02	7.51E-02	7.51E-02	7.50E-02	7.48E-02	7.48E-02
569	7.43E-02	7.46E-02	7.46E-02	7.48E-02	7.45E-02	7.45E-02	7.45E-02
570	7.44E-02	7.46E-02	7.47E-02	7.47E-02	7.46E-02	7.46E-02	7.44E-02
571	7.41E-02	7.40E-02	7.42E-02	7.43E-02	7.43E-02	7.42E-02	7.40E-02
572	7.38E-02	7.37E-02	7.40E-02	7.41E-02	7.41E-02	7.39E-02	7.37E-02
573	7.53E-02	7.52E-02	7.56E-02	7.56E-02	7.54E-02	7.54E-02	7.52E-02
574	7.32E-02	7.32E-02	7.35E-02	7.37E-02	7.37E-02	7.33E-02	7.33E-02
584	7.42E-02	7.43E-02	7.44E-02	7.45E-02	7.41E-02	7.39E-02	7.40E-02
585	7.42E-02	7.44E-02	7.50E-02	7.47E-02	7.47E-02	7.41E-02	7.42E-02
<b>Biased Statistics</b>							
Average Biased	7.41E-02	7.43E-02	7.45E-02	7.46E-02	7.45E-02	7.43E-02	7.44E-02
Std Dev Biased	7.28E-04	7.62E-04	7.57E-04	8.26E-04	7.29E-04	7.46E-04	7.24E-04
Ps90%/90% (+KTL) Biased	7.61E-02	7.64E-02	7.66E-02	7.69E-02	7.65E-02	7.63E-02	7.64E-02
Ps90%/90% (-KTL) Biased	7.22E-02	7.22E-02	7.24E-02	7.23E-02	7.25E-02	7.22E-02	7.24E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.42E-02	7.41E-02	7.44E-02	7.45E-02	7.44E-02	7.43E-02	7.41E-02
Std Dev Un-Biased	7.86E-04	7.82E-04	8.02E-04	7.36E-04	6.49E-04	7.95E-04	7.22E-04
Ps90%/90% (+KTL) Un-Biased	7.63E-02	7.63E-02	7.66E-02	7.65E-02	7.62E-02	7.64E-02	7.61E-02
Ps90%/90% (-KTL) Un-Biased	7.20E-02	7.20E-02	7.22E-02	7.25E-02	7.26E-02	7.21E-02	7.22E-02
<b>Specification MAX</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



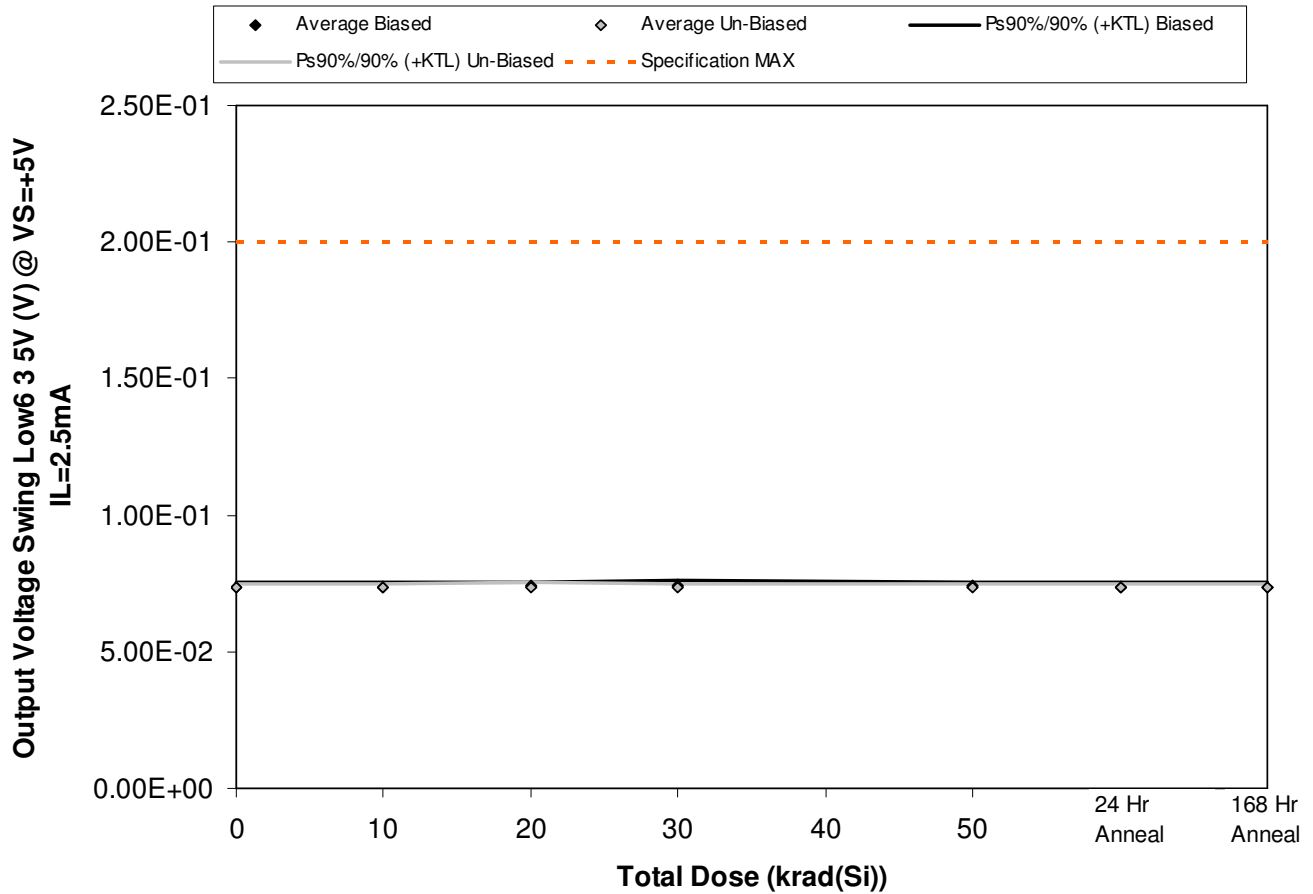


Figure 5.159. Plot of Output Voltage Swing Low6 3.5V (V) @ VS=+5V IL=2.5mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.159. Raw data for Output Voltage Swing Low6 3 5V (V) @ VS=+5V IL=2.5mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low6 3 5V (V) @ VS=+5V IL=2.5mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	7.23E-02	7.24E-02	7.27E-02	7.25E-02	7.29E-02	7.25E-02	7.24E-02
563	7.37E-02	7.36E-02	7.40E-02	7.42E-02	7.42E-02	7.38E-02	7.39E-02
564	7.35E-02	7.38E-02	7.40E-02	7.44E-02	7.41E-02	7.39E-02	7.41E-02
567	7.38E-02	7.41E-02	7.41E-02	7.43E-02	7.43E-02	7.41E-02	7.39E-02
569	7.38E-02	7.43E-02	7.44E-02	7.43E-02	7.40E-02	7.42E-02	7.42E-02
570	7.33E-02	7.34E-02	7.35E-02	7.36E-02	7.36E-02	7.35E-02	7.32E-02
571	7.37E-02	7.36E-02	7.40E-02	7.39E-02	7.40E-02	7.37E-02	7.38E-02
572	7.32E-02	7.31E-02	7.33E-02	7.34E-02	7.34E-02	7.31E-02	7.31E-02
573	7.42E-02	7.42E-02	7.45E-02	7.45E-02	7.44E-02	7.43E-02	7.43E-02
574	7.30E-02	7.30E-02	7.34E-02	7.34E-02	7.33E-02	7.32E-02	7.31E-02
584	7.30E-02	7.34E-02	7.35E-02	7.35E-02	7.32E-02	7.29E-02	7.30E-02
585	7.36E-02	7.36E-02	7.44E-02	7.41E-02	7.36E-02	7.33E-02	7.34E-02
<b>Biased Statistics</b>							
Average Biased	7.34E-02	7.36E-02	7.39E-02	7.39E-02	7.39E-02	7.37E-02	7.37E-02
Std Dev Biased	6.44E-04	7.25E-04	6.49E-04	8.10E-04	5.75E-04	7.03E-04	7.36E-04
Ps90%/90% (+KTL) Biased	7.52E-02	7.56E-02	7.56E-02	7.61E-02	7.55E-02	7.56E-02	7.57E-02
Ps90%/90% (-KTL) Biased	7.16E-02	7.16E-02	7.21E-02	7.17E-02	7.23E-02	7.18E-02	7.17E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.35E-02	7.35E-02	7.37E-02	7.38E-02	7.37E-02	7.36E-02	7.35E-02
Std Dev Un-Biased	4.67E-04	4.71E-04	5.17E-04	4.50E-04	4.42E-04	4.74E-04	5.25E-04
Ps90%/90% (+KTL) Un-Biased	7.48E-02	7.48E-02	7.51E-02	7.50E-02	7.49E-02	7.49E-02	7.49E-02
Ps90%/90% (-KTL) Un-Biased	7.22E-02	7.22E-02	7.23E-02	7.25E-02	7.25E-02	7.23E-02	7.20E-02
<b>Specification MAX</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

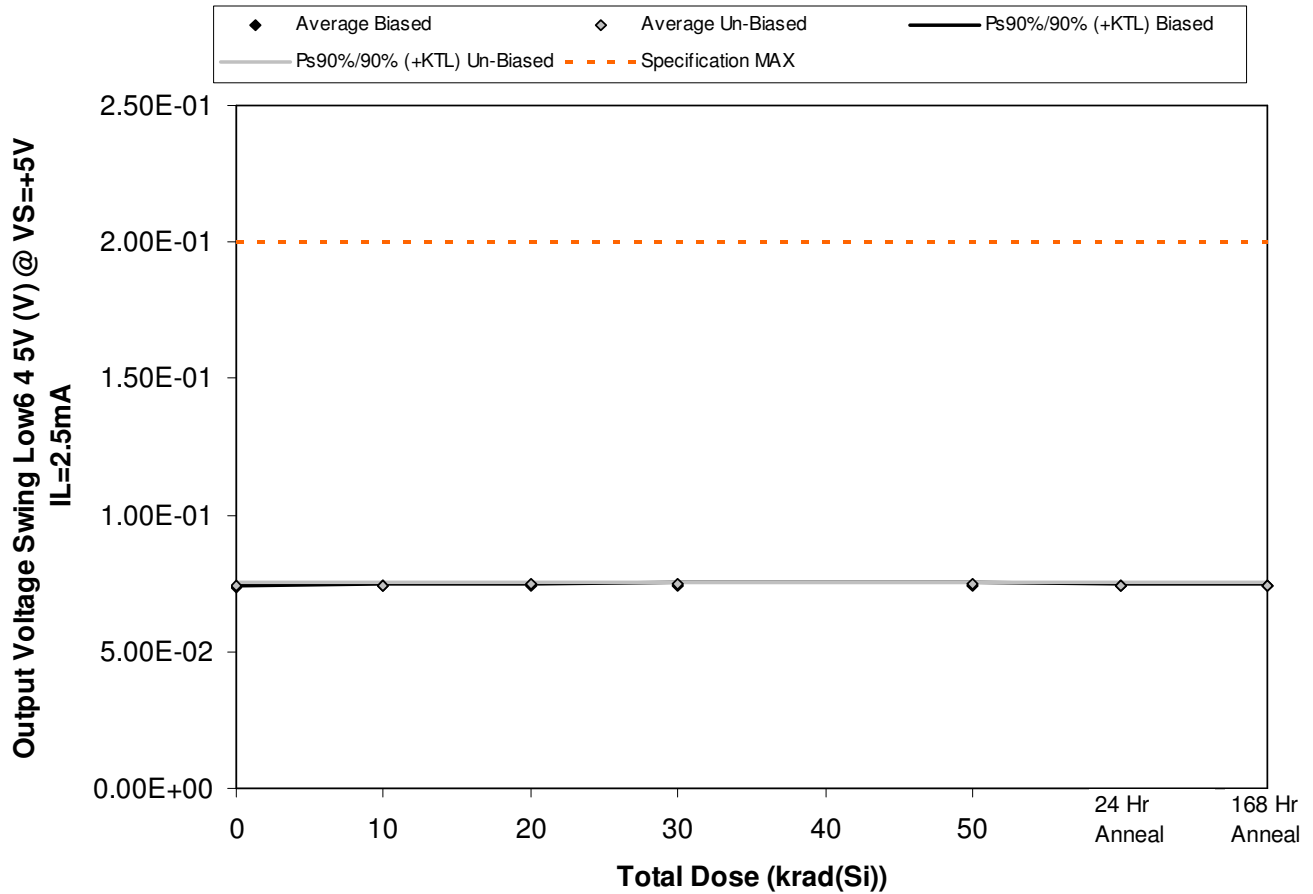


Figure 5.160. Plot of Output Voltage Swing Low6 4 5V (V) @ VS=+5V IL=2.5mA versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.160. Raw data for Output Voltage Swing Low6 4 5V (V) @ VS=+5V IL=2.5mA versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Output Voltage Swing Low6 4 5V (V) @ VS=+5V IL=2.5mA	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	7.34E-02	7.36E-02	7.38E-02	7.37E-02	7.38E-02	7.36E-02	7.34E-02
563	7.38E-02	7.37E-02	7.43E-02	7.44E-02	7.42E-02	7.40E-02	7.41E-02
564	7.40E-02	7.42E-02	7.46E-02	7.47E-02	7.47E-02	7.42E-02	7.45E-02
567	7.39E-02	7.44E-02	7.43E-02	7.46E-02	7.44E-02	7.43E-02	7.41E-02
569	7.37E-02	7.40E-02	7.41E-02	7.42E-02	7.39E-02	7.38E-02	7.40E-02
570	7.41E-02	7.44E-02	7.46E-02	7.45E-02	7.42E-02	7.44E-02	7.42E-02
571	7.42E-02	7.42E-02	7.47E-02	7.46E-02	7.47E-02	7.44E-02	7.43E-02
572	7.47E-02	7.45E-02	7.46E-02	7.46E-02	7.47E-02	7.45E-02	7.45E-02
573	7.49E-02	7.50E-02	7.51E-02	7.51E-02	7.49E-02	7.49E-02	7.48E-02
574	7.39E-02	7.39E-02	7.43E-02	7.43E-02	7.42E-02	7.39E-02	7.39E-02
584	7.35E-02	7.38E-02	7.39E-02	7.39E-02	7.37E-02	7.34E-02	7.35E-02
585	7.38E-02	7.38E-02	7.47E-02	7.42E-02	7.40E-02	7.36E-02	7.39E-02
<b>Biased Statistics</b>							
Average Biased	7.38E-02	7.40E-02	7.42E-02	7.43E-02	7.42E-02	7.40E-02	7.40E-02
Std Dev Biased	2.35E-04	3.45E-04	2.97E-04	3.84E-04	3.67E-04	2.82E-04	3.78E-04
Ps90%/90% (+KTL) Biased	7.44E-02	7.49E-02	7.50E-02	7.53E-02	7.52E-02	7.48E-02	7.51E-02
Ps90%/90% (-KTL) Biased	7.31E-02	7.30E-02	7.34E-02	7.32E-02	7.32E-02	7.32E-02	7.30E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.44E-02	7.44E-02	7.47E-02	7.46E-02	7.45E-02	7.44E-02	7.44E-02
Std Dev Un-Biased	4.28E-04	3.92E-04	3.10E-04	2.78E-04	3.30E-04	3.57E-04	3.16E-04
Ps90%/90% (+KTL) Un-Biased	7.55E-02	7.55E-02	7.55E-02	7.54E-02	7.54E-02	7.54E-02	7.52E-02
Ps90%/90% (-KTL) Un-Biased	7.32E-02	7.33E-02	7.38E-02	7.39E-02	7.36E-02	7.35E-02	7.35E-02
<b>Specification MAX</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>	<b>2.00E-01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

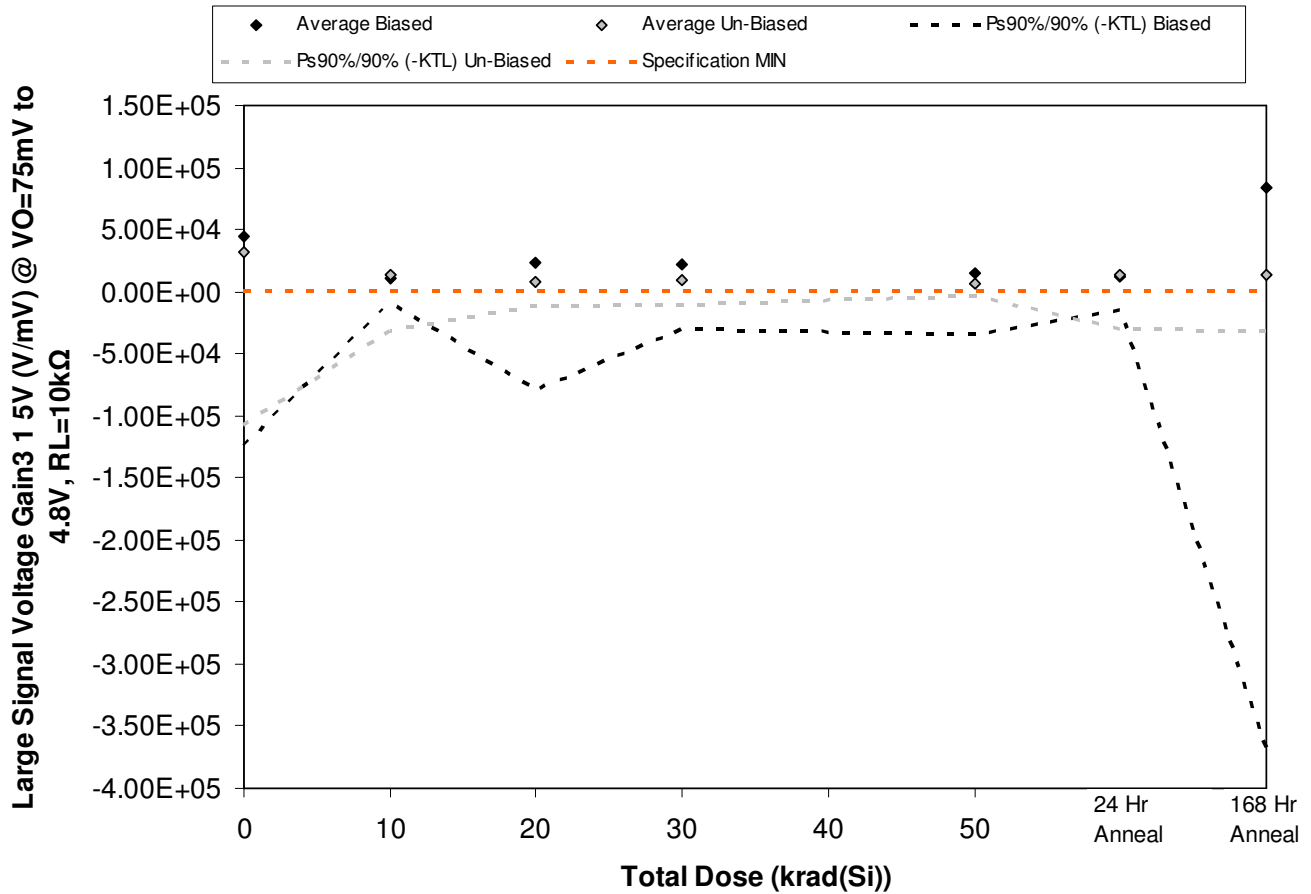


Figure 5.161. Plot of Large Signal Voltage Gain3 1 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.161. Raw data for Large Signal Voltage Gain3 1 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain3 1 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.18E+04	6.48E+03	4.18E+03	7.12E+03	3.68E+03	7.65E+03	5.34E+03
563	3.67E+04	9.32E+03	9.05E+04	2.83E+04	4.63E+04	2.93E+04	1.74E+04
564	6.74E+03	4.15E+03	6.96E+03	8.23E+03	3.83E+03	7.53E+03	6.03E+03
567	1.53E+05	2.25E+04	1.24E+04	1.37E+04	1.48E+04	6.42E+03	3.79E+05
569	1.45E+04	1.20E+04	4.89E+03	5.26E+04	5.66E+03	9.16E+03	9.17E+03
570	2.49E+03	3.13E+03	2.76E+03	2.75E+03	2.35E+03	3.69E+03	3.33E+03
571	9.76E+03	7.76E+03	6.46E+03	5.48E+03	8.00E+03	8.99E+03	6.61E+03
572	1.27E+04	5.68E+03	2.13E+03	7.46E+03	3.25E+03	7.28E+03	4.20E+04
573	9.87E+03	7.57E+03	6.76E+03	1.04E+04	6.79E+03	5.49E+03	3.23E+03
574	1.21E+05	4.18E+04	1.93E+04	2.07E+04	1.07E+04	4.18E+04	1.28E+04
584	3.16E+03	3.39E+03	3.85E+03	3.92E+03	3.10E+03	3.05E+03	3.99E+03
585	5.11E+03	6.59E+03	5.39E+03	6.88E+03	1.07E+04	1.12E+04	7.21E+03
<b>Biased Statistics</b>							
Average Biased	4.45E+04	1.09E+04	2.38E+04	2.20E+04	1.48E+04	1.20E+04	8.33E+04
Std Dev Biased	6.16E+04	7.14E+03	3.74E+04	1.91E+04	1.82E+04	9.72E+03	1.65E+05
Ps90%/90% (+KTL) Biased	2.13E+05	3.05E+04	1.26E+05	7.43E+04	6.46E+04	3.87E+04	5.36E+05
Ps90%/90% (-KTL) Biased	-1.24E+05	-8.67E+03	-7.89E+04	-3.03E+04	-3.49E+04	-1.46E+04	-3.70E+05
<b>Un-Biased Statistics</b>							
Average Un-Biased	3.12E+04	1.32E+04	7.48E+03	9.36E+03	6.22E+03	1.35E+04	1.36E+04
Std Dev Un-Biased	5.05E+04	1.61E+04	6.91E+03	6.95E+03	3.45E+03	1.60E+04	1.63E+04
Ps90%/90% (+KTL) Un-Biased	1.70E+05	5.74E+04	2.64E+04	2.84E+04	1.57E+04	5.73E+04	5.84E+04
Ps90%/90% (-KTL) Un-Biased	-1.07E+05	-3.10E+04	-1.15E+04	-9.68E+03	-3.23E+03	-3.04E+04	-3.12E+04
<b>Specification MIN</b>	<b>6.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

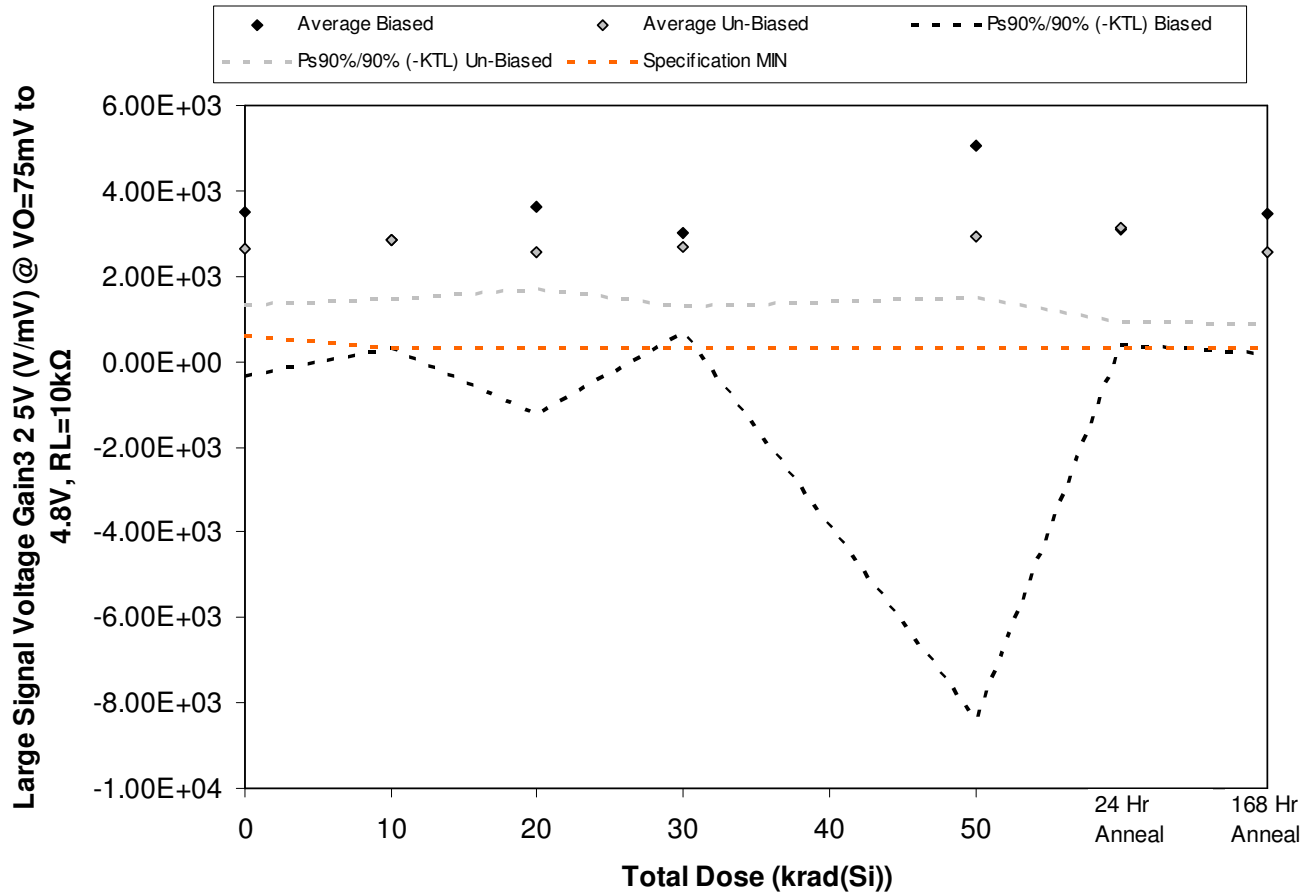


Figure 5.162. Plot of Large Signal Voltage Gain3 2.5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.162. Raw data for Large Signal Voltage Gain3 2 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain3 2 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.94E+03	1.88E+03	1.88E+03	1.93E+03	1.93E+03	1.61E+03	2.13E+03
563	5.73E+03	4.10E+03	3.73E+03	4.27E+03	1.38E+04	4.27E+03	4.30E+03
564	3.65E+03	3.45E+03	6.50E+03	3.27E+03	3.06E+03	3.57E+03	5.05E+03
567	2.88E+03	2.75E+03	2.57E+03	2.68E+03	2.73E+03	2.86E+03	2.68E+03
569	3.30E+03	2.07E+03	3.43E+03	2.90E+03	3.83E+03	3.08E+03	3.20E+03
570	3.05E+03	2.99E+03	2.92E+03	2.65E+03	2.20E+03	3.06E+03	2.56E+03
571	2.04E+03	3.41E+03	2.14E+03	2.85E+03	3.07E+03	4.19E+03	1.79E+03
572	2.24E+03	2.13E+03	2.36E+03	1.83E+03	2.73E+03	1.95E+03	2.19E+03
573	2.89E+03	2.57E+03	2.60E+03	3.00E+03	3.16E+03	3.32E+03	3.30E+03
574	3.03E+03	3.16E+03	2.81E+03	3.11E+03	3.60E+03	3.07E+03	3.01E+03
584	2.80E+03	3.34E+03	3.59E+03	3.16E+03	3.07E+03	2.88E+03	2.62E+03
585	2.00E+03	2.09E+03	2.04E+03	2.08E+03	1.92E+03	2.11E+03	1.94E+03
<b>Biased Statistics</b>							
Average Biased	3.50E+03	2.85E+03	3.62E+03	3.01E+03	5.06E+03	3.08E+03	3.47E+03
Std Dev Biased	1.40E+03	9.30E+02	1.77E+03	8.56E+02	4.91E+03	9.84E+02	1.19E+03
Ps90%/90% (+KTL) Biased	7.35E+03	5.40E+03	8.47E+03	5.36E+03	1.85E+04	5.78E+03	6.74E+03
Ps90%/90% (-KTL) Biased	-3.50E+02	3.00E+02	-1.22E+03	6.61E+02	-8.40E+03	3.80E+02	2.06E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	2.65E+03	2.85E+03	2.57E+03	2.69E+03	2.95E+03	3.12E+03	2.57E+03
Std Dev Un-Biased	4.73E+02	5.06E+02	3.20E+02	5.11E+02	5.26E+02	7.99E+02	6.09E+02
Ps90%/90% (+KTL) Un-Biased	3.94E+03	4.24E+03	3.44E+03	4.09E+03	4.39E+03	5.31E+03	4.24E+03
Ps90%/90% (-KTL) Un-Biased	1.35E+03	1.47E+03	1.69E+03	1.29E+03	1.51E+03	9.24E+02	9.00E+02
<b>Specification MIN</b>	<b>6.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



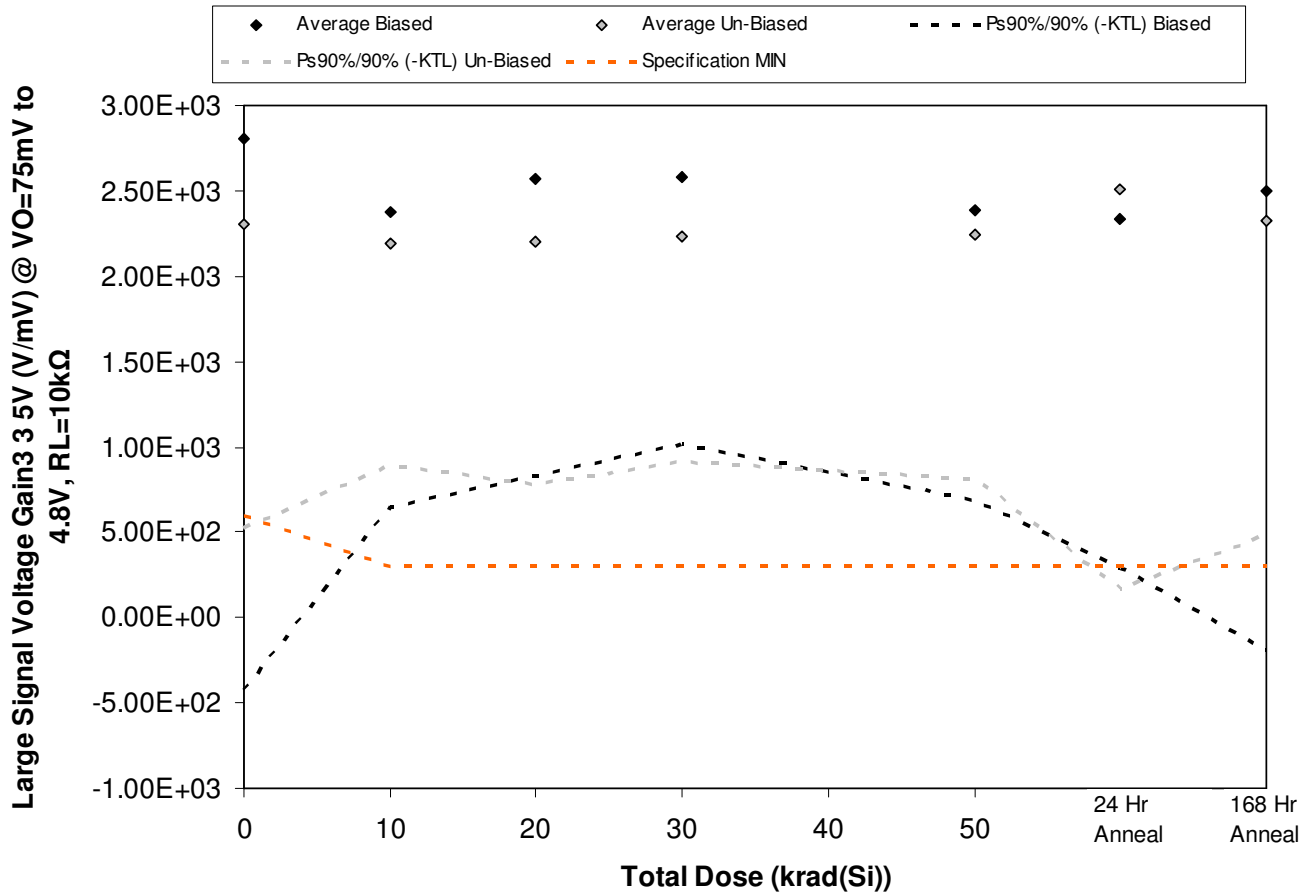


Figure 5.163. Plot of Large Signal Voltage Gain 3 3 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.163. Raw data for Large Signal Voltage Gain3 3 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain3 3 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.91E+03	1.70E+03	1.78E+03	2.08E+03	1.76E+03	1.54E+03	1.72E+03
563	2.67E+03	2.36E+03	2.80E+03	3.08E+03	2.00E+03	2.15E+03	2.36E+03
564	1.88E+03	1.93E+03	2.04E+03	2.05E+03	2.58E+03	1.99E+03	1.76E+03
567	2.77E+03	2.55E+03	3.27E+03	2.40E+03	2.23E+03	2.49E+03	2.53E+03
569	4.78E+03	3.32E+03	2.97E+03	3.27E+03	3.35E+03	3.53E+03	4.14E+03
570	2.42E+03	2.41E+03	2.48E+03	2.18E+03	2.00E+03	3.64E+03	2.10E+03
571	2.11E+03	2.15E+03	1.97E+03	2.11E+03	2.03E+03	2.18E+03	2.45E+03
572	1.65E+03	1.71E+03	1.49E+03	1.94E+03	1.69E+03	1.60E+03	1.68E+03
573	1.99E+03	1.82E+03	2.24E+03	1.88E+03	2.47E+03	1.96E+03	1.97E+03
574	3.35E+03	2.89E+03	2.86E+03	3.07E+03	3.04E+03	3.16E+03	3.42E+03
584	2.64E+03	2.69E+03	2.28E+03	2.22E+03	2.58E+03	2.28E+03	2.65E+03
585	2.17E+03	1.90E+03	2.08E+03	2.41E+03	2.12E+03	2.32E+03	2.15E+03
<b>Biased Statistics</b>							
Average Biased	2.80E+03	2.37E+03	2.57E+03	2.58E+03	2.38E+03	2.34E+03	2.50E+03
Std Dev Biased	1.18E+03	6.28E+02	6.33E+02	5.68E+02	6.19E+02	7.48E+02	9.82E+02
Ps90%/90% (+KTL) Biased	6.03E+03	4.09E+03	4.31E+03	4.14E+03	4.08E+03	4.39E+03	5.20E+03
Ps90%/90% (-KTL) Biased	-4.30E+02	6.50E+02	8.36E+02	1.02E+03	6.85E+02	2.86E+02	-1.91E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	2.30E+03	2.20E+03	2.21E+03	2.24E+03	2.24E+03	2.51E+03	2.32E+03
Std Dev Un-Biased	6.49E+02	4.76E+02	5.19E+02	4.82E+02	5.24E+02	8.55E+02	6.71E+02
Ps90%/90% (+KTL) Un-Biased	4.08E+03	3.50E+03	3.63E+03	3.56E+03	3.68E+03	4.85E+03	4.16E+03
Ps90%/90% (-KTL) Un-Biased	5.24E+02	8.90E+02	7.84E+02	9.17E+02	8.09E+02	1.64E+02	4.84E+02
<b>Specification MIN</b>	<b>6.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

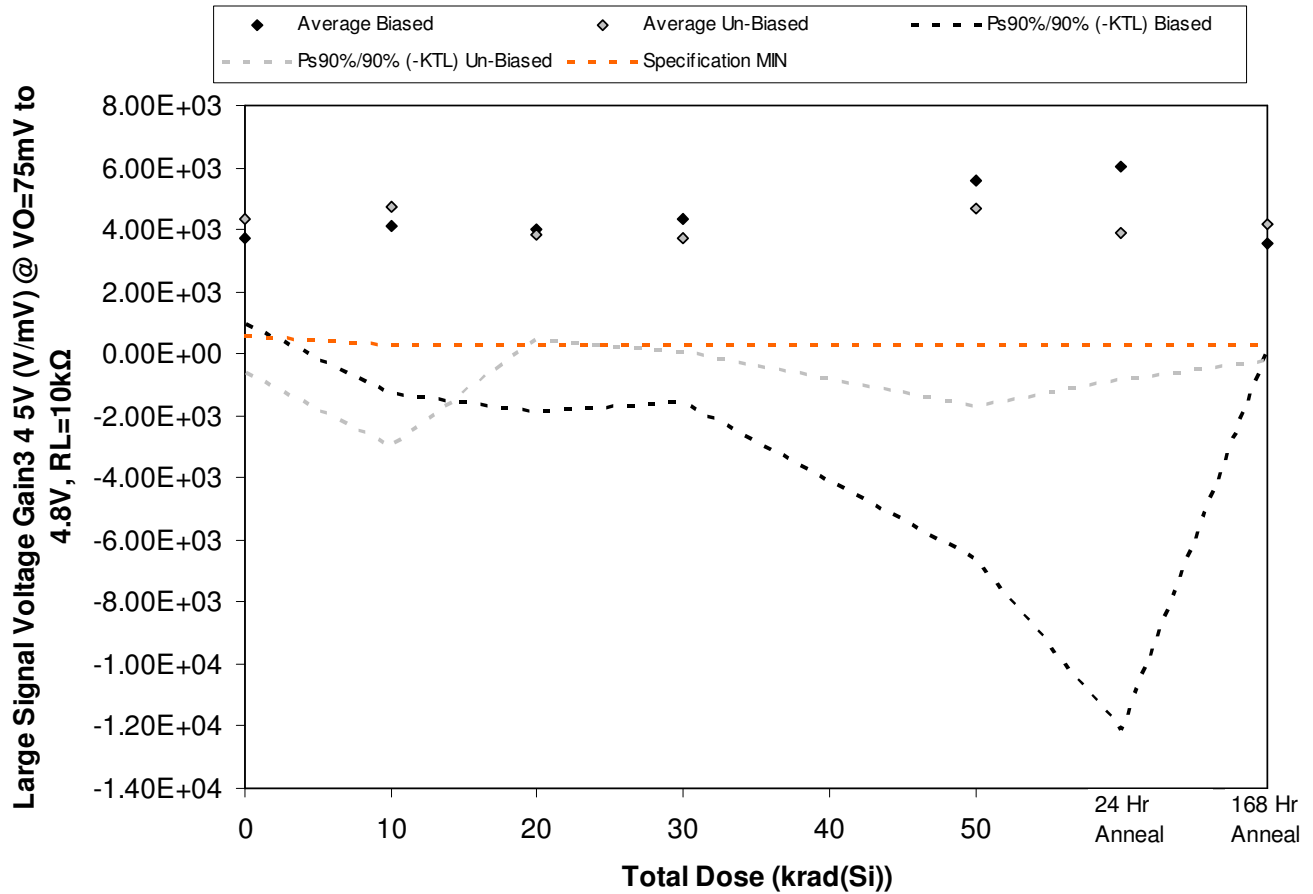


Figure 5.164. Plot of Large Signal Voltage Gain3 4 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.164. Raw data for Large Signal Voltage Gain3 4 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Large Signal Voltage Gain3 4 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	4.80E+03	3.44E+03	3.72E+03	4.39E+03	3.25E+03	4.64E+03	3.25E+03
563	3.64E+03	3.88E+03	2.96E+03	3.51E+03	5.35E+03	2.64E+03	3.70E+03
564	2.39E+03	2.17E+03	1.98E+03	1.89E+03	2.10E+03	2.03E+03	2.11E+03
567	3.20E+03	3.63E+03	3.67E+03	4.12E+03	4.01E+03	3.08E+03	3.10E+03
569	4.69E+03	7.44E+03	7.56E+03	7.76E+03	1.33E+04	1.78E+04	5.50E+03
570	6.43E+03	9.20E+03	4.41E+03	3.90E+03	6.65E+03	6.34E+03	5.56E+03
571	2.65E+03	2.56E+03	2.97E+03	2.74E+03	2.62E+03	2.33E+03	2.66E+03
572	4.42E+03	3.91E+03	4.48E+03	4.37E+03	4.88E+03	3.77E+03	5.39E+03
573	2.39E+03	2.36E+03	2.17E+03	2.11E+03	2.06E+03	2.24E+03	2.23E+03
574	5.72E+03	5.54E+03	5.15E+03	5.48E+03	7.22E+03	4.72E+03	5.16E+03
584	2.13E+03	1.95E+03	2.10E+03	2.17E+03	1.95E+03	2.28E+03	1.99E+03
585	2.61E+03	2.82E+03	2.63E+03	2.30E+03	2.55E+03	2.27E+03	2.02E+03
<b>Biased Statistics</b>							
Average Biased	3.74E+03	4.11E+03	3.98E+03	4.33E+03	5.60E+03	6.03E+03	3.53E+03
Std Dev Biased	1.02E+03	1.97E+03	2.12E+03	2.15E+03	4.46E+03	6.63E+03	1.24E+03
Ps90%/90% (+KTL) Biased	6.54E+03	9.52E+03	9.80E+03	1.02E+04	1.78E+04	2.42E+04	6.95E+03
Ps90%/90% (-KTL) Biased	9.51E+02	-1.30E+03	-1.84E+03	-1.55E+03	-6.63E+03	-1.21E+04	1.21E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	4.32E+03	4.71E+03	3.84E+03	3.72E+03	4.69E+03	3.88E+03	4.20E+03
Std Dev Un-Biased	1.80E+03	2.81E+03	1.22E+03	1.33E+03	2.32E+03	1.72E+03	1.62E+03
Ps90%/90% (+KTL) Un-Biased	9.26E+03	1.24E+04	7.19E+03	7.38E+03	1.10E+04	8.60E+03	8.63E+03
Ps90%/90% (-KTL) Un-Biased	-6.16E+02	-3.00E+03	4.77E+02	6.12E+01	-1.67E+03	-8.42E+02	-2.32E+02
<b>Specification MIN</b>	<b>6.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>	<b>3.00E+02</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

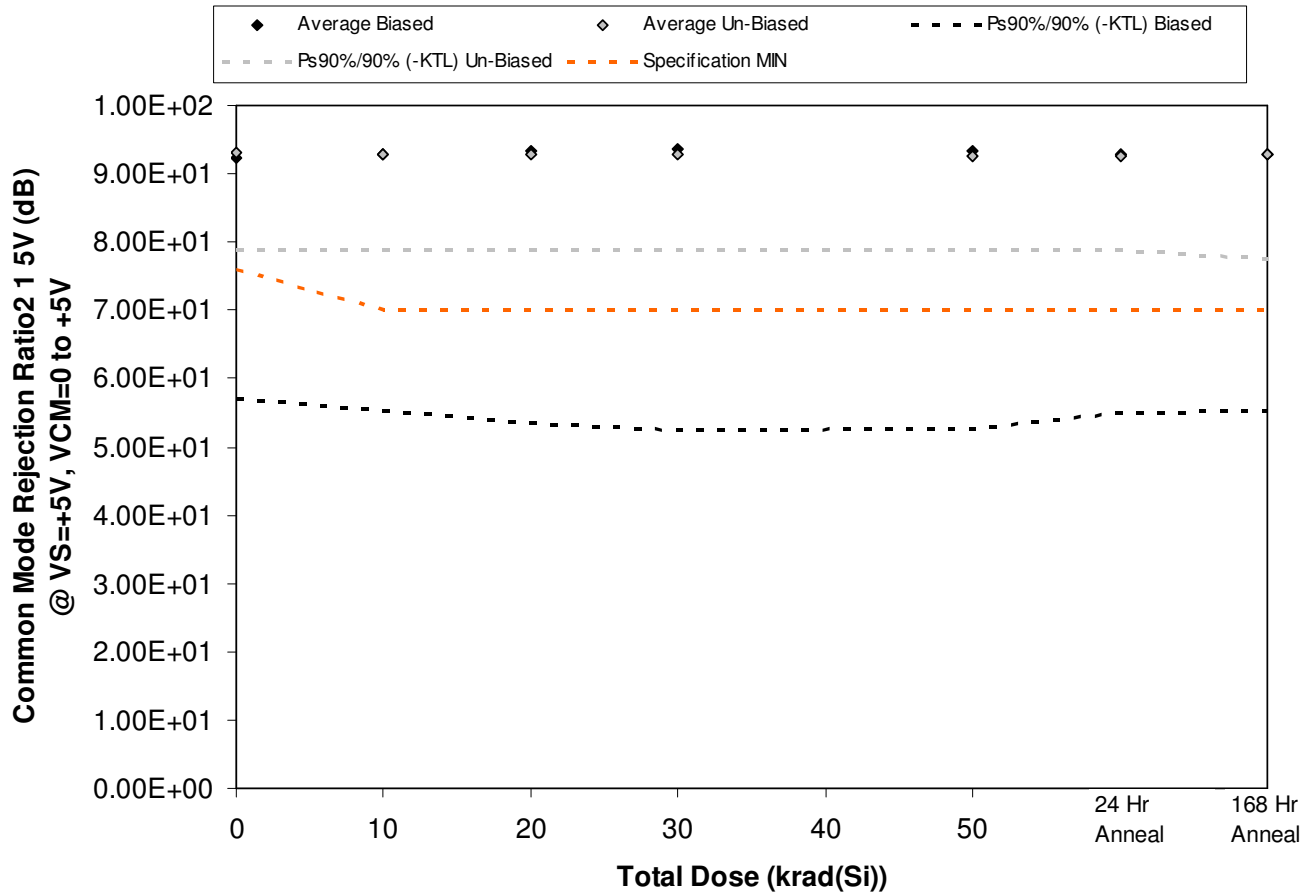


Figure 5.165. Plot of Common Mode Rejection Ratio 2 1 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.165. Raw data for Common Mode Rejection Ratio2 1 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Common Mode Rejection Ratio2 1 5V (dB) @ VS=+5V, VCM=0 to +5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	8.50E+01	8.50E+01	8.51E+01	8.52E+01	8.52E+01	8.52E+01	8.53E+01
563	9.18E+01	9.18E+01	9.18E+01	9.19E+01	9.16E+01	9.16E+01	9.11E+01
564	8.72E+01	8.73E+01	8.73E+01	8.73E+01	8.71E+01	8.71E+01	8.73E+01
567	1.15E+02	1.17E+02	1.18E+02	1.20E+02	1.19E+02	1.17E+02	1.17E+02
569	8.34E+01	8.35E+01	8.34E+01	8.35E+01	8.33E+01	8.33E+01	8.35E+01
570	1.00E+02	1.00E+02	9.98E+01	9.96E+01	9.84E+01	9.82E+01	1.00E+02
571	8.95E+01	8.94E+01	8.92E+01	8.91E+01	8.87E+01	8.87E+01	8.86E+01
572	8.67E+01	8.66E+01	8.65E+01	8.65E+01	8.63E+01	8.63E+01	8.66E+01
573	9.45E+01	9.47E+01	9.48E+01	9.50E+01	9.59E+01	9.60E+01	9.62E+01
574	9.41E+01	9.40E+01	9.39E+01	9.37E+01	9.31E+01	9.32E+01	9.30E+01
584	8.74E+01	8.73E+01	8.72E+01	8.72E+01	8.71E+01	8.71E+01	8.71E+01
585	9.46E+01	9.41E+01	9.41E+01	9.40E+01	9.39E+01	9.38E+01	9.39E+01
<b>Biased Statistics</b>							
Average Biased	9.25E+01	9.29E+01	9.32E+01	9.35E+01	9.33E+01	9.28E+01	9.28E+01
Std Dev Biased	1.29E+01	1.37E+01	1.45E+01	1.50E+01	1.48E+01	1.38E+01	1.37E+01
Ps90%/90% (+KTL) Biased	1.28E+02	1.31E+02	1.33E+02	1.35E+02	1.34E+02	1.31E+02	1.30E+02
Ps90%/90% (-KTL) Biased	5.71E+01	5.52E+01	5.36E+01	5.23E+01	5.27E+01	5.49E+01	5.52E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	9.30E+01	9.29E+01	9.28E+01	9.28E+01	9.25E+01	9.25E+01	9.29E+01
Std Dev Un-Biased	5.21E+00	5.19E+00	5.16E+00	5.14E+00	4.99E+00	4.99E+00	5.62E+00
Ps90%/90% (+KTL) Un-Biased	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.06E+02	1.06E+02	1.08E+02
Ps90%/90% (-KTL) Un-Biased	7.88E+01	7.87E+01	7.87E+01	7.87E+01	7.88E+01	7.88E+01	7.75E+01
<b>Specification MIN</b>	<b>7.60E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

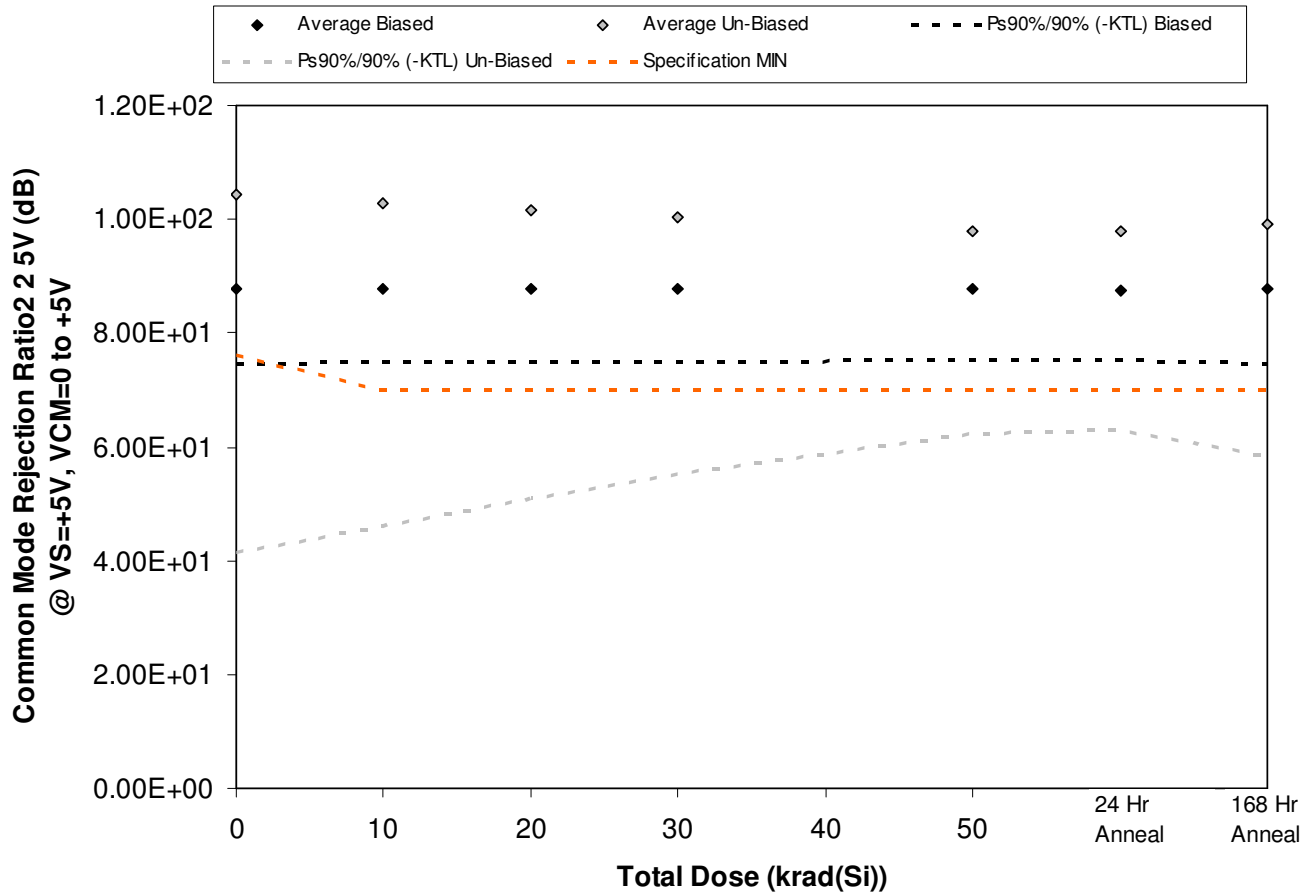


Figure 5.166. Plot of Common Mode Rejection Ratio 2 2 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.166. Raw data for Common Mode Rejection Ratio2 2 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Common Mode Rejection Ratio2 2 5V (dB) @ VS=+5V, VCM=0 to +5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	8.44E+01	8.44E+01	8.45E+01	8.45E+01	8.45E+01	8.45E+01	8.44E+01
563	9.38E+01	9.36E+01	9.37E+01	9.37E+01	9.36E+01	9.36E+01	9.43E+01
564	9.08E+01	9.09E+01	9.08E+01	9.09E+01	9.07E+01	9.06E+01	9.11E+01
567	8.71E+01	8.72E+01	8.72E+01	8.72E+01	8.70E+01	8.70E+01	8.75E+01
569	8.22E+01	8.22E+01	8.23E+01	8.23E+01	8.24E+01	8.23E+01	8.24E+01
570	1.39E+02	1.34E+02	1.27E+02	1.21E+02	1.13E+02	1.13E+02	1.19E+02
571	1.17E+02	1.14E+02	1.14E+02	1.14E+02	1.10E+02	1.09E+02	1.10E+02
572	8.73E+01	8.72E+01	8.72E+01	8.71E+01	8.71E+01	8.71E+01	8.72E+01
573	8.51E+01	8.50E+01	8.50E+01	8.49E+01	8.48E+01	8.48E+01	8.49E+01
574	9.37E+01	9.39E+01	9.41E+01	9.41E+01	9.49E+01	9.50E+01	9.47E+01
584	8.18E+01	8.17E+01	8.17E+01	8.16E+01	8.17E+01	8.16E+01	8.16E+01
585	8.44E+01	8.43E+01	8.43E+01	8.42E+01	8.43E+01	8.42E+01	8.42E+01
<b>Biased Statistics</b>							
Average Biased	8.76E+01	8.77E+01	8.77E+01	8.77E+01	8.76E+01	8.76E+01	8.79E+01
Std Dev Biased	4.71E+00	4.64E+00	4.63E+00	4.65E+00	4.55E+00	4.54E+00	4.84E+00
Ps90%/90% (+KTL) Biased	1.01E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.00E+02	1.01E+02
Ps90%/90% (-KTL) Biased	7.47E+01	7.49E+01	7.50E+01	7.50E+01	7.51E+01	7.52E+01	7.46E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.04E+02	1.03E+02	1.02E+02	1.00E+02	9.80E+01	9.78E+01	9.92E+01
Std Dev Un-Biased	2.29E+01	2.07E+01	1.85E+01	1.64E+01	1.30E+01	1.27E+01	1.49E+01
Ps90%/90% (+KTL) Un-Biased	1.67E+02	1.59E+02	1.52E+02	1.45E+02	1.34E+02	1.33E+02	1.40E+02
Ps90%/90% (-KTL) Un-Biased	4.15E+01	4.60E+01	5.09E+01	5.53E+01	6.24E+01	6.29E+01	5.84E+01
<b>Specification MIN</b>	<b>7.60E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



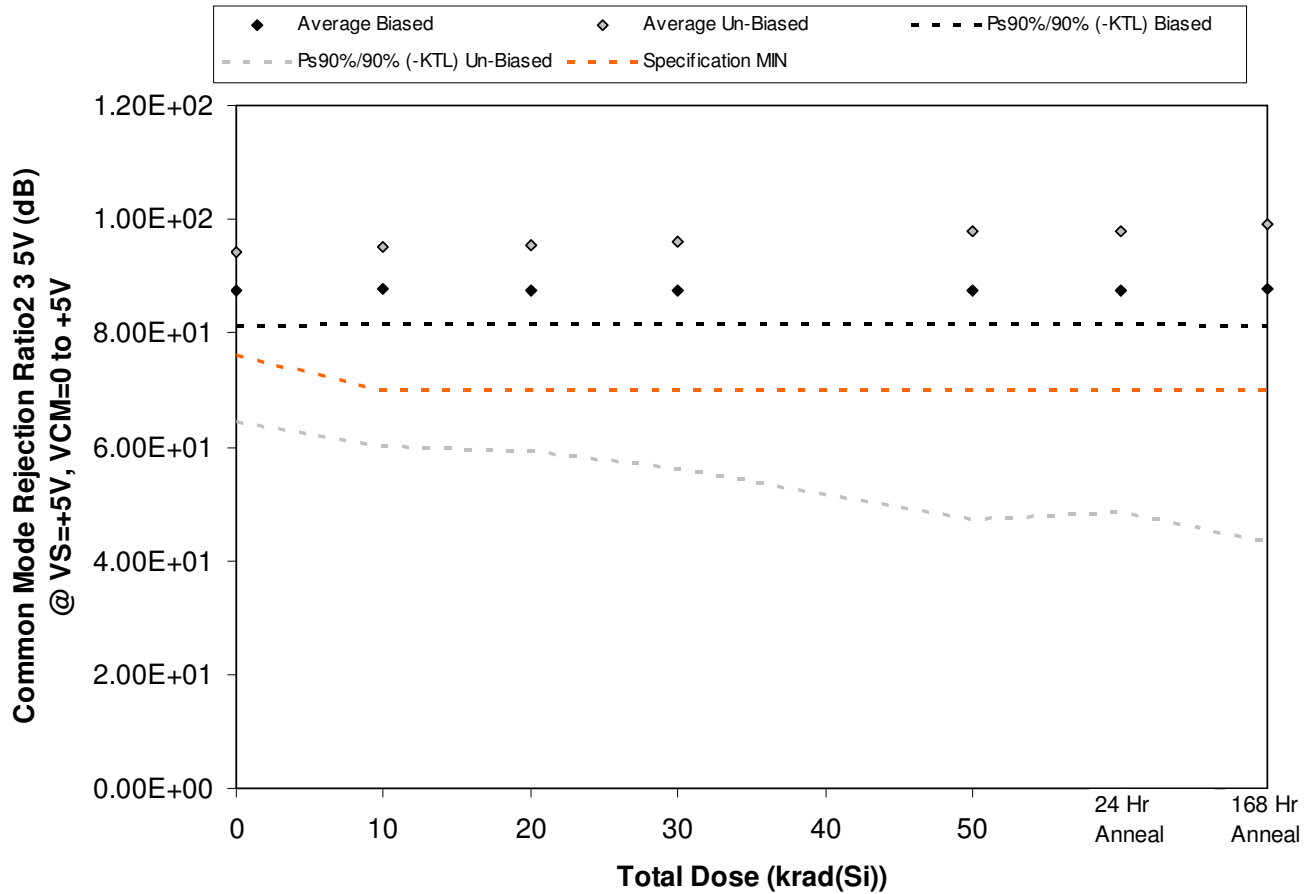


Figure 5.167. Plot of Common Mode Rejection Ratio2 3 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.167. Raw data for Common Mode Rejection Ratio2 3 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Common Mode Rejection Ratio2 3 5V (dB) @ VS=+5V, VCM=0 to +5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	8.66E+01	8.65E+01	8.66E+01	8.65E+01	8.63E+01	8.63E+01	8.64E+01
563	8.72E+01	8.72E+01	8.71E+01	8.72E+01	8.72E+01	8.71E+01	8.73E+01
564	8.56E+01	8.56E+01	8.56E+01	8.56E+01	8.55E+01	8.55E+01	8.56E+01
567	8.72E+01	8.74E+01	8.74E+01	8.74E+01	8.75E+01	8.75E+01	8.75E+01
569	9.14E+01	9.14E+01	9.13E+01	9.14E+01	9.12E+01	9.11E+01	9.16E+01
570	8.36E+01	8.35E+01	8.35E+01	8.35E+01	8.35E+01	8.35E+01	8.39E+01
571	8.66E+01	8.65E+01	8.64E+01	8.63E+01	8.61E+01	8.61E+01	8.64E+01
572	1.12E+02	1.16E+02	1.17E+02	1.20E+02	1.29E+02	1.28E+02	1.34E+02
573	9.45E+01	9.42E+01	9.42E+01	9.41E+01	9.36E+01	9.37E+01	9.33E+01
574	9.56E+01	9.59E+01	9.61E+01	9.64E+01	9.71E+01	9.74E+01	9.83E+01
584	1.20E+02	1.17E+02	1.16E+02	1.16E+02	1.13E+02	1.12E+02	1.12E+02
585	9.26E+01	9.21E+01	9.22E+01	9.21E+01	9.20E+01	9.19E+01	9.20E+01
<b>Biased Statistics</b>							
Average Biased	8.76E+01	8.76E+01	8.76E+01	8.76E+01	8.75E+01	8.75E+01	8.77E+01
Std Dev Biased	2.24E+00	2.23E+00	2.19E+00	2.21E+00	2.17E+00	2.16E+00	2.33E+00
Ps90%/90% (+KTL) Biased	9.38E+01	9.38E+01	9.36E+01	9.37E+01	9.35E+01	9.34E+01	9.41E+01
Ps90%/90% (-KTL) Biased	8.15E+01	8.15E+01	8.16E+01	8.16E+01	8.16E+01	8.16E+01	8.13E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	9.43E+01	9.52E+01	9.55E+01	9.61E+01	9.80E+01	9.78E+01	9.92E+01
Std Dev Un-Biased	1.09E+01	1.27E+01	1.33E+01	1.46E+01	1.85E+01	1.79E+01	2.04E+01
Ps90%/90% (+KTL) Un-Biased	1.24E+02	1.30E+02	1.32E+02	1.36E+02	1.49E+02	1.47E+02	1.55E+02
Ps90%/90% (-KTL) Un-Biased	6.45E+01	6.03E+01	5.91E+01	5.62E+01	4.74E+01	4.86E+01	4.32E+01
<b>Specification MIN</b>	<b>7.60E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

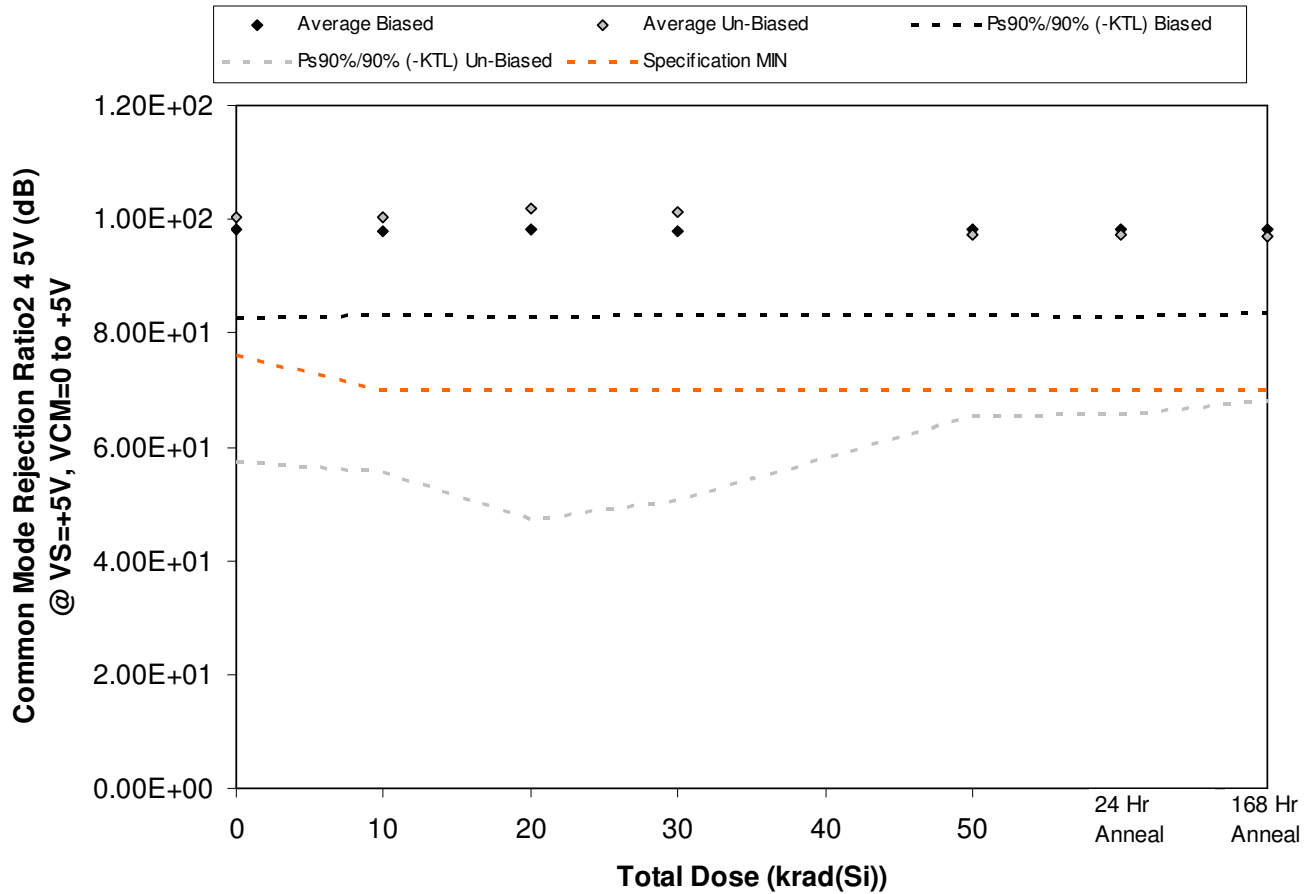


Figure 5.168. Plot of Common Mode Rejection Ratio 2 4 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.168. Raw data for Common Mode Rejection Ratio2 4 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Common Mode Rejection Ratio2 4 5V (dB) @ VS=+5V, VCM=0 to +5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	8.88E+01	8.88E+01	8.87E+01	8.88E+01	8.90E+01	8.91E+01	8.91E+01
563	9.90E+01	9.88E+01	9.89E+01	9.92E+01	9.84E+01	9.80E+01	9.90E+01
564	1.04E+02	1.03E+02	1.03E+02	1.03E+02	1.03E+02	1.04E+02	1.01E+02
567	9.90E+01	9.88E+01	9.89E+01	9.89E+01	9.96E+01	9.98E+01	9.89E+01
569	9.97E+01	1.00E+02	1.00E+02	1.00E+02	1.00E+02	9.99E+01	1.03E+02
570	1.26E+02	1.28E+02	1.36E+02	1.33E+02	1.16E+02	1.16E+02	1.14E+02
571	9.18E+01	9.18E+01	9.16E+01	9.15E+01	9.11E+01	9.12E+01	9.19E+01
572	9.69E+01	9.63E+01	9.60E+01	9.57E+01	9.48E+01	9.49E+01	9.53E+01
573	1.00E+02	9.97E+01	1.00E+02	1.00E+02	9.91E+01	9.90E+01	9.84E+01
574	8.59E+01	8.59E+01	8.59E+01	8.58E+01	8.57E+01	8.57E+01	8.54E+01
584	8.80E+01	8.79E+01	8.79E+01	8.78E+01	8.78E+01	8.77E+01	8.77E+01
585	8.96E+01	8.92E+01	8.92E+01	8.92E+01	8.93E+01	8.91E+01	8.91E+01
<b>Biased Statistics</b>							
Average Biased	9.81E+01	9.80E+01	9.81E+01	9.81E+01	9.81E+01	9.83E+01	9.83E+01
Std Dev Biased	5.63E+00	5.45E+00	5.55E+00	5.41E+00	5.42E+00	5.66E+00	5.41E+00
Ps90%/90% (+KTL) Biased	1.14E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.14E+02	1.13E+02
Ps90%/90% (-KTL) Biased	8.27E+01	8.30E+01	8.29E+01	8.32E+01	8.32E+01	8.27E+01	8.34E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.00E+02	1.00E+02	1.02E+02	1.01E+02	9.74E+01	9.74E+01	9.69E+01
Std Dev Un-Biased	1.56E+01	1.63E+01	1.99E+01	1.84E+01	1.16E+01	1.16E+01	1.05E+01
Ps90%/90% (+KTL) Un-Biased	1.43E+02	1.45E+02	1.57E+02	1.52E+02	1.29E+02	1.29E+02	1.26E+02
Ps90%/90% (-KTL) Un-Biased	5.74E+01	5.56E+01	4.73E+01	5.07E+01	6.55E+01	6.56E+01	6.82E+01
<b>Specification MIN</b>	<b>7.60E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

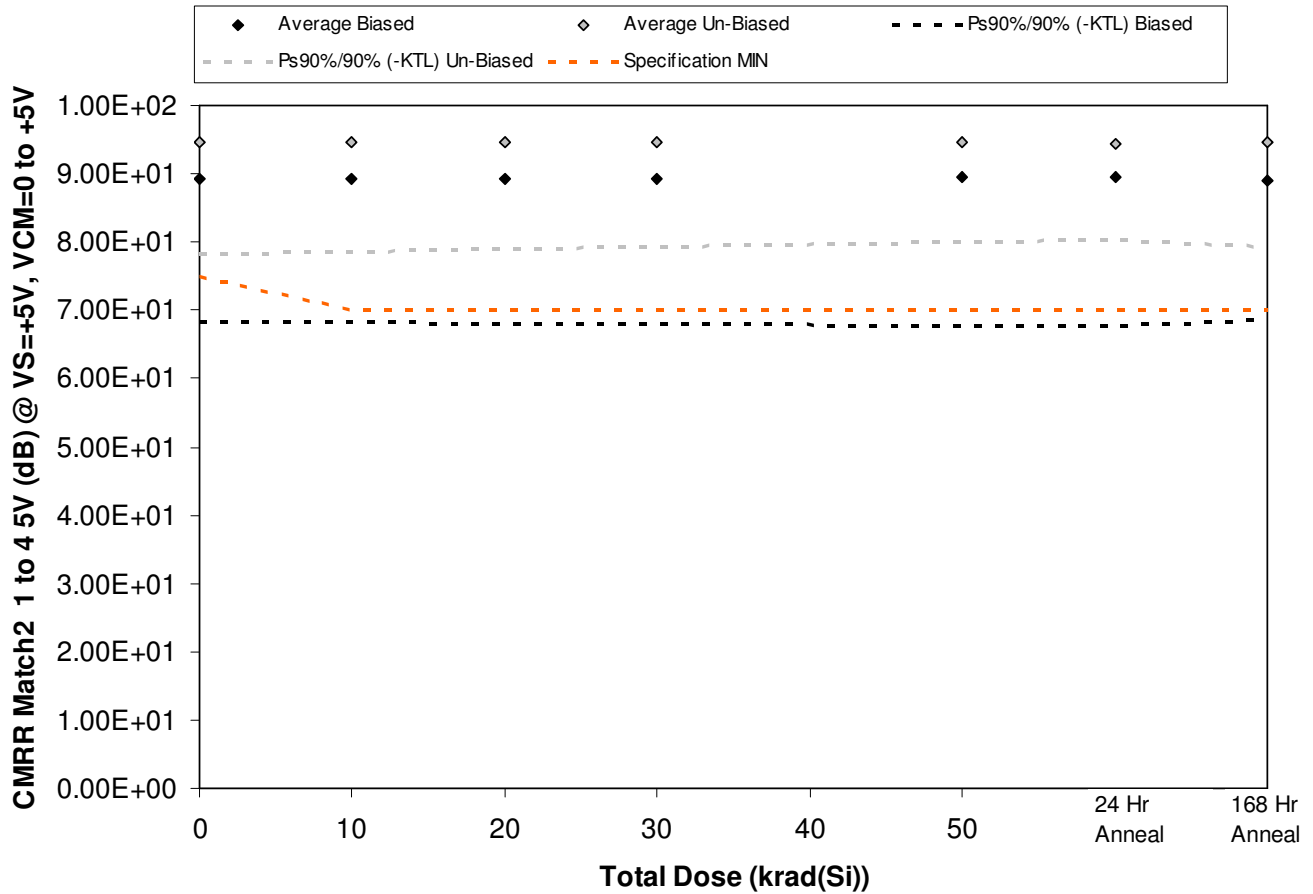


Figure 5.169. Plot of CMRR Match2 1 to 4 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.169. Raw data for CMRR Match2 1 to 4 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

CMRR Match2 1 to 4 5V (dB) @ VS=+5V, VCM=0 to +5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	8.07E+01	8.07E+01	8.07E+01	8.08E+01	8.09E+01	8.09E+01	8.10E+01
563	9.68E+01	9.68E+01	9.69E+01	9.68E+01	9.69E+01	9.72E+01	9.56E+01
564	8.60E+01	8.60E+01	8.60E+01	8.60E+01	8.59E+01	8.60E+01	8.57E+01
567	9.77E+01	9.78E+01	9.80E+01	9.81E+01	9.87E+01	9.87E+01	9.79E+01
569	8.49E+01	8.49E+01	8.48E+01	8.48E+01	8.47E+01	8.47E+01	8.45E+01
570	9.99E+01	9.97E+01	9.99E+01	9.98E+01	9.96E+01	9.94E+01	1.03E+02
571	1.02E+02	1.02E+02	1.02E+02	1.01E+02	1.01E+02	1.01E+02	9.85E+01
572	9.00E+01	9.00E+01	9.01E+01	9.02E+01	9.05E+01	9.03E+01	9.05E+01
573	9.08E+01	9.08E+01	9.10E+01	9.12E+01	9.13E+01	9.14E+01	9.13E+01
574	9.02E+01	9.02E+01	9.03E+01	9.03E+01	9.05E+01	9.04E+01	9.02E+01
584	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
585	9.67E+01	9.64E+01	9.65E+01	9.66E+01	9.70E+01	9.66E+01	9.67E+01
<b>Biased Statistics</b>							
Average Biased	8.92E+01	8.92E+01	8.93E+01	8.93E+01	8.94E+01	8.95E+01	8.89E+01
Std Dev Biased	7.60E+00	7.64E+00	7.74E+00	7.72E+00	7.91E+00	7.94E+00	7.39E+00
Ps90%/90% (+KTL) Biased	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.11E+02	1.11E+02	1.09E+02
Ps90%/90% (-KTL) Biased	6.84E+01	6.83E+01	6.81E+01	6.81E+01	6.77E+01	6.77E+01	6.86E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	9.46E+01	9.45E+01	9.46E+01	9.46E+01	9.46E+01	9.44E+01	9.46E+01
Std Dev Un-Biased	5.94E+00	5.80E+00	5.70E+00	5.56E+00	5.24E+00	5.17E+00	5.61E+00
Ps90%/90% (+KTL) Un-Biased	1.11E+02	1.10E+02	1.10E+02	1.10E+02	1.09E+02	1.09E+02	1.10E+02
Ps90%/90% (-KTL) Un-Biased	7.83E+01	7.86E+01	7.90E+01	7.93E+01	8.02E+01	8.03E+01	7.92E+01
<b>Specification MIN</b>	<b>7.50E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

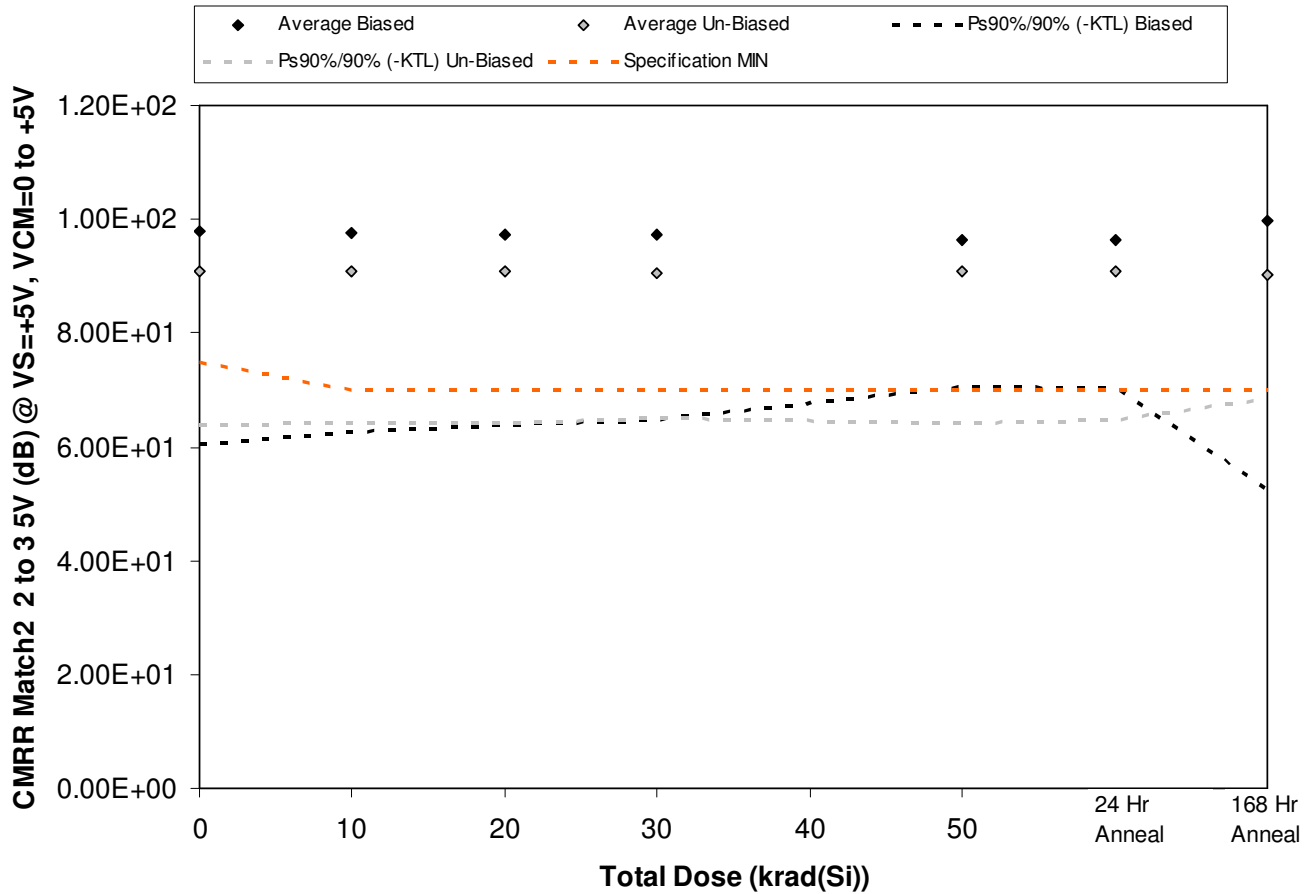


Figure 5.170. Plot of CMRR Match2 2 to 3 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.170. Raw data for CMRR Match2 2 to 3 5V (dB) @ VS=+5V, VCM=0 to +5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

CMRR Match2 2 to 3 5V (dB) @ VS=+5V, VCM=0 to +5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	9.72E+01	9.77E+01	9.79E+01	9.82E+01	9.90E+01	9.90E+01	9.80E+01
563	9.27E+01	9.29E+01	9.26E+01	9.27E+01	9.28E+01	9.27E+01	9.24E+01
564	9.24E+01	9.24E+01	9.25E+01	9.24E+01	9.25E+01	9.24E+01	9.22E+01
567	1.21E+02	1.19E+02	1.18E+02	1.17E+02	1.11E+02	1.11E+02	1.30E+02
569	8.58E+01	8.59E+01	8.61E+01	8.61E+01	8.63E+01	8.63E+01	8.60E+01
570	8.36E+01	8.36E+01	8.36E+01	8.36E+01	8.38E+01	8.38E+01	8.40E+01
571	8.69E+01	8.69E+01	8.67E+01	8.67E+01	8.67E+01	8.67E+01	8.70E+01
572	8.68E+01	8.69E+01	8.69E+01	8.70E+01	8.72E+01	8.72E+01	8.73E+01
573	8.87E+01	8.87E+01	8.86E+01	8.86E+01	8.87E+01	8.86E+01	8.90E+01
574	1.08E+02	1.08E+02	1.08E+02	1.07E+02	1.08E+02	1.07E+02	1.04E+02
584	8.19E+01	8.18E+01	8.18E+01	8.18E+01	8.19E+01	8.19E+01	8.19E+01
585	8.87E+01	8.88E+01	8.87E+01	8.87E+01	8.88E+01	8.89E+01	8.88E+01
<b>Biased Statistics</b>							
Average Biased	9.79E+01	9.76E+01	9.74E+01	9.73E+01	9.63E+01	9.64E+01	9.96E+01
Std Dev Biased	1.37E+01	1.28E+01	1.23E+01	1.19E+01	9.41E+00	9.51E+00	1.73E+01
Ps90%/90% (+KTL) Biased	1.35E+02	1.33E+02	1.31E+02	1.30E+02	1.22E+02	1.22E+02	1.47E+02
Ps90%/90% (-KTL) Biased	6.04E+01	6.26E+01	6.38E+01	6.46E+01	7.05E+01	7.03E+01	5.23E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	9.08E+01	9.07E+01	9.07E+01	9.05E+01	9.08E+01	9.07E+01	9.03E+01
Std Dev Un-Biased	9.78E+00	9.66E+00	9.65E+00	9.33E+00	9.70E+00	9.43E+00	8.02E+00
Ps90%/90% (+KTL) Un-Biased	1.18E+02	1.17E+02	1.17E+02	1.16E+02	1.17E+02	1.17E+02	1.12E+02
Ps90%/90% (-KTL) Un-Biased	6.39E+01	6.42E+01	6.42E+01	6.49E+01	6.43E+01	6.49E+01	6.83E+01
<b>Specification MIN</b>	<b>7.50E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>	<b>7.00E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



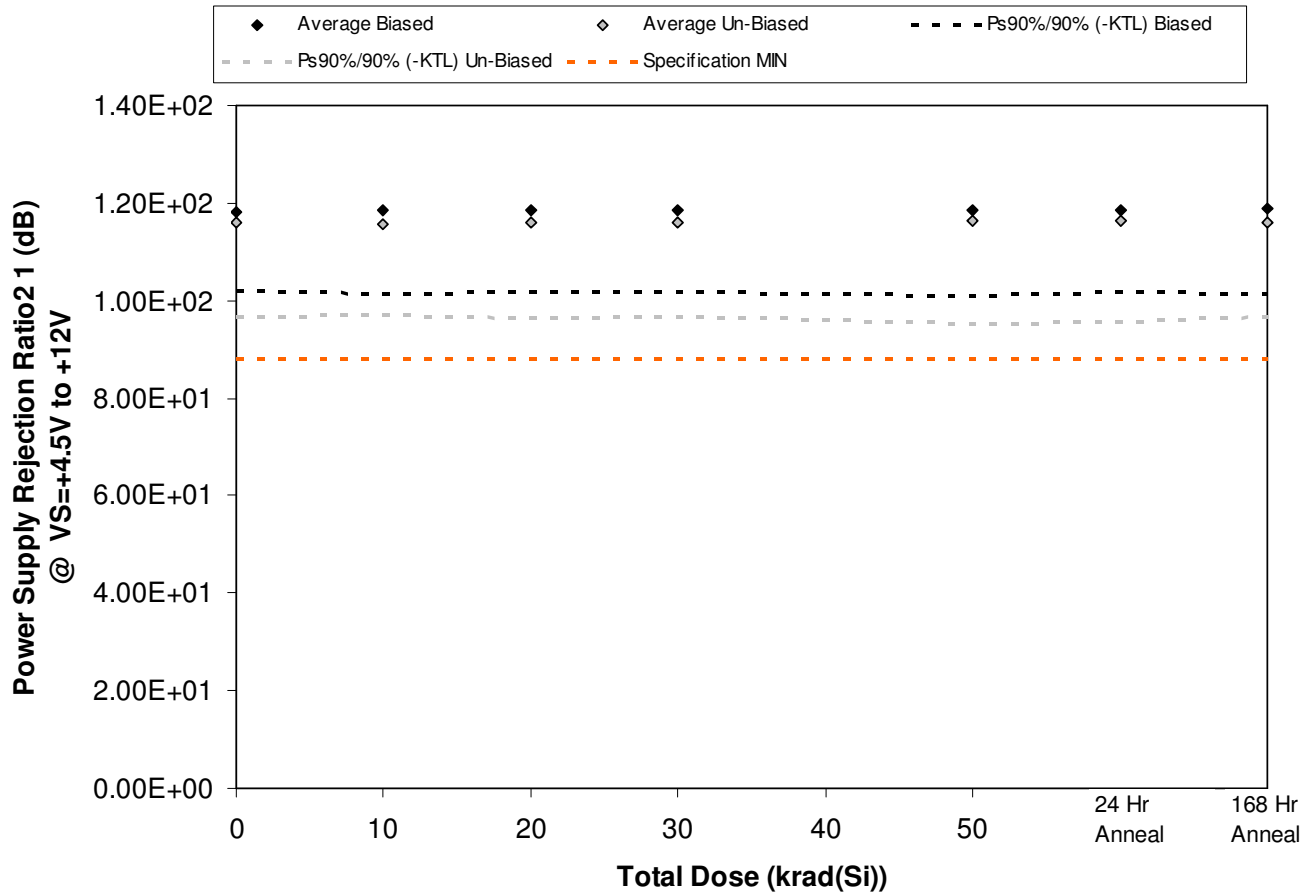


Figure 5.171. Plot of Power Supply Rejection Ratio2 1 (dB) @ VS=+4.5V to +12V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.171. Raw data for Power Supply Rejection Ratio2 1 (dB) @ VS=+4.5V to +12V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Power Supply Rejection Ratio2 1 (dB) @ VS=+4.5V to +12V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.28E+02	1.29E+02	1.29E+02	1.29E+02	1.29E+02	1.29E+02	1.29E+02
563	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02
564	1.16E+02	1.16E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02
567	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02
569	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02
570	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
571	1.25E+02	1.25E+02	1.25E+02	1.25E+02	1.27E+02	1.27E+02	1.25E+02
572	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02
573	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02
574	1.22E+02	1.22E+02	1.22E+02	1.22E+02	1.22E+02	1.22E+02	1.22E+02
584	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02
585	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02
<b>Biased Statistics</b>							
Average Biased	1.18E+02	1.18E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02	1.19E+02
Std Dev Biased	5.93E+00	6.20E+00	6.16E+00	6.16E+00	6.41E+00	6.14E+00	6.43E+00
Ps90%/90% (+KTL) Biased	1.35E+02	1.35E+02	1.35E+02	1.35E+02	1.36E+02	1.35E+02	1.36E+02
Ps90%/90% (-KTL) Biased	1.02E+02	1.01E+02	1.02E+02	1.02E+02	1.01E+02	1.02E+02	1.01E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02
Std Dev Un-Biased	6.98E+00	6.79E+00	7.15E+00	7.00E+00	7.68E+00	7.53E+00	7.13E+00
Ps90%/90% (+KTL) Un-Biased	1.35E+02	1.34E+02	1.36E+02	1.35E+02	1.37E+02	1.37E+02	1.36E+02
Ps90%/90% (-KTL) Un-Biased	9.67E+01	9.72E+01	9.63E+01	9.67E+01	9.52E+01	9.57E+01	9.65E+01
<b>Specification MIN</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

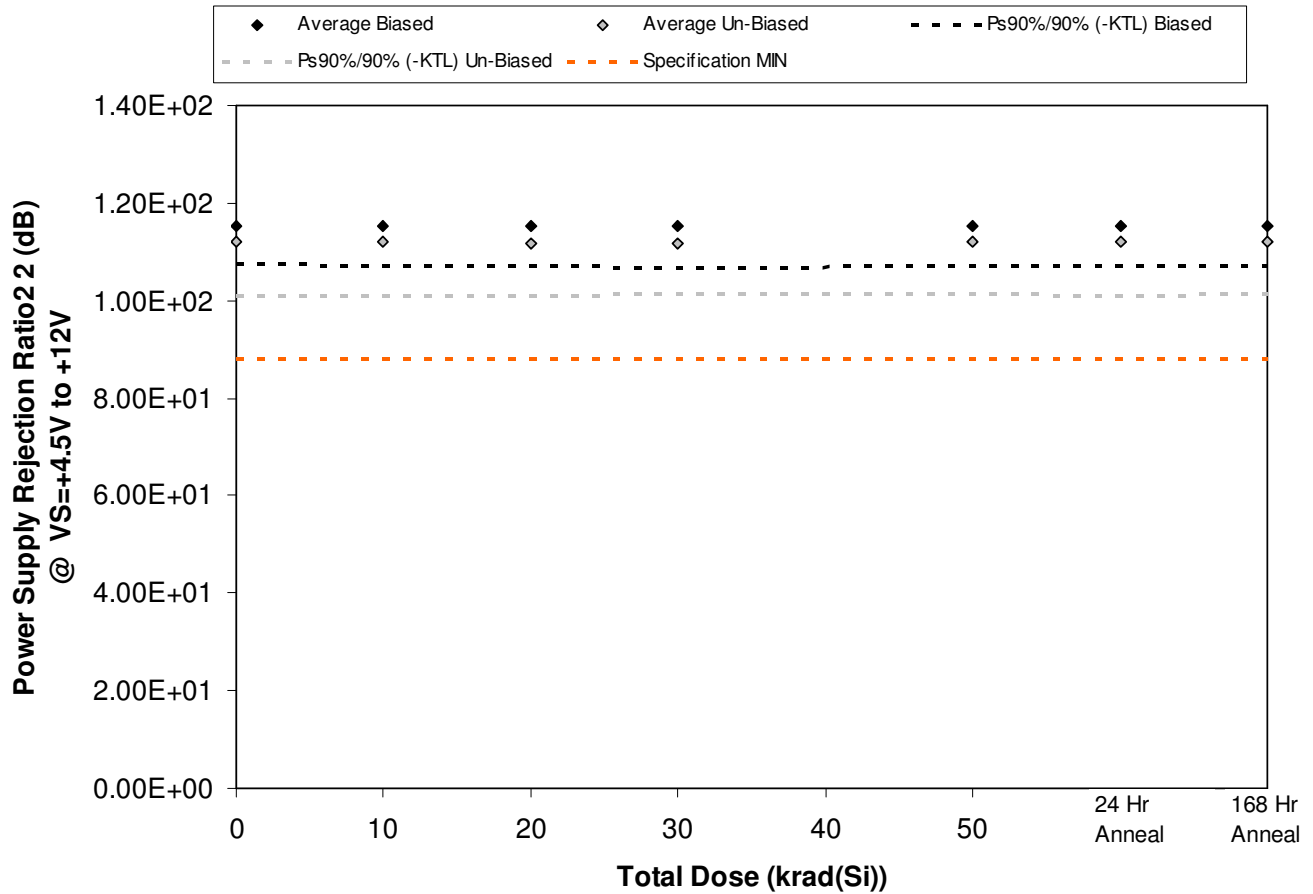


Figure 5.172. Plot of Power Supply Rejection Ratio2 2 (dB) @ VS=+4.5V to +12V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.172. Raw data for Power Supply Rejection Ratio2 2 (dB) @ VS=+4.5V to +12V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Power Supply Rejection Ratio2 2 (dB) @ VS=+4.5V to +12V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02
563	1.17E+02	1.18E+02	1.17E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02
564	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.19E+02	1.18E+02	1.19E+02
567	1.14E+02	1.13E+02	1.13E+02	1.13E+02	1.14E+02	1.14E+02	1.14E+02
569	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02
570	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02
571	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
572	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.19E+02	1.18E+02
573	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.09E+02	1.09E+02	1.09E+02
574	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
584	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02
585	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02	1.10E+02
<b>Biased Statistics</b>							
Average Biased	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02
Std Dev Biased	2.94E+00	3.04E+00	2.91E+00	3.14E+00	3.01E+00	2.99E+00	3.06E+00
Ps90%/90% (+KTL) Biased	1.23E+02	1.24E+02	1.23E+02	1.24E+02	1.24E+02	1.24E+02	1.24E+02
Ps90%/90% (-KTL) Biased	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02	1.07E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02
Std Dev Un-Biased	3.96E+00	3.96E+00	3.96E+00	3.91E+00	3.94E+00	4.02E+00	3.91E+00
Ps90%/90% (+KTL) Un-Biased	1.23E+02	1.23E+02	1.23E+02	1.23E+02	1.23E+02	1.23E+02	1.23E+02
Ps90%/90% (-KTL) Un-Biased	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02	1.01E+02
<b>Specification MIN</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

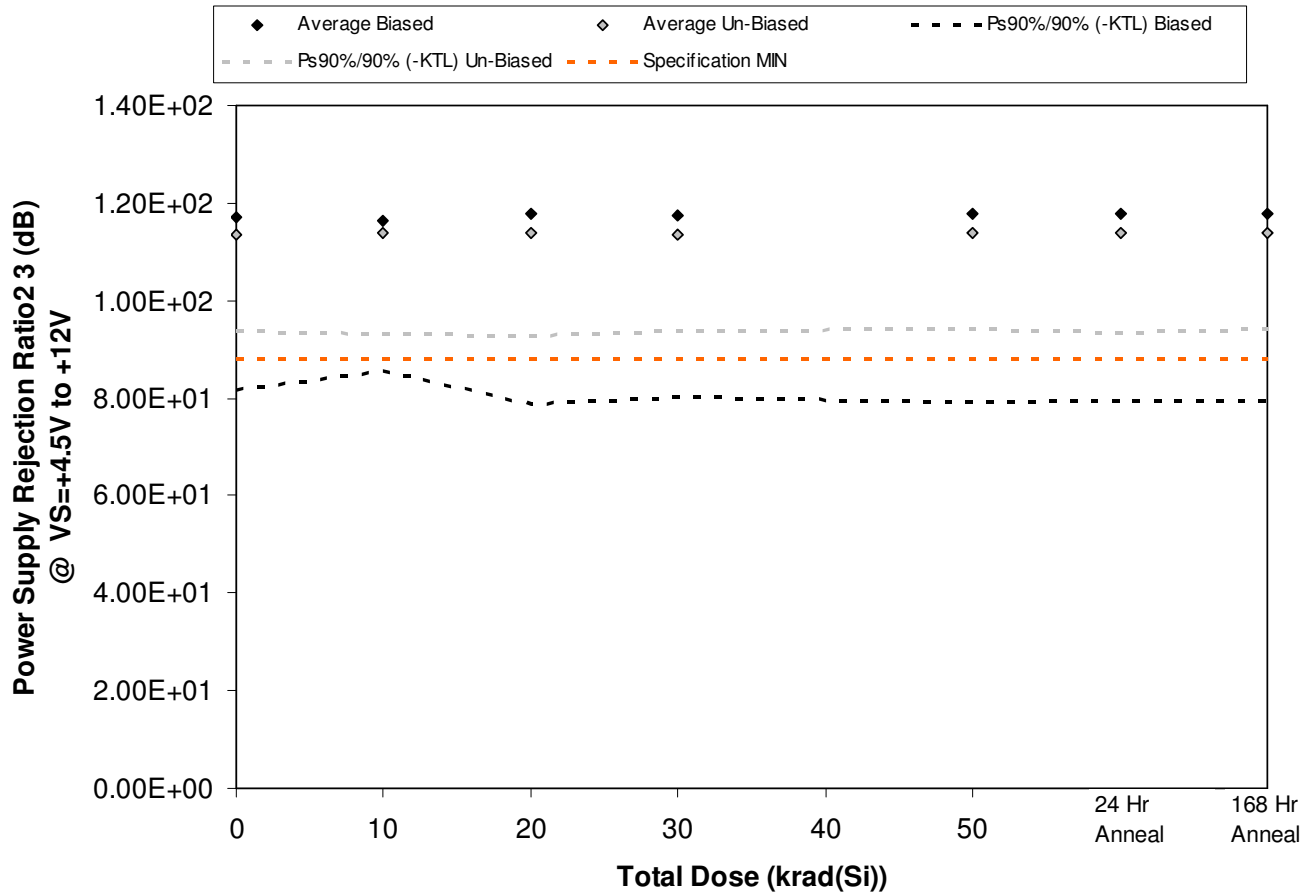


Figure 5.173. Plot of Power Supply Rejection Ratio 2 3 (dB) @ VS=+4.5V to +12V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.173. Raw data for Power Supply Rejection Ratio2 3 (dB) @ VS=+4.5V to +12V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Power Supply Rejection Ratio2 3 (dB) @ VS=+4.5V to +12V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02
563	1.40E+02	1.37E+02	1.43E+02	1.42E+02	1.43E+02	1.43E+02	1.43E+02
564	1.11E+02	1.11E+02	1.11E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02
567	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02	1.11E+02
569	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02
570	1.24E+02	1.25E+02	1.26E+02	1.24E+02	1.24E+02	1.24E+02	1.24E+02
571	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02
572	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02
573	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02	1.08E+02
574	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02
584	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02
585	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02
<b>Biased Statistics</b>							
Average Biased	1.17E+02	1.17E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02
Std Dev Biased	1.30E+01	1.13E+01	1.43E+01	1.36E+01	1.42E+01	1.40E+01	1.40E+01
Ps90%/90% (+KTL) Biased	1.53E+02	1.48E+02	1.57E+02	1.55E+02	1.57E+02	1.56E+02	1.56E+02
Ps90%/90% (-KTL) Biased	8.16E+01	8.55E+01	7.87E+01	8.03E+01	7.91E+01	7.96E+01	7.95E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02
Std Dev Un-Biased	7.20E+00	7.63E+00	7.82E+00	7.23E+00	7.20E+00	7.41E+00	7.19E+00
Ps90%/90% (+KTL) Un-Biased	1.33E+02	1.35E+02	1.35E+02	1.33E+02	1.34E+02	1.34E+02	1.33E+02
Ps90%/90% (-KTL) Un-Biased	9.39E+01	9.30E+01	9.26E+01	9.38E+01	9.41E+01	9.36E+01	9.41E+01
<b>Specification MIN</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

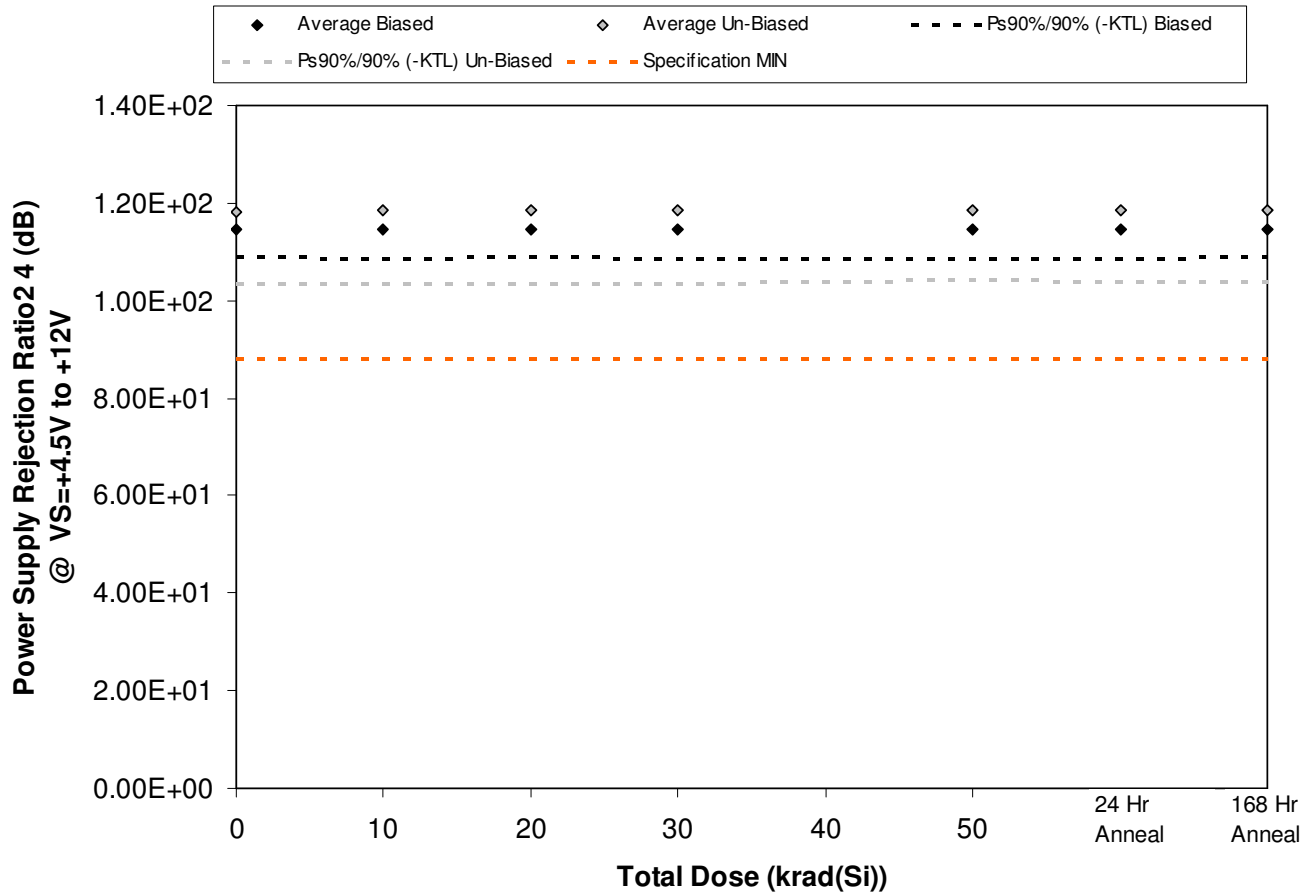


Figure 5.174. Plot of Power Supply Rejection Ratio2 4 (dB) @ VS=+4.5V to +12V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.174. Raw data for Power Supply Rejection Ratio2 4 (dB) @ VS=+4.5V to +12V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Power Supply Rejection Ratio2 4 (dB) @ VS=+4.5V to +12V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02
563	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02
564	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02
567	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02
569	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02	1.13E+02
570	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02
571	1.26E+02	1.26E+02	1.27E+02	1.26E+02	1.26E+02	1.26E+02	1.27E+02
572	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.18E+02
573	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02
574	1.20E+02	1.20E+02	1.21E+02	1.20E+02	1.21E+02	1.21E+02	1.21E+02
584	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02
585	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02
<b>Biased Statistics</b>							
Average Biased	1.14E+02	1.14E+02	1.15E+02	1.14E+02	1.15E+02	1.15E+02	1.15E+02
Std Dev Biased	2.10E+00	2.13E+00	2.11E+00	2.13E+00	2.25E+00	2.28E+00	2.15E+00
Ps90%/90% (+KTL) Biased	1.20E+02	1.20E+02	1.20E+02	1.20E+02	1.21E+02	1.21E+02	1.21E+02
Ps90%/90% (-KTL) Biased	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.09E+02	1.08E+02	1.09E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.18E+02	1.18E+02	1.19E+02	1.18E+02	1.18E+02	1.18E+02	1.19E+02
Std Dev Un-Biased	5.40E+00	5.43E+00	5.45E+00	5.43E+00	5.14E+00	5.32E+00	5.44E+00
Ps90%/90% (+KTL) Un-Biased	1.33E+02	1.33E+02	1.34E+02	1.33E+02	1.33E+02	1.33E+02	1.34E+02
Ps90%/90% (-KTL) Un-Biased	1.04E+02	1.04E+02	1.04E+02	1.03E+02	1.04E+02	1.04E+02	1.04E+02
<b>Specification MIN</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>	<b>8.80E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



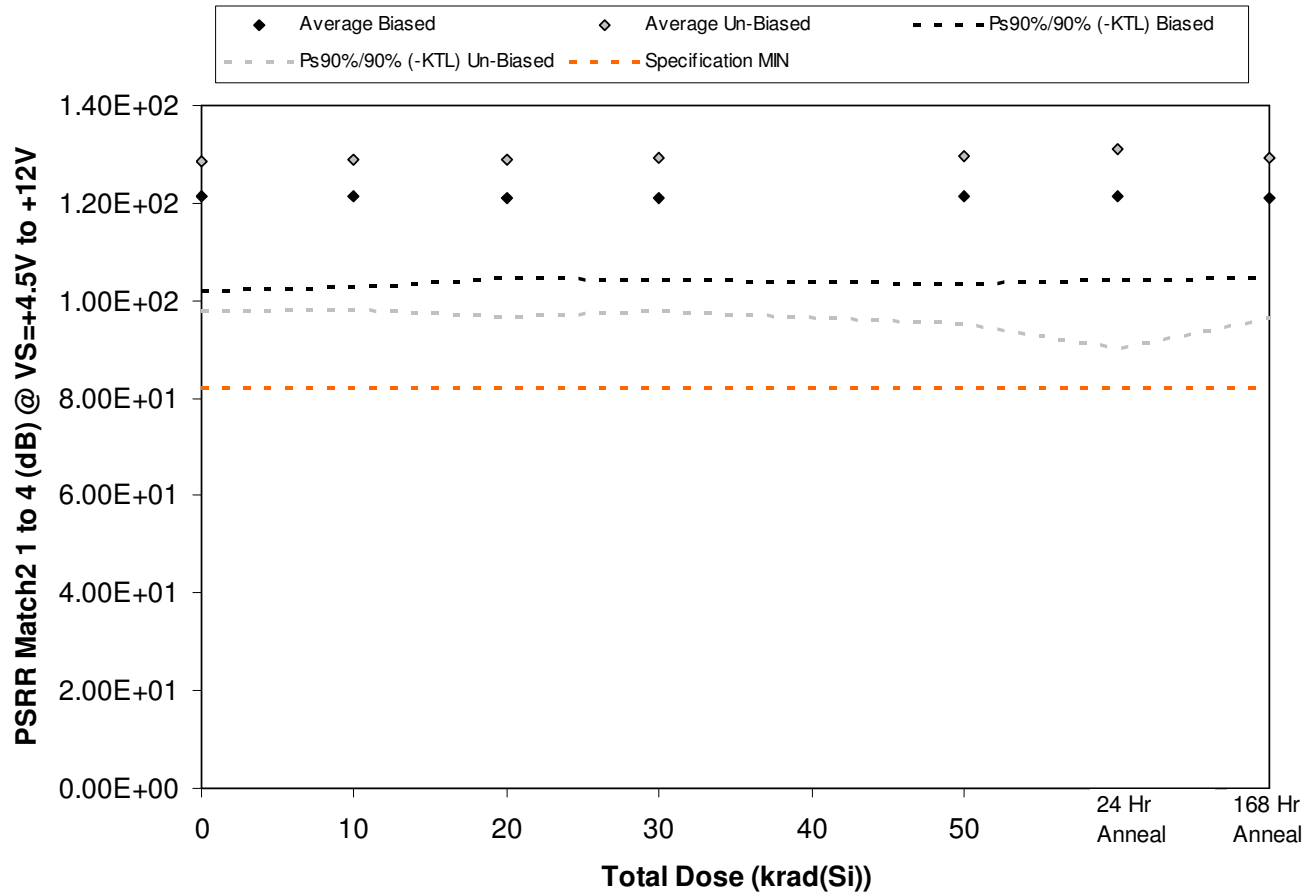


Figure 5.175. Plot of PSRR Match2 1 to 4 (dB) @ VS=+4.5V to +12V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.175. Raw data for PSRR Match2 1 to 4 (dB) @ VS=+4.5V to +12V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

PSRR Match2 1 to 4 (dB) @ VS=+4.5V to +12V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02
563	1.17E+02	1.18E+02	1.18E+02	1.18E+02	1.17E+02	1.18E+02	1.18E+02
564	1.33E+02	1.32E+02	1.30E+02	1.30E+02	1.31E+02	1.31E+02	1.30E+02
567	1.23E+02	1.23E+02	1.24E+02	1.23E+02	1.23E+02	1.24E+02	1.23E+02
569	1.20E+02	1.20E+02	1.20E+02	1.20E+02	1.21E+02	1.20E+02	1.20E+02
570	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02
571	1.41E+02	1.39E+02	1.42E+02	1.42E+02	1.44E+02	1.53E+02	1.43E+02
572	1.17E+02	1.17E+02	1.16E+02	1.17E+02	1.16E+02	1.17E+02	1.16E+02
573	1.35E+02	1.34E+02	1.33E+02	1.34E+02	1.33E+02	1.33E+02	1.34E+02
574	1.34E+02	1.38E+02	1.37E+02	1.36E+02	1.38E+02	1.36E+02	1.36E+02
584	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02	1.12E+02
585	1.35E+02	1.35E+02	1.34E+02	1.34E+02	1.33E+02	1.34E+02	1.36E+02
<b>Biased Statistics</b>							
Average Biased	1.21E+02	1.21E+02	1.21E+02	1.21E+02	1.21E+02	1.21E+02	1.21E+02
Std Dev Biased	7.04E+00	6.75E+00	5.97E+00	6.06E+00	6.49E+00	6.26E+00	5.94E+00
Ps90%/90% (+KTL) Biased	1.41E+02	1.40E+02	1.37E+02	1.38E+02	1.39E+02	1.38E+02	1.37E+02
Ps90%/90% (-KTL) Biased	1.02E+02	1.03E+02	1.05E+02	1.04E+02	1.04E+02	1.04E+02	1.05E+02
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.29E+02	1.29E+02	1.29E+02	1.29E+02	1.30E+02	1.31E+02	1.29E+02
Std Dev Un-Biased	1.12E+01	1.12E+01	1.17E+01	1.15E+01	1.26E+01	1.49E+01	1.20E+01
Ps90%/90% (+KTL) Un-Biased	1.59E+02	1.60E+02	1.61E+02	1.61E+02	1.64E+02	1.72E+02	1.62E+02
Ps90%/90% (-KTL) Un-Biased	9.79E+01	9.82E+01	9.66E+01	9.76E+01	9.51E+01	9.02E+01	9.63E+01
<b>Specification MIN</b>	<b>8.20E+01</b>	<b>8.20E+01</b>	<b>8.20E+01</b>	<b>8.20E+01</b>	<b>8.20E+01</b>	<b>8.20E+01</b>	<b>8.20E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

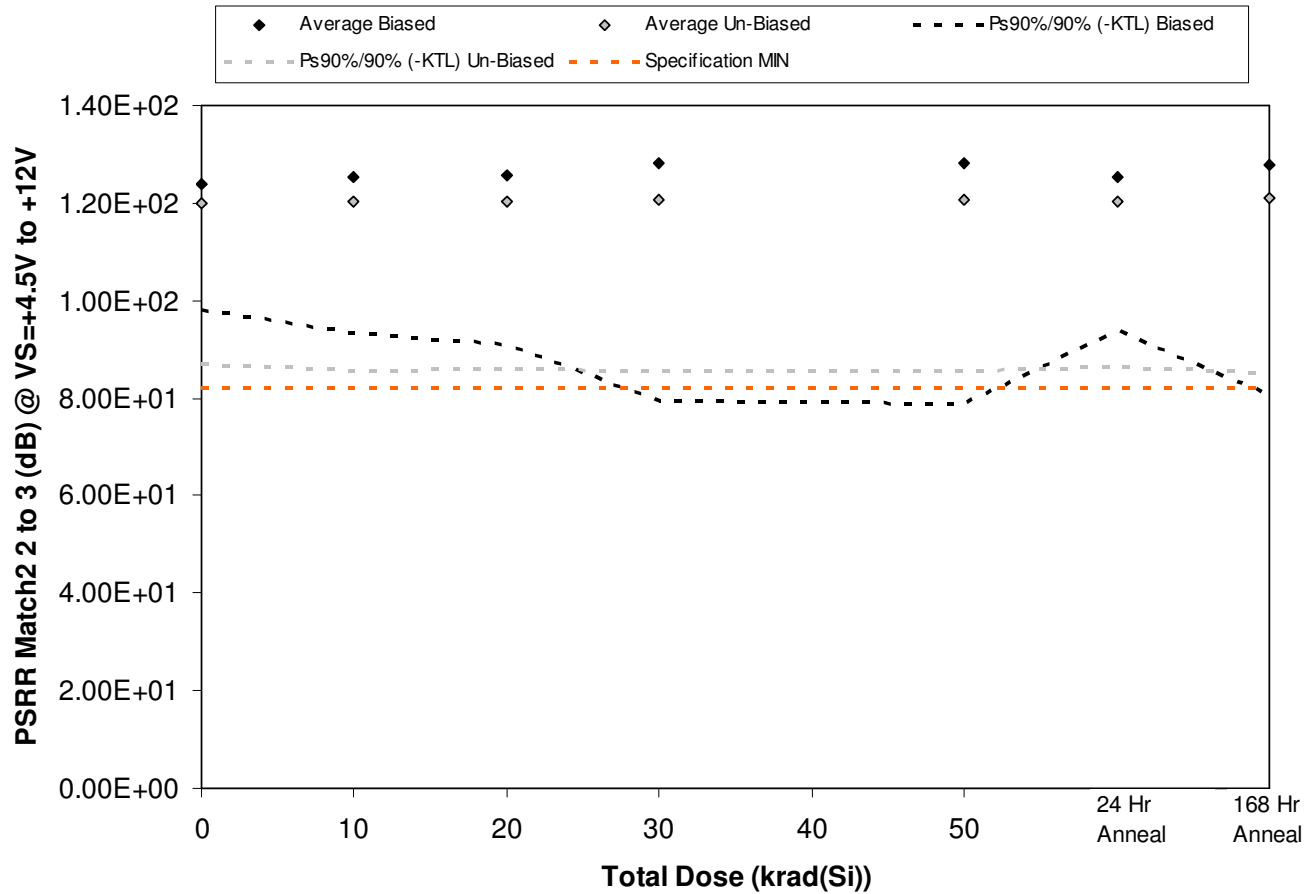


Figure 5.176. Plot of PSRR Match2 2 to 3 (dB) @ VS=+4.5V to +12V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.176. Raw data for PSRR Match2 2 to 3 (dB) @ VS=+4.5V to +12V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

PSRR Match2 2 to 3 (dB) @ VS=+4.5V to +12V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.40E+02	1.45E+02	1.48E+02	1.59E+02	1.60E+02	1.45E+02	1.58E+02
563	1.18E+02	1.19E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02	1.18E+02
564	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02	1.17E+02
567	1.24E+02	1.25E+02	1.25E+02	1.25E+02	1.24E+02	1.24E+02	1.24E+02
569	1.21E+02	1.21E+02	1.22E+02	1.22E+02	1.22E+02	1.22E+02	1.22E+02
570	1.16E+02	1.15E+02	1.15E+02	1.16E+02	1.16E+02	1.16E+02	1.16E+02
571	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02	1.14E+02
572	1.31E+02	1.32E+02	1.33E+02	1.34E+02	1.32E+02	1.33E+02	1.33E+02
573	1.34E+02	1.36E+02	1.34E+02	1.34E+02	1.36E+02	1.34E+02	1.36E+02
574	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02	1.06E+02
584	1.34E+02	1.33E+02	1.32E+02	1.32E+02	1.34E+02	1.34E+02	1.33E+02
585	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02	1.15E+02
<b>Biased Statistics</b>							
Average Biased	1.24E+02	1.25E+02	1.26E+02	1.28E+02	1.28E+02	1.25E+02	1.28E+02
Std Dev Biased	9.36E+00	1.16E+01	1.26E+01	1.78E+01	1.81E+01	1.15E+01	1.72E+01
Ps90%/90% (+KTL) Biased	1.49E+02	1.57E+02	1.60E+02	1.77E+02	1.78E+02	1.57E+02	1.75E+02
Ps90%/90% (-KTL) Biased	9.81E+01	9.35E+01	9.11E+01	7.94E+01	7.86E+01	9.39E+01	8.06E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.20E+02	1.20E+02	1.20E+02	1.21E+02	1.21E+02	1.20E+02	1.21E+02
Std Dev Un-Biased	1.19E+01	1.27E+01	1.26E+01	1.28E+01	1.28E+01	1.24E+01	1.31E+01
Ps90%/90% (+KTL) Un-Biased	1.53E+02	1.55E+02	1.55E+02	1.56E+02	1.56E+02	1.54E+02	1.57E+02
Ps90%/90% (-KTL) Un-Biased	8.71E+01	8.55E+01	8.59E+01	8.55E+01	8.56E+01	8.64E+01	8.51E+01
<b>Specification MIN</b>	<b>8.20E+01</b>	<b>8.20E+01</b>	<b>8.20E+01</b>	<b>8.20E+01</b>	<b>8.20E+01</b>	<b>8.20E+01</b>	<b>8.20E+01</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

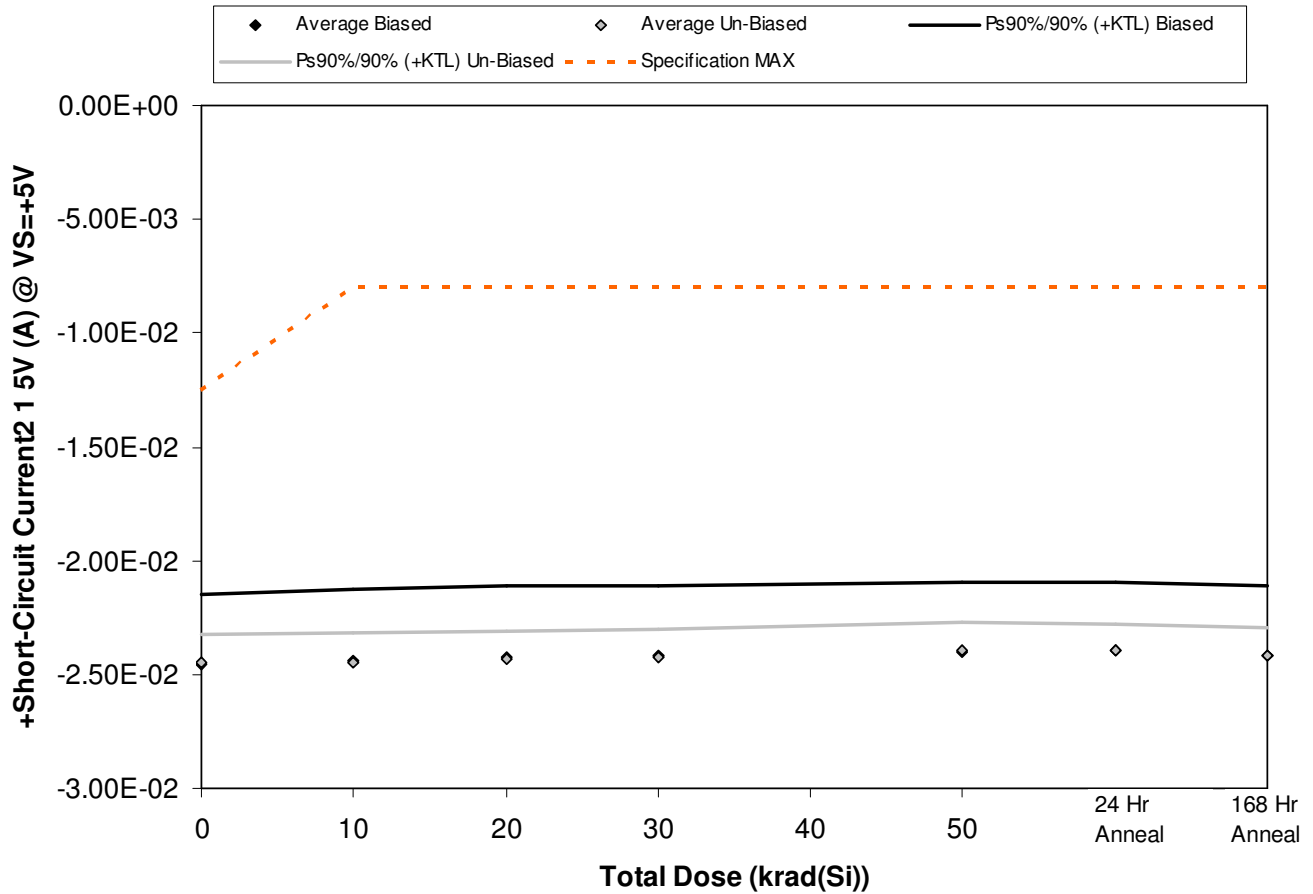


Figure 5.177. Plot of +Short-Circuit Current2 1 5V (A) @ VS=+5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.177. Raw data for +Short-Circuit Current2 1 5V (A) @ VS=+5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Short-Circuit Current2 1 5V (A) @ VS=+5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.65E-02	-2.64E-02	-2.62E-02	-2.61E-02	-2.58E-02	-2.58E-02	-2.60E-02
563	-2.43E-02	-2.42E-02	-2.40E-02	-2.40E-02	-2.37E-02	-2.37E-02	-2.39E-02
564	-2.37E-02	-2.35E-02	-2.34E-02	-2.33E-02	-2.31E-02	-2.31E-02	-2.33E-02
567	-2.38E-02	-2.36E-02	-2.35E-02	-2.34E-02	-2.32E-02	-2.32E-02	-2.34E-02
569	-2.47E-02	-2.45E-02	-2.43E-02	-2.42E-02	-2.40E-02	-2.40E-02	-2.42E-02
570	-2.44E-02	-2.44E-02	-2.42E-02	-2.41E-02	-2.39E-02	-2.39E-02	-2.41E-02
571	-2.46E-02	-2.46E-02	-2.45E-02	-2.43E-02	-2.41E-02	-2.41E-02	-2.42E-02
572	-2.45E-02	-2.44E-02	-2.43E-02	-2.42E-02	-2.39E-02	-2.39E-02	-2.41E-02
573	-2.39E-02	-2.38E-02	-2.37E-02	-2.36E-02	-2.34E-02	-2.34E-02	-2.35E-02
574	-2.52E-02	-2.51E-02	-2.50E-02	-2.49E-02	-2.46E-02	-2.46E-02	-2.48E-02
584	-2.61E-02	-2.61E-02	-2.61E-02	-2.61E-02	-2.61E-02	-2.61E-02	-2.61E-02
585	-2.62E-02	-2.62E-02	-2.62E-02	-2.62E-02	-2.62E-02	-2.62E-02	-2.62E-02
<b>Biased Statistics</b>							
Average Biased	-2.46E-02	-2.44E-02	-2.43E-02	-2.42E-02	-2.40E-02	-2.40E-02	-2.42E-02
Std Dev Biased	1.13E-03	1.16E-03	1.15E-03	1.14E-03	1.10E-03	1.10E-03	1.11E-03
Ps90%/90% (+KTL) Biased	-2.15E-02	-2.12E-02	-2.11E-02	-2.11E-02	-2.10E-02	-2.10E-02	-2.11E-02
Ps90%/90% (-KTL) Biased	-2.77E-02	-2.76E-02	-2.74E-02	-2.73E-02	-2.70E-02	-2.70E-02	-2.72E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	-2.45E-02	-2.45E-02	-2.43E-02	-2.42E-02	-2.40E-02	-2.40E-02	-2.41E-02
Std Dev Un-Biased	4.57E-04	4.64E-04	4.56E-04	4.53E-04	4.41E-04	4.40E-04	4.48E-04
Ps90%/90% (+KTL) Un-Biased	-2.32E-02	-2.32E-02	-2.31E-02	-2.30E-02	-2.27E-02	-2.28E-02	-2.29E-02
Ps90%/90% (-KTL) Un-Biased	-2.58E-02	-2.57E-02	-2.56E-02	-2.55E-02	-2.52E-02	-2.52E-02	-2.54E-02
<b>Specification MAX</b>	<b>-1.25E-02</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

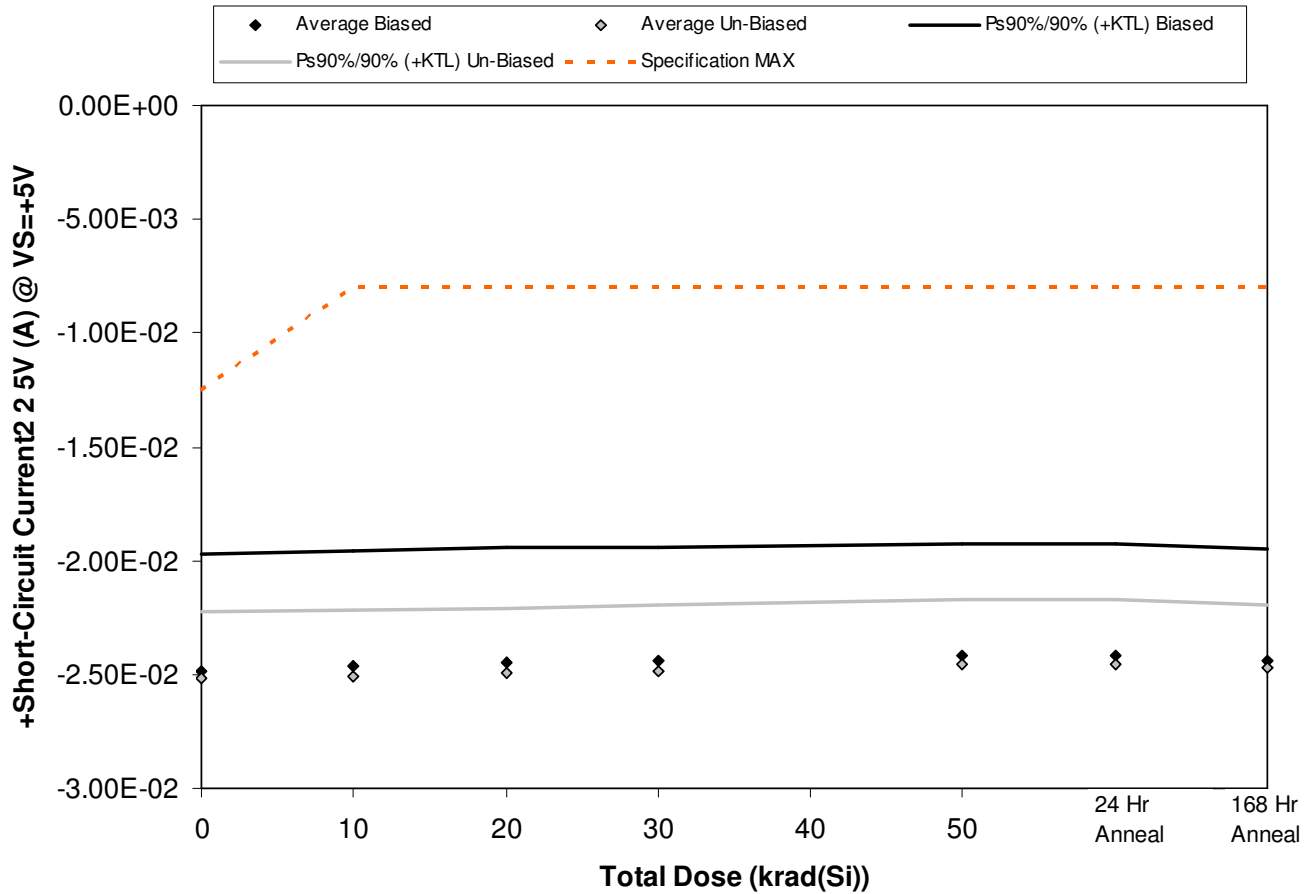


Figure 5.178. Plot of +Short-Circuit Current2 2.5V (A) @ VS=+5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.178. Raw data for +Short-Circuit Current2 2 5V (A) @ VS=+5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Short-Circuit Current2 2 5V (A) @ VS=+5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.80E-02	-2.78E-02	-2.77E-02	-2.75E-02	-2.72E-02	-2.72E-02	-2.75E-02
563	-2.38E-02	-2.36E-02	-2.35E-02	-2.35E-02	-2.32E-02	-2.32E-02	-2.34E-02
564	-2.38E-02	-2.36E-02	-2.35E-02	-2.34E-02	-2.32E-02	-2.32E-02	-2.34E-02
567	-2.35E-02	-2.33E-02	-2.32E-02	-2.31E-02	-2.29E-02	-2.29E-02	-2.31E-02
569	-2.51E-02	-2.49E-02	-2.47E-02	-2.46E-02	-2.44E-02	-2.44E-02	-2.46E-02
570	-2.44E-02	-2.44E-02	-2.42E-02	-2.41E-02	-2.39E-02	-2.39E-02	-2.40E-02
571	-2.51E-02	-2.50E-02	-2.49E-02	-2.48E-02	-2.45E-02	-2.45E-02	-2.47E-02
572	-2.62E-02	-2.61E-02	-2.60E-02	-2.58E-02	-2.55E-02	-2.55E-02	-2.57E-02
573	-2.38E-02	-2.38E-02	-2.37E-02	-2.36E-02	-2.33E-02	-2.33E-02	-2.35E-02
574	-2.63E-02	-2.62E-02	-2.61E-02	-2.60E-02	-2.56E-02	-2.56E-02	-2.58E-02
584	-2.44E-02	-2.44E-02	-2.44E-02	-2.44E-02	-2.44E-02	-2.43E-02	-2.44E-02
585	-2.43E-02	-2.43E-02	-2.43E-02	-2.43E-02	-2.42E-02	-2.42E-02	-2.43E-02
<b>Biased Statistics</b>							
Average Biased	-2.48E-02	-2.47E-02	-2.45E-02	-2.44E-02	-2.42E-02	-2.42E-02	-2.44E-02
Std Dev Biased	1.86E-03	1.86E-03	1.86E-03	1.83E-03	1.79E-03	1.79E-03	1.80E-03
Ps90%/90% (+KTL) Biased	-1.97E-02	-1.95E-02	-1.94E-02	-1.94E-02	-1.93E-02	-1.93E-02	-1.95E-02
Ps90%/90% (-KTL) Biased	-2.99E-02	-2.98E-02	-2.96E-02	-2.94E-02	-2.91E-02	-2.91E-02	-2.93E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	-2.52E-02	-2.51E-02	-2.50E-02	-2.49E-02	-2.45E-02	-2.45E-02	-2.47E-02
Std Dev Un-Biased	1.06E-03	1.07E-03	1.06E-03	1.05E-03	1.03E-03	1.03E-03	1.03E-03
Ps90%/90% (+KTL) Un-Biased	-2.22E-02	-2.22E-02	-2.21E-02	-2.20E-02	-2.17E-02	-2.17E-02	-2.19E-02
Ps90%/90% (-KTL) Un-Biased	-2.81E-02	-2.80E-02	-2.79E-02	-2.77E-02	-2.74E-02	-2.74E-02	-2.76E-02
<b>Specification MAX</b>	<b>-1.25E-02</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



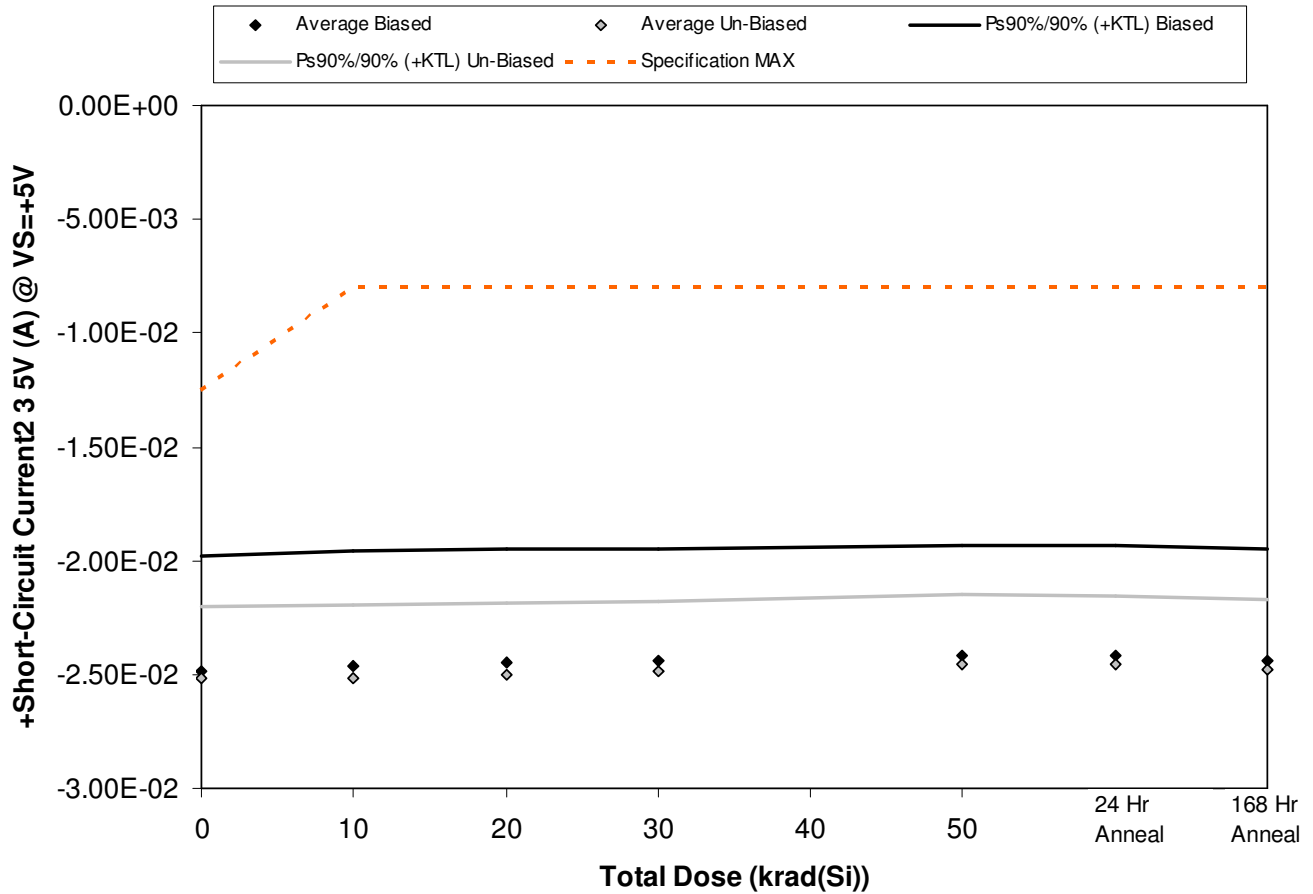


Figure 5.179. Plot of +Short-Circuit Current2 3 5V (A) @ VS=+5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.179. Raw data for +Short-Circuit Current2 3 5V (A) @ VS=+5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Short-Circuit Current2 3 5V (A) @ VS=+5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.79E-02	-2.78E-02	-2.76E-02	-2.75E-02	-2.71E-02	-2.71E-02	-2.74E-02
563	-2.36E-02	-2.34E-02	-2.33E-02	-2.32E-02	-2.30E-02	-2.30E-02	-2.32E-02
564	-2.40E-02	-2.38E-02	-2.36E-02	-2.35E-02	-2.34E-02	-2.33E-02	-2.35E-02
567	-2.36E-02	-2.34E-02	-2.32E-02	-2.32E-02	-2.30E-02	-2.30E-02	-2.32E-02
569	-2.52E-02	-2.50E-02	-2.48E-02	-2.47E-02	-2.45E-02	-2.45E-02	-2.47E-02
570	-2.43E-02	-2.43E-02	-2.42E-02	-2.41E-02	-2.38E-02	-2.38E-02	-2.40E-02
571	-2.52E-02	-2.52E-02	-2.51E-02	-2.49E-02	-2.46E-02	-2.46E-02	-2.48E-02
572	-2.62E-02	-2.61E-02	-2.60E-02	-2.59E-02	-2.56E-02	-2.56E-02	-2.58E-02
573	-2.38E-02	-2.37E-02	-2.36E-02	-2.35E-02	-2.32E-02	-2.32E-02	-2.34E-02
574	-2.64E-02	-2.64E-02	-2.63E-02	-2.61E-02	-2.58E-02	-2.58E-02	-2.60E-02
584	-2.42E-02	-2.42E-02	-2.42E-02	-2.43E-02	-2.42E-02	-2.42E-02	-2.42E-02
585	-2.43E-02	-2.43E-02	-2.43E-02	-2.43E-02	-2.43E-02	-2.42E-02	-2.43E-02
<b>Biased Statistics</b>							
Average Biased	-2.48E-02	-2.47E-02	-2.45E-02	-2.44E-02	-2.42E-02	-2.42E-02	-2.44E-02
Std Dev Biased	1.83E-03	1.85E-03	1.83E-03	1.81E-03	1.76E-03	1.76E-03	1.78E-03
Ps90%/90% (+KTL) Biased	-1.98E-02	-1.96E-02	-1.95E-02	-1.95E-02	-1.94E-02	-1.94E-02	-1.95E-02
Ps90%/90% (-KTL) Biased	-2.98E-02	-2.97E-02	-2.95E-02	-2.94E-02	-2.90E-02	-2.90E-02	-2.93E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	-2.52E-02	-2.51E-02	-2.50E-02	-2.49E-02	-2.46E-02	-2.46E-02	-2.48E-02
Std Dev Un-Biased	1.16E-03	1.16E-03	1.15E-03	1.14E-03	1.12E-03	1.12E-03	1.13E-03
Ps90%/90% (+KTL) Un-Biased	-2.20E-02	-2.20E-02	-2.19E-02	-2.18E-02	-2.15E-02	-2.15E-02	-2.17E-02
Ps90%/90% (-KTL) Un-Biased	-2.84E-02	-2.83E-02	-2.82E-02	-2.80E-02	-2.77E-02	-2.76E-02	-2.79E-02
<b>Specification MAX</b>	<b>-1.25E-02</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

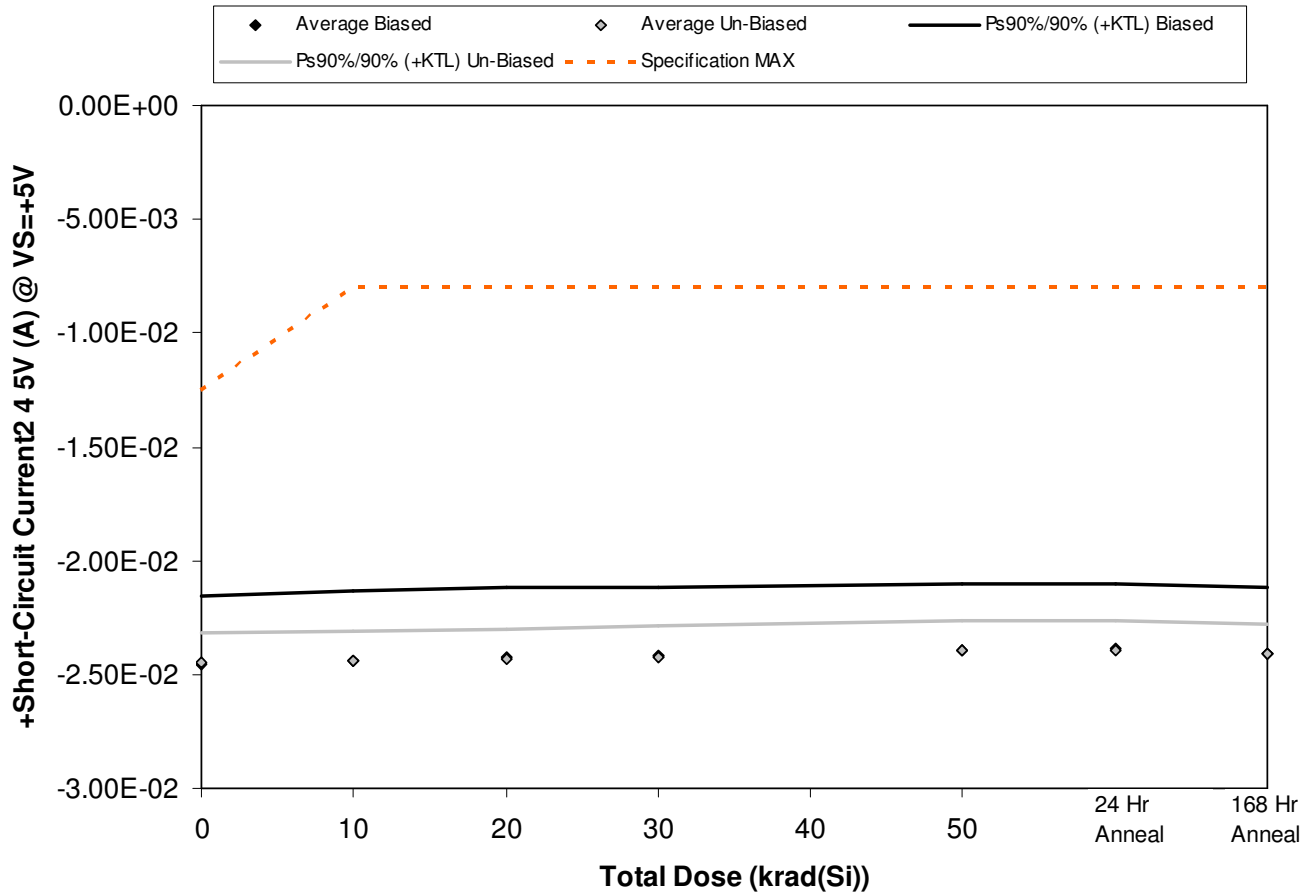


Figure 5.180. Plot of +Short-Circuit Current2 4 5V (A) @ VS=+5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.180. Raw data for +Short-Circuit Current2 4 5V (A) @ VS=+5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Short-Circuit Current2 4 5V (A) @ VS=+5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	-2.63E-02	-2.62E-02	-2.61E-02	-2.60E-02	-2.57E-02	-2.56E-02	-2.59E-02
563	-2.43E-02	-2.42E-02	-2.40E-02	-2.39E-02	-2.37E-02	-2.37E-02	-2.39E-02
564	-2.36E-02	-2.34E-02	-2.33E-02	-2.32E-02	-2.30E-02	-2.30E-02	-2.32E-02
567	-2.38E-02	-2.36E-02	-2.35E-02	-2.34E-02	-2.32E-02	-2.32E-02	-2.34E-02
569	-2.46E-02	-2.44E-02	-2.42E-02	-2.42E-02	-2.40E-02	-2.40E-02	-2.42E-02
570	-2.44E-02	-2.44E-02	-2.43E-02	-2.42E-02	-2.39E-02	-2.39E-02	-2.41E-02
571	-2.46E-02	-2.45E-02	-2.44E-02	-2.43E-02	-2.40E-02	-2.40E-02	-2.42E-02
572	-2.44E-02	-2.44E-02	-2.43E-02	-2.41E-02	-2.39E-02	-2.39E-02	-2.40E-02
573	-2.38E-02	-2.38E-02	-2.37E-02	-2.36E-02	-2.33E-02	-2.33E-02	-2.35E-02
574	-2.52E-02	-2.51E-02	-2.50E-02	-2.49E-02	-2.46E-02	-2.46E-02	-2.48E-02
584	-2.60E-02	-2.61E-02	-2.61E-02	-2.61E-02	-2.60E-02	-2.60E-02	-2.60E-02
585	-2.62E-02	-2.62E-02	-2.62E-02	-2.62E-02	-2.62E-02	-2.62E-02	-2.62E-02
<b>Biased Statistics</b>							
Average Biased	-2.45E-02	-2.44E-02	-2.42E-02	-2.41E-02	-2.39E-02	-2.39E-02	-2.41E-02
Std Dev Biased	1.09E-03	1.11E-03	1.11E-03	1.09E-03	1.05E-03	1.05E-03	1.07E-03
Ps90%/90% (+KTL) Biased	-2.15E-02	-2.13E-02	-2.12E-02	-2.11E-02	-2.10E-02	-2.10E-02	-2.12E-02
Ps90%/90% (-KTL) Biased	-2.75E-02	-2.74E-02	-2.73E-02	-2.71E-02	-2.68E-02	-2.68E-02	-2.70E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	-2.45E-02	-2.44E-02	-2.43E-02	-2.42E-02	-2.39E-02	-2.39E-02	-2.41E-02
Std Dev Un-Biased	4.86E-04	4.86E-04	4.86E-04	4.82E-04	4.71E-04	4.67E-04	4.75E-04
Ps90%/90% (+KTL) Un-Biased	-2.32E-02	-2.31E-02	-2.30E-02	-2.29E-02	-2.26E-02	-2.26E-02	-2.28E-02
Ps90%/90% (-KTL) Un-Biased	-2.58E-02	-2.58E-02	-2.57E-02	-2.55E-02	-2.52E-02	-2.52E-02	-2.54E-02
<b>Specification MAX</b>	<b>-1.25E-02</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>	<b>-8.00E-03</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

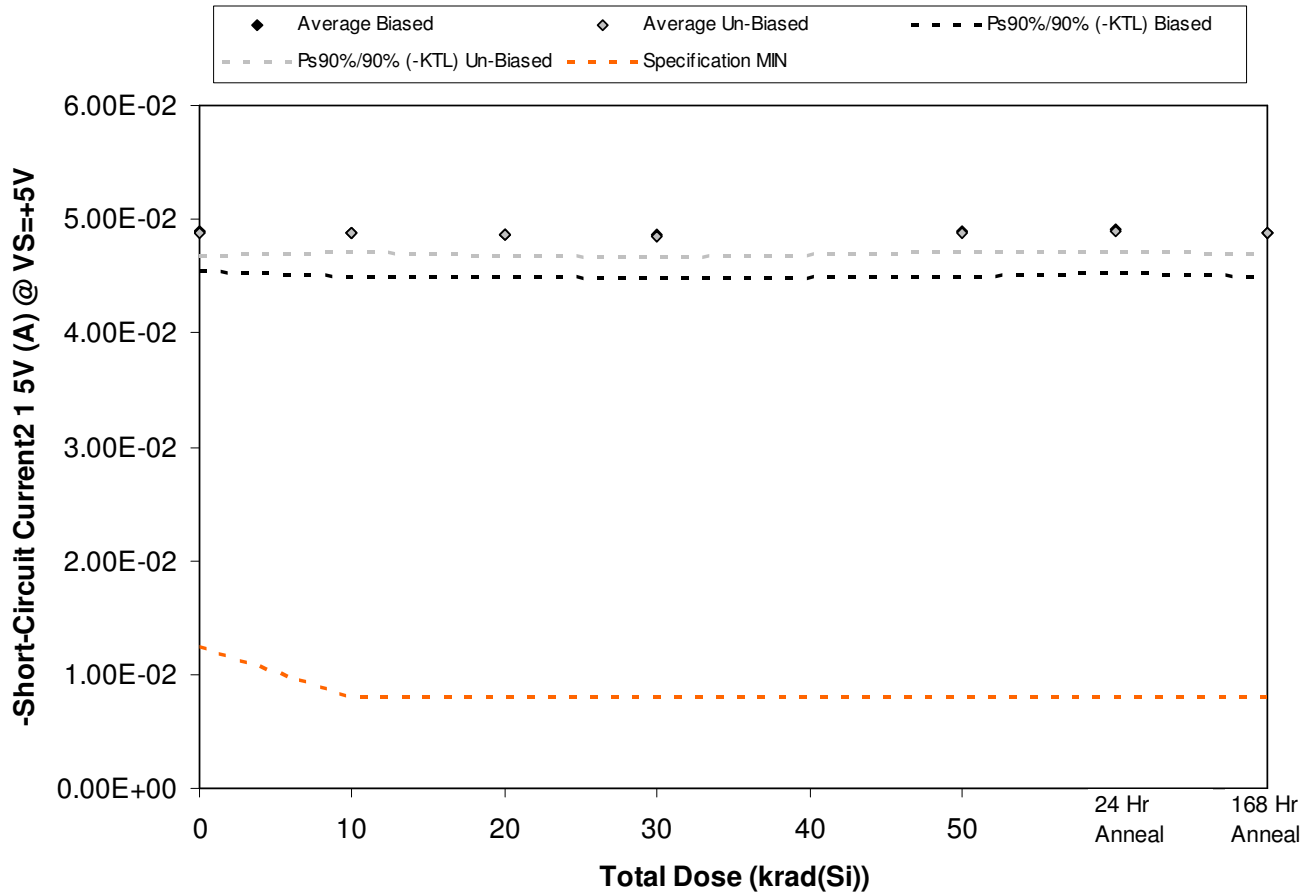


Figure 5.181. Plot of -Short-Circuit Current2 1 5V (A) @ VS=+5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.181. Raw data for -Short-Circuit Current2 1 5V (A) @ VS=+5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Short-Circuit Current2 1 5V (A) @ VS=+5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.10E-02	5.11E-02	5.10E-02	5.09E-02	5.12E-02	5.13E-02	5.11E-02
563	4.89E-02	4.90E-02	4.88E-02	4.87E-02	4.89E-02	4.91E-02	4.88E-02
564	4.79E-02	4.77E-02	4.77E-02	4.75E-02	4.77E-02	4.81E-02	4.77E-02
567	4.78E-02	4.75E-02	4.75E-02	4.74E-02	4.77E-02	4.78E-02	4.77E-02
569	4.89E-02	4.87E-02	4.87E-02	4.86E-02	4.89E-02	4.91E-02	4.88E-02
570	4.90E-02	4.89E-02	4.88E-02	4.87E-02	4.92E-02	4.91E-02	4.90E-02
571	4.89E-02	4.90E-02	4.88E-02	4.87E-02	4.90E-02	4.90E-02	4.90E-02
572	4.79E-02	4.82E-02	4.78E-02	4.78E-02	4.82E-02	4.83E-02	4.81E-02
573	4.81E-02	4.83E-02	4.80E-02	4.79E-02	4.83E-02	4.83E-02	4.82E-02
574	4.98E-02	4.98E-02	4.95E-02	4.94E-02	4.97E-02	4.99E-02	4.96E-02
584	5.10E-02	5.09E-02	5.08E-02	5.07E-02	5.12E-02	5.12E-02	5.10E-02
585	5.04E-02	5.02E-02	5.00E-02	5.02E-02	5.06E-02	5.08E-02	5.04E-02
<b>Biased Statistics</b>							
Average Biased	4.89E-02	4.88E-02	4.87E-02	4.86E-02	4.89E-02	4.91E-02	4.88E-02
Std Dev Biased	1.28E-03	1.43E-03	1.39E-03	1.38E-03	1.42E-03	1.39E-03	1.38E-03
Ps90%/90% (+KTL) Biased	5.24E-02	5.27E-02	5.25E-02	5.24E-02	5.28E-02	5.29E-02	5.26E-02
Ps90%/90% (-KTL) Biased	4.54E-02	4.49E-02	4.49E-02	4.48E-02	4.50E-02	4.53E-02	4.50E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	4.87E-02	4.88E-02	4.86E-02	4.85E-02	4.89E-02	4.89E-02	4.88E-02
Std Dev Un-Biased	7.33E-04	6.39E-04	6.76E-04	6.44E-04	6.59E-04	6.68E-04	6.54E-04
Ps90%/90% (+KTL) Un-Biased	5.08E-02	5.06E-02	5.04E-02	5.03E-02	5.07E-02	5.07E-02	5.06E-02
Ps90%/90% (-KTL) Un-Biased	4.67E-02	4.71E-02	4.67E-02	4.67E-02	4.71E-02	4.71E-02	4.70E-02
<b>Specification MIN</b>	<b>1.25E-02</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

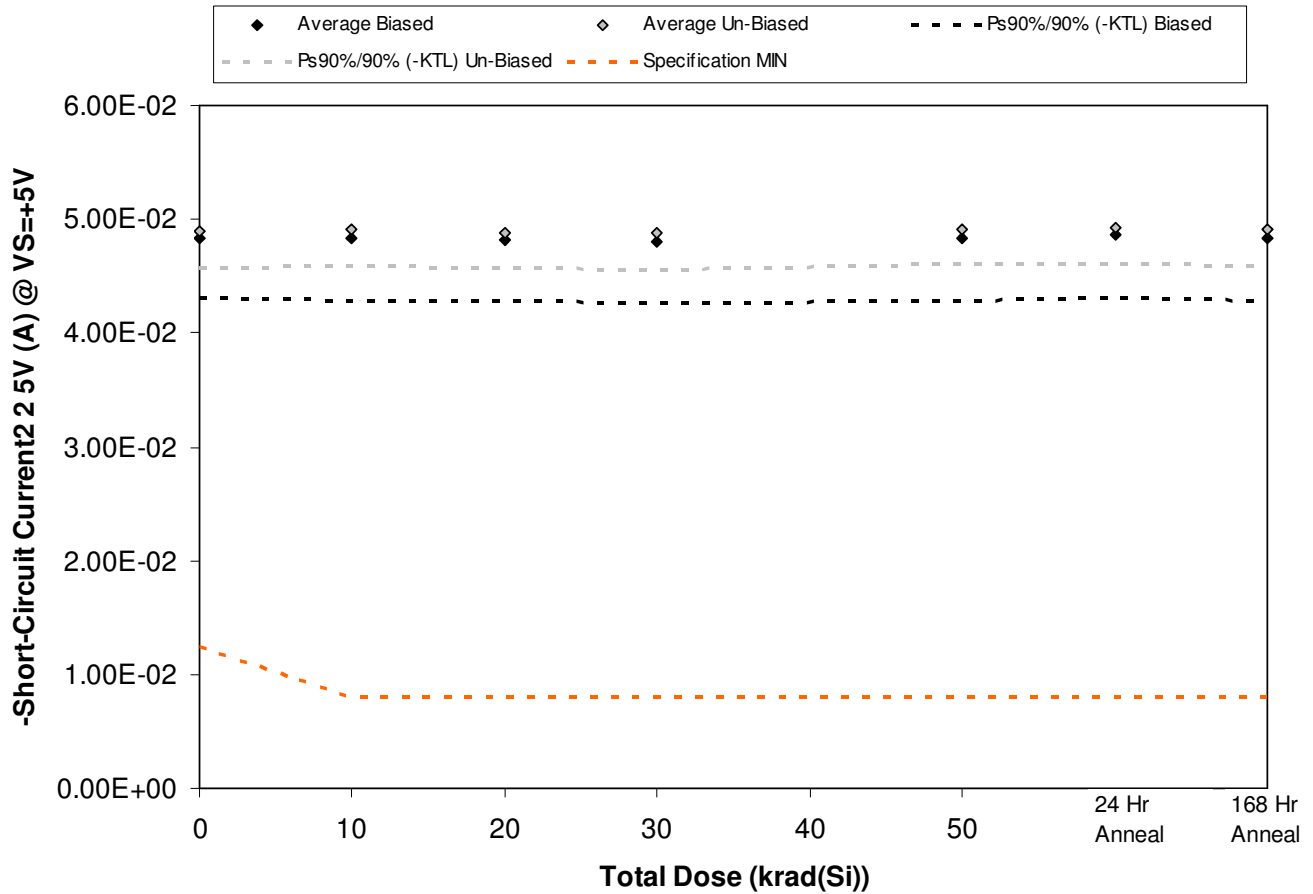


Figure 5.182. Plot of -Short-Circuit Current2 2.5V (A) @ VS=+5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.182. Raw data for -Short-Circuit Current2 2 5V (A) @ VS=+5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Short-Circuit Current2 2 5V (A) @ VS=+5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.16E-02	5.16E-02	5.16E-02	5.15E-02	5.18E-02	5.19E-02	5.17E-02
563	4.70E-02	4.71E-02	4.69E-02	4.68E-02	4.70E-02	4.72E-02	4.69E-02
564	4.73E-02	4.71E-02	4.70E-02	4.68E-02	4.71E-02	4.74E-02	4.71E-02
567	4.73E-02	4.71E-02	4.70E-02	4.70E-02	4.73E-02	4.74E-02	4.73E-02
569	4.88E-02	4.85E-02	4.86E-02	4.85E-02	4.89E-02	4.89E-02	4.87E-02
570	4.80E-02	4.79E-02	4.78E-02	4.77E-02	4.82E-02	4.82E-02	4.80E-02
571	4.90E-02	4.91E-02	4.89E-02	4.88E-02	4.91E-02	4.92E-02	4.92E-02
572	4.99E-02	5.01E-02	4.99E-02	4.98E-02	5.01E-02	5.02E-02	5.01E-02
573	4.77E-02	4.79E-02	4.77E-02	4.75E-02	4.78E-02	4.79E-02	4.78E-02
574	5.04E-02	5.04E-02	5.01E-02	5.00E-02	5.04E-02	5.05E-02	5.03E-02
584	4.79E-02	4.78E-02	4.78E-02	4.77E-02	4.82E-02	4.82E-02	4.79E-02
585	4.82E-02	4.79E-02	4.78E-02	4.79E-02	4.83E-02	4.85E-02	4.82E-02
<b>Biased Statistics</b>							
Average Biased	4.84E-02	4.83E-02	4.82E-02	4.81E-02	4.84E-02	4.86E-02	4.83E-02
Std Dev Biased	1.93E-03	1.98E-03	2.00E-03	2.00E-03	2.04E-03	2.00E-03	2.00E-03
Ps90%/90% (+KTL) Biased	5.37E-02	5.37E-02	5.37E-02	5.36E-02	5.40E-02	5.41E-02	5.38E-02
Ps90%/90% (-KTL) Biased	4.31E-02	4.29E-02	4.27E-02	4.26E-02	4.28E-02	4.31E-02	4.28E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	4.90E-02	4.91E-02	4.89E-02	4.88E-02	4.91E-02	4.92E-02	4.91E-02
Std Dev Un-Biased	1.17E-03	1.15E-03	1.14E-03	1.13E-03	1.13E-03	1.17E-03	1.15E-03
Ps90%/90% (+KTL) Un-Biased	5.22E-02	5.22E-02	5.20E-02	5.19E-02	5.22E-02	5.24E-02	5.22E-02
Ps90%/90% (-KTL) Un-Biased	4.58E-02	4.59E-02	4.58E-02	4.56E-02	4.60E-02	4.60E-02	4.59E-02
<b>Specification MIN</b>	<b>1.25E-02</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



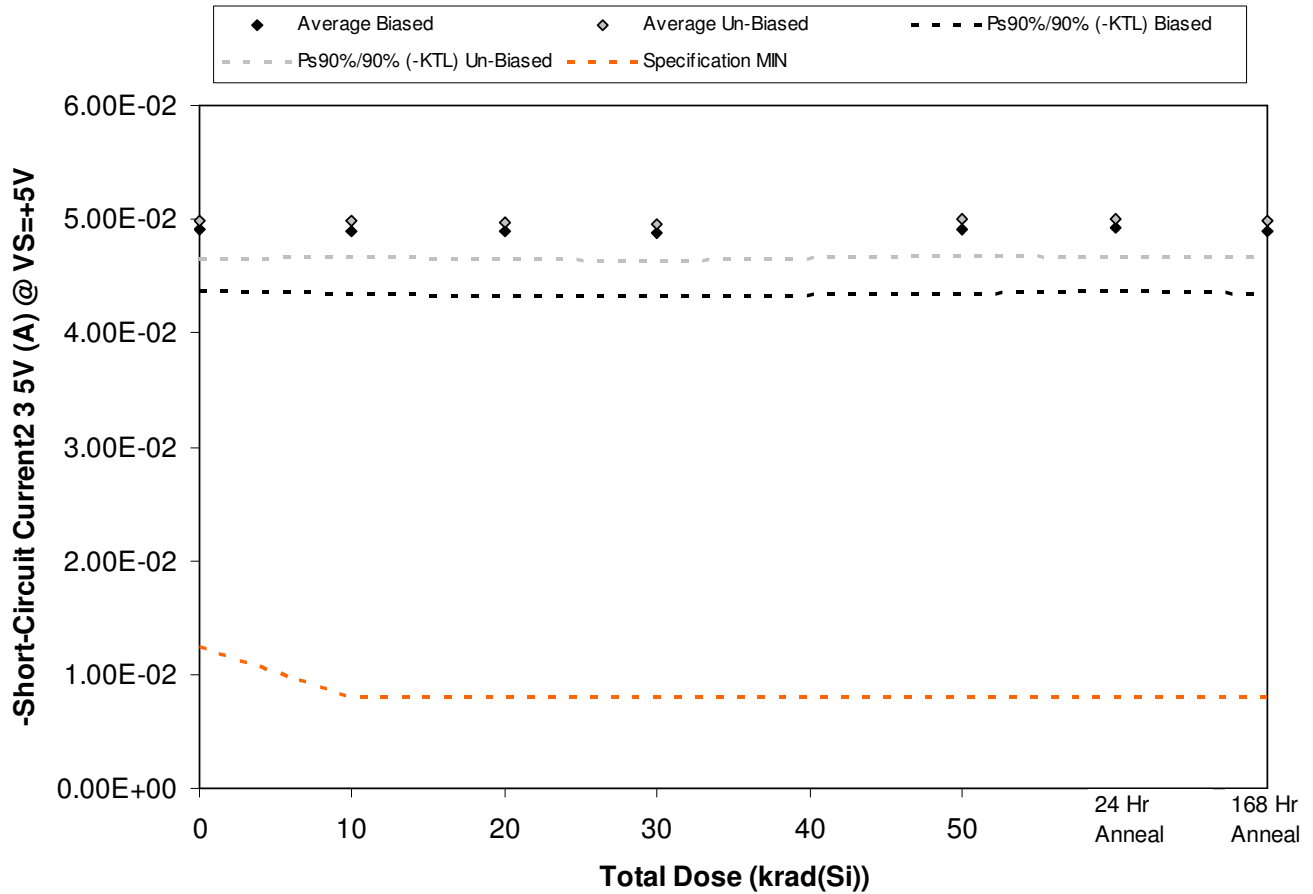


Figure 5.183. Plot of -Short-Circuit Current2 3 5V (A) @ VS=+5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.183. Raw data for -Short-Circuit Current2 3 5V (A) @ VS=+5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Short-Circuit Current2 3 5V (A) @ VS=+5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.23E-02	5.24E-02	5.23E-02	5.22E-02	5.26E-02	5.27E-02	5.24E-02
563	4.77E-02	4.78E-02	4.76E-02	4.74E-02	4.77E-02	4.79E-02	4.76E-02
564	4.79E-02	4.77E-02	4.77E-02	4.75E-02	4.77E-02	4.81E-02	4.77E-02
567	4.80E-02	4.77E-02	4.77E-02	4.77E-02	4.80E-02	4.81E-02	4.79E-02
569	4.94E-02	4.91E-02	4.93E-02	4.91E-02	4.95E-02	4.96E-02	4.93E-02
570	4.88E-02	4.88E-02	4.87E-02	4.85E-02	4.90E-02	4.90E-02	4.89E-02
571	5.00E-02	5.01E-02	4.99E-02	4.98E-02	5.01E-02	5.01E-02	5.00E-02
572	5.07E-02	5.10E-02	5.06E-02	5.06E-02	5.09E-02	5.11E-02	5.08E-02
573	4.84E-02	4.86E-02	4.83E-02	4.82E-02	4.86E-02	4.86E-02	4.84E-02
574	5.12E-02	5.12E-02	5.10E-02	5.09E-02	5.12E-02	5.14E-02	5.11E-02
584	4.87E-02	4.85E-02	4.85E-02	4.84E-02	4.89E-02	4.89E-02	4.87E-02
585	4.89E-02	4.87E-02	4.85E-02	4.87E-02	4.90E-02	4.93E-02	4.89E-02
<b>Biased Statistics</b>							
Average Biased	4.90E-02	4.90E-02	4.89E-02	4.88E-02	4.91E-02	4.93E-02	4.90E-02
Std Dev Biased	1.94E-03	2.03E-03	2.03E-03	2.02E-03	2.07E-03	2.02E-03	2.03E-03
Ps90%/90% (+KTL) Biased	5.44E-02	5.45E-02	5.45E-02	5.43E-02	5.48E-02	5.48E-02	5.46E-02
Ps90%/90% (-KTL) Biased	4.37E-02	4.34E-02	4.33E-02	4.32E-02	4.34E-02	4.37E-02	4.34E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	4.98E-02	4.99E-02	4.97E-02	4.96E-02	5.00E-02	5.00E-02	4.99E-02
Std Dev Un-Biased	1.20E-03	1.22E-03	1.18E-03	1.19E-03	1.16E-03	1.22E-03	1.18E-03
Ps90%/90% (+KTL) Un-Biased	5.31E-02	5.33E-02	5.29E-02	5.28E-02	5.31E-02	5.34E-02	5.31E-02
Ps90%/90% (-KTL) Un-Biased	4.65E-02	4.66E-02	4.65E-02	4.63E-02	4.68E-02	4.67E-02	4.66E-02
<b>Specification MIN</b>	<b>1.25E-02</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

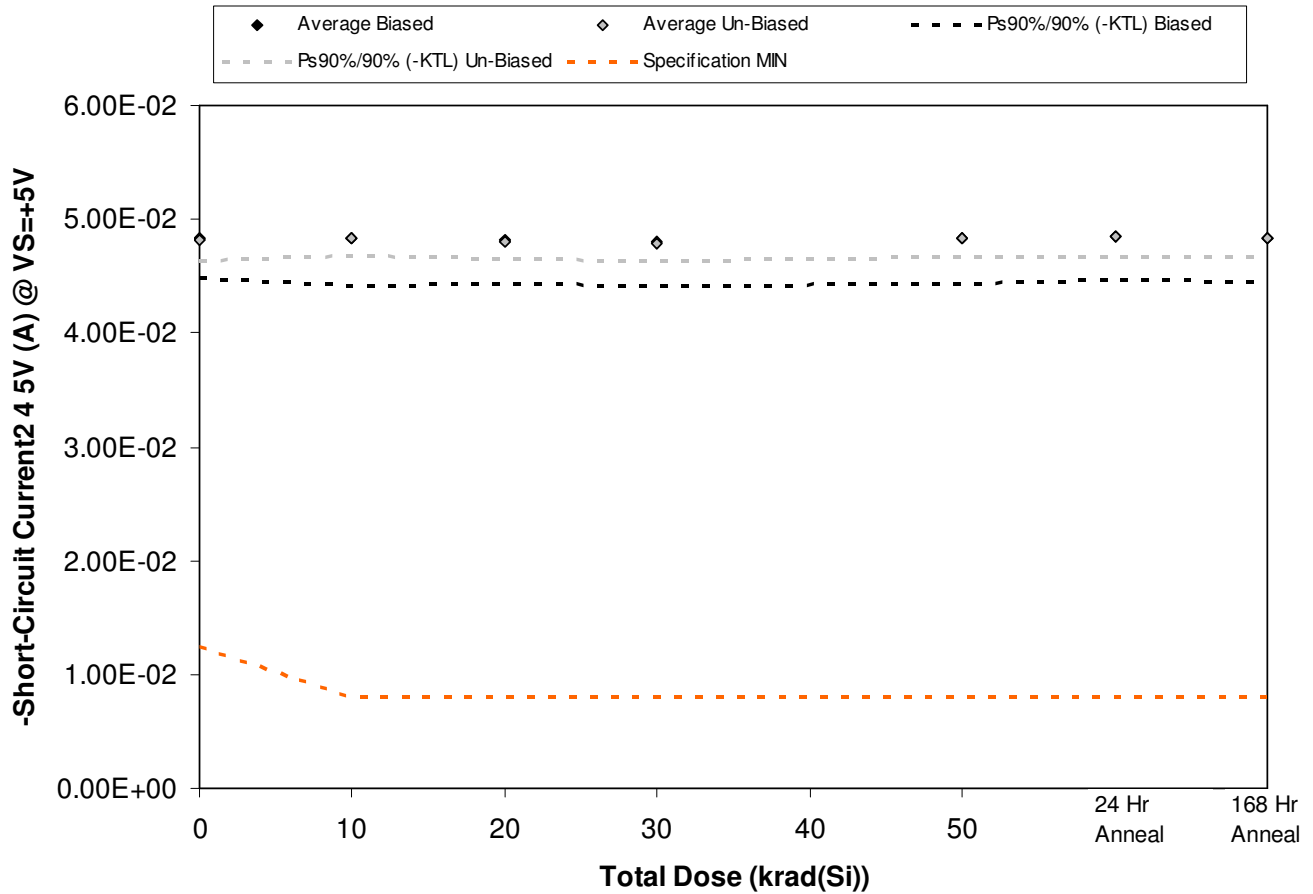


Figure 5.184. Plot of -Short-Circuit Current2 4 5V (A) @ VS=+5V versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.184. Raw data for -Short-Circuit Current2 4 5V (A) @ VS=+5V versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Short-Circuit Current2 4 5V (A) @ VS=+5V	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	5.05E-02	5.06E-02	5.05E-02	5.04E-02	5.07E-02	5.08E-02	5.06E-02
563	4.84E-02	4.85E-02	4.83E-02	4.82E-02	4.84E-02	4.87E-02	4.83E-02
564	4.75E-02	4.72E-02	4.72E-02	4.70E-02	4.72E-02	4.75E-02	4.73E-02
567	4.71E-02	4.69E-02	4.68E-02	4.68E-02	4.71E-02	4.72E-02	4.71E-02
569	4.84E-02	4.82E-02	4.82E-02	4.81E-02	4.84E-02	4.85E-02	4.83E-02
570	4.84E-02	4.83E-02	4.83E-02	4.81E-02	4.86E-02	4.85E-02	4.84E-02
571	4.83E-02	4.84E-02	4.82E-02	4.81E-02	4.84E-02	4.85E-02	4.84E-02
572	4.76E-02	4.78E-02	4.75E-02	4.74E-02	4.77E-02	4.79E-02	4.77E-02
573	4.76E-02	4.78E-02	4.75E-02	4.74E-02	4.77E-02	4.78E-02	4.77E-02
574	4.92E-02	4.91E-02	4.89E-02	4.88E-02	4.92E-02	4.93E-02	4.91E-02
584	5.03E-02	5.01E-02	5.01E-02	4.99E-02	5.05E-02	5.05E-02	5.02E-02
585	4.96E-02	4.94E-02	4.93E-02	4.94E-02	4.98E-02	5.01E-02	4.96E-02
<b>Biased Statistics</b>							
Average Biased	4.84E-02	4.83E-02	4.82E-02	4.81E-02	4.84E-02	4.86E-02	4.83E-02
Std Dev Biased	1.32E-03	1.46E-03	1.42E-03	1.42E-03	1.44E-03	1.42E-03	1.41E-03
Ps90%/90% (+KTL) Biased	5.20E-02	5.23E-02	5.21E-02	5.20E-02	5.23E-02	5.25E-02	5.21E-02
Ps90%/90% (-KTL) Biased	4.48E-02	4.43E-02	4.43E-02	4.42E-02	4.44E-02	4.47E-02	4.44E-02
<b>Un-Biased Statistics</b>							
Average Un-Biased	4.82E-02	4.83E-02	4.81E-02	4.79E-02	4.83E-02	4.84E-02	4.83E-02
Std Dev Un-Biased	6.52E-04	5.48E-04	5.97E-04	5.77E-04	5.97E-04	6.25E-04	6.07E-04
Ps90%/90% (+KTL) Un-Biased	5.00E-02	4.98E-02	4.97E-02	4.95E-02	5.00E-02	5.01E-02	4.99E-02
Ps90%/90% (-KTL) Un-Biased	4.64E-02	4.68E-02	4.65E-02	4.64E-02	4.67E-02	4.67E-02	4.66E-02
<b>Specification MIN</b>	<b>1.25E-02</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>	<b>8.00E-03</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

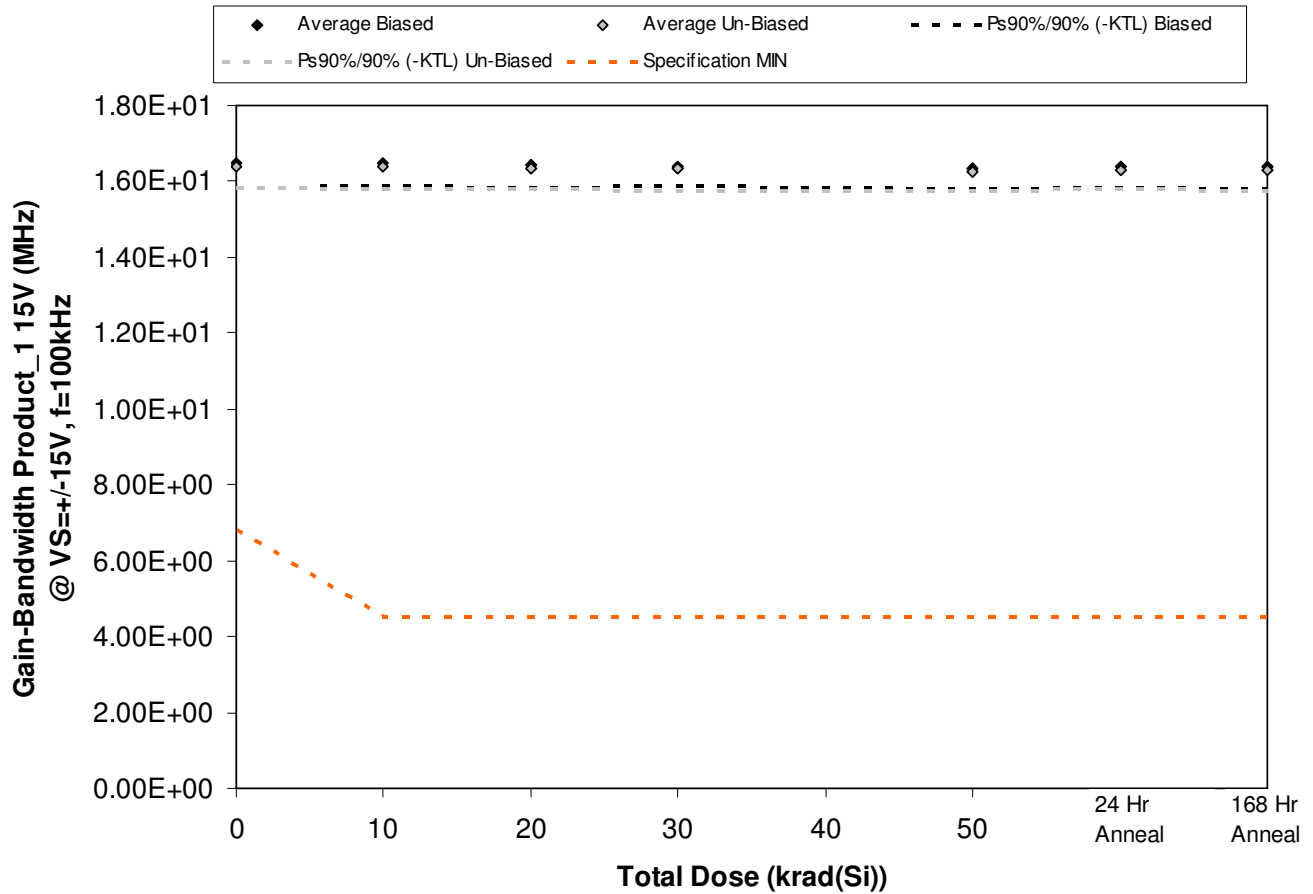


Figure 5.185. Plot of Gain-Bandwidth Product\_1 15V (MHz) @ VS=+-15V, f=100kHz versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.185. Raw data for Gain-Bandwidth Product\_1 15V (MHz) @ VS=+/-15V, f=100kHz versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Gain-Bandwidth Product_1 15V (MHz) @ VS=+/-15V, f=100kHz	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01
563	1.64E+01	1.64E+01	1.64E+01	1.64E+01	1.63E+01	1.63E+01	1.63E+01
564	1.66E+01	1.66E+01	1.66E+01	1.65E+01	1.65E+01	1.65E+01	1.65E+01
567	1.67E+01	1.67E+01	1.67E+01	1.66E+01	1.66E+01	1.66E+01	1.66E+01
569	1.65E+01	1.65E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01
570	1.66E+01	1.66E+01	1.66E+01	1.66E+01	1.65E+01	1.65E+01	1.65E+01
571	1.61E+01	1.61E+01	1.61E+01	1.60E+01	1.60E+01	1.60E+01	1.60E+01
572	1.65E+01	1.66E+01	1.65E+01	1.65E+01	1.65E+01	1.64E+01	1.64E+01
573	1.63E+01	1.63E+01	1.63E+01	1.63E+01	1.62E+01	1.62E+01	1.62E+01
574	1.63E+01	1.63E+01	1.63E+01	1.63E+01	1.62E+01	1.63E+01	1.63E+01
584	1.57E+01	1.57E+01	1.57E+01	1.57E+01	1.57E+01	1.57E+01	1.57E+01
585	1.62E+01	1.62E+01	1.62E+01	1.62E+01	1.62E+01	1.62E+01	1.62E+01
<b>Biased Statistics</b>							
Average Biased	1.65E+01	1.65E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01
Std Dev Biased	2.26E-01	2.16E-01	2.15E-01	1.89E-01	2.05E-01	2.03E-01	2.14E-01
Ps90%/90% (+KTL) Biased	1.71E+01	1.71E+01	1.70E+01	1.69E+01	1.69E+01	1.69E+01	1.70E+01
Ps90%/90% (-KTL) Biased	1.58E+01	1.59E+01	1.58E+01	1.59E+01	1.58E+01	1.58E+01	1.58E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.64E+01	1.64E+01	1.64E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01
Std Dev Un-Biased	2.00E-01	2.06E-01	1.98E-01	2.08E-01	1.95E-01	1.86E-01	1.97E-01
Ps90%/90% (+KTL) Un-Biased	1.69E+01	1.69E+01	1.69E+01	1.69E+01	1.68E+01	1.68E+01	1.68E+01
Ps90%/90% (-KTL) Un-Biased	1.58E+01	1.58E+01	1.58E+01	1.57E+01	1.57E+01	1.58E+01	1.57E+01
<b>Specification MIN</b>	<b>6.80E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

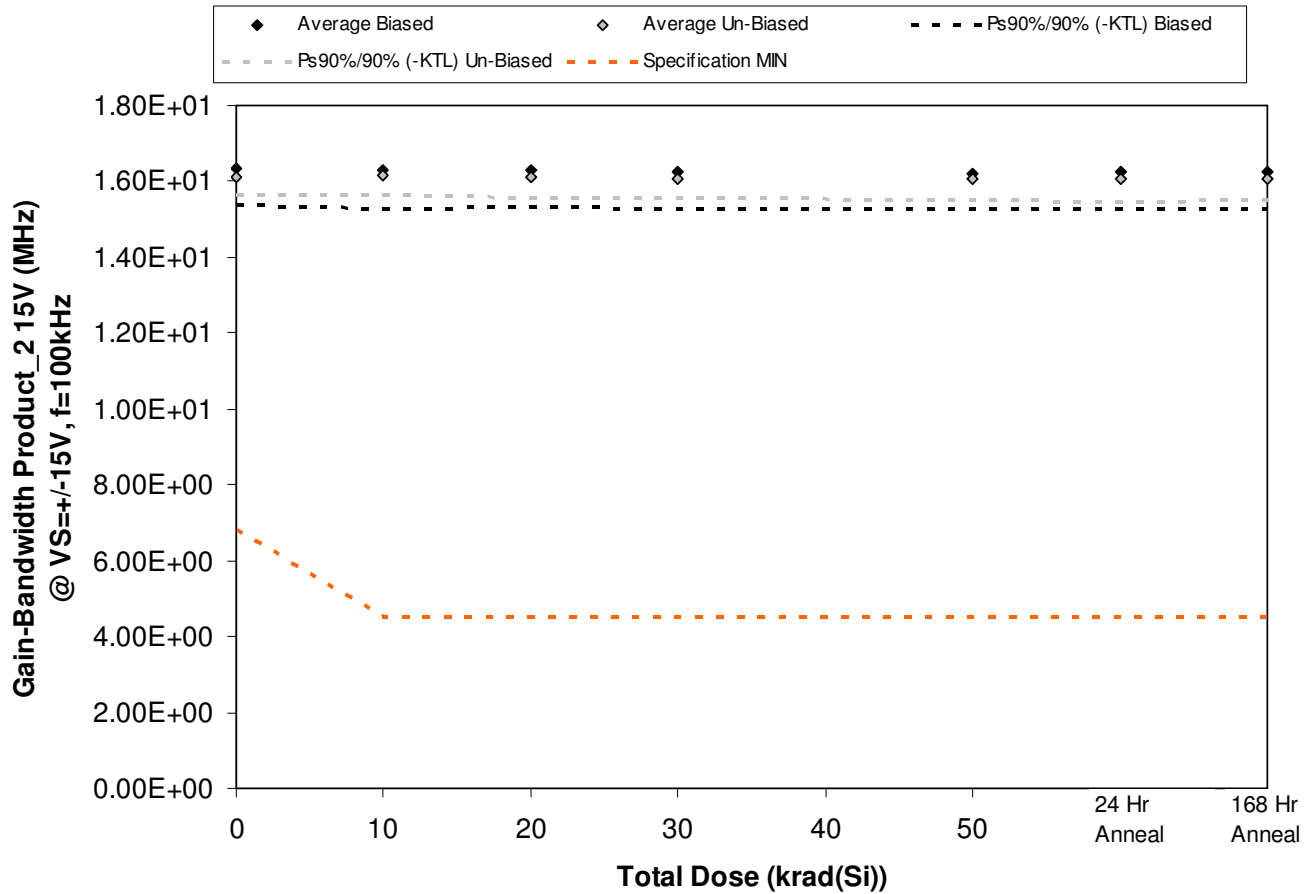


Figure 5.186. Plot of Gain-Bandwidth Product\_2 15V (MHz) @ VS=+-15V, f=100kHz versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.186. Raw data for Gain-Bandwidth Product\_2 15V (MHz) @ VS=+/-15V, f=100kHz versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Gain-Bandwidth Product_2 15V (MHz) @ VS=+/-15V, f=100kHz	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.59E+01	1.59E+01	1.59E+01	1.58E+01	1.58E+01	1.58E+01	1.58E+01
563	1.68E+01	1.68E+01	1.68E+01	1.68E+01	1.67E+01	1.67E+01	1.67E+01
564	1.65E+01	1.64E+01	1.64E+01	1.64E+01	1.63E+01	1.64E+01	1.64E+01
567	1.64E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01	1.62E+01
569	1.61E+01	1.61E+01	1.61E+01	1.60E+01	1.60E+01	1.60E+01	1.60E+01
570	1.64E+01	1.64E+01	1.64E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01
571	1.61E+01	1.62E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.60E+01
572	1.62E+01	1.62E+01	1.62E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01
573	1.59E+01	1.59E+01	1.58E+01	1.58E+01	1.58E+01	1.57E+01	1.58E+01
574	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.60E+01	1.60E+01	1.60E+01
584	1.66E+01	1.66E+01	1.66E+01	1.66E+01	1.65E+01	1.66E+01	1.66E+01
585	1.65E+01	1.65E+01	1.65E+01	1.65E+01	1.65E+01	1.66E+01	1.65E+01
<b>Biased Statistics</b>							
Average Biased	1.63E+01	1.63E+01	1.63E+01	1.63E+01	1.62E+01	1.62E+01	1.62E+01
Std Dev Biased	3.59E-01	3.71E-01	3.48E-01	3.50E-01	3.50E-01	3.52E-01	3.46E-01
Ps90%/90% (+KTL) Biased	1.73E+01	1.73E+01	1.72E+01	1.72E+01	1.72E+01	1.72E+01	1.72E+01
Ps90%/90% (-KTL) Biased	1.54E+01	1.53E+01	1.53E+01	1.53E+01	1.53E+01	1.53E+01	1.53E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01
Std Dev Un-Biased	1.69E-01	1.85E-01	1.98E-01	1.89E-01	1.99E-01	2.11E-01	1.93E-01
Ps90%/90% (+KTL) Un-Biased	1.66E+01	1.67E+01	1.67E+01	1.66E+01	1.66E+01	1.66E+01	1.66E+01
Ps90%/90% (-KTL) Un-Biased	1.57E+01	1.56E+01	1.56E+01	1.56E+01	1.55E+01	1.55E+01	1.55E+01
<b>Specification MIN</b>	<b>6.80E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



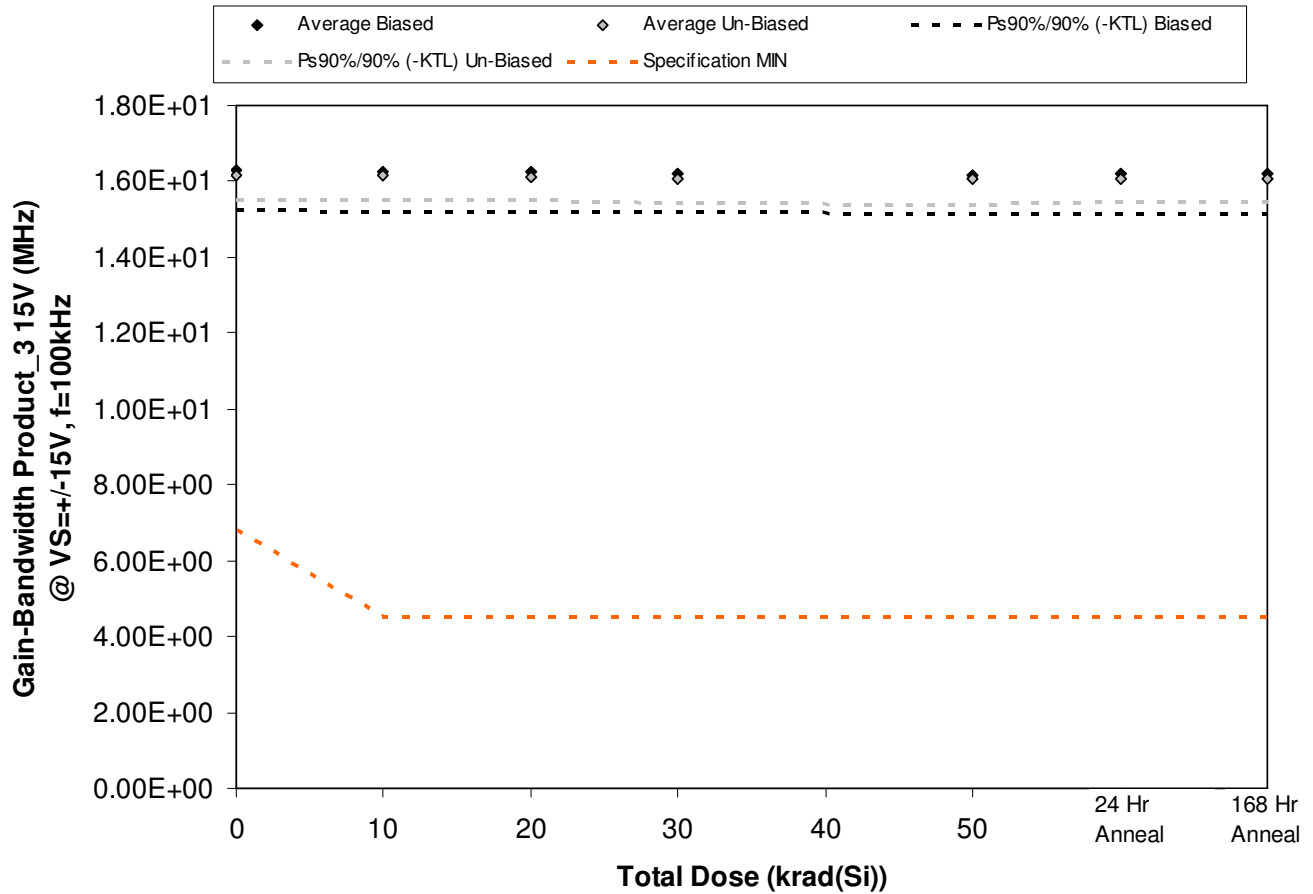


Figure 5.187. Plot of Gain-Bandwidth Product\_3 15V (MHz) @ VS=+-15V, f=100kHz versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.187. Raw data for Gain-Bandwidth Product\_3 15V (MHz) @ VS=+/-15V, f=100kHz versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Gain-Bandwidth Product_3 15V (MHz) @ VS=+/-15V, f=100kHz	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.58E+01	1.58E+01	1.58E+01	1.58E+01	1.58E+01	1.58E+01	1.58E+01
563	1.68E+01	1.68E+01	1.67E+01	1.67E+01	1.67E+01	1.67E+01	1.67E+01
564	1.65E+01	1.65E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01
567	1.64E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01
569	1.60E+01	1.59E+01	1.59E+01	1.59E+01	1.58E+01	1.59E+01	1.59E+01
570	1.65E+01	1.65E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01
571	1.61E+01	1.61E+01	1.61E+01	1.60E+01	1.60E+01	1.60E+01	1.60E+01
572	1.62E+01	1.62E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01
573	1.58E+01	1.58E+01	1.58E+01	1.58E+01	1.57E+01	1.58E+01	1.58E+01
574	1.62E+01	1.62E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01
584	1.64E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01
585	1.65E+01	1.65E+01	1.65E+01	1.65E+01	1.65E+01	1.65E+01	1.65E+01
<b>Biased Statistics</b>							
Average Biased	1.63E+01	1.63E+01	1.62E+01	1.62E+01	1.62E+01	1.62E+01	1.62E+01
Std Dev Biased	3.84E-01	3.83E-01	3.75E-01	3.74E-01	3.69E-01	3.85E-01	3.78E-01
Ps90%/90% (+KTL) Biased	1.73E+01	1.73E+01	1.73E+01	1.72E+01	1.72E+01	1.72E+01	1.72E+01
Ps90%/90% (-KTL) Biased	1.52E+01	1.52E+01	1.52E+01	1.52E+01	1.52E+01	1.51E+01	1.51E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01
Std Dev Un-Biased	2.34E-01	2.22E-01	2.23E-01	2.42E-01	2.53E-01	2.25E-01	2.17E-01
Ps90%/90% (+KTL) Un-Biased	1.68E+01	1.68E+01	1.67E+01	1.67E+01	1.67E+01	1.67E+01	1.66E+01
Ps90%/90% (-KTL) Un-Biased	1.55E+01	1.55E+01	1.55E+01	1.54E+01	1.54E+01	1.55E+01	1.55E+01
<b>Specification MIN</b>	<b>6.80E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

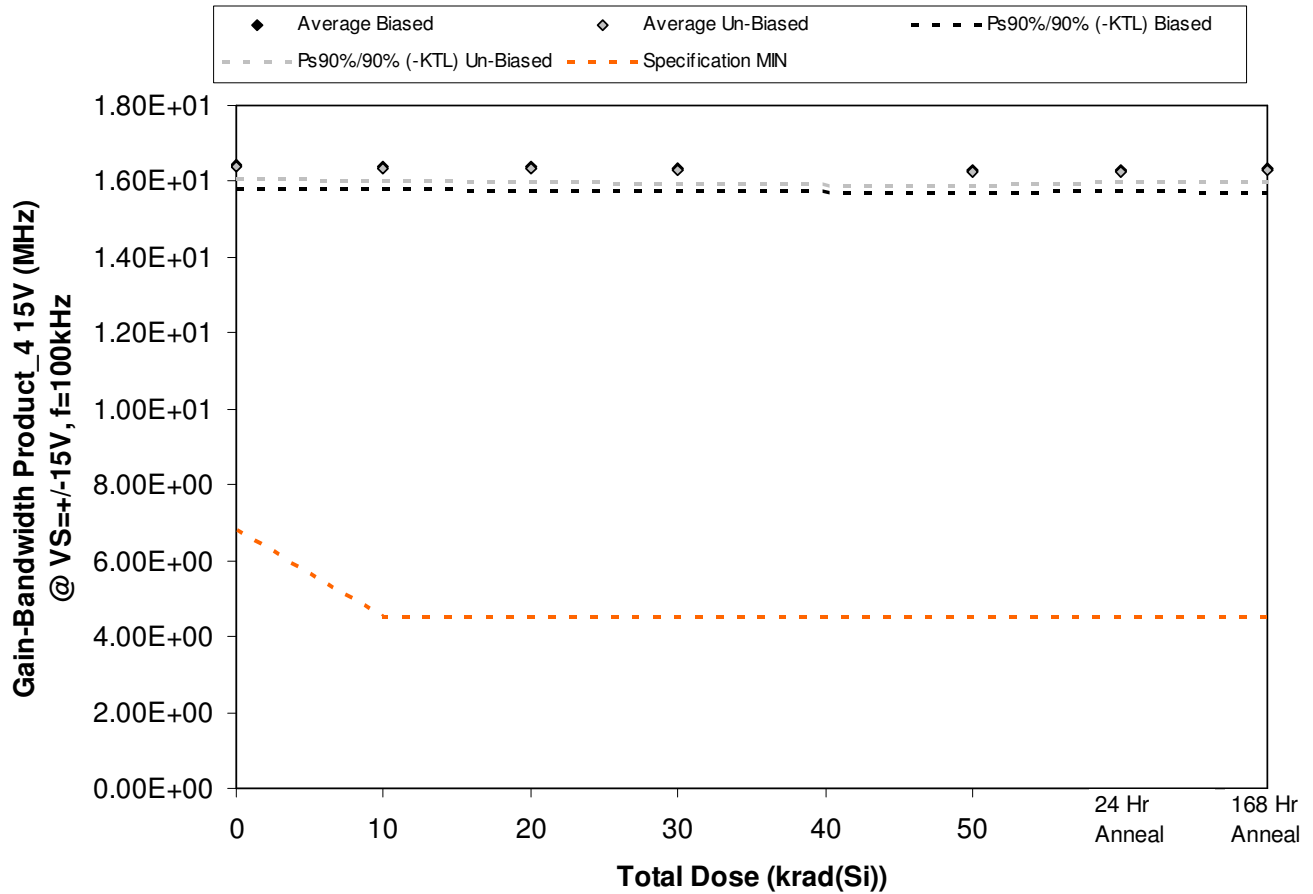


Figure 5.188. Plot of Gain-Bandwidth Product\_4 15V (MHz) @ VS=+-15V, f=100kHz versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.188. Raw data for Gain-Bandwidth Product\_4 15V (MHz) @ VS=+/-15V, f=100kHz versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

Gain-Bandwidth Product_4 15V (MHz) @ VS=+/-15V, f=100kHz	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	1.60E+01	1.60E+01	1.60E+01	1.60E+01	1.59E+01	1.60E+01	1.60E+01
563	1.65E+01	1.64E+01	1.64E+01	1.64E+01	1.63E+01	1.63E+01	1.63E+01
564	1.65E+01	1.65E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01	1.64E+01
567	1.67E+01	1.66E+01	1.66E+01	1.66E+01	1.66E+01	1.65E+01	1.66E+01
569	1.65E+01	1.65E+01	1.65E+01	1.65E+01	1.64E+01	1.64E+01	1.64E+01
570	1.65E+01	1.65E+01	1.65E+01	1.65E+01	1.65E+01	1.64E+01	1.64E+01
571	1.62E+01	1.62E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01	1.61E+01
572	1.64E+01	1.64E+01	1.64E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01
573	1.64E+01	1.64E+01	1.64E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01
574	1.64E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01	1.62E+01	1.63E+01
584	1.57E+01	1.57E+01	1.57E+01	1.57E+01	1.57E+01	1.57E+01	1.57E+01
585	1.62E+01	1.62E+01	1.61E+01	1.61E+01	1.62E+01	1.62E+01	1.62E+01
<b>Biased Statistics</b>							
Average Biased	1.64E+01	1.64E+01	1.64E+01	1.64E+01	1.63E+01	1.63E+01	1.63E+01
Std Dev Biased	2.37E-01	2.29E-01	2.25E-01	2.27E-01	2.27E-01	2.11E-01	2.27E-01
Ps90%/90% (+KTL) Biased	1.71E+01	1.70E+01	1.70E+01	1.70E+01	1.69E+01	1.69E+01	1.69E+01
Ps90%/90% (-KTL) Biased	1.58E+01	1.58E+01	1.58E+01	1.57E+01	1.57E+01	1.57E+01	1.57E+01
<b>Un-Biased Statistics</b>							
Average Un-Biased	1.64E+01	1.64E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01	1.63E+01
Std Dev Un-Biased	1.16E-01	1.18E-01	1.36E-01	1.25E-01	1.45E-01	1.16E-01	1.12E-01
Ps90%/90% (+KTL) Un-Biased	1.67E+01	1.67E+01	1.67E+01	1.66E+01	1.67E+01	1.66E+01	1.66E+01
Ps90%/90% (-KTL) Un-Biased	1.61E+01	1.60E+01	1.60E+01	1.60E+01	1.59E+01	1.60E+01	1.60E+01
<b>Specification MIN</b>	<b>6.80E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>	<b>4.50E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

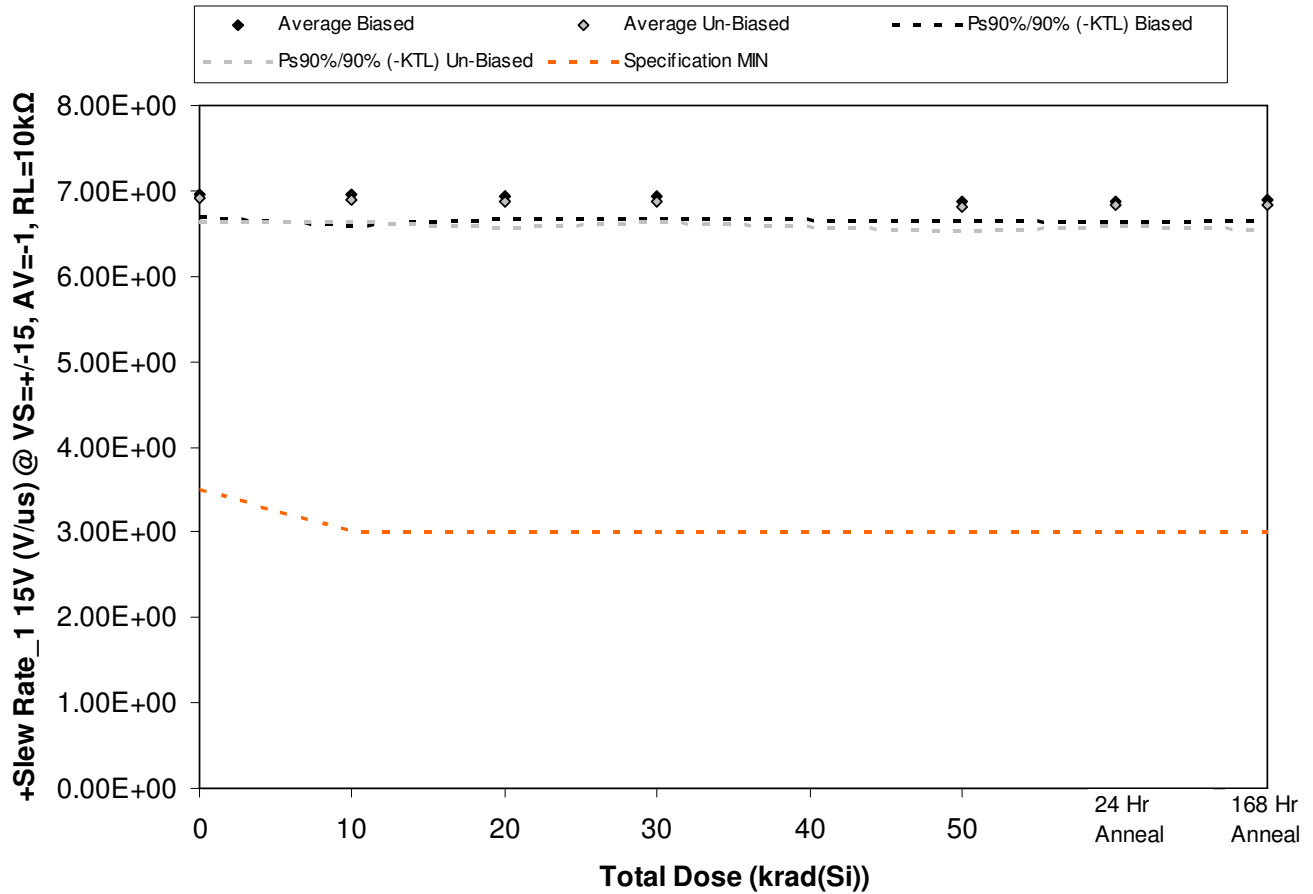


Figure 5.189. Plot of +Slew Rate\_1 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.189. Raw data for +Slew Rate\_1 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Slew Rate_1 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.83E+00	6.79E+00	6.80E+00	6.82E+00	6.76E+00	6.80E+00	6.77E+00
563	6.91E+00	6.89E+00	6.89E+00	6.86E+00	6.86E+00	6.81E+00	6.87E+00
564	6.99E+00	6.99E+00	6.98E+00	6.97E+00	6.93E+00	6.88E+00	6.92E+00
567	7.08E+00	7.15E+00	7.05E+00	7.06E+00	7.00E+00	7.02E+00	7.02E+00
569	6.94E+00	6.95E+00	6.91E+00	6.95E+00	6.87E+00	6.89E+00	6.89E+00
570	6.99E+00	6.98E+00	6.98E+00	6.95E+00	6.91E+00	6.92E+00	6.92E+00
571	6.78E+00	6.76E+00	6.72E+00	6.75E+00	6.67E+00	6.71E+00	6.70E+00
572	7.04E+00	6.97E+00	6.97E+00	6.96E+00	6.94E+00	6.92E+00	6.97E+00
573	6.87E+00	6.84E+00	6.82E+00	6.82E+00	6.76E+00	6.81E+00	6.80E+00
574	6.87E+00	6.89E+00	6.86E+00	6.85E+00	6.82E+00	6.81E+00	6.81E+00
584	6.62E+00	6.65E+00	6.63E+00	6.65E+00	6.63E+00	6.64E+00	6.65E+00
585	6.83E+00	6.82E+00	6.85E+00	6.82E+00	6.82E+00	6.80E+00	6.80E+00
<b>Biased Statistics</b>							
Average Biased	6.95E+00	6.95E+00	6.93E+00	6.93E+00	6.88E+00	6.88E+00	6.89E+00
Std Dev Biased	9.30E-02	1.33E-01	9.45E-02	9.47E-02	8.91E-02	8.80E-02	9.02E-02
Ps90%/90% (+KTL) Biased	7.21E+00	7.32E+00	7.19E+00	7.19E+00	7.13E+00	7.12E+00	7.14E+00
Ps90%/90% (-KTL) Biased	6.69E+00	6.59E+00	6.67E+00	6.67E+00	6.64E+00	6.64E+00	6.65E+00
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.91E+00	6.89E+00	6.87E+00	6.87E+00	6.82E+00	6.83E+00	6.84E+00
Std Dev Un-Biased	1.04E-01	9.20E-02	1.09E-01	8.91E-02	1.10E-01	8.85E-02	1.07E-01
Ps90%/90% (+KTL) Un-Biased	7.20E+00	7.14E+00	7.17E+00	7.11E+00	7.12E+00	7.08E+00	7.13E+00
Ps90%/90% (-KTL) Un-Biased	6.62E+00	6.64E+00	6.57E+00	6.62E+00	6.52E+00	6.59E+00	6.55E+00
<b>Specification MIN</b>	<b>3.50E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

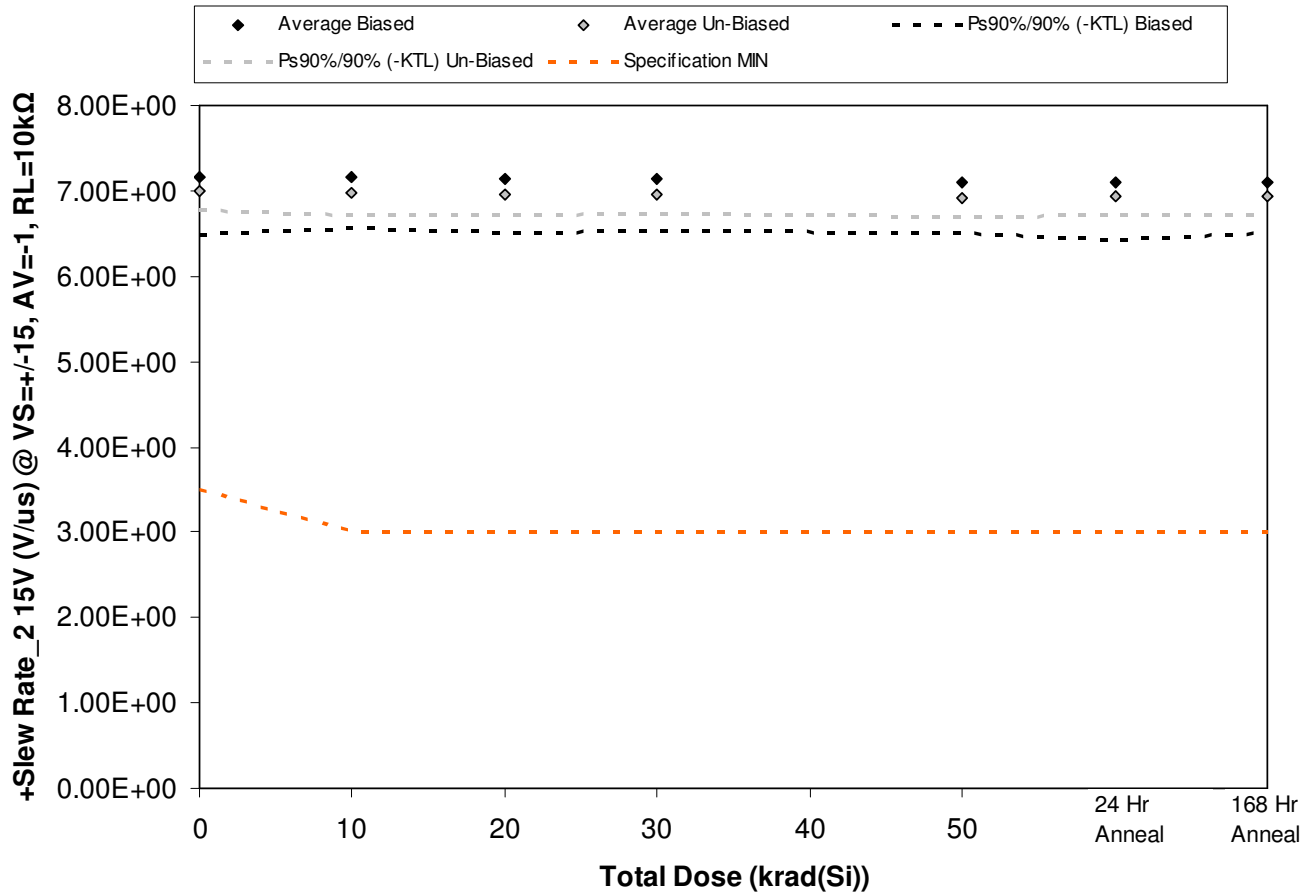


Figure 5.190. Plot of +Slew Rate\_2 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.190. Raw data for +Slew Rate\_2 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Slew Rate_2 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.96E+00	6.96E+00	6.98E+00	6.97E+00	6.91E+00	6.90E+00	6.91E+00
563	7.59E+00	7.53E+00	7.55E+00	7.54E+00	7.45E+00	7.50E+00	7.46E+00
564	7.16E+00	7.17E+00	7.09E+00	7.11E+00	7.08E+00	7.07E+00	7.08E+00
567	7.09E+00	7.14E+00	7.09E+00	7.14E+00	7.10E+00	7.05E+00	7.10E+00
569	7.03E+00	7.03E+00	7.00E+00	6.99E+00	6.95E+00	6.93E+00	6.95E+00
570	7.09E+00	7.08E+00	7.02E+00	7.02E+00	7.00E+00	6.98E+00	7.00E+00
571	6.97E+00	6.97E+00	6.96E+00	6.96E+00	6.92E+00	6.90E+00	6.93E+00
572	7.02E+00	7.03E+00	7.03E+00	7.01E+00	6.98E+00	7.00E+00	6.96E+00
573	6.87E+00	6.83E+00	6.80E+00	6.81E+00	6.79E+00	6.81E+00	6.79E+00
574	7.01E+00	6.96E+00	6.97E+00	6.97E+00	6.90E+00	6.95E+00	6.95E+00
584	7.30E+00	7.35E+00	7.36E+00	7.30E+00	7.31E+00	7.30E+00	7.34E+00
585	7.26E+00	7.24E+00	7.29E+00	7.26E+00	7.26E+00	7.22E+00	7.26E+00
<b>Biased Statistics</b>							
Average Biased	7.17E+00	7.17E+00	7.14E+00	7.15E+00	7.10E+00	7.09E+00	7.10E+00
Std Dev Biased	2.48E-01	2.20E-01	2.34E-01	2.30E-01	2.13E-01	2.41E-01	2.17E-01
Ps90%/90% (+KTL) Biased	7.85E+00	7.77E+00	7.78E+00	7.78E+00	7.68E+00	7.75E+00	7.70E+00
Ps90%/90% (-KTL) Biased	6.49E+00	6.56E+00	6.50E+00	6.52E+00	6.51E+00	6.43E+00	6.50E+00
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.99E+00	6.97E+00	6.96E+00	6.95E+00	6.92E+00	6.93E+00	6.93E+00
Std Dev Un-Biased	8.07E-02	9.40E-02	9.24E-02	8.44E-02	8.26E-02	7.60E-02	8.02E-02
Ps90%/90% (+KTL) Un-Biased	7.21E+00	7.23E+00	7.21E+00	7.19E+00	7.14E+00	7.14E+00	7.15E+00
Ps90%/90% (-KTL) Un-Biased	6.77E+00	6.72E+00	6.70E+00	6.72E+00	6.69E+00	6.72E+00	6.71E+00
<b>Specification MIN</b>	<b>3.50E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



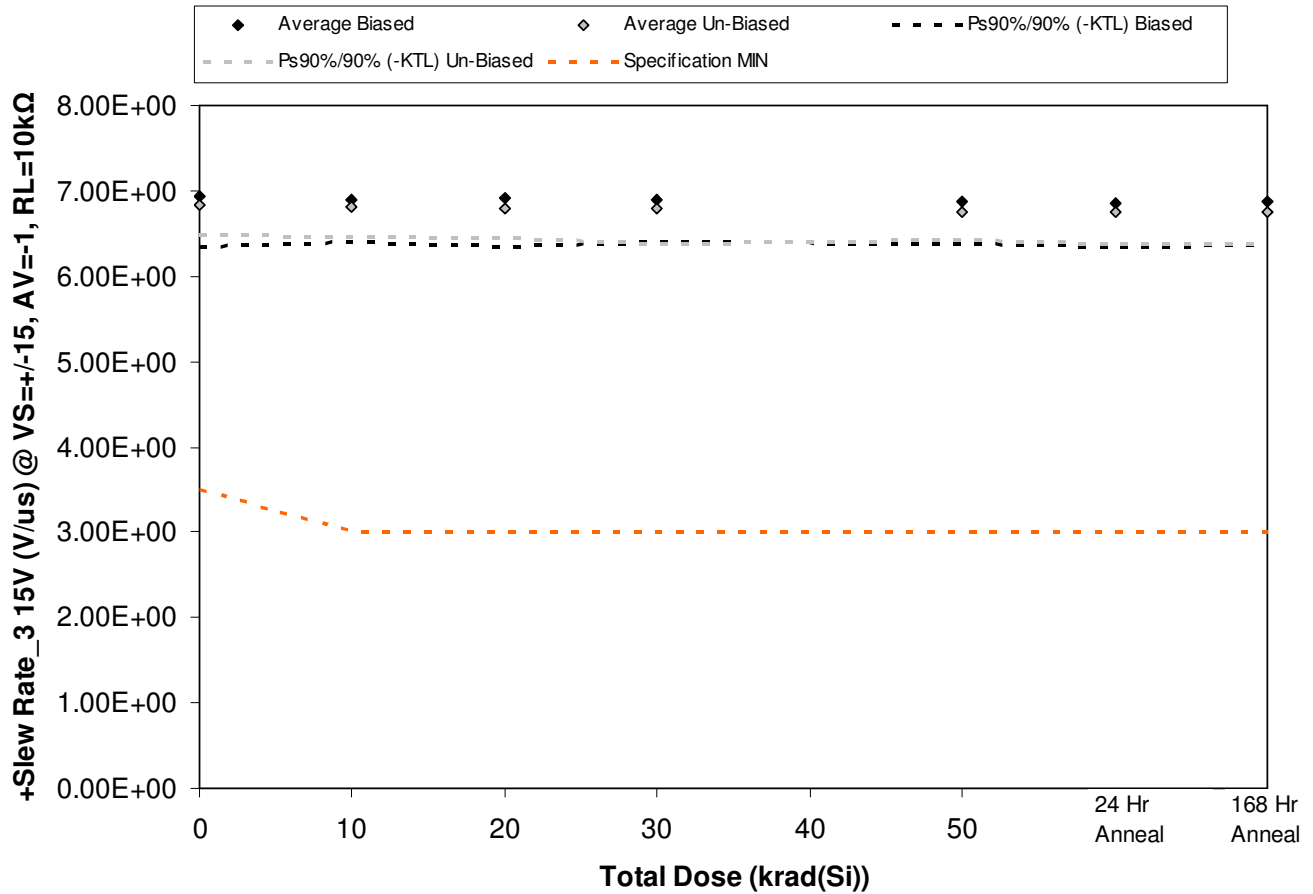


Figure 5.191. Plot of +Slew Rate\_3 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.191. Raw data for +Slew Rate\_3 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Slew Rate_3 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.70E+00	6.69E+00	6.65E+00	6.70E+00	6.67E+00	6.65E+00	6.66E+00
563	7.18E+00	7.09E+00	7.15E+00	7.11E+00	7.08E+00	7.06E+00	7.09E+00
564	7.06E+00	7.03E+00	7.05E+00	7.02E+00	6.99E+00	6.99E+00	7.00E+00
567	7.00E+00	6.98E+00	6.98E+00	6.95E+00	6.91E+00	6.90E+00	6.92E+00
569	6.72E+00	6.73E+00	6.74E+00	6.72E+00	6.71E+00	6.68E+00	6.70E+00
570	7.02E+00	7.00E+00	6.97E+00	7.00E+00	6.91E+00	6.92E+00	6.96E+00
571	6.82E+00	6.78E+00	6.75E+00	6.77E+00	6.71E+00	6.69E+00	6.69E+00
572	6.80E+00	6.82E+00	6.81E+00	6.77E+00	6.75E+00	6.75E+00	6.76E+00
573	6.67E+00	6.64E+00	6.61E+00	6.59E+00	6.58E+00	6.57E+00	6.60E+00
574	6.83E+00	6.82E+00	6.83E+00	6.84E+00	6.76E+00	6.78E+00	6.79E+00
584	6.97E+00	6.97E+00	7.01E+00	6.97E+00	6.94E+00	6.92E+00	6.97E+00
585	6.94E+00	6.93E+00	6.99E+00	6.95E+00	6.99E+00	6.93E+00	6.96E+00
<b>Biased Statistics</b>							
Average Biased	6.93E+00	6.90E+00	6.91E+00	6.90E+00	6.87E+00	6.86E+00	6.87E+00
Std Dev Biased	2.13E-01	1.82E-01	2.11E-01	1.83E-01	1.77E-01	1.84E-01	1.88E-01
Ps90%/90% (+KTL) Biased	7.52E+00	7.40E+00	7.49E+00	7.40E+00	7.36E+00	7.36E+00	7.39E+00
Ps90%/90% (-KTL) Biased	6.35E+00	6.41E+00	6.33E+00	6.40E+00	6.39E+00	6.35E+00	6.36E+00
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.83E+00	6.81E+00	6.79E+00	6.79E+00	6.74E+00	6.74E+00	6.76E+00
Std Dev Un-Biased	1.25E-01	1.29E-01	1.31E-01	1.48E-01	1.18E-01	1.28E-01	1.34E-01
Ps90%/90% (+KTL) Un-Biased	7.17E+00	7.16E+00	7.15E+00	7.20E+00	7.07E+00	7.09E+00	7.13E+00
Ps90%/90% (-KTL) Un-Biased	6.48E+00	6.46E+00	6.44E+00	6.39E+00	6.42E+00	6.39E+00	6.39E+00
<b>Specification MIN</b>	<b>3.50E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

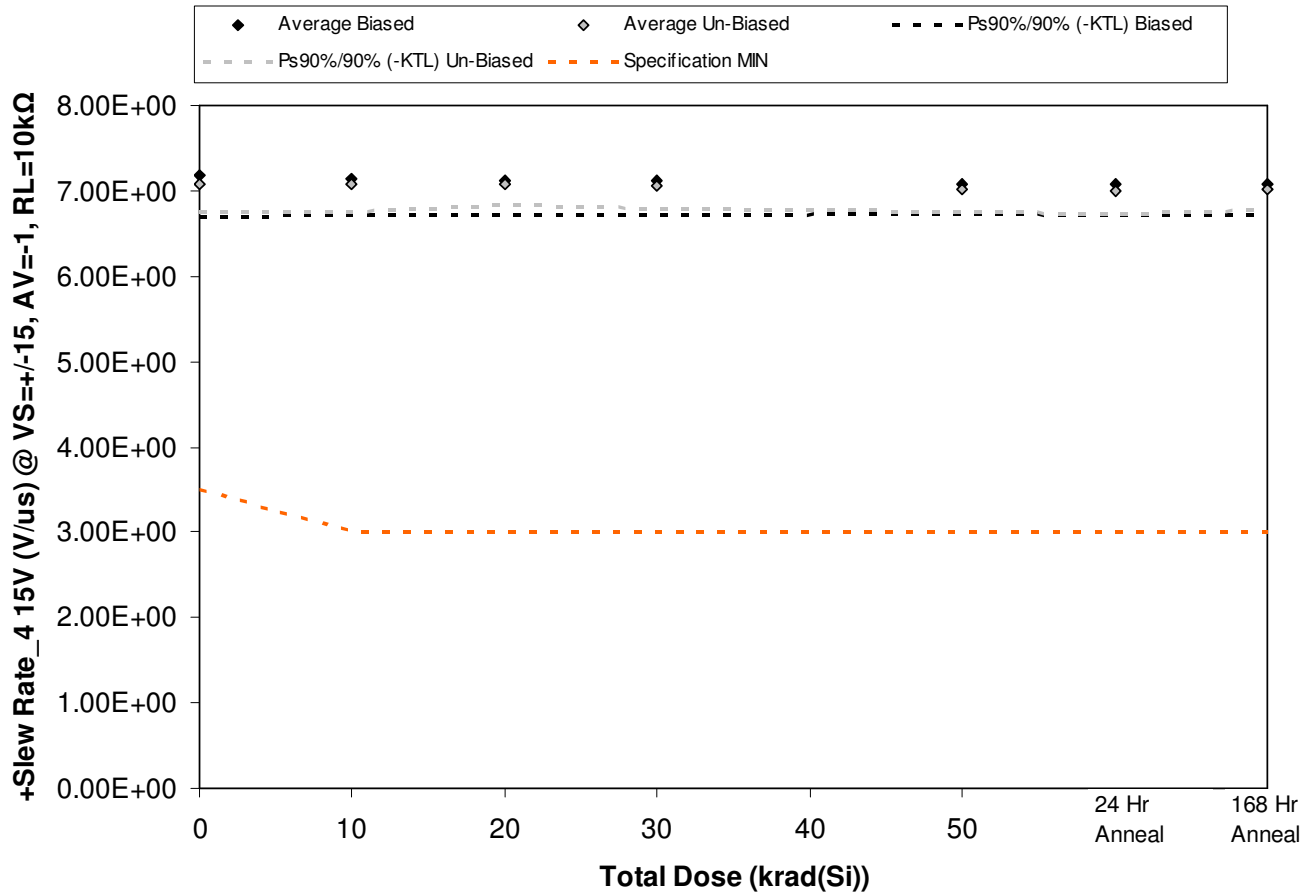


Figure 5.192. Plot of +Slew Rate\_4 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.192. Raw data for +Slew Rate\_4 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

+Slew Rate_4 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.91E+00	6.92E+00	6.91E+00	6.90E+00	6.88E+00	6.88E+00	6.87E+00
563	7.12E+00	7.09E+00	7.04E+00	7.10E+00	7.08E+00	7.08E+00	7.05E+00
564	7.24E+00	7.15E+00	7.13E+00	7.14E+00	7.09E+00	7.07E+00	7.11E+00
567	7.39E+00	7.36E+00	7.30E+00	7.31E+00	7.22E+00	7.25E+00	7.23E+00
569	7.25E+00	7.23E+00	7.22E+00	7.17E+00	7.12E+00	7.12E+00	7.16E+00
570	7.25E+00	7.23E+00	7.15E+00	7.16E+00	7.09E+00	7.10E+00	7.12E+00
571	6.91E+00	6.91E+00	6.92E+00	6.90E+00	6.86E+00	6.84E+00	6.87E+00
572	7.10E+00	7.12E+00	7.12E+00	7.10E+00	7.07E+00	7.04E+00	7.08E+00
573	7.12E+00	7.10E+00	7.09E+00	7.09E+00	7.07E+00	7.02E+00	7.03E+00
574	7.05E+00	7.04E+00	7.11E+00	7.05E+00	6.98E+00	7.01E+00	7.03E+00
584	6.72E+00	6.78E+00	6.74E+00	6.75E+00	6.76E+00	6.73E+00	6.74E+00
585	6.98E+00	6.99E+00	6.91E+00	6.95E+00	6.93E+00	6.95E+00	6.95E+00
<b>Biased Statistics</b>							
Average Biased	7.18E+00	7.15E+00	7.12E+00	7.12E+00	7.08E+00	7.08E+00	7.08E+00
Std Dev Biased	1.80E-01	1.64E-01	1.52E-01	1.48E-01	1.24E-01	1.33E-01	1.37E-01
Ps90%/90% (+KTL) Biased	7.67E+00	7.60E+00	7.54E+00	7.53E+00	7.42E+00	7.44E+00	7.46E+00
Ps90%/90% (-KTL) Biased	6.69E+00	6.70E+00	6.70E+00	6.72E+00	6.74E+00	6.72E+00	6.71E+00
<b>Un-Biased Statistics</b>							
Average Un-Biased	7.09E+00	7.08E+00	7.08E+00	7.06E+00	7.01E+00	7.00E+00	7.03E+00
Std Dev Un-Biased	1.23E-01	1.17E-01	9.09E-02	9.77E-02	9.61E-02	9.71E-02	9.50E-02
Ps90%/90% (+KTL) Un-Biased	7.42E+00	7.40E+00	7.33E+00	7.33E+00	7.28E+00	7.27E+00	7.29E+00
Ps90%/90% (-KTL) Un-Biased	6.75E+00	6.76E+00	6.83E+00	6.79E+00	6.75E+00	6.74E+00	6.77E+00
<b>Specification MIN</b>	<b>3.50E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

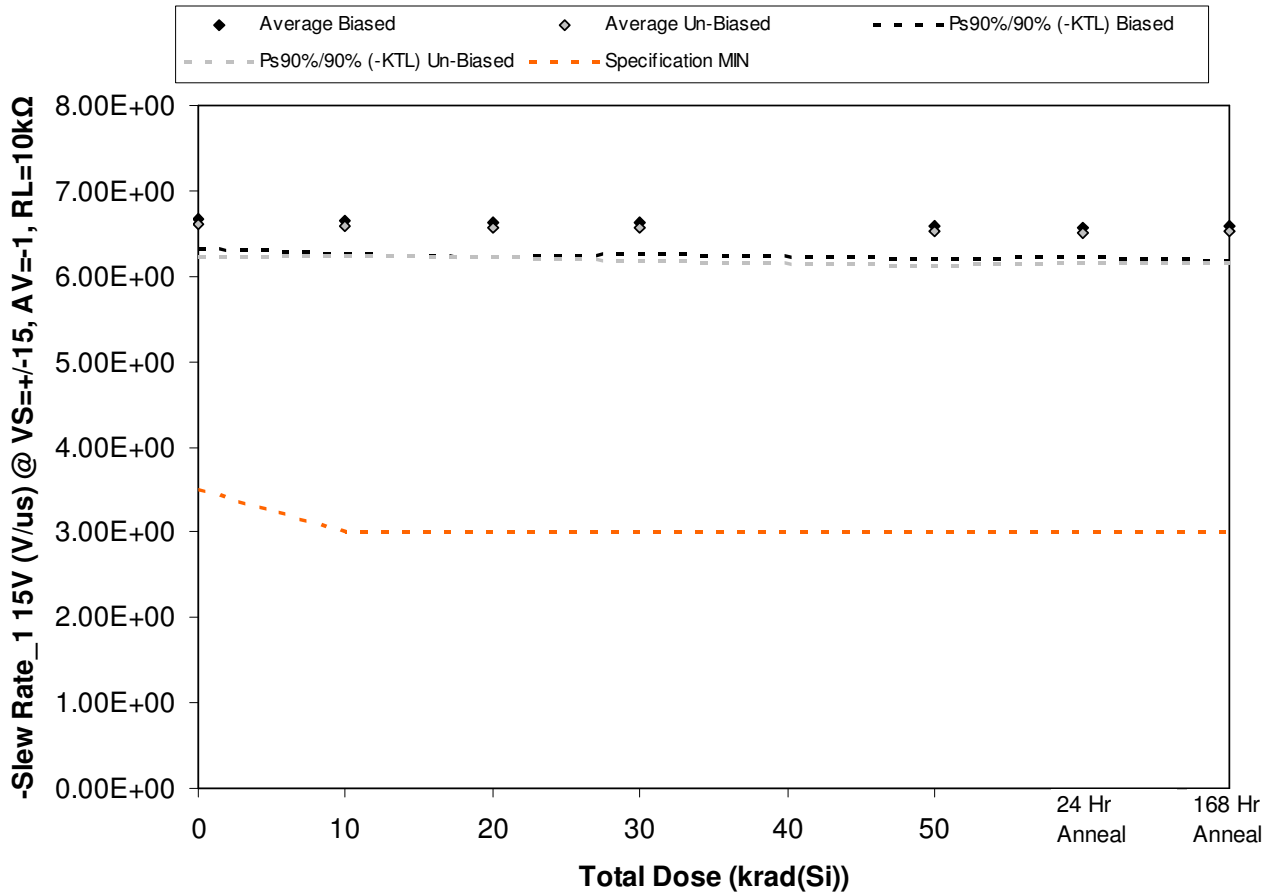


Figure 5.193. Plot of -Slew Rate\_1 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.193. Raw data for -Slew Rate\_1 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Slew Rate_1 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.47E+00	6.44E+00	6.43E+00	6.44E+00	6.40E+00	6.39E+00	6.38E+00
563	6.64E+00	6.60E+00	6.55E+00	6.58E+00	6.53E+00	6.51E+00	6.54E+00
564	6.78E+00	6.75E+00	6.75E+00	6.71E+00	6.72E+00	6.63E+00	6.70E+00
567	6.78E+00	6.79E+00	6.80E+00	6.78E+00	6.75E+00	6.73E+00	6.76E+00
569	6.67E+00	6.64E+00	6.64E+00	6.62E+00	6.59E+00	6.55E+00	6.57E+00
570	6.74E+00	6.72E+00	6.72E+00	6.72E+00	6.64E+00	6.65E+00	6.66E+00
571	6.44E+00	6.44E+00	6.43E+00	6.39E+00	6.33E+00	6.35E+00	6.35E+00
572	6.77E+00	6.72E+00	6.71E+00	6.70E+00	6.69E+00	6.64E+00	6.66E+00
573	6.53E+00	6.50E+00	6.50E+00	6.50E+00	6.43E+00	6.44E+00	6.47E+00
574	6.55E+00	6.57E+00	6.53E+00	6.54E+00	6.50E+00	6.47E+00	6.50E+00
584	6.19E+00	6.17E+00	6.18E+00	6.17E+00	6.20E+00	6.19E+00	6.21E+00
585	6.51E+00	6.51E+00	6.57E+00	6.50E+00	6.52E+00	6.50E+00	6.50E+00
<b>Biased Statistics</b>							
Average Biased	6.67E+00	6.64E+00	6.63E+00	6.63E+00	6.60E+00	6.56E+00	6.59E+00
Std Dev Biased	1.28E-01	1.38E-01	1.50E-01	1.30E-01	1.43E-01	1.28E-01	1.48E-01
Ps90%/90% (+KTL) Biased	7.02E+00	7.02E+00	7.04E+00	6.98E+00	6.99E+00	6.91E+00	7.00E+00
Ps90%/90% (-KTL) Biased	6.32E+00	6.27E+00	6.22E+00	6.27E+00	6.21E+00	6.21E+00	6.18E+00
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.61E+00	6.59E+00	6.58E+00	6.57E+00	6.52E+00	6.51E+00	6.53E+00
Std Dev Un-Biased	1.43E-01	1.27E-01	1.30E-01	1.39E-01	1.48E-01	1.31E-01	1.33E-01
Ps90%/90% (+KTL) Un-Biased	7.00E+00	6.94E+00	6.94E+00	6.95E+00	6.92E+00	6.87E+00	6.89E+00
Ps90%/90% (-KTL) Un-Biased	6.22E+00	6.24E+00	6.22E+00	6.19E+00	6.11E+00	6.15E+00	6.16E+00
<b>Specification MIN</b>	<b>3.50E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

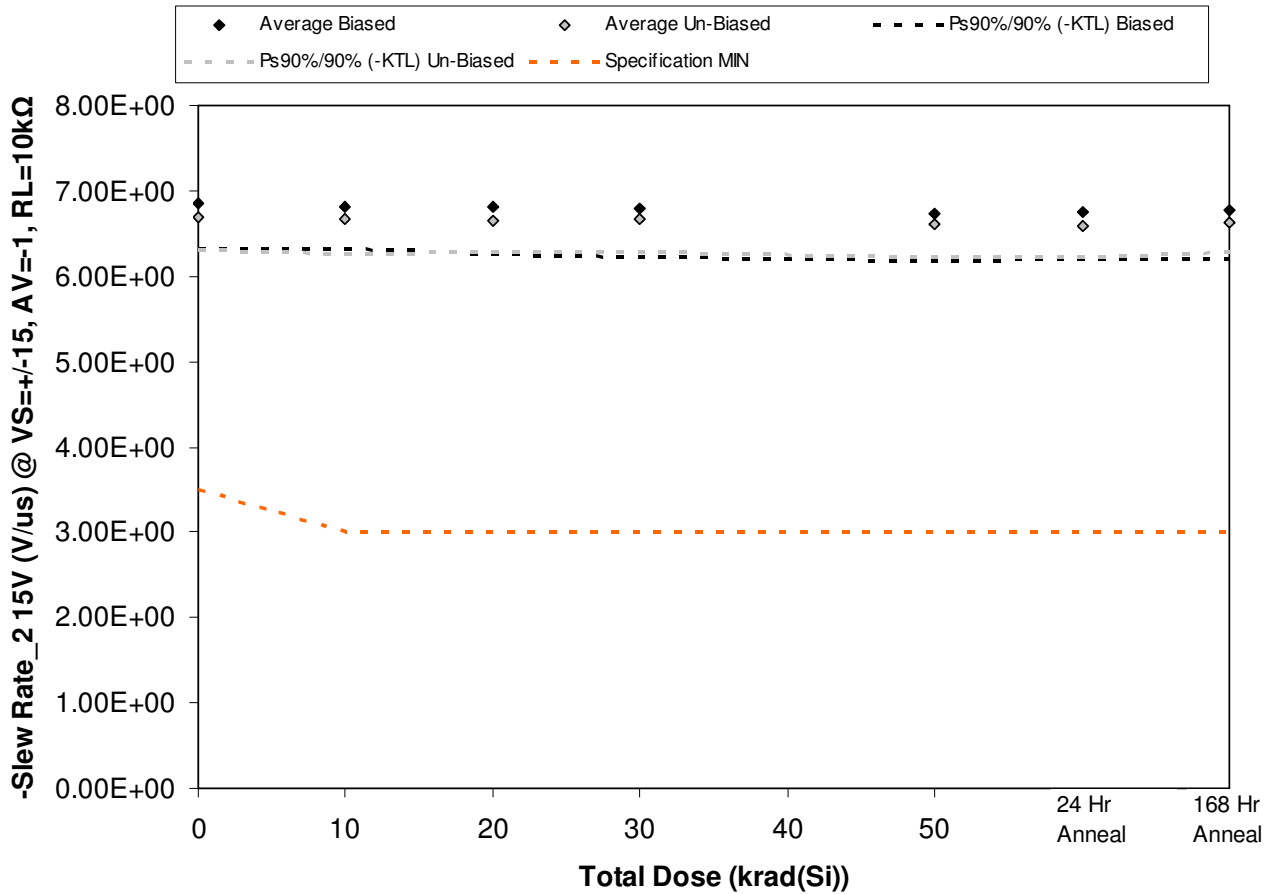


Figure 5.194. Plot of -Slew Rate\_2 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.194. Raw data for -Slew Rate\_2 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Slew Rate_2 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.66E+00	6.62E+00	6.61E+00	6.59E+00	6.54E+00	6.54E+00	6.57E+00
563	7.13E+00	7.09E+00	7.11E+00	7.12E+00	7.05E+00	7.07E+00	7.09E+00
564	6.91E+00	6.86E+00	6.85E+00	6.84E+00	6.79E+00	6.81E+00	6.80E+00
567	6.83E+00	6.83E+00	6.81E+00	6.80E+00	6.73E+00	6.73E+00	6.76E+00
569	6.70E+00	6.68E+00	6.64E+00	6.64E+00	6.58E+00	6.62E+00	6.61E+00
570	6.84E+00	6.82E+00	6.81E+00	6.81E+00	6.76E+00	6.72E+00	6.75E+00
571	6.69E+00	6.65E+00	6.62E+00	6.67E+00	6.57E+00	6.58E+00	6.62E+00
572	6.77E+00	6.75E+00	6.73E+00	6.75E+00	6.68E+00	6.65E+00	6.68E+00
573	6.46E+00	6.43E+00	6.45E+00	6.44E+00	6.38E+00	6.36E+00	6.41E+00
574	6.70E+00	6.71E+00	6.68E+00	6.67E+00	6.65E+00	6.62E+00	6.67E+00
584	6.97E+00	6.99E+00	6.99E+00	6.95E+00	6.95E+00	6.96E+00	6.97E+00
585	6.93E+00	6.95E+00	6.98E+00	6.96E+00	6.92E+00	6.85E+00	6.92E+00
<b>Biased Statistics</b>							
Average Biased	6.85E+00	6.82E+00	6.80E+00	6.80E+00	6.74E+00	6.75E+00	6.77E+00
Std Dev Biased	1.88E-01	1.83E-01	2.00E-01	2.08E-01	2.03E-01	2.05E-01	2.05E-01
Ps90%/90% (+KTL) Biased	7.36E+00	7.32E+00	7.35E+00	7.37E+00	7.29E+00	7.31E+00	7.33E+00
Ps90%/90% (-KTL) Biased	6.33E+00	6.31E+00	6.26E+00	6.23E+00	6.18E+00	6.19E+00	6.20E+00
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.69E+00	6.67E+00	6.66E+00	6.67E+00	6.61E+00	6.59E+00	6.63E+00
Std Dev Un-Biased	1.43E-01	1.49E-01	1.36E-01	1.40E-01	1.44E-01	1.36E-01	1.29E-01
Ps90%/90% (+KTL) Un-Biased	7.08E+00	7.08E+00	7.03E+00	7.05E+00	7.00E+00	6.96E+00	6.98E+00
Ps90%/90% (-KTL) Un-Biased	6.30E+00	6.26E+00	6.29E+00	6.28E+00	6.21E+00	6.21E+00	6.27E+00
<b>Specification MIN</b>	<b>3.50E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



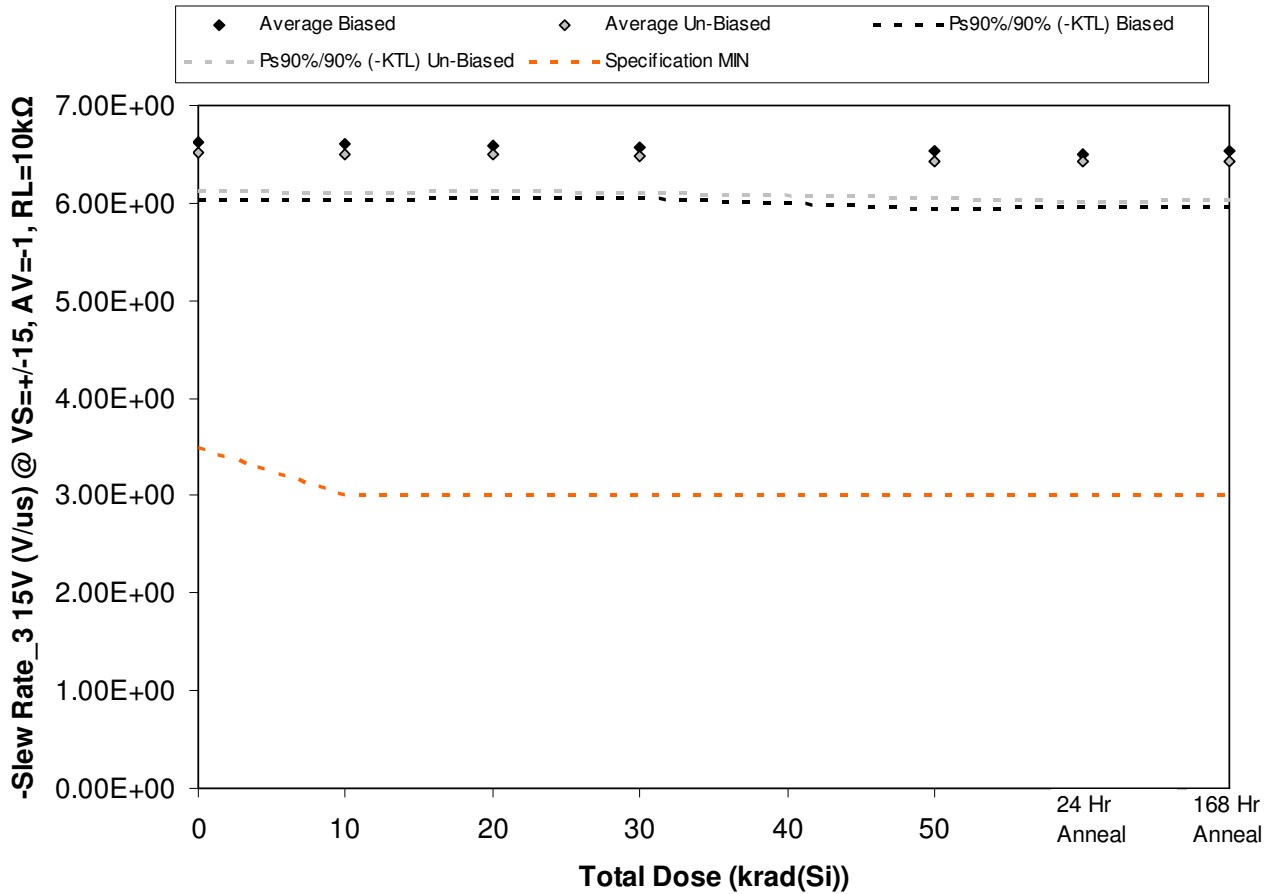


Figure 5.195. Plot of -Slew Rate\_3 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.195. Raw data for -Slew Rate\_3 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Slew Rate_3 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.44E+00	6.43E+00	6.42E+00	6.41E+00	6.35E+00	6.37E+00	6.39E+00
563	6.88E+00	6.84E+00	6.81E+00	6.79E+00	6.80E+00	6.76E+00	6.80E+00
564	6.77E+00	6.75E+00	6.72E+00	6.71E+00	6.66E+00	6.64E+00	6.68E+00
567	6.64E+00	6.62E+00	6.61E+00	6.58E+00	6.54E+00	6.49E+00	6.55E+00
569	6.38E+00	6.36E+00	6.35E+00	6.35E+00	6.28E+00	6.27E+00	6.28E+00
570	6.66E+00	6.64E+00	6.62E+00	6.63E+00	6.57E+00	6.58E+00	6.57E+00
571	6.53E+00	6.52E+00	6.49E+00	6.47E+00	6.42E+00	6.43E+00	6.42E+00
572	6.59E+00	6.55E+00	6.59E+00	6.55E+00	6.51E+00	6.52E+00	6.51E+00
573	6.28E+00	6.26E+00	6.28E+00	6.26E+00	6.20E+00	6.19E+00	6.19E+00
574	6.55E+00	6.52E+00	6.49E+00	6.49E+00	6.47E+00	6.43E+00	6.47E+00
584	6.68E+00	6.69E+00	6.66E+00	6.70E+00	6.69E+00	6.65E+00	6.65E+00
585	6.65E+00	6.70E+00	6.73E+00	6.70E+00	6.69E+00	6.67E+00	6.70E+00
<b>Biased Statistics</b>							
Average Biased	6.62E+00	6.60E+00	6.58E+00	6.57E+00	6.53E+00	6.51E+00	6.54E+00
Std Dev Biased	2.12E-01	2.04E-01	1.95E-01	1.88E-01	2.15E-01	1.98E-01	2.11E-01
Ps90%/90% (+KTL) Biased	7.20E+00	7.16E+00	7.12E+00	7.08E+00	7.12E+00	7.05E+00	7.12E+00
Ps90%/90% (-KTL) Biased	6.04E+00	6.04E+00	6.05E+00	6.05E+00	5.94E+00	5.96E+00	5.96E+00
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.52E+00	6.50E+00	6.49E+00	6.48E+00	6.43E+00	6.43E+00	6.43E+00
Std Dev Un-Biased	1.44E-01	1.42E-01	1.33E-01	1.38E-01	1.42E-01	1.48E-01	1.46E-01
Ps90%/90% (+KTL) Un-Biased	6.92E+00	6.89E+00	6.86E+00	6.86E+00	6.82E+00	6.84E+00	6.83E+00
Ps90%/90% (-KTL) Un-Biased	6.13E+00	6.11E+00	6.13E+00	6.10E+00	6.04E+00	6.02E+00	6.03E+00
<b>Specification MIN</b>	<b>3.50E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS

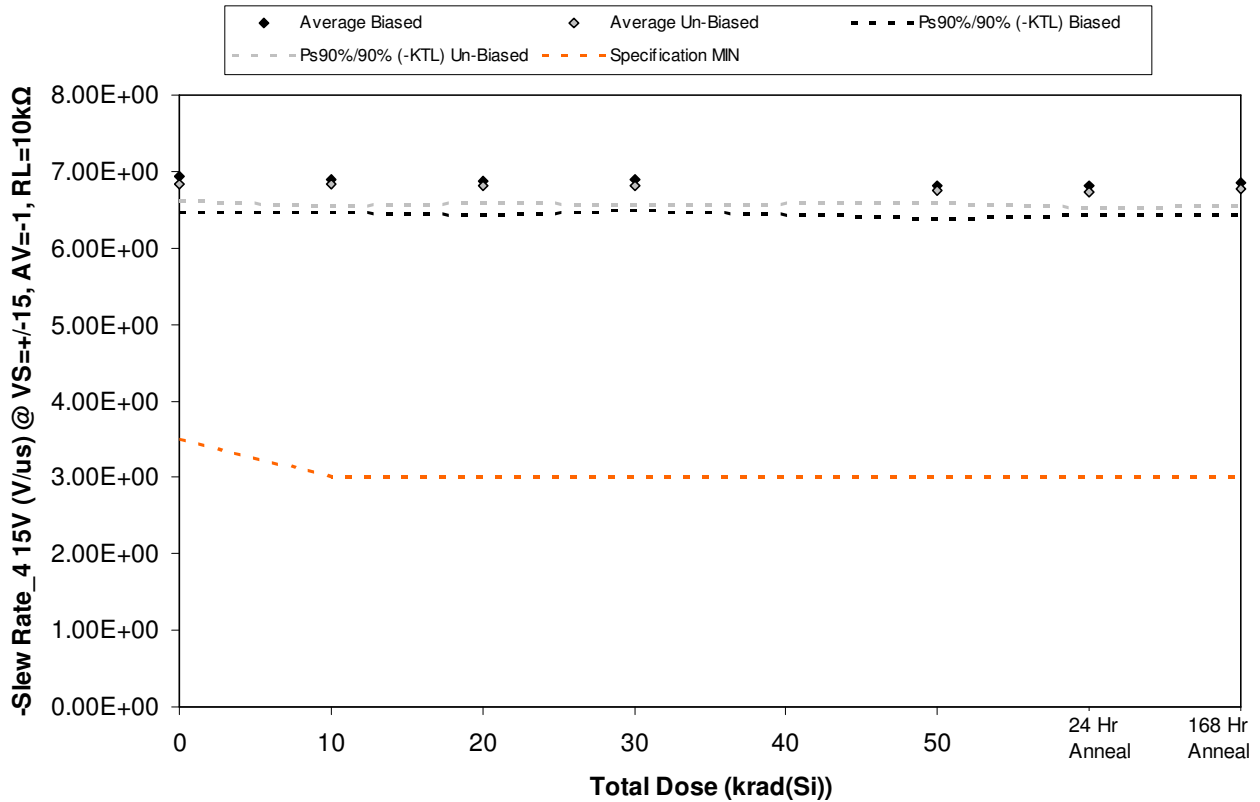


Figure 5.196. Plot of -Slew Rate\_4 15V (V/us) @ VS=+-15, AV=-1, RL=10kΩ versus total dose. The solid diamonds are the average of the measured data points for the samples irradiated under electrical bias while the shaded diamonds are the average of the measured data points for the samples irradiated with all pins tied to ground. The black lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated under electrical bias while the gray lines (solid and/or dashed) are the average of the data points after application of the KTL statistics on the samples irradiated in the unbiased condition. The red dotted line(s) are the pre- and/or post-irradiation minimum and/or maximum specification value as defined in the datasheet and/or test plan.



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Table 5.196. Raw data for -Slew Rate\_4 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ versus total dose, including the statistical analysis, specification and the status of the testing (pass/fail).

-Slew Rate_4 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ	Total Dose (krad(Si))					24 Hr Anneal	168 Hr Anneal
	0	10	20	30	50		
Device							
557	6.66E+00	6.65E+00	6.61E+00	6.65E+00	6.56E+00	6.57E+00	6.59E+00
563	6.91E+00	6.87E+00	6.87E+00	6.87E+00	6.81E+00	6.81E+00	6.83E+00
564	7.00E+00	6.96E+00	6.90E+00	6.93E+00	6.88E+00	6.85E+00	6.91E+00
567	7.11E+00	7.08E+00	7.06E+00	7.06E+00	6.98E+00	6.93E+00	6.99E+00
569	6.99E+00	6.96E+00	6.91E+00	6.92E+00	6.88E+00	6.86E+00	6.90E+00
570	6.95E+00	6.95E+00	6.93E+00	6.94E+00	6.83E+00	6.83E+00	6.88E+00
571	6.74E+00	6.70E+00	6.71E+00	6.74E+00	6.68E+00	6.64E+00	6.67E+00
572	6.90E+00	6.92E+00	6.87E+00	6.89E+00	6.82E+00	6.80E+00	6.83E+00
573	6.80E+00	6.81E+00	6.78E+00	6.78E+00	6.73E+00	6.69E+00	6.74E+00
574	6.82E+00	6.78E+00	6.81E+00	6.75E+00	6.73E+00	6.74E+00	6.73E+00
584	6.52E+00	6.52E+00	6.53E+00	6.53E+00	6.50E+00	6.51E+00	6.52E+00
585	6.79E+00	6.81E+00	6.81E+00	6.81E+00	6.81E+00	6.77E+00	6.81E+00
<b>Biased Statistics</b>							
Average Biased	6.93E+00	6.90E+00	6.87E+00	6.89E+00	6.82E+00	6.80E+00	6.84E+00
Std Dev Biased	1.69E-01	1.60E-01	1.63E-01	1.49E-01	1.58E-01	1.38E-01	1.53E-01
Ps90%/90% (+KTL) Biased	7.40E+00	7.34E+00	7.32E+00	7.30E+00	7.26E+00	7.18E+00	7.26E+00
Ps90%/90% (-KTL) Biased	6.47E+00	6.46E+00	6.42E+00	6.48E+00	6.39E+00	6.43E+00	6.42E+00
<b>Un-Biased Statistics</b>							
Average Un-Biased	6.84E+00	6.83E+00	6.82E+00	6.82E+00	6.76E+00	6.74E+00	6.77E+00
Std Dev Un-Biased	8.32E-02	1.03E-01	8.43E-02	8.97E-02	6.46E-02	7.78E-02	8.40E-02
Ps90%/90% (+KTL) Un-Biased	7.07E+00	7.11E+00	7.05E+00	7.07E+00	6.94E+00	6.95E+00	7.00E+00
Ps90%/90% (-KTL) Un-Biased	6.61E+00	6.55E+00	6.59E+00	6.57E+00	6.58E+00	6.53E+00	6.54E+00
<b>Specification MIN</b>	<b>3.50E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>	<b>3.00E+00</b>
Status	PASS	PASS	PASS	PASS	PASS	PASS	PASS



## **6.0. Summary / Conclusions**

The low dose rate testing described in this final report was performed using the facilities at Aeroflex RAD's Longmire Laboratories in Colorado Springs, CO. The low dose rate source is a GB-150 irradiator modified to provide a panoramic exposure. The Co-60 rods are held in the base of the irradiator heavily shielded by lead. During the irradiation exposures the rod is raised by an electronic timer/controller and the exposure is performed in air. The dose rate for this irradiator in this configuration ranges from approximately 1mrad(Si)/s to a maximum of approximately 50rad(Si)/s, determined by the distance from the source.

The parametric data was obtained as "read and record" and all the raw data plus an attributes summary are contained in this report as well as in a separate Excel file. The attributes data contains the average, standard deviation and the average with the KTL values applied. The KTL value used in this work is 2.742 per MIL-HDBK-814 using one sided tolerance limits of 90/90 and a 5-piece sample size. The 90/90 KTL values were selected to match the statistical levels specified in the MIL-PRF-38535 sampling plan for the qualification of a radiation hardness assured (RHA) component. Note that the following criteria must be met for a device to pass the low dose rate test: following the radiation exposure each of the 5 pieces irradiated under electrical bias shall pass the specification value. The units irradiated without electrical bias and the KTL statistics are included in this report for reference only. If any of the 5 pieces irradiated under electrical bias exceed the device post radiation data sheet specification limits, then the lot could be logged as a failure.

Based on this criterion the RH1499MW Quad Rail-to-Rail Input and Output Precision C-Load Op Amp (from the lot date code identified on the first page of this test report) PASSED the enhanced low dose rate sensitivity test to the maximum tested dose level of 50krad(Si) with all parameters remaining within their datasheet specifications. Further, the data in this report can be analyzed along with the high dose rate report titled "Total Ionizing Dose (TID) Radiation Testing of the RH1499MW Quad Rail-to-Rail Input and Output Precision C-Load Op Amp for Linear Technology" to demonstrate that these parts do not exhibit ELDRS as defined in the current test method.



**Appendix A: Photograph of Packing Label and a Sample Unit-Under-Test to Show Part Traceability**



**Appendix B: Radiation Bias Connections and Absolute Maximum Ratings**

**ELDRS Radiation Biased Conditions:** Extracted from Linear Technology RH1499M datasheet, ID No 66-10-1499.

Pin	Function	Connection / Bias
1	OUT A	To Pin 2 via 5kΩ & 40pF, in Parallel
2	-INPUT A	To Pin 1 via 5kΩ & 40pF, in Parallel
3	+INPUT A	To 8V via 5kΩ Resistor
4	V+	To +15V using 0.1μF Decoupling
5	+INPUT B	To 8V via 5kΩ Resistor
6	-INPUT B	To Pin 7 via 5kΩ & 40pF, in Parallel
7	OUT B	To Pin 6 via 5kΩ & 40pF, in Parallel
8	OUT C	To Pin 9 via 5kΩ & 40pF, in Parallel
9	-INPUT C	To Pin 8 via 5kΩ & 40pF, in Parallel
10	+INPUT C	To 8V via 5kΩ Resistor
11	V-	To -15V using 0.1μF Decoupling
12	+INPUT D	To 8V via 10kΩ Resistor
13	-INPUT D	To Pin 14 via 5kΩ & 40pF, in Parallel
14	OUT D	To Pin 13 via 5kΩ & 40pF, in Parallel

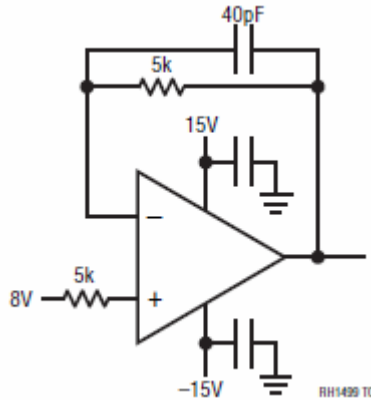


Figure B.1. Irradiation bias circuit. This figure was extracted from Linear Technology RH1499M datasheet, ID No 66-10-1499.



**ELDRS Radiation Unbiased Conditions:**

Pin	Function	Connection / Bias
1	OUT A	GND
2	-INPUT A	GND
3	+INPUT A	GND
4	V+	GND
5	+INPUT B	GND
6	-INPUT B	GND
7	OUT B	GND
8	OUT C	GND
9	-INPUT C	GND
10	+INPUT C	GND
11	V-	GND
12	+INPUT D	GND
13	-INPUT D	GND
14	OUT D	GND

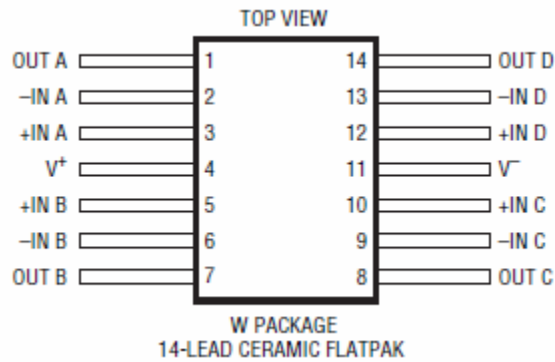


Figure B.2. W package drawing (for reference only). This figure was extracted from Linear Technology RH1499M datasheet, ID No 66-10-1499.

**Absolute Maximum Ratings:**

Parameter	Max Rating
Total Supply Voltage (V+ to V-)	36V
Input Current	±10mA
Output Short-Circuit Duration	Continuous





### ***Appendix C: Electrical Test Parameters and Conditions***

The expected ranges of values as well as the measurement conditions are taken from Linear Technology RH1499M datasheet. All electrical tests for this device are performed on one of Aeroflex RAD's LTS2020 Test Systems. The LTS2020 Test System is a programmable parametric tester that provides parameter measurements for a variety of digital, analog and mixed signal products including voltage regulators, voltage comparators, D to A and A to D converters. The LTS2020 Test System achieves accuracy and sensitivity through the use of software self-calibration and an internal relay matrix with separate family boards and custom personality adapter boards. The tester uses this relay matrix to connect the required test circuits, select the appropriate voltage / current sources and establish the needed measurement loops for all the tests performed. The measured parameters and test conditions are shown in Table C.1.

A listing of the measurement precision/resolution for each parameter is shown in Table C.2. The precision/resolution values were obtained from test data or from the DAC resolution of the LTS-2020 for the particular test shown, whichever is greater. To generate the precision/resolution shown in Table C.2, one of the units-under-test was tested repetitively (a total of 10-times with re-insertion between tests) to obtain the average test value and standard deviation. Using this test data MIL-HDBK-814 90/90 KTL statistics were applied to the measured standard deviation to generate the final measurement range. This value encompasses the precision/resolution of all aspects of the test system, including the LTS2020 mainframe, family board, socket assembly and DUT board as well as insertion error. In some cases, the measurement resolution is limited by the internal DACs, which results in a measured standard deviation of zero. In these instances the precision/resolution will be reported back as the LSB of the DAC.

Note that the testing and statistics used in this document are based on an “analysis of variables” technique, which relies on small sample sizes to qualify much larger lot sizes (see MIL-HDBK-814, p. 91 for a discussion of statistical treatments). Not all measured parameters are well suited to this approach due to inherent large variations. If necessary, larger samples sizes could be used to qualify these parameters using an “attributes” approach.



Table C.1. Measured parameters and test conditions for the RH1499MW Quad Rail-to-Rail Input and Output Precision C-Load Op Amp.

Parameter	Symbol	Test Conditions
+Supply Current 15V (A)	+ICC15	VS=+/-15V
-Supply Current 15V (A)	-IEE15	VS=+/-15V
Input Offset Voltage1 15V (V)	VOS1_1→4 15V	VS=+/-15V, VCM=0V
Input Offset Current1 15V (A)	IOS1_1→4 15V	VS=+/-15V, VCM=0V
+Input Bias Current BIAS1 15V (A)	+IBIAS1_1→4 15V	VS=+/-15V, VCM=0V
-Input Bias Current BIAS1 15V (A)	-IBIAS1_1→4 15V	VS=+/-15V, VCM=0V
Input Offset Voltage2 15V (V)	VOS2_1→4 15V	VS=+/-15V, VCM=15V
Input Offset Current2 15V (A)	IOS2_1→4 15V	VS=+/-15V, VCM=15V
+Input Bias Current BIAS2 15V (A)	+IBIAS2_1→4 15V	VS=+/-15V, VCM=15V
-Input Bias Current BIAS2 15V (A)	-IBIAS2_1→4 15V	VS=+/-15V, VCM=15V
Input Offset Voltage3 15V (V)	VOS3_1→4 15V	VS=+/-15V, VCM=-15V
Input Offset Current3 15V (A)	IOS3_1→4 15V	VS=+/-15V, VCM=-15V
+Input Bias Current BIAS3 15V (A)	+IBIAS3_1→4 15V	VS=+/-15V, VCM=-15V
-Input Bias Current BIAS3 15V (A)	-IBIAS3_1→4 15V	VS=+/-15V, VCM=-15V
Output Voltage Swing High1 15V (V)	+VOUT1_1→4 15V	VS=+/-15V IL=0mA
Output Voltage Swing High2 15V (V)	+VOUT2_1→4 15V	VS=+/-15V IL=1mA
Output Voltage Swing High3 15V (V)	+VOUT3_1→4 15V	VS=+/-15V IL=10mA
Output Voltage Swing Low1 15V (V)	-VOUT1_1→4 15V	VS=+/-15V IL=0mA
Output Voltage Swing Low2 15V (V)	-VOUT2_1→4 15V	VS=+/-15V IL=1mA
Output Voltage Swing Low3 15V (V)	-VOUT3_1→4 15V	VS=+/-15V IL=10mA
Large Signal Voltage Gain1 15V (V/mV)	AVOL1_1→4 15V	VO=+/-14.5V, RL=10kΩ
Large Signal Voltage Gain2 15V (V/mV)	AVOL2_1→4 15V	VO=+/-10V, RL=2kΩ
Common Mode Rejection Ratio1 15V (dB)	CMRR1_1→4 15V	VS=+/-15V, VCM=+/-15V
CMRR Match1 1 to 4 15V (dB)	CMRR1 MATCH 1 to 4 15V	VS=+/-15V, VCM=+/-15V
CMRR Match1 2 to 3 15V (dB)	CMRR1 MATCH 2 to 3 15V	VS=+/-15V, VCM=+/-15V
Power Supply Rejection Ratio1 (dB)	PSRR1_1→4	VS=+/-2V to +/-16V
PSRR Match1 1 to 4 (dB)	PSRR1 MATCH 1 to 4	VS=+/-2V to +/-16V
PSRR Match1 2 to 3 (dB)	PSRR1 MATCH 2 to 3	VS=+/-2V to +/-16V



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+Short-Circuit Current1 15V (A)	+ISC1_1→4 15V	VS=+/-15V, VOUT=0V
-Short-Circuit Current1 15V (A)	-ISC1_1→4 15V	VS=+/-15V, VOUT=0V
+Supply Current 5V (A)	+ICC5	VS=+5V
-Supply Current 5V (A)	-IEE5	VS=+5V
Input Offset Voltage4 5V (V)	VOS4_1→4 5V	VS=+5V, VCM=0V
Input Offset Current4 5V (A)	IOS4_1→4 5V	VS=+5V, VCM=0V
+Input Bias Current BIAS4 5V (A)	+IBIAS4_1→4 5V	VS=+5V, VCM=0V
-Input Bias Current BIAS4 5V (A)	-IBIAS4_1→4 5V	VS=+5V, VCM=0V
Input Offset Voltage5 5V (V)	VOS5_1→4 5V	VS=+5V, VCM=5V
Input Offset Current5 5V (A)	IOS5_1→4 5V	VS=+5V, VCM=5V
+Input Bias Current BIAS5 5V (A)	+IBIAS5_1→4 5V	VS=+5V, VCM=5V
-Input Bias Current BIAS5 5V (A)	-IBIAS5_1→4 5V	VS=+5V, VCM=5V
Output Voltage Swing High4 5V (V)	+VOUT4_1→4 5V	VS=+5V IL=0mA
Output Voltage Swing High5 5V (V)	+VOUT5_1→4 5V	VS=+5V IL=1mA
Output Voltage Swing High6 5V (V)	+VOUT6_1→4 5V	VS=+5V IL=2.5mA
Output Voltage Swing Low4 5V (V)	-VOUT4_1→4 5V	VS=+5V IL=0mA
Output Voltage Swing Low5 5V (V)	-VOUT5_1→4 5V	VS=+5V IL=1mA
Output Voltage Swing Low6 5V (V)	-VOUT6_1→4 5V	VS=+5V IL=2.5mA
Large Signal Voltage Gain3 5V (V/mV)	AVOL3_1→4 5V	VO=75mV to 4.8V, RL=10kΩ
Common Mode Rejection Ratio2 5V (dB)	CMRR2_1→4 5V	VS=+5V, VCM=0 to +5V
CMRR Match2 1 to 4 5V (dB)	CMRR2 MATCH 1 to 4 5V	VS=+5V, VCM=0 to +5V
CMRR Match2 2 to 3 5V (dB)	CMRR2 MATCH 2 to 3 5V	VS=+5V, VCM=0 to +5V
Power Supply Rejection Ratio2 (dB)	PSRR2_1→4	VS=+4.5V to +12V
PSRR Match2 1 to 4 (dB)	PSRR2 MATCH 1 to 4	VS=+4.5V to +12V
PSRR Match2 2 to 3 (dB)	PSRR2 MATCH 2 to 3	VS=+4.5V to +12V
+Short-Circuit Current2 5V (A)	+ISC2_1→4 5V	VS=+5V
-Short-Circuit Current2 5V (A)	-ISC2_1→4 5V	VS=+5V
Gain-Bandwidth Product 15V (MHz)	GBW_1→4 15V	VS=+/-15V, f=100kHz
+Slew Rate 15V (V/us)	+SR_1→4 5V	VS=+/-15V, AV=-1, RL=10K, VO=+/-10V
-Slew Rate 15V (V/us)	-SR_1→4 5V	VS=+/-15V, AV=-1, RL=10K, VO=+/-10V

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Table C.2. Measured parameters, pre-irradiation specifications and measurement precision for the RH1499MW Quad Rail-to-Rail Input and Output Precision C-Load Op Amp.

Parameter	Pre-Irradiation Specification		Measurement Precision/Resolution
	MIN	MAX	
+Supply Current 15V (A)		1.00E-02	±1.64E-04
-Supply Current 15V (A)	-1.00E-02		±1.61E-04
Input Offset Voltage1 15V (V)	-8.00E-04	8.00E-04	±2.51E-05
Input Offset Current1 15V (A)	-7.00E-08	7.00E-08	±9.10E-10
+Input Bias Current BIAS1 15V (A)	-7.15E-07	7.15E-07	±1.22E-08
-Input Bias Current BIAS1 15V (A)	-7.15E-07	7.15E-07	±1.13E-08
Input Offset Voltage2 15V (V)	-8.00E-04	8.00E-04	±1.28E-05
Input Offset Current2 15V (A)	-7.00E-08	7.00E-08	±9.67E-10
+Input Bias Current BIAS2 15V (A)	-7.15E-07	7.15E-07	±7.21E-09
-Input Bias Current BIAS2 15V (A)	-7.15E-07	7.15E-07	±6.44E-09
Input Offset Voltage3 15V (V)	-8.00E-04	8.00E-04	±1.65E-05
Input Offset Current3 15V (A)	-7.00E-08	7.00E-08	±7.00E-10
+Input Bias Current BIAS3 15V (A)	-7.15E-07	7.15E-07	±1.01E-08
-Input Bias Current BIAS3 15V (A)	-7.15E-07	7.15E-07	±8.88E-09
Output Voltage Swing High1 15V (V)		1.00E-02	±2.81E-04
Output Voltage Swing High2 15V (V)		1.50E-01	±1.19E-03
Output Voltage Swing High3 15V (V)		8.00E-01	±6.15E-03
Output Voltage Swing Low1 15V (V)		3.00E-02	±5.56E-04
Output Voltage Swing Low2 15V (V)		1.00E-01	±1.03E-03
Output Voltage Swing Low3 15V (V)		5.00E-01	±3.44E-03
Large Signal Voltage Gain1 15V (V/mV)	1.00E+03		±2.28E+02
Large Signal Voltage Gain2 15V (V/mV)	5.00E+01		±1.55E+01
Common Mode Rejection Ratio1 15V (dB)	9.00E+01	3.00E+02	±9.45E-02
CMRR Match1 1 to 4 15V (dB)	8.40E+01	3.00E+02	±6.79E-02
CMRR Match1 2 to 3 15V (dB)	8.40E+01	3.00E+02	±1.71E-01
Power Supply Rejection Ratio1 (dB)	9.00E+01		±3.82E-01
PSRR Match1 1 to 4 (dB)	8.30E+01		±1.35E-01



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PSRR Match1 2 to 3 (dB)	8.30E+01		±8.96E-02
+Short-Circuit Current1 15V (A)		-1.50E-02	±4.01E-04
-Short-Circuit Current1 15V (A)	1.50E-02		±6.44E-04
+Supply Current 5V (A)		8.80E-03	±8.67E-05
-Supply Current 5V (A)	-8.80E-03		±8.59E-05
Input Offset Voltage4 5V (V)	-8.00E-04	8.00E-04	±1.49E-05
Input Offset Current4 5V (A)	-6.50E-08	6.50E-08	±5.28E-10
+Input Bias Current BIAS4 5V (A)	-6.50E-07	6.50E-07	±6.11E-09
-Input Bias Current BIAS4 5V (A)	-6.50E-07	6.50E-07	±6.24E-09
Input Offset Voltage5 5V (V)	-8.00E-04	8.00E-04	±8.65E-06
Input Offset Current5 5V (A)	-6.50E-08	6.50E-08	±5.15E-10
+Input Bias Current BIAS5 5V (A)	-6.50E-07	6.50E-07	±3.27E-09
-Input Bias Current BIAS5 5V (A)	-6.50E-07	6.50E-07	±2.91E-09
Output Voltage Swing High4 5V (V)		1.00E-02	±2.53E-04
Output Voltage Swing High5 5V (V)		1.50E-01	±8.19E-04
Output Voltage Swing High6 5V (V)		2.50E-01	±1.46E-03
Output Voltage Swing Low4 5V (V)		3.00E-02	±3.86E-04
Output Voltage Swing Low5 5V (V)		1.00E-01	±4.14E-04
Output Voltage Swing Low6 5V (V)		2.00E-01	±7.42E-04
Large Signal Voltage Gain3 5V (V/mV)	6.00E+02		±5.72E+02
Common Mode Rejection Ratio2 5V (dB)	7.60E+01		±1.49E-01
CMRR Match2 1 to 4 5V (dB)	7.50E+01		±5.95E-02
CMRR Match2 2 to 3 5V (dB)	7.50E+01		±3.80E-01
Power Supply Rejection Ratio2 (dB)	8.80E+01		±4.26E+00
PSRR Match2 1 to 4 (dB)	8.20E+01		±1.05E+00
PSRR Match2 2 to 3 (dB)	8.20E+01		±6.39E-01
+Short-Circuit Current2 5V (A)		-1.25E-02	±4.02E-05
-Short-Circuit Current2 5V (A)	1.25E-02		±4.63E-04
Gain-Bandwidth Product 15V (MHz)	6.80E+00		±3.78E-02
+Slew Rate 15V (V/us)	3.50E+00		±5.70E-02
-Slew Rate 15V (V/us)	3.50E+00		±5.70E-02

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**Appendix D: List of Figures Used in the Results Section (Section 5)**

- 5.1. +Supply Current 15V (A) @ VS=+/-15V
- 5.2. -Supply Current 15V (A) @ VS=+/-15V
- 5.3. Input Offset Voltage1 1 15V (V) @ VS=+/-15V, VCM=0V
- 5.4. Input Offset Voltage1 2 15V (V) @ VS=+/-15V, VCM=0V
- 5.5. Input Offset Voltage1 3 15V (V) @ VS=+/-15V, VCM=0V
- 5.6. Input Offset Voltage1 4 15V (V) @ VS=+/-15V, VCM=0V
- 5.7. Input Offset Current1 1 15V (A) @ VS=+/-15V, VCM=0V
- 5.8. Input Offset Current1 2 15V (A) @ VS=+/-15V, VCM=0V
- 5.9. Input Offset Current1 3 15V (A) @ VS=+/-15V, VCM=0V
- 5.10. Input Offset Current1 4 15V (A) @ VS=+/-15V, VCM=0V
- 5.11. +Input Bias Current BIAS1 1 15V (A) @ VS=+/-15V, VCM=0V
- 5.12. +Input Bias Current BIAS1 2 15V (A) @ VS=+/-15V, VCM=0V
- 5.13. +Input Bias Current BIAS1 3 15V (A) @ VS=+/-15V, VCM=0V
- 5.14. +Input Bias Current BIAS1 4 15V (A) @ VS=+/-15V, VCM=0V
- 5.15. -Input Bias Current BIAS1 1 15V (A) @ VS=+/-15V, VCM=0V
- 5.16. -Input Bias Current BIAS1 2 15V (A) @ VS=+/-15V, VCM=0V
- 5.17. -Input Bias Current BIAS1 3 15V (A) @ VS=+/-15V, VCM=0V
- 5.18. -Input Bias Current BIAS1 4 15V (A) @ VS=+/-15V, VCM=0V
- 5.19. Input Offset Voltage2 1 15V (V) @ VS=+/-15V, VCM=15V
- 5.20. Input Offset Voltage2 2 15V (V) @ VS=+/-15V, VCM=15V
- 5.21. Input Offset Voltage2 3 15V (V) @ VS=+/-15V, VCM=15V
- 5.22. Input Offset Voltage2 4 15V (V) @ VS=+/-15V, VCM=15V
- 5.23. Input Offset Current2 1 15V (A) @ VS=+/-15V, VCM=15V
- 5.24. Input Offset Current2 2 15V (A) @ VS=+/-15V, VCM=15V
- 5.25. Input Offset Current2 3 15V (A) @ VS=+/-15V, VCM=15V
- 5.26. Input Offset Current2 4 15V (A) @ VS=+/-15V, VCM=15V
- 5.27. +Input Bias Current BIAS2 1 15V (A) @ VS=+/-15V, VCM=15V
- 5.28. +Input Bias Current BIAS2 2 15V (A) @ VS=+/-15V, VCM=15V
- 5.29. +Input Bias Current BIAS2 3 15V (A) @ VS=+/-15V, VCM=15V
- 5.30. +Input Bias Current BIAS2 4 15V (A) @ VS=+/-15V, VCM=15V
- 5.31. -Input Bias Current BIAS2 1 15V (A) @ VS=+/-15V, VCM=15V
- 5.32. -Input Bias Current BIAS2 2 15V (A) @ VS=+/-15V, VCM=15V
- 5.33. -Input Bias Current BIAS2 3 15V (A) @ VS=+/-15V, VCM=15V
- 5.34. -Input Bias Current BIAS2 4 15V (A) @ VS=+/-15V, VCM=15V
- 5.35. Input Offset Voltage3 1 15V (V) @ VS=+/-15V, VCM=-15V
- 5.36. Input Offset Voltage3 2 15V (V) @ VS=+/-15V, VCM=-15V
- 5.37. Input Offset Voltage3 3 15V (V) @ VS=+/-15V, VCM=-15V
- 5.38. Input Offset Voltage3 4 15V (V) @ VS=+/-15V, VCM=-15V
- 5.39. Input Offset Current3 1 15V (A) @ VS=+/-15V, VCM=-15V
- 5.40. Input Offset Current3 2 15V (A) @ VS=+/-15V, VCM=-15V
- 5.41. Input Offset Current3 3 15V (A) @ VS=+/-15V, VCM=-15V
- 5.42. Input Offset Current3 4 15V (A) @ VS=+/-15V, VCM=-15V
- 5.43. +Input Bias Current BIAS3 1 15V (A) @ VS=+/-15V, VCM=-15V
- 5.44. +Input Bias Current BIAS3 2 15V (A) @ VS=+/-15V, VCM=-15V



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- 5.45. +Input Bias Current BIAS3 3 15V (A) @  $V_S=+/-15V$ ,  $V_{CM}=-15V$
- 5.46. +Input Bias Current BIAS3 4 15V (A) @  $V_S=+/-15V$ ,  $V_{CM}=-15V$
- 5.47. -Input Bias Current BIAS3 1 15V (A) @  $V_S=+/-15V$ ,  $V_{CM}=-15V$
- 5.48. -Input Bias Current BIAS3 2 15V (A) @  $V_S=+/-15V$ ,  $V_{CM}=-15V$
- 5.49. -Input Bias Current BIAS3 3 15V (A) @  $V_S=+/-15V$ ,  $V_{CM}=-15V$
- 5.50. -Input Bias Current BIAS3 4 15V (A) @  $V_S=+/-15V$ ,  $V_{CM}=-15V$
- 5.51. Output Voltage Swing High1 1 15V (V) @  $V_S=+/-15V$   $I_L=0mA$
- 5.52. Output Voltage Swing High1 2 15V (V) @  $V_S=+/-15V$   $I_L=0mA$
- 5.53. Output Voltage Swing High1 3 15V (V) @  $V_S=+/-15V$   $I_L=0mA$
- 5.54. Output Voltage Swing High1 4 15V (V) @  $V_S=+/-15V$   $I_L=0mA$
- 5.55. Output Voltage Swing High2 1 15V (V) @  $V_S=+/-15V$   $I_L=1mA$
- 5.56. Output Voltage Swing High2 2 15V (V) @  $V_S=+/-15V$   $I_L=1mA$
- 5.57. Output Voltage Swing High2 3 15V (V) @  $V_S=+/-15V$   $I_L=1mA$
- 5.58. Output Voltage Swing High2 4 15V (V) @  $V_S=+/-15V$   $I_L=1mA$
- 5.59. Output Voltage Swing High3 1 15V (V) @  $V_S=+/-15V$   $I_L=10mA$
- 5.60. Output Voltage Swing High3 2 15V (V) @  $V_S=+/-15V$   $I_L=10mA$
- 5.61. Output Voltage Swing High3 3 15V (V) @  $V_S=+/-15V$   $I_L=10mA$
- 5.62. Output Voltage Swing High3 4 15V (V) @  $V_S=+/-15V$   $I_L=10mA$
- 5.63. Output Voltage Swing Low1 1 15V (V) @  $V_S=+/-15V$   $I_L=0mA$
- 5.64. Output Voltage Swing Low1 2 15V (V) @  $V_S=+/-15V$   $I_L=0mA$
- 5.65. Output Voltage Swing Low1 3 15V (V) @  $V_S=+/-15V$   $I_L=0mA$
- 5.66. Output Voltage Swing Low1 4 15V (V) @  $V_S=+/-15V$   $I_L=0mA$
- 5.67. Output Voltage Swing Low2 1 15V (V) @  $V_S=+/-15V$   $I_L=1mA$
- 5.68. Output Voltage Swing Low2 2 15V (V) @  $V_S=+/-15V$   $I_L=1mA$
- 5.69. Output Voltage Swing Low2 3 15V (V) @  $V_S=+/-15V$   $I_L=1mA$
- 5.70. Output Voltage Swing Low2 4 15V (V) @  $V_S=+/-15V$   $I_L=1mA$
- 5.71. Output Voltage Swing Low3 1 15V (V) @  $V_S=+/-15V$   $I_L=10mA$
- 5.72. Output Voltage Swing Low3 2 15V (V) @  $V_S=+/-15V$   $I_L=10mA$
- 5.73. Output Voltage Swing Low3 3 15V (V) @  $V_S=+/-15V$   $I_L=10mA$
- 5.74. Output Voltage Swing Low3 4 15V (V) @  $V_S=+/-15V$   $I_L=10mA$
- 5.75. Large Signal Voltage Gain1 1 15V (V/mV) @  $V_O=+/-14.5V$ ,  $R_L=10k\Omega$
- 5.76. Large Signal Voltage Gain1 2 15V (V/mV) @  $V_O=+/-14.5V$ ,  $R_L=10k\Omega$
- 5.77. Large Signal Voltage Gain1 3 15V (V/mV) @  $V_O=+/-14.5V$ ,  $R_L=10k\Omega$
- 5.78. Large Signal Voltage Gain1 4 15V (V/mV) @  $V_O=+/-14.5V$ ,  $R_L=10k\Omega$
- 5.79. Large Signal Voltage Gain2 1 15V (V/mV) @  $V_O=+/-10V$ ,  $R_L=2k\Omega$
- 5.80. Large Signal Voltage Gain2 2 15V (V/mV) @  $V_O=+/-10V$ ,  $R_L=2k\Omega$
- 5.81. Large Signal Voltage Gain2 3 15V (V/mV) @  $V_O=+/-10V$ ,  $R_L=2k\Omega$
- 5.82. Large Signal Voltage Gain2 4 15V (V/mV) @  $V_O=+/-10V$ ,  $R_L=2k\Omega$
- 5.83. Common Mode Rejection Ratio1 1 15V (dB) @  $V_S=+/-15V$ ,  $V_{CM}=+/-15V$
- 5.84. Common Mode Rejection Ratio1 2 15V (dB) @  $V_S=+/-15V$ ,  $V_{CM}=+/-15V$
- 5.85. Common Mode Rejection Ratio1 3 15V (dB) @  $V_S=+/-15V$ ,  $V_{CM}=+/-15V$
- 5.86. Common Mode Rejection Ratio1 4 15V (dB) @  $V_S=+/-15V$ ,  $V_{CM}=+/-15V$
- 5.87. CMRR Match1 1 to 4 15V (dB) @  $V_S=+/-15V$ ,  $V_{CM}=+/-15V$
- 5.88. CMRR Match1 2 to 3 15V (dB) @  $V_S=+/-15V$ ,  $V_{CM}=+/-15V$
- 5.89. Power Supply Rejection Ratio1 1 (dB) @  $V_S=+/-2V$  to  $+/-16V$
- 5.90. Power Supply Rejection Ratio1 2 (dB) @  $V_S=+/-2V$  to  $+/-16V$

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- 5.91. Power Supply Rejection Ratio1 3 (dB) @  $V_S=+-2V$  to  $+-16V$
- 5.92. Power Supply Rejection Ratio1 4 (dB) @  $V_S=+-2V$  to  $+-16V$
- 5.93. PSRR Match1 1 to 4 (dB) @  $V_S=+-2V$  to  $+-16V$
- 5.94. PSRR Match1 2 to 3 (dB) @  $V_S=+-2V$  to  $+-16V$
- 5.95. +Short-Circuit Current1 1 15V (A) @  $V_S=+-15V$ ,  $V_{OUT}=0V$
- 5.96. +Short-Circuit Current1 2 15V (A) @  $V_S=+-15V$ ,  $V_{OUT}=0V$
- 5.97. +Short-Circuit Current1 3 15V (A) @  $V_S=+-15V$ ,  $V_{OUT}=0V$
- 5.98. +Short-Circuit Current1 4 15V (A) @  $V_S=+-15V$ ,  $V_{OUT}=0V$
- 5.99. -Short-Circuit Current1 1 15V (A) @  $V_S=+-15V$ ,  $V_{OUT}=0V$
- 5.100. -Short-Circuit Current1 2 15V (A) @  $V_S=+-15V$ ,  $V_{OUT}=0V$
- 5.101. -Short-Circuit Current1 3 15V (A) @  $V_S=+-15V$ ,  $V_{OUT}=0V$
- 5.102. -Short-Circuit Current1 4 15V (A) @  $V_S=+-15V$ ,  $V_{OUT}=0V$
- 5.103. +Supply Current 5V (A) @  $V_S=+5V$
- 5.104. -Supply Current 5V (A) @  $V_S=+5V$
- 5.105. Input Offset Voltage4 1 5V (V) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.106. Input Offset Voltage4 2 5V (V) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.107. Input Offset Voltage4 3 5V (V) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.108. Input Offset Voltage4 4 5V (V) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.109. Input Offset Current4 1 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.110. Input Offset Current4 2 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.111. Input Offset Current4 3 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.112. Input Offset Current4 4 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.113. +Input Bias Current BIAS4 1 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.114. +Input Bias Current BIAS4 2 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.115. +Input Bias Current BIAS4 3 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.116. +Input Bias Current BIAS4 4 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.117. -Input Bias Current BIAS4 1 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.118. -Input Bias Current BIAS4 2 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.119. -Input Bias Current BIAS4 3 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.120. -Input Bias Current BIAS4 4 5V (A) @  $V_S=+5V$ ,  $V_{CM}=0V$
- 5.121. Input Offset Voltage5 1 5V (V) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.122. Input Offset Voltage5 2 5V (V) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.123. Input Offset Voltage5 3 5V (V) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.124. Input Offset Voltage5 4 5V (V) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.125. Input Offset Current5 1 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.126. Input Offset Current5 2 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.127. Input Offset Current5 3 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.128. Input Offset Current5 4 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.129. +Input Bias Current BIAS5 1 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.130. +Input Bias Current BIAS5 2 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.131. +Input Bias Current BIAS5 3 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.132. +Input Bias Current BIAS5 4 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.133. -Input Bias Current BIAS5 1 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.134. -Input Bias Current BIAS5 2 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.135. -Input Bias Current BIAS5 3 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$
- 5.136. -Input Bias Current BIAS5 4 5V (A) @  $V_S=+5V$ ,  $V_{CM}=5V$

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- 5.137. Output Voltage Swing High4 1 5V (V) @ VS=+5V IL=0mA
- 5.138. Output Voltage Swing High4 2 5V (V) @ VS=+5V IL=0mA
- 5.139. Output Voltage Swing High4 3 5V (V) @ VS=+5V IL=0mA
- 5.140. Output Voltage Swing High4 4 5V (V) @ VS=+5V IL=0mA
- 5.141. Output Voltage Swing High5 1 5V (V) @ VS=+5V IL=1mA
- 5.142. Output Voltage Swing High5 2 5V (V) @ VS=+5V IL=1mA
- 5.143. Output Voltage Swing High5 3 5V (V) @ VS=+5V IL=1mA
- 5.144. Output Voltage Swing High5 4 5V (V) @ VS=+5V IL=1mA
- 5.145. Output Voltage Swing High6 1 5V (V) @ VS=+5V IL=2.5mA
- 5.146. Output Voltage Swing High6 2 5V (V) @ VS=+5V IL=2.5mA
- 5.147. Output Voltage Swing High6 3 5V (V) @ VS=+5V IL=2.5mA
- 5.148. Output Voltage Swing High6 4 5V (V) @ VS=+5V IL=2.5mA
- 5.149. Output Voltage Swing Low4 1 5V (V) @ VS=+5V IL=0mA
- 5.150. Output Voltage Swing Low4 2 5V (V) @ VS=+5V IL=0mA
- 5.151. Output Voltage Swing Low4 3 5V (V) @ VS=+5V IL=0mA
- 5.152. Output Voltage Swing Low4 4 5V (V) @ VS=+5V IL=0mA
- 5.153. Output Voltage Swing Low5 1 5V (V) @ VS=+5V IL=1mA
- 5.154. Output Voltage Swing Low5 2 5V (V) @ VS=+5V IL=1mA
- 5.155. Output Voltage Swing Low5 3 5V (V) @ VS=+5V IL=1mA
- 5.156. Output Voltage Swing Low5 4 5V (V) @ VS=+5V IL=1mA
- 5.157. Output Voltage Swing Low6 1 5V (V) @ VS=+5V IL=2.5mA
- 5.158. Output Voltage Swing Low6 2 5V (V) @ VS=+5V IL=2.5mA
- 5.159. Output Voltage Swing Low6 3 5V (V) @ VS=+5V IL=2.5mA
- 5.160. Output Voltage Swing Low6 4 5V (V) @ VS=+5V IL=2.5mA
- 5.161. Large Signal Voltage Gain3 1 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ
- 5.162. Large Signal Voltage Gain3 2 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ
- 5.163. Large Signal Voltage Gain3 3 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ
- 5.164. Large Signal Voltage Gain3 4 5V (V/mV) @ VO=75mV to 4.8V, RL=10kΩ
- 5.165. Common Mode Rejection Ratio2 1 5V (dB) @ VS=+5V, VCM=0 to +5V
- 5.166. Common Mode Rejection Ratio2 2 5V (dB) @ VS=+5V, VCM=0 to +5V
- 5.167. Common Mode Rejection Ratio2 3 5V (dB) @ VS=+5V, VCM=0 to +5V
- 5.168. Common Mode Rejection Ratio2 4 5V (dB) @ VS=+5V, VCM=0 to +5V
- 5.169. CMRR Match2 1 to 4 5V (dB) @ VS=+5V, VCM=0 to +5V
- 5.170. CMRR Match2 2 to 3 5V (dB) @ VS=+5V, VCM=0 to +5V
- 5.171. Power Supply Rejection Ratio2 1 (dB) @ VS=+4.5V to +12V
- 5.172. Power Supply Rejection Ratio2 2 (dB) @ VS=+4.5V to +12V
- 5.173. Power Supply Rejection Ratio2 3 (dB) @ VS=+4.5V to +12V
- 5.174. Power Supply Rejection Ratio2 4 (dB) @ VS=+4.5V to +12V
- 5.175. PSRR Match2 1 to 4 (dB) @ VS=+4.5V to +12V
- 5.176. PSRR Match2 2 to 3 (dB) @ VS=+4.5V to +12V
- 5.177. +Short-Circuit Current2 1 5V (A) @ VS=+5V
- 5.178. +Short-Circuit Current2 2 5V (A) @ VS=+5V
- 5.179. +Short-Circuit Current2 3 5V (A) @ VS=+5V
- 5.180. +Short-Circuit Current2 4 5V (A) @ VS=+5V
- 5.181. -Short-Circuit Current2 1 5V (A) @ VS=+5V
- 5.182. -Short-Circuit Current2 2 5V (A) @ VS=+5V

**An ISO 9001:2008 and DSCC Certified Company**



**ELDRS Report  
12-640 130125 R1.1**

**Aeroflex RAD  
5017 N. 30th Street  
Colorado Springs, CO 80919  
(719) 531-0800**

- 5.183. -Short-Circuit Current<sub>2 3</sub> 5V (A) @ VS=+5V
- 5.184. -Short-Circuit Current<sub>2 4</sub> 5V (A) @ VS=+5V
- 5.185. Gain-Bandwidth Product<sub>1</sub> 15V (MHz) @ VS=+/-15V, f=100kHz
- 5.186. Gain-Bandwidth Product<sub>2</sub> 15V (MHz) @ VS=+/-15V, f=100kHz
- 5.187. Gain-Bandwidth Product<sub>3</sub> 15V (MHz) @ VS=+/-15V, f=100kHz
- 5.188. Gain-Bandwidth Product<sub>4</sub> 15V (MHz) @ VS=+/-15V, f=100kHz
- 5.189. +Slew Rate<sub>1</sub> 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ
- 5.190. +Slew Rate<sub>2</sub> 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ
- 5.191. +Slew Rate<sub>3</sub> 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ
- 5.192. +Slew Rate<sub>4</sub> 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ
- 5.193. -Slew Rate<sub>1</sub> 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ
- 5.194. -Slew Rate<sub>2</sub> 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ
- 5.195. -Slew Rate<sub>3</sub> 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ
- 5.196. -Slew Rate<sub>4</sub> 15V (V/us) @ VS=+/-15, AV=-1, RL=10kΩ